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RESEARCH REPORTS - 1980 NASA / ASEE SUMMER FACULTY FELLOWSHIP PROGRAM

University of Alabama University, Alabama

and

University of Alabama in Huntsville Huntsville, Alabama

October 1980



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Prepared for

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This document is a collection of	of reports on t	he research condu	ucted by the p	articipants in
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ran from May 26. 1980 through	August 1. 1980	and was conducted	by the Unive	rsity of
Alabama in cooperation with MSI	FC and the Univ	ersity of Alabam	in Huntsvill	e. As in the
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RESEARCH REPORTS

1980 NASA/ASEE SUMMER FACULTY FELLOWSHIP PROGRAM

George C. Marshall Space Flight Center The University of Alabama and The University of Alabama in Huntsville

EDITORS:

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NASA CR - 161511

PREFACE

For the sixteenth consecutive year, a NASA/ASEE Summer Faculty Fellowship Research Program was conducted at the Marshall Space Flight Center (MSFC). The program was conducted by The University of Alabama and MSFC during the period May 26, 1980 through August 1, 1980. The program was operated under the auspices of the American Society for Engineering Education (ASEE). The program at MSFC, as well as those at five other NASA Centers, was sponsored and funded by the Office of University Affairs, NASA Headquarters, Washington, D.C. The basic objectives of the programs, which are in the seventeenth year of operation nationally, are:

- a. To further the professional knowledge of qualified engineering and science faculty members;
- b. To stimulate an exchange of ideas between participants and NASA:
- c. To enrich and refresh the research and teaching activities of participants; instutions; and,
- d. To contribute to the research objectives of the NASA Centers.

The Faculty Fellows spent ten weeks at MSFC engaged in a research project commensurate with their interests and background and worked in collaboration with a NASA/MSFC Colleague. This document is a compilation of Fellow's reports on their research during the Summer of 1980. University of Alabama Report No. BER-259-94 presents the Co-Directors' report on the administrative operations of the Research Fellowship Program. Further information can be obtained by contacting any of the editors.

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

1980

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

DEVELOPMENT OF A FACILITY FOR LARGE-SCALE TESTING OF MULTISTORY BUILDINGS

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Date:

Contract No.:

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Space Sciences Atmospheric Sciences

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August 1, 1980

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Development of a Facility for Large-Scale Testing of Multistory Buildings

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Daniel P. Abrams, Ph. D. Assistant Professor of Civil Engineering University of Colorado Boulder, Colorado

Abstract

Current experimental research pertaining to response of structures subjected to lateral loads such as strong winds or earthquake motions is limited to either tests of single structural components or small-scale (approximately one-tenth) multistory structures. The feasibility of developing a facility where large-scale multistory structures could be loaded to failure is discussed.

The test facility would consist of a series of hydraulic actuators mounted on reaction frames currently in use at the Marshall Space Flight Center for structural testing of spacecraft components. The actuators would be controlled from signals computed by an on-line analysis of measured data. This method of loading could be used to simulate inertial forces resisted by a structure behaving in the nonlinear range of response subjected to motion at the base or to impulses along the height as would occur during a strong earthquake or wind.

Development and utilization of the test facility would occur in two phases. In the first phase, the testing system would be developed and verified for loading a structure within a single plane. The second phase would utilize the loading system by testing a half-scale ten-story reinforced concrete building 45 feet tall. Further development of the test facility may include the capability of loading individual floor levels to simulate translational and rotational inertia in three directions.

ACKNOWLEDGEMENTS

The writer expresses his appreciation to the National Aeronautics and Space Administration, and the University of Alabama and the American Society of Engineering Education for funding and conducting the Summer Faculty Fellowship Program at the Marshall Space Flight Center under the direction of Marion Kent of NASA and Dr. Robert Barfield of the University of Alabama.

Special gratitude is extended to Dr. Nicholas Costes who provided many creative ideas and stimulating conversations, and was responsible for introducing the writer to numerous helpful individuals at Marshall.

The writer wishes to thank Dr. George McDonough for his support of the project and George Shofner, Charles Watson, Frank Vinz and Gerry Waggoner for their technical advice and constructive comments.

Credit is given to Willa Eslick for her patience in typing the paper.

INTRODUCTION

"Earthquakes have caused, and can cause in the future, enormous loss of life, injury, destruction of property, and economic and social disruption."

This statement quoted from the Earthquake Hazards Reduction Act of 1977 [1] demonstrates the importance for safer structures in regions of high seismicity. More specifically, the primary objective of the Act passed by Congress is

"The development of technologically and economically feasible design and construction methods and procedures to make new and existing structures, in areas of seismic risk, earthquake resistant..."

In accordance with this objective, several investigators have examined both analytically and experimentally the response of structures subjected to strong ground motions. Of the experimental studies, investigations have been limited to response of one of two general specimen types: large-scale single components of more complex structures, or small-scale (on the order of one-twelfth) multistory structures. Large-scale multistory structures have not been tested to destruction because costs of developing a loading system and constructing a test structure were thought previously to be prohibitive.

This paper presents the feasibility of developing a facility where largescale multistory structures could be loaded to failure. The proposed test facility would consist of a series of hydraulic actuators mounted on reaction frames currently in use at the Marshall Space Flight Center (MSFC) for structural testing of spacecraft components. Development and utilization of the test facility is discussed in terms of the cost-value relationship of using large-scale test structures for earthquake engineering research.

OBJECTIVES

Results of an experimental study using a large-scale test structure could be the necessary evidence required to transfer existing research findings to standards for building earthquake-resistant structures. Moreover, tests of large-scale structures may help discover and develop new methods of designing and constructing safer structures. Measured response of a largescale multistory structure would:

(1) verify the capability of the testing system to simulate inertial loads resulting from a programmed impulse;

(2) for the first time, provide comprehensive data for an indepth study of both the overall and local response of a multistory structure subjected to a strong ground motion;

(3) verify currently used small-scale modeling procedures thus extend experimental research of multistory structures using shaking tables;

(4) provide a data base for testing newly developed analytical models used for calculating nonlinear dynamic response of multistory structures;

(5) serve as a "proof test" of recent improvements in earthquakeresistant design procedures developed with mathematical and small-scale physical models;

(6) provide data to evaluate methods of rehabilitation of existing and damaged structures such as epoxy grout injections or masonry in-fill panels.

The objective of the study presented in this paper is to examine the feasibility of developing a large-scale testing facility and to outline a test program utilizing the facility to illustrate these attributes of large-scale testing.

A hypothetical structure (Fig. 1) has been chosen as an example of a typical test article. The structure is a one-half scale reinforced concrete building consisting of two three-bay frames coupled to a slender shear wall at ten levels with floor slabs poured monolithically. The configuration was chosen to replicate a similar configuration previously used with small-scale models [2, 3, 4]. The scale was chosen so that sizes of members and reinforcement would be representative of actual construction. It is planned to develop a testing system to load this structure laterally at all ten levels from a single direction.

OUTLINE OF TEST PROGRAM

An outline of the test program is presented in Fig. 2. The program would consist of three stages. In the first stage the testing system would be developed using existing loading equipment at MSFC and a computer analysis that would be developed. The second stage would consist of verifying operation of the testing system by constructing and loading a replica of a smallscale (approximately 8-ft. tall) ten-story structure tested previously on a shaking table [2]. The loading procedure which would consist of a series of slowly applied loading reversals simulating inertial forces could be validated by comparing displacement response of the structure tested on a shaking table with that of the structure loaded laterally with actuators. If agreement can be made, then the loading system would be developed further to test the 45-ft tall structure shown in Fig. 1 using the same load control system and on-line computer analysis with larger size actuators and reaction structure.

It is planned to test the 45-ft tall half-scale structure using the same input base - acceleration history as used for the 8-ft tall structure. In this way, scaling relationships may be examined for modeling reinforced concrete at small scales. After the structure has been tested, it can be repaired and loaded once again to investigate methods of rehabilitation. The test structure then can be used as a loading system for investigating the behavior of masonry sub-panels by repairing the structure once again, in filling each frame panel with masonry and retesting. In this manner, each of sixty frame panels, or masonry elements, will be subjected to a different ratio of shear to normal stress thus providing a larger population of data than currently exists in all of the past masonry research.

LOADING SYSTEM

The proposed loading system consists of a series of hydraulic actuators mounted to an existing reactor frame used presently for testing portions of the liquid oxygen tanks of the Space Shuttle. The reactor structure (Fig. 3) which is located within the structural test tower (Fig. 4) of the load test annex of building 4619 has sufficient lateral-load capacity to support the 20 actuators (two per level, Table 1) required to load the 45-ft tall test structure. Minor modifications of the reaction structure would be necessary to support individual actuators. In addition, the reaction structure could be used to support actuators mounted in transverse and vertical directions for further development of the loading facility.

A contingency plan could also be developed to use the existing test tower (Fig. 4) if removal of the reaction frame were necessary for other reasons. The test area measures $51 \times 49 \times 47$ meters high. A double trolley crane with a total capacity of 54 metric tons is accessible for erection of the test structure. Further detailed information about the facility is given in Reference 5.

The existing load control system located in building 4619 has been cited [6] by the Japanese as being a unique system for controlling several actuators simultaneously. A closed-loop control system using a PDP-11 computer monitors response of a specimen at intervals of 1/60th of a second and adjusts the load to attain a preselected specimen response. This method of control is particularly useful if it is desired to displace a structure through a specified deflected shape. Actuators loading a structure at several levels can be programmed to displace prescribed amounts despite interaction among actuators which has troubled investigators previously. The capability of the load-control system to coordinate simultaneous actuator movement is proven by numerous experiments including a recent one where several actuators were used to load in three directions an ortho-grid assembly used for part of the floor system in Space lab. The proposed loading facility would utilize ten of fifty-eight channels of the existing load-control system.

The actuators would be controlled from signals generated by an on-line analysis of measured data to simulate inertial loads resulting from a prescribed impulse. For a standard time increment of the impulse duration, each actuator would displace an amount calculated from previous force and displacement measurements and the prescribed forcing function. The differential equation to be satisfied for each floor level is:

 $\dot{mx} + F_r = p(t)$ (1) where m is the mass of the floor and lumped portions of the columns and wall, \ddot{x} is the acceleration of the mass, F_r is the restoring force of the structure, and p(t) is the prescribed forcing function. Using finite differences, the acceleration may be related to the displacement over a time increment by

$$\ddot{\mathbf{x}}_{i} = (\mathbf{x}_{i+1} - 2\mathbf{x}_{i} + \mathbf{x}_{i-1}) / (\Delta t)^{2}$$
(2)

where Δt denotes the time interval and i refers to the particular time increment. The new displacement, x_{i+1} , that controls the actuator movement, may be calculated from \ddot{x}_i which is determined from equation (1)

$$\mathbf{m}_{i} = \mathbf{p}(t)_{i} - \mathbf{F}_{ri}$$

For an impulse at the base of a multistory structure, p(t) becomes $m_{x_0}^{*}$ where

xo is the input acceleration at base. Any prescribed ground motion including translational, rocking or torsional motions may be input to the online analysis to load the fixed-base structure "pseudo dynamically."

The restoring force, F_r , is measured continuously during the loading which is particularly important for a nonlinearly behaving structure because the restoring force or stiffness of the structure is constantly changing and sometimes unpredictable. For a nonlinear dynamics problem the fact that the inertial forces are dependent on the stiffness, and the stiffness is dependent on the loading history, justifies the on-line analysis as an irreplaceable technique for simulating inertial loads. Because the pseudo-dynamic test method is not velocity dependent, the actuators may be operated as slow as the hydraulic power supply requires. Some investigators have even advocated that slowing the loading process down to a nearly static rate is good for observing propagation of cracks and other types of progressive damage. It should be noted that the loading method does not account for effects of viscous, or velocity dependent damping, and strain-rate effects. However, it is reasonable to assume that most of the energy dissipation in reinforced concrete structures behaving within the nonlinear range of response is attributable to hysteretic damping which is not velocity dependent. Furthermore, strain-rate effects for velocities corresponding to the fundamantal mode and possibly the second mode of vibration of prototype structures have been shown to be negligible [7].

EXPERIMENTAL PROCEDURES

To economize on formwork the test structure (Fig. 1) would be erected from planar wall and frame elements cast in the horizontal plane and lifted to the vertical position. Reinforcement at base of columns and wall would be anchored in concrete blocks prestressed to the floor of the test area to prevent welding of reinforcing bars. Floor slabs could then be cast to complete erection of the structure. A minor amount of disassembly of the reaction structure may be necessary for lifting and placement of the structure.

Instrumentation would consist of two displacement and two load transducers at each level of the structure. Additionally, strain gages would be placed on reinforcing bars to detect internal forces in members and to infer bond characteristics between concrete and reinforcing bars. An estimated maximum of 200 channels of data would be a small percent of the 6000 channel Structural Test Data Acquisition System (STDAS) available at MSFC.

The test structure would be subjected to a series of lateral loads simulating response to the ground motion measured at El Centro, California, in the 1940 Imperial Valley earthquake (NS component). The intensity of the input motion would be scaled according to an analysis used for design of the structure so that similar levels of damage would be attained as for the smallscale structures. After the first test run, or loading, the structure would be loaded corresponding to an input motion of twice the intensity to further investigate strength and stiffness deterioration and energy dissipation characteristics. This pattern may be repeated until destruction occurs. At that time, the structure may be repaired using epoxy grout injections in the cracked concrete and tested once again. If the rehabilitation process can regain a sufficient amount of the original stiffness, the structure can be repaired once again and then strengthened with concrete-block masonry placed in each frame panel. Instrumentation can be installed to measure normal and shear stresses on each masonry panel when the structure is loaded once again.

In addition to the pseudo-dynamic testing, a series of low-amplitude free and forced vibration tests can be run to determine dynamic characteristics such as modal frequencies, shapes, and damping factors.

COST ESTIMATE

Approximate costs of developing a large-scale testing facility to load a 45-ft tall ten-story structure are itemized below. Costs include verification of the pseudo-dynamic loading system, and construction of the reinforced concrete test structure. Cost estimates have been compiled by engineers at MSFC who would be directly involved with the proposed work.

(1) Verify pseudo-dynamic testing method. Costs include testing an 8-ft tall model structure with the newly developed test method.

Reaction structure	\$5,000
Loading system	\$20,000
Instrumentation	-
Construction of 8-ft model	\$8,000
	\$33,000
Man months	30

(2) Develop large-scale testing facility. Costs include modifying existing structural test equipment and purchasing needed actuators, hardware, cables, hydraulic lines and miscellaneous items.

Reaction structure	\$30,000	
Loading system	\$65,000	
Man months	\$95,000 35	

(3) Constructing and testing 45-ft tall structure

Construction of structure	\$85,000	
Instrumentation	\$7,000	
Disassembly	\$10,000	
	\$102,000	
Man months	25	
Total	\$230,000	
Man months	90	

(4)

The overall cost of the project appears to be justifiable when compared with a similar attempt in Japan [6] and a previous feasibility study [8], each costing well over twenty million dollars.

EXTENDED DEVELOPMENT OF THE TEST FACILITY

Development of the loading system could be extended further in several steps to result ultimately in a loading system that could simulate translational inertia of each floor slab in three directions in addition to rotary inertia about three axes. Base motions input to the on-line analysis could then contain three translational components: two horizontal and one vertical, and three rotational components: torsion and rocking about each horizontal axis.

The existing reaction structure, hydraulic power supply, and loadcontrol system could be utilized. Two additional horizontal actuators, and two additional vertical actuators would be required per floor level.

Operation of the loading system could be verified by constructing several test structures at a small scale in duplicate. One of each pair of structures would be tested on the six-degree-of-freedom shaking table located in building 4663. The other structure of the pair would be tested using the newly developed loading system. Comparing response of each structure would verify the reliability of the pseudo-dynamic test method for multiaxial loading.

Furthermore, the existing structural test tower (Fig. 4) located in the local test annex of building 4619 is sufficiently tall and strong to accommodate a test structure up to 100-ft tall. A twenty-story half-scale, or ten-story full-scale, building could be tested with the additional cost primarily attributable to the purchase and support of additional actuators.

SUMMARY AND CONCLUSIONS

The feasibility of developing a facility for testing large-scale multistory buildings to failure has been presented. The facility would consist of a series of hydraulic actuators mounted to existing structural test equipment at the Marshall Space Flight Center. Displacement of each actuator would be controlled by an on-line analysis of measured data to simulate motion of a multistory structure subjected to a prescribed series of impulses input at the base as would occur during an earthquake. Construction, instrumentation, and test procedures are outlined for testing a 45-ft tall reinforced concrete structure to illustrate the worth of large-scale testing and the approximate costs.

The role of a large-scale testing facility for earthquake engineering research has been shown to be consistent with the objectives of the Earthquake Hazards Reduction Act of 1977. Development of such a facility at the MSFC using existing structural test equipment appears to be feasible technically and justifiable economically.

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Table 1

Actuator Requirements (2 per level)

Level	Capacity	Bore	Stroke
	(kips)	(inches)	(inches)
10	35	5	48
9	35	5	48
8	35	5	38
7	35	5	38
6	25	4	29
5	25	4	29
4	25	4	19
3	25	4	19
2	15	3	10
1	15	· 3	10



Fig. 1 Test Structure





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Fig. 3 Reaction Structure



Fig. 4 Structural Test Tower

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

MSFC PERSONNEL MANAGEMENT TASKS: RECRUITMENT AND ORIENTATION OF NEW EMPLOYEES

Prepared By:

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NASA/MSFC: Office Division

MSFC Counterpart:

Date:

Contract No.:

Personnel Office Personnel Development

James R. Johnson

August 1, 1980

NGT-01-002-099 (University of Alabama)

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MSFC PERSONNEL MANAGEMENT TASKS: RECRUITMENT AND ORIENTATION OF NEW EMPLOYEES

ΒY

Thomas A. Brindley, Ph. D. Associate Professor of Education The University of Alabama in Huntsville Huntsville, Alabama

ABSTRACT

In order to encourage highly motivated young students to learn about NASA and consider it for a career, a formal program will be initiated whereby selected students can work on a voluntary basis at Marshall Space Flight Center. These students will work under the guidance and supervision of expert NASA employees. The first task has been to develop the working plan and procedures for this program, called Student Volunteer Service Program, in the writing of MSFC official guidelines, the Marshall Management Instruction (the MMI) which is a binding document that defines policy and establishes procedures and guidelines. Particular considerations written into the MMI after numerous consultations, interviews, and discussions about a satisfactory policy, include: arrangements to be made between the student, the school authorities, and concerned MSFC employees; management of the work assignments; and procedures for the student's welfare and safety.

The second task has been the development of a Recruitment Brochure for the attraction of new employees, especially scientists and engineers. Since private industry has certain advantages in hiring, particularly in offering higher initial salaries, it is imperative that NASA stress the valid reasons why working at MSFC would be of great benefit to the prospective employee. Thus, the brochure needs to stress aspects of ongoing NASA projects which show how various disciplines of science and engineering apply.

The third task assigned has been to develop a plan called Orientation of New Employees.¹ The main intention is to establish a procedure whereby new employees can best become acquainted in their new work with a minimum of stress involved in coming to a new organization. This plan attempts to schedule various experiences that will enable the new employee to understand not only the particular work situation for which the employee is assigned, but to show the overall mission and operations of the Marshall Space Flight Center. The plan is to indicate the types of orientation believed necessary to aid the new employee in adjusting to work at MSFC.

ACKNOWLEDGEMENTS

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INTRODUCTION

The Personnel Development Division of the Personnel Office requested that three tasks be accomplished by this NASA/ASEE Summer Faculty Fellow. The tasks were to investigate the needs and ramifications of several aspects of recruiting and orientation of employees and to write up a study or report on each of the subjects, taking each project as far as it could be carried in the ten weeks. Specifically, these management tasks were:

- 1) the orientation of new employees;
- 2) a recruiting brochure for the hiring of new scientists and engineers; and,
- 3) a student volunteer service program.

These three tasks have been completed and are reported here in respective sections.

The research undertaken involved the reading of all materials pertinent to past actions on the subjects and numerous interviews, consultations, and discussions with concerned MSFC employees about satisfactory policies related to these tasks. The tasks also demanded that this writer understand as much as possible about NASA and MSFC in a holistic, comprehensive way. Since the author had little previous acquaintance with MSFC in either a technological sense or in an organizational management sense, it was necessary to learn about NASA/MSFC in a short time so that the tasks could be begun. Thus, in effect this writer experienced his own orientation program.

VOLUNTARY STUDENT SERVICE PROGRAM

In 1978, the MSFC Personnel Office in response to various university and school requests in the Huntsville area initiated inquiries into the feasibility of forming a plan to describe means whereby exceptional students could work at MSFC on a voluntary basis. The initial exchange of memorandum and letters regarding the subject were described as the "Worksite Experience Program."

Laboratory supervisors were asked if they had needs in their organizations for visiting students. Several responded that they would be interested in allowing students to work in their laboratories. The Associate Director of the Center and the Director of Science and Engineering were especially interested in pursuing this program.

Coincidentally and unrelated to local efforts, guidelines were being discussed at the national level to provide for voluntary student services. The Civil Service Reform Act of 1978, allowed agencies to devise memoranda or official guidelines which would establish workable programs of this nature. MSFC temporarily delayed pursuing this further until the assignment for this NASA/ASEE Fellow.

Until the Civil Service Reform Act of 1978, there were no provisions for agencies of the Federal government to accept voluntary or gratuitous services from interested persons or parties. Thus, visiting individual researchers and interested students could find no means to offer services to a Federal agency because no employment status existed for them. There were no arrangements or agreements to allow students to take part in government programs gratuitously. Thus, a talented high school student could not work at MSFC in a laboratory where the youngster could gain in knowledge and experience. Such an opportunity would also encourage the youngster to think about future employment at NASA after completing college work.

The first task assigned and completed was to write a proposed Marshall Management Instruction (the MMI) which is a binding document that defines policy and establishes procedures and guidelines. The MMI sets up a formal mechanism whereby selected, highly motivated young students can work on a voluntary basis at MSFC. The following study plan, following the format of the Marshall Management Instruction, describes the Voluntary Student Service Program.

STUDY PLAN: THE MARSHALL MANAGEMENT INSTRUCTION (DRAFT)

SUBJECT: Student Volunteer Service Program

1. PURPOSE

- a. To provide a means whereby qualified students can volunteer their services to the Center in order to gain experience and knowledge.
- b. To establish Center policy and procedures and to identify responsibilities in the management of the Student Volunteers.
- c. To establish guidelines for the Student Volunteers while they are working at the Center.

2. SCOPE

This instruction is applicable to all elements of MSFC.

3. REFERENCES

- a. FPM Chapter 308, Subchapter 7.
- b. FPM Letter 308-16, November 8, 1979.

4. POLICY

- a. High School students who show outstanding promise in their school work or school activities as determined by their school teachers and administrators in all areas of school study, especially, but not limited to science subjects, may wish to receive additional knowledge and expertise and be provided advanced opportunities to learn through on-the-job experience. These students will be allowed to work in a nonpay status on a voluntary basis at the Marshall Space Flight Center during a specified time and under the direction of a designated NASA employee.
- b. Each student assignment will be established and conducted through written agreement between the Marshall Center and the educational institution or with the organization so

designated by schools or boards of education.*

- c. The participating student is not to be considered a Federal employee for any purposes other than injury compensation or laws related to the Federal Tort Claims Act. Service is not creditable for leave accrual or any other employee benefits.
- d. Assignments will be tailored individually at the chief discretion of the project officer (Mentor).

5. DEFINITIONS

- a. The definitions of "volunteer service," "student," "half-time student," and "agreement" are those contained in FPM Chapter 308, Subchapter 7 and FPM Letter 308-16.
- b. Mentor -- the MSFC employee responsible for the student's work, welfare, and learning experiences, who is in charge of the student's assignments, scheduling, reporting, and evaluation, and who supervises the student.

6. BACKGROUND

The authority for the acceptance of unconditional gifts and services donated to the agency is contained in the National Aeronautics and Space Act, Section 203 (c)(4). Based upon this authority the Center has been developing a program to allow participation in Center activities by students who are willing to donate their time and effort, in response to interest expressed by local educational institutions. The Civil Service Reform Act of 1978 authorized the acceptance of volunteer service and the Office of Personnel Management implemented regulations outlining procedures for the development of such programs government-wide.

7. GENERAL PROVISIONS

- a. Responsibilities for the student's work at the Center shall be mutually entrusted to the Mentor. Participation in the program is conditioned upon the student's consent by written agreement to certain specified guidelines. Although students are not considered Federal employees, they will be allowed to work alongside and at the direction of Federal employees at the Center.
- b. This program is limited to students <u>enrolled</u> not less than half time in high school, trade school, technical or vocational institution, or junior college, college or university.
- * Agreements and forms, as attachments, are not included here.

- c. Students receive no compensation.
- d. The student offers service (comes to work at NASA) with permission of sponsoring school or institution where student is enrolled.
- e. Nominations for participation will be made by the sponsoring school or institution where the student is enrolled. Selection shall be within the sole discretion of the Center.
- f. The student will not replace or displace any Center employee or staff a vacancy.
- g. The student will not be used to replace or substitute for routine and/or clerical duties while on assignment.
- h. The student will not be allowed to enroll or partake in MSFC training courses.
- i. Students will be at least 16 years old and must be at least in their junior year in High School. Students must be citizens of the United States. Participation shall not be based upon race, color, religion, sex, national origin, age, mental or physical handicap, marital status, or political affiliations, as prohibited by law, rule, or regulation.

8. **RESPONSIBILITIES AND PROCEDURES**

- a. The academic institution will be responsible for:
 - Requesting in writing to the MSFC Center Director placement of nominated students in designated disciplines.
 - (2) Recommending students who have demonstrated a serious interest in gaining work experience at the Center and who have demonstrated outstanding curricular and/or extracurricular achievements as deemed appropriate by the academic institution.
 - (3) Executing and complying with the terms of the Memorandum of Understanding with MSFC.
- b. The MSFC Personnel Office will be responsible for:
 - (1). Selecting participants from those nominated by their educational institution.
 - (2) Identifying work locations.
 - (3) Appointing a Mentor to supervise the student during the student's assignment at MSFC.
 - (4) Negotiating appropriate agreements.
 - (5) Documenting volunteer service on Standard Form 50 (SF-50), "Notification of Personnel Action."
 - (6) Establishing an Official Personnel Folder (OPF).
 - (7) Evaluating the program.
 - (8) Submitting any required reports.
 - (9) Managing a one week orientation program to acquaint the student with the overall NASA-MSFC mission.
- c. The MSFC Security Office will be responsible for:
 - Providing proper authorization of the student's special status while assigned or visiting the Center.
 - (2) Acquainting the student with necessary security measures.
 - (3) Limiting the student only to non-security materials and areas.
- d. The MSFC Mentor will be responsible for:
 - (1) Supervising the student's work and learning experiences.
 - (2) Supervising the student's assignments and schedules.
 - (3) Assigning the student a definite worksite and monitoring the student's activities.
 - (4) Evaluating the student's performance and submitting any necessary reports to the Personnel Office.
 - (5) Maintaining informal relationships with responsible parties of the student's academic institution.
- e. The student will be responsible for:
 - (1) Complying with rules and regulations governing the internal operations of the Center. Any infractions of responsibilities may be cause for termination of the program.
 - (2) Being at the work location during the hours specified in the work experience Memorandum of Understanding or in other designated places upon approval of the Mentor.
 - (3) Following the authority of the assigned Mentor.
 - (4) Contacting the Mentor if absence from work is necessary.
 - (5) Caring for and properly maintaining all equipment and facilities used.
 - (6) Providing transportation to and from the MSFC worksite.
- f. Mutual agreements between parties:
 - A written agreement, called the Memorandum of Understanding, will be signed by the Director of the Personnel Office and the representative of the participating institution. The agreement will explain the general assignments, time of assignment, and any special requirement desired by the parties.
 - (2) A "Notification of Personnel Action," Form 50, will be completed and signed by Department Head and Applicant.
 - (3) An "Application For Use of Research Facility, Equipment, or Computation Service" will be completed and signed by designated persons.
 - (4) A "Memorandum Agreement Relative to an Unconditional Donation of Services and Acceptance Thereof," will be completed and signed by designated persons.

THE RECRUITMENT BROCHURE

The second management task has been the development of a recruitment brochure for the attraction of new employees, especially scientists and engineers. In 1968, the first reduction in force (RIF) affected MSFC. From time to time thereafter various reductions of employees occurred through 1979, so that the work force which was once over 7000 in the heyday of the Apollo-Saturn missions fell by Summer, 1980, to 3600 employees. Coupled with this, there are over 1500 employees who have reached twenty years of service and are eligible for retirement. The rate of employee attrition will certainly increase in the next five years unless new people can be brought in. Although there has been some hiring in critical skill areas over the last twelve years, there is abundant need to recruit and hire scientists and engineers at MSFC to maintain a strong and active work force. Even though there is a 3561 end of fiscal year 1980 employment ceiling at MSFC imposed by Congressional budgetary considerations, new hiring is very necessary.

Recruitment teams are sent to selected universities each year. There are numerous kinds of materials, but there is no special handout available for recruiters to utilize which is aimed definitely at attracting employees to this center to work on the kinds of projects in process for which MSFC is renowned, and to praise the advantages of living in the Huntsville, Alabama area. A recruitment brochure is deemed necessary to enhance the search for new employees of critical skills in science and engineering.

There were several important considerations that were discussed in the numerous interviews and inquiries taken by this researcher in order to determine a final plan for the nature of the brochure. It was determined that the particular engineering and scientific skills in which a prospective employee has been educated should be shown in their direct relationship to the kinds of projects and activities being developed at this particular center. A prospective employee should feel that his or her university preparation and past experience will be properly utilized at MSFC. The employee has to feel that there are opportunities to work on significant projects, to acquire a sense of mission and purpose, to see one's work in meaningful relation to the whole, and to work with materials and processes that enhance one's skills and draw upon one's best talents. The new employee has to be shown that MSFC allows for personal and professional growth and development and that MSFC provides abundant opportunities for advancement and recognition. Since private industry has certain advantages in hiring, particularly in offering higher initial salaries, a recruiting brochure must show how the Federal pay and

promotion scale and the MSFC organization allow an employee to gain in pay and status rather rapidly over the years. New employees are concerned about the area in which they live. Thus, the many advantages of the good life in the Tennessee Valley should be described.

The actual development of the brochure itself included a number of steps. The researcher had to ascertain what the needs are at MSFC and what kind of employees are being sought. The researcher had to learn what MSFC offers that would be of concern and interest to possible new employees. What especially attracts recent college graduates and/or experienced hands? Can NASA/MSFC attract candidates of the highest quality in the face of considerable competition from other governmental organizations and from private industry?

Various federal agencies, other NASA centers, and some aerospace companies were contacted about their own recruiting efforts. After this information was gathered, the researcher had to discuss the plan of the brochure with various supervisors, chiefly the head of recruitment.

Then the researcher made several plans, called thumbnail sketches. Priorities of arrangement and order were determined. The final sketch was presented to the graphics department to make a draft mockup. This is the stage reached by the end of the seventh week. Thereafter, each draft must then be developed further and refined. Appropriate pictures must be acquired and adequate text must be written. Then a final mockup is made by the graphics department. This is presented to various directors for approval and then submitted to the printers for the final edition.

The organizational pattern of the draft mockup recruitment brochure as completed follows in this order. First, an attractive cover is planned to show the chief ongoing project for which MSFC is mainly responsible -- the Space Shuttle itself. At the beginning of the booklet the Director of the Center introduces MSFC to prospective employees. The Center itself is shown and the geographic relationship of MSFC to other field centers is represented. Chief accomplishments of NASA in the past, in the present, and planned for the future are pictorially shown. Then the main missions and projects of the Marshall Center are depicted. These include the Space Shuttle, the Spacelab Payloads, various important scientific laboratories, and some of the spin-offs, materials processing in space, and special assigned tasks at MSFC, such as solar heating and cooling. Integrated into the portrayal of these various missions are references indicating how the education and experience of qualified engineers and scientists work on each of the projects in particular. Then some pages describe briefly how future employees will benefit by

working at MSFC. Several pages show how employees have special advantages and opportunities at MSFC in advancement, career development, pay and status, training programs, and professional enhancement. Finally, the attractive surroundings of the Tennessee Valley and the numerous educational, cultural, and social advantages of this area of America are portrayed. The sense of living in a multicultural, pleasant, and attractive community is stressed.

The various thumbnail drafts and the first mockup from graphics are already completed at the time of this writing. However, the bulk of the draft brochure precludes it being inserted as a part of this report. The first draft mockup brochure serves as a springboard for its final development and incorporates and organizes the many conceptual ideas into a meaningful plan for further action. The ongoing continuation of the recruitment brochure lies in the hands of the Personnel Director.

ORIENTATION OF NEW EMPLOYEES

The third task completed has been to develop a study plan called the Orientation of New Employees. The main purpose is to establish a procedure indicating guidelines whereby new employees can best become acquainted in their new work with a minimum of stress involved in working in a new organization.

Presently very little is being done at MSFC in a formal manner to orient new employees about the ways of the Center. There is a one time meeting given by a representative of the Personnel Office, as presented by law in the guidelines of the Office of Personnel Management to describe the necessary work conditions and benefits of employees. This is not a true orientation since it is limited to a description of procedural matters relative to all NASA employees.

The Director and supervisors of the Personnel Office recognize the need for a completely developed orientation plan. But there are differing opinions among them and among various supervisors and employees throughout MSFC about the merits and the type of orientation that would be necessary. Informal inquiries taken among several new employees also show a division of opinion about the nature and need of an orientation program for the recently hired.

Some feel that orientation efforts are a waste of time, others feel they are beneficial. Some believe orientation meetings should be brief and narrowly construed. Others feel that meetings should be very comprehensive of the entire MSFC operations beyond one's own workplace. Others feel that there is no need to learn about areas unrelated to one's work. Some feel that an orientation schedule should occur within the first few days of a new person's hire or, at most, but a week long. Others feel that a proper orientation cannot be hurried or overloaded in a short time frame, but should be extended over several months. There are many concerns about the nature of an orientation program. Does it encourage better morale in the work force? Does it enhance the sense of mission? Does it build cooperative efforts?

The main argument seems to be whether a new employee needs to become acquainted with the general workings of the new organization, or whether the new employee needs to learn only about one's own particular job and only needs to learn about the wider ramifications of the organization as the person's contacts develop from the job site. Although this might be an individual matter, there seems to be a broad difference in approach between generalists and particularists based upon one's own research training and education. Some scientists and engineers want to work alone and without much to do with others. Some scientists and engineers wish to see how their own discipline relates with others and wish to ascertain how their own particular skills might be relevant to other parts of the whole center.

Management, on the other hand, has to determine what is best for the new employee and what kind of orientation would lead to the best satisfaction of the missions and purposes of the center as a whole. There are conflicting views here, too. Some personnel supervisors feel that the integrated nature of much of the work at NASA demands a general understanding of MSFC as a whole and of different projects and laboratories other than one's own specialty or assigned area. Other supervisors feel that an extensive orientation program would be too time consuming on the parts of both the participants and the presenters and would be too costly.

The orientation plan devised by this researcher incorporates many approaches to meet expected needs of new employees to help them adjust to work at MSFC. This plan attempts to schedule various experiences that will enable the new employee to understand not only the particular work situation in which the employee is assigned, but to show the overall mission and operations of the Marshall Space Flight Center. The study plan which follows here is devised to allow for maximum opportunities, but it may be pared down or condensed if so desired, as the plan moves up the ladder in the approval process.

STUDY PLAN: ORIENTATION OF NEW EMPLOYEES

PROBLEM:

Since 1968, when MSFC's first reduction in force took place, NASA-MSFC has been in a reduced hiring mode. As a result, new employee orientation during this time has been based primarily upon satisfying general information needs. Much of a new person's orientation is conducted informally at the work site by the employee's immediate supervisor. The Personnel Office, on the other hand, gives the new employee basic procedural information concerning OPM regulatory requirements and benefits. This is usually done on a one-to-one basis and later in a short general meeting for those brought on-board that week.

In the last year, NASA-MSFC hiring of new employees has increased. Yet, no plan has been developed to acquaint these new employees with the overall mission and purposes of NASA or with a proper perspective in seeing the relationship of one's own work to the whole. This has generated a need for a more comprehensive, in-depth orientation of new employees.

OBJECTIVES:

The objectives of a plan for the orientation of new employees are:

- 1. To inform each employee about the basic requirements of adjusting to the new organization. This includes acquiring a knowledge of benefits, hospitalization, security, NASA-MSFC regulations and various other procedural and administrative matters.
- 2. To provide a method whereby the employee is thoroughly oriented to the work situation. Presently, the employee is acquainted with the work situation in an informal manner.
- 3. To provide a general understanding of the overall NASA mission and to show how the various organizations work together at MSFC to achieve national goals. Not only will the employee begin to sense the importance of NASA-MSFC as a whole, but also will learn how the new employee's particular work fits into a wider framework.

This study deals with these objectives and outlines the structure and content of a proposed orientation plan that will satisfy the needs of the new employees and be beneficial to NASA.

PROPOSAL:

The "Orientation Plan for New Employees" will consist of three phases as follows:

- 1. Administrative Orientation -- procedures, responsibilities and rights, guidelines and benefits.
- 2. Work Site Orientation -- the particular tasks of the employee at the immediate place of work.
- 3. NASA-MSFC Orientation -- the overall perspective and acquaintanceship of the mission of MSFC as a whole.

PHASE ONE: ADMINISTRATIVE ORIENTATION

1. Personnel Staffing Specialist Meeting

The very first acquaintanceship of the new employee upon being hired will be a scheduled visit with an assigned Personnel Staffing Specialist (PSS) on an informal, one-to-one, personal basis. The most immediate concerns of the new employee, such as housing, locating main facilities of the Center, work hours, health plans, and pay procedures, will be discussed. The main attempt here is to give the new employee a feeling that he or she is welcome and has a place to find information immediately. A designated number of new employees will be assigned to each of the Personnel Staffing Specialists. Even new employees who have worked with other federal agencies would be expected to participate in this orientation. The PSS will "follow through" with each of the new employees over the course of the entire three phase orientation period. From time to time the PSS will contact the newcomer to inquire about the person's welfare at MSFC. The PSS should give the newcomer a contact phone number on the first visit. Also, the new employee will be given a packet, which includes necessary information about MSFC and Huntsville, employee unions, equal opportunity, and regulations, to keep and study.

2. Personnel Administrative General Meeting

At a designated time, preferably at the beginning of every two week pay-period in order to keep in phase with payroll records, the new employees hired up to that date will meet as a group for a general orientation conducted, as presently done, by the Personnel Office. The necessary items scheduled for discussion will follow the "New Employee Orientation Checklist," MSFC Form 3688 (April, 1968), which is signed upon completion by both the employee and Staffing Officer and kept in the employee's 201 File. Discussion of any particular points will be encouraged and details will be provided as needed by the new employees.

PHASE TWO: WORK SITE ORIENTATION

It is of utmost importance that the new employee learn to feel at home in his/her own work environment as soon as possible. The adjustment to a new situation will produce some frustrations, but it need not be stressful if proper considerations are given. The new employee will be under the authority of the immediate supervisor. This person should pay great attention to the psychological welfare of the newcomer. Introduction to all fellow employees, an opportunity to see others at work and to see who is responsible to whom, a review of work procedures, and an acquaintance with the location of key facilities and equipment are some of the concerns necessary to the well being of the new employee. This acquaintanceship period takes time, cannot be rushed, and should include some free time to digest the new information. In essence, one is learning some of the informal ways of the organization.

During this time the Personnel Staffing Specialist will be in contact to review progress and handle problems. This is in line with regular personnel procedures which require a ninety day follow-up. Sometimes, several other orientation activities (of Phase Three, below) will be provided during the time the new employee is on the job in this early acquaintaceship period. Such activities might include the bus tour of MSFC or selected lectures and/or interviews by NASA specialists on particular topics. No additional paperwork is required by the supervisor other than the checklist now used routinely by the supervisor in reviewing the completion of special tasks in this part of the orientation. The intent of work site orientation is to keep procedures as natural and informal as possible.

PHASE THREE: NASA-MSFC ORIENTATION

1. The major purpose of this phase is to assure that new employees are given opportunities to see their own particular work in relation to the whole of MSFC and of the entire NASA agency. It is important to the overall mission of NASA that integration and cooperation of efforts be understood by all employees not only better to achieve the goals of NASA, but to enhance esprit de corps. Also, an understanding of the interrelationships of NASA's many projects often leads to a better feeling about one's own work and aids an individual in one's own personal and professional advancement.

- 2. Since the new employee will now be at work on the job site, this phase of the orientation must be scheduled so as to cause minimum disruption to the person's work schedule. It is proposed that this general orientation be staggered over a number of weeks to allow the new employee sufficient time to digest the new information and to prevent overburdening the offices of those who present materials by taking time out of their regular workload.
- 3. Administration of all aspects of Phase Three, including scheduling and monitoring, will be under the management of the Personnel Office.
- 4. All new employees should be involved together as a group in a one day common orientation. In the morning a bus tour should take the newly hired to various locations of MSFC. They should visit the main projects, test stands, certain laboratory facilities, museum mockups, and special projects, such as the Neutral Buoyancy Facility.

In the afternoon a general meeting should be arranged in the Tenth Floor Conference Room of Building 4200. At this time various selected Center management officials will introduce themselves and conduct a presentation on various important general MSFC topics. Such topics might include a general discussion of the Space Shuttle or of the importance of coordinating payloads.

A representative of the Office of the Director or one of the Executive Staff Offices should give an introductory address called the Center Overview, followed by other senior management speakers, who can lend an aura of importance to the new hiree's appointment into the MSFC workforce. This Conference Room meeting should include as many new hirees as possible at the same time.

- 5. Up to this time the orientation is the same for all types and categories of employees: scientists and engineers, administrative and professional, technicians, clerical and operational. At this point the orientation is divided into two modules. Each module applies to different categories of new personnel. The difference in orientation lies in the degree of depth and scope. The two modules are:
 - 1) Scientists and Engineers, Business and Professional, and

Technicians (NCC 200/700, 600, 300)

- 2) Clerical (NCC 500).
- New employees of both categories (modules) should visit certain basic projects, labs, or offices in common and as a large group. These include:
 - 1) selected science and selected engineering laboratories;
 - 2) key projects, such as Shuttle propulsion.
- 7. The module plan could be modified or compressed if the plan involves too much time of the employees and of the supervisors by cutting down on the staggered sessions and by having the new employees meet together in larger groups.

Module One: Scientists, Engineering, Technicians, Business and Professionals

- On a bi-weekly basis a certain number of new hirees will meet as a group to interface with each other, to share experiences, and occasionally to listen to guest speakers about special projects. The purpose of this meeting is to provide for some identifiable group loyalty and cohesion to disparate members of the MSFC work force in order to build up a sense of common solidarity across NASA as a whole, to build a sense of community and shared associations, and to provide for cross-fertilization of ideas. (Precedence for this has already been established by the NASA/ASEE Summer Faculty weekly "fellowship" meetings).
- 2. An opportunity for new employees to meet key personnel can be developed by inviting such people to these bi-weekly meetings to converse with the group, or to schedule specially arranged times when small numbers of hirees can visit in selected offices.
- 3. Rather fundamental kinds of programs, projects, and interfaces ought to be included in the itinerary. These might include:
 - Advanced Systems, planning layout
 Examples: (1) Description of all future projects;
 (2) Coal Casification;
 - (2) Coal Gasification;
 - (3) Nuclear Waste Disposal;
 - (4) Solar Energy Use.
 - b. Space Shuttle operations
 Examples: (1) Configuration Change Board of Solid Rocket

Boosters in Building 4610;

- (2) Telecon Level II PRCB in Building 4202, Room 411.
- c. Payload and Spacelab Projects
 - (1) Overview.
- d. Science and Engineering Laboratories
 - Examples: (1) Metallurgical analysis and use of electron microscopes;
 - (2) Cell separation in zero gravity
- e. MSFC Administrative Support
 - Examples: (1) Personnel Training;
 - (2) Procurement;
 - (3) Plans and Analysis Office;
 - (4) Overall administration.

Module Two: Clerical

- 1. Since the new employees of this group will not have had extensive, formal scientific and engineering education, the presentations should be given in less complicated technical detail. However, the general nature of the various projects and tasks indicated in Module One should be of interest to this group. Thus, a schedule should be developed in the Personnel Office for this module following the same pattern.
- 2. Scheduling for both modules will be done in accordance with new hiring activity and with the concern to distribute presentations among many different people and offices.
- 3. A special session for Module Two would be a general, overall tour and explanation of a selected number of key installations. This would be different from the usual NASA tour. This would encompass such office functions as procurement, personnel training, computer services, and the public affairs office. Selected scientific laboratories would be included on the itinerary. This tour would be planned to encompass an entire morning.

ORIENTATION PLAN RECOMMENDATIONS:

- 1. That a comprehensive, in-depth new employee orientation be implemented at MSFC.
- 2. That the administration and coordination of the Orientation of New Employees be the responsibility of the Personnel Office.
- 3. That an MMI be published identifying Center policy and assigning duties and responsibilities.

CONCLUSIONS AND RECOMMENDATIONS

The Personnel Office of Marshall Space Flight Center assigned three management tasks to this researcher. All three were completed and the results were presented to the Personnel Director. A meeting of selected supervisors was called so that the researcher could orally present a status report on these topics. They expressed satisfaction with the projects and the work done. Final suggestions were made, although constant surveillance and assistance by these same people had been given continuously during the entire time of investigation and writing.

This report has described the nature of the three tasks and the substance of their results. Since each of the tasks is a topic that is ongiong in nature, the final products will not be ready until all reviewers and authorities give approval. Undoubtedly some changes and revisions will be made. Nevertheless, the basic structure, the main outline and format, and the conceptual plans have been determined at this point.

There was no shortcut in the undertaking of these tasks. First, a thorough orientation and grounding into the nature of the scientific and engineering projects which make up the mission of NASA-MSFC and the nature of the administration and organization of MSFC had to be obtained by this researcher. Then, many different viewpoints and opinions had to be gathered and discussed about the specific nature of the tasks. Materials relevant to the tasks were read and analyzed, but these usually consisted of memos, letters, and similar works previously done. Since most of these materials are on file in various offices at MSFC, they do not form a descriptive bibliography or a list of references, and, consequently, are not stated in this report. Finally, each draft of each task had to be reviewed by an authority on the subject before the next revision could be written. Most often the suggestions of several people were incorporated into the next stage of the writings.

It is recommended that these three projects be continued immediately until their final approval is given by the Director of the Center. A Marshall Management Instruction (MMI) on the Student Volunteer Service Program should be completed in final form following the model presented here. The Recruitment Brochure should follow the general theme as worked upon to this point. Pictures should be selected and minimal text written. A comprehensive Orientation Plan for New Employees should be implemented at MSFC and an MMI should be written to identify Center policy and guidelines. All three of these tasks should be administered by the Personnel Office of MSFC.

1980 NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

THE EFFECT OF TIME DELAY IN THE 6 DOF MOTION SYSTEM AND ITS COMPENSATION

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ANALYSIS AND IMPROVEMENT OF CONTACT DYNAMICS SIMULATION USING THE SIX DEGREE OF FREEDOM MOTION SYSTEM

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ABSTRACT

The 6DOF motion system has been employed for closed loop simulation of the contact dynamics involved in the docking of two satellites (for example TRS and Skylab). Under most initial conditions however the system gives inaccurate results. Typically in the simulation if docking fails to occur the rebound velocity of the TRS exceeds its approach velocity, thus generating an artificial and unacceptable gain of momentum in the system.

It has long been well known that the presence of a time lag can generate instability in closed loop systems. To see if the time lag (about 200 ms.) in the 6 DOF system can satisfactorily account for its errors, a simple computer mode of the system incorporating this lag and other revelant parameters has been implemented. The model in fact does predict all the observed rebound errors with reasonable precision.

Also, since it is probable that the time delay can only be reduced but not eliminated, various compensation schemes have been devised. Two give adequate correction for delays under 100 ms for a non-preloaded probe. More powerful schemes may be adequate for the present 200 ms. environment and the presence of a preload.

Our study relies heavily on the mathematical theory of second order differential equations with retarded arguments and standard tools of numerical analysis.

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NOMENCLATURE

7	-	Time lag of the 6 DOF system							
A t	-	Sample frame time of the AD converter between the sensor and the EAI 8900							
F(t)	-	Sensor force signal							
۵F	-	Change in force signal in time step							
r	- '	Probe compression							
ົາ .	-	Maximum probe compression							
K	-	Hooke's constant of probe							
М	-	Mass of probe							
е	-	Base of the natural logarithmns							
v	-	Initial velocity of probe							
v _f	-	Observed rebound velocity of probe							
∇(ŧ)	-	Velocity of probe							
a(t)	-	Acceleration of probe							
IVP	-	Initial value problem							
ω, ²	-	K/M							
Fp	-	Preload of probe							
X.	-	n+ Fp/K							
× _T	-	×(+-7) + +							
*	-	Convolution, $f = q := \int_{0}^{\infty} f(e-4) g(s) ds = \int_{0}^{\infty} f(s) g(t-s) ds$							

F_t - Force threshold
 λ(t) [a,b] - Characteristic function based on the interval [a,b]
 h - Step in a digital simulation

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M	-	Step parameter ; 🕆 = h.M
∂(h*)	-	Error proportional to h
v _n	-	v (nh)
qin	-	a(nh)
ve	-	Compensated version of ${f v}$
×c	-	Compensated version of x

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I INTRODUCTION

The LINK Six-Degree-of-Freedom (6 DOF) Motion System has been employed by the Marshall Space Flight Center for the physical simulation of the contact forces and dynamics in the docking of two satellites - for example the Teleoperator Retrieval System (TRS) and Skylab. A similar device was developed at the Johnson Space Center in Houston for contact dynamics simulation prior to the Apollo-Soyuz mission of 1975.

In this section we give an informal description of the system and its performance. Some illustrations, photographs, and values of some key parameters may be found in the Appendix. See in particular the block diagram, Fig.10.

A docking probe assembly is placed on the platform of the LINK 6 DOF Motion System. The platform is free to move with any general motion within its limits of travel. Above the probe is a docking collar or other target which is fixed. The software of the EAI 8900 hybrid computer is capable of simulating a set of initial conditions which might include velocities, accelerations, and rotations preliminary to docking.

Since, as mentioned above, the target is stationary, this information is calculated relative to a coordinate system fixed in the target. The initial conditions are translated by the CAI digital computer into commands to change lengths of the six legs supporting the 6 DOF platform. These commands are executed by the hydraulic actuators in the legs causing the 6 DOF system and the probe to perform motions appropriate to the initial conditions.

When the probe is in contact with the target, sensors, also placed on the table, record the forces and torques encountered by the probe. In the open loop mode this information is recorded on strip charts for later use. If desired software can be developed so that the probe simulates dynamic interaction with This option has so far been rejected since the the target. resulting motion would not be generated by the forces actually encountered in the contact phase. A more useful choice is closed loop simulation where the forces are used in a feedback loop through the EAI 8900 and the CAI computers to control the motion of the probe itself. Basically two integrations of the hybrid subsystem give velocity and position functions of the TRS relative to the target. As in the case of the initial conditions the position function is converted into leg length commands. The result is that the probe is supposed to move as if it was freely responding to its own contact dynamics. This mode when perfected should be a valuable tool in the testing and design of docking hardware.

In preliminary testing of the system, the closed loop simulation has been radically simplified so that probe-target interaction is "head on;" only (vertical) translational motion is accepted. Also no thrusts firings of the chase vehicle are allowed. Table 1 presents results of some of these tests.

Obviously apart from the unacceptable level of noise, there is an artificial and unwarranted gain of momentum in the system. The analysis and attempted resolution of this problem is the central concern of the present study.

We close this section with a brief survey of the rest of the paper. In Section II a simple mathematical model based on the time delay inherent in the system is developed. It is also shown how the model can be modified so that it is "noisy." Section III developes several methods to compensate for the delay. The last two sections contain respectively data and graphs illustrating our results and recommendations for further action. II THE EFFECT OF TIME LAG ON THE 6 DOF CLOSED LOOP SIMULATION

It has long been known that the presence of time delay can affect the stability of a closed loop feedback system - see for example.

Minorsky [10], [1] or Callendar, Hartree and Porter [4]. It has been verified that a time delay defined as the time it takes for the legs to complete a response to a signal from the force sensor, exists in the 6 DOF system.

This delay (let us call it " π ") is approximately 200 ms; the various contributions to it by hardware subsystems are shown in the block diagram Fig.10.

A simple physical argument shows how $\boldsymbol{\tau}$ might explain the high rebound velocities of table 1. Suppose at time t the probe has reached maximum compression $\boldsymbol{\bar{n}}$ and should turn around. The command to do this is executed $\boldsymbol{i} + \boldsymbol{\tau}$ later; in the meantime, the probe has continued to move and overshot $\boldsymbol{\bar{n}}$. Therefore during a time period of length $\boldsymbol{\tau}$ additional force has been communicated to the software resulting in a gain in energy. If the probe did not detach, $\boldsymbol{\tau}$ sec. after reaching its rest position the overshot would be repeated and one might expect a sequence of oscillations of increasing amplitude.

2.1 A Mathematical Model - Let us now try to make the above argument mathematically precise. Suppose in the interval $[+, \pm, \pm]$ a change in the force signal AF is sampled. When the EAI 8900 computes a change of compression An corresponding to AF, it does this by digitally solving the equation $(+, \pm)$ and computing the solution at t + At

$$(2.1) \qquad M\ddot{n} = F(t)$$

Now $\eta(t+\Delta t)$ should equal $\eta(t) + \Delta h$. However Δh is not executed until the actuators have finished their response at $t+\tau$. Thus $\eta(t+\tau)$ corresponds to $F(t) - \eta(t)$ equivalently corresponds to $F(t+\tau)$. It follows - (τ includes the sample interval or "frame time" Δt)that the system behave as if it were solving the equation

(2.2) $M\ddot{n} = F(t-\tau)$

Thus we could model the effect of delay by using (2.2) instead of (2.1) in a computer simulation.

In case the probe is an ideal spring F = -kn and (2.2) becomes

(2.3) $M\ddot{\eta} + K \eta(t-\tau) = 0$

(2.2) and (2.3) are examples of retarded differential equations. Because of their importance to control theory applications, such equations have been intensively studied [3], [6], [7] in recent years. The resulting theory has many similarities with the classical theory of differential equations but also important differences. In particular it can be shown that if

TC 2/w.e

then "practically all" solutions oscillate with exponentially increasing amplitude (R. D. Driver, private communication, also cf. Driver [6]).

Also unlike differential equations, a correctly formulated initial value problem (IVP) for (2.2) - (2.3) requires initial conditions on an initial interval rather than just at a point. For example, consider the first τ seconds after contact: The probe continues to compress oblivious of contact since the legs have not yet moved in response to F(+). Thus

$$\eta(t) = N_t$$

(2.4)

 $\dot{\eta}(t) = N_0, 0 \leq 1 \leq T$.

These replace the point conditions of a differential equation IVP.

2.2 A Few Refinements - Essentially equations (2.1) and (2.2) will constitute the mathematical model of the 6 DOF system in our report. Before solving it we discuss some possible improvements (only the most significant of which have been implemented).

2.2.1 Probe Nonlinearity - As is shown in Fig. 2, the probe is not an ideal spring. It is both nonlinear and preloaded. The nonlinearity can be modeled by an equation of the form

$$M\ddot{n} + K(n(t-\tau)) = 0$$

For the graph of k(u) see Fig. . To approximate K(n) one might choose a piecewise linear function, a least squares parabolic fit, or a spline. None of these choices is difficult to implement on the computer. However, since K(n) is nearly constant in the neighborhood of 50-60 lbs/ft, its variation is probably not a source of major error, we will omit this feature of the spring from our model.

Of much greater significance is the existence of a preload (F_p) of approximately 69 lbs. By energy considerations a preloaded spring is equivalent to a compressed longer spring having the same Hook's constant; the fictitious compression is F_P/K . This suggests that we define $\chi(t) := \eta(t) + F_P/K$ and solve

(2.5)

 $\dot{X} + \omega_0^2 \mathcal{X}_{+} = 0$ $\chi(t) = \chi_0 + \mathcal{N}_0 t$ $\dot{\chi}(t) = \mathcal{N}_0 \qquad o_{\mathcal{L}} t \leq \tau$

 $X_{o} := F_{P}/K$ $w_{o}^{2} := K/M$ $X_{D} := X(t-T)$

It will turn out that the preload magnifies the effect of a pure delay.

In this report we will also consider an ideal probe with no preload and K=1200 lbs/ft., since this value has been used in a recent analog simulation [1] of the effect of delays on spring motion in the 6-DOF system.

-2.2.2 Filters - As the block diagram Fig. 10 shows there are several filters in the system. They contribute to the total delay and probably somewhat distort the signal. In [1] it has been shown that the addition of a low pass filter with transfer function </arc gives an additional destablizing effect.

In a digital simulation the presence of such a filter changes (2.3) to the equation

$$M\ddot{n} + K - e(t) + n(t - \tau) = 0$$

(2.6)

e' `

 $e(4) := 1 - e^{-4}$

In general the presence of several filters with constants $c_1 \ \cdots \ c_n$ gives the equation

(2.5)
$$M\ddot{n} + K R_1 + R_2 + \cdots + R_n + N(t-\tau)$$

where

The presence of convolutions can be handled by nested integration loops in a digital simulation. Since the parameters of the filters actually in the system are unknown we ignore their effect except in sofar as they contribute to the delay. Our results compared with tests suggest that this is not a crucial omission.

2.2.3 Force Threshold - In addition to the filters a force threshold (F_{4}) is used to reduce noise. This means that F(t) is accepted if and only if its absolute value exceeds F_{4} i.e.,

$$F(t) = \begin{cases} F(t) & \text{if } |F(t)| \gg F_{t} \\ 0 & \text{otherwise} \end{cases}$$

Thus the IVP (2.5) becomes

(2.6)
$$M\ddot{x} + K\lambda(x) = N_0 + F_0/K$$

(2.6) $\chi(4) = N_0 + F_0/K$

$$\dot{x}(t) = N_{\bullet}$$
, $o \leq t \leq \gamma$

....

Fortunately (2.6) is equivalent to a simpler IVP where F_{\pm} plays a role like the preload. The probe must travel F_{\pm}/K before force due to compression is "accepted." The elapsed time is $\bar{t} = F_{\pm}/Kv_{\pm}$: If we regard \bar{t} as time zero, (2.6) becomes

$$\ddot{x} + \omega_0^2 x_{\tau} = 6$$

X(+) = Xo+ No+

(2.7)

$$\dot{X}(t) = N_0$$

 $X_0 = (F_P + F_{tr}) / K$
 $N(t) = X(t) - F_0 / K$

Note that the system should be very sensitive to F_t . If F_t is large and v_0 is small the only force affecting the probe might be that of the bottoming spring. For example if K= 60, $F_t = 50$ $x_0 > 14.4$ in which is greater than the maximum compression of the probe. In the absence of delay, even threshold of 30 lbs. would produce a severe distortion. When delay is present its destablizing effects are greatly magnified. In the case of a spring with K = 1200 and no preload the effects thought not so severe are still noticable.

The presence of a force threshold also causes some ambiguity in time measuresments during the simulation. Suppose t is the time during rebound when $K_{\Pi} = F_{t}$. Since F(t) is measured directly on the strip chart the simulation period is $E-F_{t}/Kv_{0}$, $t_{F} + F_{t}/Kv_{0}$. The period in which the forces are producing a response in the legs is $[\tau , t_{F} + \tau]$. Currently the exit velocity is measured at $t_{F} + \tau$, time $t_{F} + \tau + F_{t}/Kv_{0}$ from contact. To avoid confusion one needs to keep these various times clearly in mind especially when F_{t} is high and/or K, V is low.

2.2.4 Variable Delay - The IVP (2.6) is a continuous realization of a discutty sampled system. The AD and DA converters (1), (2) (see Fig. 10) sample the signal at discrete intervals Atapproximately 31-35 ms. If all the converters where synchronous little would be lost since we in fact solve the I V P in steps on the computer. However, the converters (3), (4) sample at intervals of 25 ms. This means that periodically (3) samples the same signal twice, producing an additional 25 ms delay. Since they do not start in synchrony (they start where they stopped) the effect varies from run to run. We have put a "noisy" delay into the model. The results suggest that the asynchronization explains some of the noise in the data.

2.2.5 Noise from the table - Since the force sensors are in the table, they may feel some of the inertial forces in the table itself. Again forces due to this source are executed seconds later. This suggest that we consider the neutral to second order equation.

$$(2.8) \qquad \qquad \ddot{X} - \epsilon \underbrace{M}_{r} \ddot{X}_{r} + \omega_{0}^{2} x = 0$$

with the same initial conditions of (2.7) where ϵ is a noise parameter given by a random number generator and M₁ is the mass of the table + probe = 323.5. Preliminary tests (see Appender T) show that this complication is indeed a potent source of noise.

2.3 Solving the Model

2.3.1 Formulas in closed form - Suppose we linearise (2.7) by taking the first two terms of the Taylor expansion, We obtain

(2.9)

 $\ddot{x} + \omega_0^2 x - \omega_0^2 \tau \dot{x} = 0$ $x(0) = X_0$ $\dot{x}(0) = N_0$

If $\omega, \gamma << j$ and $\chi_{o} = 0$ (no preload, no threshold) an approximate solution to (2.9) is

$$X(t) = - \sum_{n=1}^{n} \sum_{j=1}^{n} \sum_{j=1}^{n} w_{i}t$$

Hence

$$(2.10) \qquad \forall \mathbf{r} \geq \mathbf{v}_{\mathbf{r}} \mathbf{e}^{\mathsf{H}_{\mathbf{w}}} \mathbf{r}$$

Neither of these formulas are accurate for much beyond a few seconds. However, (2.9) gives an error of under 3% for $\gamma \leq .2$. If there is a force threshold the formula

(2.11)
$$V_{F} = V_{0} e^{\frac{\pi}{2} W_{0} T} (V_{0} + F_{t} T/_{2M})$$

yields an error < 15% provided F_t < 120 lbs.

An exact closed form solution to (2.7) or 2.8) can be given by an inductive procedure known as the "Method of Steps." Suppose \sim and \times are known on the interval [(k-i)+, k+]. Then setting .

+ = KT+S

we have for $k + \leq t \leq (k+1)$.

(2.12)

$$N(t) = N(kT) - w_0^2 \int_{kT}^{t} X(s) ds$$

$$X(t) = X(kT) + \int_{kT}^{t} V(u) du$$

Since the initial functions are simple the solution may be calculated in closed form, step by step. Thus for $\tau < t \leq 2\tau$

$$N(+) = N_0 + \frac{1}{2} W_0^2 V_0 (+-\tau)^2$$

$$X(4) = X_0 + V_0 T + \frac{1}{3!} W_0^2 V_0 (t-T)^3$$

etc.

Input

2.3.2 Numerical Integration- The Method of Steps gives a solution in the form of an infinite series. Since the result tells us nothing about the properties of the solution, nothing is lost if we numercially integrate (2.7). The following algorithm which uses the corrected trapezoid rule (IISI P.74) has $O(H^4)$ discretization error and has been implemented on the Pict Sigma 5 computer and the writers TISQ.

K, Vo, Xo, Ft, Fp, M, K, T, N

$$X_0 \leftarrow X_0 + (F_{+} + F_{0})/K$$

For i= 1 to N+1

$$X_{i} = X_{i-1} + V_{0} H$$
$$V_{i} = V_{0}$$

Continue

$$V_{i+1} = V_i - W_0^2 (H_2(X_{i+1} - H_1 + X_{i-H_1}) + H_{12}^2 (V_{i-H_1} - V_{i+1-H_1})$$

Write Vir,

$$X_{i+1} = X_i + \frac{H_2}{V} (V_{i+1} V_{i+1}) - \frac{\omega_0^2 H^2}{12} (X_{i+1-k} - X_{i-k})$$
$$\eta_{i+1} = X_{i+1} - F_{\mu}/K$$

Write Miti

Continue

2.4 Results - Figures (2)-(7) give the results of several runs with different initial conditions and parameters. Note that the results are consistent with tests of the 6 DOF system and also agree almost perfectly with the results of the analog simulation [1].

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III COMPENSATING FOR DELAY

It is hoped that most of the delay can be eliminated by suitable modifications in the hardware. Nervertheless even delays as low as 50 ms can cause noticeable instability. Therefore in this section we develop several algorithms that in some cases can produce near normal performance in spite of delay. Test results for some of the methods described below are given in Section IV.

3.1 Taylor Approximations

Since

(3.1)

$$X_{T} = X - T\dot{X} + \frac{T^{2}\ddot{X}}{2} + \cdots + (-1)^{h} \frac{T^{h}}{h!} X^{(h)}_{(A)} + T < d < 4$$

we can truncate the series and solve for an approximation x_c to x_{-i,e_1}

$$X_{c} \approx X_{+} + T \dot{X} - T^{2} \ddot{X} + \cdots (-1) \frac{1}{2} T^{n-1} X^{(n-1)}$$

with error $\mathcal{O}(\tau^*, x^*)$. We then solve.

$$\ddot{X} + w_0^2 X_c = 0$$

 $X(r) = X_0$

h = x - Fp/K

instead of (2.1).

3.1.1 Runge Kutta - In theory (3.1) can be solved for arbitrarily high n by the Runge Kutta algorithm without knowledge of high derivatives. For example if n = 4 (3.1) can be converted to the system:

$$\begin{pmatrix} X_{1} \\ X_{2} \\ X_{3} \end{pmatrix}^{l} = \begin{pmatrix} O & I & O \\ O & O & I \\ E_{T} & C_{1} & C_{2} \end{pmatrix} \begin{pmatrix} X_{1} \\ X_{2} \\ X_{3} \end{pmatrix}$$
$$\begin{pmatrix} X_{1} \\ X_{2} \\ X_{3} \end{pmatrix} (O) = \begin{pmatrix} X_{0} \\ V_{0} \\ O \end{pmatrix}$$

where

$$E_{T} := backwards chift
C_{1} := - 3!/T^{2}
C_{2} := \frac{3}{T} \left(\frac{3}{T^{2}} w_{0}^{2} + 1 \right)
X_{1} := X^{(1-1)} \quad i = 1, 2, 3$$

Writing (3.2) in the abbreviated form

and applying the Runge Kutta algorithm.

we obtain

$$X_{i+1} = X_i + H\left(\frac{K_{i1}}{6} + \frac{K_{2i}}{3} + \frac{K_{3i}}{3} + \frac{K_{4i}}{6}\right)$$

where

$$k_{1i} = X_i + \frac{H_2}{2} A Y_i$$

$$k_{2i} = X_i + \frac{H_2}{2} A k_{1i}$$

$$k_{3i} = X_i + \frac{H_2}{2} A k_{2i}$$

$$k_{4i} = X_i + \frac{H_2}{2} A k_{3i}$$

The difference between the above version of Runge Kutta and the conventional one for differential equations is that (because of the shift operation) k_i ; requires $q_{i-m} \cdot k_{2i}$, requires k_{i-m} etc. However, the effect this deviation has on the stability and accuracy of the algorithm is unknown and will require additional investigation. Higher order versions of Runge Kutta are also possible. They can be used alone or combined with equivalent Adams predictor corrector methods. If they work quite high order Taylor approximations can be easily generated.

3.1.2 The Algorithm "FIX*T4" - The following direct approach to (3.1) has been implemented and found to work well. We write.

....

$$\ddot{x}_{+} = \ddot{x} - \tau x^{(iv)}$$
$$x_{+}^{iv} = x^{iv}$$

By back substitution the present values of the derivatives can be eliminated. We finally obtain

$$X_{c} = X_{T} + \tau \dot{X}_{T} + \frac{T^{c}}{2} \ddot{X}_{T} + \frac{T^{3}}{6} \ddot{X}_{T} + \frac{T^{9}}{24} \times \frac{W}{7} + O(\tau^{5}, \chi^{(5)})$$

We can truncate the series obtaining second, thind on fourth order connections

The 4th order version, however, is as easy to implement as the others and more accurate

The algorithm is $O(h^{q}; \times^{n})$

<u>Remark</u> - The corrected trapezoid rule and the two estimates of $\ddot{x}_i - q_i, q_i$ are necessary to maintain accuracy. Warning - In a 6 DOF simulation

$$q_{i+1} = q_{i+1}^{c} = F_{i+1} = F(i+1) \Delta t$$

(The frame time $4\pm$ is the step). Also all delayed terms *, *, *, * etc. are the present values of *, * etc., generated in the hybrid (recall that the backward shift introduced into the algorithm simulates the loop circuit time in the 6 DOF system) With this in mind, we write the algorithm in a form suitable for implementation on the 6 DOF. Let $V_{i+1}, *_{i+1}$ be the velocity and position produced by the hybrid from F by integration. Let $V_{i+1}, *_{i+1}$ be the compensated versions. Then the main loop in (3.3) looks like

For n = m + 1 until satisfied:

 V_{int} = Integration of F

 x_{ini} = Integration of v

$$V_{i+1}^{c} = V_{i} - \omega_{0}^{z} \left\{ \frac{H_{2}(X_{i+1} X_{i+1}) + \frac{H_{12}^{2}(V_{i-1} - V_{i+1})}{T_{2}(V_{i-1} - V_{i}) + \frac{T_{3}^{2}}{T_{6}^{2}}(F_{i+1} - F_{i}) \right\}$$

$$X_{i_{11}}^{c} = X_{i} + \frac{H}{2} (V_{i} + V_{i_{11}}^{c}) + \frac{H^{2}}{2} (F_{i} - F_{i+1})$$

 $V_{i} \in V_{i_{11}}^{c}$ $X_{i} \leftarrow X_{i_{11}}^{c}$

(i.e., these values replace V_i, x_i in the next iteration of the loop)

Continue

In the remainder of the paper all algorithms will be written the form (3.3) instead of (3.4) and it will be understood that terms $*_r$ and their digital form $*_{i-m}$ etc. refer to present not past values of variables calculated in the hybrid.

3.2 Polynomial Extrapolation - Porter and Stoneman [12] (also see [13] have proposed the use of Newton-Gregory interpolating polynomials to compute X_c. Specifically they fit a polynomial to X_{n+1}-m, X_{n+1}-(m+4), ... X_{n+1}-(m+4) and extrapolate to compute X_c = X_{n+1}. Thus by the Newton-Gregory backwards interpolation formula

where

$$\nabla X_{n+1} - m = X_{n+1-m} - X_{n+1-(m+1)}$$

$$\nabla^{2} X_{n+1-m} = \nabla X_{n+1-m} - \nabla n_{n+1-(m+1)} \quad \text{efc}$$

No higher than a cubic should be taken. The procedure might begin with a 4th order Taylor method to compute enough x values beyond $[\circ, \uparrow]$ to fit the cubic. For example, the first cubic could be passed through $X_{m+1}, \dots X_{m+4}$, or through $X_{m}, \dots X_{m+3}$ etc. The best choice would be found experimentally. Since interpolating polynomials are extremely sensitive to noise, we suggest substituting a least squares polynomial of low degree based on as many previous points as possible. If we write the polynomial in the form.

$$P_{v}(x) = a_{v} + a_{1} x + \cdots + a_{v} x^{v}$$

and set $\overline{a} = (a_0, a_1, \dots a_n)$ \overline{a} is the solution of the system.

(3.6) Cā = F

where C is the V+lxV+l matrix with general component

$$c_{ij} = \sum_{\substack{p=m}\\p=m}^{p} f_{a}^{i+j-2}$$

where

$$\overline{h} = \begin{pmatrix} \sum_{i=1}^{e} x_{i} \\ \sum_{j=1}^{e} t_{j} x_{j} \\ \sum_{i=1}^{e} t_{i} x_{i} \\ \sum_{j=1}^{e} t_{i} x_{j} \\ e^{-m} \end{pmatrix}, \quad t_{i} := PH$$

and p is a preassigned integer.

Remark - matrix system (3.6) becomes poorly conditioned for large V; most machines will give meaningless results at V = 7 or 8. We recommend double precision arithmetic and V < 4.

Because velocities are available at the same time as the position function, anther choice would be to use this information and require that the polynomial pass through X_{n-m}, V_{n-m} ... etc. For formulas for this type of interpolating polynomial see [5] p62ff. The error is $O(H^{m+1})$ where m is the degree of the polynomial (e.g., 5 if three points are used.)

Remarks

- Although error terms for polynomial extrapolation schemes are similar to Taylor methods, their performance may be superior (particularly for the least squares version) since more information is used and sensitivity to noise is reduced.
- (2) Warning Neither method (or any other known to the author) will make the system stable for more than a short time. The high derivatives present in the error terms ruin the approximation as .

3.3 Transfer Function Approximation - The Laplace transform of \times_{τ} is $e^{\tau_4} \downarrow_{x}$. Therefore, it is tempting to find an approximation P(s) to e^{τ_5} and define

$$X_e R X = L^{-1}(P(4)e^{-Ts} IX)$$

= $J^{-1}(P(4)) = X_T$

Thus we solve.

(3.7)
$$\ddot{X} = -\omega_0^2 f'(P(q)) \wedge X_{\tau}$$

The advantage of this method is that if P(s) is properly chosen, (3.7) can be solved on an analog computer much more easily than it can be on a digital machine. This technique provided P(s) is "close" to e^{75} can be shown to be as good as polynomial extrapolation (see [13] p32ff).

Some Approximations for e^{r4}

3.3.1 <u>Chebyshev polynomials</u> lead to approximations which are much more accurate than Taylor polynomial approximations of the same degree.

Thus

(3.8)	e ^{T1} 3	. 994792 +	. 997396 74	+ . 541667 (T4) ² + . 177083 (T4) ³
(3.9)	(. 99 4571 -	. 9 4 7 3 6 F T S	+ · 5 4 2 9 9 / (T 1) ² + · 177 3 4 7 (T 1) ⁸
(3.10)	ŝ	. 99457(+	. 997308 74	T . 542591 (72) + . 177 347(15)

See Atkinson [2] Ch 4

The error of each of these approximations is less than $c \times 10^{-3}$ if $|\tau s| < 1$

Tests based on (3.10) have shown that it is generally superior to a fourth order Taylor approximation when there is no threshold and no preload. For a description of the resulting algorithm "FIX*C" see p below.

3.2.2 Pade Approximations - It is possible to approximate accurately by rational functions of equal degree in the numerator and denominator. The functions are called Pade approximations. Inverting them offers the advantage that numerical or analog differentation is avoided. Also Pade approximations are much more accurate than Taylor series approximations of equal degree. For example the 2nd degree Pade
(3.11)
$$\frac{1 + \frac{TS}{2} + (ts)^{2}}{1 - \frac{TS}{2} + (ts)^{2}}$$

coincides with the first five terms of the Taylor series of the sixth term is $(\tau^{s})^{s}/144$ which is close to $(\tau^{s})^{s}/120$. Hence this approximation is $O(\tau^{s})^{s}$.

The third degree

(3.12)
$$\frac{1 + r_{s}}{2} + \frac{(r_{s})^{2}}{10} + \frac{(r_{s})^{3}}{120} + \frac{(r_{s})^{3}}{120$$

is even better, it concides with the first seven terms of the Taylors series. Hence, if our previous discussion is correct these approximations should be similar to cubic and six degree polynomial extrapolation. Pade approximation can be further improved using Chebychev polynomials (See Ralson [17] p 296) Thus

$$(3.13) \quad e^{\tau t} = \frac{2353 + 1176 \tau 5 + 142(\tau 5)^2}{2153 - 1176 \tau 5 + 142(\tau 5)^2}$$

The error of the approximation for ITSICI is 0-10-4

Inversion of Padé approximations and appeal to (3.7) result in complicated integro-differential equations. For example the second degree Pade yields

Unfortunately all Pade approximations for have poles in the half plane. We conjecture that because of the short contact time this source of instability will not be of major imporance. <u>3.4 Richardson Extrapolation</u> - We finally mention a technique which can "boost" the degree of approximation when used in conjunction with the previous techniques; that is if the error term of a given method is $O(H^*)$ we will obtain by modifying the method an error term $O(H^{**})$

Suppose

(3.14)
$$X_c(H) = X + C(H^*) + O(H^{(WT')})$$

Having the step gives

$$(3.15) \qquad X_{c}\left(\frac{H}{2}\right) = X + \frac{c}{2}\left(\frac{H}{2}\right) \rightarrow O\left(\frac{H^{H+1}}{2}\right)$$

(The notation " X_c " indicates the dependence of the compensated position on the step h). Multiplying (3.14) by 2⁴ and subtracting 3.13 gives

$$2^{*} x_{c} (\frac{H_{2}}{2}) - x_{c} (H) \geq (2^{*} - 1) \times + O(H^{**})$$

Therefore

.

$$x = \frac{2^{*} x_{c}(\frac{1}{2}) - x_{c}(H)}{2^{*} - 1} + O(H^{**})$$

IV GRAPHS AND TABLES

KEY TO GRAPHS

In figures 2 and 3 the vertical scale is 1 cm = .01 ft. while in figures 4 and 5 it is 1 cm = .001 ft. In fig. 7 the vertical scale is 1 cm = .01 ft/sec.

In all position vs time or velocity vs time graphs the horizontal scale is 1 cm = .1 sec.

"1" signifies theoretical performance with the given parameters.

"2" signifies uncompensated performance.

"3" is FIX*C correction.

The dashed line in Figs. 6,7 is FIX*T4 correction.

"4" in Fig. 2 is performance with a thirty pound force threshold.

Fig. 2 shows the distorting effect of the force threshold (at two levels) with attempted correction.

Fig. 3 represents theoretical, uncompensated and compensated performance of an Apollo type probe with typical parameters.

Fig. 4 contrasts the performance and compensation for a preloaded vs non-preloaded probe.

Fig. 5 is similar to Fig. 3 but the probe has no preload.

6 DOF CONTACT DYNAMICS TEST RESULT (8/27-28/79)

Test involved vertical motion only and a .75" plywood target simulating the docking collar.

Ι.	V ₀ .05 .05 .05 .05	V_{4} .1927 .1907 .1971 .1730 V_{4} = .1884	8/29/79 F _t = 30 lbs.
II.	V ₆ .10 .10 .10 .10	V_{f} .1965 .2122 .2245 .2203 $\overline{V}_{f} = .2134$	8/17/79 F _t = 30 lbs
111.	Ve .1 .2 .2	V4 .2216 .3826 .4101	8/28/79 F. = 35

TABLE 1

THE EFFECT OF FORCE THRESHOLD ON REBOUND PARAMETERS

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V =.1 ft/sec. K=1200 lbs/ft M=310.56 Slugs ← =.15 sec

F _t	n - model	V ₄ - formula	V _f - Analog Simulation	V _f - Model
0	.0637	.159	.157	.157
20	.0668	.1666	-	.162
30	.0701	.1704	.165	.170
40	.0746	.1742	-	.171
60	.855	.1818	.182	.182
70	.978	.1850	-	.188
80	.984	.1896	-	.1968
90	.102	.1934	·	.1974
100	.112	.1973		.198
120	.127	.2048	.22	.223
240	.22	.2510	.312	.332

PROBE DEFLECTION PROFILE

η (ft)	F(lbs)
0	69
.125	74.8
.25	31
.417	89.3
.5	93.75
.625	101
.708	105.2
.792	112.5
.854	118
.88	121
.9	125
.911	130

For $\eta_{7}.912$ there is a bottoming spring with K = 480,000 lbs/ft

TABLE 3



COMPARATIVE CORRECTION BY 4TH ORDER TAYLOR METHOD (FIX*T4) AND CHEBYCHEV APPROXIMATION (FIX*C)

I F_p=O K=1200 LBS/FT M=311 SLUGS

TH	EORETICAL	UN	CORRECTED		FI	<u>X*T4</u>		FI	<u>X*C2</u>	
A $\gamma = .05$ V h .05 .025 .1 .051 .2 .102 .5 .255 1 .51	t 1.6 1.6 1.6 1.6 1.6	V: .0582 .117 .233 .58 1.16	h .0274 .053 .11 .274 .544	+ 1.65 1.65 1.65 1.65 1.65	V; .052 .1 .2 .3 1.00	n .05258 .051 .1 .256 .511	t 1.65 1.65 1.65 1.65 1.65	V _f .049 .1 .2 .499 .997	<i>h</i> .0256 .051 .1024 .255 .512	£ 1.7 1.6 1.65 1.65 1.65
Η _{-B} ~ =.1		V; .068 .135 .268 .67 1.33	Th .029 .0589 .118 .29 .59	4 1.7 1.7 1.7 1.8 1.8	v; .048 .0943 .2 .48 1.00	n .0257 .052 .2 .257 .52	- 1.85 1.8 1.7 1.85 1.7	<pre>V₄ .0499 .999 .195 .488 .976</pre>	h .0259 .052 .1 .26 .52	t 1.7 1.7 1.75 1.75 1.75
C 7 = . 2		V4 .0903 .180 .261 .902 1.81	ъ .0342 .0684 .137 .342 .684	t 1.9 1.8 1.8 1.8 1.8 1.8	<pre>V↓ .0976 .101 .190 .427 .95</pre>	4 .0274 .0576 .116 .276 .551	t 1/85 1.8 1.85 1.85 1.85	V _F .0471 .098 .188 .471 .98	7 .0272 .0545 .108 .272 .54	+ 1.8 1.8 1.85 1.8 1.8

TABLE 4

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t.

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COMPARATIVE CORRECTION BY 4TH ORDER TAYLOR METHOD (FIX*T4) AND CHEBYCHEV APPROXIMATION (FIX*C)

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II F =69 lbs K=60lbs/ft M =311 SLUGS

TH	EORETICAL	UN	ICORRECTED		. <u>FI</u>	X*T4		FI	IX*C2	
$A T = .05$ $V_{\bullet} \overline{h}$ $.05 .0055$ $.1 .0223$ $.2 .0869$ $.5 .468$	+ .45 .9 1.25 3.6	V; .0725 .125 .233 .536 1.04	7 .008 .027 .096 .491 1.44	t .6 1.05 1.9 3.70 5.05	V ₄ .0725 .12 .22 .53 1.06	и .0083 .0272 .096 .49 1.45	د .6 1.025 1.85 3.7 5.3	V ₄ .0718 .135 .23 .528 1.02	% .0081 2.73 .0967 .488 1.43	.6 1.1 1.9 3.7 5.1
III-26 B ↑ = . 1		V _f .128 .170 .269 .582 1.13	Ъ .01 .0295 .106 .514 1.48	t 1.1 1.3 2.1 3.9 3.4	<pre>V₄ .0949 .162 .268 .574 1.06</pre>	n .0106 .0225 .105 .5 1.45	t .75 1.1 2.1 3.9 5.3	V. .094 .147 .24 .55 1.04	Th .011 .032 .106 .506 1.45	.75 1.2 2.0 3.8 5.2
C 7 = . 2		V ₄ .129 .184 .288 .61 1.15	n .0155 .0422 .126 .56 1.57	+ 1 1.45 .225 4.0 5.3	<pre></pre>	й .0155 .0419 .124 .54 1.5	t 1 1.45 2.25 4 5.35	<pre>√+ .129 .173 .28 .574 1.09</pre>	\overline{h} .015 .0412 .122 .54 1.49	+ 1 1.4 2.25 3.9 5.35

 $F_{p} = 69 \text{ LBS } K= 60 \text{ LBS/FT} M = 311 \text{ SLUGS}$ $F_{\downarrow} = 30 \text{ LBS}.$ Ι $V_{f} = .163$ $V_{a} = .05$ II $V_{h} = .1$ V. = .227 III $V_{o} = .2$ $V_{f} = .33$

IV Ft = 35165

V4 = . 343 $V_0 = \cdot 2$

TABLE 6

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APPROXIMATE FORMULAS FOR A DELAYED SPRING

Assuming $\omega_{\bullet} \tau_{2} << i$ the following approximate formulas may be derived for the IVP:

 $\ddot{n} + w_0^2 n_r = 0$ $n(t) = v_0 t \quad 0 \le t \le r$ $\dot{n}(t) = v_0$

$$h(t) = N_0 / w_0 \exp(w_0^2 \tau t/z) \sin w_0 t$$

$$\overline{n} = V_0 / w_0 \exp(\pi \tau w_0 / 4)$$

$$V_F = V_0 \exp(\pi \tau w_0 / 2)$$

These formulas give relative errors of under 3%. If a force threshold is present then

$$V_{F} \approx \exp\left(\frac{\pi}{2} \omega_{0} r\right) \left(V_{0} + F_{r} r/2M\right)$$

TABLE 7

Ħ 11 ÷ 111 H 4.4 11 Ţ,Ē u lii 1.... ł; iu: H iΗ · 1200 163 Ę. 11 Шł -11 ţ. 1,1 Īŕ <u>F</u> Ħ ÷ 311 41455 41 Luc 115 i II Ţ άĘ), ÷. 111 1.11 11. 11 11 I HI 151 ŧĿ ÷. 11 1 . []] Ξ. ī. -F 14 2 Ē 71 Т Ц; 147 11. ÷. 1 L' Σ <u>د</u> ilļ. ΕÌ HILL 110 (j) 10 4. Н H 4 1 ēl; 山 .1 d: 1 j: 4 ili - II ٠. i. 16-1 間 11 1.1 :::[1.] . H 1 Ìti ÷. 14 11 ii; 1 :¢ 1 :: 1 $\frac{1}{1}$ Î 1111 Lt: 1 L. M. 3 ١. 11 'r 50 Ŧ 1 Ξh T T: 1 2 \mathbb{P}^{2} нÌ 1.11 17 2 Į. 11 11 ្នូភ្ È 10 ŀ ·i.. ;iii ÷. Į. ii. 1 []IT 9 15 - - -1.1 1 H i 2 • • ្សា .11 Filli 1 lin t. 1.14 ÷ 111 i, ШÌ . H T - 11 ġ. ŧ. ij. 41 4 htt 14 41 11 117 ĺ H 11 10 H n: L 間 T 1 Πţ 11 旧日 111 1 11 11 • J. 1.5 I 11 1..; 11 . Ţ 周围 ÷ T 11 111 :: Hil . i (| li. iin: ħΕ 1 111. Π. 1 1 dia di 1.1 li i 4015334 0 MOD 11

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詽 ΗĒ 1121 hh ÷ Ft/SEC Y :11 2 580 .1 - (300 Lujo M= 3/1 - 54055 $\mathbb{T}_{\mathbb{P}}$ E E ï <u>іц</u> ÷ 甘甘 K = - 1 i i l 1 ١Ţ. ġ. 111 1.: . 111 ï . Ťŀ: TT hij in i 1.11 t i i i 1 attra. T - .1 ÷, 111 49 1 11: ł Ťų. Πþ hi id:[Å lit a Ha ÷ЦЕ 4 į ... 1 Ţ 긝 p . . . <u>a di</u> h.H. 41. 154 t Hil 5 Ti H H ł łщ 1 :: . 11. 111 11 ÷È. 4. т. Т 1.11 围 titt ŧ. 1 (1,1). 1 ΞĒ 11 T 計師 ÷i. i. 1 ЩЦ! i. 1 <u>lu</u> ij 1 (1^{1}) 14 pe ee: $\mathbf{\dot{t}}$ 1 1 111 Kaser7 ! $\frac{k}{T}$ <u>.</u> 3 ŀ J ÷. . . - 1 ÷ į ij: į :___ ÷., 0 i: t di , d -|. 1 1.14 Φ_{1} ... þ. t <u>intr</u> ŧ. 11 1114 11 alte 1 Ŀ 4 111 19 HF. 1 111 da 94 HELLITI' HH 1949 11 H 111 ίŧ. be l 1E h 11 副 :11 11 П itri 110 94 r II H H H 11 ÷ ÷1 2 间出去 Fre ٠E j. 7 T H 12 1 1. Li (1 出日 闄 1 T. inter; 31' LINE •1

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V CONCLUSIONS AND RECOMMENDATIONS

The second order delay equation model developed in this paper agrees with a recent analog simulation [1] of the effect of delay. It is also reasonably consistent (See Table 6 with the observed behavior (up to noise) of the 6 DOF system when V_{\bullet} = .1 or .2. The most disagreement happens at V_{\bullet} = .05 when our simulation gives a rebound velocity about 13% below the mean of the measurements in Table 1.

The model predicts that for a pure spring with no preload or force threshold V_{4} /V, depends only on r and and not on V_{5} . V_{6} can also be computed quite accurately by a simple formula without numerically integrating the equation in the model. The use of а increase the effect of delay. The results are threshold relatively most severe at high threshold levels and low initial velocities. For thresholds under 100 lbs and delays less than .2 can be predicted with reasonable accuracy by sec V. an approximate formula. Verification of these aspects of the model in hardware tests would strengthen the hypothesis that delay is the predominate factor in the observed errors in the system.

These tests and the isolation of other factors - such as phase shifts due to the filters-should be possible when the noise of the system is reduced. Some of this noise is probably caused by the sensitivity of the force sensors on the table to inertial effects, and by variable delay due to the aysynchronization of the AD/DA converters (see 2.2.4-2.2.5 above). There may also be another source of apparent noise: for the parameters chosen to model the probe and a force threshold the rebound velocity changes rapidly towards the end of the simulation. If the rebound velocity is measured at $t_{\pm} + \gamma$ (cf. 2.2.3) an error of \pm Δ t in the time of measurement can produce a large relative change in V_s . For example when $V_1 = .2 V_s$ is .343; 033 sec later it is 354; 066 sec later it is.38, 066 sec before it is .32. Hence, slight differences in time of final measurement in repeated runs can cause variations close to the order of magnitude of those observed.

Every effort ought to be made to reduce noise and delay. Several means to this end are suggested in [1]. We agree with these recommendations. Since a delay as low as 50 ms still causes considerable errors and this may be close to an achievable lower limit, means of compensating for delay need to be implemented.

In this study both a fourth order Taylor method and a Chebychev polynomial approximation to the transfer function ℓ^{15} gave good results for for an unpreloaded spring when no force threshold is used. The velocity profile correction in this case was excellent; penetration errors were reduced to under 10% (most of the time less than 5%). The Chebychev algorithm "FIX*C" was the most accurate.

We regret however that neither algorithm works in the case of a preloaded spring, when the parameters model the probe tested in Table 1. Indeed its is remarkable that they hardly perturb the uncompensated position time profiles even when $\tau < .05$ sec. Their effects on an unpreloaded spring with a force threshold are more complicated but also unsatisfactory.

If these options are not satisfactory, a deeper mathematical analysis needs to be made on whether compensation of a preloaded system with delay is possible. On this topic the following rough observation seems appropriate. Since the difference between the compensated and the theoretically correct simple harmonic system is $O(\tau^n, X^{(n)})$ where π is the solution of the compensated system an n is the order of the method, the derivative $x^{(n)}$ may grow faster beyond $X= \times_c$ - than τ^n goes to zero. If this phenomenon occurs for all realistic compensation schemes it is doubtful that the 6 DOF system can simulate contact dynamics unless the delay is reduced far below 50 ms.

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APPENDIX I

INERTIAL NOISE AND THE FORCE SENSOR

The following is an attempted simulation of the effects of noise caused by the inertial forces of the table affecting the sensor. We integrate equation (2.8) (see § 2.2.5), thus representing a "shaking" of the sensor at each step in the movement of the table. Here the "noise parameter" ϵ is a uniformly distributed random variable taking values between 0 and either .5 or 1. The mass of the table is about 12 slugs so that the mass of the table and probe is 323 slugs. Note that the rebound velocities with the model exceed those observed. Parameters: F = 69 lbs K= 60 lbs/ft $\gamma = .2$ sec.

I. € =.5

A. $V_{6} = .05$

C. $V_0 = .2$

V4		V.
.1778	•	.395
.204		.4012
.2001		.383
.1967		.398

B V₀ =.1

V, .2773 .2525 .269

.2649

II. € =1

A. V. =.05

C. $V_{0} = .2$

Vŧ	V.
.2248	. 4434
.2186	.46
.2356	.4537
.2433	.4376

B. $V_{p} = .1$

V.						
•	3100					
•	3429					
	3828					
	3298					

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APPENDIX II

LIST OF PROGRAMS

All programs are in BASIC completely interactive and implemented on MFC's Xerox Sigma 5 system.

Name	Purpose
LAG*R	Simulates the basic delay model.
PSP*I	Theoretical spring with arbitrary initial conditions
FIX*C	Chebychev polynomial correction
FIX*T4	Fourth order Taylor method correction
LAG*N	Simulates the delay model with inertial noise

THE ALGORITHM "FIX*C"

Let $C_i := .994526$ $C_2 := .995682$ $C_2 := .543081$ $C_4 :+ .179519$

Set

 $X_{L} := C_{1} X_{T} + C_{2} X_{T} + C_{3} X_{T} + C_{4} X_{T}$

The following algorithm solves the IVP

 $X'' + w_0^2 X_c = 0$ $X(t) = X_0, \dot{X}(t) = V_0, \quad 0 \in t \leq T$

For i= 1 to m

$$V_{i} := V_{0}$$

$$X_{i} := i + V_{0} + X_{0}$$

Continue

For i = m+1 until satisfied

$$V_{i+1} = V_i - W_0^{2} \begin{cases} \frac{4}{2} C_i \left((X_{i-m} + X_{i+1-m}) + \frac{4}{2} (V_{i-m} - V_{i+1-m}) + C_{2} (X_{i+1-m} - X_{i-m}) + C_{3} (V_{i+1-m} - V_{i-m}) \end{cases}$$

+ $C_4 \left((Q_{i+1-m} - Q_{i-m}) + C_{3} (V_{i+1-m} - V_{i-m}) + C_{4} (Q_{i+1-m} - Q_{i-m}) \right)$

III−40

$$Q_{i+1} = - w_0^2 X_{i+1-m}$$

 $Q_{i+1}^c = - w_0^2 (X_{i+1-m} + V_{i+1-m})$

$$X_{i+1} = X_i + H/2 (V_i + V_{i+1}) + H^3/_{12} Q_i^c - (Q_{i+1}^c)$$

Continue

APPENDIX IV

ILLUSTRATIONS OF THE 6 DOF MOTION SYSTEM



SIX DEGREE-OF-FREEDOM MOTION SYSTEM





Fig 10

	POSITION	RATE	ACCELERATION		
			NO LOAD	23,000 LB. LOAD	
PITCH ROLL	+ 30°, -20° ± 22°	± 15°/SEC. ± 15°/SEC.	± 6.5 RAD/SEC ² ± 7.0 RAD/SEC ²	± 2 RAD/SEC ² + 1.6 - 2.0] RAD/SEC ²	
YAW	± 32°	± 15°/SEC	\pm 6.0 RAD/SEC ²	± 2.0 RAD/SEC ²	
VERTICAL	39 IN. UP, 30 IN. DOWN	± 24 IN./SEC.	± 1.6 g	± 1.0g	
LATERAL	±48 INCHES	± 24 IN./SEC.	± 2.4 g	± 0.6 g	
LONGITUDINAL	= ± 48 INCHES	± 24 IN./SEC.	± 2.0 g	± 0.6g	

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PERFORMANCE OF SIX-DEGREE-OF-FREEDOM MOTION SYSTEM . .

1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

PILOT SIGNALS FOR LARGE ACTIVE RETRODIRECTIVE ARRAYS

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Woolsey Finnell III

Preliminary Design Office

Electrical System Branch

Subsystems Design Division

PILOT SIGNALS FOR LARGE ACTIVE RETRODIRECTIVE ARRAYS

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ABSTRACT

It has been suggested that for large active retrodirective arrays, as in the solar power system, a two-tone uplink pilot signal with frequencies symmetrically situated around the downlink frequency be used in order to reduce ionospheric biases and to lower the cost since a two-tone receiver is economically much cheaper than a single-tone phase-locked receiver. Unfortunately such a system now faces the following well-known difficulties: (i) the π -ambiguity, (ii) a large phase difference between the downlink and uplink signals.

We show in this report how the π -ambiguity can be easily removed by using a two-tone uplink signal with both frequencies situated at one side of the downlink frequency, and the phase difference can be greatly reduced with a three-tone or a four-tone uplink pilot signal.

ACKNOWLEDGMENT

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I. Introduction

It has been suggested¹ that active retrodirective arrays^{2,3} would be particularly suitable as solar power satellite's antennas⁴ because they are inherently failsafe. The active retrodirective array works on the so-called phase-conjugation principle. It electronically points a microwave beam back at the apparent source of an incident pilot signal. Retrodirectivity is achieved by retransmitting from each element of the array a signal whose phase is the conjugation of that received by the element. In the satellite power system, the pilot source on ground may be situated at the center of a large rectenna and the retrodirective array is the space antenna in geosynchronous orbit.

Retrodirectivity can be most easily achieved if the uplink signal and the downlink beam have the same frequency. But due to input-output isolation problems, the uplink frequency is either upshifted or downshifted from the downlink frequency, a phase-locked receiver is used to achieve phase conjugation. When the uplink and downlink frequencies are different and because the ionosphere and transmission lines are dispersive, the conjugated uplink phase is no longer exactly equal to the downlink phase and the beam coherence at the rectenna can be lost. The downlink beam then points to wrong directions and this is known as beam squint.

A two-tone pilot uplink signal with frequencies symmetrically situated around the downlink frequency has subsequently been suggested. The two-tone uplink signal circumvents the beam squint problem. It reduces ionospheric biases and biases due to the dispersion of the transmission line. It also lowers the cost since a two-tone receiver is much

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cheaper than a single-tone phase-locked receiver. But, it introduces a new problem, known as the π -ambiguity, and the old problem that the conjugated uplink phase could still differ from the downlink phase by an intolerable amount remains. Raytheon, Boeing⁶, and Rockwell⁷ have all made further suggestions to remedy the problems. Their solutions not only are complicated and require much extra hardware in the already very complicated phase conjugation circuitry, but certain problems still remain.

In this report new designs of two-tone and multi-tone uplink signals with frequencies situated at one side of the downlink frequency are suggested. This method removes the above mentioned difficulties and does not require extra components in the phase conjugation circuit. We shall review in our next section the basic principle of phase conjugation and where the problems are in a symmetrically situated two-tone uplink signal. In section III we show how these problems can be circumvented with our new designs.

II. Difficulties With Symmetrically Situated Two-Tone Uplink Signal

A retrodirective array electronically transmits a microwave beam back to the apparent source of a coherent pilot signal. The beam radiated by self-phasing antenna may or may not be coherent across the aperture but it is coherent when it arrives back at the source. Retrodirectivity is the result of phase conjugation of the pilot signal received by each element of the array. Let the phase of the pilot signal of angular frequency ω received by the kth element of the array at time t be $\phi_k(t) = \omega(t - r_k/c)$ where r_k is the distance from the kth element to the source. We define the conjugate of ϕ_k to be

$$\phi_k^*$$
 (t) = $\omega(t + r_k/c) + \phi_0$

where ϕ_0 is an arbitrary phase offset but is constant over the entire array. The phase of the beam received from the kth element by a receiver located at the pilot source (r = 0) is, at time t,

$$\phi_{k}(t,0) = \omega(t + \frac{r_{k}}{c} - \frac{r_{k}}{c}) + \phi_{0} = \omega t + \phi_{0}$$

Thus the contributions to the field at r = 0 from various elements of the array are all in phase at that point.

In the above simple example the uplink frequency was chosen to be the same as the downlink frequency. This restriction is neither necessary nor desirable and is usually avoided because of input-output isolation problems. When these two frequencies are different, a phase-locked receiver is used. Retrodirectivity can still be achieved - provided that the propagating medium is nondispersive.

Due to the fact that single-tone phase-locked receivers are expensive and the ionosphere and transmission lines are dispersive, a two-tone uplink signal with frequencies symmetrically situated around the down-link

frequency was suggested and the average of the phases of the uplink tones be taken as a good estimate of the phase at the downlink frequency. Such a system lowers the cost and removes partially the difference between the uplink and downlink phases but it also introduces a new problem known as the π -ambiguity. We shall review here where these problems are. We shall use the ionosphere as an example to study the effect on the phase conjugation due to the dispersive property of the propagating medium.

The dispersion relation for ionosphere with $\omega > \omega_{p}$ is

$$k = \frac{\omega}{c} \left(1 - \frac{\omega \rho^2}{2\omega^2}\right)$$
 (1)

where c is the speed of light in vacuum, k the wave number, ω the angular frequency and ω_p is the plasma frequency. The plasma frequency ω_p is related to the electron density as

$$\omega_{\rm p}^{2} = \frac{{\rm Ne}^{2}}{\varepsilon_{\rm o}m}$$
(2)

where ε_0 is the vacuum permittivity, e the charge of the electron, m the mass of the electron and N is the volume electron density. From Eqs. (1) and (2)

$$k = \frac{2\pi f}{c} - \frac{Ne^2}{4\pi \varepsilon_0 fcm}$$

where $f = \omega/2\pi$ is the frequency. For a beam to transverse a path length L, the total phase change is

$$\phi = \int k \, ds$$

$$= \frac{2\pi f L}{c} - \frac{e^2}{4\pi \varepsilon_0} \frac{1}{f cm} \int N \, ds$$

$$= A f - \frac{B}{f} \qquad (3)$$

IV - 7
where $A = \frac{2\pi L}{c}$, $B = \frac{e^2}{4\pi\epsilon_0} \frac{1}{c m} \int N ds$, and $\int N ds$ is the columnal electron density.

With uplink frequencies situated around the downlink frequencies, we have $f_1 = f_D - \Delta f$ and $f_2 = f_D + \Delta f$ where $f_D = 2.45$ GHz is the downlink frequency. Using the notation of Eq. (3)

$$\phi(f_1) = Af_1 - \frac{B}{f_1} = \phi_1$$

$$\phi(f_2) = Af_2 - \frac{B}{f_2} = \phi_2$$

and

then the average of the two phases is

$$\overline{\phi} = \frac{1}{2} (\phi_1 + \phi_2)$$

$$= A f_D - \frac{B}{2} \left(\frac{1}{f_D - \Delta f} + \frac{1}{f_D + \Delta f} \right)$$

$$= A f_D - \frac{B}{f_D} (1 + \varepsilon^2 + \varepsilon^4 \dots)$$
(4)

where $\varepsilon = \Delta f/f_D$ is a small number. We may compare this phase $\overline{\phi}$ with the downlink phase

$$\phi_{\rm D} = {\rm Af}_{\rm D} - {\rm f}_{\rm D}^{\rm B}$$

e.g. their difference is of the order

$$\Delta \phi = | \phi_{\rm D} - \overline{\phi} | \approx \frac{B\varepsilon^2}{f_{\rm D}}$$

To estimate this difference, we shall assume

N ds =
$$5 \times 10^{17} \text{ electrons/m}^2$$

a rather large value for $\int N \, ds$ but taking into account for the possible worst condition. With $\Delta f = 50$ MHz, $\Delta \phi$ is estimated to be about 4°, which is not too small.

When we took the average of phases ϕ_1 and ϕ_2 in Eq. (4), there could introduce an ambiguity known as the π -ambiguity. Let

$$\phi_1 + \phi_2 = K(2\pi) + \Delta$$

where $0 \leq \Delta < 2\pi$ and K is a positive, zero or negative integer. Hence

 $\overline{\phi}$ = K π + $\frac{\Delta}{2}$

In performing the phase average, the KT term could get lost. For K even, no damage is done. For K odd a π error is introduced and one would conjugate the wrong phase.

In order to remove these two difficulties, especially the π -ambiguity, Raytheon⁵, Boeing⁶, and Rockwell⁷ have all made suggestions. Their solutions are very complicated and usually require a lot of hardware in the receiving and phase conjugation circuitries with much added cost. Furthermore, their soultions do not solve the problem completely. We shall show in our next section several simple solutions which circumvent the above mentioned difficulties and do not add extra costs.

III. New Designs of Pilot Beam System

In this section, several uplink designs are proposed. The first simple design avoids the π -ambiguity and the rest are improved versions of the first one. They are all free from the π -ambiguity but reduce the phase difference $\Delta \phi$ to various orders.

(i) This is also a two-tone uplink, but the two frequencies are both on one side of the downlink frequency with

$$f_{1} = f_{D} - \Delta f$$

and $f_{2} = f_{D} - 2\Delta f$ (5)

where f_D is the downlink frequency. We now let $\overline{\phi} = 2\phi (f_1) - \phi (f_2)$ to be the estimation of the downlink phase. With the notation of Eq. (3)

$$\overline{\phi} = Af_D - B \left(\frac{2}{f_D - \Delta f} - \frac{1}{f_D - 2\Delta f} \right)$$
$$= Af_D - \frac{B}{f_D} \left(1 - 2\varepsilon^2 + \dots \right)$$

where again $\varepsilon = \Delta f/f_D$ is a small number. In this simple design the π -ambiguity is removed since no division of the phase is used anywhere. The combined phase $\overline{\phi}$ is also a good estimate of the downlink phase ϕ_D . Their difference $\Delta \phi = |\phi_D - \overline{\phi}|$ is

$$\Delta \phi = \frac{2 B}{f_{\rm D}} \varepsilon^2 \tag{6}$$

which is of the same order as the one with two uplink frequencies situated symmetrically around the downlink frequency and is about 8° when the same values for $\int N \, ds$ and Δf are used as in the last

section. We also note that in this simple design no extra components are required in the receiving circuitry.

(ii) This is an improved version of the first design. It requires three uplink tones but it also greatly improves the accuracy in estimating the downlink phase $\phi_{\rm p}$. The three frequencies are

$$f_1 = f_D - \Delta f$$

$$f_2 = f_D - 2\Delta f$$
and
$$f_3 = f_D - 3\Delta f$$

We now let

$$\overline{\phi} = 3\phi (f_1) - 3\phi (f_2) + \phi (f_3)$$
(7)

to be the estimation of the downlink phase. With the notation of Eq. (3)

$$\overline{\phi} = Af_D - B \quad (\frac{3}{f_D - \Delta f} - \frac{3}{f_D - 2\Delta f} + \frac{1}{f_D - 3\Delta f})$$
$$= Af_D - \frac{B}{f_D} \quad (1 + 6\varepsilon^3 + \ldots)$$

where again $\varepsilon = \Delta f / f_D$. In this design, there is no π -ambiguity as before and the difference between ϕ_D and $\overline{\phi}$ is reduced by an extra factor ε , e.g. the difference $\Delta \phi$ is now

$$\Delta \phi = \frac{6B}{f_{\rm D}} \varepsilon^3 \tag{8}$$

With $\Delta f = 50$ MHz and $\int N \, ds = 5 \times 10^{17} \, \text{electrons/m}^2$, this difference $\Delta \phi$ is only about 0.5°, which is samll.

(iii) This version can be used in the event we would like to have an even smaller $\Delta \phi$ or we would like to use a larger Δf , which

would otherwise result in a too large $\Delta \phi$ even with a three-tone uplink design. These new specifications can be achieved at the expense of adding a fourth tone. The four frequencies are

$$f_{1} = f_{D} - \Delta f$$

$$f_{2} = f_{D} - 2\Delta f$$

$$f_{3} = f_{D} - 3\Delta f$$

$$f_{4} = f_{D} - 4\Delta f$$

and we now let

$$\overline{\phi} = 4 \phi(f_1) - 6 \phi(f_2) + 4 \phi(f_3) - \phi(f_4)$$
(9)
= $\Lambda f_D - B \left(\frac{4}{f_D - \Lambda f} - \frac{6}{f_D - 2\Lambda f} + \frac{4}{f_D - 3\Lambda f} - \frac{1}{f_D - 4\Lambda f} \right)$
= $\Lambda f_D - \frac{B}{f_D} \left(1 - 24 \epsilon^4 + \dots \right)$

In this design, the phase difference is reduced further by a factor $\epsilon,$ e.g. $\Delta \varphi$ is only

$$\Delta \phi = \frac{24B}{f_D} \epsilon^4$$
 (10)

With $\Delta f = 50$ MHz and $\int N \, ds = 5 \times 10^{17}$ electrons/m², this difference is only about 0.04°. Even with $\Delta f = 100$ MHz, this difference is only 0.66° which is still very small.

In all these three designs the uplink frequencies are all on the lower side of the downlink frequency and they are all equally spaced. These are not the only choices. One can use all frequencies on the upper side of the downlink frequency and they need not be equally spaced

either. As a simple example one may very well have a two-tone uplink with

$$f = f_{\rm D} + 2\Delta f \tag{11}$$
$$f = f_{\rm D} + 3\Delta f$$

and $\overline{\phi} = 3 \phi(f') - 2 \phi(f'')$. It will work just as well.

f

f

So far we have used the ionosphere as an example to show how the dispersion of the transmission medium could introduce sizable biases between the uplink and downlink phases. For a two-tone uplink signal, this phase difference is about 8°. We suggested one way to suppress it is to use a three-tone uplink. However, it turns out that if the biases were purely due to the ionosphere, it is really not necessary to use a three-tone uplink. This is because even though the phase difference between $\overline{\phi}$ and $\phi_{\rm D}$ in our two-tone uplink design is large, its variation from subarray to subarray will be decimal if not infinitesimal. To corroborate more on this statement, from Eq. (6) and the definition of B, the difference between the uplink and downlink phases from the pilot to the kth subarray for a two-tone uplink is

$$\Delta \phi_{\mathbf{k}} = \frac{2(\Delta \mathbf{f})^2}{\mathbf{f}_{\mathbf{D}}^3} \frac{\varepsilon^2}{4\pi\varepsilon_{\mathbf{O}}} \frac{1}{\mathrm{cm}} \int \mathbf{N} \, \mathrm{ds}_{\mathbf{k}}$$
(12)

where $\int N \, ds_k$ is the columnal electron density along the path from the pilot to the kth subarray. Since the horizontal dimension of the region of the ionosphere that would be transversed by the pilot signal to any subarray is very small, typically of the order less than 100 meters, the transverse variation of the total electron along a path of several hundred kilometers within a tube of diameter less than 100 meters would be very small. Hence even though $\Delta \phi_k$ is estimated to be about 8°, its variation is at least several orders less. Then with

the use of the phase from one of the subarrays as the reference phase, this difference $\Delta \phi_k$ can be subtracted out and the remainder be treated as a constant phase offset which has no effect on the retrodirective beam. In this sense, though the ionosphere is dispersive, it does not cause any problem, and a two-tone uplink is sufficient.

On the other hand, with the use of "central phasing" we cannot avoid the extra path length of transmission lines for some subarrays. Since these lines are not dispersionless, they will introduce a sizable phase difference. This phase difference can also be estimated. If we assume that this transmission line is a wave guide, its dispersion relation is well known

$$k = \frac{2\pi}{c} \sqrt{f^2 - f_{\lambda}^2}$$
(13)

where f_{λ} is the cut-off frequency. Hence the phase for any link is $\phi(f) = \frac{2\pi \ell}{c} \sqrt{f^2 - f_{\lambda}^2} \qquad (14)$

where ℓ is length of the transmission line. Just as before the phase differences for various uplinks can be calculated. For a two-tone, uplink with $\overline{\phi} = 2 \phi(f_1) - \phi(f_2)$, $\ell = 500$ meters and $f_{\lambda} = \frac{1}{2} f_{D}$, where f_1 and f_2 are given as in Eq. (5), $\Delta \phi$ is

$$\Delta \phi = |\phi_{\rm p} - \overline{\phi}| = 256^{\circ}$$

Similarly for a three-tone uplink with $\overline{\phi} = 3 \phi(f_1) - 3 \phi(f_2) + \phi (f_3)$, one obtains $\Delta \phi = 23^{\circ}$

For a four-tone uplink with $\overline{\phi} = 4 \phi(f_1) - 6 \phi(f_2) + 4 \phi(f_3) - \phi(f_4)$, $\Delta \phi$ is further reduced to

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As we see in this example, the phase difference for a two-tone uplink is very large but this number is greatly reduced in a three-tone or four-tone uplink. These multi-tone uplink signals can be used as a useful alternative method to suppress biases due to the dispersion of the transmission line and the medium.

IV. Conclusion

In our last section we illustrated how simple designs can be used to eliminate the π -ambiguity and reduce the ionospheric biases and biases from dispersive transmission lines. We also note that none of our designs require extra components in the receiving circuitry. All one is required to do is to obtain $\overline{\phi}$, which can be achieved rather easily, and simply conjugate it and use it as the phase of the downlink signal leaving the space antenna.

It is also important to remember that we are here to design a pilot beam system as simple as possible with the phase received by the array as close to the downlink phase as possible. We are not asked to and it is not necessary to determine the ionospheric electron density as required in some other designs.

Lastly our designs of pilot beam can be implemented easily in any large retrodirective arrays. Their advantages are (i) avoiding using phase-locked receiver (ii) free from phase ambiguity (iii) greatly reducing biases due to dispersion of the transmission line and medium (iv) very simple to be constructed.

It will be extremely interesting to have such a system built and tested in the very near future.

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ION PLATING STUDIES FOR HIGH TEMPERATURE APPLICATIONS

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A. Abstract

An experimental project was undertaken to ion plate by electron beam evaporation Al films onto 4340 steel substrates using (and at the same time troubleshooting) the custom built V.T.A. 7375 electron beam ion plating system. A careful recent literature and commercial vendor survey indicates possible means (reported herein) of improving the trouble plagued V.T.A. system.

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I wish to express appreciation to the National Aeronautics and Space Administration, the American Society of Engineering Education, and the University of Alabama for operating and supporting this summer program. Special thanks are due the Marshall Space Flight Center and personnel of the Materials and Processes Laboratory. I have enjoyed meeting many new people - some with a fascinating special expertise with whom further collaboration is expected. Everyone has readily offered their help and assistance. I have relied heavily on the clear, lucid lab logs and final reports of my predecessor, R. J. Holliday. Special thanks to Hobert Gregory and John McClure.

C, Introduction

Holliday¹² gave the following concise introduction to ion plating.

Since first being reported in the literature in 1963 (ref. 1), ion plating has progressed to the point that today it is used in several commercial processes including the aluminum coating of fasteners used in the manufacture of aircraft (ref. 2). Ion plating has several positive qualities. Probably the most important of which are outstanding film adhesion and deposition on all sides of the substrate (including coverage into cavities) whereas normal vacuum deposition gives the usual line-of-sight coverage. Other qualities obtainable, depending on the material deposited, include exceptional corrosion resistance, high film purity, fine grain structure, very low-coefficient of friction, and improved mechanical properties of metals (ref. 3-5).

Several articles have been published describing the ion-plating process (e.g., ref. 6 and 7). Basically the process consists of two phases. In the initial cleaning phase the object to be plated (substrate) is made the cathode of a dc inert gas discharge or plasma. Some of the inert gas atoms are ionized and accelerated towards the substrate. The bombardment of the substrate by these ions having high kinetic energy produces a clean surface preparatory to the actual plating process. In the plating phase the material to be plated is evaporated from the anode while maintaining the inert gas discharge. Some of the coating material atoms are also ionized and accelerated towards the substrate. These ions follow the electric field lines which terminate on all sides of the biased substrate and thereby help coat not only the front but all sides of the substrate. However, since the degree of ionization in many plasmas is very low (0.1-2%), it has been suggested that this mechanism is probably secondary to gas scattering of neutral atoms in contributing to the high throwing power of ion plating (ref. 8). Thus the energies of the impinging particles range from that obtained from ions accelerated by the potential difference between the anode and cathode to the thermal energy of unionized atoms. These factors, along with the heating of the substrate surface due to its continued bombardment, produce the graded-fused interface, which provides the superior adherence and improved mechanical properties characteristic of ion plating.

D. Objective

A Materials and Processes Laboratory objective is to have the capability to coat a wide variety of mechanical parts with a host of good-bonding protective thick (up to 40μ) films. Ion plating is well suited for providing good film bonding.

Electron beam evaporation of source materials provides a technique applicable to the widest range of materials, even the refractory metals which are vital to both high temperature rocket engines and to high temperature superconductors. However, most electron beam evaporation ion plating systems were not off the shelf but were custom built and debugged.

The immediate objective was to debug and put into smooth operation the trouble plagued (for its five year life) electron beam evaporation ion plating system Model 7375 custom built by Vacuum Technology Associates (now out of business).

E. Experimental Hardware

The ion plating apparatus used, V.T.A. Model 7375, was custom built by Vacuum Technology Associates and consisted of three main components: (1) The vacuum system, a Varian NRC 3117, attained an ultimate pressure of 10^{-6} torr using a 6" diffusion pump. (2) The electron beam gun system was a Sloan Multihearth 270° gun powered by a Sloan Model Five/Ten Power Supply. (3) The high voltage supply for the substrate bias was a 10 KV/500 ma unit made by Vacuum Technology Associates.

A typical ion plating apparatus is shown in Fig. 1.

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Figure 1. Ion Plating Apparatus with an Electron Beam Gun (D. G. Teer 1977)

F.1. Experimental Improvements Made

a. A brass cathode sample holder was removed from the system since brass was sputtercoating the substrate during precleaning and during ion plating. The chance of Zn contamination is thus reduced.

b. A cylindrical (5½ in. diameter by 3 in. long) grounded skirt extension was constructed which provides two inches of extra shielding to the top of the sample's support. This could reduce some of the above brass sputtering and efficiently concentrate the discharge near the sample substrate.

c. Due to modifications, the position of the sample holding rectangle may now be continuously located by a screw adjustment from direct contact with the cooled cathode plate to a position 5" lower.

d. Greater plating rates are anticipated as minimum sample substrate to hearth distances from about 4" to about 2". Some concern existed about reduced throwing power with the sample close; however, Hollidayll found no reduction in throwing power as hearth-substrate distances are reduced to from 5" to 3". The mean-free-path is in the several mm range so the transport is diffusion controlled.

F.2. Discussion of Recent Literature

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a. In a recent (Oct. '79) review article on ion plating sources, T. Spalvins¹⁶ mentions the following advantages of Wan's¹ hollow cylinder electron beam source:

- (1) It operates in the plasma.
- (2) It does not have the hot filament or the filament related problems.
- (3) It is easy to design and construct.

The main disadvantage is some contamination due to the cylinder sputtering into the substrate.

b. Ion plating by radio frequency induction evaporation is mentioned by Spalvins¹⁰. The source metal is placed in a ceramic crucible which is centered in the inducation coil. Frequency reduction by a factor of 1/6 to 75 MHz prevented coil arcing in the plasma.

- c. Rules for ion plating: 16
 - (1) Ideal conditions for ion plating include:
 - (a) Edge of cathode dark space is as close as possible to the boat.
 - (b) Dark space is as wide as possible.
 - (2) A cathode to anode distance of 15 cm is adequate to establish a glow discharge.
 - (3) A metal screen is used to coat plastics and insulators.
 - (4) Precleaning (surface oxide removal) is usually complete when the discharge current flattens out with time. It may take one hour for stainless steel.
 - (5) Bare wire should not be used to make high voltage connections according to Mattox.⁶
- d. References 19 and 20 are listed because they are recent.
- e. Discussion

The only reason which comes to mind for having a wide dark space is that the high electric field is only in the dark space and not in the plasma. The larger the dark space volume the greater the region from which to draw ions into the cathode substrate. If the boat to dark volume boundary distance is so reduced (the diffusion transport distance is small), the plating rate will be greater.

The metal shield stack (3" high x 4.5" diamter) is now recognized to have a detrimental effect since it acts as a Faraday (shield) cage around the hearth zeroing the E field needed to pull the positive ions to the substrate.

Even with the above stack shield removed, the top of the crucible is surrounded on 3 sides by a $1\frac{1}{4}$ " high by 3" wide magnetized rectangle having 3 sides $1\frac{1}{4}$ " above the top of the crucible (about 2" above the crucible bottom). This shielding could reduce the local electric field near the melted source enough to dramatically reduce the coating rate. The Sloan 270° evaporation hearth and gun were designed for vacuum evaporation and not for ion plating; thus, the irregular top profile is not unexpected. The shielding rectangle arms are magnetized and could not be ground down or removed without a magnetic compensation. Perhaps a large external Helmholtz coil could hopefully compensate and permit removal.

For both ion plating systems shown in ref. 9 and 10 the crucible cup top is flush with the flat baffle plate. Likewise in Teer's²¹ ion plating unit, nothing is shown higher than the hearth. The top of the hearth is flush with the flat baffle plate. See Fig. 1. The Heinz¹³ hearth is only slightly shielded by the horizontal gun.

The sparce $1/2 \mu$ coating on sample #11 could be due to excessive shielding of the source.

F.3. Vendor Search

On June 3rd letters requesting complete brochures with prices on electron beam evaporation ion plating systems and components were sent to all 16 vendors listed under Vacuum Coating Equipment on the <u>Science Instrumentation Index</u>. Not that a new system purchase is expected but that new components might be acquired for a much-needed upgrading of the V.T.A. system.

Denton Vacuum offered a complete unit with a DEG-801 Gun on the DIP-1 ion plating unit.

Hughes uses extensively, but rarely builds, ion plating units for customers. Mr. Cristy at 213/648-2345, Ext. 84369, may however be of help.

Nanotech* literature and prices just arrived listing a wide range of ion plating units with accessories. In fact they offer an option much like NASA's V.T.A. system except the e-beam gun is a Sloan 8 kW or 12 kW (costing about \$31,000) instead of our Sloan 5 kW. Unfortunately no gun mounting drawings were sent. Sloan no longer lists the 5 kW (Five/Ten) power supply. Since the V.T.A. system hearth is rated 12 kW it may be underpowered.

Inflicon Leybold-Heraeus responded indicating no ion plating systems for sale.

F.4. Films Plated

a. e-beam generated films.

All samples were #4340 hot roll steel disk one inch in diameter by 1/4 inch thick. Samples #3, #4, and #11 were

*Prestwich, Manchester M258WD England Phone: 061-773 8514

		Plasma	Back Front	1	Shield	1]	1		B) (B	(afa)	(ku)	1
Sample #	Coating Date	(µ Hg) P	(µm) Al Film Thickness	(in) Elect Spacing	Used Hearth? Cathode?	(mg) ∆m	Film Material	Front µ" Surf. Sm Subst.	r.m.s. oothness Film	KV (B	Time	Power	Comments
3	6 June	5	8 <u>+</u> 2	3-4	Not Cathode		Al Marz Grade	100	100	.3 (4)	-	-	Numbers listed are estimates
4	12 June		2.5	5-6	Hearth & Cathode	1	Brass Al	100	100	1 (200)	-	-	
11	25 June	24	<u>0</u> .5	-8	Cathode Top Collar Hearth	.3	Marz Al	5	5	1,5	17 (10- 35)	.5 to	
14	31 July	30	8	2	None	20	Marz Al	5	40	2 (20-5)	20		Resistance evap.
12	l Aug	30	12	2	None	14	Marz Al	5	30	3.5 (10- 20)	60		Resistance evap.

TABLE I (Accuracy ± 30%)

ion coated with Al during trial runs of the V.T.A. 7375 system. Samples #3 and #4 had surface roughness of ~ 100μ while #11 (12, 13 and 14) were polished to a ~ 5μ " smooth finish on one side. Film thickness on samples 3, 4, and 11 were ~ 8, 2.5 and .5µm respectively. Some direct evaporation was possible on #3 where the recorded pressure was in the 5μ range.

Sample #3 was mounted on a bare unshielded 1/2" rod. Sample #4 used the 5" cathode and grounded shield but was spaced away by about 3" by the brass interface. Sample #11 was flat mounted against the cooled cathode (to avoid heat induced blackening) and had an extra 2" of grounding skirt. Samples #4 and #11 also had a grounding cup shield around the hearth. Sample #11 had further shielding in the form of a brim ring around the cup top.

b. While the V.T.A. e-beam evaporation system was being repaired, the Denton resistance heated filaments were used to ion plate 8μ and 12μ Al coatings on samples #14 and #12, respectively. The unshielded sample cathode was screw mounted to a vertical 1/4" steel rod and positioned 2" above the filament.

c. Film surface roughness is several times greater than substrate roughness on samples #12 and #14.

d. The Al was M.R.C. Marz grade while the crucibles were Carbon EB-9 Union 76 (POCO).

F.5. Discussion

a. Samples #3, #4, and #11 were coated under exploratory conditions with the e-beam power being gradually increased. The cathode voltage was adjusted to prevent arcing in the chamber. The above variations plus the fact that only three films were coated suggests that only tentative conclusions should be drawn. The worst conditions (lack of shielding and close substrate source distance) gave the greatest film thickness.

b. Holliday¹¹ & ¹² and this author observed that their ion plated films were rather dull. Jones, Griffith, and Williams²³, ion plating on plastic, also found reflectivities reduced relative to vacuum coating, by about 2.5%, 10%, 18% for Au, Al, and Cu, respectively. Could the trace contaminants always present²² from e-beam evaporation hearth liners in vacuum plating Al account for the decrease reflectivity? Perhaps ion impact induced surface roughness makes the surface less specular (smooth). If one found that plasma cleaning on a 100% reflecting mirror surface causes loss of reflectivity in a lab experiment then the dullness in our films could be explained. The μ sized column film structure is common in ion plating and thus could easily account for the depressed reflectivities. c. The trouble with the V.T.A. system may be inefficiency due to lack of optimum adjustment and that troubles arise as increased high powers are used to compensate for the inefficiency. The Al was easily melted with .6 kW power (only 12% of the rated full power of 5 kW). The highest power recorded was 2.2 kW which was held for the last 5 minutes before the system blinked out 25 June. The Al melt temperature was considerably above the melting point. G.1. Suggested improvements which may be incorporated into the V.T.A. Model 7375 electron beam evaporation ion plating system are listed:

a. Baffle plate improvements

During the past two years previous prospective V.T.A. system users¹² designed a complex aluminum baffle plate using a small orifice which does an excellent job of providing the correct macroscope gauge pressure, both for the plasma above and for the filament chamber below the plate. The following further improvements are recommended for this baffle to lower further the filament pressure.

(1) Remachine this baffle totally from stainless steel instead of aluminum to match more closely the refractory materials (tungsten and molybdenum) in the Sloan e-beam gun. The present Al readily melts and evaporates around the Al orifice casting a direct shadow in the lower high vacuum region onto the gun and onto the high voltage electrodes causing shorts and arcs.

(2) Place stainless steel shim stock over the present Al baffle in the heat sensitive areas. This has been done.

(3) Bore a 1" diameter hole in the Al plate centered on the orifice hole. Machine a set of 7 stainless steel seats with orifice sizes 1/8, 3/16, 1/4, 5/16, 3/8, 7/16, 1/2. The smaller sizes would suffice for material which requires no sweep and would provide a higher vacuum around the filament.

(4) Use only a very small quantity of vacuum grease on the O-rings. Use only enough to give a wet look but not enough for the grease to be visible.

(5) A rectangular orifice may enhance the electron beam current while maximizing the gas flow impedance.

(6) The above rectangles could be continuously adjustable slits. If made of a bimetallic strip the adjust-ment would be automatic.

(7) Add extra fins and shields around the e-beam path to shield the exposed insulators from unintentional e-beam induced evaporation from around the orifice.

(8) The orifice could be placed with its axis horizontal at the top of the beam's arch, thus causing the gas to jet 180° away from the filament and anode, instead of the present 90° jet. A secondary advantage would be that more of the beam's path would be in the higher vacuum. A disadvantage would be increased coating around the orifice. (9) Again the orifice is only an ~!inch from the filament while the ion gauge is about 10" away. A gauge should be placed within an inch of the orifice with its short tube pointed toward the orifice jet to get the best indication of the filament pressure.

b. Improving other parts of the V.T.A. system other than the baffle plate:

(1) Place low melting point low vapor pressure materials on parts of the vacuum system for overheating indicators for sensitive components such as magnetic coils which must operate under 400 °C.

(2) Purchase at least all the parts listed on the suggested spare parts inventory (cost about \$2000).

(3) Add a shutter to shield initial volatile outgassing impurities from the substrate during the high vacuum soak of the crucible and source.

(4) In view of the manpower shortage connect a 4-pen recorder to the ion plating system to monitor the cathode voltage and current and the electron beam (emission) current. The fourth pen could monitor such quantities as sample temperature by thermocouple or magnet current.

(5) Dr. Arthur Nunes suggested using a focusing current ring (or an electrostatic ring) around the orifice to contact the beam to a finer thread to minimize orifice material evaporation.

(6) Apply the magnetic field sweep above the orifice so as to keep the orifice size as small as possible.

(7) Use a double hearth liner crucible stack with the inner crucible cut off to provide a lower target which should, because of greater insulation, rise to a higher temperature with less power to provide a higher plating rate.

(8) Entering the Ar leak from the bottom (instead of from the top) would cause some upflow which could enhance the transport of metal to the substrate increasing the deposition rate.

(9) Even with the cathode in its lowest position it is still ~ 6" from the hearth. Extending the substrate to the 2" to 3" range would produce a good enhancement in the deposition rate at no loss of throwing power according to Prof. Holliday's experimental data.¹¹ Suggested optimum distance for best ion plating is about six inches between substrate and source so some loss of adhesion may be expected. (10) Switch the two baffle O-rings to Viton to assure better high temperature performance.

(11) The V.T.A. 15 KV 500 ma cathode supply was found inoperative due to both a blown fuse and a blown milliampmeter. An 8 amp fuse was found necessary to withstand the current surges during critical arcing while providing some meter protection. This recently added fuse holder should be upgraded to a 15 KV rating.

G.2. Major additions to the V.T.A. Model 7375 ion plating system.

a. Acquire a "Balzers" e-beam gun and hearth which measures the positive ion current which is "proportional to the ion plating rate." Geometry dependent coating rates with ion plating are difficult to determine compared to vacuum evaporation.

b. Purchase an identical Sloan e-beam evaporation unit so that one unit may be refurbished while the other unit is in operation.

c. Use boronnitride-titanium diboride ribbon evaporator boats with resistance heating of Al as done by Walley and Cross¹⁴ in the article "An Aluminum Evaporation Source for Ion Plating." The electrodes must be water cooled and conducting graphite paper provides better electrical contact to the electrodes. This BN-TB₂ is cited in the Handbook of Thin Film Technology, page 1-47, as a crucible material sold under the name (HDA Composite Ceramic) by Union Carbide, New York, NY.

G.3. Conclusions

The V.T.A. system shows promise in that it operated for about a month with no major problems. The V.T.A. low coating rate will probably improve when the excess electrostatic shielding is reduced. However for quick ion plating of Al, Denton resistance evaporation unit is much more reliable.

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

STATISTICAL WIND PROFILE GUST MODEL

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STATISTICAL WIND PROFILE GUST MODEL

ΒY

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ABSTRACT

The purpose of this study is to develop a statistical wind profile gust model for the Space Transportation Operations and Trade Studies by using 1800 Jimsphere wind profile data collected at Cape Kennedy during 1965-1972. Wind profiles from the surface to 20 km in component form, i.e., zonal and meridional are processed through the digital filters of different wave length ranges based on the Martin-Graham cosine rolloff model. The residuals obtained from the filtering processes form the data base for the statistical analysis.

For each wind component the gust and gust length at a specified reference altitude in a residual profile are defined. A two-parameter gamma probability marginal distribution seems to fit well the component gust amplitude, and the gust length when redefined. The problem of finding an appropriate bivariate joint distribution of the gust amplitude and length remains to be solved.

The probability distribution of the modulus of the gust amplitudes has been derived under the assumption that they are independently distributed as gamma variates. It seems to fit the observed data.

INTRODUCTION

Accurate wind profile measurements from the surface of the earth to 20 km are made possible by the Jimsphere-radar system. This system consists of a 2 m diameter, constant-volume balloon and an AN/FPS'-16 or equivalent high precision radar which tracks the position of the balloon. The position data collected by the system are smoothened over a 25 m interval. The resulting data are differenced over 50 m intervals to produce wind profile data points.

This study utilizes 1800 wind profile data in component form collected at Cape Kennedy during 1965-1972. They are processed through the digital filters of different wave length ranges based on the Martin-Graham cosine rolloff model. The residuals obtained from the filtering processes form the data base for the statistical analysis (see Figure 1).

1.1 Definitions

Adelfang [1] in a recent report defines gust amplitude and length for a wind component in a residual profile at a specified reference altitude H_0 . For instance in Figure 2 the gust amplitude (gust) for the zonal wind component u' is defined as the maximum value of |u'| in the vicinity of altitude H_0 with like sign to u' at H_0 . The gust length L_u is defined as the altitude difference of the zero crossings on either side of the gust, i.e.,

$$L = H_2 - H_1 \tag{1}$$

where H_1 = altitude of the first zero crossing for the downward scan,

 H_2 = altitude of the first zero crossing for the <u>upward</u> scan.

Similarly, the gust amplitude and length are defined for the meridional gust component v'.

1.2 Purpose of the Study

One of the objectives of this study is to develop a theoretical probability gust model for each component as well as a joint model for both the components. Then the probability distribution of the modulus of the gust amplitudes can be derived.

GUST ANALYSIS

In statistical literature it is not uncommon to fit a gamma probability



Figure 1. Cape Kennedy Residual Profiles

VI-4



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model to a climatological measurement. However, when more than one random variable is involved, it is not yet clear whether or not a particular species of several multivariate gamma probability distributions is adequate to describe the behavior of random variables under consideration. This difficulty stems from the fact that any given univariate marginal distributions do not uniquely determine their joint probability distribution. If one marginal of a component of a random vector happens to be different from that of another component, e.g., gamma and beta, then the complexity of reconstructing their joint distribution increases.

2.1 Gust Amplitude

Adelfang [1] has shown that the gust amplitude of any wind component at a given reference altitude for filters of different wave length ranges seems to be distributed as a two-parameter gamma distribution and the fit seems to be good. A gamma probability density of a random variable x is here defined as \checkmark \checkmark \checkmark

$$f(x) = \beta x^{-1} \exp(-\beta x) / \Gamma(Y), \quad x \ge 0, \quad (2)$$

where scale parameter β and shape parameter \forall are positive and estimated by the maximum likelihood procedure as in Thom [3]

$$\hat{\beta} = \hat{\gamma} / \bar{x}$$
(3)

and

$$= \{ 1 + (1 + 4A/3)^{\frac{1}{2}} \} / 4A_{3}$$
(4)

$$A = ln(\bar{x}) - \overline{ln(x)}, \qquad (5)$$

2.2 Gust Length

Although the gamma and truncated normal probability distributions seem to fit fairly the data on gust length, a pronounced bimodality appears to persist in the observed frequency distribution of the gust length. Therefore, there are two options to pursue:

- 1. To fit a mixture of two distributions
- 2. To redefine the gust length and hopefully avoid bimodality.

Since the first option involves computation of more parameters and analytical complexity, a redefinition of the gust length is in order. Instead of defining the gust length as the distance between two successive zero crossings, it can be defined as the length of the interval containing the reference altitude H_0 , whose end points form successive extrema of the wind profile. In Figure 2, the distance from A to B is the new gust length for u' and the distance from C to D is the new gust length for v'.

It is encouraging to find that newly defined gust length seems to fit a gamma probability distribution without exhibiting any bimodality. It is premature at present to accept this observation without further investigation.

2.3 Joint Distribution of Gust Amplitude and Length

Once it is assured that the gust length follows a gamma model a search for an appropriate bivariate gamma distribution should be made for the gust amplitude and length. Three bivariate gamma distributions are given in Mardia [2], p. 88. When the shape parameters of gamma marginals are almost equal, the first bivariate distribution involving a modified Bessel function may be considered. Because of the restriction, namely, $y \ge x$ imposed on the third distribution, it cannot be employed in fitting the gust amplitude and length.

2.4 The Modulus of the Gust Amplitude

Since it is found that the correlation between the gust amplitudes of the components u' and v' is less than 0.2, the maximum of modulus

$$R = \{ (u')^2 + (v')^2 \}^{1/2}$$
(6)

can be derived from the gamma marginal of the gust amplitudes under the assumption that they are independently distributed. In fact, the probability density of R is:

$$\frac{1}{4} \frac{\beta_{1}^{Y_{1}} \beta_{2}^{Y_{2}} R^{Y_{1}+Y_{2}}}{\Gamma(Y_{1}) \Gamma(Y_{2})} \sum_{n=0}^{\infty} \frac{(-\beta_{1}R)^{n}}{n!} \sum_{m=0}^{\infty} \frac{(-\beta_{2}R)^{m} \Gamma(Y_{1}+n) \Gamma(Y_{2}+n)}{m!} \Gamma(Y_{1}+Y_{2}+n+m+2)$$
(7)

where all parameters β_1 , β_2 , γ_1 , γ_2 are positive. This has to be validated by the data.

2.5 Sum of Two Adjacent Amplitudes

Denote the amplitude of the zonal component at the reference altitude H_0 by |u'| and the amplitude just above by $|u'_2|$. Then it has been found for a set of data that the correlation between them is in the vicinity of 0.5. However,

the observed data on their sum $|u'_1| + |u'_2|$ seems to fit a gamma distribution. (Similar observation may be true also for the other component.) It raises a theoretical question: When is the sum of two correlated gamma random variates distributed as a gamma?

CONCLUSIONS AND RECOMMENDATIONS

This report presents several unanswered questions to which answers have to be sought. It is, with reasonable assurance, seen that the gust amplitude follows a two-parameter gamma distribution the probability model of the newly defined gust length seems promisingly to be a gamma distribution.

The joint distribution of the gust amplitude and length, and the distribution of the modulus of gust amplitudes need to be explored. In fact finding the joint distribution of the gust amplitudes and length, of both the components should be the ultimate goal. One realizes that there are many loopholes in this investigation, but it is hoped that by this time next year the statistical model for the gust is resolved.

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

UPGRADING THE FREE FLYING RENDEZVOUS AND DOCKING SIMULATOR AND THE ORBITAL SERVICER SYSTEM

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UPGRADING THE FREE FLYING RENDEZVOUS AND DOCKING SIMULATOR AND THE ORBITAL SERVICER SYSTEM

ΒY

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ABSTRACT

The objective of the research was to make recommendations for upgrading two teleoperator/robotics test and simulation systems based upon a review of latest technology advances in the involved disciplines. The Free Flying Rendezvous and Docking Simulator has two vehicles, the Free Flying Mobility Unit and the Free Flying Target Assembly, operating on air pads on the air bearing epoxy flat floor. The Orbital Servicer System has a six degrees-of-freedom manipulator arm for transferring modules between the Orbital Servicer and a prepared satellite.

Based on the research, a new second-generation Free Flying Mobility Unit is It will add a sixth degree-of-freedom and incorporate other recommended. improvements which will greatly expand the Center's capability to perform evaluation tests and demonstrations of advanced systems concepts for rendezvous and docking in support of the Teleoperator Maneuvering System (TMS) Program. Current plans for the TMS call for a technology readiness in 1985 for placement and retrieval of a satellite/payload in a predetermined orbit with the TMS moving from and returning to the Shuttle Orbiter. The second generation Free Flying Mobility Unit will incorporate TMS design features which will enable it to perform realistic simulations for evaluating rendezvous concepts, ranging sensors, lighting and video systems, and docking mechanisms. At a later time it will incorporate advanced technology features for future TMS missions and will be invaluable in defining the requirements and evaluating promising concepts for automated rendezvous and docking.

The Orbital Servicer System provides the capability for testing and demonstrating concepts for on - orbit servicing of compatibly designed satellites/payloads. The TMS will be the transporting vehicle for the servicer. The manipulator arm of the Orbital Servicer System is presently computer controlled in the trajectory portion of the module transfer operation. The ultimate objective is to fully automate its operation having the manipulator arm move from its stowed position, latch on to a mock-up faulty module, remove the module and stow it in the base of the servicer, latch on to a replacement module, place it in the satellite, and having the manipulator arm return to its stowed position. This will require additional capabilities in several fields basic to robotics research. These include sensors, artificial intelligence, image analysis, communications, computer programming, pattern recognition, kinematics and manipulator design. It is recommended that the Electronics and Control Laboratory move to acquire the basic competencies in robotics necessary to achieve the major objective of full automation.

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INTRODUCTION

The Free Flying Rendezvous and Docking Simulator consists of the Free Flying Mobility Unit and the Free Flying Target Assembly both of which operate on the air bearing epoxy flat floor. The two vehicles are mounted on air pads which provide frictionless motion in one plane for simulating translational movement in space. Simulated propulsion is provided by compressed air jets under the control of the remotely located operator. The simulator is illustrated in Figures 1, 2, and 3 and described in reference (1).

The simulator is an engineering tool used to define, test, evaluate and demonstrate the rendezvous and docking techniques and procedures, and the components and systems designs needed for rendezvous and docking a remotely controlled teleoperator vehicle with a satellite payload. The data recorded include air consumed (measure of fuel consumption), time to dock, docking success, lighting patterns and camera positions. The evaluation and test data influence the selection of the most promising concepts and designs and the refinement of them for potential use in future projects.

The Orbital Servicer System is an engineering model of an on-orbit maintenance system. It contains full-scale typical satellite replacement modules which are exchanged by the six-degree-of-freedom manipulator It also includes the interfacing control system for the manipulator arm. The Servicer System model is used to test, evaluate, and demonstrate arm. the on-orbit maintenance concept and to define design features that would enhance its performance. At present (1980), the operation is partially automated. A computer program controls the teleoperator arm trajectory movement until the module is close to its destination. Then control is transferred to the human operator who completes the module transfer. He operates from a remote location using video cameras and manual controls. The servicer is illustrated in Figure 4 and described in references (2) and (3).

One of the key questions concerning the Orbital Servicer is whether the teleoperator arm can be fully automated to eliminate the human operator (man-in-the-loop). There are advantages and disadvantages to each alternative and strong advocates on each side. A major purpose of the Orbital Servicer System is testing the feasibility of the fully-automated transfer.



FIGURE 1. FREE FLYING RENDEZVOUS AND DOCKING SIMULATOR



FIGURE 2. FREE FLYING MOBILITY UNIT



FIGURE 3. FREE FLYING TARGET ASSEMBLY



FIGURE 4. ORBITAL SERVICER SYSTEM

OBJECTIVES

The first research objective is to recommend design improvement for the Free Flying Rendezvous and Docking Simulator based upon a review of latest developments in associated disciplines. The subsidiary objectives are:

1. A 6 DOF Free Flying Mobility Unit which could be either a modification of the existing 5 DOF vehicle or a new vehicle.

2. Automatic docking capability.

3. Alleviation or elimination of some current limitations including:

(a) Reliability and maintenance problems with existing equipment.

(b) Physical balance of the current equipment, i.e., stability in pitch and roll.

The second research objective is to recommend design improvements in Orbital Servicer System based on review of latest developments in appropriate disciplines. Subsidiary objectives are:

1. Automated fast servicing of a class of satellites by robotic arm from the Orbital Servicer vehicle.

2. To review the proposed new electrical self-aligning connector design.

3. To suggest improved methods of rack positioning.

METHOD OF INVESTIGATION

The following methods of investigation were used:

1. Literature search.

2. Material and information from the NSF Robotics Research Workshop held April 15-17, 1980, at the University of Rhode Island and from personnel at the McDonnell Aircraft Company (part of McDonnell Douglas Corporation in St. Louis, MO).

3. Observation of the Free Flying Rendezvous and Docking Simulator and the Orbital Servicer System.

- 4. Discussions with MSFC personnel.
- 5. Sketches and calculations.
- 6. Review of previous and associated work.

SYSTEMS INTEGRATION

NASA Headquarters has assigned MSFC the mission of "Systems Integration" or the co-ordination and interfacing of teleoperator/robotics sub-systems and components into an effective total system to support future NASA programs. The term "System Integration" also connotes optimizing the effectiveness of the system while using scarce resources efficiently.

The two lab facilities, the Free Flying Rendezvous and Docking Simulator and the Orbital Servicer System, are essential for evaluating and demonstrating the integration of the functions and the system performance in a simulated space mission. The full-scale dimension provides the experimental setting necessary for accurate test and evaluation. Scale models can be helpful but there are too many possibilities for discrepancies between actual mission systems and part-scale simulators to permit complete reliance on the part-scale model. Computer modeling and simulation can be efficient and time-saving; however, their results require full-scale physical verification because of the possibilities of conceptual errors and data omissions and inadequacies.

BASIC ROBOTICS RESEARCH OVERVIEW

This section will be devoted to a discussion, necessarily brief, of several fields of basic robotics research pertinent to the main objectives of full automation of the Orbital Servicer Teleoperator System and to upgrading the Free Flying Rendezvous and Docking Simulator.

The following research areas are fundamental to advanced teleoperator and robotics development:

1. Artificial intelligence

2. Sensors

- 3. Kinematics
- 4. Control
- 5. Communications

- 6. Manipulator design
- 7. Image analysis
- 8. Locomotion

ARTIFICIAL INTELLIGENCE

Artificial intelligence is the branch of computer science which studies the way machines can replicate human actions requiring intelligence. It involves receiving and evaluating environmental data and making a decision based upon the data and a set of decision criteria. At an advanced level, the machine can learn from experience and adjust its behavior accordingly. Artificial intelligence is necessary for any teleoperator or robot which has an operation which is not completely and undeviatingly predetermined.

Systems have been developed which will perform at least one but never all of the following: (4)

(1) Plans can be generated at multiple levels of detail.

(2) Plans can be viewed as partially ordered sequences of actions with respect to time.

(3) Each action is expected to produce a single state change characterized by a single primary effect.

(4) A plan is not generated at all unless the planner determines that it will be totally successful in meeting all specified goals.

(5) Simple plans requiring information gathering can be generated.

(6) Unsophisticated techniques for dynamic repair of unsuccessful plans during execution have been developed.

(7) Plans can be used to control robot devices with simple use of sensory feedback and systematic replanning.

Major research problem areas in intelligent robots are: (4)

1. Planning for parallel execution

2. Planning for information gathering

3. Planning for planning

4. Learning: Using a plan data base

5. Interactive planning

6. Dynamic plan repair

7. Distributed robotics (i.e., disbots)

a. Hierarchal planning

- b. Control
- c. Basis
- d. Communication
- e. Plan execution

The central problem of robotic intelligence in the real world is that a robot may have a large number of alternative actions, but the user does not want to be burdened with specifying them and the computer is too busy to compute them anyhow (5). -----"Intelligence and decision making" usually mean the ability of a robot to sense some aspect of its environment and take alternative courses of action.

SENSORS

A sensor is a device which collects data from the environment for transmission to the robotics command system. An important research issue in robotics is sensory control in which the sensor is the first link in the chain which finishes with the completed robot action. Fast and accurate sensing is essential to reaching the goal of fully automated space robotics (6).

Among the research areas to be addressed are:

- 1. More capable visual processing
- 2. Faster visual processing
- 3. Better dynamic models of arms
- 4. Tactile and force sensors with desirable characteristics
- 5. Better understanding of the role of compliance

Visual sensing is important in space applications. Some needed improvements are (7):

- 1. Higher resolution, dimensional density and precision
- 2. Improved pixel (i.e., picture element) quality
- 3. Color discrimination
- 4. Better lenses
- 5. Better cameras
- 6. Increased robustness
- 7. Controlled illumination
- 8. Software development
- 9. Range and proximity sensing

Sensor types which have negligible usefulness for space functions are tactile, force, acoustic and temperature.

Radar as a sensor has advantages and disadvantages. The distances involved may be too short to permit radar to function properly. Even more difficult is the problem of interfering reflections from structural components of the system. These reflections will prevent the system from receiving clear and accurate readings on the position of any system component.

However, some current and research in radar may facilitate using radar in fully automated orbital servicer. It has the capability of rapid location of an object and determination of its velocity and direction of movement provided the reflection problem can be solved.

Video cameras produce a good picture for the human operator. The major problem is automated image analysis of the picture. (Image analysis is the conversion of visual pictures such as video to a set of impulses which can be processed and interpreted by a digital computer). The human operator is much better at analysing the video picture and taking appropriate action than is an automated system.

Lasers may be the best sensors for space robotics applications. Much additional research is needed. Light-beam sensors (photoelectric cells) can not produce the detailed image needed. Acoustic sensors lack the medium to transmit sound wave. Contact sensors would require delicate, easily-damaged antennas and would probably be unable to gather enough environmental data to be useful.

Sensors present several robotic control problems such as data filtering and smoothing, multidirectional sensors and data acquisition. Control structures, particularly hierarchical, and control logic need further work. The man-machine interface requires additional development (12).

KINEMATICS

Kinematics and mechanical design refer to the static and dynamic relationships of the physical components of the teleoperator manipulator system. Examples are mass, velocity, momentum, strength and deflection. Correct handling these factors is vital to successful teleoperator and robot operation. Several important research areas remain.

Kinematic preformance can be either time-based (velocity and acceleration) or geometric-based (space and orientation). Further work is needed in both areas (8). This effort should get away from position-byposition analysis to a broader knowledge which eliminates the need for the detailed position approach. A general solution to the optimal number of degrees-of-freedom has yet to be resolved. More DOF produce greater flexibility and versatility; fewer DOF produce a system easier to design and control, cheaper to build and generally more reliable.

Some robotic configurations are more efficient than others. However, the knowledge about these configurations is empirical rather than theoretical. Among the research questions to be resolved are:

1. The optimal manipulator configuration for flexibility, dexterity and reliability.

2. Actuator placement and control.

3. Basic design theory for fluid and electrical actuators.

4. Increasing the number of design parameters which can be rationally chosen given the present state of the art.

5. Elimination or minimization of elastic vibration due to system resonance.

6. Coping with large inertial forces at high speeds.

Another practical design problem is that robot and teleoperator performance fall short of theoretical optimum. Some causes are mechanical interference by structural members, limited rotational range and the mass of components particularly the motors (8).

Speed of operation of robots is vitally important to industrial applications, but less so to space applications. High-speed dynamic effects become critical yet little is known definitively about these effects. Present manipulator configuration design and trajectory are not the best for high speed operation. More needs to be done (9). Three difficulties with high-speed operation are:

1. Non-linear dynamic effects

2. Structural flexibility

3. Discrete time increments resulting from micro-computer controls produce undesirable effects.

Some modifications of manipulator design may be necessary to make the design compatible with automated operation. Present plans are based on the assumption that full automation can be achieved by rewriting the control computer program. This may or may not be a valid assumption. At the very least, the manipulator design should be reviewed for compatibility with full automated control.

CONTROL

Control theory is the branch of engineering and science which deals with monitoring and direction of the teleoperator to achieve the desired result. Control theory has two facets:

1. Systems study and modeling and (2) measuring (sensing) the states of the system. System and task modeling are essential to advanced robot control development. Modeling can be defined as quantitative descriptions of the system and tasks in measurable, calculable and controllable terms.

Among the research issues are sensitivity studies of the model, robot control in feedback schemes and multi-unit robotic systems (10).

Four assumptions of robotics control theory are:

1. Robots are complex articulated mechanical devices designed to perform operations normally requiring human skills.

2. Robots are equipped with sensors capable of measuring internal and external states.

3. Robots are equipped with computers.

4. Humans can communicate with robots.

Paul discusses control applied to robotic operations in space. He postulates 6 DOF with either velocity or force but not both specified along each DOF. He also discusses kinematic control and Jacobian control. Each method has advantages (11).

Graupe and Saridis hold that technological advances of the last fifty years depended upon development of system theoretic methodologies (14). Intelligent control uses the digital computer along with advanced techniques of system theory to produce a unified engineering approach. Based on this, control systems for robotic tasks and systems have been developed for prosthesis and orthotic devices and for general purpose robots. They propose a hierarchally intelligent control approach distributed according to "decreasing precision with increasing intelligence." The levels would be:

- 1. Organization
- 2. Co-ordination
- 3. Hardware Control

Present computer-based systems for robot control require the program to direct all movements and actions of the robot. A specially-designed computer language may be used although some programs are in a standard language such as Fortran. The program can include provision for receiving external stimuli and directing action based on the stimuli received. However, there is no provision for stimuli not in the program or for unprogrammed reactions no matter how desirable (15). Libraries of sub-routines can be developed since the programs can be independent os specific locations. The number and usefulness of sub-routines handling contingencies, errors and emergencies has increased.

The major deficiencies of the second-generation programmed robotic systems are (15):

1. The programs are difficult to debug and modify.

2. Achieving the final position with maximum accuracy is inefficient.

3. It is difficult to foresee all possible emergencies and contingencies. This is particularly important in the Space Shuttle - Orbiter Servicer system. In the next (third) generation of computer robotics control systems, the robot will formulate an appropriate plan of action based on goal directions received from the operator. The robot will have greater artificial intelligence capabilities and much more data than it needs with the present computer program motion direction system. Research on this system is now underway (1980).

The elementary "Pick-and-place" robotic systems are relatively easy to design, program and implement. Many industrial robots are in this category. However, they are unable to handle effectively and reliably events and environments which deviate even slightly from the environment for which the program was designed. However, as the program is modified to handle environmental variations, the complexity of the problem domain and the resulting program increase many-fold (13).

COMMUNICATIONS

Communications will be a major robotics design problem. Data impulses from sensors must be transmitted to the control computer and instructions sent from the control center to the teleoperator components. Another major R&T issue is the computer languages and control algorithms needed for full automation. This is inextricably interconnected to the determination and optimization of the desired operating characteristics.

IMAGE ANALYSIS

The role of image analysis will be the identification and location of the components of the shuttle and the servicer. These components include:

1. Structural components of the Shuttle.

2. Structural components of the Servicer.

3. Alignment of the space vehicle (Servicer and satellite) during docking.

4. The modules at the beginning, during, and of the end of the transfer process.

5. Alignment of the rack which will receive the module.

6. Any component out of its regular position to the extent it might cause damage.

7. Any stray object in a position to cause a collision.

Image analysis is a particularly difficult field in robotics research and application. The processes by which a human operator's mind receives signals from his sensors, and evaluates, interprets and identifies the object seen, its location and its orientation are incredibly complex. Performing these processes automatically has been done only in simple situations with great difficulty.

Basic research in image analysis is going forward. Further progress is essential to the full automation of the Orbital Servicer Teleoperator.

LOCOMOTION

Locomotion is defined as movement of the robot over an irregular terrain surface. This contrasts with space travel in which the robot has no terrain contact. At a cursory glance, locomotion has little to do with the NASA Space Shuttle and Orbital Servicer missions. However, some locomotion research results have application to the simulation of rendezvous and docking operations. Furthermore, locomotion could become important to the MSFC robotics efforts if the mission is changed to include mobile robots for space applications.

THE FREE FLYING RENDEZVOUS AND DOCKING SIMULATOR

The present Free Flying Rendezvous and Docking Simulator uses aging equipment of limited capabilities. The two vehicles were assembled partly from surplus and scrounged components. They require considerable maintenance with increased down time and decreased capability. Further, the data output is limited in comparison to the data potential of a simulator with better equipment and instrumentation.

Second - Generation Free Flying Mobility Unit

A major research and policy question is "Should NASA build a new, second-generation Free Flying Mobility Unit or should it rebuild and improve the present vehicle?" In either case, the vehicle should incorporate a sixth degrees-of-freedom (6 DOF), balance stability in the pitch, roll and Z axes, increased reliability and more data acquisition instrumentation.

The general specifications for a second-generation Free Flying Mobility Unit are:

- 1. Incorporate six degrees- of-freedom.
- 2. Maintaining the vehicle balance during docking maneuvers.
- 3. Minimize weight without interfering with operating characteristics.
- 4. Be compatible with existing equipment and existing data.
- 5. Provide for installing alternative docking mechanisms.
- 6. Have on-board computer capabilities.
- 7. Provides for lighting and camera alternatives.
- 8. Have good maintainability and reliability characteristics.
- 9. Have the necessary communication and control capabilities.
- 10. Permit modification for automated docking maneuvers.

Advantages of a new second-generation unit are:

1. The desired 6th DOF can be incorporated into the design of the new vehicle more easily than into the existing one.

2. Some faults of the present design can be eliminated in the new vehicle design.

3. The reliability of a new vehicle would be much better.

4. Maintenance costs should be lower at least in the early years of its service life.

5. Vehicle balance can be incorporated into the design and operation.

6. Provision for alternative docking mechanisms can be installed.

7. Additional features such as improved lighting and vision can be incorporated.

Disadvantages of a new second-generation unit are:

1. The cost will be considerable. It may be more difficult to obtain the fund appropriation for a new vehicle than to rebuild the present unit with NASA personnel.

2. The procurement lead-time will probably be a minimum of three years between the date of the approval and the date the new vehicle goes into full service.

3. Unforeseen bugs and normal new model difficulties will arise.

Alternative Design Concepts for a Second-Generation Free Flying Mobility Unit

The following alternative design concepts were considered:

1. A vehicle suspended from a mobile overhead track-mounted vehicle.

2. A new floor mounted vehicle with its mass concentrated towards the center of gravity.

3. A floor-mounted vehicle with automated computer - controlled balancing.

4. A vehicle mounted on top of a two-way track system above the floor level. (Dr. Campell's concept) This would have some advantages in stability and simpler motion design. However, the mounting might cause interference problems and possible damage (16).

Overhead Track-Mounted Vehicle

The concept of an overhead track vehicle with the docking mechanism suspended underneath is illustrated in Figure 5. The track and carrier will permit locating the mechanism in the X and Y directions. An actuator operated



column or beam would raise or lower the mechanism on the Z axis. Pitch yaw and roll would be provided by movement about the lower column end. Communications could be by direct electrical connection rather than by radio.

The advantages of suspending the docking vehicle from an overhead track are:

1. The sixth degree-of-freedom will be easier to incorporate.

2. Some of the technology is known and well-established.

3. Some components may be completely or partially "off-the-shelf." This will reduce the lead-time and possibilities of trouble with new technology.

4. There will be fewer interference problems such as those with the bases of the two present vehicles.

A major disadvantage is:

1. Maintaining vehicle balance through all DOF movements. This will require either a complex mechanical system or a sophisticated computer control program.

The research and design problems include:

- 1. Adequate building structure which may be difficult to fund.
- 2. Kinematics and deflection.
- 3. Mass and momentum.
- 4. The control system.

Floor-Mounted Free Flying Mobility Unit

A floor-mounted Free Flying Mobility Unit with computer-controlled balancing is a possibility. A sixth degree-of-freedom could be added. This would have the advantages of floor mounting while providing solutions to some major problems with the present model.

The major difficulty with this concept is the design of the control system and the computer programming. Both would be complex and expensive. Further, modifications to the design or latching mechanisms would require extensive redesign, reprogramming and modification.

A second-generation floor-mounted Free Flying Mobility Unit would be similar in some respects to the present model. The design concept is illustrated in Figure 6. A major change is the use of the three actuators to control the plane of the mechanism. This will provide more possibilities of movement and improve the units balance. Some of the other components can be relocated nearer the center of gravity to improve the balance. Other improvements can be incorporated.

CONCEPTUAL SKETCH FLOOR MOUNTED SECOND-GENERATION FREE FLYING MOBILITY UNIT



FIGURE 6.

Floor-Mounted Unit with Automated Computer-Controlled Balance

Computer balance control will have the following advantages:

1. Proper design of the balancing system will hold down the mass of the vehicle.

2. The computers can be located remotely from the vehicle. This will hold down the complexity and mass of the vehicle itself.

3. Although trained computer personnel are presently scarce, the number in training who will become available in the near future is increasing substantially.

Major difficulties with Mechanical Balance Control are:

1. Increase in the vehicle mass. This may cause difficulties in operation. The higher mass will increase the impact forces and may also aggrevate some imbalance situations.

2. Personnel capable of designing, building and maintaining mechanical devices are scarce and will become almost unavailable within a few years.

Display System Definition

The present display system for the Free Flying Rendezvous and Docking Simulator needs a thorough review to determine whether it meets current requirements and is optimum for the test facility mission.

FULLY-AUTOMATED ORBITAL SERVICER SYSTEM

The objective of full automation of the Orbital Servicer will require a closely coordinated research and test effort involving several advanced robotics disciplines. The result of successful effort will be the elimination of the manin-the-loop requirement of the present system.

Full automation of the Orbital Servicer Module transfer operation involves complex difficult research issues. It is not enough to extend the present computer controlled trajectory to cover the final movement of the module into the rack and to complete the latching operation. Functions performed by the man-in-loop must be incorporated into the automation. These functions include collision avoidance, path adjustment, coordination of the teleoperator movement and others.

In this discussion, the following assumptions are made:

1. The precision and accuracy, capabilities of the present Orbital Servicer robotic system are inadequate for efficient operation and collision avoidance in the full automation mode.

2. The major configuration features of the present Space Shuttle, Orbital Servicer and TMS will remain substantially unchanged.

Among the manipulator design features which should be reviewed are:

- 1. Mass of the components and the assembly.
- 2. Oscillation and deflection.
- 3. Placement of sensors, controls, motors and similar parts.
- 4. Collision and damage avoidance features.

Application of Basic Robotics Research to the Orbital Servicer System

In the section "Basic Robotics Research Overview," several basic knowledge areas are discussed. In this section, application to the Orbital Servicer System will be covered.

The first major difference between the present partially automated, partially manual mode and the fully automated mode is the need for substantially increased precision and accuracy in the final approach, contact and latching. Extending the present computer control program will not provide enough accuracy to complete the final mating and latching successfully. In order to attain this accuracy, knowledge from several basic fields must be added.

The first addition will be sensors to determine accurately the position of the module with respect to the rack. The predicted accuracy with the present system is about $\pm 1/2$ inch. This is insufficient to insure proper completion of the maneuver.

A necessary function of the sensors will be to detect deviations from the planned or expected movements and locations. The human operator can recognize situations which deviate from plan and take action to abort or adjust the teleoperator arm action. If there is no man-in-the-loop, the teleoperator must be designed to recognize the situation and to take appropriate action.

The first situation the sensors must recognize is misplacement, deviation or absence of the rack, module or other system component. The other is the presence of an obstruction, accidental or not with which the teleoperator would collide if the programmed paths are continued.

At the time of this report (Summer 1980), it is infeasible to specify the type and technical details of the needed sensors. Several types are mentioned in the previous section.

After the sensors have collected data from the environment, image analysis is necessary to interpret the data for action by the control system. Data impulses received by the sensors must be converted into an information format upon which a decision can be based. This has turned out to be one of the most difficult fields in robotics research and application.

The human's ability to analyze and interpret data collected by his sensory organs is unbelievably complex and difficult to replicate. Yet the teleoperator system must perform this function if it is to carry out its mission. After the teleoperator system has received and analyzed the environmental data decisions on the teleoperator action must be made by the system without human intervention. This is the domain of artificial intelligence, another basic field in robotics research.

Communications are essential to the teleoperator system operation. Data on the environment and the system must be transmitted to the analysis and control sub-system. Commands resulting from decisions must be transmitted to the functioning sub-systems and components. Accuracy, reliability, speed and other characteristics are important to mission success and efficient operation.

Control function provides the machine direction and monitors of the of the teleoperator system. Again replicating the process of human control in the fully-automated teleoperator system is an exceedingly complex and difficult task. However, modern control theory research has made considerable progress which will be helpful in this effort.

The kinematics and mechanical design of the teleoperator system and its components will require further research and technology. For example, each additional joint adds degrees of freedom. The number of degrees-of-freedom in the teleoperator exceeds the number which can be analyzed kinematically at the present level of knowledge. Further basic research is needed. Other problems concern⁻⁻ the mass, momentum and impact characteristics of the teleoperator system and its components.

End effector design is an field of robotics research important to the Orbital Servicer Teleoperator system. Improvements are needed in the latching mechanism and in the latching and unlatching operations. One such improvement is computer control of the latching and unlatching as the module moves into and out of the rack.

Locomotion, a basic field of robotics research at some institutions, has little relevance to the current mission of neither the Orbital Servicer System nor the Free Flying Rendezvous and Docking Simulator. However, should the missions change, locomotion might become essential to mission success.

Resolver Feedback

The use of resolver feedback for manipulator joint position sensing should be investigated. The current method is subject to inaccuracies due to nonlinearities in the potentiometers, grounding and noise, and variation in the reference voltages. The very accurate resolver feedback is especially needed for the successful implementation of the current dead-reckoning control system.

ADDITIONAL ORBITAL SERVICER SYSTEM PROBLEMS

In addition to full automation of the Orbital Servicer TMS, there are three subsidiary problems in the assignment.

- 1. Latching mechanism operation.
- 2. Rack attachment.
- 3. Electrical self-aligning connector.

Latching Mechanism Operation

The mechanism for latching and unlatching the modules needs improvement in operation and in coordination with the full automation trajectory mode.

The following constraints must be met:

- 1. Automated operation.
- 2. Positive latching.
- 3. No damage to the module or the mechanism of the manipulator arm.

4. No major modification of the present latching mechanism, teleoperator end effectors, components or the existing control program.

One alternative solution is a mechanical device actuated by contact or visual sensors. As the device takes over motion control, the computer control would be released. The mechanism would complete the latching operation. There are a number of difficult problems with this alternative such as the sensing device, powering the latching device and operational difficulties with the mechanism and teleoperator.

A better solution appears to be computer operation and control of the latching operation from start to completion. The coordination problems will be less than with mixed mode control. Full computer control will produce weight savings over mechanical latching devices. In the future, it will be easier to acquire personnel with the necessary computer and electronic skills than personnel with mechanical design, manufacturing and maintenance skills.

Rack Attachment

The present method of attaching the racks to the satellite and to the Orbital Servicer allows some movement and variation in the rack position. This condition creates little difficulty with the manual mode of completing the trajectory. However, it produces major problems for full automation. Variation in the rack position makes completion of the trajectory by dead reckoning infeasible since this operating mode requires that the final rack position be known within close tolerances. If trajectory completion requires complex systems design using image analysis, artificial intelligence, pattern recognition, and other knowledge areas, variable rack position will add substantially to the difficulty, complexity and expense of full automation.

The constraints on the solution are:

1. No major design change or modification of the module, teleoperator rack or present computer control program.

2. Accuracy of the position must be such that automated teleoperator functioning is feasible.

3. No collision, damage, binding or interference be permitted.

Four Alternate Solutions are:

1. Attach the racks positively and solidly to the Servicer and the Satellite by welding, metal fasteners or similar method.

2. Spring load from one or both sides to center the rack in the desired position.

3. Use artificial vision and feedback with the computer control program to position the module regardless of the location of the rack.

4. Redesign the rack to provide wide entry space tapered to fit the module closely. The best solution appears to be fixed, accurate location of the racks. Full automation will require complex devices and programs to complete the trajectory successfully. Fixed rack positions will hold down the complexity and difficulties of full automation.

Electrical Self-Aligning Connector

Avoiding damage to electrical connectors during transfer of a module between Satellite and Orbiter Servicer is a serious problem. If a pin is bent or the connector is out of alignment, the connection may fail or the connector be bent and damaged.

The proposed solution is an electrical self-aligning connector, NASA Invention Disclosure Case No. MFS - 25211. The plug and receptacle are conical with annular conductive rings spring-loaded for positive contact. This connector does not require precise alignment and is not as liable to damage as the pin-type connector.

It is recommended that the proposed electrical self-aligning connector NASA Invention Disclosure Case No. MFS - 25211 be built and tested. If tests are successful, the design should be incorporated into the TMS and other programs as appropriate.

COMPUTER RESOURCES FOR ROBOTICS

Although MSFC is an acknowledged leader in modern computer facilities, continuous acquisition of new computer technology and upgrading of present computer resources is essential to support the robotics activities.

The robotics and teleoperator efforts should have dedicated computer resources in addition to the general computer resources available at MSFC. The dedicated computers will avoid access delays, provide immediate interface and permit efficient programming and output.

Computers themselves are improving steadily. Storage capacity, operating speed, reliability, flexibility and computing power are steadily increasing while size, weight and cost are going down. There are limits to possible improvements. (The exponential growth curve cannot go on forever.) However, the limits do not appear on the near-time horizon.

Among the dedicated computer facilities that will be needed are:

1. On-board operating and control computers for the Free Flying Mobility Unit in the Free Flying Rendezvous and Docking Simulator. This will provide for maintaining the balance, recording data, and other functions in which the human test subject need not be involved.

2. Graphics software and hardware for both robotics simulators. This may interface with the major computers to gain increased capacity and allow verification through simulation prior to hardware implementation.

3. Full automation of the Orbiter Servicer System will require substantial increase in computer capacity and power in order to perform the necessary command control, image analysis, and other activities.

COMPUTER MODELING

Computer models and simulations can be useful even though they cannot replace full-scale physical mock-ups and simulators. A computer model can be developed, tested and implemented more quickly and less expensively than can a full-scale simulator. The information gained can be useful in design development.

Computer modeling is developing a considerable body of basic knowledge, practical experience, applications and published articles. The topic is included in many current Engineering, Math and Science education programs. The number of professionals with education and training in computer modeling and simulation is steadily increasing. Competence in this area will become increasingly available within NASA and from its contractors.

Computer modeling and simulation does have limits. The validity and reliability of the model output depend upon the extent to which the model represents reality and upon the quality of input data. The right parameters and the correct representations of their behavior must be incorporated in the model. In order to keep the model to manageable size, simplifying assumptions and short cuts are used. These may introduce unacceptable errors. The input data quality is vital to good results. Sometimes there is inadequate communication between the mathematical modeler and the designer-operator of the physical system. The result may be failure to interpret and apply the results properly and to detect anomalies in the model and its output. A major problem in modeling robotics system is the representation of the physical components and the automated sensory - based interpretation of the data. Another is the present method of representing all trajectories as a set of straight-line elements. This requires a large number of steps and is expensive. A third is incorporation of five or more degrees of freedom; most current modules are limited to three (15).

An important application of robotic programming models is the development of "goal domain" programs. This permits the programmer to specify the goal states of the robot while the robot selects the appropriate actions to achieve the desired goal state (17).

Task specification definition needs to be refined and improved. Too great detail in task definition reduces the scope of adaptive programming to meet variations and contingencies. On the other hand, present state of the art in communications, artificial intelligence, computer languages and artificial vision is inadequate to support goal-oriented task definition in NASA's robotics efforts(13).

CONCLUSIONS AND RECOMMENDATIONS

The major conclusions from the research on robotics in the Free Flying Rendezvous and Docking Simulator and the Orbital Servicer System are:

1. These facilities perform an important service in support of NASA's Space Missions.

2. These facilities should be upgraded and improved.

3. MSFC should move to acquire professional competence in research areas basic to robotics research and technology.

The main recommendations are summarized below. Detailed discussion is the body of this report.

1. A second-generation Free Flying Mobility Unit be acquired. This would provide six degrees of freedom and other improvements infeasible with the present model. The present unit might be kept if its role is complementary to the new unit.

2. The Orbital Servicer System be fully automated.

3. MSFC move to acquire competence in areas necessary to robotics teleoperator development. These include artificial intellignece, sensors, image analysis, pattern recognition, control, communication and computer science applied to robotics.

4. Enhanced computer facilities be acquired for the robotics and teleoperator activities. Some can be additions to Center-wide computer resources; others must be dedicated to the robotics and teleoperator work.

5. Procurement and test of the new electrical self-aligning connector be implemented.

6. Other recommendations are contained in the body of the report. These include rack attachment, latching mechanisms and others.
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MATERIAL AND PROCESS CONSTRAINTS FOR A FLAT INTERFACE IN THE BRIDGMAN-STOCKBARGER TECH-NIQUE

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MATERIAL AND PROCESS CONSTRAINTS FOR A FLAT INTERFACE IN THE BRIDGMAN-STOCKBARGER TECHNIQUE

By

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ABSTRACT

The functional relationships between various material and process parameters necessary for a flat interface in the Bridgman-Stockbarger technique are given. In particular, two boundary condition cases of

(1) $\nabla^2 T = P_{\mathbf{g}} \frac{\partial T}{\partial x}$, x < 0 and 0 < r < 1(2) $\nabla^2 T = P_{\mathbf{g}} \frac{\partial T}{\partial x}$, x > 0 and 0 < r < 1(3) $-K_{\mathbf{g}} \frac{\partial T}{\partial x} \Big|_{\mathbf{x}=0^-} + K_{\mathbf{g}} \frac{\partial T}{\partial \mathbf{x}} \Big|_{\mathbf{x}=0^+} + L = 0$

are considered.

Case 1:
$$T(x,1) = \begin{cases} T_c, x>0 \\ T_h, x<0 \end{cases}$$

Case 2: $\frac{\partial T}{\partial r}(x,1) = \begin{cases} -B_s T, x>0 \\ -B_g (T - T_i), x<0 \end{cases}$

Necessary interval bounds on T_1 and T_h are given assuming a flat melt-solid interface at x = 0. Approximations of T (x, r) and related error estimates are also given.

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NOMENCLATURE

- P liquid Péclet number
- P_s solid Peclet number
- T_c cooler temperature
- T_{μ} heater temperature
- Q material melting point
- K_0 liquid thermal conductivity
- K solid thermal conductivity
- \mathcal{L} crystal growth rate \cdot liquid density \cdot latent heat
- B_s solid region Biot number
- B₉ liquid region Biot number
- T₁ scaled ambient temperature for liquid region
- 'T temperature

INTRODUCTION

The partial differential equations defining cyrstal growth by the Bridgman - Stockbarger technique [2] are

$$\nabla^2 T = P_1 \frac{\partial T}{\partial x}, x < 0$$

and

$$\nabla^2 T = P_s \frac{\partial T}{\partial x}, x > 0$$

where P_{i} and P_{s} are the liquid and solid P_{eclet} numbers respectively, T is temperature and x is distance from a flat solid - melt interface. To conserve energy at the interface,

$$K_{\chi} = \frac{\partial x}{\partial x} \Big|_{x=0^{-}} + K_{s} = \frac{\partial x}{\partial x} \Big|_{x=0^{+}} + \chi = 0$$

where K, and K_s are the respective liquid and solid thermal conductivities and \mathcal{L} is the product of the crystal growth rate, the melt density and the latent heat of solidification. Two heating mechanisms are investigated; first considered is conductive heating defined by

$$T(x,1) = T_{c}, x > 0$$

$$\Gamma(\mathbf{x},1) = \mathbf{T}_{\mathbf{n}} , \mathbf{x} < \mathbf{0}$$

followed by Newton heating

$$\frac{\partial T}{\partial r}(x, 1) = -B_s T, x > 0$$

$$\frac{\partial T}{\partial r}(x, 1) = -B_t (T - T_t), x < 0$$

where T_c and T_{μ} are the respective cooler and heater temperatures, B_s and B_{μ} are the solid and melt Biot numbers respectively, and T_{μ} is the ambient temperature surrounding melt region. The ambient temperature for the solid region has been scaled to 0.

The assumption of a flat melt-solid interface forces K_s , K_s , T_c , T_{μ} , B_s , B_{μ} , T_{μ} , P_s , P_{μ} and Q, the material melting temperature, to be functionally dependent. This dependence, the solutions of the above partial differential equations, and various error estimates are given in the next section followed by several numerical experiments. The final section is devoted to conclusions and recommendations.

SOLUTIONS AND APPROXIMATIONS

The solutions of Problems I-II and their computable approximations are given in this section. Also given are the functional relationships between the material and process parameters P_{g} , P_{s} , K_{s} , K_{s} , T_{c} , T_{μ} , B_{s} , B_{g} , and T_{i} necessary for a solid-melt interface at x = 0. We begin with two elementary but fundamental facts.

Fact 1. If (1) $\{a_m\}$ alternates (2) $|a_{m+1}| \le |a_m|$ (3) $a_m \to 0$ as $m \to \infty$ then (1) $\sum_{i=1}^{m} a_m$ converges (2) $|\sum_{i=1}^{N} a_m - \sum_{i=1}^{m} a_m| \le |a_{N+1}|$

Fact 2. For f(x) sufficiently smooth,

$$f'(x) = \frac{f(x + h) - f(x)}{h} + O(h)$$

Problem I.

We wish to solve, in cylindrical coordinates,

(1)
$$\nabla^2 T = P_1 \frac{\partial T}{\partial x}$$
, $x < 0$, $0 < r < 1$

(2)
$$\nabla^2 T = P_3 \frac{\partial T}{\partial x}$$
, $x > 0$, $0 < r < 1$

subject to

(3)
$$T(x, 1) = T_{c}, x > 0$$

(4)
$$T(x,1) = T_{H}, x < 0$$

(5)
$$-K_{\lambda} \frac{\partial T}{\partial x} + K_{3} \frac{\partial T}{\partial x} + \chi = 0$$

where χ = crystal growth rate • melt density • latent heat

N.

Condition (5) implies a solid-melt interface at x = 0, i.e.,

(6)
$$T(O, r) = Q$$
.

Unfortunately, conditons (3) - (6) overpose (1) and (2) and generally, overposed problems are impossible to solve. However, in this case, the overposing of (1) and (2) will give constraints on the material and process parameters P_{I} , P_{S} , T_{c} , Q, T_{H} , K_{I} , K_{s} , and $\boldsymbol{\chi}$.

By separation of variables, (1) and (2) with conditions (3), (4) and (6) have solutions [1]

(7) T(x, r) =

$$T_{c} + \sum_{i}^{\infty} \frac{2(Q-T_{c})}{\beta_{m} T_{i}(\beta_{m})} J_{o}(\beta_{m}r) E_{xp} \left[(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{m}^{2}}) \frac{x}{2} \right],$$

$$X > O$$
 and $O < r < |$

$$(8) \qquad T(x,r) =$$

$$T_{H} + \sum_{i}^{\infty} \frac{2(Q-T_{H})}{\beta_{m} J_{i}(\beta_{m})} J_{o}(\beta_{m} r) E_{XP} \left[(P_{J} + \sqrt{P_{J}^{2} + 4\beta_{m}^{2}}) \frac{x}{2} \right],$$

X < 0 and 0 < r < 1

where $\{\beta_m\}$ is the increasing sequence of all positive roots of J. We next show that Q, K, K, T, T, T, X, P, and P, cannot be arbitrary if (5) is to hold. In fact, (5) will imply that Q, K, K, T, T, T, X, P, and P, satisfy a functional inequality.

<u>Remark 1:</u> An intuitive approach to enlisting (5) is to differentiate (7) and (8) with respect to x and insert the resulting series into (5). But this would require $\sum_{i=1}^{\infty} J_{i}^{-1}(\beta_{m})$ to converge, an impossibility. Hence, we will approximate the partial derivatives in (5).

By Fact 2, (5) and (6) imply

(9)
$$-K_{j} \frac{Q - T(-h, 0)}{h} + K_{s} \frac{T(h, 0) - Q}{h}$$

+ $\chi = O(h)$

Fact 3. Let $\{\beta_n\}$ be the increasing sequence of all nonnegative roots of $J_o(x)$. Then

$$\left\{ \begin{array}{c} \frac{1}{\beta_{m} J_{i}(\beta_{m})} \end{array} \right\} \quad \text{alternates in sign,} \quad \left| \frac{1}{\beta_{m+1} J_{i}(\beta_{m+1})} \right| \leq \\ \left| \frac{1}{\beta_{m} J_{i}(\beta_{m})} \right| \quad \text{and} \quad \frac{1}{\beta_{m} J_{i}(\beta_{m})} \longrightarrow 0 \\ \end{array} \right\}$$

Combining Facts 1 and 3 with (7), (8), and (9),

$$\begin{cases} 10 \\ \chi_{H}^{(10)} & = (K_{J} + K_{S})Q + K_{S} \left\{ T_{c} + 2(Q - T_{c}) \sum_{1}^{M} \frac{e^{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{m}^{2}})\frac{h}{2}}}{\beta_{m} \tau_{i}(\beta_{m})} \right\} \\ & + K_{J} \left\{ T_{H}^{} + 2(Q - T_{H}) \sum_{1}^{M} \frac{e^{(P_{J}^{} + \sqrt{P_{J}^{2} + 4\beta_{m}^{2}})\frac{-h}{2}}}{\beta_{m} \tau_{i}(\beta_{m})} \right\} \\ & = O(h^{2}) + \left[K_{S} 2(Q - T_{c}) \frac{e^{(P_{s}^{} - \sqrt{P_{s}^{2} + 4\beta_{M+i}^{2}})\frac{h}{2}}}{\beta_{M+i} \tau_{i} (\beta_{M+i})} \right] \\ & + \left[K_{J} 2(Q - T_{H}) \frac{e^{(P_{J}^{} + \sqrt{P_{J}^{2} + 4\beta_{M+i}^{2}})\frac{-h}{2}}}{\beta_{M+i} \tau_{i} (\beta_{M+i})} \right]$$

In fact, for computational purposes, if P $_{S}$ \ll 1 and P \ll 1, then the right hand side of (10) can be replaced by

$$O(h^{2}) + 2K_{s}(Q-T_{c}) \frac{e^{(P_{s}-2\beta_{M+1})\frac{h}{2}}}{|\beta_{M+1}J_{1}(\beta_{M+1})|} + 2K_{1}(T_{H}-Q) \frac{e^{(P_{1}+2\beta_{M+1})\frac{-h}{2}}}{|\beta_{M+1}J_{1}(\beta_{M+1})|}$$

(11)

<u>Remark 2:</u> (10) forces \mathcal{X} , K_{g} , K_{g} , Q, T_{g} , T_{H} , P_{g} and P_{g} to be functionally dependent. For computional use, we may set

(12)

$$\begin{aligned}
\mathcal{L}_{h} - (K_{I} + K_{s})Q + K_{s} \left[T_{c} + 2(Q - T_{c}) \sum_{i}^{M} \frac{e^{(P_{s} - \sqrt{P_{s}^{2}} + 4\beta_{m}^{2})\frac{h}{2}}}{\beta_{m} J_{i}(\beta_{m})} \right] \\
+ K_{J} \left[T_{H} + 2(Q - T_{H}) \sum_{i}^{M} \frac{e^{(P_{J} + \sqrt{P_{J}^{2}} + 4\beta_{m}^{2})\frac{-h}{2}}}{\beta_{m} J_{i}(\beta_{m})} \right] \\
= 0
\end{aligned}$$

for h sufficiently small and M sufficiently large. This gives an equation linear in χ , K_s, K_s, Q, T_e, T_H and nonlinear in P_s and P_s. In particular, (12) gives T_H in terms of χ , K_s, Q, T_e, P_s and P_s. Furthermore, if (10) is violated, (1) and (2) cannot have a solution satisfying (3) - (6).

Remark 3: Since
$$f(x + h) - f(x) = f'(x + \frac{h}{2}) + O(h^2)$$
,
h

it may appear profitable to replace

 $\frac{T(h,0)-Q}{h} \quad \text{and} \quad \frac{Q-T(-h,0)}{h} \quad \text{in (9) by}$

 $\frac{\partial T}{\partial x}(\frac{h}{2},0)$ and $\frac{\partial T}{\partial x}(\frac{-h}{2},0)$ respectively. However,

$$\frac{\partial T}{\partial x}\left(\frac{h}{2},0\right) = 2\left(Q-T_{c}\right)\sum_{i}^{\infty}\frac{P_{s}-\sqrt{P_{s}^{2}+4\beta_{m}^{2}}}{\beta_{m}J_{i}\left(\beta_{m}\right)}e^{\left(P_{s}-\sqrt{P_{s}^{2}+4\beta_{m}^{2}}\right)\frac{h}{4}}$$

converges much slower than the estimates in (10).

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<u>Remark 4:</u> An interval estimate of linear parameters χ , K_{1} , K_{5} , T_{c} and T_{H} can be given. For example, suppose χ , K_{1} , K_{5} , T_{c} , P_{5} , P_{1} and Q are fixed. Then (10) implies

(12)

$$O(h^{2}) - K_{s} 2(Q - T_{c}) \frac{C}{|\beta_{M+1} J_{1}(\beta_{M+1})|}$$

$$- \lambda h + (K_{1} + K_{s})Q + \lambda Q K_{1} \frac{e}{|\beta_{M+1} J_{1}(\beta_{M+1})|}$$

$$-K_{s}\left(T_{c} + 2(Q - T_{c})\sum_{1}^{M} \frac{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{m}^{2}})\frac{h}{2}}{\beta_{m} J_{i}(\beta_{m})}\right)$$

$$-K_{1} 2Q \sum_{1}^{M} \frac{e^{(P_{1} + \sqrt{P_{1}^{2} + 4\beta_{m}^{2}})\frac{-h}{2}}}{\beta_{m} J_{1}(\beta_{m})} \leq$$

$$K_{1}T_{H}\left(1-2\sum_{i}^{M}\frac{e^{\left(P_{1}^{2}+\sqrt{P_{1}^{2}+4\beta_{m}^{2}}\right)\frac{-h}{2}}}{\beta_{m}J_{i}(\beta_{m})} + 2\frac{(P_{1}^{2}+\sqrt{P_{1}^{2}+4\beta_{M+i}^{2}})\frac{-h}{2}}{\left|\beta_{M+i}J_{i}(\beta_{M+i})\right|}\right)$$

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and
(13)
$$K_{I}T_{H}\left(1-2\sum_{i}^{M}\frac{e^{(P_{I}+\sqrt{P_{I}^{2}+4\beta_{m}^{2}})\frac{-h}{2}}}{\beta_{m}J_{i}(\beta_{m})}-2\frac{(P_{I}+\sqrt{P_{I}^{2}+4\beta_{H+i}^{2}})\frac{-h}{2}}{|\beta_{M+i}J_{i}(\beta_{M+i})|}\right)$$

$$\leq O(h^{2}) + 2K_{s}(Q - T_{c}) - \frac{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{M+1}^{2}})^{\frac{h}{2}}}{|\beta_{M+1} J_{1}(\beta_{M+1})|}$$

$$-2K_{J}Q - \frac{e^{(P_{g} + \sqrt{P_{g}^{2} + 4\beta_{M+1}^{2}})\frac{-h}{2}}}{|\beta_{M+1} J_{i}(\beta_{M+1})|} - 2h + (K_{g} + K_{s})Q$$

$$-K_{s}\left(T_{c} + 2(Q - T_{c})\sum_{i}^{M} \frac{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{m}^{2}})\frac{h}{2}}{\beta_{m} J_{i}(\beta_{m})}\right)$$

$$-K_{1} 2Q \sum_{1}^{M} \frac{(P_{1} + \sqrt{P_{1}^{2} + 4\beta_{m}^{2}})^{-h}}{\beta_{m} J_{1} (\beta_{m})}$$

Solving (12) and (13) for $\mathbf{T}_{\boldsymbol{y}}$,

$$T_{1}(M, h) + O(h^{2}) \leq T_{H} \leq T_{2}(M, h) + O(h^{2})$$

For practical purposes, set

(14)
$$T_1(M,h) \le T_H \le T_2(M,h)$$

Since we only know bounds on T₁ (from (14)), for computational use, approximate $T_{H,APP} = \frac{T_2 (M, h) + T_1 (M, h)}{2}$. If T_H is replaced by $T_{H,RPP}$ in (8), then T by

the resulting error is

(15)
$$\left| T_{H} - T_{H, APP} - 2 \sum_{i}^{\infty} \frac{T_{H} - T_{H, APP}}{\beta_{m} J_{i} (\beta_{m})} J_{o} (\beta_{m} r) e^{\left(\frac{P_{A} + \sqrt{P_{i}^{2} + 4\beta_{m}^{2}}\right)\frac{X}{2}}{\beta_{m} J_{i} (\beta_{m})} \right|$$
which has an upper bound of

(16) $(T_{\lambda}(M,h) - T_{i}(M,h)) \left| \frac{1}{\lambda} - \sum_{i}^{m} \frac{J_{o}(\beta_{m}r)}{\beta_{m}J_{i}(\beta_{m})} e^{(P_{\lambda} + VP_{\lambda} + 4\beta_{m}^{-})\frac{1}{\lambda}} \right|$

Problem II.

We wish to solve, in cylindrical coordinates,

(17)
$$\nabla^2 T = \int_{x}^{0} \frac{\partial T}{\partial x}$$
, x < 0 and 0 < r < 1
(18) $\nabla^2 T = \int_{y}^{0} \frac{\partial T}{\partial x}$, X > 0 and 0 < r < 1

subject to

(19)
$$\frac{\partial T}{\partial r}(x, 1) = -B_s T$$
, x >0

(20)
$$\frac{\partial I}{\partial r}(x, 1) = -B_{\chi}(T-T_{\chi}), x < 0$$

$$(21) - K_{l} \frac{\partial T}{\partial x} \Big|_{x=0^{-}} + K_{s} \frac{\partial T}{\partial x} \Big|_{x=0^{+}} + \mathcal{L} = 0$$

where \mathcal{L} = crystal rate of growth \cdot liquid density \cdot latent heat, $B_{,} \ge 0$ and $B_s \ge 0$. Condition (21) implies a solid-melt interface at x = 0, i.e.,

(22)
$$T(0, r) = Q$$

As in Problem I, conditions (19) - (22) overpose (17) and (18). This dilemma can be resolved only if the material and process parameters P_{s} , P_{s} , Q , T_{i} , K, , K, and χ are functionally dependent.

Separating variables, (17) and (18) subject to (19), (20) and (22) have solutions [1]

$$T(x, r) = \sum_{j}^{\infty} \frac{2QB_{j}J_{o}(\beta_{m}r)}{(\beta_{m}^{2} + B_{j}^{2})J_{o}(\beta_{m})} \stackrel{(P_{s} - VP_{s}^{2} + 4\beta_{m}^{2})}{(\beta_{m}^{2} + \beta_{s}^{2})J_{o}(\beta_{m})} e^{-(P_{s} - VP_{s}^{2} + 4\beta_{m}^{2})\frac{X}{2}}, X > 0$$

(24)

$$T(s, r) = T_{i} + \sum_{1}^{\infty} \frac{2(Q - T_{i}) B_{g} J_{o}(\beta_{m} r)}{(\alpha_{m}^{2} + B_{g}^{2}) J_{o}(\alpha_{m})} e^{(P_{g} + \sqrt{P_{g}^{2} + 4\beta_{m}^{2}})\frac{r}{2}}, x < 0$$

where $\{\alpha_{m}\}$ and $\{\beta_{m}\}$ are the increasing nonnegative sequences of all roots of (25) $\beta_{s} \ \overline{J}_{o} (\beta_{m}) = \beta_{m} \ \overline{J}_{i} (\beta_{m})$ (26) $\beta_{s} \ \overline{J}_{o} (\alpha_{m}) = \alpha_{m} \ \overline{J}_{i} (\alpha_{m})$ <u>Fact 4:</u> $\left\{ \left(\beta_{m}^{2} + \beta_{s}^{2}\right) \ \overline{J}_{o} (\beta_{m}) \right\}$ alternates in sign and $\left| \frac{1}{(\beta_{m}^{2} + \beta_{s}^{2}) \ \overline{J}_{o} (\beta_{m})} \right|$ decreases to 0. A similiar result holds for $\left\{ \frac{1}{(\alpha_{m}^{2} + \beta_{s}^{2}) \ \overline{J}_{o} (\alpha_{m})} \right\}$

As in Problem I, (21) and Fact 2 imply

(27)

$$-K_{f} \frac{Q - T(-h, 0)}{h} + K_{s} \frac{T(h, 0) - Q}{h} + L = O(h)$$

Combining Facts 1 and 4 with (23), (24) and (27),

(28)

$$J_{h} - Q(K_{s} + K_{g}) + K_{s} \sum_{i}^{M} \frac{2 B_{s} Q}{(\beta_{m}^{2} + \beta_{s}^{2}) T_{o}(\beta_{m})} e^{(P_{s} - \sqrt{P_{s}^{2} + \gamma \beta_{m}^{2}})\frac{h}{2}}$$

+
$$K_{g}\left\{T_{i} + \sum_{l}^{M} \frac{2(Q-T_{i})B_{g}}{(\alpha_{m}^{2}+B_{g}^{2})J_{o}(\alpha_{m})}e^{\left(P_{g}+\sqrt{P_{g}^{2}+4\alpha_{m}^{2}}\right)\frac{-h}{2}}\right\}$$

$$\leq O(h^{2}) + \left| \frac{2QB_{s}K_{s}}{(\beta_{M+i}^{2} + B_{s}^{2})J_{o}(\beta_{M+i})} e^{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{M+i}^{2}})\frac{h}{2}} \right|$$

+
$$\left| \frac{2(Q-T_i)B_{g}K_{g}}{(\alpha_{m+1}^{2}+B_{g}^{2})J_{g}(\alpha_{m+1})} e^{\left(P_{g}+\sqrt{P_{g}^{2}+4\alpha_{m+1}^{2}}\right)-\frac{h}{2}} \right|$$

As in Problem I, (28) implies various interval constraints on Q, K_s , K_k , T_1 , P_s , P_k , B_s and B_k . For illustration, consider T_1 . Because we have transformed (in practice) the Newton cooling condition (19) to imply a 0 ambient temperature around the rod for x>0, $0 < Q < T_1$. (28) then implies

(29)

$$O(h^{2}) + Q(K_{s} + K_{g}) - 2QK_{g}B_{g}\sum_{i}^{M} \frac{(P_{g} + \sqrt{P_{g}^{2} + 4\alpha_{m}^{2}})^{-h}}{(\alpha_{m}^{2} + B_{g}^{2})^{-J}\sigma(\alpha_{m})}$$

$$-2K_{s}B_{s}Q\sum_{i}^{M}\frac{e^{(P_{s}-\sqrt{P_{s}^{2}}+4\beta_{m}^{2})\frac{h}{2}}}{(\beta_{m}^{2}+B_{s}^{2})J_{o}(\beta_{m})} -2h$$

+
$$\frac{2B_{s}QK_{s}e^{(P_{s} - \sqrt{P_{s}^{2} + 4\beta_{M+1}^{2}})\frac{h}{2}}{(B_{M+1}^{2} + B_{s}^{2})[J_{o}(\beta_{M+1}^{2})]} - \frac{2B_{l}QK_{l}e^{(P_{l} + \sqrt{P_{l}^{2} + 4\alpha_{M+1}^{2}})\frac{-h}{2}}{(\alpha_{M+1}^{2} + B_{l}^{2})[J_{o}(\alpha_{M+1})]}$$

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$$\geq T_{i} K_{g} \left\{ 1 - 2 B_{g} \sum_{i}^{M} \frac{e^{(P_{g} + \sqrt{P_{g}^{2} + 4 \alpha_{m}^{2}}) \frac{-h}{2}}}{(\alpha_{m}^{2} + B_{g}^{2}) J_{o} (\alpha_{m})} - 2 B_{g} \frac{e^{(P_{g} + \sqrt{P_{g}^{2} + 4 \alpha_{m+1}^{2}}) \frac{-h}{2}}}{(\alpha_{m+1}^{2} + B_{g}^{2}) |J_{o} (\beta_{m+1})|} \right\}$$

and

(30)

$$O(h^{2}) - \frac{2 B_{s} K_{s} Q e}{(\beta_{M+1}^{2} + B_{s}^{2}) | \overline{J}_{o}(\beta_{M+1})|} +$$

$$\frac{2 Q B_{g} K_{g} c}{(\alpha_{M+1}^{2} + B_{\chi}^{2}) | J_{\sigma}(\beta_{M+1})|} + Q(K_{s} + K_{g})$$

$$-2K_{I}B_{I}Q\sum_{i}^{M}\frac{e^{(P_{I}+\sqrt{P_{I}^{2}+4\alpha_{m}^{2}})^{-\frac{h}{2}}}{(\alpha_{m}^{2}+B_{I}^{2})J_{o}(\alpha_{m})}$$

$$-2K_{s}B_{s}Q\sum_{i}^{M}\frac{\frac{(P_{s}-\sqrt{P_{s}^{2}+4\beta_{m}^{2}})^{\frac{h}{2}}}{(\beta_{m}^{2}+B_{s}^{2})\overline{J_{o}}(\beta_{m})} - Lh$$

$$\leq T_{1}K_{1} \left\{ 1 - 2B_{1}\sum_{i}^{M} \frac{(P_{1} + \sqrt{P_{1}^{2} + 4\alpha_{m}^{2}})^{\frac{1}{2}}}{(\alpha_{m}^{2} + B_{1}^{2})J_{0}(\alpha_{m})} \right\}$$

+
$$2 B_{g} \frac{(P_{g} + \sqrt{P_{g}^{2} + 4 \alpha_{M+1}^{1}}) - \frac{h}{2}}{(\alpha_{M+1}^{2} + B_{g}^{2}) | \overline{J}_{o}(\alpha_{M+1}) |}$$

Solving (29) and (30) for ${\rm T}_{\rm j}$,

$$T_{4}^{LOW}(M,h) + O(h^{2}) \leq T_{1} \leq T_{1}^{H/GH}(M,h) + O(h^{2})$$

For computational purposes, let

(31)
$$T_{\perp}^{LOW}(M,h) \leftarrow T_{i} \leftarrow T_{i}^{HIGH}(M,h)$$

(32)

$$T_{l, APPROX} = (T_{l}^{LOW}(M, h) + T_{l}^{HIGH}(M, h)) / 2$$

The error committed by replacing T_{l} in (24) by $T_{l,APPRox}$ is no more than (33)

$$\left(T_{i}^{HiGH}(M,h)-T_{i}^{LOW}(M,h)\right)\left[\frac{1}{2}-\sum_{i}^{\infty}\frac{B_{i}J_{o}(\alpha_{m}r)}{\left(\alpha_{m}^{2}+B_{i}^{2}\right)J_{o}(\alpha_{m})}C\right]$$

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<u>Remark 5:</u> It is possible to substitute (23) and (24) into (21) and solve for T_1 . However, this would require computing

(34)

$$\sum_{1}^{\infty} \frac{P_{s} - \sqrt{P_{s}^{2} + 4\beta_{m}^{2}}}{(\beta_{m}^{2} + \beta_{s}^{2}) J_{o}(\beta_{m})}$$

and

(35)

$$\sum_{i}^{\infty} \frac{P_{i} + \sqrt{P_{i}^{2} + 4\alpha_{m}^{2}}}{(\alpha_{m}^{2} + B_{i}^{2}) J_{o}(\alpha_{m})}$$

Although (34) and (35) conditionally converge, the sums in (28) - (30) and (33) converge faster by several orders of magnitude.

<u>Remark 6:</u> Let $B_s = B_l = P_s = P_l = 0 = \chi$ and fix 0 < h << 1.

Letting M = 39, (10) implies $Q = \frac{K_s T_c + K_s T_{\mu}}{K_s + K_s}$

for Problem 1 and (28) gives

$$Q = \frac{K_{I} T_{i}}{K_{S} + K_{I}}$$

for Problem 2.

NUMERICAL EXAMPLES

The results of several numerical experiments are given in this section.

Example 1: In Figure 1 and Table 1 we illustrate the dependence on M of the interval estimate (14). Let $T_c = 400$, Q = 700, $P_s = P_g = 0.001$, $\chi = 0.01$, h = 0.1, $K_s = 0.0032$ and $K_g = 0.002$.

м	Interval Estimate of $T_{_{H}}$
9	[1391.34, 1476.13]
14	[1202.19, 1214.26]
19	[1180.56, 1182.74]
24	[1176.34, 1176.54]
29	[1176.34, 1176.54]
34	[1175.92, 1175.93]
39	[1175.90, 1175.90]





Figure 1

<u>Example 2</u>: In Table 2 and Figure 2 we illustrate the sensitivity of the interval estimate (14) to changes in \mathcal{X} . Let $K_{g} = K_{s} = P_{s} = P_{s} = 0.001$,

h = 0.1, $T_c = 200.0$, Q = 700.0 and M = 39.

z	Interval Estimate of T _H
.001 .011 .021 .031	[1192.386, 1192.389] [1116.514, 1116.517] [1040.642, 1040.645] [964.770, 964.773]
.041 .051 .061	[813.026, 813.029] [737.154, 737.157]







CONCLUSIONS AND RECOMMENDATIONS

Equations (10) and (28) imply that the material and process parameters cannot be arbitrary if a flat melt-solid interface is to be achieved. The sensitivity of one parameter to changes in another parameter (Example 2) suggests great care should be taken in obtaining the various material parameters.

The relationships between M and h that minimize the interval widths in (14) and (31) remain open questions. Further investigations of Problems I and II could incorporate adiabatic boundary zones near the melt-solid interface and the influences of various container configurations.

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

A RANKING ALGORITHM FOR SPACELAB

CREW AND EXPERIMENT SCHEDULING

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A RANKING ALGORITHM FOR SPACELAB CREW AND EXPERIMENT SCHEDULING

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ABSTRACT

This report is concerned with the problem of obtaining an optimal or near optimal schedule for scientific experiments to be performed on Spacelab missions. The design criteria of a method for solving this problem is two-fold. First, the method must produce a schedule which satisfies all material and resource constraints while maximizing a function assigning a grade to each schedule. Secondly, the method should reduce the amount of preflight manpower and computer time currently necessary to achieve this goal and be rapid and flexible enough to allow real-time support of rescheduling problems arising due to launch delays, equipment malfunction, or other factors.

In this paper the current capabilities in this regard are examined and a method of ranking experiments in order of difficulty is developed to support the existing software. Experimental data is obtained from applying this method to the sets of experiments corresponding to Spacelab missions 1, 2 and 3. Finally, suggestions are made concerning desirable modifications and features of second generation software currently being developed for this problem.

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ACKNOWLEDGEMENT

The authors of this report wish to thank their counterparts and John Jaap for the careful and complete introduction to the problem which they provided and for the generous support afforded in terms of assistance, supplies, and computer access.

INTRODUCTION

The problem under consideration is that of scheduling a set of experiments to be performed on a given Spacelab mission. Through a preliminary analysis, which is not discussed here, a set of compatible experiments is compiled which are hopefully to be included in a specific mission. The experiments are then converted into model sheets by the principal investigator, who is responsible for the experiment design, and a NASA project engineer familiar with the format and requirements of the model sheets. The model sheet divides each experiment into a sequence of steps, each of which has certain requirements in terms of crew, equipment, and energy usage; and may in addition require that the Spacelab be in a certain position or configuration, or have certain targets available. Examples of targets are planets, communication satellites, and data receiving facilities on the earth's surface. If the experiment is to be performed more than once the number of performances desired is included on the model sheet. A typical Spacelab mission lasts for seven days and involves six crewmembers.

Extremely sophisticated software is available to assist in scheduling of the experiments. The current program is designated by TLP for timeline program. This program takes the model sheets in some order and "front loads" them in this order. By <u>front load</u>, it is meant that the model is scheduled at the earliest possible time which satisfies all the model constraints and which does not conflict with the requirements of previously scheduled models. If it is impossible to schedule a certain model at any time the program then goes to the next model in the sequence. This program is currently being upgraded to a program denoted by ESP for experiment scheduling program, which has the capability of either front loading or back loading any given model, and which is to supersede TLP sometime in 1981.

Even with the extremely advanced and effective software available, the problem of scheduling the experiments in an optimal way currently requires an enormous amount of pre-flight man-hours. By an optimal schedule, we roughly mean one that includes the maximal number of experiments and performances, and which makes maximal use of the available resources. Since each set of models designated for inclusion in a specific mission are only roughly sorted for compatibility, it is frequently impossible to include every performance of every experiment. The method previously employed has been to feed TLP various random orderings of the model sheets and have the project engineers examine the characteristics of the resulting schedules. From these examinations other orderings are suggested and fed to TLP. After months of such trial and error, the best resulting schedule is then modified and edited by hand by a group of NASA personnel familiar with the characteristics of the given mission. The current schedule for Spacelab mission one has been under development for five years. It is clear that such a time expenditure is not only economically prohibitive, but is unacceptable in light of the fact that the Spacelab program eventually envisions flying several missions a year.

OBJECTIVES

The main object of this paper is to provide a method of ranking the model sheets in order of difficulty. By scheduling the most difficult experiments first it is thought that an optimal schedule will result. In support of this idea a grading function is used which assigns a higher grade to schedules which are in some sense better. The problem is then to find a ranking function of the models which provides an ordering which results in a schedule which maximizes the grading function. Since there are 218 model sheets corresponding to Spacelab mission one, an exhaustive search is clearly out of the question.

The remainder of this paper is devoted to the development and examination of such a ranking function. While the method developed did not result in a schedule superior to the schedule hand produced over a five-year period for Spacelab mission one, it did quickly produce schedule for Spacelab missions two and three, which were superior to the best existing schedules for these missions.

These experimental results are described and suggestions are made on the basis of these for possible modifications or additions to the existing software.

THE RANKING ALGORITHM

The problem is now to produce a ranking algorithm which produces an ordering of the models which produces an optimal schedule in terms of a grading function which is described in the results section. While this has certain aspects of a linear programming problem which might be treated with either the simplex method or the new Khachiam method, it is unclear if it is possible to convert this to a linear problem. The method we exhibit is similar to the one described by Garey, Graham, Johnson, and Yao in J. Comb. Theory (A) 21 (1976), 257-298.

We now proceed to describe the method used to rank the models in decreasing order of difficulty. The steps involved are: the construction of a nonnegative real vector corresponding to a single performance of each model, the normalization of these vectors, and the evaluation of the difficulty function on the normalized vectors. The models (vectors) are then arranged in decreasing order of difficulty and this ordering is fed to TLP to produce a schedule.

The vector includes a component corresponding to crew time required. The length of each step is multiplied by the number of crewmen required for the step, and the sum of these terms over all steps in the model is computed to give a figure in crewman-minutes.

The vector includes components for up to 10 resources. On Spacelab mission 1 a total of 4 resources were included: power, high rate multiplex, computer memory, and data transmission. The components for each of these resources were computed by multiplying the length of each step times the level usage of the resource and then summing over all steps.

The vector includes up to 40 components corresponding to various pieces of <u>equipment</u>. As in the case of crew and resources, the number of equipment-minutes is computed by summing the number of minutes a certain piece of equipment is required over all steps of the model. On Spacelab mission 1, a total of 38 pieces of equipment are considered as components of the vector. The vector includes components corresponding to attitude and maneuvers. If a step requires that the Orbiter be performing a certain maneuver the length of the step is multiplied by 9, and if a step requires that no maneuvers are to be performed during its execution the length of the step is multiplied by 1. The sum over all steps of the model then produces the component corresponding to maneuvers. The attitude (Orbiter orientation) component is computed in an analogous fashion.

The vector includes up to 72 components corresponding to <u>targets</u>; Spacelab mission 1 having a total of 50 such components. Once again, a figure in target-minutes is produced for each target and model by summing the number of minutes each target is required by a particular model over all steps of that model.

The vector includes two components referred to as Δ -start and start-time. For the ith model, let M_1 and m_1 denote the maximum and minimum respective times at which the performance of the first step of the model may be initiated. The Δ -start component is

$$\Delta_{i} = L - (M_{i} - m_{i}),$$

where L is the total length of the mission. This component is higher for models which are less flexible with respect to possible starting times. The start-time component is

$$S_i = L - M_i$$
,

and gives higher values to models which must be started earlier in the mission. The start-time figure is included in view of the front-loading nature of TLP which causes the time and resources at the earlier part of the mission to be used up first.

The next step in the ranking algorithms is the <u>normalization</u> of the vectors corresponding to the models. Let v_{ij} denote the jth component of the vector corresponding to the ith model. Hence, if there are m models and n vector components then

$$V = [v_{ij}],$$

is an m-by-n nonnegative real matrix. Spacelab mission 1 corresponds in this fashion to a 218-by-95 matrix. The scaling is obtained by dividing the jth component of each

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vector by the sum of the jth components of all the vectors. That is: we normalize the matrix V to a column-stochastic matrix by dividing each column by its column sum. The targets constitute an exception to this rule. The target time component is normalized by dividing by the total length the target is available during the mission rather than the time the target is required by all the models.

The next step in the ranking algorithm is to evaluate the difficulty function at each model (row of V). The programmer has the option of assigning nonnegative weights; w_j, j=1,...,n, to each of the components of a vector (or alternatively, columns of V). If the ith model has corresponding vector $v_i = (v_{i1}, \ldots, v_{in})$, the <u>difficulty of the ith</u> model is defined by

$$d_{i} = \sqrt{p_{i}} (v_{i1}w_{1} + \ldots + v_{in}w_{n}),$$

where p_i is the number of performances of the ith model requested. The capability of adjusting the weights allows a scheduler to emphasize or de-emphasize certain aspects of the mission deemed more critical or less critical to produce various rankings of the models.

The above described procedure of ranking the models in order is referred to as the <u>model-sort</u> method. A slightly different method referred to as <u>performance-sort</u> was also implemented and tested on SpaceTab missions 1, 2, and 3. The idea behind the performance-sort is to treat each performance of an experiment as a separate model. With the model sort program, all possible performances of a given model are scheduled consecutively. With the performance sort program, each performance of a model corresponds to a vector. For example: SpaceTab 1 lists 935 performances of the 218 models. Hence, when using model-sort, a 218-by-95 matrix is envisioned; and when using performance-sort a 935-by-95 matrix is envisioned. If v_i is the vector previously described which corresponds to a single performance of the ith model, and the ith model requires p_i performances, the difficulty level of the kth performance of the ith model is

 $\sqrt{k} (v_{i1}w_1 + ... + v_{in}w_n); k=1,...,p_i.$

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Another feature of the ranking method is the selection of <u>fixed models</u>. This allows the programmer to specify a certain subset of the models or performances which will be scheduled first. For example, on Spacelab mission 1, such items as "crewman sleep" and "crewman lunch" have model sheets corresponding to them. These models are scheduled first and then the remaining models are ranked using either the model-sort or performance-sort method. On Spacelab mission 1 a total of 16 models were fixed.

Another feature of the algorithm is the <u>model weight</u> capability. This is in some sense dual to the vector normalization in that a row is multiplied by a nonnegative scalar in the model weight feature. This allows the programmer to assign weights to any or all of the models which will change the corresponding vector. This option lets the operator increase the difficulty function of a model which is considered particularly important for political or other reasons not reflected in the difficulty function. The authors used this feature to schedule models which were not included in an otherwise excellent schedule. Successive doubling of the weight of a certain model insures that it will appear higher and higher in the ordering until it is the first model scheduled, if necessary.

RESULTS

We proceed to discuss the results obtained using the previously described methods. The schedule produced due to some choice of sorting technique, weights, fixed models, and model weights is evaluated by means of a grading function which is dependent on four parameters: percentage of crew time, percentage of experiment time, percentage of performances, and percentage of models. The average of these four percentages yields the grade of the corresponding schedule. All four parameters are obtained by comparing amount scheduled to amount requested. In this connection, it should be mentioned that the experiment and crew time requested is the minimum experiment time for experiments whose steps have variable length. Hence, it is possible for the percentage score on experiment and crew time, and the grade, to be over 100. Another fact worth noting is that is possible for a fraction of a model to be performed in some cases. For example, if 3 out of 4 steps in a given model were performed this would be counted The percentage of models reflects the as .75 of a model. extent to which experiment on the mission is performed at least once, and the percentage of performances measures the extent to which all requested experiments (including multiplicities) were scheduled.

For each of Spacelab missions 1, 2, and 3 we include tabulated data comparing the effects of varying sorting technique, weights, fixed models, and model weights. For each mission we include for comparison the best schedule which had been previously produced by the personnel at Marshall Space Flight Center. Their method was to experiment with various orderings, feed them to TLP, obtain some reasonably good schedules, and then to invoke software referred to as TLE (timeline editor) to then shift and fit experiments. The TLE affords the capability of removing and rescheduling a single performance from an existing schedule.

Spacelab mission 1 has undergone the longest development time, and we were unable to exceed the best previous score by our methods. Mission 1 is particularly complicated due to the fact that the set of models chosen for inclusion were selected more for political considerations of being included on the first mission than for compatibility of the various models. It is thought that subsequent missions will be designed around a particular theme such as atmospheric research, materials processing, space physics, biological sciences, or astronomy. On Spacelab mission 1 it was found, somewhat unexpectedly, that the model sort technique worked best. On Spacelab missions 2 and 3, the performance sort worked best and produced schedules superior to the previous best. The overall best results were obtained by using the weights which had produced the schedule with maximal score and then increasing the model weights of those models which failed to schedule. On these missions every model was scheduled for at least one performance. The following three tables summarize the results obtained on these three missions, and compares these to the previous best schedule.
SPACELAB 1

MODELS - 218 -- PERFORMANCES - 935

MIN. EXP. TIME - 4869.71 HRS. -- MIN. CREW TIME - 800.62 HRS.

1						
WEIGHTING	TYPE OF SORT	MODELS	PERFORMANCES	EXP. TIME	CREW TIME	GRADE
ALL EQUAL	MODEL	183.69	858.61	4 <u>9</u> 39.35	756.25	92.99
ALL EQUAL	PERFORMANCE	184.51	851.22	4847.83	757.56	92.46
TARGETS = 10 , Δ -START = 1	MODEL	193.90	884.39	4664.38	762.87	93.64
	an a	• • • • • • •	• • • • • • • •			
PREVIOUS BEST		203,03	897.94	4866,52	751.04	95.73
	and a second		(1,1,1,1,1,1,1,1,1,1,1,1,1,1,1,1,1,1,1,			

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SPACELAB 2

MODELS - 168 -- PERFORMANCES - 1992

MIN. EXP. TIME - 2887.64 HRS. -- MIN. CREW TIME - 647.44 HRS

WEIGHTING	TYPE OF SORT	MODELS	PERFORMANCES	EXP. TIME	CREW TIME	GRADE
ALL EQUAL EXCEPT Δ-START = 0	MODEL	154.54	1931.09	3804.08	682.90	106.54
ALL EQUAL EXCEPT Δ -START = 0	PERFORMANCE	159.50	1971.09	3813.67	693.83	108.28
CREW, RESOURCES, TARGETS, WINDOW SIZE ONLY. (EQUIPMENT AND START TIME = 0)	PERFORMANCE	162.15	1974.09	3820.48	700.44	109.03
ABOVE WITH MODEL WEIGHTS ADJUSTED	PERFORMANCE	164.15	1976.09	3821.98	702.48	10 <u>9</u> .44
PREVIOUS BEST		161.82	1976.65	3808.10	658.08	107.27

SPACELAB 3

MODELS - 61 -- PERFORMANCES - 592

.

MIN. EXP. TIME - 2507.48 HRS. -- MIN. CREW TIME - 569.02

WEIGHTING	TYPE OF SORT	MODELS	PERFORMANCES	EXP. TIME	CREW TIME	GRADE
ALL EQUAL	MODEL	57.03	519.00	2476.10	562.52	94.69
ALL EQUAL	PERFORMANCE	57.70	519.00	2480.03	562.55	95.00
TARGET AND A-START ONLY	PERFORAMCNE	58.90	520.00	2478.37	565.72	95.66
ABOVE WITH MODEL WEIGHTS ADJUSTED	PERFORMANCE	59.77	521.00	2480.97	568.75	96.22
PREVIOUS BEST		57.03	519.00	2484.29	565.94 `	94.92
	-					

CONCLUSIONS

In this section, we indicate some avenues of approach suggested by our investigations. These suggestions arose largely on an intuitive basis, and are in no particular order.

It is certain that experimentation with weights is necessary to implement this algorithm. It appeared that no one weighting would produce the best results for all Spacelab missions. Perhaps a scheme could be developed to give an approximation to the optimal weighting by considering the resource profiles of the specific mission.

The difficulty function could be modified. The difficulty function discussed in the body of this paper was motivated by the sum norm on nonnegative vectors. That is, if $v = (v_1, \ldots, v_n)$ is a nonnegative real vector, the sum norm of v is defined via

$$v_1^{+\dots+v_n}$$

We also experimented with a grading function related to the supremum norm

The results obtained were equal or slightly less than the results described in the previous section. It is rather remarkable that a greater difference was not observed. Further experimentation is possible. Perhaps the Euclidean norm might be investigated.

The grading function could be modified. For example, weights could be assigned to the four parameters involved. Also, the grading function does not take into consideration the evenness of the scheduling distribution. It would be better, for example, if the crew were not completely utilized during the first half of the mission and have a lot of unused time during the second half. Perhaps some mechanism might be devised to give preference to schedules whose resource utilization levels are held fairly constant over the duration of the mission.

An examination of what we shall term a dynamic sort scheme was done. In the method described in this paper no consideration is taken of the fact that a model may become more difficult to schedule if models preceding it deplete the resources it requires. We implemented the following iterative technique to circumvent this phenomena. A re-examination of the normalization procedure employed shows that most components of the vector were normalized by the total amount required by all the models in that component. The target components were normalized by the total available target time rather than the total target time requested. We also experimented with normalizing all components by the amount available corresponding to each component. With this normalization scheme we implemented the following dynamic sort option. In this scheme we would find the most dificult model and then re-normalize the remaining vectors by the amounts remaining of the various resources, etc. This iterative technique has the effect of dynamically increasing the weighting factors on those components which are being depleted fastest. We then assigned various weighting factors and computed the corresponding orderings with and without the dynamic sort The ordering produced with the dynamic sort option option. consistently produced a schedule inferior to the one produced without using the dynamic sort. Even in view of these results, we feel that investigation along these lines might yield superior techniques.

All of the previous discussions have focused on possible ways to improve the method of ordering the models to feed to TLP. Our final suggestion arises from limitations imposed by the front-loading nature of TLP, and involve factors internal to TLP rather than external. With the front-loading scheme. a model is scheduled at the earliest possible time. This results in a schedule which has no flexibility during the first part of the mission. It is fairly certain that this period in the mission is very likely to be plagued with correction and adjustment factors, and perhaps space sickness on the part of the crew. Also, the pieces of equipment are scheduled to begin operation at maximum capacity and then level off. This makes the execution of the mission highly dependent on the Spacelab being able to operate at full capacity immediately. The implementation of a front- or back-loading option on ESP is largely motivated by a desire to avoid this type of scheduling. It would be advantageous to schedule each successive model at the "best" possible time rather than the earliest or latest. "Best" might

be defined by scheduling the model at the time during the mission which keeps the overall resource-available profile the flattest over the duration of the mission. If "best" turns out to be impossible to define, it is possible that even a random choice among possible scheduling times for a model in the sequence might result in a superior scheduling method.

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Continuous Flow Electrophoresis:

The Effect of Sample Concentration on Throughput and Resolution in an Upward Flowing System

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The Effect of Sample Concentration on Throughput and Resolution in an Upward Flowing System

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ABSTRACT

The principle of continuous flow electrophoresis is as follows: a suspension of sample material is introduced as a fine, steady stream into a vertical, flowing "curtain" of electrolyte. A horizontal d.c. electrical field is applied to the curtain. Where a mixture of particles/cells having different electrophoretic mobilities is analyzed, each type particle/cell will assume a different, collectable band position in the curtain electrolyte.

The fundamental behavior of the continuous electrophoretic process in the Beckman Continuous Particle Electrophoresis (CPE) System, with flow in the downward direction, has recently been investigated. The purpose of this research is to determine the effect of sample concentration on throughput and resolution in the CPE System with flow in an upward direction. To maintain upward flow of the curtain buffer and sample stream, and to collect same, certain modifications to the CPE System were made; these also are described.

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INTRODUCTION

As developed by Strickler⁵, Hannig² and their coworkers, continuous flow electrophoresis is a technique for separating small amounts of biological material. In this process, a suspension of sample is introduced as a fine, steady stream into a vertical, flowing "curtain" of electrolyte. A horizontal d.c. field is then applied to the curtain. Where a mixture of particles/ cells having different electrophoretic mobilities is analyzed, each type particle/cell will assume a different, collectable band position in the curtain electrolyte/buffer.

The fluid containing the particles/cells to be separated moves through a thin chamber. The depth of the chamber is dictated by a need to suppress temperature gradients within the chamber and by a need to reduce chamber wall effects, both of which generate undesirable flow characteristics. As a result of these considerations, so-called "narrow gap" (0.5 mm - 3.0 mm) chambers lack sufficient sample capacity and/or resolving power, particularly with respect to separating cell populations.

OBJECTIVES

Though it is unlikely to improve resolution, increasing particle/ cell concentration in the sample should increase sample throughput. However, higher cell concentrations lead to a density mismatch between sample stream and curtain buffer. Small amounts of sedimenting sample, diluted by the curtain buffer subsequently are rapidly displaced within the curtain. This results in broadening of the sample stream and ultimately in poorer resolution at higher sample concentrations.

Tests conducted by McDonnell-Douglas⁶ demonstrated upflow machines to be much more sensitive to the described density mismatch than downflow machines, further limiting sample stream concentration, resolution and throughput of material.

The objective of this study, then, is to determine the limits to throughput and resolution effected by sample concentration in the Beckman Continuous Particle Electrophoresis (CPE) System with flow in the upward direction. The data may then be compared to similar data exacted from the same CPE System, but with flow in the downward direction.

To maintain upward flow of the curtain buffer and sample stream, and to collect the sample, certain modifications to the CPE System were necessary; these will be described.

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MATERIALS AND METHODS

To regulate and maintain upward flow of the curtain buffer and sample stream, a 0-140 volt output powerstat was used in tandem with a variable speed fluid pump. Dilute R-1 buffer' cooled to approximately 4°C was pumped through the curtain flow meter at approximately 28cc/min. with the powerstat set at 90 volts.

Sample injection was accomplished using a Sage Instruments Model 355 Syringe Pump. The sample, contained in a 3 cc syringe fitted with a 21 gauge needle and connected to the sample inlet tube by a short piece of PVC tubing, was injected into the electrophoretic cell at an approximate rate of 1 ml/hr (range 1/100 at 24.3% flow). To prevent sedimentation of the sample contained in the syringe, a small stirring bar was placed within the syringe. A magnetic stirrer supported by the syringe pump housing was then inverted over the syringe.

A prototype of the collection system depicted by Figures 5 and 6 facilitated sample collection. The CPE System collecting tubes were connected to the collection bench by 10 inch lengths of 17 gauge PVC tubing fitted with 18 gauge needles at the tubing's distal end. The needle-containing tubes were seated in the 48 hole array of the collection bench. A 48 testtube fraction collector was placed below the collection bench to receive the eluted sample.

The d.c. field was generated by a Hewlett Packard Model 712B power supply; 65 volts/cm constituted the field for each experimental separation.

Concentrated R-1 buffer was used in the electrode rinse and coolant loops. Dilute R-1 buffer (800 ml R-1 concentrate added to 1.2 liters of deionized water) was used as curtain buffer.

To establish the effect of concentration on throughput and resolution in this CPE system, fixed turkey and cow red blood cells were used. These cells are stable, well-characterized standards, having different electrophoretic mobilities; further, they are morphologically distinguishable⁴.

DATA ANALYSIS

Two data sets were collected; the first data set consisting of seven "runs" at sample concentrations ranging from 5×10^7 cells/ml to 2×10^9 cells/ml (Table 1; Figure 3); the second data set consisting of eight runs at the aforementioned seven concentrations plus one run at a sample concentration of 1.5×10^9 cells/ ml. A 5-minute stabilizing flow followed by 10 minutes of sample collection without (zero) and with (field) voltage applied constitutes a "run". Aliquots of the collected sample were examined microscopically; recovered cells were counted using an Improved Neubauer hemocytometer. Percent recoveries for each cell type and for the combined cells were then determined (Table 1). Based on the total number of recovered cells of each type and of the combined cells, percent relative abundances of the recovered cells were determined. This data, plotted for both data sets, is presented in Figures 1 and 2 as percent recovery of fixed cells vs. concentration, and in Figures 3 and 4 as percent relative abundance of recovered fixed cells vs. tube number.

DISCUSSION OF RESULTS

Examination of Table 1 (1st data set) and Figure 1 reveals that, in general, more cells are recovered at lower concentrations than are recovered at higher concentrations, either with (field) or without (zero) voltage applied. This may be explained as a sedimentation effect; i.e., higher cell concentrations engender a density mismatch between sample stream and curtain buffer. Small amounts of sedimenting sample, diluted by the curtain buffer subsequently are rapidly displaced within the curtain. This results in broadening of the sample stream, "spreading" of cells over a broader range of sample collection test tubes (see higher concentrations Tables 2 and 3 and higher concentrations Figures 3 and 4) and ultimately to poorer sample resolution. This interpretation is supported by the lowered recovery of the larger, heavier turkey cells at higher concentrations (Figure 1) and by the enhanced recovery of the smaller, lighter cow cells at higher concentrations (also Figure 1). In part, the apparent increased recovery of cow cells at higher concentrations is, perhaps, due to examining and counting a greater number of sample collection test tubes. In general, the data of Table 1 (2nd data set) and Figure 2 also fit this interpretation, but with notable exception: the turkey cells do not sediment at higher concentrations. It is, perhaps, significant that the electrophoretic cell was coated with 1% bovine serum albumin, the electrode membranes and electrode rinse replaced, and the buffer temperatures lowered to approximately 4°C between collection of the first and second data sets. These measures, taken to improve CPE chamber performance, may have inadvertently altered the previously noted turkey cell sedimentation behavior.

Tables 2 and 3 and Figures 3 and 4 reveal "spreading" of the sample over a widening range of sample collection test tubes with increasing concentration. This is especially evident at the higher concentrations $(1.5 \times 10^9 \text{ and } 2 \times 10^9 \text{ cells/ml})$ at which the sample stream was observed to "fall back" on the inlet tube; periodically, "clouds" of the sample billowed upward in the buffer flow apparently being transported more rapidly than cells remaining in the sample stream.

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CONCLUSIONS

With particular reference to Table 3 and Figure 4, data collected <u>after</u> treating the electrophoretic cell as described in Discussion of Results, and with voltage applied, it appears that maximum resolution in the Beckman CPE System, with flow in an upward direction, is achieved at concentrations ranging from $2 \times 10^{\circ}$ cells/ml to $8 \times 10^{\circ}$ cells/ml. The widest peak separation is at $2 \times 10^{\circ}$ cells/ml; however, the sharpest peaks and least overlap between cell populations is at $8 \times 10^{\circ}$ cells/ml.

Apparently as a result of improved electrophoresis cell performance due to coating the chamber with bovine serum albumin, changing the electrode membranes and rinse, and lowering buffer temperatures, sedimentation effects attending to higher concentrations are diminished.

As measured by recovery of fixed cells, throughput is greatest at lower sample concentrations (ranging from 5×10^7 to 2×10^8 cells/ml in this study), diminished at moderate concentrations (4 x 10⁸ to 1 x 10⁹ cells/ml) and increasing at higher concentrations (1.5 x 10⁹ to 2 x 10⁹ cells/ml) although not increasing to the higher recovery levels noted for lower sample concentrations.

Throughput as measured by recovery of fixed cells is, then, diminished at the concentrations judged most likely to yield satisfactory resolution. The "tradeoff" appears to be as follows: improved recovery/throughput at the expense of resolution.

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	;		Field			Zero				
Concentration	Data		% Recovery			% Recovery				
(Cells/ML)	Set	Comb.	Turkey	Cow	Comb.	Turkey	Cow			
5×10^{7}	1	87.22	77.4	98.04	92.88	108.36	77.4			
	2	76.38	64.06	89.7	98.56	118.28	78.84			
1×10^8	1	65.79	69.66	61.92	74.82	98.04	51.6			
	2	68.99	81.32	56.67	70.22	86.24	54.2			
2 x 10 ⁸	1	74.18	83.84	64.5	81.27	81.28	81.28			
	2	69.61	80.08	59.14	53.59	46.82	60.36			
4×10^{8}	_1	55.15	57.4	52.88	53.86	50.96	56.76			
	2	43.12	35.72	50.52	43.12	37.58	48.66			
8 x 10 ⁸	1	48.86	45.8	51.92	42.73	42.24	43.22			
	2	48.05	53.9	42.2	30.18	32.64	27.72			
1×10^9	1	50.31	37.66	62.96	39.22	28.9	49.44			
	2	29.81	15.28	44.36	48.17	28.08	68.26			
1.5 x 10 ⁹	2	54.7	71.95	37.45	27.6	31.7	23.48			
2 x 10 ⁹	1	53.66	26.44	80.88	41.34	29.02	53.66			
	2	58.27	60.98	55.56	54.45	53.1	55.8			

TABLE 1. RECOVERY OF FIXED CELLS AT INDICATED CONCENTRATION WITH (FIELD) AND WITHOUT (ZERO) VOLTAGE APPLIED FOR FIRST (1) AND SECOND (2) DATA SETS

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TABLE 2.	PERCENT RELATIVE ABUNDANCE (FIELD) AND WITHOUT (ZERO)	OF RECOVERED CELLS BY VOLTAGE APPLIED FIRST	TUBE NUMBER AT DATA SET	INDICATED CON	CENTRATION (CELL	S/ML.) WITH

	5×10^{7}				1 x 10 ⁶				2 x 10 ⁸				4 x 10 ⁸			
Tube	Tur	key	Co	W	Tur	key	Co	Ŵ	Tur	key	Cow		Turkey		C	ow
#	Zero	Field	Zero	Field	Zero	Field	Zero	Field	Zero	Field	Zero	Field	Zero	Field	Zero	Field
21 22 23 24 25 26 27 28 29 30 31 32 33 34 35 36	4.76 0 4.76 57.14 19.05 14.29 0	0 13.33 13.33 46.67 13.33 13.33 0	0 20.00 33.33 40.00 0 6.67 0	0 10.53 10.53 31.58 42.10 5.26 0	0 26.32 57.90 15.79 0	0 7.41 14.82 40.74 29.63 7.41 0	0 5.00 20.00 55.00 10.00 10.00 0	0 4.17 11.11 29.63 40.74 0 3.70	0 3.18 31.75 49.21 15.87 0	0 7.69 32.31 53.85 4.62 1.54 0 1.54	0 31.75 56.92 9.23 0	0 2.00 3.08 0 2.00 29.23 24.62 15.38	0 1.27 35.44 58.23 5.06 0	0 31.46 61.80 6.74 0	0 35.23 60.23 4.54 0	0 1.22 4.88 51.22 35.37 7.32 0
	••••••••••••••••••••••••••••••••••••••						.	A	·		<u></u>		<u> </u>	<u>.</u>	å	l

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TABLE 2: PERCENT RELATIVE ABUNDANCE OF RECOVERED CELLS BY TUBE NUMBER AT INDICATED CONCENTRATION (CELLS/M.L.) (Cont'd) WITH (FIELD) AND WITHOUT (ZERO) VOLTAGE APPLIED FIRST DATA SET

		8 x	108		1×10^9				1.5 :	2×10^9				
Tube	Tur	key	C	W	Tur	key	Cơ	W	Turkey	Cow	Tur	key	Con	7
#	Zero	Field	Zero	Field	Zero	Field	Zero	Field	Zero Field	Zero Field	Zero	Field	Zero	Field
14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 29 31 32 33 45 36 37 38 940	0 1.53 12.21 61.83 24.43 0	0 8.45 42.96 42.25 6.33 0	0 8.21 63.43 28.36 0	0 0.62 0.62 6.83 55.28 36.02 0	0 0.89 0.89 31.25 64.29 2.68 0	0 2.74 13.70 31.51 30.82 14.38 6.16 0.68 0	0 0.52 40.62 56.77 1.56 0.52 0	0 0.82 14.34 31.97 32.79 16.80 3.28 0	Did not collect this concentration first data set	Did not collect this concentration first data set	$\begin{array}{c} 0\\ 0.44\\ 0\\ 1.33\\ 1.33\\ 0.89\\ 0.44\\ 0.44\\ 0\\ 0\\ 0\\ 0.44\\ 1.33\\ 0.89\\ 2.67\\ 9.78\\ 31.56\\ 35.11\\ 10.22\\ 2.22\\ 0.44\\ 0\\ 0.44\\ 0\\ 0.44\\ 0\end{array}$	0 0.98 0.49 0.49 0.49 1.46 5.85 10.73 29.27 20.98 17.56 7.32 2.93 0.98 0	$\begin{array}{c} 0\\ 0.24\\ 0.48\\ 1.20\\ 0.48\\ 1.20\\ 0.96\\ 0.24\\ 0.24\\ 0\\ 0.96\\ 0.72\\ 0\\ 1.44\\ 3.36\\ 6.49\\ 30.05\\ 34.13\\ 11.54\\ 2.64\\ 2.16\\ 0\\ 0.24\\ 1.20\\ -\end{array}$	0.32 0.16 0.96 7.18 25.52 24.88 24.88 14.20 1.91 0.32 0 0.16 0

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 Table 3.
 PERCENT RELATIVE ABUNDANCE OF RECOVERED CELLS BY TUBE NUMBER AT INDICATED

 CONCENTRATION (CELLS/ML.) WITH (FIELD) AND WITHOUT (ZERO) VOLTAGE APPLIED:

 SECOND DATA SET.

		5 x 10 ⁷			1 x 10 ⁸			2×10^8				4×10^8				
Tube	TUR	KEY	C	OW	TUR	KEY	CC	DW.	TUR	KEY	С	OW	TUR	KEY	C	WC
#	zero	fleld	zero	fleld	zero	field	zero	fleld	zero	field	zero	field	zero	field	zero	field
13 14 15 16 17 18 19 20 21 22 23 24 25 26 27 28 30 31 32 34 35 36 37 38 39 40 41 42 43 44	0 56.25 37.5 6.25 -	0 7.69 23.08 46.15 23.08 0	0 4.17 50.00 45.83 0	0 61, 11 27. 78 11. 11 0	0 2.86 5.71 45.71 42.86 2.86 0	0 9.09 42.42 36.36 9.09 3.03 0	0 18.18 50.00 31.82 0	0 8.70 17.39 34.78 39.13 0	0 7.89 36.84 36.84 18.42 0	0 3.08 13.85 43.08 21.54 18.46 0	0 6.12 18.37 53.06 22.45 0	0 2.08 31.25 47.92 16.67 2.08	0 16.40 70.49 13.11 0	0 1.72 36.21 48.28 13.79 0	0 1.27 16.46 59.49 22.78 0	0 3.66 39.02 46.34 10.98 0

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		8 🤋	108 4		1×10^9					1.5	x 10 ⁹		2×10^9			
F	TUE	KEY	C zero	OW field	TUF	KEY	C	OW lfield	TUR	KEY field	C	OW field	TUR	KEY field	C zero	OW field
	0 4.72 83.02 12.26 0	0 2.29 14.86 62.86 15.43 4.57 0	0 8.89 68.89 20.00 2.22 0	0 5.84 65.69 22.63 5.11 0 0.73 -	0 1.75 22.81 62.28 12.28 0.88 0	0 11. 29 51. 62 24. 19 12. 90 0	0 2.89 26.35 57.04 12.64 1.08 0	- 1.12 0 0.56 0.25 27.53 35.39 32.58 1.12 0.56 0	0 10.35 1.04 0.52 0 56.48 26.42 1.04 2.07 2.07 0	0 0.68 0.46 0 0.91 2.28 5.48 20.78 26.94 18.95 17.35 4.57 1.37 0 0.23 0	0 3.50 27.27 11.89 3.50 37.76 13.29 2.10 0 0.70 0	0 0.88 0.44 0 0 1.75 11.84 23.25 26.75 29.39 3.07 2.19 0 0.44 0	0 0.23 0.23 3.02 10.90 25.99 34.34 19.95 5.10 0.23	0 0.20 0.81 0.40 0.81 1.62 4.24 15.35 23.03 45.66 7.68 0.20 0	0 0.44 2.43 12.58 25.39 30.46 22.52 6.18 0	0 0.22 1.33 12.42 45.23 29.49 9.76 1.55 0
	1							:								

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PERCENT RECOVERY.

Figure 1. Percent Recovery of Fixed Cells vs. Concentration with (Field) and without (Zero) Voltage Applied: First Data Set.



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Percent Recovery of Fixed Cells vs. Concentration with (Field) and without (Zero) Voltage Applied: Second Data Set. Figure 2.



PERCENT RECOVERY

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Percent Relative Abundance of Recovered Fixed Cells vs. Figure 3. Tube Number at Indicated Concentration With (Field) and Without (Zero) Voltage Applied: First Data Set.

PERCENT RELATIVE ABUNDANCE





- - 6



PERCENT RELATIVE ABUNDANCE

Figure 3. Continued

Figure 3. Continued

PERCENT RELATIVE ABUNDANCE

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TUBE NUMBER



Figure 4. Percent Relative Abundance of Recovered Fixed Cells vs. Tube Number at Indicated Concentration With (Field) and Without (Zero) Voltage Applied: Second Data Set.

PERCENT RELATIVE ABUNDANCE

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PERCENT RELATIVE ABUNDANCE

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PERCENT RELATIVE ABUNDANCE

Figure 4. Continued



PERCENT RELATIVE ABUNDANCE

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Continuous Particle Electrophoresis (CPE) System: Collection Bench/Syringe Pump Support Platform.

Figure 6.

1980

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MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

MODELING A MAINTENANCE SIMULATION OF THE GEOSYNCHRONOUS PLATFORM

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Contract No. :		NGT-01-002-099 (University of Alabama)					

MODELING A MAINTENANCE SIMULATION OF THE GEOSYNCHRONOUS PLATFORM

by

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ABSTRACT

With the advent of the Space Transportation System it will be possible to service equipment in space. In particular the effect of a maintenance capability for the Geosynchronous Platform (GSP) needs to be examined. Because of the size and complexity of the GSP, analytic results in this area are beyond reach. Hence a simulation study comparing various maintenance routines appears to be the most fruitful approach. The purpose of this report is to outline the basic model which will be used to conduct such a study. Information is included on the computer model and maintenance. A sample system is also modeled.

Acknowledgements

The 1980 NASA/ASEE program has provided me with many benefits both professional and personal. I would like to thank the following people for their assistance this summer: Jim Steincamp, my counterpart, for providing me with an interesting problem and the time to understand it; John Cole, Chief of the Operations Analysis Branch for providing support for my work; Dr. Barfield and Marion Kent for the running of the program; Ronnie Barnes, John Springer and Hank Stoll, fellow participants, for a stimulating carpool and friendship for 8 weeks; Dawn Walton, Carol Byler and Janet Coker for typing this report, and most importantly Mary, Alex and Mimi for making a home away from home for the summer.
1. Introduction

With the advent of the space transportation system NASA will be able to implement a new approach to the reliability of space missions. Rather than build for the mission life from the start it will be possible to visit spacecraft for the purpose of servicing the equipment. The Geosynchronous Platform (GSP) provides a particularly good example of the possibilities of this service for two reasons: (1) GSP will have an extended mission life, 10 to 16 years, requiring heavy redundance costs if maintenance is not available and (2) GSP will serve the communications industry with projected increases in demand over the course of the mission, thus the ability to increase capability is a valuable option.

An analysis of service for GSP is to be carried out to determine if maintenance is a viable concept and to aid in the scheduling of such if it proves feasible. One approach to this problem is to seek an analytic solution by techniques in decision analysis, such as in [1]. The size of this problem however precludes such an analysis (see for example the "small" sample system in Chapter 3). A numerical approach to the same problem can be developed by means of simulation.

Since the problem of maintenance will arise in other settings besides GSP it is useful to develop a general simulation method. Such a method should allow for the incorporation of special features which arise in individual problems such as the need to increase capacity that is an important part of the GSP. This method should be able to accept different mission types and different maintenance policies and produce data which indicate which policies are better.

This report is a preliminary one on work done to develop such a general method. The method is based on earlier work of Dr. J. Steincamp of the Marshall Space Flight Center. Specific details of the method may be found in [3].

2. Objectives

The immediate objective is to construct a simulation model which can be used for an analysis of maintenance for the GSP. It is required to find out if maintenance is an economic approach and if so how it should be carried out.

A more general objective is to develop a method which can answer the above questions for many different space missions. The method is to accept as input the particular system and be capable of running the system through a mission life with different maintenance policies.

This report contains an overview of such a method. The system model is described and illustrated, the basic concepts of a simulation pass are detailed and sections on failures and maintenance are included.

3. The System Model

3.1 Introduction

An operating, physical system may be considered from many points of view. For the purpose of a maintenance simulation two such points of view are required. When a piece of equipment fails it must be replaced, so its location and accessibility are important. Hence a geometric or physical model of the system which details the replacement relationships among the parts is necessary. More over, in order to carry out a program of part failures on the system, it is necessary to have a model of the system's functional or operational mode.

The operation of the system requires that a physical part fail, the operational effects of this failure be carried out and a determination of the need for maintenance of the system be checked. Hence the physical and operational models must be interrelated. The interrelation will be carried out at the most elementary level of the system by identifying the individual parts which fail, called items, with the lowest level operations carried out by the system, called basic functions. Hence forth the dual nature of these items/basic functions will be emphasized by the name IBF. Thus an IBF can be considered either as a specific physical part which supports a basic function of the system or as a basic operation which is performed by some physical item.

3.2 The Physical Model

Inspace fine tuning of systems will not be available in the foreseeable future. Rather, when a part fails some package which contains the failed part will be replaced. This package may contain other parts which have failed as well as good ones. Such a package is called a module. More generally, a module is a replaceable or stockable unit which may contain both items and other modules (sub modules). Each item belongs to same, smallest module. A module which contains only items is called a simple module, one which contains only other modules is called pure and a module which is neither simple nor pure is called mixed. The smallest module which can be used to replace the failed item is said to contain the item.

In a physical system with planned redundancy there will be many instances of duplication. Identical parts will be used in various places and essentially similar but distinct modules will be used for replacement purposes. Although duplicate items will have the same failure distributions, the randomness of the actual failures requires that each physical part be individually represented in the computer model. As a result replacement must be performed and recorded for each module rather than on the classes of similar types. On the other hand it is desirable to take advantage of the similarities among the items and modules for efficient input of the system. For instance if only separate types of items and modules must be entered in the computer a good deal of labor can be saved. Also the identification of these duplicates can streamline ordering, packing and inventory procedures and costs. This identification is established by the concept of generic items and modules. The essential features of each type of item and module are entered into the machine and these types are referred to as generic. The specific items are then identified with the basic functions of the operational model to form the actual IBF's which form the base of the system. It is the IBF's which actually fail according to the failure rule prescribed for each generic item. The actual physical instances of the modules are created by the computer as copies of the appropriate generic module. Records of maintenance are kept for specific modules.

One further feature regarding the physical model of the system is useful. When an IBF fails there are several possibilities for replacement. The IBF may already be scheduled for replacement because it is contained in some module which is to be replaced as a previous failure or because its containing module is a submodule of same module scheduled for replacement. In this case the failure is noted but no adjustment need be made to the list of modules to be replaced. On the other hand if the module containing the IBF was not previously scheduled for replacement it is necessary to add it to the list of modules to be replaced. Moreover any module previously scheduled for replacement whose replacement will be included with the new module should be removed from this list. This procedure is accomplished by distinguishing between kitted and packed modules. A packed module is any module which is scheduled for replacement, either of its own right or because it is contained in some such module. A module is kitted only if it is to be replaced in its own right. Thus, if a module not on the packed list must be replaced, it is to be added to the kitted list, any module which will be replaced with it is removed from the kitted list and all such modules are put on the packed list.

3.3 The Operational Model

Each system has one overall mission or function to perform. This function is accomplished by subfunctions each of which contributes something to the operation of the whole system. Usually, each subfunction can be divided further into functions whose composition is the subfunction. This process of dividing functions into lower level functions until functions which are performed by the basic items of the physical model are reached. These functions, which are called basic functions, are identified with the physical items that perform them and form the IBF's upon which the system rests. Thus the operational mode of the system modeled by a treegraph. The nodes correspond to the various functions with the root node representing the overall system function and the terminal nodes the IBF's.

Each function has a set of attributes which are used for defining the system state, processing failures and keeping records. The tree like structure of the system is defined by the attributes chief and base. The chief of a function is the immediate superior of that function in the tree while the base is the set of immediate subordinates of the function. The duty cycle of a function is that proportion of its chief's operating time which it must operate while the condition indicates if the function exists, is online, in standby or has failed. For the purpose of implementing failures, several attributes such as figure of merit, reserve and a user defined index are useful (these are illustrated in the section on failures). Attributes such as operating life, on line time, number of times failed and time to first failure are useful for record keeping and statistics gathering. Each basic function also has a set of failure distributions which are used to cause failure events (see the section on failures).

3.4 A Sample Model

Some of the preceeding concepts are illustrated by the sample model with function tree as displayed in Figures 1-4 and module definitions as in Table 1. This model is for a simplified GSP type system with 119 IBF's, 5 generic modules and 200 functions. Note that in this model several of the modules contain only one IBF and since there is no nesting of modules the distinction between kitted and packed modules does not arise. Each node of the function tree is identified by name and initial duty cycle modifier. Failure rules are included for the non basic functions. The failure distributions for the IBF's are indicated in Table 2.



PARTIAL FUNCTION TREE - SAMPLE SYSTEM



condition and one in ready condition. A channel is switched from ready to on if (a) one of the other 5 subfunctions of its chief fails or (b) a channel fails in some other XPDRSET and no backup is left in that set. The XPDRSET will stay on as long as at least one of its channels is on.

FIGURE 2

XPDR GROUP TREE - SAMPLE SYSTEM





XPDR SET DETAILS - SAMPLE SYSTEM

.







* duty cycle is 66% until first failure then 100%.

FIGURE 4

DETAILS - SAMPLE SYSTEM

MODULE	NUMBER NEEDED	WEIGHT (Kgs)
XPDR GROUP	3	5.2
RCVR PK	1	2.1
IRA	1	3.4
FHST	4	1. 2
RW	3	5.1

Payload Capacity of tug is 7.0 Kgs.

Minimum Capability of system is to be 15 channels over a 10 year life.

Desired statistics are

- 1. time average of on line capacity (# of transponders)
- 2. time to first maintenance
- 3. number of times maintenance scheduled due to weight
- 4. number of times maintenance scheduled due to capability
- 5. sample mean and variance for the randum variables
 - a. pass duration
 - b. tug payload weight

TABLE 1

SAMPLE SYSTEM DEFINITIONS

NAME	NUMBER NEEDED	FAILURE DISTRIBUTION
TDA, AMP & ATTN	36	Expon,.488, .0488
TWT, AMP & ISOL	36	Expon, 2.795, .2795*
RFSW, MVX, FLTR & I	50L 18	Expon, .811, .0811
TDA	6	Expon, .4, .04
TDAB	4	Expon, 1.811, .1181
LOC OSC	4	Expon, 1.6, .16
DRIRU	4	Expon, 15.0
RFSW	3	Expon, .025
FHST	3	Expon, 4.411, .4411
RW	3	Expon, 15.0
RCVR, INL, SW & FLTE	2	Expon, .095,

* Also a drop dead time of 26298 hours

TABLE 2

IBF DEFINITIONS FOR SAMPLE SYSTEM

4. The Simulation Model

4.1 Introduction

As previously indicated, the complexity of this problem suggests an analysis by simulation. For this purpose, the operation of the system across time is best modeled by a discrete event approach with two basic events - failure and maintenance of the system. Various languages are available for such a simulation. In particular, the language SLAM with its discrete event capability and its built-in use of FORTRAN is appropriate in this context (See [2]).

Each overall simulation run will consist of introducing a particular model of the physical system, together with a maintenance policy, demand function and mission lifetime. The system is then run through many passes, each pass corresponding to one mission and the model is re-initialized before each pass. Statistics are compiled at the end of each pass and after the last pass a report is printed. Items of interest typically include the time to first maintenance, total number of maintenance trips for each pass, average capability of the system, etc. The remainder of this section will treat PASS, the subroutine package which completes each simulation pass. The problem of loading the system model is a significant one and has not yet been fully developed - see the section on recommendations and conclusions.

4.2 <u>PASS</u>

The PASS routine sets the system in initial condition, schedules failures of IBF's, carries out failures, schedules maintenance, when required, performs maintenance, increases capability in response to demand, terminates the mission and keeps records.

Several assumptions about the computer model need to be detailed. 'The model is to be capable of increasing the system capability in response to demand. This is done by building the model to its full size at the beginning and introducing a condition DOES NOT EXIST for excess equipment. This equipment is then "brought into existence" during maintenance missions as it is needed. Additionally, some procedure must be chosen for terminating a pass. The standard procedure for this method will be to discontinue maintenance when the mission horizon is reached and then to terminate the mission when the system figure of merit drops to some cutoff point.

Table 3 gives the basic flow ideas of PASS and its major subroutines. These ideas are amplified in the pages following Table 3. PASS

INITIALIZE SAMPLE TIME TO FAIL FAIL MAINT DEMAND MAXTIME STAT

FAIL

MAINT

STORE

DEMAND

IMPACT STAT TIME TO FAIL SMAINT

HEAL MODIFIED FAIL ADDON SAMPLE TIME TO FAIL STAT TURN ON UPDATE SDEMAND TIME TO FAIL STAT

TABLE 3

FLOW IDEAS FOR PASS AND ITS MAJOR SUBROUTINES

INITIALIZE	Sets the model into its initial condition at the start of each pass, each IBF is set to its proper starting condition, duty cycles are computed.
SAMPLE	Input is a set of IBF's, output is the time to fail in on-line (TTFO) and standby (TTFS) modes for each IBF in the input set.
TIME TO FAIL	Input is a set of IBF's, output is the time to next failure for this IBF (see section on Failures for details).
FAIL	An event subroutine which carries out the details of a failure (see Table 3 and below).
MAINT	An event subroutine which carries the details of maintenance (see Table 3 and below).
DEMAND	An event subroutine which carries out the details of "creating" new capacity for the GSP (see Table 3 and below).
MAXTIME	When the mission horizon is reached this routine terminates all maintenance and sets a test for mission termination.
STAT	A general routine which uses the SLAM statistics collection capability to record desired statistics.
IMPACT	Uses actions to carry out the effect of failures on the function trees (see section on Failures).
SMAINT	Uses a given maintenance policy to test the need for maintenance and to schedule maintenance when required.
STORE	Keeps the current records of those failed IBF's which will not be replaced during the current maintenance.
HEAL	Similar to initialize, however, all functions, including those which have been added in response to demand, are set to their initial state.
MODIFIED FAIL	A reduced version of FAIL, this routine refails all IBF whose records have been saved in STORE, no records are kept and no new failure times are required.

ADD ON	All equipment which is "delivered" on the current maintenance mission is "brought into existence" and statistics gathering is started.
TURN ON	New equipment is brought on-line in response to increasing demand.
UPDATE	The system definition which is used to HEAL the system for maintenance is brought up to date.
SDEMAND	The known demand curve is used to schedule the next DEMAND.

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5. Failures

5.1 <u>IBF Failures</u>

In general, each IBF has a failure distribution with known parameters. Sample time to fail are drawn from this distribution for both on-line (TTFO) and standby (TTFS) modes. The proportion of on-line time (i.e., the duty cycle), \triangleleft , is then used to project the time to fail in each mode. The Red Life Method of failure is assumed here (see [4, page 16]) so that the minimum of these prorated times is used as the time to next failure (TTF) of the IBF. Thus,

TTF = MIN
$$\left\{ TTFO/a , TTFS/(1-a) \right\}$$
.

Variations of this rule occur when the IBF will not fail in standby mode, TTFS =, when it is on, d = 1, or off, d = 0, over an entire interval or when a drop dead time (DDT) requires that the item must fail after a fixed time. These variations are handled by adding or dropping terms in the preceeding formula.

I some other IBF fails first, say after ΔT time units, then the failure times are adjusted by:

TTFO = TTFO -
$$\mathcal{A}(\Delta T)$$
, TTFS = TTFS - (1- \mathcal{A})(ΔT), DDT = DDT- (ΔT)

where \mathbf{d} is the duty cycle of the preceding period. The computation then proceeds as before.

5.2 Failure Propagation

When an IBF fails, a message announcing this failure must be transmitted to its chief. The chief must then react to this message, perhaps issuing orders to its subordinates or send messages further up the function tree. This process must be repeated at each function which receives a message until all effects of the original failure are carried out.

These messages are delivered by means of actions. An action is an internally generated message which includes an ORIGIN (the originating function), a TARGET (the receiving function) and a CMD/CAUSE (a command to change state if the action is directed to a subordinate, a cause if the action is directed to a chief).

Several assumptions are made concerning actions. First among these is the assumption that no function will issue a command to a subordinate unless the subordinate is capable of carrying out the command. Another is that downward actions are always carried out before an upward action. (Actions are filed in a last in - first out set called ACTS).

5.3 A Standard Failure Rule

Let F be a function with a n/((2+m)) failure rule. That is, F has (2+n)identical subordinates and requires that n be in an up condition for F to be up. Further, in the initial state \mathfrak{L} of the subordinates are up ($\mathfrak{L} \ge \mathfrak{n}$) and m have condition ready. The first m failures have no effect on the operation of F, the next **l** -n failures each cause a decrease in the figure of merit of F while the $(\mathbf{Q} + \mathbf{m} - \mathbf{n} + 1)$ th failure causes F to fail. The attributes INDEX, FOM and **RESERVE** are used as follows: INDEX is a user-defined index which assigns to each subordinate of F an integer such that in the initial state the first λ subordinates are up and the last m are ready; FOM is the figure of merit of F, if F is up FOM(F) is the number of subordinates which are on, otherwise FOM(F)=0; RESERVE is a pointer which indicates the lowest index of a subordinate in a ready state, when no such subordinates remain, RESERVE is set to zero. Thus, if FOM(F) \geq N, and S is a subordinate of F, then INDEX(S) is less than RESERVE(F) if COND(S) = UP and greater than or equal to RESERVE(F) if COND(S) = READY. The function F can receive two kinds of notices: a failure notice from a subordinate or a notice to go to a ready state from its chief. The next several tables outline the flow ideas in these two cases.

5.4 A Special Failure Rule

In the sample system of section 3, the XPDRSET's have a special failure rule. Each XPDRSET starts with six channels, five on-line and one standby. When a first channel fails, the standby, if still available, is turned on. When a second fails, the XPDRSET forwards an action to its chief asking that a channel in some other set be turned on if any standbys are left in the system. This can be implemented by using the figure of merit for each XPDRSET to be the number of channels on-line and the reserve to be the number in standby mode. The same meanings are attached to the attributes for each XPDR GROUP while the attributes of ME are the sum of the attributes of all these XPDR GROUPS.

* a failure message has been received by F from subordinate S

IF FOM(F)=0 THEN RETURN	* this failure occurred when F was not up
ELSE	
IF FOM(F)=N THEN GO TO FAIL	* this caused F to fail
ELSE	
IF RESERVE(F)=0 THEN FOM(F)=FOM(F)-1	* no standby left, F does not fail
ELSE	•
IF INDEX(S) $>$ RESERVE(F) THEN RETURN	* a stanby beyond the pointer failed
ELSE	
IF THERE IS A T IN BASE(F) WITH	* at least two standbys before the failure
COND(T) = READY AND INDEX(T)	
\$ RESERVE(F) THEN	
IF RESERVE(F) \leq INDEX(S) THEN CREATE	* failure was on-line, turn on first standby
\$ AN ACTION AS FOLLOWS	
TARGET (ACTION) = $RESERVE(F)$	
ORIGIN (ACTION) = F	
CMD (ACTION) = UP	
FILE ACTION IN ACTS	
RESERVE(F) = INDEX OF FIRST MEMBER	* move pointer to next standby
\$ OF BASE WITH COND = READY	• • • •
ELSE	* RESERVE(F) is only standby
IF RESERVE(F) \lt INDEX(S) THEN CREATE	* failure was on-line, turn on reserve
\$ AN ACTION AS FOLLOWS	
TARGET (ACTION = $RESERVE(F)$	
ORIGIN (ACTION) = UP	
FILE ACTION IN ACTS	
RESERVE(F) = 0	* no reserves left
RETURN	

STANDARD FAILURE RULE

* the FAIL part of the standard failure rule

FAIL:

COND(F) = FAIL FOM(F) = 0 CREATE AN ACTION AS FOLLOWS TARGET (ACTION) = CHIEF(F) ORIGIN (ACTION) = F CAUSE (ACTION) = FAIL FILE ACTION IN ACTS FOR EACH S IN BASE(F) WITH COND = UP CREATE AN ACTION AS FOLLOWS TARGET (ACTION) = S ORIGIN (ACTION) = F CMD (ACTION) = READY FILE ACTION IN ACTS * adjust attributes of F

* send action to chief

* send action to all subfunctions which are up

RETURN

TABLE 5

FAIL

\$

* F is sent an action to go to ready state

```
COND(F) = READY
FOM(F) = 0
FOR EACH S IN BASE(F) WITH COND = UP
$ CREATE AN ACTION AS FOLLOWS
TARGET (ACTION) = S
ORIGIN (ACTION) = F
CMD (ACTION) = READY
FILE ACTION IN ACTS
RETURN
```

* adjust attribute of F

* send action to all subordinates which are up

TABLE 6

DOWNWARD ACTIONS FOR STANDARD FAILURE RULE

6. Maintenance Policies

6.1 Introduction

It is assumed that demand, D, for the GSP capacity will increase as a function of time and that the demand is known in advance. The minimum acceptable capacity, MC, is typically of the form D + constant where the constant is a "cushion" designed to avoid penalty costs. The nominal capacity, NC, is a desirable level for ordinary purposes. As time increases NC - MC will typically decrease (refer to Figure 5).

At the initial time of the mission, capacity will be NC (0). As time increases failures will occur. Some of these failures will be in the support system and will not cause any decrease in capacity, others will cause such a decrease. For example, in Figure 5 the broken line gives the actual capacity of the system (AC). Capacity failures occur at points 1 and 3, subsystem failures at 2 and 4.

The intent of the simulation is to minimize the cost of maintenance. In order to do this, two sources of cost are considered: (1) the cost of the delivery system, and (2) the inventory cost of delivering capacity before it is needed. The major cost of the delivery system is independent of payload size, thus a trip with less than full payload is inefficient. There exists one or more size limits on the payload (e.g., weight, volume) and these are grouped under the heading size limit. When the first of these is reached, the payload is full. It is never possible to fly with a payload in which the size limit is exceeded.

The inventory cost is kept small by keeping the capacity between the minimal and nominal capacity. Because penalties occur when the capacity is below the minimum the requirement AC \rightarrow MC will be enforced. Thus, whenever the payload is full or the actual capacity drops to the minimum, a service mission is scheduled. Since it is desirable to keep the payload as large as possible and the capacity as close to nominal capacity as possible, two different policies arise. It is assumed that there exists a supply list which contains, in the order needed, the items necessary to bring the mission to nominal capacity.

6.2 Size Constrained Policy

When a failure occurs the proper replacement parts are loaded and a test is made to determine if the size limit has been reached. If so, the service mission is launched. If the size limit has not been reached, the current value of AC is compared to MC. If AC = MC all available space is filled with modules from the supply list and the mission is launched. Under this policy, a service mission always flys a full payload but no relation between AC and NC can be drawn.

6.3 Capacity Constrained Policy

When a failure occurs the proper replacement parts are loaded and so are those items on the supply list which will bring the capacity up to NC at the time of failure. Size and capacity tests are then checked to see if a mission should be launched at the current time. If a size limit is not reached before the actual capacity drops to MC, the launch then takes place when AC = MC. This approach always brings the actual capacity of the system up to the nominal capacity but may produce less than full payloads.

6.4 An Additional Problem

Since failures come at distinct points in time with discrete jumps in capacity (and corresponding payload) it may be that at some point the payload is below the size limit and AC is above MC, however, at the next failure either AC is less than MC or the payload is greater than the size limit. Since minimal capacity is demand plus a cushion, the mission should be flown at once with no change of plans if AC falls below MC. In the case that payload has exceeded the size limit, a problem arises since the size limit is an absolute constraint, the mission cannot be flown if it is violated. In this case, the procedure will be to remove the last package(s) which caused the limit to be exceeded, mark these packages as first on the next service mission and fly the current mission.



TIME

FIGURE 5 CAPACITY CURVES

7. Conclusions and Recommendations

The problem of maintenance of space missions is a serious one and the method outlined herein is a useful tool for approaching this problem. The particular problem of GSP maintenance is a significant one and will be a good test of the method.

Development of tools to solve the GSP problem, starting with the sample system of Chapter 3, will provide significant progress toward the general method.

Among the problems which arise in the implementation of the method one in particular deserves special study. Just as many modules have the same features and can be built into the computer model by the generic module concept, so to many functions one duplicates. A concept of generic function would be useful in this respect (one estimate is that the final GSP model will have 30 identical XPDR GROUPs rather than the 3 of the simple system). In the general case it cannot be assumed that identical basic functions will belong to the same module types. Thus any concept of generic function must allow for the placement of specific IBF's in different modules.

It is recommended that work on this problem continue in two directions. First that a simulation package actually be built and run for GSP and second that work on the general method continue beyond the GSP version of this problem.

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AXIALLY SYMMETRIC MOTION OF A ROTATING STRATIFIED FLUID

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AXIALLY SYMMETRIC MOTION OF A ROTATING STRATIFIED FLUID

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ABSTRACT

A spherical model of the general circulation of the Earth's atmosphere is planned for Spacelab. In order to provide adequate support for the experiment, analytical and numerical studies and simulations must be done. Therefore, an analysis of an earlier effort by Joseph Pedlosky in the area of spherical modeling of geophysical fluid flow is examined. Possible extension of his work is considered and alternative approaches suggested. Recommendations are made for future investigations.

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NOMENCLATURE

\mathcal{L}	magnitude of the angular velocity vector
R	radius of inner sphere
D	distance between inner and outer spheres
J.	kinematic viscosity
vo	velocity scale factor
$E = \frac{v}{200^2}$	Ekman number $(= \frac{1}{2} E_{1})$

$$\varepsilon = \frac{V_0}{2\Omega R}$$

ΔT temperature difference between inner and outer spheres

 α coefficient of thermal expansion

X thermal diffusivity

g gravitational constant

 $\beta = \frac{q_{\alpha} D \delta \Gamma}{4 \Omega^2 R^2} \text{ thermal Rossby number } (= \frac{1}{4} S)$

T temperature (scaled)

p pressure (scaled)

P density

 $S = \mathcal{V}_R$ aspect rates

u eastward velocity (scaled)

✓ northward velocity (scaled)

ω vertical velocity (scaled)

$$\mu \equiv \sqrt{\frac{1}{2}} | \rho \dot{\rho} \theta |$$

$$\rho g h \theta \equiv \begin{cases} 1, \theta > 0 \\ -1, \theta < 0 \end{cases}$$

$$q' \equiv \frac{d \varphi}{d \theta}$$

.

•

1. INTRODUCTION.

When the Space Shuttle becomes operational some of the flights will take into orbit a laboratory known as Spacelab. A principal use of Spacelab will be the exploitation of the low gravity environment of the shuttle for scientific and technological investigations. In particular, it will be possible to perform geophysical fluid flow model experiments in true spherical geometry. A radial dielectric body force, which is analogous to gravity, can be achieved over a volume of liquid held between two concentric spheres. However on the Earth's surface the dielectric force cannot be made large enough to dominate the effect of terrestrial gravity. Hence the low-gravity environment of Spacelab is the ideal location for these experiments.

In order to adequately design the experiment for Spacelab, preliminary theoretical and numerical work must be done. ^Specifically, the scientific design program for the Atmospheric General Circulation Experiment (AGCE) requires that some baroclinic stability studies in spherical geometry be tackled. This can be done only after a basic state has been established. Simplified models must be used since otherwise the equations are nonseparable.

The particular task here is the extension of some previous work done in spherical geometry by Joseph Pedlosky to the specific case of interest in AGCE. This involves changing the boundary conditions under which the basic equations are to be solved. For simplicity the linear, axially symmetric steady state solution is sought.

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The general governing equations for an incompressible fluid in

dimensional form are

The Momentum Equation

Momentum Equation

$$\frac{\partial}{\partial t} \nabla + (\nabla \cdot \nabla) \nabla + 2 \nabla \times \nabla = -\frac{1}{2} \nabla T + \frac{1}{2} + \nabla T + \frac{1}{2} \nabla T$$

The Thermodynamic Equation

$$\frac{\partial}{\partial t} \widetilde{\tau} + (\overline{v} \cdot \overline{v}) \widetilde{\tau} = v \overline{v}^{3} \widetilde{\tau}$$

The Continuity Equation

and The Equation of State for a liquid

$$\widehat{P} = f_{c} \left(1 - \alpha \left(\widehat{T} - T_{0} \right) \right)$$

Thus we have six equations in six unknowns

$$\overline{\mathsf{V}} = (\widetilde{\mathsf{V}}_r, \widetilde{\mathsf{V}}_{\vartheta}, \widetilde{\mathsf{V}}_{\vartheta}), \ \widetilde{\mathsf{T}}, \ \widetilde{\mathsf{P}}, \ \text{and} \ \widetilde{\mathsf{P}}.$$

Note also that the equations are non-linear. For the model under consideration the steady-state axially-symmetric case is of interest so that the operators are two-dimensional involving only r and e in spherical geometry:

$$(\overline{V} \cdot \nabla) \overline{V} + 3 \overline{\Lambda} \times \overline{V} = - \frac{1}{P} \nabla \widetilde{P} + \overline{q} + V \nabla^2 \overline{V}$$
$$(\overline{V} \cdot \nabla) \widetilde{T} = \chi \nabla^2 \widetilde{T}$$
$$\nabla \cdot \overline{V} = 0$$
$$\widetilde{P} = P_0 (1 - \alpha (\widehat{T} - \overline{T}_c)).$$

Introducing non-dimensional variables

$$\widetilde{r} = R + SR Z, S = \frac{D}{R}$$

$$\widetilde{V}_{r} = S V_{0} \omega(e, Z)$$

$$\widetilde{V}_{\theta} = V_{0} V(\theta, Z)$$

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$$\widetilde{V}\varphi = V_0 u(\theta, \overline{z})$$

$$\widetilde{T} = T_0 + \Delta T \overline{z} + (\Im \Omega R V_0 / g \alpha D) \overline{T}(\theta, \overline{z})$$

$$\widetilde{P} = P_0 - f_0 g D \overline{z} + \frac{1}{2} g \alpha D \Delta T f_0 \overline{z}^2 + 2\Omega V_0 R f_0 P(\theta, \overline{z})$$

the equations become

$$\begin{split} \mathcal{E}\left[\omega\frac{\partial u}{\partial z} + v\frac{\partial u}{\partial \theta} + \delta u\omega - u \cdot v \cdot \overline{ton \theta}\right] + (\omega \delta tod \theta - v' \cdot \Delta u \cdot \theta) \\ &= S^{2} \mathbb{E}\left[\frac{1}{tod \theta} \frac{\partial}{\partial \theta} \left(\frac{\partial u}{\partial \theta} \cdot \cos \theta\right) - \frac{u}{tod \theta}\right] + \mathbb{E}\left[\frac{\partial^{2} u}{\partial z^{2}} + \partial \delta \frac{\partial u}{\partial z}\right] \\ \mathcal{E}\left[\omega\frac{\partial v}{\partial z} + v'\frac{\partial v}{\partial \theta} + S v'\omega + u^{2} \cdot ton \theta\right] + u \cdot \Delta u \cdot \theta = -\frac{\partial p}{\partial \theta} + \partial S^{3} \mathbb{E}\left[\frac{\partial w}{\partial \theta} + S^{3} \mathbb{E}\left[\frac{$$

$$\frac{\partial w}{\partial z}$$
 + 2 S w + $\frac{1}{\cos \theta} \frac{\partial}{\partial \theta} (V \cos \theta) = 0$

For $\boldsymbol{\mathcal{E}}$ sufficiently small the above equations can be linearized

$$\begin{split} & Sul (use - V ain e = S^{2} E \left[\frac{1}{(use \frac{1}{2}e)} \frac{1}{2e} \left(\frac{1}{2e} e^{\frac{1}{2}e} \left(\frac{1}{2e} e^{\frac{1}{2}e} e^{\frac$$

These are the equations of motion interms of non-dimensional variables which are appropriate for linear, axially-symmetric, steadystate motion of an incompressible fluid in spherical geometry.

3. THE SOLUTION OF THE SYSTEM.

The system that is used here is the system as derived and simplified by Pedlosky [1] with some obvious corrections and a few notational changes

$$-V \Delta u \dot{u} \theta + S w \cos \theta = S^{2} E \left[\frac{1}{\cos \theta} \frac{2}{\partial \theta} \left(\frac{2u}{\partial \theta} \cos \theta \right) - \frac{u}{\cos \theta} \right] + E \left[\frac{3^{2}u}{32^{2}} + 3S \frac{3u}{32} \right] u \Delta u \dot{u} \theta = -\frac{3T}{3\theta} + S^{2} E \left[\frac{1}{\cos \theta} \frac{2}{3\theta} \left(\frac{2v}{3\theta} \cos \theta \right) - \frac{v}{\cos \theta} \right] + E \left[\frac{3^{2}v}{32^{2}} + 3S \frac{3v}{32} \right]$$

$$-Su \cos \theta = -\frac{\partial P}{\partial z} + T + S^{4} E \left[\frac{\partial}{\partial x \theta} \frac{\partial}{\partial \theta} \left(\frac{\partial w}{\partial \theta} \cos \theta \right) \right] \\ + S^{3} E \left[\frac{\partial^{2} w}{\partial z^{2}} + \partial S \frac{\partial w}{\partial z} \right]$$

$$\beta \omega = \frac{S^{2}E}{\sigma} \frac{1}{\omega 0} \frac{\partial}{\partial \theta} \left(\frac{\partial F}{\partial \theta} \cos \theta \right) + \frac{E}{\sigma} \left[\frac{\partial^{2}F}{\partial z^{2}} + \partial S \frac{\partial F}{\partial z} \right]$$

$$\frac{\partial \omega}{\partial z} + \partial S \omega + \frac{1}{\omega 0} \frac{\partial}{\partial \theta} \left(V \cos \theta \right) = 0.$$

The boundary conditions are

$$(u, v, w) = (0, 0, 0)$$
 on $z=0$ and $z=1$
 $T(0, 0) = H_{1}(0)$
 $T(0, 1) = H_{T}(0)$

In order to solve the system with reasonable effort, the solution is decomposed into three parts--the interior motion (the I-subscripted variables), the lower boundary layer corrections (the L-subscripted variables), and the upper boundary layer corrections. Therefore

$$\begin{split} & u(\theta, \xi) = u_{I}(\theta, \xi) + u_{T}(\theta, \chi) + u_{L}(\theta, q) \\ & \forall (\theta, \xi) = E V_{I}(\theta, \xi) + V_{T}(\theta, \chi) + V_{L}(\theta, q) \\ & u(\theta, \xi) = E^{V_{2}} \left[w_{I}(\theta, \xi) + w_{T}(\theta, \chi) + w_{L}(\theta, q) \right] \\ & T(\theta, \xi) = P_{I}(\theta, \xi) + S E^{V_{2}} \left[P_{T}(\theta, \chi) + P_{L}(\theta, q) \right] \\ & T(\theta, \xi) = T_{I}(\theta, \xi) + E^{V_{2}} \beta \left[T_{T}(\theta, \chi) + T_{L}(\theta, q) \right] \end{split}$$
where $Y = (1-2) E^{\frac{1}{2}}$ and $Y = 2 E^{\frac{1}{2}}$. Since the L and T subscripted variables are signicant only near the boundary, it is required that they tend to zero for large Y and χ .

The equations for the lowest order correction functions in the respective boundary layers are

Lower Boundary Layer

$$-V_{L} \sin \theta = \frac{\partial^{3} u_{L}}{\partial y^{2}} \qquad (3.1)$$

$$u_{L} \sin \theta = \frac{\partial^{3} v_{L}}{\partial y^{2}} \qquad (3.3)$$

$$-S u_{L} \cos \theta = -S \frac{\partial P_{L}}{\partial y} + E^{\frac{N_{2}}{2}} \beta \overline{\Gamma}_{L} \qquad (3.3)$$

$$w_{L} = \frac{1}{2} \frac{\partial T_{L}}{\partial y^{2}} \qquad (34)$$

$$\frac{\partial w_{L}}{\partial y} = -\frac{1}{\cos 2} \frac{\partial}{\partial \theta} \left(V_{L} \cos 2 \right) \quad (3.5)$$

Upper Boundary Layer

$$-V_{T} \sin \theta = \frac{\partial^{2} u_{T}}{\partial x^{2}}$$

$$u_{L} \sin \theta = \frac{\partial^{2} V_{T}}{\partial x^{2}}$$

$$-S u_{T} \cos \theta = S \frac{\partial P_{T}}{\partial x} + E^{V_{2}} \beta T_{T}$$

$$w_{T} = \frac{1}{\partial} \frac{\partial^{2} T_{T}}{\partial x^{2}}$$

$$\frac{\partial w_{T}}{\partial y} = \frac{1}{\cos \theta} \frac{\partial}{\partial \theta} (V_{T} \cos \theta)$$

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Similarly equations for the interior solution are obtained to lowest

order in E

$$V_{I} \Delta w_{i} \Theta = \frac{\partial^{2} u_{I}}{\partial z^{2}} \qquad (3.6)$$

$$U_{I} \Delta w_{i} \Theta = -\frac{\partial P_{I}}{\partial \Theta} \qquad (3.7)$$

$$T_{I} = \frac{\partial P_{I}}{\partial Z} \qquad (3.8)$$

$$\partial T \beta E^{-V_{Z}} \omega_{I} = \frac{\partial^{2} T_{I}}{\partial z^{2}} \qquad (3.4)$$

$$\frac{\partial \omega_{I}}{\partial z} = 0 \qquad (3.10)$$

where, following Pedlosky, we have assumed $\zeta < \varepsilon^{t_2}$ and have dropped all terms involving powers of ζ . The Boundary Layer Corrections.

The system of equations for the lower boundary layer corrections can be easily solved. First the coupled equations (3.1) and (3.2) are solved. This allows the solution of equation (3.5), which then permits the solution of equation (3.6).

$$\begin{aligned} U_{L}(\theta,q) &= -U_{I}(\theta,c) \in \frac{\mu^{2}}{6} & (e^{\mu}) \\ V_{L}(\theta,q) &= U_{I}(\theta,c) \in \frac{\mu^{2}}{6} & (e^{\mu}) \\ & (e^{\mu}) = \frac{1}{696} \xrightarrow{2}{30} \left[\frac{U_{I}(e,c)}{6} & p_{I}me^{2} e^{-\mu^{2}} \\ & (e^{\mu}) e^{\mu} e^{2\mu} \\ & T_{L}(\theta,q) = \frac{1}{600} \xrightarrow{2}{30} \left[\frac{U_{I}(e,c)}{6} & p_{I}me^{2} e^{-\mu^{2}} \\ & (e^{\mu}) e^{\mu} e^{2\mu} \\ & (e^{\mu}) e^{2\mu} e^{2\mu} \\ & (e^{\mu}) e^{2$$

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where the boundary conditions have been used to get

$$\begin{aligned} u_{I}(\theta, o) + u_{L}(\theta, o) &= c \\ EV_{L}(\theta, o) + V_{L}(\theta, c) \approx U_{L}(\theta, o) &= 0 \\ T_{I}(\theta, o) + E^{V_{2}} \beta T_{L}(\theta, c) \approx T_{I}(\theta, c) &= H_{L}(\theta) \quad (3.11) \\ \omega_{I}(\theta, o) + \omega_{L}(\theta, c) &= c \end{aligned}$$

2

$$\omega_{I}(e,o) = -\frac{1}{2lore} \frac{\partial}{\partial e} \left(\frac{\omega_{I}(b,o)}{\mu} \frac{\Delta q_{II}e^{-ce_{I}}e^{-c}}{\mu} \right) (3.12)$$

Similarly, for the upper boundary layer corrections we have $U_{T}(\theta, \chi) = -e^{-\mu \chi} U_{I}(\theta, 1) \quad (\xi, \eta) \quad ($

The Interior Variables.

Equation (3.10) implies that $\omega_{\underline{r}}$ is independent of $\underline{2}$ therefore $\omega_{\underline{r}}(\theta, 0) = \omega_{\underline{r}}(\theta, 1)$. Hence $\mathcal{U}_{\underline{r}}(\theta, 0) = \mathcal{U}_{\underline{r}}(\theta, 0)$. Assuming $\mathcal{U}_{\underline{r}}(\theta, 0) = \omega_{\underline{r}}(\theta, 1)$ to be known the system can be solved beginning with equation (3.9) working back to equation (3.6):

$$T_{I}(0,z) = \sigma \beta E^{-V_{2}} \omega_{I}(0) (z^{2} - z) + H_{I}(0) z - H_{L}(0) (z^{-1})$$

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$$U_{I}(\theta, z) = -\frac{1}{2\omega_{t}\theta} \left[\sigma_{\beta} E^{-1/2} \omega_{I}'(\theta) \left(\frac{4z^{3} - 6z^{2} + 1}{12} + H_{r}'(\theta) \frac{\theta^{2} z^{3} - 1}{4} \right) - H_{L}'(\theta) \left(\frac{2z^{3} - 4z + 1}{4} \right) \right]$$

$$V_{I}(\theta, z) = \frac{1}{2\omega_{t}^{3}\theta} \left[\sigma_{\beta} E^{-1/2} \omega_{I}'(\theta) \left(\frac{2z^{3} - 4z + 1}{4} \right) + H_{r}'(\theta) - H_{L}'(\theta) \right]$$

(Note: $\mathcal{P}(\theta, z)$ is not of interest except as needed to find the other dynamic variables and thus has been omitted.)

The system is completely solved when $U_{I}(\theta,c)$ is known (or, equivalently, $W_{I}(\theta)$). $W_{I}(\theta)$ has not yet been found but a second order differential equation for W_{I} can be derived $W_{I}(\theta) = \frac{\Delta q_{L} \theta}{2 \cos \theta} \frac{d}{d\theta} \left\{ \begin{bmatrix} -\frac{1}{12} \sigma \beta e^{-hL} \frac{d}{d\theta} W_{I}(\theta) - \frac{1}{4} (H_{T}'(\theta) + H_{L}'(\theta)) \end{bmatrix} \frac{\cos \theta}{\mu \sin \theta} \right\}.$

This equation has not yet been solved.

4. CONCLUSIONS AND RECOMMENDATIONS.

(a) The technique of Pedlosky is a pertubation technique, however this is disguised in the analysis. The net result is that the order of approximation is different for each variable. It is recommended therefore that each variable be explicitly represented as a perturbation, e.g., $\phi = \phi_0 + E^{k_2} \phi_1 + E \phi_3 + \cdots$, and all solutions be found to the same order of approximation if possible or as nearly as is possible.

(b) Some of the assumptions of smallness made by Pedlosky are too stringent for AGCE. As many as possible should be relaxed, in particular, $\zeta < < E^{\frac{h_2}{2}}$. (c) The author derived the equations of motion for spherical geometry. The resulting equations differ non-trivially from those of Pedlosky. Unless these discrepancies can be adequately explained, all future work should be done using the author's equations.

(d) Some consideration should be given to the non-linear equations, possibly using the technique of Rahm and Walin [2].

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

A RANKING ALGORITHM FOR SPACELAB CREW AND EXPERIMENT SCHEDULING

Prepared by: Frank H. Mathis and Robert D. Grone

Refer to Section IX for report.

1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

PAYLOAD CREW TRAINING COMPLEX (PCTC) UTILIZATION AND TRAINING PLAN STATUS REPORT

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PAYLOAD CREW TRAINING COMPLEX (PCTC) UTILIZATION AND TRAINING PLAN

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ABSTRACT

The first section describes the physical facilities that comprise the Payload Crew Training Complex (PCTC). The PCTC is located at MSFC, Huntsville, Alabama, and contains the Host Simulator; Experiment Simulators; Spacelab Aft Flight Deck, Experiment Pallet, and Experiment Rack mockups; the Simulation Director's Console; Payload Operations Control Center; classrooms; and supporting soft- and hardware.

The second section of the report establishes the parameters of a training philosophy for Payload Crew Training at the PCTC. Major parameters include: (1) The intent of training is not to be diagnostic, to select the "best" Payload Crew, but should be enhancing to the development of high levels of proficiency in every Payload Crew trainee; (2) The intelligence of each Payload Crew trainee is obviously to be respected. This implies that training at the PCTC, while highly procedural and sophisticated should tend to be less rigid than similar kinds of traditional high technology training; and (3) The function of trainee evaluation will be to determine how well training is being conducted. From the cooperative debriefings between the Payload Crew and PCTC trainers, should come ideas for improving the training sequence.

Section three discusses the development of the training plan. Included are discussions of preassessment, skill identification, procedures, material development, and evaluation options.

INTRODUCTION

NASA finds itself on the threshold of a new era in space travel, namely repeated flights with a reuseable Space Transportation System (STS), i.e., the Space Shuttle. Additionally, they have diversified their payload configurations to include a larger portion of the scientific community not traditionally associated with NASA. For the first time too, the European Space Agency (ESA) has primary development responsibility for the Shuttle payload. The result is a new learning opportunity in the co-development of space missions and requires new thinking in training concepts.

One of the major distinctions between past NASA manned flights and this new era has been the changes in training philosophy and requirements. In the past everyone that has flown space missions has been a career astronaut with a scientific or technical background with flight training and experience. Additionally, all of the training tended to be centralized under NASA auspices. Yet in the presently scheduled flights, i.e., Spacelabs 1, 2, and 3, the Principle Investigators (PI) have primary responsibility for training the Payload Crew (PC) in how to conduct the PI's experiments. The PI's are research oriented, typically in a university setting, and literally distributed around the world.

These factors have precipitated the need for decentralized training. The effect of the move to decentralized training has been to: 1) reduce substantially the cost of training to NASA, since NASA does not have to reproduce all of the PI's equipment for training, and 2) add impetus to assuring overall flight competence prior to the actual flight via systems integration training. Concern with this second component is part of the issue addressed in this document. Another facet of the issue is how to best use the Payload Crew Training Complex (PCTC).

The PCTC was established to train the PC on those experiments that require interface with the onboard Spacelab computer, i.e., the Command and Data Management System (CDMS). In establishing the facility many questions arose as to how to achieve maximum utilization from the facility. Some of those questions are addressed herein.

OBJECTIVES

The concern then has been to examine the parameters associated with decentralized training; which, as mentioned previously is a situation unique to the Space Shuttle/Spacelab missions, but a concept that appears to be one that NASA plans to pursue at least for the foreseeable future. The objectives then that derive from this goal are, at present, threefold:

- 1) To describe the PCTC and its training capabilities.
- 2) To define a training philosophy that might guide the PCTC trainers in developing a training plan.
- 3) To describe a procedure for the development and implementation of a training plan for training the PC at the PCTC.

What makes this report a status report is that training has not yet begun, so there are no evaluations of actual training procedures discussed. Furthermore, decisions on the best training approach are still in a deliberative state due to the fact that all of the experiments requiring CDMS interface, while known, have not been broken down into the step-by-step procedures level. This breakdown is basic to skill identification and the subsequent training procedures development.

PCTC

The PCTC is located at MSFC, Huntsville, Alabama. The facility houses the Host Simulator (HS); Experiment Simulators (ES); the Spacelab Aft Flight Deck (AFD), Experiment Pallet, and Experiment Rack mockups; a Simulation Director's Console (SDC), a Payload Operations Control Center (POCC) console; classrooms; and supporting soft- and hardware.

The HS is the computer system that provides the capability to simulate the command, communications, control, and display functions of the Spacelab CDMS. This capability is necessary to execute experiment-unique simulations. It has the following features:

- 1) Two Data Display Systems (DDS) which can be simultaneously operated in support of one mission phase.
- 2) Reconfiguration and turnaround for the support of one training mission to another can be accomplished in eight hours.
- 3) Drives the SDC and POCC consoles for training and to approximate flight conditions.
- 4) Is modular in design and does not preclude expansion in size or computing speed.
- 5) Can simultaneously simulate multiple experiments, consistent with CDMS operating capabilities and provides standard analog-to-digital and digital-to-analog services for interfacing with simple experiment-unique control and display panels.
- 6) Allows for operation in a real time mode so that display time and command responses are commensurate with actual flight conditions.
- 7) Simulates symbolic pictures of the earth, sun, and sky scenes in a standard TV format for training in experiment pointing commands.
- 8) Protects against inadvertent damage to hardware and/or software by any operator or trainee.
- 9) Allows for environmental inputs to experiment models such as orbital state vector, vehicle attitude, and ephemeris of heavenly bodies.
- 10) Allows for detection and accumulation of characteristic data, such as PC errors, response times, and operating times.

The ES's include the hardware and software necessary to simulate experiments through the HS during training. A Data Display Unit (DDU) showing simulated data for experiment operations originates from either an instrument or Experiment Computer Applications Software (ECAS) simulation software package.

Experiment-unique command data is initiated through the DDS-Keyboard (KB). The CDMS is entered via KB command, item, type, and/or function keys and acted upon, and thus generates the appropriate response within the simulation software. Each ES will send data and accept commands from certain key simulated control and display panels located in the experiment racks onboard the Spacelab mockup. Field of view imagery and alphanumeric data for display on payload-unique Cathode Ray Tubes (CRT's) are provided from the ES. Simulated POCC ground command inputs are available to the crew via the ES. The ES accepts and processes commands from the SDC during simulation. These commands control such simulation circumstances as simulation modes, control sequencing, fault initiation, and time cycling.

The SDC enables the Simulation Director and Assistant Simulation Director to monitor, control, and modify the simulation operation. It is composed of four racks containing two computer terminals, a hard copy machine, four large black and white Closed Circuit TV (CCTV) monitors, and a work surface which encompasses the CCTV camera controls. DDU monitors in rack 4 will display the same DDU displays as the trainee sees in the Spacelab module. Cameras for the TV monitors will be used thus: two inside the Spacelab module, one for the AFD and one for general surveillance of the high bay area. CCTV cameras are controllable in pitch and azimuth from hand controllers on the SDC work surface. Three video tape recorders may be used to record data from any one of several video sources: four CCTV cameras, four DDU's, and three Spacelab CCTV's used with scene generation. Hard copies of data seen on any of the CRT's are available by merely pressing a button on the hard copier after selecting the appropriate CRT.

The PCTC mockups include the Spacelab Module Interior, Shuttle AFD Interior, and associated equipment and pallets for part task activities with the capability for supporting payload crew training for any single Spacelab mission and the capability for reconfiguration to any payload.

TRAINING PHILOSOPHY

A training philosophy is nothing more than an acknowledgement of the guiding ideals within which training will hopefully be implemented. The components of that philosophy may not actually be formally stated again, but they should be reflected in how the training is actually conducted. Philosophy statements describe thoughts or events that typically are extremely difficult to quantify for measurement, yet are important enough to be considered. The training philosophy for the utilization of the PCTC hopefully incorporates the following parameters:

- The intent of training is not to be diagnostic to select the "best" PC, but should facilitate the development of high levels of proficiency in every PC trainee.
- 2) The intelligence of each PC trainee is obviously to be respected. This implies that training at the PCTC, while highly procedural and sophisticated should tend to be less rigid than similar kinds of traditional high technology training.
- 3) The function of trainee evaluation will be to determine how well training is being conducted. From the cooperative debriefings between the PC and PCTC trainers should come ideas for improving the training sequence to help assure the highest quality of training and the maximum utilization of the PCTC's capabilities.

Specifically, those philosophical considerations include:

- 1) In order to proceed in a logical training sequence, critical skills and critical experiment sequences should be identified to better prepare the PC for the time when he actually encounters them.
- 2) There is a need for PC assessment upon initiation of training at the PCTC. This assessment is necessary for the PCTC trainers to correctly determine how well they are conducting the training. Initial assessment should probably involve assessment of the PC's skills in utilizing the DDU/KB, understanding the Experiment Computer Operating System (ECOS), and communication skills.
- 3) While individual PC decision making ability is a major concern, it is not planned to "assess" those skills during PCTC training. Instead, the goal is to provide training experiences to facilitate those skills. For example, while PCTC training is highly procedural, in selecting the contingencies for use in training, some of the training scenarios are speculative in nature. They have been developed using the best information available, but in some cases the exact flow of the experiment will not be encountered until the actual flight. Therefore, a training goal should be for the PC to remain cognizant of the overall experiment goal(s). The value of this is to be able to periodically step back from the minutia of experiment procedures and conceptually think through what is supposed to be happening. This should enhance the likehood that the PC would make the best decision when, in flight, he actually encounters that option point in the experiment flow.
- 4) It follows from the above statement that a large segment of learning will not occur until the actual flight because of the sheer uniqueness of space flight; therefore, optimum operations proficiency may be approximated but never achieved. This becomes important in setting achievement criteria for training.

- 5) Training should proceed from the simple to the complex, both in skill acquisition and in experiment training. There is some thought about starting with the more complex because of their criticality and the need for ample training time. However, it is conversely believed that if the PC trainee is allowed to progress from simple to complex, and if an adequate amount of time is allowed for learning each experiment regardless of its complexity, that the PC trainee will be developing the necessary skills to more easily handle the complex experiment when he gets to it. For example, by taking the simple experiments first the trainee is getting familiar and comfortable with the DDU/KB, experiment layout, ECOS, various ECAS/DEP, and the language in which the procedures are written. Then he gathers experience in nominal operations, simple off-nominals, and simple contingencies. All the while he is developing his skill to recognize subtle differences on the DDU displays, learns to discriminate messages, and is enhancing his intuitive knowledge of all the systems. Then when he encounters the more complex experiment, his prior knowledge and experiment experience actually aid in reducing some of the complexity factors of the experiment.
- 6) There should be sufficient training opportunities in the training schedule to allow the PC to work in the various possible dyads that might actually be chosen to fly the various Spacelab missions. Again this is not done to gather information for selection purposes (since the Investigators Working Group (IWG) will actually make the choices), but rather to give the dyads themselves the opportunity to better learn each others style of operation and idiosyncrasies prior to the flight crew selection.
- 7) The focus of training at the PCTC is on CDMS controlled experiments. Non-CDMS experiments will only be addressed as they mesh into the timeline training, i.e., while the PC is conducting a CDMS supported experiment, his operations timeline might call for him to initiate a life sciences experiment, hence, he might walk over to the lifesciences rack and flip a dummy switch and then resume his CDMS procedures.

TRAINING

The intent of this section is to discuss how the PCTC will actually be utilized during training. At present, however, all of the information necessary to make such a plan is incomplete. Therefore, this section represents an estimation of how that training might progress.

Traditionally, training is approached as the compilation of its sequential parts. That sequence is usually thought to be assessment, objectives, materials, procedures, and evaluation. That is generally how training has been approached in the present endeaver. Assessment in this situation refers to pretraining assessment. Three questions have been explored here; 1) why have pretraining assessment, 2) what type assessment is mandated, and 3) who will do the assessment? The why was partially addressed in the previous philosophy section; specifically, the PCTC trainers need to determine how well they are conducting the training. In order to achieve that goal, it will be necessary to determine where the PC trainee is in his training when he arrives at the PCTC. This will allow the PCTC trainers to assess how the trainee has progressed during training and then devise ways to better conduct future training. The second aspect of the why question deals with determining entry level abilities at skills basic to CDMS operation. At present, five areas have been tentatively identified as being basic to all experiment operations, and as such will comprise the initial assessment/training period at the PCTC. The five areas are:

- 1. Keyboard operation; skill and location
- 2. CDMS entry; recognizing different DDU displays, functions, etc.
- 3. ECOS operations
- 4. Communications; transmitting acurately and quickly with POCC
- 5. Timeline operations; getting the total picture of when everything is supposed to run during the mission.

The type of assessment could be group or individual discussions or written exams to determine overall understanding of the various areas. This assessment could preceed, run concurrent with, or follow PC trainee demonstration of skill proficiency in those areas requiring manipulative skills. At present, our thinking is that a group of PCTC trainers could do the assessment, supported with statistical records supplied by the HS on key stroke rate, error, and ability to call up various pages and experiments.

The objectives of training would include the development of high operations proficiency and overall experiment competence. Operations proficiency would include the PC's ability to perform the five areas listed previously, their ability to follow experiment procedures in a timely fashion, and the identification of critical sequences in the experiment operations that require special attention, which is partially a function of the PC's decision making abilities.

Once proficiency in the five basic areas has been acquired, two objectives become primary. The first deals with the PC's successful mastery of experiment procedures. The second deals with developing proficiency in the skills necessary to carry out the first objective. These "critical" skills would be above and beyond those skills mastered during training in the five basic areas. At present, however, these skills have not been identified. This condition exists for two reasons. The first is that the procedures for all the experiments have not been written, which precludes looking at them to identify critical sequences. The second reason is that skill identification has not been prioritized; that is, at present some feel there is questionable doubt as to whether such skills exist, and if they do, they would be developed when the procedures are learned and practiced during training.

At issue too is a philosophical question as to whether training, and hence mission operations, is simple or complex. Is it simple in that all the PC has to do is follow the written procedures which will caution for upcoming critical sequences. The notion here is that all the PC needs to do is develop very high proficiency at knowing and implementing the already spelled out procedures, and then relying on the POCC if questions arise. And while it may be true that the POCC may understand each experiment in more depth than the PC, the POCC has not necessarily developed the procedural knowledge to the degree that the PC has and may be of little substantive help to the PC in some unforseen situations.

The other view is that good scientific enquiry requires complex thinking skills. In this view the PC has the capability to conduct the experiment as he best sees fit, due to the fact that at that instant he possesses the most advanced conceptual understanding of the entire mission. Scientific enquiry demands sharp decision making skills, and as such these should be addressed during training at the PCTC. If this complex view is ascribed to, then training should afford direct or indirect opportunities to make decisions based on prior knowledge of and training in critical sequences or contingencies in each experiment.

Skill identification can start by asking and answering the following questions, pulled from Ely (1962):

"In the main, the definition of critical task characteristics is most effectively accomplished by considering the consequences of a particular activity if it were accomplished poorly or required excessive time for completion. Asking the following questions with respect to the various tasks is helpful for determining criticality.

Would below-minimum performance:

- o lead to an accident?
- o result directly in mission failure?
- o be impossible to remedy within time constraints or not at all?
- o be difficult to detect because of inadequate information feedback?
- o recur over time in such a way as to produce a cumulative effect?
- o contribute a large proportion of time to the total time required for some larger and critical function?

An affirmative reply to at least one of the above questions implies that the activity in question should be further considered in determining the critical behaviors for measurement."

In order to approach this issue, a skill matrix is being compiled from the available experiment procedures. Actually, two matrices are being developed. Both are modifications of existing skill charts (Rabideau, 1964; and Smode, Gruber, and Ely, 1962). Both are felt will yield useful information and will hopefully validate each other (the original charts and their modifications are in Appendix A). In the final evaluation, the skill matrices might very well show that training is in fact "simple" as described previously, but then at least there would be more support for that position.

Following skill identification, training procedures can be more fully articulated using the present training definitions. These definitions exist for each experiment and are described in three levels, from A to C. The descriptions progress from a general description (A), to typical off-nominals (B), and finally to step-by-step procedures (C). These skills should then be incorporated into the level A and B experiment descriptions. The level A, B, and C descriptions could then be utilized additionally by; 1) sending out the A and B descriptions as part of the PC's pre-arrival training materials, and 2) using all three levels during training to brief each experiment from and then to train from. "A" descriptions should reflect time of training, the skills addressed, and where the training will take place. "B" descriptions should identify the training personnel, the possible off-nominals, and critical experiment stages; i.e., where contingencies exist or where the experiment could be aborted or drastically effected via operator error. "C" descriptions represent the training guide the PC might follow during training. "C" descriptions list nominal and off-nominal procedures.

After initiation to the experiment during the pretraining briefing and exposure to experiment procedures, but before going to the mockup for practice, the PC should be able to demonstrate the following:

- What is the PC's knowledge of the experiment; communicated verbally?
- 2) What is the PC's knowledge of the possible off-nominals for this experiment and where will they occur?
- 3) What are the PC's perceptions of his anticipated responses to those off-nominals?
- 4) Can the PC verbally walk through the experiment's nominal run?

Evaluation criteria follow from skill identification and should be fully planned for prior to the implementation of training. At this point, four recommendations are made for training:

- 1) Pertinent PCTC trainers should go through the PC training program prior to any PC trainee to debug and improve on the system.
- 2) If the modified Ely chart for skill identification is validated, then his three instrument and criteria measures in Appendix B can be used to develop PCTC evaluation criteria and instruments.
- 3) Additionally, video tapes, PC record books, debriefing questionnaires, and data graphs of performance can be collected to trace training progress
- 4) Two additional types of measures have been located in our review that have application to the current evaluation needs. One is an effectiveness rating scale:

		Decision Speed		
Extremely Rapid	Very Fast	Acceptable	Slow	Very Slow

Decision Quality

			1	
Outstanding	Superior	Adequate	Somewhat Adequate	Poor

The second is an assessment tool of procedural operations:

	<u>Task Step</u>	Error & Consequences
1.	Turn power switch to ON position	
2.	Read external temperature	
3.		
4.	etc.	
5.		

The final area addressed in this report is the matter of developing a training schedule. This can not be developed at present until the skill identification is completed. Additional parameters in formulating a schedule would be:

- 1) A need to determine the total time for experiment training, so that a training schedule can be developed.
- 2) How much time is needed for the dyads to work in each of the possible pairs.
- 3) Number of actual training locations within the PCTC for the PC to be trained at.

APPENDIX A

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Modified skill identification charts used to identify PC skills for training definition.

	Types of Tasks	100	002	002	200	800		0 1 3	0 14	016	110	0 19	0 2 0	021	0 22	073	240	027	029	0 33	034	300
\mathbf{h}	Follow Routine, Pre-established Checkout Sequence	<u> </u>	<u>-</u>						†	\vdash		+		•			i	1	†			
ł	Position a Set of Discrete/Serial Controls	j	1-	-											I		1	1_				
	Obtain Information From Dynamic Displays	1	1	Ī	Π													1_	1		$\lfloor 1 \rfloor$	
t	Adjust Instrument or Other Equipment Item	C_	L	[_	Ľ		1					F			ļ			+	↓			
	Track						İ									 .	L	l				
ſ	Communicate Information																	1_	1			
	Utilize Status or Reference Data		1_	ļ				.		<u> _</u>					ļ	ļ	<u> </u>	4-				
L	Directly Observe External Events	<u> </u>	₊				┥					+			<u> </u>	¦		<u> </u>	. 		;	
	Compute				+					$\left\{ -\right\}$		\vdash	~~- i				 	-	; - ;		i	
1	Select Action From Among Alternative Chines	1	+		┝╡		-		-			╂═╡						<u>†</u> =	1	rær å		
	Calibration, and/or Checkout.											ļ_		ine.				<u> </u>				
ľ	Acquire Information From Among Multiple Sources				\vdash		·'					$\left - \right $					<u> </u>	1-	1	<u> </u>		
.[Make Multiple Control Actions	1										i-ł					1	1-	\mathbf{T}			
	Locate Malfunctions in Complex Equipment	<u>}</u>	┼	<u> </u>			<u> </u>			┝─┤		\vdash		.		<u> </u>	i –	1	<u>†</u>			
	Remedy, Repair, Fabricate, and/or Assemble Complex Equipment.				Ŀ							\square		. <u></u> .			 	1	Ļ.			
Ī	Carry Out Computational/Measurement Sequences for Determining Status																		<u> </u>			
ł	Make Decisions Based on Multiple Information Sources															·						İ
														•								
:1	A	\vdash	1-	\vdash	H		†			\square		T	-	•				T	T			[

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Modified from Smode, Gruber, and Ely, 1962

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	Processes	Activities	Specific Bebarions Expt. # (frequency)
			Detects
		• .	Inspects
	•		Observes
		Searching for and Receiving	Reads
		Information	Receives
	Perceptual Processes		Scans
	receptuar r messes		[Surveys
			Discriminates
		Identifying Objects, Actions, Events	Identifies
		_	Locates
			[Categorizes
			Calculates
	•	•	Codes
			Computes
	•	Information Processing	Interpolates
	•		Itemizes
М	-	· · · · · · · · · · · · · · · · · · ·	Tabulates
bd	Mediational Property		Translates
Ľ.	Mediational Processes		CAnaluzes
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fr		Problem Solving and Decision Making	- Compares
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ne		· · · · · · · · · · · · · · · · · · ·	Answers
•			Discus
19	Commission Deserves		
64	Communication Processes –		
		· .	Instructs
			Tracomit
		•	Activates
			Closes
		•	Connects
		Esimple/Discrete	Disconnects
		· .	Joins
	•		Moves
			- Presses
	Motor Processes —		L Sets
••••			[Adjusts
			Aligns
		Complex Continuous	- Regulates
		•	

	(Based on	S	no	de,	G	rubc	r,	and	E	ly,	196	2)										
	Types of Tasks	Error Amplitude	Error Frequency	Error Content Analysis	Error Change Over Time	Number of Control Responses and Manipulations	Number of Communications	Number of Personnel Interactions	Number of Diagnostic Checks	Number of Errors	Number of Out-of-Tolerance Conditions	Number of Observations	Number of Verbal or Written Reports	Number of Requests for Information	Per cent of Activities Accomplished	Measures of Achieved Reliability	Measures of Achieved Maintainability	Equipment Failure Rate	Cumulative Response Output	Proficiency Test (Written) Scores	Magnitude Achieved-Steady- State Value	Magnitude Achieved- Changing Value
	Follow Routine, Pre-established Checkout Sequence	X	X	X			-		X	X	X				X					X		
1	Position a Set of Discrete/Serial Controls	T	Ī	X		X			_	X									_			
	Obtain Information From Dynamic Displays	X		X						X		X									X	X
	Adjust Instrument or Other Equipment Item	X		X		X				X												
믭	Track	X	X	X	X	X				X									X		X	X
	Communicate Information			X			X	Х		X			X	X								
5	Utilize Status or Reference Data	X		X						X										X	X	X
	Directly Observe External Events	X	X	X						X		X			•						X	X
	Compute	ĪĀ	X	X						X										X		
	Select Action From Among Alternative Choices		X	X						X										X		
	Follow Established Procedures in Inspection, Calibration, and/or Checkout.	×	×	×			_		×	X	×				×					×		
	Acquire Information From Among Multiple Sources	X		X						X		X		X								X
	Make Multiple Control Actions	X	X	X	X	X				X												
-iei	Locate Malfunctions in Complex Equipment			X					X	X	X					X	X			X		
Con	Remedy, Repair, Fabricate, and/or Assemble Complex Equipment.	×	×	×		×			×	×							X					
	Carry Out Computational/Measurement Sequences for Determining Status	×	×	×						×			x							×	×	X
•	Make Decisions Based on Multiple Information Sources	×	×	X						X	_									×		

Application of Task Data for Error, Frequency, and Achievement Measures • (Based on Smode, Gruber, and Ely, 1962)

TABLE 8-2B

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DATA ANALYSIS METHODS 233

Application of Task	Data for Latency and Accuracy Measures	
(Based on	Smode, Gruber, and Ely, 1962)	

TABLE 8-2A

		_			T 7 3				1									-						-		
	• Types of Tasks	Types of Measures	Time to Perceive Event	<u>Movement Reaction Time</u> Time to Initiate Correction	TimetoInitiateActivityFollow	Time to Detect Trend of Multime Related Events	Time to Identify Stimulus	Time to Complete Message. Decision. Control Adjustmen	Time to Reach Criterion Value	Time Spent in Activity	Per Cent Time on Target	Time-sharing among Events	Displays Internal to System	Accuracy in Identifying Displays External to System	Accuracy in Estimating Dis- tance, Direction, Speed. Time	Detection of Change in Stimulus Over Time	Detection of Trend Based on Multiple Related Events	Observation Correctness	Recognition of Signal in Noise	Recognition of Out-of- Tolerance Condition	Accuracy in Control Positioning of Tuol Usage	Accuracy in Reading Displays	Accuracy in Symbol-Usare, Decision-Makine, Computing	Accuracy in Response Selection Among Alternatives	Accuracy in Serial Resnonse	Trucking Accuracy Communications Accuracy
	Follow Routine Pre-Established Checkout Sequence									X		X	X			X		X		X	X	X			\mathbf{X}	
	Position a Set of Discrete/Serial Controls	·			<u> </u>			X		\times			X								X				凶	
	Obtain Information From Dynamic Displays		X				X		-	X			×	X	X	X	_	X	X	X		\mathbf{X}			\square	
	Adjust Instrument or Other Equipment Item		_					X	X	×			_							_	X				\square	
Ē	Track		\square	<u>××</u>					X	×	XI.			_	X	X					X				X)	직_!
:5	Communicate Information							X		$ $ \times																_ <u> ×</u>
	Utilize Status or Reference Data									\times																
	Directly Observe External Events		×			X	X			X				X	X	X		\times	X						\square	
	Compute						Γ		X	X	Т												X		Π	
	Select Action From Alternative Choices							X		\overline{X}													X	X	П	
	Follow Established Procedures in Inspection, Calibration and/or Checkout				×			×	×	×	T		×					×		×	X	×	X			
	Acquire Information From Among Multiple Sources					X	Т			X			X	X		X	X	X	X		_	X	Х		Π	Т
	Make Multiple Control Actions	·		X	X	1	1	X		X		T									X				X	Т
-e	Locate Malfunctions in Complex Equipment		X			T	T			X			X					X		\overline{X}			X			Т
Comp	Remedy, Repair, Fabricate, and/or Assemble Complex Equipment							×	×	×											×					
-	Curry out Computational/Measurement Sequences for Determining Status									×					×	×				_			×		I	
	Make Decisions Based on Multiple			×	×	×		×		×							×			- [×	×Ι	!	11

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TABLE 8-2C

Application of Task Data for Consumption, Physiological and Behavioral Judgment Measures (Based on Smode, Gruber, and Ely, 1962)

	Types of Tasks	Types of Measures	Fuel/Energy Conservation	Units Consumed in Activity Accomplishment	Rate of Consumption	Operator/Crew Physiological Condition	Operator/Crew Behavioral Condition	Rating of Operator/Crew Performance Adequacy	Rating of Task Performance Adequacy	Estimation of Amount or Degree of Behavior Displayed	Analysis of Operator/Crew Behavior Characteristics	Omission of Relevant Behavior	Occurrence of Nonrelevant Behavior	Description of Out-of- Tolerance Condition	Interview Content Analysis	Self-Report of Experiences	Prer, Self, or Supervisor Ratings
	Follow Routine Pre-established Check- out Sequence	·						×	X	X	×	X	X		×	×	×
Ī	Position a Set of Discrete/Serial Controls	·						X	X	X	X	X	X		X	X	×
	Obtain Information From Dynamic Displays							X	X	X	X	X	X		X	X	X
	Adjust Instrument or Other Equipment Item							X	Х	X	X	X	X		X	X	×
尙	Track							X	X	X	X	X	X		X	X	×
<u>[</u>]	Communicate Information							X	X	X	X	X	X		X	X	×
"	Utilize Status or Reference Data							X	X	X	Χ.	X	X		X	X	×
	Directly Observe External Events							X	X	X	X	X	Х		X	X	×
	Compute							X	X	X	_X_	X	X		X	X	X
	Select Action from Among Alternate Choices							X	X	X	_X_	X	_X_		X	X	×
	Follow Established Procedures in Inspection, Calibration, and/or Checkout							×	×	×	×	×	Х		X	x	×
	Acquire Information from Among Multiple Sources.							×	×	×	×	×	×		×	×	×
ĸ	Make Multiple Control Actions							X	_X_	X	X	X	X		X	X	X
a	Locate Malfunctions in Complex Equipment							X	X	X	X	X	X	X	X	×	×
В С	Remedy, Repair, Fabricate, and/or Assemble Complex Equipment			×	X			×	×	×	×	×	×		×	×	×
	Carry Out Computional/Measurement Sequences for Determining Status							×	×	×	×	×	×		×	×	<u>×</u>]
	Make Decisions Based on Multiple Information Sources				÷			_ <u>×</u>	×	X	_×	_× [<u>×</u>	_ [×Į	×Į	-]

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

SOME METHODS IN HIGH ENERGY COSMIC RAY MEASUREMENT

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August 1, 1980

NGT-01-002-099 (University of Alabama)

SOME METHODS IN HIGH ENERGY COSMIC RAY MEASUREMENT

By

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ABSTRACT

The response of ion chamber detectors to cosmic rays of energy a few GeV/nucleon and up shows a logarithmic rise with energy. The energy resolution has not been accurately defined. In Ref. 1 a calculation technique has been outlined which gives useful results for cosmic ray protons. The present study has applied the method to much heavier particles and higher energies.

In addition, a balloon flight will soon detect cosmic ray showers. A detector of acoustic waves produced by the showers will be carried, as will emulsion detectors. The present study has involved calibration of a flat plastic scintillation plate which will act as a trigger for the acoustic detector, and will determine the position of exit of the showers in order to expedite visual examination of the emulsions.

INTRODUCTION

Cosmic rays have been investigated since their discovery in 1911. Their flux in space is nearly independent of time and direction. They consist of nuclei, electrons, and electromagnetic radiation. The nuclei are mostly protons (around 90%) and helium (around 9%) but heavy nuclei are present also, being over represented as compared to solar abundances. The energy spectrum extends to the greatest energies known, reaching as much as 10^{20} eV or 1 joule.

The origin of cosmic rays is a mystery, as is their acceleration to ultra high energy. Exploding galaxies, supernovae, pulsars, white dwarfs, and other exotic types of objects have been proposed as sources, but none have been clearly identified.

Measurement of the energy, knowledge of the energy resolution of the measuring devices, and identification of the various nuclear species are important for an understanding of the phenomena. A logarithmic rise in ionization of gas in ion chamber detectors, as cosmic ray energy increases, has long been observed, for energy a few GeV/nucleon and up. The energy resolution has not been accurately defined. In Ref. 1 a procedure has been outlined for calculating resolution for the case of particles of charge 1. This type information is needed also for the heavy nuclei in cosmic rays, and work on this problem is described in the following section.

Flat plates of plastic scintillator can serve several functions in a balloon-borne cosmic ray experiment. Rays passing through a plate produce light in the plate, which can be collected and measured by photomultiplier tubes. The signals from these tubes can indicate the passage of a "shower" of particles produced by collision of a high-energy cosmic ray with a nucleus. These signals can thus be used as a trigger for another detector designed specifically for measuring the energy of such showers. In addition, the relative strengths of the signals from the photomultiplier tubes can be used to determine the place of exit of the particles. This information facilitates examination of nuclear emulsions located next to the plastic scintillator, in order to find tracks in the emulsion created by the particles passing through.

OBJECTIVES

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Two main objectives were pursued. The first was to calculate the average energy actually deposited in an ion chamber by an ultra-high energy particle of large mass and charge. The method was to extend a calculational scheme already applied successfully to particles of charge 1.

The second objective was to calibrate a plate of plastic scintillator for measurement of the position of a cosmic ray shower passing through it. The method of calibration was to inject pulses of light at known positions on the plate and record the responses of photomultiplier tubes at the corner of the plate.

BODY OF REPORT

On Relativistic Rise in Ionization

Relativistic charged particles passing through a gasfilled chamber lose energy mainly by excitation and ionization of the gas atoms (Ref. 4). Experiment shows a slow logarithmic increase in energy loss as particle energy increases. This is called the relativistic rise. The rise finally stops and energy loss becomes constant in what is called the Fermi plateau. Examination of the relativistic rise and knowledge of the energy resolution can allow one to determine the energy of the particle. This requires that charge be measured independently by other detectors through which the high energy particles pass. Typically a Cerenkov counter utilizing solid radiators such as lucite plastic is used for charge identification in the ultrarelativistic energy range. Thus for cosmic ray work the particular kind of nucleus striking the detector can be found (Ref. 5).

One way to look at the interaction between an incident particle and the electrons of an absorber is by representing the electromagnetic field of the particle by two terms (see Fano, Ref. 2). One, called the longitudinal term, is merely a static Coulomb interaction. The second term, called the transverse term, involves emission and reabsorption of virtual photons. Fano has treated the interaction in the lowest order (Born) relativistic approximation. The longitudinal interaction is effectively constant at high velocities. The transverse term, however, increases in strength as velocity increases. This is expected since the transverse field increases proportional to γ , where

$$\gamma = (1 - \beta^2)^{-\frac{\pi}{2}}$$
 and $\beta = v/c$.

This relativistic rise eventually stops because of polarization of the absorbing medium.

Fano found expressions for differential cross sections for ionization. By integrating over energy he found energy loss. This approach does not agree well with experiment for the case of thin gas absorbers (Ref. 1,3) because the energy loss occurs in a relatively few discrete collisions. Cobb et al. (Ref. 1) have used Fano's results up to a point but instead of integrating over energy have used Monte Carlo techniques and calculated energy losses in discrete collisions many times to get an average energy loss, a spectrum of energy loss, and the amount of relativistic rise. The results are in good agreement with experiment for incident particles of charge 1. This author has adapted Cobb's method, which came from Fano, to the case of particles of large charge. Several difficulties were encountered:

A. Cobb's use of the letter E in expressions was thought to be ambiguous: it could mean energy transfer to an electron, which would include the binding energy of the electron, as Fano seems to use it: or it could mean the kinetic energy of the electron after collision, as is suggested by Cobb's referring to the Rutherford cross-section as being

$$\frac{2\pi}{\mathrm{mv}^2} \frac{1}{\mathrm{E}^2}$$

In this expression Rutherford did mean E as kinetic energy of the electron.

B. Cobb's expression for the longitudinal differential cross-section for ionization included the factor (with units 1/energy)

$$\delta(E-E_i)$$

where E; is the electron binding energy. This has the form of the Dirac delta function, which has meaning when integrated. Since integration is not used in Cobb's method, it is not clear how to use it.

C. Cobb's expression for the dielectric constant ε of the absorber gas contains the frequency ω . This seems ambiguous: earlier in his paper the same variable had been used as the frequency of a virtual photon. However, Fano wrote that the ω in the dielectric constant expression is a root of the equation

$$c^2q^2-\varepsilon(\omega)=o$$

where c is the speed of light and q is momentum transfer to the electron. Since Cobb's treatment follows Fano, an uncertainty in interpretation is introduced.

Consultation with some experts on energy loss and a search of the literature have shed little light on these difficulties. Communication with the authors (Fano, Cobb et al.) will be attempted to resolve the ambiguities. This author has written computer code to calculate cross sections for ionization, using various combinations of interpretations, in order to be able to distinguish the correct ones. The work is still in progress.

Calibrating A Plastic Scintillator for Position Determination

In September 1980, a balloon flight will carry several cosmic ray experiments. Events of the highest energy will be of particular interest. Nuclear emulsions, X-ray film, and calorimetry will measure characteristics of these events. A plastic scintillator can be configured to determine the position of exit of cosmic rays. The rays cause the plastic to emit light. Most of the light is trapped in the thin plate of plastic by total internal reflection. When photomultiplier tubes are optically coupled to the corners of the plate, the tubes measure the amount of light reaching them. The amount varies inversely with the distance to the event, roughly. Several factors complicate the tube response, including edge effects, scratches, crazing of the plastic, inhomogeneity of the scintillating material, and probably others.

Preliminary calibration of the scintillator was done by this author. The method required a light-tight box. The scintillator plate, which measured 44" by 44" by 1/4", lay in the box on white paper which had a grid of horizontal and vertical lines drawn on it, with 10 cm spacing. A photomultiplier tube was attached with optical coupling grease to a specified position at one corner of the plastic plate. The photomultiplier tube was a 3", ten stage EMI, type 9708KB. The output of the tube was amplified and referred to a multichannel analyzer which displayed pulse heights and allowed a determination of average pulse height.

Light pulses were obtained by sending electric pulses at frequency 10Khz to a light-emitting diode (LED). The LED was mounted at the top of a shiny brass tube whose open end fit into a clear plastic disk. The disk, with LED, could be stuck to the plastic scintillator with optical grease and accurately located above an intersection of grid lines on the paper underneath. Thus positions of photomultiplier tube and LED were known to about ½ cm.

After pulses had been injected for 90 seconds and the average pulse height ascertained, the disk with the LED was removed and the plate wiped with dry cotton material and then with the same kind of material moistened with pure ethyl alcohol. All other procedures tried left some residue of film which scattered light out of the plate. After the cleaning, the LED disk was regreased and repositioned. In this way a map was generated. Upon completion, the photomultiplier tube was moved to another corner and another map generated. Only one photomultiplier tube was ready at the time, so 3 other "dead" tubes were kept at the 3 other corners to absorb light as would happen in the final setup.

Checks were made of the reproducibility of the reading from a particular point. Deviations ranged from 0 to 12%, averaging about 5%.

A sample of experimental results is shown here. The positions refer to a Cartesian coordinate with the plastic scintillator plate defining the first quadrant, and the photomultiplier tube centered at x = 5.9 cm, y = 5.9 cm. Pulse heights along an edge and along an approximate diagonal are given. Positions are not integral multiples of 10 cm because visualization is easier than in the system actually used.

Position (cm) Position х У Pulse height y Pulse height х 21.8 10 21.8 20 1640 2740 30 10 1260 31.8 720 31.8 740 41.8 40 410 41.8 10 50 51.8 10 450 51.8 280 61.8 10 300 61.8 60 190 240 71.8 70 180 71.8 10 81.8 10 180 81.8 80 160 91.8 90 130 91.8 10 130 101.8 100 120 101.8 10 110

At several positions in the scintillator pulse heights had local maxima or minima. Some of these could be identified with defects mentioned in the first paragraph under calibrating.

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CONCLUSIONS AND RECOMMENDATIONS

Concerning relativistic rise in ionization, an attempt should be made to locate the authors of Ref. 1 and correspond with them to resolve the difficulties of interpretation of their paper. In addition, the computer trial and error attempts to find the correct interpretation should be continued in case all else fails.

Calibration of the plastic scintillator as a determiner of position has been done. The experimental error indicates a positional error of nearly 5 cm can be expected. Since the calibration was done with light injected from outside, while the actual use will have light generated inside the plastic, a check of the numbers should be made with all 4 photomultiplier tubes in place, mounted in final form. Energetic radiation which will cause the plastic to scintillate should be injected from outside.

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MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

PHOTOCHEMISTRY OF MONODENTATE AND BIDENTATE CARBONATO COMPLEXES OF RHODIUM (III)

Prepared By: Academic Rank: Assistant Professor University and Department: Colgate University Department of Chemistry NASA/MSFC: (Laboratory) (Division) (Branch) _ _ _ Robert J. Naumann MSFC Counterpart: Date: August 2, 1980

Contract No:

Space Sciences Laboratory Materials Processing in Space

NGT-01-002-099

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by

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ABSTRACT

A scheme for the photochemical fixation of water (eq 1) has been proposed.

$$2 \quad H_2 0 \quad \xrightarrow{h \ v} \quad 2H_2 \quad + \quad 0_2 \tag{1}$$

Fuel cells which generate electrical energy using the reverse of eq 1 are used in NASA spacecraft, so the solar-induced regeneration of H_2 and O_2 would allow the same materials to be recycled through the fuel cells, dramatically increasing energy output per pound of fuel carried aloft.

The proposed scheme involved a 5-step reaction sequence; the first step involves the 2-electron reduction of a metal by a coordinated carbonate ligand, with corresponding oxidation of the carbonate to CO_2 and O_2 .

Ligand field photolysis of trans- $[Rh(en)_2 (H_20)(CO_3)] ClO_4 (I)$, and $[Rh(en)_2 (CO_3)] ClO_4 (II)$ have been studied in the solid state and in aqueous solution at various pH values. Both salts are photoinert in the solid phase, but are quite photoreactive in aqueous solution. In solution, the monodentate ion (I) undergoes efficient isomerization to a mixture of cis and trans - $[Rh(en)_2 (H_20)(CO_3)]^+$, presumably with water exchange. A minor pH increase upon photolysis is evidence of inefficient carbonate $(CO_3 =)$ release, with formation of $[Rh(en)_2 (H_20)_2]^{-3+}$.

In contrast, aqueous solutions of the bidentate carbonato complex, (II) undergo efficient pH decrease upon ligand field photolysis. Changes in the electronic spectrum (200-500 nm) and pH changes indicate that the desired redox is occurring (eq 2)

$$\left[\operatorname{Rh}(\operatorname{en})_{2} (\operatorname{CO}_{3}) \right]^{+} \xrightarrow{\operatorname{hv}}_{\operatorname{H}_{2}0} \longrightarrow \left[\operatorname{Rh}(\operatorname{en})_{2} \right]^{+} + \operatorname{CO}_{2} + \frac{1}{2} \operatorname{O}_{2} (2)$$

The pH increase is due to the aqueous behavior of CO_2 (eq 3).

$$CO_2 + H_2O \longrightarrow H^+ + HCO_3$$
 (3)

A positive test for released carbonate ion supports this assignment. Work is proceeding to confirm this new photochemical reaction, with emphasis on gaining understanding of the exact nature of the rhodium photoproduct, the details of the photochemical mechanism, and to test the generality of photoredox reactions of bidentate carbonato complexes.

ACKNOWLEDGEMENTS

I wish to thank Dr. Robert Naumann for allowing a stimulating summer of research, without memos or committees; it was great. Mr. Charles Carter and Mr. Marion Kent were instrumental in facilitating my application, and I thank them for their help and support. Ms. Margie Phillips typed this manuscript, for which I am most grateful. Finally, I owe a debt to Dr. Robert Snyder who found room in his Separations Processes Lab for an inorganic photochemist.

NOMENCLATURE

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LMCT	-	ligand-to-metal-charge-transfer			
en	-	ethylenediamine $(H_2NCH_2CH_2NH_2)$			
К	-	equilibrium constant (K = 4.3×10^{-7} for hydrolysis	of C0 ₂)		
		$CO_2 + H_2O \rightleftharpoons H^+ + HCO_3^-$			
hv	-	implies the reaction conditions included the incidence of light			
nm	-	nanometer			
		LIST OF FIGURES			
Figure No		Title	Page		
1.		Electronic Absorption Spectra of <u>trans</u> - $[Rh(en)_2$ (H ₂ 0) (CO ₃)] ⁺ , $[Rh(en)_2$ CO ₃] ⁺ and the Corning 7-59 Colored Glass Filter	XVI-10		
2.		Spectral changes induced by photolysis of <u>trans-[Rh(en)</u> 2 (H ₂ 0) (C0 ₃)] +	XVI-12		
3.		Spectral changes induced by photolysis of [Rh(en) ₂ CO ₃] ⁺	XVI-16		
4.		Acidity increase in photolyzed solutions of $[Rh(en)_2 CO_3]^+$ as a function of photolysis time	XVI-19 、		
		LIST OF TABLES			
Table Nur	mber	Title	Page		
1.		pH changes induced by photolysis of <u>trans-[Rh(en)</u> 2 (H20) (CO3)] ⁺	XVI-13		
2.	2. pH changes induced by photolysis of X' [Rh(en) ₂ CO ₃] ⁺ .				

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INTROPHCTION

The photochemical behavior of Rh(III) complexes has attracted considerable interest¹, as a variety of photoinduced aquations and stereochemical rearrangements have been observed. While exceptions exist, Rh(III) amine complexes characteristically undergo efficient photoinduced ligand loss/aquation, with rearrangement to a symmetric trans configuration. There is little evidence of any photoinduced reduction of the Rh(III) center, even upon photolysis of LMCT bands in such complexes as $[Rh(NH_3)_5I]^{2+2}$; the instability of the Rh(II) oxidation state and the photoreactivity of the ligand field excited states lead to a predominantly ligand field excitedstate chemistry for Rh(III) amines.

Our work on the photochemistry of rhodium complexes has led to a reaction sequence which, on paper, represents the photochemical cleavage of water into H_2 and O_2 . It is a five step reaction sequence (eq4-8); the net reaction is the desired water fixation.

- $L_{4}Rh(H_{2}0)(CO_{3})^{+} \longrightarrow L_{4}Rh^{+} + CO_{2} + \frac{1}{2}O_{2} + H_{2}O \qquad (4)$ $L_{4}Rh^{+}H_{3}O + \longrightarrow L_{4}Rh(H)(H_{2}O)^{2+} \qquad (5)$
- $L_4Rh(H)$ (H₂0) ²⁺ + H₂0 \longrightarrow $L_4Rh(H_20)$ (0H) ²⁺ +H⁺ + H⁻ (6)
- $H^- + H^+ \longrightarrow H_2$ (7)

$$L_4Rh(H_20) (0H)^{2+} + CO_2 \longrightarrow L_4(Rh(H_20) (CO_3)^{+} + H^{+}$$
 (8)

net reaction
$$H_20 \longrightarrow H_2 + \frac{1}{2} \frac{0}{2}$$
 (1)

The first step is the photoinduced oxidation of a d^6 metal center (Rh(III) here) by a carbonate ligand, generating 0_2 , $C0_2$ and a coordinatively unsaturated d^8 complex (eq 4). Oxidative-addition of H_30^+ then regenerates the Rh(III) center, creating a hydride ligand (eq 5). Photoinduced (or thermal) labilization of this pseudohalide ligand (eq 6) would lead to instantaneous H₂ generation (eq 7). Under the proper pH conditions, reaction of the photogenerated CO₂ (eq 1) and the aquohydroxo complex (eq 8) would regenerate the carbonato starting material (eq 8).

This reaction sequence has many advantages over other currently studied water-photolysis schemes:

a) Each of the steps is either a well-known reaction (eq $_7$ and $_8$) or is a reaction for which closely analogous reactions have been studied (eq 4, 5, and $_6$).

b) No radical intermediates are involved, as the 2-electron transfer of the $d^6 \text{-} d^8$ transition metal system allows complementarity.

c) The scheme is a self-contained, catalytic cycle, with only water consumed and H_2 and 0_2 generated.

d) The scheme is quite flexible, as many variables can be adjusted.

A major difficulty with this scheme is the first step, as there is little precedence for such a photoinduced two-electron transfer. An additional problem is that reports on the photochemistry of carbonato complexes are surprisingly rare.

An apparent two-electron transfer was observed upon irradiation of alcohol solutions of some carbonato complexes of $Pt(II)^3$. In the presence of nucleo-philes (X = C₂H₄, P ϕ_3 , CO, ϕ C \equiv C ϕ) photolysis of $PtL_2(CO_3)$ (L = P ϕ_3 , As ϕ_3 or P(CH₃) ϕ_2) generates PtL_2X_n (N = 2 for X = CO; n = 1 for bulkier ligands), consistent with the in situ formation of PtL_2 . Carbon dioxide was released during the photolysis (one mole per mole of Pt) and alcohols added to the photolysis solutions could be oxidized to aldehydes and ketones, confirming that the carbonato ligand was the two-electron reducing agent.

Such apparent two-electron transfers have also been observed upon photolysis of some oxalato complexes. Some $PtL_2(ox)$ complexes, similar to the carbonato complexes just discussed, photolyze to give CO_2 and similar Pt(0) photoproducts.⁴ Irradiation of $Pd(NH_3)_2(ox)$ was reported⁵ to generate CO_2 and a reactive species identified as $Pd(NH_3)_2$, which decomposed to give Pd black. Poulenc⁶ noted that the yellow $Rh(py)_3(ox)Cl$ solid turned red in sunlight, and Gillard et. al⁷.have shown the reaction involves another photoinduced two-electron transfer

 $Rh(py)_3(ox)C1 \longrightarrow Rh(py)_3C1 + 2 CO_2$

Work at the Space Sciences Laboratory this summer focused on this first step, the photolysis of Rh(III) carbonato complexes. Two complexes were chosed for study - trans - $[Rh(en)_2 (H_20) (CO_3)]^+$ and $[Rh(en)_2 (CO_3)]^+$ - as they allowed a study of the affect of monodentate vs. bidentate coordination of the carbonate ion on the resulting photochemistry.

OBJECTIVES

Research was directed toward an understanding of the following questions:

- 1. What is the photochemical behavior of Rh(III)-carbonato complexes?
- 2. Do the charge-transfer and ligand field states of these Rh(III) complexes display distinct photochemical reactivity, or does intersystem crossing lead to a common photoreactive state?
- 3. What affect does monodentate vs. bidentate coordination of the carbonato ligand have on the resulting photochemistry?
- 4. Are such complexes photosensitive in the solid state, or is an aqueous solution necessary for photoreactivity? In solution, does the pH affect the photochemical reaction.

The objective of the work was to determine if photoinduced two-electron reduction of a Rh(III) center could be induced by photolysis of the appropriate Rh(III)-carbonato complex.

EXPERIMENTAL

A. Preparation of Complexes

trans-Aquochlorobis(ethylenediamine)rhodium(III) Perchlorate

The trans- $[Rh(en)_2 (H_20) (CO_3)]^+$ ion was prepared by the method of Rerek⁸. A sample of trans- $[Rh(en)_2 (C1)_2] NO_3 .H_20^9$ was anated with a five fold excess of NaN₃ (under reflux) and the desired trans- $[Rh(en)_2 (N_3)_2]^+$ was crystallized as the BF₄ salT upon addition of NaBF₄. This diazido ion was dissolved in dilute HClO₄, and NaNO₂ was added; this generated NO⁺, destroying the coordinated azide.

 $N_3 \rightarrow N_2^0(g) + N_2(g)$

At a neutral pH (adjusted with LiOH) the resulting trans- $[Rh(en)_2 (OH)(H_20)]^{2+}$ was precipitated as the perchlorate salt. A solution of this ion was acidified at pH 1 with HClO₄, and NaHCO₃ slowly added until a pH of 5.80 was reached. The perchlorate salt was precipitated by cooling in ice, followed by dropwise addition of ethanol. The absorption spectrum had λ_{max} at 347 nm ($\epsilon = 105$), consistent with published data.

Carbonatobis(ethylenediamine)rhodium(III) Perchlorate

 $(Rh(en)_2CO_3] C1O_4$ was prepared by the method of Harris et.al.¹⁰ It displayed a single peak in the electronic spectrum at 327 nm (ε =250); this absorption coefficient is less than the literature value, but any impurities were shown not to interfere in the photochemistry. There were no detectable changes in the electronic absorption spectrum of this ion in solutions between pH 1 and pH 13, clearly ruling out significant contamination of either of the monodentate ions, <u>cis</u> or <u>trans</u>- (Rh(en)₂ (H₂O) CO₃)⁺.

Barium chloride solution

Aqueous solutions of barium chloride were prepared by dissolving $BaCO_3(s)$ in 1 M HCl_(aq) until effervescence ceased, and a pH of 7 (+1) was reached. The resulting solution was filtered and kept in a sealed flask to avoid CO_2 contamination. It was boiled for ca. 20 minutes before use.

Other reagents were used as supplied by the manufacturers.

B. Photolyses

Photolyses were performed on either solid samples of aqueous solutions of the complexes. Solid samples were finely ground with mortar and pestle, and then stuck on a piece of green tape (1 cm x 3 cm). This tape was suspended in a 1 cm fused silica cell (Beckman), connected to a microvolumeter (vide infra).

For the solution studies, a sample of the desired sample was dissolved in the appropriate aqueous solution at room temperature, and placed in a 1 cm fused silica cell (Beckman). Electronic spectra were recorded with the sample in the same cell.

C. Equipment

The irradiation source was a 1000 watt Mercury-Xenon Lamp (Hanovia Manufacturing Corporation) with compatible power supply and starter (Schoeffel LPS 255 power supply and Model 359 igniter). Photolyses were performed at 28.5 amps at ²² V. Use of the compatible Schoeffel high-intensity monochromator did not allow sufficient intensity to pass to the sample, so wavelength selection was affected with a Corning colored glass filter (C-7-59). This filter effectively absorbed all radiation below 280 nm, but allowed irradiation of the ligand field bands. The absorption spectra of the C-7-59 filter along with the spectra of the two complexes studied is given in Fig. 1.

Electronic spectra were recorded on a Beckman Acta CII spectrophotometer with an external 10 inch recorder (Beckman Model 1005). The pH measurements were done with a PHM 64 Research pH Meter (Radiometer/Copenhagen) with a GK 2321C Combined Electrode. Samples averaged about 3.0 ml for pH measurements.

A microvolumeter was prepared after a design of $tevenson^{10}$. A 1 ml graduated pipet (graduated in 0.01 ml units) was used, and the evolution of a gas was detected by monitoring the flow of water bubbles down the pipet. Photolysis of solid samples of $[Rh(en)_2(N_3)_2]BF_4$, which releases N_2 , was used to check the sensitivity of the microvolumeter.



A. <u>Trans-</u> $[Rh(en)_2 (H_20) (C0_3)]^+$

1. Results

In the solid state, $trans-[Rh(en)_2 (CO_3) (H_2O)] ClO_4$ is photoinert. Prolonged photolyses (2 hrs.) with both filtered and unfiltered light did not cause any detectable release of gas. When the photolyzed solid was dissolved in water, it had an electronic spectrum indistinguishable from that of an unphotolyzed sample.

In aqueous solution, and in the absence of light, $(Rh(en)_2 (H_20)(CO_3)]^+$ is relatively unreactive. At room temperature and at a solution pH between 6 and 10, there is a minor pH increase and a minor increase in the intensity of the ligand field band. This reaction is presumably the thermal aquation of the carbonate ion, but it was slow enough to have no measurable impact on the photochemical reactions.

Upon photolysis, the electronic spectrum undergoes pronounced changes (Fig. 2). Note that photolysis causes:

- a) an increase in intensity of the ligand field band,
- b) a blue shift of the peak maximum from 347 nm to about 332 nm,
- c) virtually no shift in the position of the low-energy edge of the charge-transfer band.

There appears to be an isosbestic point near 242 nm, although the spectra are nearly parallel at that point, so the presence of an isobestic is difficult to determine.

In addition to the spectral changes observed in Fig 2., photolysis causes the release of a base into solution. Data from a typical experiment are given in Table 1, where the pH changes observed in an unphotolyzed blank and photolyzed sample are listed. (The pH changes in Table 1 were recorded from the same experiment monitored in Fig 2.).

After extended photolysis, only minor spectral changes could be photoinduced. To determine the isomeric composition of this solution, 2 ml of conc HCl was added to a 3 ml sample of photoproduct, and refluxed for 1 hour. The resulting solution had an electronic spectrum of a mixture of <u>cis</u> and <u>trans</u> - $[Rh(en)_2Cl_2]^+$ (<u>ca</u>. 63% cis and 37% trans).

The specific experiment described in Fig 2 and Table 1 was done with unfiltered light, but the same results were obtained using filtered light. The reaction was approximately 5 times more rapid using the more intense unfiltered irradiation, but the nature of the spectral and pH changes were independent of excitation wavelength.



total		• • • • • • • • • • • • • • • • • • •
photolysis time	sample	blank
(seconds)	рН	pH
Initial	7.032	7.060
100	7.110	7.070
200	7.184	7.081
300	7.245	7.096
450	7.325	7.129
600	7.376	7.136
800	7.435	7.151
1000	7.470	7.184
1300	7.504	7.216
2000	7.540	7.220

TABLE 1

Typical pH changes induced by Photolysis of Trans- $Rh(en)_2$ (H₂0)(C0₃) +

TABLE 2

total photolysis time (seconds)	sample pH	blank pH
Initial	9.905	9.916
100	9.411	9.862
200	8.557	9.789
300	7.729	9.721
400	7.375	9.616
550	7.120	9.508
705	7.002	9.380
900	6.911	9.277
1300	6.691	9.185
2200	6.495	9.086

Typical pH changes induced by Photolysis of $Rh(en)_2 (CO_3)$ +

The available results force the conclusion that photolysis of trans- $[Rh(en)_2 (CO_3)(H_20)]^+$ causes isomerization (eq⁹).

 $\frac{\text{trans-}[Rh(en)_2 (H_20) (CO_3)]}{Rh(en)_2 (H_20) (CO_3)]} \stackrel{+}{\text{ion has an absorption maximum at 332 nm, at}} (9)$ The <u>cis-</u> Rh(en)₂ (H₂0) (CO₃)] + ion has an absorption maximum at 332 nm, at a significantly higher absorption coefficient than the <u>trans</u> isomer, consistent with the blue shift and increased absorption observed upon photolysis. The lack of change in the charge-transfer edge is also significant, as the intense charge-transfer peak is a LMCT band with carbonate ligand as the donor; the LMCT bands for the analogous [Rh(en)₂ (H₂0)₂] + ions begin at significantly higher energies. As photolysis causes no shift in that edge, it is clear that significant amounts of carbonate ion are not labilized during the photolysis.

The pH changes are not consistent with this proposed reaction, however, as the reaction of eq 9 should not lead to any pH changes. Calculation of the amount of OH⁻ released after extensive photolysis shows that only a very minor amount of the Rh complex is releasing base to the solution. For example, during the experiment described in Fig 2 and Table 1, 1000 seconds of photolysis causes spectral changes indicating that about 80% of the starting material has undergone photoinduced isomerization. After those same 1000 sec., only about .0026% of the starting material has released an OH⁻ into solution. We conclude that any pH changes are due to a minor side reaction which is not related to the dominant photoisomerization. The pH increase is apparent as soon as photolysis begins, suggesting that whatever reaction causes the pH increase, it is a primary photochemical process. The rate of pH increase remains relatively constant throughout the photolysis, even when little starting material remains to be photolyzed; this implies that there is also an inefficient base-releasing secondary photochemical reaction. Whether these pH changes are due to inefficient release of carbonate ion or an ethylenedimine chelate is not known at this time.

Further support for the proposed photoisomerization comes from the anation studies. Refluxing the photoproduct in HCl leads to the acid-catalyzed aquation of the carbonate ion, which would be followed by chloride anation of the diaquo ions. Since hydrolysis of the carbonate ion occurs without metal-oxygen bond cleavage, and anations at Rh(III) centers are also known to be stereoretentive, the composition of the resulting mixture of <u>cis</u> and <u>trans-</u> [Rh(en)₂ Cl₂] + would reflect the stereochemical composition of the <u>cis</u> and trans- [Kh(en)₂ (H₂0) (CO₃)] + photoproduct mixture.

The best value for this composition - 63% cis and 37% trans-must be considered a preliminary result; further work will be done to determine whether photolysis of trans- $[Rh(en)_2 (H_20) (CO_3)]^+$ generates a photostationary state of that composition. Such a result, which available information supports, would imply that the dominate photochemical reaction of cis- $[Rh(en)_2 (H_20) (CO_3)]^+$ is isomerization back to the trans_isomer.

The reactions described above occurred upon irradiation with filtered (ligand field) and unfiltered (ligand field and charge-transfer) light. This suggests a single photoreactive state; since no evidence of photoinduced redox behavior was observed, a ligand field photoreactive state is indicated.

(Presumably, photoinduced water exchange accompanies isomerization, although the necessary isotope exchange studies have not been done to verify this assumption). There is no evidence of CO_2 release, which would suggest a photoredox process, even upon excitation of the LMCT bands. The rate of photoreaction was markedly increased when the LMCT bands were irradiated, implying that intersystem crossing, from the initially populated charge-transfer states to the photoreactive ligand field state, is efficient.

In summary, the photochemical behavior of the monodentate carbonate complexes is reminiscent of the behavior of analogous haloamine complexes of Rh(III). The LMCT states are photoinert, while the ligand field states are photoreactive, leading to ligand labilization and aquation, with concomitant stereochemical rearrangement about the Rh(III) center.

B. $[(Rh(en)_2 (CO_3)]^+$

1. Results

In the solid state, $[Rh(en)_2 (CO_3)]$ ClO₄ is photoinert. Prolonged photolysis (2 hrs) with both filtered and unfiltered light did not cause any detectable release of gas, and when a sample so photolyzed was dissolved in water, it had an absorption spectrum indistinguishable from that of an unphotolyzed sample.

In aqueous solution, and in the absence of light, $[Rh(en)_2 (CO_3)]^+$ is very inert. At room temperature and at a solution pH between 6 and 10, there was no detectable change in the absorption spectrum for over 48 hours. No pH changes, beyond those observed in the blank due to absorption of atmospheric CO₂, were observed in aqueous solutions of $[Rh(en)_2 (CO_3)]^+$.

Upon photolysis, the electronic spectrum undergoes pronounced changes (Fig. 3). Note that photolysis causes:

- a) a decrease in intensity of the ligand field band, with virtually no change in wavelength maximum
- b) a minor shift in the low-energy edge of the charge-transfer band to higher energy.

Isosbestic points are not observed in the spectrum during the initial stages of the photolysis, but an isosbestic point does develop at about 314 nm after the initial stages of the photolysis are complete.

In addition to the spectral changes observed in Fig 3, photolysis causes a marked decrease in the solution pH. Data from a typical experiment are given in Table 2. The pH changes recorded in Table 2 were observed from the same experiment monitored in Fig 3.

The presence of photoproduced carbonate ion in solution was checked by photolyzing a sample of $[Rh(en)_2 (CO_3)]^+$ in a solution containing Ba² +



ions; formation of $BaCO_{3(S)}$ would signal the presence of CO_3 in solution. (A stream of $N_{2(g)}$ was bubbled through a slightly acidic solution of $[Rh(en)_2 - CO_3]^+$ for 30 min. This solution was made basic (pH 10) with $LiOH_{(S)}$, and bubbling was continued for another 15 min. This solution volume was doubled with the addition of a freshly boiled $BaCl_2$ solution (0.5 M), with N_2 bubbling continued throughout these manipulations. Any $BaCO_{3(S)}$ which formed was allowed to precipitate and a clear solution was put into a closed, fused silica cell for photolysis. The formation of a precipitate was monitored visually, or by recording the absorption.) Photolysis with unfiltered light rapidly led to precipitate formation (presumably $BaCO_{3(S)}$), which did not occur in a blank sample held in the dark. Photolysis with the filtered light did not lead to immediate precipitate formation, but prolonged photolysis did lead to a measurable cloudiness. We attribute this to the less efficient formation of $BaCO_{3(S)}$.

In an effort to determine the stereochemical composition of the photoproduct, a sample of $[Rh(en)_2CO_3]^+$ was photolyzed with unfiltered radiation for 3200 sec., and the photoproduct solution was then diluted with an equal volume of conc HC1. The solution immediately became yellow, and displayed a broad absorption band with local maxima at about 355 nm and 325 nm. Refluxing this solution for about 1 hour led to a yellow solution without a peak at 355 nm, but a more intense, clean peak centered at 331 nm; this peak had an absorption coefficient of about 3 x 10 ${}^{3}M {}^{-1}cm^{-1}$.

2. Discussion

The photochemical reactivity of $[Rh(en)_2 CO_3]^+$ has not yet been clearly elucidated; additional work is necessary to fully explain the phenomena observed. The following hypothesis, therefore must still be considered tentative.

Direct labilization of carbonate or ethylenediamine ligands can be ruled out as primary photochemical processes, as such reactions would lead to pH increases, not the observed pH decrease. Photoinduced isomerization, as observed for the monodentate complex (vide supra), may be occurring, but cannot account for the dramatic pH decrease; in addition, the photoinduced spectral changes do not support the idea of an isomerization to some other Rh(III) tetramine complex. The observed increase in acidity, along with the detection of free $CO_3^{=}$ in solution, strongly implies that CO_2 is a primary photoproduct. The H⁺ (aq) and $CO_3^{=}$ (aq) result from the rapid hydrolysis of the acidic oxide.

 $CO_2(aq) + H_2O \longrightarrow H^+ + HCO_3^- \longrightarrow 2H^+ + CO_3^=$

Independent detection of H^+ and CO_3^- in the photolyzed solutions supports the supposition of photogeneration of CO_2 .

Two possible routes for CO_2 release seem likely:

- a) Decarboxylation of coordinated CO_3^{-1} to generate CO_2 and OH^{-1}
- b) oxidation of coordinated $CO_3 = to$ give CO_2 and $\frac{1}{2}O_2^2$. In case a), observed for the thermal reaction of the analogous CO(III) complex, the following reaction sequence would be anticipated:

$$[Rh(en)_{2}CO_{3}]^{+} + H^{+} \longrightarrow |Rh(en)_{2}CO_{3}H]^{2+}$$

$$H_{2}O + [Rh(en)_{2}CO_{3}H]^{2+} \longrightarrow |Rh(en)_{2}(H_{2}O)CO_{3}H]^{2+}$$

$$[Rh(en)_{2}(H_{2}O)CO_{3}H]^{2+} \longrightarrow |Rh(en)_{2}(H_{2}O)(OH)]^{2+} + CO_{2}$$

$$Net$$

$$reaction H_{3}O^{+} + [Rh(en)_{2}CO_{3}]^{+} \longrightarrow [Rh(en)_{2}(H_{2}O)(OH)]^{2+} + CO_{2}$$

This process does release the weak acid, CO_2 , but consumes the strong acid $H_3O + .$ Thus, the observed pH decrease would not be anticipated if such a process were occurring. In addition, reaction of the photoproduct of such a sequence with HCl would lead to <u>cis</u> or <u>trans-</u> [Rh(en)₂Cl₂]⁺; the observed product, with a single, intense peak at 331 nm is neither of the [Rh(en)₂ Cl₂]⁺ isomers.

Possibility b), the two electron oxidation of the carbonate ligand, is more consistent with the available information (and is the more fascinating photochemical reaction). Assuming concomitant two-electron reduction of the Rh(III) center, a reaction of the form (eq 10)

$$\left[\operatorname{Rh}(\operatorname{en})_{2}\operatorname{CO}_{3} \right]^{\dagger} \longrightarrow \left[\operatorname{Rh}(\operatorname{en})_{2} \right]^{\dagger} + \operatorname{CO}_{2} + {}^{1}_{2}\operatorname{O}_{2}$$
(10)

would be occurring.

Reaction 10 is consistent with a variety of observations. Plots of "moles of H⁺ released" as a function of photolysis time showed two distinct patterns, depending upon the initial pH (Fig. 4). At pH 6, the rapid initial generation of H⁺ becomes less pronounced as the photolysis proceeds; at pH 10, the initial photolysis period generates only minor amounts of H⁺, followed by a more rapid rate of H⁺ generation. This is consistent with the release of a weak acid, as at pH 10 the $[HCO_3 -] / [CO_2]$ ratio would be four orders of magnitude larger than at pH 6.

$$H_20 + CO_2 \implies HCO_3^- + H^+$$
(11)

$$K = \frac{[H^+][HCO_3^-]}{[CO_2]}$$
(12)

$$\frac{K}{[H^+]} = \frac{\left[HCO_3^{-}\right]}{[CO_2]}$$
(13)

Such a large concentration of bicarbonate ion would act as a buffer, resisting the generation of H^+ ions upon the addition of CO_2 to the solution. As shown in Fig. 4, H^+ increase was initially quite slow, until the buffering action of the bicarbonate ion was overcome. At pll 6, the bicarbonate ion concentration would be less formidable, and little buffering action would be apparent. If we consider that for reaction 11,

$$\begin{bmatrix} H^{+} \end{bmatrix} = \begin{bmatrix} HCO_{3}^{-} \end{bmatrix} \text{ and } \begin{bmatrix} CO_{2} \end{bmatrix} = \begin{bmatrix} CO_{2} \end{bmatrix} \text{ initial } - \begin{bmatrix} H^{+} \end{bmatrix}$$

$$K = \frac{|H^{+}|^{2}}{\begin{bmatrix} CO_{2} \end{bmatrix}} = \frac{|H^{+}|^{2}}{\begin{bmatrix} CO_{2} \end{bmatrix} \text{ initial } - \begin{bmatrix} H^{+} \end{bmatrix}}$$

$$XVI-18$$

we can write



Solving for H^+ , one obtains:

$$[H^+] = \left\{ K \left(\begin{bmatrix} CO_2 \end{bmatrix} \right] \text{ initial} + \frac{{}^{1_4}K^2}{2} - {}^{1_2}K \quad (14) \right\}$$

Evaluating for H^+ at increasing levels of $[\text{CO}_2]$ initial (representing the CO_2 gnerated by photolysis) gives a curve which closely models the pH 6 curve of Fig. 4.

After 2200 seconds of unfiltered irradiation of $[Rh(en)_2CO_3]^{T}$, the spectrum shows that a significant amount of the starting material has photochemically reacted. The data from Table 2 can be used to show that the H⁺ released at that time is equivalent to about 10% of the total Rh(III) concentration. This, again, is consistent with the photogeneration of a weak acid (CO₂). A more quantitative assessment is not yet possible, as the exact nature of the Rh -containing photoproduct is not known.

The nature of the Rh-containing photoproduct is a major mystery remaining after this summer's work. The observed spectral changes do not suggest the formation of any obvious Rh(III) tetraamine species, and refluxing the photoproduct in HCl leads to an intensely yellow species which has, as yet, escaped identification. The spectral changes are consistent with the formation of the same product observed upon BH₄⁻ reduction of $cis - [Rh(en)_2Cl_2]^+$, suggestive of a two-electron reduction of the Rh(III) center, but further work would be necessary to corroborate this supposition.

In summary, work this summer has led us to the tantalizing hypothesis that ligand field and charge-transfer photolysis of a bidentate carbonato complex of Rh(III) leads to the two-electron oxidation of the carbonate ligand, with complementary reduction of the Rh(III) center. This result, if borne out by further studies, would represent a new type of photochemical reaction, and would encourage further work on the water-photolysis scheme (eq 4-8).

1. Conclusions

a) The monodentate carbonato complex, <u>trans-</u> $[Rh(en)_2 (H_{20})(CO_3)]^+$ efficiently undergoes photoisomerization:

 $\underbrace{\operatorname{trans-}\left[\operatorname{Rh}(\operatorname{en})_2 (\operatorname{H}_20)(\operatorname{CO}_3)\right]^+ \xrightarrow{\operatorname{hv}} \operatorname{cis-}\left[\operatorname{Rh}(\operatorname{en})_2 (\operatorname{H}_20) (\operatorname{CO}_3)\right]^+ }_{ \text{There is no evidence of electron-transfer upon either ligand field or charge-transfer excitation. A very inefficient base-releasing photochemical reaction also occurs, but its nature has not been characterized. Preliminary evidence implies that the cis-aquocarbonato photoproduct undergoes photoinduced isomerization back to <math display="block"> \underbrace{\operatorname{trans-}}_{\mathrm{Rh}(\operatorname{en})_2 (\operatorname{H}_20)(\operatorname{CO}_3)}^+.$

b) Ligand field and charge-transfer photolysis of the bidentate carbonato complex, $Rh(en)_2 CO_3^+$ causes the release of CO_2 into solution by a reaction tentatively described as:

 $\left[\operatorname{Rh}(\operatorname{en})_2 \operatorname{CO}_3 \right]^+ \xrightarrow{h \, v} \left[\operatorname{Rh}(\operatorname{en})_2 \right]^+ + \operatorname{CO}_2 + \frac{1}{2} \operatorname{O}_2$

If subsequent studies corroborate the occurrence of a two-electron transfer, it will represent a new class of photochemical reaction. Such a reaction is the crucial first step in a water-photolysis scheme (eq 4-8), so confirmation of an efficient two-electron transfer, induced by a single photon, will open a new area of transition metal photochemistry.

2. Recommendations

This summer's study has shown that a promising area of transition metal photochemistry can be found in the study of bidentate carbonate complexes. The nature of the Rh-containing photoproduct in the photolysis of $[Rh(en)_2 CO_3]$ must receive immediate attention, and the design of future experiments depends on the results of that study. Available evidence strongly suggests that a two-electron redox process is involved, so the next steps must include:

a) a study to determine the factors which maximize the efficiency (quantum yield) of this redox reaction.

b) Studies must be initiated to increase the amount of the solar spectrum absorbed by the photoreactive complex. A logical approach would be to look at some substituted bipyridyl ligands or other aromatic ligands with extensive absorption in the visible and near-IR portions of the spectrum. The use of intensely colored sensitizers should also be studied.

c) Parallel studies should explore the detailed chemistry of the watersoluble complexes of Rh(I). The nature of the four-coordinate d^8 complexes, and the proposed d^6 hydrides must be determined. The thermal and photochemical properties of a variety of such hydride complexes must be studied to determine the conditions which would lead to a photoreactive hydride complex.

In summary, the discovery of a two-electron redox reaction, induced by a single photon, suggests that it may be possible to photochemically generate H₂ from water without the complications inherent in the hydrogen atom radical. This should encourage further study of a carbonate-based system for the photochemical cleavage of water.

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CALCULATIONS AND MEASUREMENTS IN SUPPORT OF THE TRIGLYCINE SULFATE ZERO GRAVITY GROWTH EXPERIMENT

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CALCULATIONS AND MEASUREMENTS IN SUPPORT OF THE TRIGLYCINE SULFATE ZERO GROWTH GRAVITY EXPERIMENT

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ABSTRACT

The solution growth of crystals of triglycine sulfate (TGS) in a zero gravity environment is a materials processing experiment planned for an early Spacelab mission. This experiment has the twin objectives of both studying the growth process by optical means and also returning the grown crystals to earth for characterization.

This paper describes two areas of investigation which are required for maximum utilization of the flight experiment results. The first area studied is the use of an ultramicroscope to characterize structural defects in the grown TGS crystals. Mie theory has been applied to the light scattering expected from idealized crystal defects in order to predict the sensitivity of ultramicroscopy in the detection of small defects.

The second area of investigation has involved the measurement of optical properties of TGS solutions in water. This data is needed in order to interpret interferometric studies of mass transport through the TGS solution during the growth phase of the flight experiment. In particular, refeactive index data has been obtained for a wide range of temperatures and concentrations of TGS solutions. Absorbance measurements in the ultraviolet have also been made for the same samples.

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INTRODUCTION

One of the materials processing experiments that will be flown aboard an early Spacelab mission is the solution growth of triglycine sulfate (TGS). This experiment has two objectives, one being the observation of the crystal growth process itself by optical techniques such as Schlieren photography and interferometry, the other being the return of the zero-gravity grown crystals to earth for testing and comparison with their earth-grown counterparts.

This report describes two studies performed which are related to the TGS growth experiment. The first part discusses the use of a light scattering technique called ultramicroscopy to characterize triglycine sulfate crystals. The theory of Mie for the scattering of light by spheres is used to indicate the sensitivity of the ultramicroscope in the detection of volume defects. Although based on an idealization of the actual defects that would be present in a real crystal, this analysis is useful in analyzing the effectiveness of this technique.

The second part of the report presents data on the optical properties of solutions of TGS in water. This information on the refractive index and optical absorbance of TGS in solution is required for the analysis of the Schlieren and interferometric data which will be obtained during the crystal growth experiment on Spacelab 3.

I. Crystal Characterization by Ultramicroscopy

A. General

Crystal characterization involves describing a crystal's structure and composition in such a way that those of its properties of relevance to the study at hand are well enough known to predict in principle the behavior of the crystal. One of the important features of a crystal are its departures from the perfect array of atoms by which its structure is commonly described. These departures from ideality, called defects, exist in every real crystal and range from the simple absence of a single atom from the lattice to dislocations involving the entire crystal.

The scattering of electromagnetic radiation incident on a crystal is one tool for detecting defects. The scattering and diffraction of X-rays yields information on structural features whose size is on the order of the lattice spacing. In the case of optically transparent erystals, the scattering of visible light can also reveal structural defects in a crystal, though not with the detail of X-ray topography. For a crystal whose optical properties are germane to its application, however, the measurement of visible light scattering is essential for its proper characterization.

One method being implemented to study TGS crystals by light scattering is that of the ultramicroscope. In this technique, illustrated in Figure 1, a beam of light focussed to a small diameter is used to illuminate the crystal. As the light passes through the crystal, it is scattered by inhomogeneities in the crystal's refractive index, such as are caused by certain types of defects. In order to observe the light scattered from the defects, a microscope is used to collect the light scattered at right angles to the beam. Small, isolated defects show up as points of light in the dark surrounding field of view. Regions of a crystal where the defect density is quite high will show nebulous or diffuse scattering regions. As described by Vand,¹ a small He-Ne laser makes an excellent source for the ultramicroscope. This method has already been used to study the relation between defects in TGS and its dielectric properties.²

A diagram of an ultramicroscope being constructed for the study of TGS is shown in Figure 2. This ultramicroscope will use photoelectric rather than photographic detection of scattering centers, and will be computer driven so a three dimensional map of the light scattering defect may be constructed.^{*} In the remainder of this section of the report, an analysis is described in which the expected sensitivity of this ultramicroscope to defects is calculated. This sensitivity will be seen to depend on defect size and relative effective refractive index.

* This is being constructed at Fisk University with the support of NASA Grant #NSG-8060.





FIGURE 1: Schematic diagram of ultramicroscope used to observe defect scattering.



FIGURE 2: Automated ultramicroscope

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B. Discussion

The model "defect" which has been used in this study is that of a homogeneous sphere of diameter D and refractive index n. This spherical defect is assumed to be surrounded by the undisturbed TGS lattice. The absorption coefficient of the defect is assumed to be zero, so the refractive index is a real number. It is illuminated in the ultramicroscope by a plane electromagnetic wave of wavelength 632.8 nm in air.

The theory of scattering of electromagnetic waves by spheres is a classical problem, and was solved analytically by Mie.³ His solutions involve infinite sums of complex functions, but several sets of tables are available in the literature which make the evaluation of the solutions for particular cases straightforward, if somewhat tedious.^{4,5,0} Computer programs for this purpose have also been written, and would be useful if a large number of cases must be calculated.

Figure 3 defines the geometry of the problem. According to the treatment by Boll, the scattered light intensity is represented by two intensity functions i_1 and i_2 , given by

$$i_{1} = \frac{\lambda^{2}}{g_{\pi^{2}}} \left| \sum_{n=1}^{\infty} \left\{ A_{h} \frac{dP_{n}(x)}{dx} + B_{h} \left[x \frac{dP_{n}(x)}{dx} - (1-x^{2}) \frac{d^{2}P_{n}(x)}{dx^{2}} \right] \right\} \right|^{2} (1)$$

and

$$i_{2} = \frac{\lambda^{2}}{\beta_{\pi^{2}}} \left| \sum_{n=1}^{\infty} \left\{ A_{n} \left[x \frac{dP_{n}(x)}{dx} - (1-x^{2}) \frac{d^{2}P_{n}(x)}{dx^{2}} \right] + B_{n} \frac{dP_{n}(x)}{dx} \right\} \right|^{2} (z)$$

where $P_n(x)$ is a Legendre polynomial of order n, with $x = -\cos(\theta)$. Θ is the scattering angle from the incident direction. The coefficients A_n and B_n are complex Ricatti-Bessel and Hankel functions, and for the values to be considered here can be obtained from tables.⁴ These coefficients depend on only two physically relevant parameters for their evaluation, a size parameter.

$$\mathcal{L} = \frac{\pi \mathbf{D}}{\lambda} \tag{3}$$

where D = the scattering particle diameter

 λ = the wavelength of the incident light in the surrounding medium

and m, the refractive index of the scattering particle relative to the surrounding medium.



FIGURE 3: Orientation of the intensity functions for right angle scattering.

For plane-polarized incident light, the intensity function i_1 is the component of scattered light polarized perpendicular to the electric vector of the incident beam, and i_2 represents the component of scattered light polarized parallel to the plane formed by the electric vector of the incident beam and its direction of propagation. The resulting scattered intensity per unit incident intensity and unit solid angle is for any direction θ , \emptyset given by

$$\mathbf{I} = \frac{\lambda^2}{4\pi^2} \left[(\cos^2 \phi) \mathbf{i}_1 + (\sin^2 \phi) \mathbf{i}_2 \right]$$
(4)

In the ultramicroscope, the scattered light collected by the objective lens is nominally at a scattering angle $\theta = 90^{\circ}$. If the incident light on the crystal is polarized with its electric vector perpendicular to the plane formed by the incident and scattered light directions of propagation, then $\emptyset = 90^{\circ}$ also, so the total scattered intensity per unit solid angle is

$$I_{n} = I_{0} \frac{\lambda i_{1}}{8\pi^{2}}$$
(5)

where I_0 is the incident intensity (W/m²).

A typical objective used on the microscope will have a numerical appearature of 0.25. Taking into account the refraction that occurs at the surface of the TGS crystal as the scattered light passes into the air, an objective lens of N. A. 0.25 will collect a cone of light with a half-angle of 9° in the crystal, corresponding to a solid angle of 0.00612. So for this case, the scattered power entering the objective lens will be

$$P_{s} = I_{o} \frac{\lambda}{9n^{2}} (6.12 \times 10^{-3}) i_{2}$$
 (6)

In the ultramicroscope the detector is a photodiode with an active area which is larger than the image of the smaller defects with which this analysis is concerned, so the scattered light power collected by the objective lens will all fall on the detector when the defect is centered in its field of view. P_s , therefore, is the relevant value which must be calculated and compared with the sensitivity of the detector and its amplifier.

C. Calculations

The relevant physical parameters of a defect are its diameter D and refractive index n. TGS in solution at its saturation point at 25° has a refractive index of approximately 1.38. The crystalline solid has three principal indices which range from 1.484 to 1.584.⁸ Values of the relative refractive index m could be expected to vary typically from 0.6 for a void with absolute index 1 to 0.93 for a volume defect consisting of uncrystallized solution. The actual values of m could of course be close to 1 for small distortions of the lattice. Values of the size parameter which are available in Boll's? tables range upward from 1 to 120. Since only small defects are of interest in finding the limit of detectable scattering, values of from 1-10 were used in the calculations. In triglycine sulfate, this corresponds to a diameter of from approximately 1.2 x 10-7 meters to 1.2 x 10⁻⁰ meters when the wavelength of the incident light is 632.8nm.

The laser which will be used is a 5mW He-Ne laser, which can be focussed to a 20 x 10^{-0} meter diameter in the crystal. This gives an average beam intensity of $I_0 = 1.6 \times 10^7 \text{ W/m}^2$. Using a refractive index of 1.58 for the crystalline TGS, the wavelength of the laser light in the crystal is $\lambda = 400$ nm. These values give a scattered power from equation 6 of

$$P_{g} = I_{0} \frac{\lambda^{2} (6.12 \times 10^{-3})}{8\pi^{2}} i_{z} = (1.98 \times 10^{-10} \text{Watts}) i_{z}$$
(7)

Representative values of the scattered power collected by the ultramicroscope for several values of and m are shown in Table 1. The effective scattering defect size D is also given.

An evaluation of these values in terms of photoelectric detection can be made by comparison with the noise figure for a photodiode which is being evaluated in the ultramicroscope. The photodiode, a model PN-40A from United Detector Technology, has a noise equivalent power (NEP) of 10⁻¹¹ Watts. For spherical defects with a relative refractive index near unity (0.93), defects of this type would have to exceed 300nm to be above the noise level of the detector. For voids, where the refractive index would be around 0.6, a defect somewhat small (100nm) would scatter sufficiently to be observed.

Power scattered at 90° from spherical defects for plane polarized incident beam of wavelength 400 nm and intensity 1.6 x 10^7 W/m². Power is in Watts.

	Defect Diameter (nm)	Relative Refractive Index m					
d		0.6	0.7	0.75	0.8	0.9	0.93
1	127	6.2x10-14	2.9x10 ⁻¹⁵	1.5x10 ⁻¹⁵	6.6x10 ⁻¹⁶	4.7×10 ⁻¹⁷	1.2x10 ⁻¹⁷
2	250	2.7x10 ⁻¹²	1.2x10 ⁻¹²	7.5x10 ⁻¹³	3.2x10 ⁻¹³	2.8x10 ⁻¹⁴	7.5x10 ⁻¹⁵
3	381					4.1x10 ⁻¹⁴	1.1x10 ⁻¹³
4	508					4.9x10 ⁻¹⁴	1.3x10 ⁻¹³
5	635					8.9x10 ⁻¹⁴	3.2x10 ⁻¹³
10	127					2.0x10 ⁻¹²	1.6x10 ⁻¹²

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II. Optical Measurements

Refractive index and ultraviolet absorbance measurements were made on solutions of triglycine sulfate in distilled water at concentrations ranging from 0.25 grams-TGS/100 grams-H₂O to 32 grams-TGS/100 grams-H₂O. Samples of various concentrations were obtained by making an initial solution of 32g/100g, dividing this in half and diluting one part to make a 16g/100g solution, and then repeating this process to form a series of samples each one-half as concentrated as its predecessor. The resulting solutions were stored in sealed bottles. The samples were weighed during their preparation to a precision of ± 0.01 grams.

Refractive index measurements were made using a Billingham and Stanley Model 60/ED precision Abbe refractometer. The sample and prism temperature was controlled by water circulated from a water bath in which the temperature was regulated to ± 0.01 degree centigrade. The actual refractometer head temperature versus bath temperature was determined by calibration to compensate for heat loss in the connecting tubing. Temperature measurement was made using a Cole-Parmer Model 8502-25 thermistor thermometer, and a Yellow Springs Inc. Model 703 thermistor probe. A sodium lamp was used to illuminate the refractometer, so the values obtained are for the sodium D₁ line, 589.6 nm. Values calculated from the critical angle measurements using the refractometer are given in Table 2. Graphs of n_d vs temperature for various concentrations and n_d vs concentration for different temperatures are shown in Figures 4 and 5.

Transmission curves in the range of 200 - 300 nm were measured for the same samples used in the refractive index study. The curves were recorded on a Model 701 Heath/Schlumberger single-beam spectrophotometer. All measurements were made for a 10 mm path length. This data will be used in experimentally determining mass diffusion coefficients for TGS in water. For this purpose, a graph of the wavelengths at which the present transmission of the solutions reaches 50% is useful. This graph is shown in Figure 6.
TABLE 2: Refractive Index Data for Triglycine Sulfate Solution $-(n_d)$

Concentration	Solution Temperature - Degree Celsius												
g/100g H ₂ 0	24.98	29.66	34.36	39.28	43.95	48.75	53.45	58.23					
0.25	1.33290	1.33236	1.33170	1.33100	1.33018	1.32938							
0.50	1.33312	1.33252	1.33191	1.33114	1.33052	1.32952	1.32858	1.32762					
1.00	1.33381	1.33326	1.33259	1.33184	1.33108	1.33020	1.32929						
2.00	1.33541	1.33476	1.33411	1.33337	1.33253	1 .3317 6	1.33085	1.32989					
4.00	1.33853	1.33791	1.33721	1.33643	1.33560	1.33471	1.33380	1.33292					
8.00	1.34408	1.34343	1.34274	1.34190	1.34101	1.34009	1.33918	1.33819					
16.00	1.35430	1.35352	1.35270	1.35188	1.35011	1.35011	1.34917	1.34815					
32.00	1.37116	1.37038	1.36948	1.36879	1.36779	1.36681	1.36590	1.36494					





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FIGURE 5: Refractive index vs concentration for solutions of TGS in water.

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FLUID DYNAMIC ANALYSIS OF THE SPACE SHUTTLE MAIN ENGINE HIGH PRESSURE OXIDIZER TURBOPUMP SLINGER SEAL

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FLUID DYNAMIC ANALYSIS OF THE SPACE SHUTTLE MAIN ENGINE HIGH PRESSURE OXIDIZER TURBOPUMP

SLINGER SEAL

By

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ABSTRACT

An analytical study has been conducted to clarify the details of the flow on the bladed side of a centrifugal type dynamic shaft seal utilized to contain liquid oxygen in the Space Shuttle Main Engine high pressure oxidizer turbopump.

The governing equations are solved to predict the pressure and temperature gradients and to aid in investigating the nature of the liquid-vapor interface.

Recommendations for design improvements are discussed.

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NOMENCLATURE

.

a	-	Axial clearance between seal and housing (in)
b	- .	Blade height (in)
С	-	Constant pressure specific heat (BTU/1bm- ^O R)
Cm	-	Moment coefficient (one side), $\tau / \chi_{\rho \omega}^2 r^5$
C _{ms}	-	Smooth disk moment coefficient (one side)
c _{mv}	-	Vaned disk moment coefficient
Ec	-	Eckert Number, $\omega^2 R^2 / CT_o$
h	-	Enthalpy (BTU/1bm)
k	-	Thermal conductivity (BTU/fthr ^O R)
к	-	Fluid angular velocity ratio, eta / ω
'n	-	Mass flow rate (1bm/sec)
Р	-	Pressure (lbf/in ²)
Ē	-	Dimensionless pressure, $p/\rho \omega^2 R^2$
Pr	-	Prandtl number, Cµ/k
r	-	Radial coordinate, radial distance (in)
r	-	Dimensionless radial coordinate, r/R
R	-	Disk radius (in)
Rint	-	Liquid-vapor interface radius (in)
Re	-	Reynolds number, $\omega R^2 / \nu$
т	-	Temperature (^O R)
Ŧ	-	Dimensionless temperature, T/T _o
т _о	-	Seal fluid flow inlet temperature (^O R)
u	-	Radial velocity component (ft/sec)
ū	-	Dimensionless radial velocity component, u/R $_{\odot}\omega$

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v	-	Tangential velocity component (ft/sec)
v	-	Dimensionless tangential velocity component, v/R ω
W	-	Axial velocity component (ft/sec)
w	-	Dimenisonless axial velocity component, w/R $_{\omega}$
z	-	Axial coordinate, axial distance (in)
z	-	Dimensionless axial coordinate, z/R
β	-	Angular velocity of fluid (rad/sec)
μ	-	Viscosity (lbm/ft-sec)
ν	-	Kinematic viscosity (ft ² /sec)
ρ	-	Density (1bm/ft ³)
τ	-	Torque (ft-1bf)
ω	-	Angular velocity of disk (rad/sec)
1,2	-	Subscripts denoting radial location on disk

INTRODUCTION

In high pressure oxidizer turbopumps it is necessary to have effective sealing systems to prevent contact between the turbine hot gas and the oxidizer being pumped. The centrifugal dynamic shaft seal, or slinger seal, can be a valuable part of such a sealing system.

In a slinger seal, a disk shaped impeller with vanes on one side and the other side smooth, rotates with the shaft to be sealed inside a close fitting, but non-contacting housing, as shown in Fig. 1. The liquid to be sealed is centrifuged to the outer periphery of the rotating disk, but because the vaned side has a steeper pressure gradient [1] there will be a resulting net pressure difference across the seal which limits the fluid flow. A gas introduced to the system or vaporized liquid will form an interface with the liquid on the vaned side of the seal.

The primary seal in the Space Shuttle Main Engine high pressure oxidizer turbopump uses this type of slinger with a downstream labyrinth as shown in Fig. 2. The actual seal is modeled by the simplified geometry indicated by Fig. 3.

Previous investigations have primarily been concerned with the more general topic of rotating disks. The theoretical work on free rotating disks done by von Karmán [2], which was corrected by Cochran [3], and the analysis of the enclosed rotating disk by Schultz-Grunow [4] are fundamental to many of the later studies. Daily and Nece, with their experimental work on enclosed rotating disks [5], [6], [7], laid a base for much of the theoretical [8], [9] as well as experimental [10], [11], [12] work that followed.

A limited number of researchers have studied the utilization of enclosed rotating disks as centrifugal seals, with most of their work being experimental or the correlation of experimental data with simple models [13], [14], [15], [16], [17], [18]. A notable exception is the theoretical analysis of smooth slinger seals by Rosenthal and Reshotko [19], [20].

OBJECTIVES

The purpose of this paper is to analyze the dynamics of the fluid on the vaned side of a slinger seal. The governing equations are established and reduced to a form solvable by numerical methods. Time constraints prevent the complete solution by matching of the boundary conditions and numerical analysis so this will be done as a future task.

Some of the important thermodynamic design considerations for this type seal are the radial pressure distribution, temperature distribution, and the liquid-vapor equilibrium interface. A solution is found for the radial pressure distribution and in order to look at the liquid-vapor interface a simplified analysis is used to obtain a restrictive temperature distribution.

DEVELOPMENT OF EQUATIONS

The fluid will be treated as an incompressible, Newtonian fluid where body forces and radiation effects are negligible. Temperature variations will generally be small so the viscosity, thermal conductivity and specific heats can be treated at constants for a particular temperature range [21]. The flow is steady and axisymmetric. Using these assumptions and the usual notation for rotational flow, the governing equations are:

Continuity

$$\frac{\partial u}{\partial r} + \frac{\partial w}{\partial z} = 0 \tag{1}$$

Radial Momentum

$$\mathbf{u} \frac{\partial \mathbf{u}}{\partial \mathbf{r}} - \frac{\mathbf{v}^2}{\mathbf{r}} + \mathbf{w} \frac{\partial \mathbf{u}}{\partial z} = -\frac{1}{\varrho} \frac{\partial \mathbf{p}}{\partial \mathbf{r}} + \nu \left[\frac{\partial^2 \mathbf{u}}{\partial \mathbf{r}^2} + \frac{\partial}{\partial \mathbf{r}} \left(\frac{\mathbf{u}}{\mathbf{r}} \right) + \frac{\partial^2 \mathbf{u}}{\partial z^2} \right]$$
(2)

Tangential Momentum

$$\mathbf{u} \quad \frac{\partial \mathbf{v}}{\partial \mathbf{r}} + \frac{\mathbf{u} \mathbf{v}}{\mathbf{r}} + \frac{\partial \mathbf{v}}{\partial z} = \mathbf{v} \left[\frac{\partial^2 \mathbf{v}}{\partial r^2} + \frac{\partial}{\partial r} \left(\frac{\mathbf{v}}{\mathbf{r}} \right) + \frac{\partial^2 \mathbf{v}}{\partial z^2} \right]$$
(3)

Axial Momentum

$$u \frac{\partial w}{\partial r} + w \frac{\partial w}{\partial z} = -\frac{1}{\varrho} \frac{\partial p}{\partial z} + \nu \left[\frac{\partial^2 w}{\partial r^2} + \frac{1}{r} \frac{\partial w}{\partial r} + \frac{\partial^2 w}{\partial z^2} \right]$$
(4)

Energy

$$\rho C \left(u \quad \frac{\partial T}{\partial r} + w \quad \frac{\partial T}{\partial z} \right) = k \left(\frac{\partial^2 T}{\partial r^2} + \frac{1}{r} \quad \frac{\partial T}{\partial r} + \frac{\partial^2 T}{\partial z^2} \right) +$$

$$\mu \left[2 \left(\frac{\partial u}{\partial r} \right)^2 + 2 \left(\frac{u}{r} \right)^2 + 2 \left(\frac{\partial w}{\partial z} \right)^2 + \left(\frac{\partial v}{\partial z} \right)^2 + \left(\frac{\partial u}{\partial z} + \frac{\partial w}{\partial r} \right)^2 + \left(\frac{\partial v}{\partial r} - \frac{v}{r} \right)^2 \right]$$
(5)

Equations (1)-(5) can be non-dimensionalized by using the following substitutions:

$$\overline{r} = \frac{r}{R}, \overline{Z} = \frac{Z}{R}, \overline{u} = \frac{u}{\omega R}, \overline{v} = \frac{v}{\omega R}, \overline{w} = \frac{w}{\omega R}, \overline{P} = \frac{P}{\rho \omega^2 R^2}, \overline{T} = \frac{T}{T_0}$$

where T_0 is the fluid inlet temperature.

Using these expressions the differential equations become in dimensionless form:

Continuity

$$\frac{\partial \overline{u}}{\partial \overline{r}} + \frac{\overline{u}}{\overline{r}} + \frac{\partial \overline{w}}{\partial \overline{z}} = 0$$
(6)

Radial Momentum

$$\overline{\mathbf{u}} \quad \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{r}}} \quad -\frac{\overline{\mathbf{v}}^2}{\overline{\mathbf{r}}} + \overline{\mathbf{w}} \quad \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{z}}} = -\frac{\partial \overline{\mathbf{p}}}{\partial \overline{\mathbf{r}}} + \frac{1}{\mathrm{Re}} \left[\frac{\partial^2 \overline{\mathbf{u}}}{\partial \overline{\mathbf{r}}^2} + \frac{1}{\overline{\mathbf{r}}} \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{r}}} - \frac{\overline{\mathbf{u}}}{\overline{\mathbf{r}}} + \frac{\partial^2 \overline{\mathbf{w}}}{\partial \overline{\mathbf{z}}^2} \right]$$
(7)

Tangential Momentum

$$\vec{u} \quad \frac{\partial \vec{v}}{\partial \vec{r}} + \frac{u \vec{v}}{\vec{r}} + \vec{w} \quad \frac{\partial \vec{v}}{\partial \vec{z}} = \frac{1}{Re} \left[\frac{\partial^2 \vec{v}}{\partial \vec{r}^2} + \frac{1}{\vec{r}} \frac{\partial \vec{v}}{\partial \vec{r}} - \frac{\vec{v}}{\vec{r}^2} + \frac{\partial^2 \vec{v}}{\partial \vec{z}^2} \right]$$
(8)

Axial Momentum

$$\overline{\mathbf{u}} \quad \frac{\partial \overline{\mathbf{w}}}{\partial \overline{\mathbf{r}}} + \overline{\mathbf{w}} \quad \frac{\partial \overline{\mathbf{w}}}{\partial \overline{\mathbf{z}}} = - \quad \frac{\partial \overline{\mathbf{P}}}{\partial \overline{\mathbf{z}}} + \frac{1}{\mathsf{Re}} \left[\frac{\partial^2 \overline{\mathbf{w}}}{\partial \overline{\mathbf{r}}^2} + \frac{1}{\mathsf{r}} \quad \frac{\partial \overline{\mathbf{w}}}{\partial \overline{\mathbf{r}}} + \frac{\partial^2 \overline{\mathbf{w}}}{\partial \overline{\mathbf{z}}^2} \right] \tag{9}$$

Energy

$$\overline{\mathbf{u}} \quad \frac{\partial \overline{\mathbf{T}}}{\partial \overline{\mathbf{r}}} + \overline{\mathbf{w}} \quad \frac{\partial \overline{\mathbf{T}}}{\partial \overline{\mathbf{z}}} = \frac{1}{\Pr \operatorname{Re}} \left(\frac{\partial^2 \overline{\mathbf{T}}}{\partial \overline{\mathbf{r}}^2} + \frac{1}{\overline{\mathbf{r}}} \quad \frac{\partial \overline{\mathbf{T}}}{\partial \overline{\mathbf{r}}} + \frac{\partial^2 \overline{\mathbf{T}}}{\partial \overline{\mathbf{z}}^2} \right) + \frac{\mathbf{E} \operatorname{c}}{\operatorname{Re}} \left[2 \left(\frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{r}}} \right)^2 + 2 \frac{\overline{\mathbf{u}}^2}{\overline{\mathbf{r}}^2} + 2 \left(\frac{\partial \overline{\mathbf{w}}}{\partial \overline{\mathbf{z}}} \right)^2 + \left(\frac{\partial \overline{\mathbf{v}}}{\partial \overline{\mathbf{z}}} \right)^2 + \left(\frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{z}}} \right)^2 + \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{z}}} \partial \overline{\mathbf{r}}} + \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{z}}} \partial \overline{\mathbf{r}}} + \frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{z}}} \partial \overline{\mathbf{r}}} \right) \left(\frac{\partial \overline{\mathbf{w}}}{\partial \overline{\mathbf{z}}} \right)^2 + \left(\frac{\partial \overline{\mathbf{v}}}{\partial \overline{\mathbf{z}}} \right)^2 + \left(\frac{\partial \overline{\mathbf{u}}}{\partial \overline{\mathbf{u}}} \right)^2 + \left(\frac{\partial \overline{\mathbf{u}}}{\partial$$

where

$$Re = \frac{\omega R^2}{\nu}, Pr = \frac{\mu C}{k}, Ec = \frac{\omega^2 R^2}{C T_0}$$
(11)

Equations (6)-(9) can be solved independent of equation (10) and are to be done by numerical analysis. The resulting flow field solution can then be used to solve equation (10) for the temperature distribution. The entire solution of these equations will be completed at a later time.

RADIAL PRESSURE DISTRIBUTION

The sealing capability of a slinger will be determined by the radial pressure gradient. The exact nature of this gradient will be quite complex due to the complicated flow across the disk. As an example, see reference 22 for a detailed look at secondary flows in a centrifugal impeller. Other interrelated factors are the presence of a liquid-vapor interface [18], pressure variation between vanes [23], and fluid throughflow [24], although the experimental results of Due [25] indicated that there was no significant dependance on flow coefficient.

A simplified approach is necessary so it is assumed that once steady state operation is reached the fluid in any thin annulus moves as a solid mass rotating about its own axis with angular velocity K ω where K is the ratio of the fluid angular velocity, β , to the disk angular velocity, ω . The radial velocity will be small compared to the tangential velocity and will be neglected, so the radial momentum equation (2) becomes:

$$\frac{1}{r} \frac{1}{v^2} = \frac{1}{\rho} \frac{\partial p}{\partial r}$$
(12)

Since the pressure is a function of the radius only, this equation reduces to an ordinary differential equation. Then substituting $K\omega r$ for the tangential velocity results in:

$$\frac{dp}{dr} = \frac{\rho (K \omega r)^2}{r}$$
(13)

Integrating between any two radial points on the face of the slinger yields:

$$\Delta p = p_2 - p_1 = \frac{\rho}{2} \kappa^2 \omega^2 (r_2^2 - r_1^2)$$
(14)

Other investigators [5], [12], [19], have obtained the same result by different approaches and their close correlation with their experimental results verifies its general applicability.

The value of K must be determined to solve for the pressure gradient, but K will be influenced by several variables including geometry of the seal, solidity, clearances, Reynolds number and radius. Since the fluid between the vanes on a slinger will rotate essentially with the slinger angular velocity, $K \approx l$, but the fluid in the gap between the vanes and the housing will rotate at some lesser angular velocity. The regions could be considered separately but in reference 25 Due established equations for K by correlating experimental data to equation (14) using a statistical regression analysis. The applicable equation from Due is:

$$K = 0.951 - 0.282 \frac{r}{R} + 0.2137 \frac{b}{a+b} + 0.175(b)$$
(15)

where R is the seal radius, a is the seal to housing gap width, b is the blade height, and r is the particular radial distance. Average values for the subject seal are: a = 0.08 in., b = 0.25 in., and R = 2.24 in. Using these values in equations (14) and (15) the radial pressure distribution can be determined.

TEMPERATURE DISTRIBUTION

Due to the rotation of the slinger, energy is imparted to the fluid, manifested as a temperature rise and eventually as a phase change from liquid to vapor. This phase change causes a drastic change in the density of the fluid and a resulting smaller radial pressure change. To account for this effect, the radial temperature distirbution must be known.

A simple control volume analysis will be used to look at the enthalpy increase from one radial plane to another. Knowing the enthalpy and pressure defines the state at a point so the temperature, density or any other required properties can be found using a standard computer code [27] or from tables or charts [28]. The process will be assumed to be steady state, steady flow [26] and the radial distance between inlet and exit planes will be small so the change in kinetic and potential energies will be negligible. Heat transfer to the walls will be considered negligible. Continuity requires the mass flow at the inlet to equal that of the exit and with the other conditions as above, the one dimensional energy equation will be:

$$\mathbf{\mathring{m}h}_{1} = \mathbf{\mathring{m}h}_{2} + \mathbf{\mathring{W}}$$
(16)

where \dot{m} is the fluid mass flow through the seal, h is the enthalpy at a particular radius and \dot{W} is the shaft power absorbed by the fluid.

$$\dot{\mathbf{W}} = -\tau \omega \tag{17}$$

with torque being defined for one side of a disk $\begin{bmatrix} 5 \end{bmatrix}$, $\begin{bmatrix} 12 \end{bmatrix}$ as:

$$\tau = \frac{C_{\rm m} \rho \omega^2 (r_2^5 - r_1^5)}{4}$$
(18)

so the change in enthalpy becomes:

$$h_2 - h_1 = \frac{C_m \rho \omega^3 (r_2^5 - r_1^5)}{4 \dot{m}}$$
 (19)

The moment coefficient C_m must be determined. For the smooth side of the seal the value of C_{ms} is found to be 0.0008 for $R_e = 10^8$ using the empirical

equations from reference 8. For this seal the flow is between regimes 3 and 4 as defined by Daily and Nece $\begin{bmatrix} 5 \end{bmatrix}$ so an average value of C_{ms} from the two applicable equations is used. The disk is thin so no contributions due to the tip are considered.

For the vaned side of the disk the moment coefficient will be greater and will be approximated by the method derived by Thew $\lceil 15 \rceil$ where

$$C_{mv} = C_{ms} + 1.2 \frac{b+a}{R} (I-K)^2 \left[\left(\frac{a+b}{0.8 a} \right) - 1 \right]^2 \left[1 - \left(\frac{R_{int}}{R} \right)^4 \right]$$
 (20)

The pressure and enthalpy distributions can now be calculated, yielding any other thermophysical properties needed at a radial point. The velocity ratio is found to be essentially constant for the smooth side, K = 0.44, but varies with radius on the vaned side so C_m also varies as shown. The mass flow of 0.13 lbm/sec and slinger angular velocity of 2932 rad/sec are obtained from engine balance data [30]. On the vaned side it is necessary to assume a value of R_{int} , determine the point at which the fluid begins vaporizing, and use this as the new assumed value of R_{int} , continuing until the assumed and determined values converge. For this seal a radius of 2.2 in. is where vaporization, therefore the interface begins.

Using the property values from reference 29 (their station 20) as being at the root of the smooth side of the slinger (r = 1.7 in.) the radial property variations are calculated and summarized in Table 1.

CONCLUSIONS AND RECOMMENDATIONS

A thorough literature survey has been completed with the most applicable work listed beginning on page XVIII-16. A set of non-dimensional partial differential equations have been established which describe the flow on the face of a slinger seal. The pressure and temperature distributions for the Space Shuttle Main Engine high pressure oxidizer turbopump primary slinger seal have been described and the location of the liquid-vapor interface determined.

The radial pressure distribution equation (14) should provide good results based on the experimental work confirming it, but the analysis of the temperature variation is approximate at best and too many simplifying assumptions are made to trust its validity. The smooth side values for C_m are sufficiently grounded with experimental work but the equation for C_{mv} has not been investigated enough to verify its generality. Due to these factors and the nature of the inital data used from reference 29, it is believed that this simplified analysis can be used only to predict tendencies.

Further work needs to be done on vaned slinger seals. Solution of the governing equations and matching of all boundary conditions should be done to get a complete picture of the flow involved and to predict more accurate pressure and temperature distributions. An experimental program should be conducted to determine actual pressure and temperature values to correlate with the analytical work. No previous experimental work could be found through the literature survey which deals with liquid oxygen, high rotational speeds as found in modern turbopumps, or the energy transfer involved with the production of a liquid-vapor interface.

Recommendations based on the literature survey that could improve the sealing performance of the Space Shuttle Main Engine high pressure oxidizer turbopump slinger are:

- include circumferential tangs on the vaned side of the seal with matching grooves in the housing to stabilize the liquid-vapor interface, thereby reducing leakage [14].
- increase the number of vanes to 24 which has been established as optimum [14].
- utilize a non-wetting coating on the housing opposite the vaned side of the seal to reduce secondary flow that enhances leakage. [20].

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Figure 1. Cutaway view of slinger seal model



Figure 2. Actual slinger configuration

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Figure 3. Slinger model with notation.

TABLE 1

SLINGER RADIAL PROPERTY DISTRIBUTIONS

Radius (in.)	Velocity Ratio	Moment Coefficient	Enthalpy Pressure (BTU/1bm) (1bf/in ²)		Temperature (^O R)	Density (1bm/ft ³)
		0000				
1.7	.44	.0008	-34.3	334	216	61.2
1.8	.44	.0008	-32.5	361	219	60.5
1.9	.44	.0008	-30.3	388	223	59
2.0	.44	.0008	-27.5	416	230	58
2.1	.44	.0008	-24.3	446	237	56
2.2	.44	.0008	-20.6	476	245	54
2.24	.44	.0008	-18.9	488	247	53

Smooth Side

Vaned Side

١

Radius (in.)	Velocity Ratio	Moment Coefficient	Enthalpy (BTU/1bm)	Pressure (1bf/in.2)	Temperature (^o R)	Density (1bm/ft ³)	Quality
2.24			-18.9	488	247	53	0.0
2.22	.88	.0040	-14.8	464	254	51	0.0
2.20	.88	.0039	-11.2	442	258	48	0.0
2.18	.88	.0037	- 8.0	421	255	42	0.1
2.16	.89	.0036	- 5.4	402	253	35	0.2
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VALIDATION OF THE SOLAR HEATING AND COOLING HIGH SPEED PERFORMANCS (HISPER) COMPUTER CODE

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VALIDATION OF THE SOLAR HEATING AND COOLING HIGH SPEED PERFORMANCE (HI S PER) COMPUTER CODE

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ABSTRACT

Computer simulations of solar energy systems are used to evaluate system performance, size system components and predict fossil fuel savings. The solar heating and cooling high speed performance (HISPER) computer code was previously developed to give a quick and accurate predictions. As a simplification of the TRNSYS program, it achieves its computational speed by not simulating detailed system operations or performing detailed load computations.

In order to validate the HISPER computer code for air systems the simulation was compared to the actual performance of an operational test site. The site selected was the Home Builders Association of Huntsville office building in Huntsville, Alabama. Solar insolation, ambient temperature, water usage rate, and water main temperatures from the data tapes for the site were used as input for the HISPER program.

The HISPER program was found to predict the heating loads and solar fraction of the loads with errors of less than ten percent. Good correlation was found on both a seasonal basis and a monthly basis. Several parameters (such as infiltration rate and the outside ambient temperature above which heating is not required) were found to require careful selection for accurate simulation.

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INTRODUCTION

Solar energy collection systems are installed on dwellings in order to reduce the occupant's dependence on conventional forms of energy for heating and cooling. Due to the diffuse nature of solar energy and the variability in the weather, it is impractical to install a system large enough to provide all of the energy needs. A back-up system, using conventional energy, must be provided for supplying energy during long periods of cloudy weather. The solar energy system is ideally sized to maximimize the benefit to cost ratio (the ratio of annual solar energy provided divided by the life cycle cost of the solar energy system). Because of the large number of design parameters and the weather variability, the design optimization problem is a difficult one.

Computer programs have been developed to help predict solar heating and cooling (SHAC) performance. One widely used program is TRNSYS which was developed at the University of Wisconsin Solar Energy Laboratory [1]*. This is a general purpose program that allows the user to simulate a system by defining the performance of and the interaction between various types of components (collectors, storage, pumps, control logic, etc.). TRNSYS gives an accurate indication of the model performance but it does require a significant amount of computer time to run. In a design situation it is more desirable to have an analysis tool which can quickly and economically give reasonable answers. This allows more design iterations to be analyzed.

In response to the need for a rapid solar simulation computer program, Northrup Services, Inc. (under contract to NASA) developed HISPER - a high speed performance program [2]. HISPER is basically a simplification of the TRNSYS program in which some detailed system operation and load calculations are not performed (such as room temperature oscillations and ductwork heat losses). When HISPER was compared to TRNSYS for identical cases, the predicted system performance differed by less than 7 percent while computer time required by TRNSYS was approximately 30 times greater than the time required by HISPER.

The usefulness of any simulation is dependent on how well it predicts the performance of the actual system. This study provides this validation of the HISPER program by comparing the predicted results using actual weather data

*numbers in brackets refer to references at the end of this paper.

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with the measured performance of the site during this same period. The Home Builders Association of Huntsville office building was selected as the site to be simulated.

This report first describes the Home Builders Association office building and its operation over a period from September, 1978 to April, 1979. Next, the basic organization of the HISPER program and the modifications necessary to run actual weather data is presented. Third, the simulation input data is discussed. The fourth part is a discussion of the results of the study including the effects of several critical design parameters. Finally the results of this study are discussed and recommendations made for the use of HISPER and for topics which need further study.

OBJECTIVES

The primary objective of this study are to verify the general computational philosophy of the HISPER program by demonstrating that the program adequately predicts the performance of actual solar energy systems. This verification will result in more confidence in HISPER for use as a design tool.

Secondary objectives include: identification of the effects of parameter values on the simulation performance, identification of any desirable changes in the HISPER logic, and the establishment of a post-design review procedure in which the actual performance of a site can be compared with the predicted design value.

OPERATIONAL TEST SITE

Site Description:

The operational test site selected for use in this study is the Home Builders Association of Huntsville office building located in Huntsville, Alabama (see Figure 1). This building has two stories with a total floor area of approximately 210 square meters (2270 square feet). The building was designed by IBM (under contract to NASA) to be a single family dwelling but is being used as an office building at this location.

The south facing roof is sloped at 45° and contains 30 solar collectors (manufactured by Solar Energy Products) for a gross area of 67 square meters (720 square feet). These collectors are single glazed and use air as the energy transport medium.



Figure 1. Office Building for the Home Builders Association of Huntsville, Alabama Figure 2 shows a schematic of the solar energy collection system. Air heated in the solar collectors first passes through an air/water heat exchanger so that the domestic water going to the hot water heater (not shown) may be preheated. Then the hot air is directed by the air handles either to the house or to the pebble bed storage, depending upon the energy needs of the house at that time. The pebble bed storage has a volume of 14 cubic meters (500 cubic feet) and contains 23 metric tons (25 tons) of river rock.

During periods when no solar energy is being collected, house air may be passed through the pebble bed thus providing energy to the house. If the temperature of the pebble bed storage is too low (below $32^{\circ}C$ or $90^{\circ}F$), a Westinghouse air-to-air heat pump provides the heat demanded by the house.

A complete description of the building and the solar energy system design and operation is given in various reports prepared by the designers - the IBM Corporation Federal Systems Division [3, 4, 5].

Operational Test Site Data:

The Home Builders Association office building was equipped with 45 sensors to obtain data for performance evaluation. These include 27 temperature sensors, 7 electric power recorders, 5 flow rate sensors, a solar insolation indicator, and 5 others. Each of these sensors is scanned at 320 second intervals (5 minutes and 20 seconds) and their average value is recorded by a data logger. All of this information is then put on to magnetic tapes.

This data is used by IBM to prepare a monthly performance summary for the site. The performance summary includes the climatic conditions, house heating and hot water loads, and solar collection information. The monthly summaries also include any known problems (such as malfunctioning equipment) which occur during the month.

The period chosen for the comparison of HISPER and the actual system was October 1978 through April, 1979. This was chosen since both the 5 minute recorder data (on magnetic tape) and the monthly reports were available. Summer months were not included since the real system is put in "Summer Mode" in which the pebble bed storage is not used. HISPER does not have the capabilities of the "Summer Mode".

A review of the information on the data tapes indicated that the data tapes could not be used directly with the HISPER program. First, periodic sensor malfunctions were discovered (such as ambient temperature going from about $29^{\circ}C$ ($84^{\circ}F$) to $-20^{\circ}C$ ($-4^{\circ}F$) for a period of about 45 minutes and then back again). Secondly, gaps in the data of up to 30 hours was observed on several occasions. These problems were overcome by correcting the obviously erroneous data and inserting reasonable values for the missing data. This data manipulation will result in a small discrepancy in the IBM Monthly Reports and the HISPER predictions. Since the total amount of bad or missing data is



Figure 2. Actual System Configuration
very small, the discrepancy is insignificant.

Site Operation:

A review of the test site data revealed several areas which could lead to significant errors. These relate to hot water usage and temperature control of the house.

Since the site is being used as an office building rather than a residence, the demand for hot water was quite low. When the hot water tank was set at $63^{\circ}C$ (145°F), before November 22, 1978, an average of only 30kg (7.8 gallons) of hot water were used daily. After the hot water temperature was lowered to 51°C (123°F) on November 22, 1978, the hot water demand rose to an average of 36kg (9.5 gallons) a day. Very little water was used on the weekends.

The temperature of the water coming out of the water main fluctuates over the period of the year. Water main temperature varies from a high in August at about $25^{\circ}C$ ($77^{\circ}F$) to a low in February at about $9^{\circ}C$ ($48^{\circ}F$). This variation probably results from the water being transported in mains that are not buried deep enough to be unaffected by seasonal temperature variations.

Another problem is illustrated in Figure 3. March 24th and 25th were cold weekend days following a rather mild week (high ambient temperatures). Apparently someone had shut off the thermostat before leaving work on Friday so that when the workers returned on Monday, the building temperature was $8^{\circ}C$ (46°F). There is other evidence that the thermostat settings had been adjusted over the period of investigation.

Figure 3 also shows that a significant variation in room temperature does occur on a daily basis. This may be due to a direct solar gain either through the windows or through the walls. The resulting heating in the occupied area will reduce the amount of solar or auxiliary energy required.

HISPER MODIFICATIONS

The HISPER simulation program consists of a main program and three fundamental subroutines: MODEL, WETHR, and SOLAR. The purpose of each of these subprograms is:

1. MAIN - The main program reads the system parameters, performs the time integration, and controls the output of the program. The main program calls subroutine MODEL.



Figure 3. Ambient and Room Temperatures in March, 1979

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- 2. MODEL This subroutine calculates all of the energy flows in the system model in a given increment of time. It calculates collector performance, the dwelling heating load, the hot water load, and the flow of energy in the solar system (including in to and out of storage). It calls WETHR and SOLAR.
- 3. WETHR This subroutine provides ambient temperature and horizontal solar insolation to MODEL. These values are read from weather tapes containing typical weather data.
- 4. SOLAR This subroutine receives the total hourly horizontal insolation output by the WETHR subroutine and converts it to total insolation incident on the collector surface using one of four user determined methods.

The basic HISPER procedure, with the exception of WETHR, was not changed significantly. Some control logic was added to MODEL and different forms of output were provided for in MAIN. Subroutine SOLAR was not altered at all. Since the climatic data was from a new source, WETHR had to be changed completely.

HISPER was designed to read weather tapes which contain typical climatic data for a particular location. In order to validate HISPER predictions for an actual operational test site, it was necessary to modify HISPER to read the actual climatic conditions at that site. Sensors at the Home Builders Association office building include an ambient temperature sensor and a pyranometer to measure total solar insolation in the collector plane.

HISPER uses both insolation on a horizontal surface (for load calculations) and insolation on the collector plane (for solar collector performance) in its simulation procedure. Normally the horizontal insolation is provided by the weather tapes and HISPER uses one of four standard techniques to estimate the tilted insolation from the horizontal value (see references [1, 6, 7]). Since the site data includes only tilted insolation data, HISPER's WETHR subroutine had to be modified to reverse the standard procedures and predict the horizontal insolation value which will produce the observed tilted value when SOLAR is called.

HISPER is designed to simulate a typical domestic dwelling so the assumed hot water load represents what a normal family might use each day. Since the system being studied is an office building, the HISPER predicted daily usage (224kg -- 59 gal) does not correspond well to the actual usage of about 33kg (8.7 gallons) per day. Therefore HISPER was modified to read (in WETHR) actual water usage and true water main temperature from the site data. The control logic used in HISPER is designed to provide the maximum amount of energy to the loads as possible. The main control features include:

- 1. Turning on the collector when ever energy can be gained.
- 2. Energy is extracted by the hot water preheat tank whenever the collector is on and the outlet temperature is greater than the preheat tank temperature.
- 3. Energy is provided to the house whenever the house has a load and the air inlet temperature, either from the collector or storage, is greater than the house temperature (returns air temperature is assumed to be room temperature).
- 4. Energy is not allowed to go to storage if the temperature from the collector is less than the temperature at the top of the storage bed.

In order to study the effects of actual control settings on the HISPER Simulation performance, the following features were added to the MODEL subroutine control logic.

- 1. A minimum temperature difference between the collector plate temperature and the bottom of the pebble bed storage bin before the collector would collect energy (note: the plate temperature was based on steady state flow conditions) Actual site required a 15°C (28°F) temperature difference [8].
- 2. A minimum temperature difference between the collector outlet temperature and the preheat tank for domestic hot water before energy could be extracted from the air and be put in the preheat tank. Actual site required 11°C (20°F) to turn on and no less than 2°C (3°F) before turning off [8].
- 3. A minimum temperature at the top of the pebble bed storage was necessary for the storage to be allowed to provide energy to the house. Actual site required a temperature from the storage of at least 32°C (90°F). [8].
- 4. An air return temperature from the house that was lower than the nominal house temperature. Review of data tapes indicates that the return air is approximately 5°C (9°F) below room temperature. This is probably due to thermal stratification in the rooms.

The control logic as modified by these four features will be referred to as the "modified control logic."

SIMULATION INPUT DATA

A variety of sources was used to develop the input data for the HISPER simulation program. The attempt was to make the model for the Home Builders of Huntsville office building as realistic as possible.

The manufacturer's data for the sunworks solar collectors was used since other tests of the collectors by Wyle Laboratories showed good correlation with the predicted performance. Manufacturers data was also used for the air to water heat exchanger used for preheating water.

Flow rates in the air ducts were taken from actual tests performed by IBM after the construction of the test site.

Internally generated heat loads were assumed to be 2890 kJ/hr. This corresponds to the average heat generation at 10 people, lights, 2 refrigerators, and three coffee pots. The storage losses (since the storage bed is in the building, is considered to be part of the internally generated heat.

The parameters used for heat load calculations are primarily based on a design analysis done at NASA/MSFC in 1977. After the Home Builders Association building was constructed, tests were conducted to determine actual heat loss coefficients. The results of the study indicate that the building load demand is commensurate with the 720 BTUH/^oF design building loss coefficient-area product (UA).

The only significant difference between the NASA/MSFC design values and the values used in the HISPER simulation was for infiltration. The NASA/MSFC value was one half air change per hour which assumes very tight construction. The tests performed on the building were conducted at night with no employees present at the office building. ASHRAE [9] recommends design infiltration rates from one half to two air changes per hour, depending on the number of windows and doors in the building. Since the building is being used as an office, with the possibility of many people entering and leaving during the day, an air infiltration rate of 1.5 air changes per hour was used.

SIMULATION RESULTS

HISPER was designed to give a reasonable prediction of solar performance of a home. This means that it should be able to predict the loads and the amount of solar energy delivered to the loads. The accuracy of the predictions was investigated with respect to several of the input parameters: infiltration rate, the outside ambient temperature above which the house is assumed to require no heat (TLH), and the effect of control logic. The domestic hot water predictions were also investigated. Effect of TLH: (Temperature above which no energy is required by the house)

A house does not always require energy whenever the outside ambient temperature is less than the house temperature. This is because any house has some direct solar gain and a large amount of thermal capacitance. The direct solar gain statisfies some of the current house demand as well as being absorbed in the house for use at night. This effect can be seen in the room temperature fluctuations in Figure 3.

The data tapes for the Home Builders Association building were searched to determine what percentage of the time the heating/cooling system was on as a function of the outside temperature. Figure 4 shows this relationship. The increase in the percentages for the higher temperatures is due to cooling, not heating. From Figure 4, it is obvious that if the house is set at $22^{\circ}C$ $(72^{\circ}F)$, it actually does not require significant heating until well below that value, at say $10^{\circ}C$.

Initial simulations were run assuming heating was not required over an ambient temperature of 10° C, i.e. TLH 10° C (50° F). The HISPER results are shown on a monthly load basis in Figure 5 and on a daily load basis in Figure 6 (a). An infiltration rate of 1.1 was assumed so that the total house load for the period was correct. This value of TLH results in HISPER under predicting the actual loads on cold days (heavy loads) and over predicting on warm days (light loads).

A value of TLH of $7^{\circ}C$ (45°F) and an infiltration rate of 1.5 air changes an hour was then used to produce the results in Figure 5 and Figure 6 (b). These values result in a very good load prediction on both a monthly and daily basis.

Effects of Control Logic:

Once the actual loads were matched through the appropriate selection of TLH, the portion of the total load provided by solar energy was investigated. Figure 7 shows that a good correlation was achieved on a monthly basis.

A closer examination of component performance revealed that the temperature at the top of the storage was higher after periods of heavy load than HISPER predicted. (See Figures 8 and 9). This was due to the actual control logic which stopped energy withdrawal at temperatures of less than $32^{\circ}C$ ($90^{\circ}F0$. The storage bed model of HISPER is programmed to supply, on demand, energy to the building anytime the temperature at the top of the storage is greater than the thermostat setting.

The temperature at the bottom of the pebble bed storage at the actual site often reached temperatures $5^{\circ}C$ ($9^{\circ}F$) below the nominal room temperature setting. This is probably due to the return air from the house being at a lower temperature than the room.

XIX - 11



Figure 4. Heating/Cooling System "on" Time



Figure 5. Predictions of Monthly Heating Load



Figure 6. Actual Versus Predicted Daily Heating Loads

XIX - 13



Figure 7. Solar Percent of House Heating Load





 $XIX \sim 15$







The four changes to the "control logic detailed in the HISPER Modification section were made with the following values:

- 1. Minimum temperature difference between collector plate and storage bottom: 7°C (13°F)
- 2. Minimum temperature difference between collector output temperature and preheat tank temperature: $5^{\circ}C(9^{\circ}F)$
- 3. Minimum temperature from storage to house: $32^{\circ}C$ (90°F)
- 4. House return temperature: $5^{\circ}C(9^{\circ}F)$ below room temperature.

The effects of this modified control logic can be seen in Figures 7, 8 and 9. The temperature difference criteria for turning on the collector and preheat tank heat exchanger did not have a great effect on the results. The minimum temperature to the house requirement reduced the solar percentages since the storage could no longer be "drained." Lowering the return temperature from the house allowed the collectors to operate more efficiently, collect more energy and thus deliver more to the house. The last two effects tend to counteract one another thus resulting in still a very good prediction of solar percentages on a monthly basis (Figure 7). Figures 8 and 9 show that these changes do result in a significant improvement in the simulation of the pebble bed storage behavior.

Hot Water Percentages:

Hot water loads were accurately predicted since almost all of the information required for the load calculation was read from the data tapes. The percentage of the domestic hot water was not predicted well by HISPER. HISPER predicted a larger solar fraction than actually existed.

The inaccurate prediction is a result of several factors. First, the water usage demand is so low in this application that energy losses are of a much greater magnitude than energy used in heating the water actually used. Therefore any error in heat loss parameters will have a large effect on the solar percentage.

The second effect is that HISPER only simulates heat lost from the preheat tank, not the standard hot water tank. Due to the low usage rate, most of the solar provided heat will be lost before it is used.

The solar percentages of the hot water load for the actual site and the HISPER predictions are shown in Table 1.

Month	Actual Site Percentage	HISPER Predicted Percentage
October, 1978	52	99
November,1978	49	90
December, 1978	64	91
January, 1979	50	68
February, 1979	43	69
March, 1979	59	100
April, 1979	64	100

Table 1. Solar Percent of Hot Water Load

CONCLUSIONS AND RECOMENDATIONS

The major conclusion is that the HISPER solar simulation program seems to be a sufficiently accurate design tool. Errors of less than 10 percent were observed when comparing predicted results to the actual results. One caution, however, is that parameters such as infiltration and TLH (the temperature above which no heating is required) must be carefully selected to achieve good monthly predictions.

Although HISPER predictions have been validated against actual performance, several areas were discovered which need further attention:

- The value of 7°C for TLH (temperature above which heating is not required) seems lower than the site data indicates it should be (Figure 4). This should be investigated for this site and others.
- 2. The validation process should be carried out for several other operational test sites.
- 3. The four control options previously discussed should be added to HISPER. This will give HISPER greater flexibility but will not significantly increase computer time required for simulation.
- 4. The water main temperature was observed to vary from 8°C to 25°C over the period of a year. This variation could significantly affect the predicted hot water load since HISPER currently assumes a constant water main temperature.

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

INCIPIENT FAILURE DETECTION (IFD) OF ANTI-FRICTION BALL BEARINGS

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INCIPIENT FAILURE DETECTION (IFD) OF BALL BEARINGS

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ABSTRACT

Because of the immense noise dissipated during the operation of a large engine such as the SSME, the unique ball bearing signals are often buried by the overall signature of the machine. As a result, the most commonly used technique, pattern recognition (1)*, to detect and predict ball bearing failures is rendered useless.

In order to retrieve the buried bearing defect signals from the background noises, a survey of two improved techniques was conducted.

Signal averaging method (2) averages n^{**} signals over a time duration equaling the known period of the ball bearing defect frequency. With this method, the desired ball bearing defect signal will be enhanced over the noise by a factor of \sqrt{n} .

A second method is to perform a further frequency analysis on the logarithmic spectrum. The purpose of this operation is to detect and separate different families of harmonics and sidebands, thereby giving information about modulating frequencies.

The above mentioned alternate IFD methods were carried out with a Norland 3001 waveform and data system. The obtained results are then compared with the power spectral density (PSD) of the overall machine signals and conclusions are made accordingly.

^{*} Number within the parentheses refers to the references at the back of the report.

^{**} Number of samples taken.

ACKNOWLEDGEMENTS

The author wishes to acknowledge contributions made to this project by his counterparts at NASA, Dr. L. A. Schutzenhofer and Mr. J. H. Jones. The author also wishes to express his appreciation to those of the Environmental Analysis Branch who provided help in preparing this report.

NOMENCLATURE

∮(t)	-	complex signal
S(t)	-	periodic signal
n(t)	-	noise
S/N	_	signal to noise ratio
t _k	-	beginning time of the kth repetitive signal
ts	-	sample time interval
Т	-	period
σ	-	rms of noise n(t)
fo	-	ball pass frequency over outer race
fi	-	ball pass frequency over inner race
fs	-	ball spin frequency
D _w	-	ball diameter
dm	-	bearing pitch diameter
α	-	contact angle
N	-	number of rolling elements
R	-	shaft rotative speed in Hz

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INTRODUCTION

Every operating machine will generate a combination of sound and vibration in the form of 'signatures' which are unique to the devices being evaluated. The ability to monitor, analyze, and use this signature to locate vibratory sources and predict future failures is the goal of an IFD system. Pattern recognition is the most commonly used technique in evaluating ball bearing conditions. It is performed by spectrum analyzing the output of an accelerometer signal over a specified frequency range that includes the ball pass frequencies. An abnormal increase in amplitude of this 'signature' over some duration of time indicates deterioration of ball bearings.

During the operation of a large machine such as the SSME, the bearing 'signature' in the form of electronic signals is often buried by the large background noise. Therefore, it is necessary to extract the bearing defect signals from the combined signal before an evaluation of the bearings can be made. This report describes a signal averaging or summation technique to extract the repetitive bearing defect signal from a complex signal with a high level background noise.

A cepstrum (3) type of signal analysis was also carried out. The advantage of cepstrum over a spectrum analysis is that it can separate families of periodic sidebands around some fundamental frequencies. The purpose of this cepstrum analysis is to cross check its results with that obtained using the signature averaging method. The possibility of using cepstrum in evaluating ball bearing conditions was also explored.

XX-6

OBJECTIVE

The objective of this project is to seek a data reduction process in order to extract pertinent information from the time record of SSME during its tests. The extracted information is, then, used to predict condition of ball bearings installed in the high pressure oxygen turbopump (HPOTP) of the SSME. Of numerous available methods, signal averaging or summation analysis (3), (7), were chosen to be examined in this report.

SIGNATURE EXTRACTION

A signal with known periodicity, T, is buried deep in noise. To extract that signal by averaging or summation, the total signal plus noise is divided into m segments of duration T. Each segment is sampled at a number of points during every period. The samples are stored in a data storing device such as a magnetic tape which algebraically adds together all m samples.

A repetitive event of period T will always be added in the same sample location. The resulting sum, thus obtained, will be m times the average amplitude of that event. Events which do not repeat with the same period will result in a sum proportional to \sqrt{m} , therefore, the desired signal has been enhanced over the noise by a factor of \sqrt{m} .

The above described signal averaging process can be described as follows. Signal \neq (t) is

$$f(t) = S(t) + n(t) ----$$
(1)

the signal at kth repetition starts at time instant t_k , if taking $t_1 = 0$, is

$$f(t_{k} + it_{s}) = S(t_{k} + it_{s}) + n(t_{k} + it_{s})$$
$$= S(it_{s}) + n(t_{k} + it_{s}) ----$$
(2)

Since noise, n(t), is random and the m segments of samples are independent, summation of the m noises will yield a mean square value of $m\sigma^2$ and a rms value of $\sqrt{m\sigma}$. Hence, after adding the m segments of the signal, equation (2), which indicates values at the ith location of the signal f(t) within the period T becomes

$$\sum_{k=1}^{m} f(t_k + it_s) = mS(it_s) + \sum_{k=1}^{m} n(t_k + it_s)$$
$$= mS(it_s) + \sqrt{m\sigma}$$

Therefore, the signal to noise ratio, after m summations, is

$$\binom{S}{N}_{m} = \frac{mS}{\sqrt{m\sigma}} = \int m \binom{S}{N}_{m}$$

A Norland 3001 waveform analyzer was used to carry out the signal extraction procedures described above. There are two ways to accomplish signal extraction. One is to stack segments of signal of given period T by shifting the signal segment of duration T, without any gap, m times successively. Another way is to convolute the signal, f(t), with a train of m units impulses at a time delay of the given period T. The latter procedure is described by the following operation.

$$a(t) = \int_{\infty}^{\infty} f(t - \varepsilon) \sum_{k=1}^{m} (\varepsilon - kT) d\varepsilon$$

 $= \sum_{k=1}^{m} f(t - kT)$

CASE HISTORY AND DATA COLLECTION

Failures of bearings within the HPOTP were experienced during tests of the SSME. Spallings, damage cuts, pittings, and discoloration appear on both inner and outer races, rolling elements, and cages. The most serious failure seems to occur at bearings closest to the turbine of HPOTP. It was suspected from evidences of damages, that these failures were caused by excessive loading in the axial direction of the turbopump during the starting stage of the test. In order to be able to predict the oncoming bearing as well as other types of failures, data were collected from several strategically located accelerometers. These signals were usually low pass filtered at 10 KHz or under before storing on magnetic tapes for later analysis. Because of the low pass filtering of data, possibility of adopting various IFD techniques in the higher frequency range (30 KHz and higher) as diagnostic instruments is precluded.

The collected data in the form of time record is time averaged or summed and then transformed to the ferquency domain as power spectral density (PSD) diagrams. This allows one to relate specific periodic occurrence of the bearing to specific frequencies in the data.

In order to analyze the obtained results, ball pass frequencies over a defect were computed according to the following equations.

$$\mathcal{L}_{o} = \frac{N}{2}R(1 + \frac{D_{W}}{d_{m}}\cos\alpha)$$

$$\mathcal{L}_{i} = \frac{N}{2}R(1 - \frac{D_{W}}{d_{m}}\cos\alpha)$$

$$\mathcal{L}_{s} = R\frac{d_{m}}{D_{W}}(1 - \left(\frac{D_{W}}{d_{m}}\right)^{2}\cos^{2}\alpha)$$

For the given bearing configuration, various ball pass frequencies and other relevant data (at 100% SSME power) are listed as follows:

 $f_0 = 2570 \text{ Hz}, f_1 = 3530 \text{ Hz}, f_s = 2920 \text{ Hz}$ N = 13, R = 469 Hz

Static capacity of the bearing 🛎 3050 lbs.

DATA ANALYSIS

Results obtained from the test carried out in the Spring of 1980 are presented in figure 1 through figure 11. Figure 1 is a collection of three PSD's for the initial, middle, and final stage of the bearing life span. Narrow band spikes at shaft rotative speed and turbine blade frequencies appear in the diagram at 469 Hz, 1836 Hz and 3672 Hz, as expected. Note the growth of the narrow band spike at 2570 Hz region which indicates a possible fault on the outer race. Defects on the inner race and rolling elements are not obvious in this particular figure.

Figure 5 through figure 10 are the so-called zoom PSD's at the same time instants as those in figures 1 through figure 4. It is more desirable thatn the normal PSD's because it provides a considerably finer resolution over the portion of the spectrum that we are interested in. Again, possible defects on the outer race appear on these spectra in the neighborhood of 2600 Hz region. Finally, a useful technique in detecting the deterioration of bearings with respect to time is presented in the form of a three dimensional PSD with time as the third parameter.

CONCLUSIONS AND RECOMMENDATIONS

A signal averaging or summation process has been described that is used to extract the bearing defect signals form the time record of SSME. It appears that this procedure can also be applied to the zoom and three-dimensional PSD for finer resolution and better presnetation of the deterioration history of ball bearings. An electronic equipment of black box type based on this principle could be constructed and adopted as part of an "on-line" IFD system. One drawback in applying this technique is that the period, T, of a repetitive signal cannot be absolutely time-locked in an analog to digital converter because of the limitation of the sampling time interval. The result of this deficiency is the tendency of the summed time signal being smeared gradually. Signal to noise gain will be decreased accordingly.

Even though other techniques such as "acoustic emission" (10) and "shock pulse" have been proposed, they have not been proven successful. One alternative method in ball bearing defects detection is to utilize the bearing high frequencies (13), (14), especially for large machines. Natural frequencies of ball bearings are usually far beyond that of the noise level, therefore, less noise interference to the bearing signal. In order to adopt this method of approach, real time signal should be collected without any low pass filtering.

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NARROW BAND FREQUENCY ANALYSIS - INITIAL, MIDDLE, AND FINAL STAGES

1

Figure

XX-14

PSD (INITIAL STAGE)



189 HPDT RAD 135 ACC S+ 110

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PSD (MIDDLE STAGE)

XX-16

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(FINAL STAGE)

PSD



+ ഗ ACC 117 HPOT RHD



ZOOM (INITIAL STAGE)

XX-18





XX-19





XX-20







XX--22








L. St.

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THREE DIMENSIONAL PSD

XX-214

1980

NASA/ASEE FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

PULSED EDDY CURRENT TESTING

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Materials and Processes Engineering Physics Nondestructive Testing

Department of Scientific Technologies

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August 1, 1980

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PULSED EDDY CURRENT TESTING

ΒY

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ABSTRACT

The traditional nondestructive testing technique used for inspecting welds in large space structures, such as the "External Tank", has been radiographic testing, in conjunction with surface inspection methods, such as dye penetrant testing. In order to improve upon the economics and reliability of these critical inspections, new approaches to the test methods are under consideration. One approach is to replace the very expensive radiographic inspection with an automated eddy current testing technique. A description of pulsed eddy current and its relationship to multifrequency techniques if presented here, as well as a some preliminary results obtained from observing pulsed waveforms with apparatus and algorithms currently in use for ultrasonic testing of welds. It can be shown the pulsed eddy current techniques can provide similar results.

Eddy current testing has primarily been used for sorting of materials due to differences in conductivities, detecting differences in surface due to corrosion on cracks, and in some instances to detect flaws below the surface. Manual operation of the test proves to be very unreliable due to such test parameters as lift off, non-uniform conductivity, depth of penetration, surface treatment, and complex geometries of the test object. The use of a pulsed eddy current techniques can eliminate some of the noncritical parameters affecting the eddy current signals and facilitate in the detection of critical parameter such as flaws, subsurface voids, and corrosion.

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Introduction

The nondestructive inspection of large space structures requires that a large part of the inspection procedure be automated in order to reduce human errors and to reduce the amount of time and money spent in this critical phase of production. Since a large number of the procedures used for inspecting the External Tank are concerned with determining flaws in welds, there is a need to develop an inspection technique, which can be automated, to determine flaws in welds and structures with complex geometries. The techniques; whereby one generates eddy current in a metallic material and observes the changes in the circuit parameters due to material differences, has been chosen as one possible approach. The principles of eddy current testing has been treated in a number of publications (1-3). Of particular interest to the researcher is the book by Libby¹ and the work of Dodd³.

Eddy currents are generated in metallic specimens by alternating currents in coils in close proximity to the material. Some of the properties associated with eddy currents are:

1

- They constitute a closed circuit; hence, in the material, they usually have a circular configuration
- 2. They penetrate into the material with decreasing

amplitude away from the surface.

- Variations in part distances introduces electrical phase differences.
- The magnitude of eddy current flow is proportional to the current in the test coil.
- Both the electrical conductivity and the magnetic permeasbility affect the eddy current flow in the material.
- Discontinuities which affect the eddy current flow are easily detected as the eddy current redistribute themselves around the discontinuity.

These general properties have enabled eddy current techniques to be useful for a number of applications. Some of the most notable are:

- 1. Measurements of electrical conductivity
- 2. Measurements of magnetic permeability
- 3. Sorting of metallic materials
- 4. Measurements of distances between components
- 5. Thickness determinations
- Detections of voids on discontinuities in metallic materials

A number of commerical eddy current instruments are available for these applications. The reliability and sensitivity of each test depends upon many parameters, for instance:

- 1. Coil-to-conductor spacing and geometry
- 2. Choice of frequency for a particular conductor
- 3. Orientation of defects to coil
- 4. Sample geometry
- 5. Coil characteristics

Such a large number of parameters affecting an eddy current measurement accounts for the range and flexibility of the technique, as well as its pitfalls. For instance, in the determination of flaws in welds, one has to keep all other parameters constant so that only the interaction of the eddy currents with a flaw would be observed as a signal. Even with a judicious laboratory arrangement, this is very difficult to accomplish. When testing complex geometries, in a production environment, it is practically impossible to maintain that many parameters constant. Also, most materials exhibit minute changes in composition which can affect the eddy current measurements and this can be misinterpreted as a flaw. Since it can be so difficult to make a single eddy current measurement and interpret the results correctly, many researchers in the field are developing methods which take a number of measurements and solve simultaneously for different parameters which can change. The use of computers in both hardware control and data acquisition and analysis allows these approaches to become easily automated.

Objectives

The primary objectives of this work is to determine the feasibility of using pulsed eddy current methods for nondestructive testing. As described in the report there are many ways of handling the data received from the eddy current test. Our approach has been to pulse an eddy current probe, use present FFT data processing and determine if the information contained in the frequency domain does allow one to solve for the properties of the material under inspection.

Multiparameter Methods

The electrical quanities of interest in an eddy current measurement are usually a voltage or current and its phase relationship to the driving voltage or current. Eddy current circuits are most easily represented as simple RLC circuits and their signal responses represented as impedance of the material being inspected. Hence impedance plane plots are most often used to illustrate and differentiate between the different parameters affecting the eddy current measurement. For example, if we consider a simple coil and driver arrangement such as



then if $V_0 = V_0 \cos w t$ (i.e. a sinusoidal waveform) then

$$V = V_0 \left(\frac{Z}{R+Z}\right) = V_0 \left|\frac{Z}{R+Z}\right|$$
$$= V_0 \sqrt{\frac{(R_2 + 2\pi f L_1)^2}{(R_1 + R_2 + 2\pi f L_1)^2}}$$

Notice that the measurement of a single voltage can determine only a single parameter or the combined effect of several parameters. In order to differentiate between the parameters in an eddy current measurement, one has to synthesize an excitation signal which then can be decomposed into frequencies affected by the desired parameters. One approach is to use multifrequency excitation from which we can extract a voltage and a phase value for each frequency. For example, if we use two frequencies, then we have four measurements for each test and

where A_1 , A_2 , A_3 , A_4 , represent the material properties as coefficients in response to the eddy current source and each Pij represents the magnitude of that effect in each measurement. V_1 through V_4 represents either a voltage or phase measurement. This procedure has been developed and successfully demonstrated by Dr. Dodd and his Union Carbide Corp. in Oak Ridge(4,5). Although the parameters A_1 through A_4 appear to be linearly independent, experimentally it can often be difficult to determine unique solutions and thus to identify such effects as lift-off, voids, or corrosion. However, their approach was to synthesize known types of defects, liftoff's, etc into the laboratory calibration. Then, during an inspection procedure, their system uses a pattern recognition approach to go back and fit the experimental data

to the calibration data in order to determine what responses are contained in each measurement. To date, this approach has worked very well in the inspection of tubing used in nuclear reactor heat exchangers.

The frequencies chosen for this approach use a high frequency signal for surface effects and a lower frequency (say 1/10) for multilayer identification, and even another lower frequency (say 1/100) for detection of voids farther away from the surface.

Pulsed Eddy Current Techniques

The multifrequency technique provides a workable solution to the eddy current testing problem. The major drawback to the method is that it is expensive. A multifrequency head using several coils will prove to be extremely costly. In addition to the data acquisition circuit, precise frequency filters are required to maintain a reliable signal-to-noise ratio for each phase and amplitude measurement. A promising technique, which should prove to be less expensive, is to use a pulsed excitation rather than the continuous alternating current as in the previous work. In reality pulsed eddy current and multifrequency eddy current provide similar information. For instance, a short duration pulse can be transformed into the frequency domain and the resulting wave form consists of a large number of frequencies. Hence, we can also produce multifrequency excitation using a pulse with a finite time period.

Pulsed eddy current data can be obtained in two different ways, although the two approaches are essentially equivalent. The pulsed eddy current experiment can be performed in a manner similar to the multifrequency experiment discussed above, the only deviation is using a finite pulse instead of several continuous wave frequencies. The interaction of the coil with the eddy currents is still dependent on the inherent frequency of interaction. Hence, one would still measure amplitudes and phases of the resulting signals and perform the data reduction in exactly the same way as before. The two methods are equivalent in that same sense.

The other approach one might take in using pulsed eddy currents is to actually transform the time domain data into the frequency domain and use the multifrequency analytical approach with these transformed values. Our approach this summer has been to obtain data in this mode in order to determine the feasibility of the approach. A number of algorithms currently in use for ultrasonic imaging applications one applicable, as well as a hardwired Fast Fourier Transform Analyzer (6). Hence we felt that this approach might proceed the quickest for a summer's work.

Experimental Results

All of the measurements taken in this work were obtained with a Microtek model 101 ultrasonic pulsing system driving a Kervonics reflection eddy current coil. The pick-up coil signals were digitized by a 8-bit A/D and stored in a Biomation Transient Analyzer. Model #8100. The data was then transferred to a PDP11/45 computer and analyzed via software generated by contractor personnel. An example of the data obtained here is shown in Figure 1-4. The pick-up signal itself is shown in Figure 1 and its FFT is shown in Figure 2. These observations were obtained statically with a Kervonics 40A probe (pick-up coil radius=0.7 cm) on aluminum.

Lift-off simulation is shown in Figure 3 and the resulting waveform when over a 20 mil surface defect in shown in Figure 4.

Note the changes which occur for the frequency domain data, particularly at 0.5, at 1.3, and at 3 MHZ. In all three cases the pick-up signal changes somewhat but not as quantitative as given in the frequency data. Obviously then the analysis of a three frequency probe at 0.5, 1.3, and 3 MHZ should provide the same type of information, but would require three frequencies with separate pick-up coils. Since the scanning mechanism, which was expected to be used in this work, never did arrive; all the measurements were made using a specially inprovised mount for the probe. Since no motion occurred during the measurement, all tests were static.

Conclusions and Recommendations

The pulsed eddy current technique can differentiate between various materials properties using FFT analysis. Since we were not able to obtain data while scanning over a specimin, that should be the next objective in this project. Also, in view of the information published by Dr. Dodd and his associates, the following recommendations can be made.

- Improve the resolution of the A/D converter presently being used by replacing it with at least a 12-bit A/D converter.
- Use waveform synthesis techniques to generate

 a pulse which contains those frequencies of
 interest for a particular inspection. A micro processor generated pulse can do this.
- Implement the pattern recognition algorithms at Marshall Space Flight Center. Upon request most of his software is available.

If pulsed eddy current is to be developed at MSFC, a full time effort should be provided. The nondestructive testing requirements for large spacecraft will be more easily implemented using either a pulsed or multi-frequency method.

XXT-10





XXI-12



Figure 3: FFT Signal for Lift-Off

XXI-13

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.91 USEC. BBBB DELAY

MAGNITUDE FFT



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MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALBAMA

STABILITY OF THE STRATIFIED CYLINDRICAL ANNULUS FLOW

Prepared By:

Academic Rank:

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by

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ABSTRACT

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INTRODUCTION

It is generally believed that the existence of flucuations in the circulation of the atmosphere can be attributed to the instability of the stationary dynamical state without fluctuations. Partial confirmation of this belief has recently come from detailed analysis of the numerical general circulation models. However, no exact laboratory experiments have been conducted of the atmospheric circulation in order to test this hypothesis. The absence of such a laboratory model is basically due to the difficulty arising from the large earth gravity field which is ever present in any terrestrial experiment. Recently hopes for the possibility of setting up an experiment model of the earth's global circulation has been rekindled again through the availability of the gravity free environment of the forthcoming missions of Spacelab. Indeed an experiment to model and study atmospheric fluctuations arising from stability considerations in a true spherical geometry is being considered by NASA for a future Spacelab Mission [1].

The existence of fluctuations in the flow inside a rotating cylindrical annulus in which the inner cylinder is cooled while the outer cylinder is heated have been observed experimentally by Fultz et al. [2] and Fowlis and Hide [3]. These fluctuations were found to resemble in a remarkable way those that are observed in the atmosphere although the geometries are different. Due to this striking resemblence between the waves in the annulus experiments and the waves in the atmosphere, the flow field in the rotating cylindrical annulus has been studied extensively (see Hide and Mason [4] for an up to date discussion on the annulus problem).

One of the major findings common to both the analytical and experimental studies of the annulus problem is that waves of different azimuthal wave lengths appear only for specific value of the governing parameters of the problem. This fact is usually shown by plotting a curve in the Taylor-Froude number plane which separates the wave regime from the no-wave (symmetric) regime. Such a curve has been obtained experimentally by Fowlis and Hide [3]. However, in the theoretical treatment of the exact annulus problem only few points on that curve have been obtained, originally by Williams [5] and subsequently by Quon [6]. These theoretical confirmations

have been obtained through the complete, three-dimensional, numerical solution of the governing equations for the annulus geometry. These numerical solutions of the exact problem consume excessive amounts of computer time to perform. For this reason the regime diagram which was obtained experimentally have not been reproduced in full through numerical solutions, since the amounts of computer time needed to perform these calculations are beyond the scope of present day computers.

In this report we will outline a different numerical method for obtaining the regime diagrams for the annulus Since the existence of the observed fluctuations problem. in the annulus is due to instability of the basic dynamical state, it then seems reasonable that a stability analysis of the basic state, symmetric annulus flow should predict under what conditions the fluctuations will appear. Now, it is well known that stability analysis requires far less calculations than the total solution of the governing system of equations. Hence, such an analysis may be efficiently used to generate the desired regime diagrams. In this report two methods of stability analysis will be presented and the advantages and disadvantages of each method will be discussed in detail. Furthermore, a recommendation will be given on the best numerical implementation of the techniques in question.

STABILITY ANALYSIS

As indicated in the introduction there are basically two analytical approaches that may be used to verify the experimental regime diagrams. The first approach is to integrate the initial-boundary value problem starting from a state of no motion and following the solution in time. This approach requires the soltuion of the full governing equation in three-dimensions and for long enough time to discern whether fluctuations will appear or not. However, the computation time that may be necessary to implement this approach could be prohibitive. Quon [6] has indicated that as much as 150 hours of computer time on the Univac 1108 is necessary to establish only one point in the regime diagram using this approach.

The alternative approach which is subsequently outlined is to use linear stability analysis to establish the regime diagrams. This approach may be implemented in one of two ways both of which will be discussed at length.

The linear stability analysis starts by first formulating the governing equation for the annulus flow in cylindrical geometry. These equations are the Navier-Stokes equations, the energy equation and the mass conservation equation. The Navier-Stokes equations in cylindrical geometry in a rotating reference frame, are the following:

$$\begin{aligned} u_{t} + uu_{r} + & \underbrace{\psi}_{u_{q}} + wu_{t} - \underbrace{\psi}_{r}^{2} - z \mathcal{N} \psi = -\frac{1}{2} P_{r} \\ & + \sqrt{\left(\nabla^{2} u_{r} - \frac{2}{r} \cdot \psi_{q} - \frac{u}{r} \right)} \end{aligned} \tag{1}$$

$$w_{1} + uw_{2} + \frac{\omega}{r}w_{q} + ww_{2} = -\frac{1}{5}p_{2} + \sqrt{\nu}w + \alpha gT \qquad (3)$$

where

$$\nabla^2 f = f_{rr} + \frac{1}{rc} f_{qq} + f_{zz} + \frac{1}{r} f_r$$

and

$$fa = \partial f/\partial a$$

In Eq. (3) the Boussinesq approximation has been used. In the above equations u, v and w are the radial (r), aximuthal (ϕ) and axial (z) velocity components, respectively. p and ρ are the pressure and density; v is the kinematic viscosity; α is the volumetric expansion coefficient and T is the temperature. Ω is the angular velocity of both cylinders. In conjunction with above system the energy and mass conservation equations are needed which are given by

$$\overline{T_{t}} + U\overline{T_{t}} + \stackrel{\omega}{=} \overline{T_{q}} + \omega \overline{T_{t}} = K \overline{D^{2}T}$$

$$\tag{4}$$

$$u_{r} + \frac{1}{r} v_{\bar{q}} + w_{\bar{z}} + \frac{u}{r} = 0 \tag{5}$$

where κ is the thermal diffusivity of the fluid.

Next, all the field variables are separated into a stationary mean part and a perturbation part in the following way:

$$U = u_0 + u'$$

$$V = V_0 + V'$$

$$w = w_0 + w'$$

$$P = P_0 + P'$$

$$T = T_0 + T'$$

When the above variables are substituted into the governning system of equations (1)-(5) and using the fact that the mean variables (f_o) themselves satisfy equations (1)-(5)a system of equations governing the perturbation functions results. However, this latter system of equations is as complicated as the original system with the added complexity of having the basic state functions appearing as coefficients in the equations. This means that in order to solve for the perturbation functions one needs to solve for the basic state first.

If it is further assumed that the perturbation functions are very small, i.e.infinitesimal then it is possible to linearize the system of equation for the perturbations. These equations will be of the following form after dropping the primes:

$$u_{i} + u_{0}u_{r} + \frac{U_{0}}{r}u_{q} + w_{0}u_{z} + uu_{0r} + wu_{0z} - 2\frac{U_{0}}{r}u - 2NU = -\frac{1}{r}u_{r} + v(v_{1}u - \frac{2}{r}u_{q} - \frac{u_{1}}{r})$$
(6)

$$w_{t} + u_{0}w_{r} + \frac{v_{0}}{r}w_{p} + w_{0}w_{t} + uw_{0r} + ww_{0t} = -\frac{1}{8}P_{t} + vv_{w} + agT \qquad (8)$$

$$T_{t} + u_{o}T_{r} + \frac{U_{3}}{r}T_{q} + w_{o}T_{t} + uT_{or} + wT_{oz} = K \mathcal{V}^{2}T \qquad (9)$$

$$u_{\mu} + \frac{\mu}{r} + \frac{1}{r} \frac{\nu_{q}}{r} + \frac{\omega_{1}}{r} = 0$$
 (10)

In the above equations the stationary basic state variables are functions of r and z alone are assumed to be known everywhere.

EIGENVALUE PROBLEM

We continue with the stability analysis by looking for solutions to Eqs. (6)-(10) for the perturbation functions with the known stationary basic state for some known initial small values for the perturbations. The solution will proceed by first formulating the eigenvalue problem. Eqs. (6)-(10) can be simplified by noting that they are linear and the coefficients are independent of the azimuthal direction ϕ . Under these conditions the perturbation functions admit the following form of solution:

$$[u, \sigma, \omega, \tau, \rho] = [\hat{u}(r, t), \hat{\upsilon}(r, t), \hat{\omega}(r, t), \theta(r, t), \pi(r, t)] \times$$

$$exp[ik(q-ct)]$$

$$(11)$$

The solution form (11) represents a wave of wavelength $2\pi/k$ which is propagating in the azimuthal direction ϕ with a speed c. Upon substituting the functional form (11) into the perturbation equations (6)-(10), the following equations result

$$-ikc\dot{u} + u_{0}\dot{u}_{r} + \frac{v_{0}}{2}; k\dot{u} + w_{0}\dot{u}_{1} + \dot{u}u_{0r} + \dot{w}u_{0} - \frac{zv_{0}\dot{w}}{2} - \frac{zv_{0}\dot{w}}{2} - \frac{zv_{0}\dot{w}}{2} - \frac{zv_{0}\dot{w}}{2} - \frac{zv_{0}\dot{w}}{2} - \frac{zv_{0}\dot{w}}{2} - \frac{v_{0}\dot{w}}{2} - \frac{v_{$$

$$= -\frac{i}{2}kc\hat{\sigma} + u_{\sigma}\hat{\sigma}_{r} + \frac{i}{2}kc\hat{\sigma}_{r} + w_{\sigma}\hat{\sigma}_{r} + \frac{i}{2}\hat{\sigma}_{r} + \frac{i}{2}(u_{\sigma}\hat{\sigma} + \hat{u}\hat{\sigma}_{r}) + 2S\hat{u}$$
(13)
$$= -\frac{i}{2}k\hat{\rho} + i(\nabla^{2}\hat{\sigma} + \frac{i}{2}k\hat{u}\hat{u} - \frac{\hat{\sigma}_{r}}{r^{2}})$$

$$-ikc\hat{w} + u_{0}\hat{w}_{1} + ikv_{0}\hat{w}_{2} + w_{0}\hat{w}_{2} + \hat{u}w_{0} + \hat{w}w_{0} = -\frac{1}{5}\hat{p}_{2} \qquad (14)$$

$$+\sqrt{p}\hat{w} + \alpha q \Theta$$

$$-ikc\theta + u_{\theta}\theta_{r} + ikto \theta + w_{\theta}\theta_{z} + \hat{u}T_{\theta_{r}} + \hat{w}T_{\theta_{z}} = K D^{*}\theta \qquad (15)$$

$$\hat{u}_{r} + \hat{\underline{u}}_{r} + \hat{\underline{v}}_{t} + \hat{w}_{t} = 0$$
(16)

In the present work the perturbation functions will be zero at the boundaries.

Now Eqs. (12)-(16) may be written in the following operator form:

$$\mathcal{A}_{\cdot} \begin{bmatrix} \hat{u} \\ \hat{v} \\ \hat{\mu} \\ \hat{\rho} \end{bmatrix} = \mathcal{L}_{\cdot} \begin{bmatrix} \hat{u} \\ \hat{v} \\ \hat{w} \\ \hat{\rho} \\ \hat{\rho} \end{bmatrix}$$
(17)

where k, and k are linear partial differential operators which involve the basic state u, v, w, T and kSince Eq. (17) is homogeneous with Romogeneous boundary condition then it forms an eigenvalue problem for the eigenvalue c.

Normally the system (17) is solved through the method of separation of variables which will reduce the eigenvalue problem to an ordinary differential eigenvalue problem. Such a problem may be solved either by the shooting method or the matrix method (see Antar [7] for a discussion on the application of these techniques). However, in the present case we can not use the method of separation of variables since the coefficients in the operators are not separable. Thus, the partial differential eigenvalue problem (17) has to be solved as it stands.

A logical way to handle the system (17) is to use the finite difference method especially since the coefficients are given as a set of numbers at specific points in the domain. This is due to the fact that the basic state solution is obtained through a finite difference method. Without going too much into the details of the finite differencing procedure, if the derivatives in the operators of and for are approximated by finite differences, the equation (17) will be transformed to the following alegebraic problem

$$[A]\{\bar{x}\} + c[B]\{\bar{x}\} = 0 \qquad (18)$$

where [A] and [B] are banded matrices and is a vector representing the value of the field variables at the discrete points in the solution domain. Taking the inverse of [B] in (18), the equation may be rewritten as

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$$\{ [b] - c [I] \} \{ x \} = 0$$
 (19)

where $[\mathbf{\delta}] = [\mathbf{B}]^{-1}$ [A]. Clearly (19) then is an algebraic eigenvalue problem which may be solved through matrix manipulations.

Although in principal the technique is straight forward, in reality the transformation of Eq. (17) into Eq. (18) is quite involved and will not be discussed here. The major difficulty in formulating Eq. (19) is that the vector \bar{x} is very large. In fact if one chooses to discretize Eq. (17) through 10 points in each of the z and r directions the vector x will have 400 elements. However, we know from experience that 10 points for the discretization is not enough and a reasonable choice will be 50 points. For this latter value the vector x will possess 10⁴ elements. This size of the vector will make the solution of the eigenvalue problem very lengthy. Another approach which might be more suitable for the present problem is discussed next.

INITIAL VALUE PROBLEM

The second alternative for obtaining a solution to the perturbation equations (6)-(10) is to assume a solution which possesses a sinusoidal form in the azimuthal direction, ϕ , i.e.

$$f(r, z, q, t) = \hat{f}(r, z, t; k) \sin kq$$
 (20)

This form of the solution is admissible due to the linearity of the equations and also the independence of the coefficient function of the azimuthal direction ϕ . Upon substituting the functional form (20) into eqs. (6)-(10), the following linear system of equations results:

$$\hat{u}_{1} + u_{0}\hat{u}_{r} + i k \underbrace{\sigma}_{p} \hat{u}_{1} + w_{0} \hat{u}_{2} + \hat{u} u_{0r} + \hat{w} u_{02} - \underbrace{z}_{r} \hat{v}_{0} \hat{v}_{1} - z \mathcal{R} \hat{v}_{1}$$

$$= -\frac{1}{2} \hat{P}_{r} + v \left(\overline{v}^{2} \hat{u}_{1} - \frac{z}{k} \underbrace{v}_{r} - \underbrace{u}_{r} \right)$$

$$(21)$$

$$\hat{v}_{1}^{2} + u_{0}\hat{v}_{1} + \dot{v}_{0}\hat{v}_{2} + \dot{w}\hat{v}_{0} + \dot{w}\hat{v}_{0} + \frac{1}{4}(u_{0}\hat{v} + \dot{u}v_{0}) + 2\Omega\hat{u}$$

$$= -\frac{ik}{r}\hat{b} + v\left(\nabla\hat{v} + \frac{i}{2}\hat{u}\hat{u} - \frac{\partial}{2}\right)^{(22)}$$

$$\hat{w}_{t} + u_{0}\hat{w}_{1} + \hat{w}_{0}\hat{w}_{2} + \hat{w}_{0}\hat{w}_{1} + \hat{w}_{0}\hat{w}_{3} = -\frac{1}{2}\hat{b}_{1} + \frac{1}{2}\hat{w}_{1}\hat{w}_{3}\hat{v}_{3} = -\frac{1}{2}\hat{b}_{1} + \frac{1}{2}\hat{w}_{1}\hat{v}_{3}\hat{v}_{3}\hat{v}_{3} = -\frac{1}{2}\hat{b}_{1}\hat{v}_{3}\hat{v}_{$$

$$O_{t} + u_{0} O_{r} + i k \sigma_{0} O_{t} + w_{0} O_{2} + \hat{u} T_{o_{r}} + \hat{w} T_{o_{2}} = \kappa \sigma^{2} O \qquad (24)$$

The set (21)-(24) constitute a linear partial differential set depicting an initial value problem. Thus a solution to the system may be obtained once the proper initial conditions are given. The initial conditions in this case are given again as a wave function with a specified wavenumber k and a specified amplitude function.

The stability or instability of the perturbations is resolved by examining the behavior of the amplitude functions with time. If for a given wavenumber k, the amplitudes appear to grow with time, then the perturbations are said to be unstable. If, on the other hand, the perturbation amplitudes seem to decay with time then the pertubations are said to be stable. As for the eigenvalue problem, however, the sign of the imaginary part of c determines stability or instability. In this case if the sign of c_i is negative, then the perturbations are said to be stable, otherwise it is unstable.

Now, due to the complexity of the coefficients of the system (21)-(24), no closed form solution is possible. Thus one has to resort to numerical solutions. In this case it seems logical to use finite difference techniques for both the time and the two spatial directions. Conceptually, a numerical solution for this system should be obtained without difficulty due to the linearity of the system.

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ON ROSEN'S THEORY OF GRAVITY AND COSMOLOGY

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August 1, 1980

NGT-01-002-099 (University of Alabama)

ON ROSEN'S THEORY OF GRAVITY AND COSMOLOGY By

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ABSTRACT

Formal similarities between general relativity and Rosen's bimetric theory of gravity have been used to analyze various bimetric cosmologies. The following results have been found:

- (1) Physically plausible model universes which have a flat static background metric, a Robertson-Walker fundamental metric and which allow co-moving coordinates do not exist in bimetric cosmology.
- (2) It is difficult to use the Robertson-Walker metric for both the background metric and $g_{\mu\nu}$ and require that $g_{\mu\nu}$ and $\gamma_{\mu\nu}$ have different time dependences because there are not enough bimetric field equations to simultaneously fix the time dependences.
- (3) A consistency relation for using co-moving coordinates in bimetric cosmology was derived.
- (4) Certain spatially flat bimetric cosmologies of Babala (1975) were tested for the presence of particle horizons.
- (5) An analytic solution for Rosen's (1978) $k = +1 \mod 1$ was found.
- (6) Rosen's singularity free k = +1 model arises from what appears to be an arbitary choice for the time dependent part of $\gamma_{\mu\nu}$.

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I. INTRODUCTION

In 1973 and 1974 Nathan Rosen proposed a bimetric theory of gravitation. The origin of its name arises from Rosen's assumption that two tensor fields $(g_{\mu\nu} \text{ and } \gamma_{\mu\nu})$ exist at each point (x^1, x^2, x^3, x^4) of spacetime. Rosen (1973,1974,1978) has given the following interpretations for $g_{\mu\nu}$ and $\gamma_{\mu\nu}$:

As in general relativity, $g_{\mu\nu}$ is the fundamental metric tensor of Riemannian geometry. The motion of material bodies and photons is determined by $g_{\mu\nu}$. Moreover, those aspects of spacetime which can be observed by using clocks and measuring rods are contained in $g_{\mu\nu}$.

On the other hand, $\gamma_{\mu\nu}$ may be thought of as representing the spacetime metric that one would obtain if all the mass-energy in the universe was removed. $\gamma_{\mu\nu}$ is called the "background" metric. According to Rosen (1978), " $\gamma_{\mu\nu}$ describes a geometry of spacetime not directly observable at present."

Bimetric gravitation has a number of interesting features:

- 1. It is a metric theory which, if suitable boundary conditions are chosen, agrees exactly with general relativity in the post-Newtonian limit (Lee, et. al. 1976).
- 2. It does not appear to predict the existence of black holes (Rosen 1973, 1974).
- 3. Considerably larger (5-6X) masses for neutron stars are allowed by bimetric gravitation than by general relativity (Rosen and Rosen 1975).
- 4. If the background metric is assumed to be Minkowskian $(\gamma_{\mu\nu} = \gamma_{\mu\nu})$, then it is possible to express gravitational energy and momentum density via a conserved tensor and the field equations and resulting calculations are simpler than in general relativity (Rosen 1973, 1974).
- 5. Homogeneous bimetric cosmological models which have acceptable values for the Hubble parameter H_o and the deceleration parameter q_o have been found and studied by Babala (k=0, 1975), Goldman and Rosen (k=-1, 1977), and Rosen (k=+1, 1978).
- 6. At the present time the only observation known to pose difficulties for Rosen's theory is the period change |P/P|= 1.2 x 10⁻⁷ yr⁻¹ determined by Taylor et.al. (1976) for the binary pulsar PSR 1913 + 16. Will and Eardley (1977) analyzed binary star motion using

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bimetric theory and, assuming that gravitational radiation from a source is described by a retarded potential solution of the wave equation, have shown that bimetric gravitation allows dipole radiation. (However, also see Rosen 1978b for a different view.) Will and Eardley concluded that Rosen's theory is consistent with observations only if PSR 1913 + 16 contains either (a) two very heavy neutron stars of nearly equal mass or (b) a very light neutron star whose companion is a rapidly rotating white dwarf or helium main sequence star.

II. MOTIVATION--COSMOLOGICAL HORIZONS

One of the most intriguing predictions of general relativity is its prediction of "event horizons" in spacetime. These are boundaries which separate observeable events from those not observeable. The best known example of an event horizon is that which surrounds a spherical black hole and which happens to arise at the same value of the radial coordinate, $r = 2GM/c^2$, for which the Schwarzchild metric

$$ds^{2} = (1 - \frac{26M}{Rc^{2}})dt^{2} - \frac{dr^{2}}{1 - 2GM/Rc^{2}} - r^{2}d\theta^{2} - r^{2}sin^{2}\theta d\phi^{2} \qquad (1)$$

has a singularity.

However, the existence of an horizon in spacetime is independent of the choice of a coordinate system and, in fact, it is possible to have event horizons even when spacetime is perfectly homogeneous. Rindler (1956), in his classic paper on cosmological horizons, showed that homogeneous cosmology permits universes with particle horizons, event horizons or both.

The presence of particle horizons (a surface in 3-space which divides all fundamental particles into two classes: those which have been observed by a given "fundamental observer" and those which have not been observed) has troubled cosmologists for the following reason. Particle horizons represent regions which have been and still are causally disconnected from other parts of the universe. However, according to the precepts of canonical cosmology, all fundamental observers must find identical physical conditions (of course disregard small scale local inhomogenities) at the same instant of cosmic time. The obvious and difficult question is: How do regions which are causally disconnected achieve such a remarkable degree of physical identity?

Of course, one can always postulate special initial conditions, but this approach seems more in the spirit of theology than of science. A more challenging approach is to assume that the universe began with anisotropies present and that through the actions of certain mechanisms homogeneity naturally arose (Misner, Thorne and Wheeler 1973, ch. 30). For this approach to be successful it is essential that the following two requirements be met:

- (1). A satisfactory mechanism for converting initial anisotropies into isotropy be found.
- (2). Whatever the mechanism, there must be sufficient time to create the degree of homogeneity and isotropy now observed.

It is possible to use the 3° K microwave background radiation to place some constraints on the time available for producing homogeneity (Misner, Thorne and Wheeler 1973, ch. 30). These constraints are so severe--the universe must be already homogeneous as early as the epoch z = 1000 (only 600,000 yr after creation in an Einstein-de Sitter model) that no entirely satisfactory chaotic cosmology has yet been found.

Therefore, because particle horizons pose an important problem for cosmology, it is important to analyze bimetric cosmology in order to discover if these horizons exist in bimetric models as they do in general relativity.

III. BIMETRIC COSMOLOGY WITH THE ROBERTSON-WALKER METRIC.

Nowadays it is popular to use Robertson-Walker spacetime $ds^{2} = dt^{2} - \frac{R^{2}(t)}{(1+kr^{2}t)^{2}} \cdot \left(\frac{\partial r^{2} + r^{2} d\theta^{2} + r^{2} \sin^{2} \theta}{\partial t^{2} + r^{2} \sin^{2} \theta} d\phi^{2} \right)$ (2)

for cosmological investigations. Here (r, θ, ϕ) form a set of "comoving" spherical coordinates, t is cosmic time, R(t) is the scale factor function, and k is the constant of space curvature.

Rindler (1956) derived equations which allow one to test for horizons in Robertson-Walker spacetime. In models which have R = 0 a particle horizon will exist at time t_0 if $\int_{0}^{t_0} \frac{\partial t}{\partial t}$ converges. (3)

Some cosmologies never pass through R = 0 and begin their motion as $t \rightarrow -\infty$. In these models a particle horizon will exist at t_0 if

 $\int_{-\infty}^{+\infty} dt/R(t) \qquad \text{converges.} \qquad (4)$

(5)

For an event horizon there is only one test, viz.,

Although the above tests are, at least in principle, straightforward there do arise problems when one attempts to use them in bimetric cosmology. The principle difficulty arises from the

converges.

from the fact that none of the published bimetric cosmological models are consistent with the Robertson-Walker line element for $g_{\mu\nu}$ and, at the same time, consistent with the form used for $\gamma_{\mu\nu}$ in solving the bimetric field equations. For example, Babala (1975) initially assumes

$$ds_{I}^{2} = g_{\mu\nu} dx^{\mu} dx^{\nu} = e^{2\Phi} dt^{2} - e^{2\Psi} (dr^{2} + r^{2} d\theta^{2} + r^{2} sin^{2} \theta d\phi^{2})$$
(6)

$$ds^{2}_{II} = \chi_{\mu\nu} dx^{\mu} dx^{\nu} = dt^{2} - dr^{2} - r^{2} d\theta^{2} - r^{2} sin^{2} \theta d\phi^{2}$$
(7)

where Φ and Ψ are functions of t. By redefining the time coordinate it is possible to transform eq. (6) into Robertson-Walker form

$$\tau = \int e^{\frac{\pi}{2}} dt \qquad ; \qquad ds_{\pi}^2 = d\tau^2 - e^{2\Psi(\tau)} (dr^2 + r^2 d\theta^2 + r^2 sin^2 \theta d\phi^2). \quad (8);(9)$$

From equations given by Babala it is easy to show that his models require

$$\tau = e^{2\circ} \tanh t + k \tag{10}$$

where \mathbf{F}_{\bullet} and k are obtained from initial conditions. The simplest case to analyze is $k = \mathbf{F}_{\bullet} = 0$ and then one finds

(12)

 $\tau = \tanh t \qquad -|<\tau < | \qquad (11)$

$$t = \frac{1}{2} \ln \frac{1+\tau}{1-\tau}$$

$$e^{\psi(\tau)} = e^{\psi_0} \frac{1}{1-\tau^2} \left(\frac{l+\tau}{1-\tau}\right)^{(13)}$$

where λ' is a constant of integration related to the value of Ψ' . According to Babala, expanding models are given by $\lambda' > 1, \lambda' = 1$ $-1 < \lambda' < 1$. The simplest case to study is the one with $\lambda' = 1$ because eq. (13) simplifies to form easy to integrate.

If the Rindler tests are applied, then one finds that this model contains both a particle horizon and an event horizon at τ_o because both

$$\int_{-\infty}^{+0} \frac{dt}{R(t)} \rightarrow \int_{-1}^{\tau_0} e^{-\psi_0} (1-\tau)^2 d\tau = \frac{e^{-\psi_0}}{3} (8 - (1-\tau_0)^3)$$
(14)

$$\int_{t_0}^{\infty} \frac{dt}{R(t)} = \int_{T_0}^{t} e^{-\frac{t}{6}} (1-\tau) d\tau = \frac{e^{-\frac{1}{6}}}{3} (1-\tau_0)^3$$
 (15)
converge.

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However, it is possible to find bimetric models without particle horizons. An example is afforded by choosing $\lambda = 2$. In this model the particle horizon integral logarithmically diverges as $\tau \rightarrow -1$. $\int_{-1}^{\infty} e^{-\frac{1}{2}} \left(\frac{1-\tau}{1+\tau}\right)^{3} d\tau = \left(8 \ln(1+\tau) - 8(1+\tau) + 2(1+\tau)^{2} - \frac{1}{3}(1+\tau)^{3}\right) e^{-\frac{1}{2}} \left(\frac{1+\tau}{1+\tau}\right)^{3} e^{-\frac{1}{2}}$ (1b)

The difficulty which results when the time coordinate is redefined lies in the fact that while eq. (8) succeeds in converting eq. (6) to Robertson-Walker form it also forces the background metric to be time dependent. However, in deriving eqs. (10)-(13), gotten by substituting eqs. (6) and (7) into the bimetric field euations, Babala assumed that $\gamma_{\mu\nu}$ was independent of time. Bimetric cosmologies published by Goldman and Rosen (1977) and Rosen (1978) are subject to the same criticism. However, in the latter paper Rosen assumes that $\gamma_{\mu\nu}$ is time dependent at the outset and that $q_{\mu\nu}$ is given by eq. (6). In this case the effect of making a new time coordinate via eq. (8) is to change the time dependence of $\gamma_{\mu\nu}$ away from the form used in setting up the field equations.

The preceding considerations suggest that the Robertson-Walker line element be introduced at the start rather than making an attempt to transform to it at a later stage. Unfortunately, this procedure does not work if one uses a flat, static background metric. On substituting eqs. (2) and (7) into the bimetric field equations (see Rosen 1973,1974 for more detail):

$$N_{\mu\nu} = \frac{1}{2} \chi^{\alpha\beta} g_{\mu\nu} |_{\alpha\beta} - \frac{1}{2} \chi^{\alpha\beta} g^{\alpha\beta} g_{\mu\lambda} |_{\alpha} g_{\nu\beta} |_{\beta} = -8\pi \pi \left(T_{\mu\nu} - \frac{1}{2} g_{\mu\nu} T \right)$$
(17)

and evaluating the (4,4) component one finds

(18)

for a matter dominated universe with neglible pressure. Apparently, only empty Robertson-Walker bimetric cosmologies are allowed by using eqs. (2) and (7).

The simplest way to produce non-empty bimetric Robertson-Walker models is to let $\gamma_{\mu\nu}$ be time dependent. A straightforward method would be to let $\gamma_{\mu\nu}$ have a Robertson-Walker form but with a different time dependence than $g_{\mu\nu}$, viz.,

$$ds_{I}^{2} = dt^{2} - \frac{R^{2}(t)}{(1+kr^{2}/4)^{2}} \left[\partial r^{2} + r^{2} \partial \theta^{2} + r^{2} \sin^{2} \theta d\phi^{2} \right]$$
(19)

$$ds_{II}^{2} = dt^{2} - \frac{S^{2}(t)}{(1+kr^{2}/4)} \left[dr^{2} + r^{2} d\theta^{2} + r^{2} \sin^{2}\theta d\theta^{2} \right].$$
(20)

However, this approach is not completely satisfactory because

there are not enough field equations to simultaneously determine both R(t) and S(t).

Rosen (1978) made an interesting attempt to fix the time dependence of $\gamma_{\mu\nu}$ by using the cosmological principle. It is well known, e.g., see Robertson and Noonan 1968, ch. 14, 347, that theonly non-static metric which satisfies the perfect cosmological principle is the spatially flat de Sitter line element

$$ds^{2} = dt^{2} - e^{\alpha t} (dr^{2} + r^{2} d\theta^{2} + r^{2} sin^{2} \theta d\theta^{2})$$
(21)

When $\gamma_{\mu\nu}$ is identified with de Sitter's metric it is possible to solve Rosen's field equations for R(t). Rosen, however, rejected the resulting model because it has a big-banglike singularity at $t \rightarrow \infty$. Assuming that the time dependence of $\gamma_{\mu\nu}$ is cosh t/a rather than exp 2t/a and that both $g_{\mu\nu}$ and $\gamma_{\mu\nu}$ are spacetimes of constant positive curvature, Rosen was able to derive an expanding, closed and singularity free universe.

However, it should be pointed out that these goals were reached by making what seems to be an arbitary choice for S(t). Also Rosen fails to point out that if $S(t) = \cosh t/a$, then $\gamma_{\mu\nu}$ no longer satisfies the perfect cosmological principle because the Hubble parameter of this metric

is not independent of time.

During the course of this fellowship the author attempted to develop a satisfactory mehod for fixing the time dependent part of $\gamma_{\mu\nu}$. One approach, which looked promising, was suggested by the fact that in general relativity one can start with a rather general spacetime

$$ds^{2} = e^{\nu(r_{1}t)}dt^{2} - e^{\mu(r_{1}t)}(dr^{2} + r^{2}d\theta^{2} + r^{2}\sin^{2}\theta d\theta^{2})$$
(23)

and derive the Robertson-Walker line element by making use of a "consistency relation" which stems from the use of co-moving coordinates (McVittie, 1965, ch.8).

Since no published work about bimetric consistency relations now exists, the author hoped to (1) derive a consistency relation for the use of co-moving coordinates and (2) use it, if possible, to pin down the time dependence of $\gamma_{\mu\nu}$.

(22)

The first step was accomplished for the following case. If one assumes that $\gamma_{\mu\nu}$ and $g_{\mu\nu}$ generate spherically symmetric spacetimes

$$ds_{I}^{2} = g_{\mu\nu} dx^{\mu} dx^{\nu} = e^{\nu(r,t)} dt^{2} = e^{\mu(r,t)} (dr^{2} + r^{2} d\theta^{2} + r^{2} sin^{2} \theta d\theta^{2})$$
 (24)

$$ds_{II}^{2} = \chi_{\mu\nu} dx^{\mu} dx^{\nu} = dt^{2} - e^{\lambda(r_{1}+1)} (dr^{2} + r^{2} d\theta^{2} + r^{2} sim^{2} \theta d\phi^{2})$$
 (25)

and then substitutes these into the bimetric field equations, then one finds the following non-vanishing components

$$N'' = \frac{2}{7} \left[H^{\mu} - y^{\mu} + (h^{\mu} - y^{\mu}) - \frac{8}{7} y_{f}^{f} e_{y+\eta} + \frac{7}{7} \left[y^{ff} - h^{ff} + \frac{3}{3} (y^{f} - h^{f}) \right] e_{h} \right]$$
(77)

$$N_{22} = r^2 N_{11}$$
 (27)
(38)

$$N_{33} = r^{4} N_{41} \sin^{2} \Theta$$

$$N_{41} = -\frac{1}{4} \left[v_{rr} + \left(\frac{2}{r} + \frac{1}{2}\lambda_{r}\right)v_{r} \right] e^{v_{r}\lambda} + \frac{1}{2} \left[v_{41} + \frac{3}{2}\lambda_{4}v_{4} \right] e^{v} + \frac{3}{8}\lambda_{4}^{2} \left[e^{H-\lambda} - e^{\lambda+3v-\mu} \right]$$
(29)

$$N_{H} = \frac{1}{4} \left[\lambda_{tr} + \lambda_{t} \left(\nu_{r} + \lambda_{r} - \mu_{r} \right) \right] e^{\nu} - \frac{1}{4} \left[\lambda_{tr} - \lambda_{t} \left(\nu_{r} + \lambda_{r} - \mu_{r} \right) \right] e^{\mu - \lambda}$$
(30)

The use of co-moving coordinates requires that, in spherically symmetric spacetime,

$$T'' = (p+p) \frac{dx'}{ds} \frac{dx'}{ds} - g''p$$
(31)

vanish since and g = 0. However, these conditions also require T^{14} -g¹⁴T/2 = 0 and that means N₁4 =0. Thus, the bimetric consistency relation is

$$\left[\lambda_{tr} + \lambda_{t} (\nu_{r} + \lambda_{r} - \mu_{r})\right] e^{\nu} = \left[\lambda_{tr} - \lambda_{t} (\nu_{r} + \lambda_{r} - \mu_{r})\right] e^{\mu - \lambda}$$
(3>)

For comparison, the analogous general relativistic equation is

$$\mu_{rt} = \frac{1}{2} \mu_{t} \nu_{r} \tag{33}$$

As outlined in McVittie's textbook, it is possible to integrate eq.(33) and, by requiring that the (1,1) and (2,2) components of the Einstein tensor yield the same cosmological fluid pressure, one arrives at the Robertson-Walker line element.

Unfortunately, when the same procedure is followed in bimetric theory, one discovers that N_{11} and N_{22} already give the samedifferential equation for pressure. Thus, unlike general

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relativity, the consistency relation for co-moving coordinates does not lead to appreciable progress and, in particular, no new information is gained about the time dependence of $\gamma_{\mu\nu}$.

IV. AN ANALYTIC SOLUTION FOR ROSEN'S 1978 k =+1 MODEL

As mentioned in the previous section, Rosen (1978) found a closed space expanding model which does not have a singularity. During the course of this summer's work the author found an analytic solution to the bimetric field equations of this model.

$$\ddot{\mp} + \frac{3}{a} (\tanh \frac{1}{a}) \dot{\mp} + \frac{3}{a^2} \tanh^2 \frac{1}{a} \sinh (2\Psi - 2\overline{\Phi}) = -4\pi e^{\frac{1}{2} + 3\Psi} (p + 3p) \quad (34)$$

$$\ddot{\psi} + \frac{3}{a} (\tanh \frac{1}{2}) \dot{\psi} - \frac{1}{a^2} \tanh^2 \frac{1}{a} \sinh((2\psi - 2\bar{\psi})) = 4\pi e^{\frac{1}{2} + 3\psi}(p-p)$$
 (35)

$$\dot{g} + 3(g+p)(\dot{\psi} + \frac{1}{4} \tanh \frac{1}{6}) = 0$$
 (36)

If one investigates a zero pressure model and sets $g_{44} = 1$, then these equations simplify and it is possible to use the integral of eq.(36)

$$ge^{3^{4}}cosh^{3} \frac{t}{a} = A$$
; A is a constant of integration, (37)

to set up a single second order differential equation which is linear in $\ \Psi$

$$\dot{\psi} + \frac{3}{2}\dot{\psi} \tanh t_{\alpha} = \frac{8\pi A}{3} \operatorname{sech}^{3} \frac{t}{\alpha}$$
 (38)

By using the classical variation of parameters method it is possible to arrive at the following general solution to eq.(38):

$$\Psi(t) = \left(\frac{8\pi A}{3} \pm \frac{1}{2} aB\right) \left[\operatorname{sech} \pm \tanh \pm \frac{1}{2} \tanh \frac{1}{2} + \tan^{-1}(\sinh \frac{1}{4})\right] + \frac{8\pi A}{3} \operatorname{sech} \pm \frac{1}{2} - \frac{8\pi A}{3} \int \tan^{-1}(\sinh \pm) \frac{d\pm}{2} + (..., (39))$$

In this solution B and C are constants of integration and the integral can be carried out by expanding $\tan^{-1}(\sinh t/a)$ in a power series.

Although eq.(39) is not as simple as one would like, it is nevertheless, sufficiently simple to analyze for possible singularities in cosmic time. By letting $t \rightarrow -\infty$, $t \rightarrow 0$ and $t \rightarrow \infty$ and looking at each term in (39) one can verify that Rosen's conclusion about the absence of a singularity in this model is correct.

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V. SUMMARY

Because the formalism of Rosen's bimetric theory is so similiar to general relativity one would think that it would be a simple matter to set up bimetric cosmology by using the Robertson-Walker metric for g $\mu\nu$. However, if such is attempted, then one finds that there are too few bimetric field equations to simultaneously fix the time dependence of g $_{\mu\nu}$ and $\gamma_{\mu\nu}$.

Other results are:

- (1) Certain flat bimetric cosmologies of Babala have particle horizons; others do not. Apparently, the bimetric field equations (by themselves) are not strong enough to prevent the occurence of cosmological particle horizons, although strangely enough, they do exclude black holes.
- (2) An empty universe results if one tries to use a flat background metric along with a Robertson-Walker fundamental metric.
- (3) Rosen's singularity free universe of positive spatial curvature (Rosen 1978) arises from what seems to be a an arbitary choice for the time dependent part of $\gamma_{\mu\nu}$.
- (4) A consistency relation for using co-moving coordinates in bimetric cosmology was derived.
- (5) An analytic solution was found for the field equations which describe Rosen's (1978) universe of positive space curvature.

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MEASUREMENTS OF THE SAMPLING VOLUME OF AN INFRARED LASER DOPPLER VELOCIMETER FOR THE STUDY OF FEASIBILITY OF SIMULTANEOUS THREE-DIMENSIONAL VELOCITY PROFILE MAPPING

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XXIV

MEASUREMENTS OF THE SAMPLING VOLUME OF AN INFRARED LASER DOPPLER VELOCIMETER FOR THE STUDY OF FEASIBILITY OF SIMULTANEOUS THREE-DIMENSIONAL VELOCITY PROFILE MAPPING

Ву

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ABSTRACT

This project is a continuation and configuration of the experimental work performed during the summer of 1979. Data obtained after the submission of last year's report gave strong indication that it would be possible by spatial masking to code information onto an outgoing laser beam which would yield three-dimensional velocity information when analyzed at an interferometer.

The work continued into this year has involved detailed, high resolution incoherent mapping of the sampling volume to determine the three-dimensional profile of the volume of the beam from which information will be obtained by scattering.

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INTRODUCTION

Marshall Space Flight Center has been involved in the application of Laser Doppler Velocimeters (LDVs) since their inception by Yeh and Cummins¹ in 1964. Subsequent research has applied LDVs to the study of aircraft wake vortices,²,³ atmospheric turbulence measurements,⁴ remote intensity fluctuations,⁵ dust devil measurements,⁶ and presently to severe storms.⁷

Except for the earliest work in wind tunnels, most applications have used CO₂ lasers to increase the signal-to-noise ratio - an advantage resulting from the atmospheric window at 10.6 micrometers. Present work involves pulsed CO₂ laser to further increase the signal-to-noise ratio. Future work will utilize the advantages of off-axis telescopes and, possibly, lasers operating at wavelengths which more nearly match atmospheric windows.

Each LDV has certain limitations on the velocity vectors which it can measure. The early LDV of Yeh and Cummins, for example, could easily measure flow velocities perpendicular to the incident optical plane. However, it could not measure velocity components along the optical axis. Subsequent systems, such as those used to measure aircraft wake vortices, measure the components along the optical direction at the expense of the orthogonal components. A need exists for an LDV which is capable of reading all orthogonal velocity components. Such an LDV could be used to map the three-dimensional characteristics of a remote flow field.

Several developments in LDVs point to the possibility of coding sufficient information into a laser beam so that the returned radiation will contain three-dimensional velocity component data. These developments include the classical heterodyne, fringe, and the more recent time-of-flight LDVs. It is possible that a combination of these approaches would yield the three-dimensional information necessary to map a three-dimensional flow field. The most likely impediments appear to be instrumentation artifacts which may obscure the signal of one or more velocity components or produce an unacceptable signal-to-noise ratio.

OBJECTIVES

The purpose of this work has been to obtain a detailed understanding of the sampling volume of the infrared laser Doppler velocimeter assembled during the 1979 Summer Faculty Fellowship Program. Detailed, high resolution maps were to be made of both the coherent and incoherent sampling volumes. The response of the sampling volume to spatial masking within the telescope was also to be determined. The response of the system to various objects moving through the sampling volume was also to be determined.

EXPERIMENTS

The infrared laser Doppler velocimeter (Figure 1) assembled during the Summer Faculty Fellowship Program last summer was returned to its operational status. The system was improved by modifying the external mirrors to permit mechanical rather than electrical positioning. This step was necessary to maintain more precise alignment of the entire laser Doppler velocimeter (LDV).

The detailed study of the coherent sampling volume yielded essentially the same results as those obtained last summer. The double maximum present last summer in the Doppler Signal Power vs. Secondary Mirror Position curves was not as pronounced. The cause of this phenomenon was isolated to the z-scan mechanism of the secondary mirror. As the secondary mirror is moved along the optical (z) axis, the focal point projected onto the detector assembly (27-50 feet away) moves erratically about in the x-y plane of the detector. Of course, similar wandering of the beam occurs relative to a fixed position on the rotating sandpaper wheel.

Ironically, a similar phenomenon occurs when the rotating sandpaper wheel located on a carriage on the optical bench is moved along the z-axis of the beam. In this case the "wandering of the beam" is only apparent. A fixed point on the rotating wheel is actually moving in the x-y plane as the ztraverse is made. Obviously, data entailing movement of both the wheel and secondary mirror contains a compound error resulting from both phenomena.

Data taken by scanning the secondary mirror, first in one direction, then in the reverse direction, is reasonably repeatable but is not symmetric relative to the maximum power point in the scan. This asymmetry is in part due to the x-y motion introduced into the outgoing beam.

The same data taken by scanning the rotating wheel along the optical axis, first in one direction, then in the reverse direction, is approximately as repeatable but with much less asymmetry.

When the signal power (as measured by a specturm analyzer) was plotted against the voltage (as measured on an oscilloscope) there were discontinuities on the semi-log plot. The causes of these points which did not fall on the straight line plot were never determined. There is a remote possibility that they resulted from an ailing Honeywell specturm analyzer which failed to function after this data was taken.

The incoherent data verified and accentuated the conclusions arrived at from the coherent data - namely that the beam wanders about in the x-y plane as it rotates in an irregular arc about the optical axis. An example of the phenomenon is as follows. With the secondary mirror adjusted to focus at the near end of the optical bench let us assume the focal point is on the optical axis. As the secondary mirror is adjusted to move the focal point toward the far end of the optical bench, the beam first swings toward the left as it swings upward and finally swings back toward the right as it reaches its maximum height at the far end of the optical bench. This general pattern was repeated for many experiments. Occasionally there was some fine detail in the arc but the trend remained the same. It was determined that the relationship between the secondary mirror position and the focal point position on the optical axis was highly repeatable and agreed with theoretical predictions.

The incoherent sampling volume was measured by moving an aperture throughout the double cone defined by the focused beam from the laser. Figure 2 is a traverse in the x-axis of the laser beam without secondary mirror or wire filter. This x-axis profile is the standard for all additional work which was taken with the beam focused between 27 and 50 feet by the secondary mirror. A 500 µm aperture was selected for the traverse of the unfocused beam to keep the power density within the limits of the pyroelectric detector and lock-in amplifier used for power detection. Apertures of suitable size were always used for taking data since neutral density filters operable at 10.6 µm were not available. Attempts to use existing flats of Ge, CaF2 or BaF2 were futile because of significant artifacts introduced into the data via diffraction and multiple reflections. Notice the asymmetry in the beam which is present to some extent in all data.

Initial data was taken with a 1.0 mm aperture as was done last year. It was determined that this aperture did not produce sufficient resolution for a laser beam that has a theoretical focal diameter of approximately 40 mil. The resolution would be particularily dismal if one were interested in detecting auxillary maxima about the center of the beam. As a result, the 1.0 mm aperture attached to a Coherent Radiation power head was replaced with pinholes of either 25 or 50 μ m attached to a pyroelectric detector. Depending upon the laser output power, the 50 μ m aperture was frequently so large that it produced slight saturation of the pyroelectric detector or lock-in amplifier. Therefore, much of the data was taken with the 25 μ m aperture when the laser power was too large for the other size aperture. The Coherent Radiation power head could not be used because it did not have sufficient sensitivity with small apertures and because its frequency response was below the 4 Hz minimum response of the lock-in amplifier and accompanying rotating aperture. Though data were taken at many z-axis positions, those which follow were taken at a nominal 47 feet.

Figure 3 is a trace along the optical axis obtained by moving the aperture along the optical bench with the secondary mirror set for a nominal distance of 47 feet. Notice the asymmetry relative to the nominal focal plane of the nominal focal plane is caused by variation in time of the x-y position of the focal point. The beam was originally positioned in x, y and z to provide maximum power at the nominal focal plane.

Figure 4 compares the trace along the z-axis taken with and without the wire filter in place. There is a natural reduction in total power when the wire is in place but otherwise the two traces are similar.

Additional information was obtained by x and y traverses of the sampling volume at the nominal focus and at distances before and after the nominal focal plane. Figure 5 compares the x-axis traverse taken at the nominal focal plane with and without the wire filter in position. Figure 6 presents the same information for the y-axis. Other than the normal reduction in power produced when the wire is introduced, the two traces are similar for both the x and y traverses.

Figure 7, in combination with Figure 8, represents several x traverses in the nominal focal plane and in several planes before and after the nominal focal plane. Figure 7 compares the x trace in the nominal focal plane to the x traces taken at nominal half (5 in.) and quarter (7 in.) power points before focus. Figure 8 compares the x trace in the focal plane to the x trace taken at nominal half power (3 in.) and quarter power (4 in.) points after focus.

Figure 9 and 10 present corresponding traces for the y axis.

The introduction of the wire filter just prior to the secondary mirror of the telescope splits the outgoing laser beam into two distinct nearly equal components - one left and one right. Each component is made up of a large lobe of radiation separated into several smaller diffraction lobes whose intensity decreases rapidly as one progresses from the z axis outward - to right for right hand lobe - to left for left hand lobe. Data indicates that the x and y tracings taken at the nominal focal plane for the whole beam is not the simple intensity sum of the two individual half beams. It is speculated that the system is sufficiently abberated that the individual lobes each form a non-detailed blur in the region of the focal plane. When the two lobes are simultaneously present at the focal plane, they coherently interfer to form an interferance pattern with its maximum on axis and usually with side lobes.

Figure 11 presents a trace along the x axis at the nominal focal plane for the total beam and for the left and right hand halves of the beam. Either the right or left half of the beam is removed by placing a mask near the telescope. The edge of the mask coincides with the center of the shadow of the wire filter. The introduction of only one half the beam at a time is guaranteed by viewing the pattern with liquid crystal paper.

Figure 12 presents a trace along the y axis. The x-y position of the focal point has moved in this plot.

Figure 13 and 14 present the same data for a nominal half power point 2.5 inches after the nominal focal plane.

The normal sampling interval for the x, y traverses is 2.5 inches, which provides that there is no overlap of sample areas whether a 25 or 50 μ m aperture is used. For the data with the unfocused beam a 500 μ m (approximately 20 mil) aperture sampled every 25 mils.

CONCLUSIONS AND RECOMMENDATIONS

The incoherent sampling volume of the infrared laser Doppler velocimeter assembled in the 1979 Summer Faculty Fellowship Program was found to be heavily dependent upon the configuration of the outgoing laser beam. In general when only half the beam is allowed to focus at the focal plane, the x, y traverses indicate a broader beam with nominal side lobes. However, if the total beam is permitted to impinge on the focal plane there is substantial narrowing of the beam with increased maximum intensity and an increase in side lobes.

The double maximum indicated by the coherent sampling volume appears to be an artifact of the scanning process - not a fundamental entity of the sampling volume.

It is not known at this point how significant any of these effects are on the actual Doppler signal and its analysis. It is recommended that this information be obtained by first "calibrating" the laser output followed by automated data taking procedures to minimize the very apparent time factor which permeates all the data.



 1. LASER
 12.

 2. BEAM SPLITTER
 13.

 3. BRAGG CELL
 14.

 4. ATTENUATOR
 15.

 5. 45° MIRROR
 16.

 6. HALF WAVE PLATE
 17.

 7. BEAM SPLITTER
 18.

 8. FOCUSSING LENS
 18.

 9. DETECTOR
 20.

 10. BREWSTER WINDOW
 21.

 11. 45° MIRROR
 22.

-

QUARTER WAVE PLATE
 PRIMARY MIRROR
 SECONDARY BACKSCATTER ATTENUATOR
 SECONDARY MIRROR
 SERVO MOTOR
 SCANNING MIRROR
 SERVO MOTOR
 SINE COSINE POT
 INTERFEROMETER
 TELESCOPE









FIGURE 4. TRACE ALONG z-AXIS OF BEAM FOCUSED AT 47 FEET -- COMPARISON WITH AND WITHOUT WIRE FILTER -- 50 μm PINHOLE









FIGURE 7. COMPARISON OF BEFORE FOCUE TRACES IN X-AXIS





FIGURE 9. COMPARISON OF BEFORE FOCUS TRACES IN X-AXIS



FIGURE 10. COMPARISON OF AFTER FOCUS TRACES IN y-AXIS







FIGURE 12. TRACES (y) IN FOCAL PLANE FOR THE TOTAL BEAM AND FOR LEFT AND RIGHT HALVES





FIGURE 13. TRACES (x) 2.5 INCHES AFTER FOCUS FOR THE TOTAL BEAM AND FOR LEFT AND RIGHT HALVES



FIGURE 14. TRACES (y) 2.5 INCHES AFTER FOCUS FOR THE TOTAL BEAM AND FOR LEFT AND RIGHT HALVES

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

A MONTE CARLO APPROACH TO TOLERANCE ANALYSIS OF A NEAR-DIFFRACTION LIMITED OPTICAL IMAGING SYSTEM

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A MONTE CARLO APPROACH TO TOLERANCE ANALYSIS OF A NEAR-DIFFRACTION LIMITED OPTICAL IMAGING SYSTEM

by

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ABSTRACT

Using the theory of Don Knuth, a computer program has been developed to generate random numbers on the Sigma V computer. A subroutine gives a random real number from a uniform distribution on the interval (0,1). A normal distribution with mean zero and variance 1 is also obtained. In my NASA/ASEE report for 1979, a statistical description of 5 possible errors is given. These 5 errors are S₁ which is X-axis tilt; S₂ which is Y-axis tilt; S₃ which is X-decenter; S₄ = Y-decenter; and S₅ which is despace.

Combining the above results a quality function, $Q(S_1, S_2, \ldots, S_5)$, is obtained via a computer program. Values of Q^2 are given in fractional wavelengths. The (variables) errors S_1, \ldots, S_5 are assumed to be independent of each other with possibly different statistical descriptions. Consequently, Q is a linear function.

ACKNOWLEDGEMENTS

The author would like to express his gratitude to Dr. Bob Barfield for directing a very successful summer program. I would also like to express my appreciation to my MSFC counterpart, Don Griner, for his consultations and guidance during the summer; to Charlie Jones for the many technical discussions concerning this project; and to Julie Taylo for her programming assistance.

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I. INTRODUCTION

A Monte Carlo approach is used to determine wavefront error on a two mirror telescope. A computer program that traces N rays through an optical system and calculates the root mean square of the optical path difference (RMSOPD) is used for this analysis. An expanded version of this program will also give the Zernike coefficients. In this study only five errors are used, X-tilt, Y-tilt, X-decenter, Y-decenter, and despace of the secondary mirror. A statistical description is obtained for these five errors. Assuming a uniform probability of any one of these errors, we obtain a wavefront error.

The critical ingredient in a Monte Carlo method is a good random number generator. Knuth has developed a theory for an algorithm that generates a uniformly distributed set of pseudorandom numbers. This algorithm was programmed in FORTRAN IV and used to obtain a uniform distribution of random numbers on (0,1) and a normal distribution of mean zero and variance of 1.

II. OBJECTIVES

To develop a statistical simulation that uses the Monte Carlo techniques in the form of a computer program. The RSS method of tolerance analysis then is to be compared with the Monte Carlo method.

III. TOLERANCE ANALYSIS OF A NEAR-DIFFRACTION LIMITED OPTICAL SYSTEM

A near-diffraction limited optical imaging system is an optical system designed such that root mean square of the optical path difference (RMSOPD) is less than or equal .25 λ . In this analysis the wavelength (λ) used was 632.8 nm. A ray trace computer program written in FORTRAN IV for the Sigma V computer was used. This program can trace N (N = 101 to 1000) rays through an optical system and calculates RMSOPD. The optical path difference (wavefront errors) is obtained by subtracting the chief ray length from the remaining ray lengths. The chief ray is always traced by the program; ignoring the central obscuration it is used as our reference. A spherical wavefront on the image plane (focal plane) is used as the reference. The optical system is a modified Cassegrain or Ritchey-Chretian design. The exit pupil for this design is back of the secondary mirror (see Figure 1). The entrance pupil is the primary mirror.

The ray trace program has a graphics capability of plotting the spot. Figure 2 is a spot diagram of the program when no aberrations are present. Page XXV-10 gives the output that corresponds to this case. Recall that aberration describes the lack of homocentricity in a pencil of rays (input) or the deviation of a wave surface from a spherical form. In Figure 3 we have a spot diagram with 0.1 arc min of tilt about the X-axis. The output that corresponds to this case is on page XXV-9.

The primary lens (mirror) will remain fixed. The secondary has six degrees of freedom but is symmetric with respect to rotation; hence, we only consider:

- (i) X-axis tilt (S₁) -.95 to .95 arc min -1.7 to 1.7 arc min (centroid correction) -2.9 to 2.9 arc min (best chief ray)
- (ii) Y-axis tilt (S₂)
 Same range of numbers as X-axis tilt
- (iii) X-axis decenter (S₃) -165 to 165 μ m -300 to 300 μ m (centroid correction) -530 to 530 μ m (best chief ray)
- (iv) Y-axis decenter (S₄)
 Same range of values as X-axis decenter
- (v) Despace (S₅) -10.9 to 10.9

When the optical system is perturbed by one of the above five perturbations, it is the exit pupil wavefront that is operated upon.

IV. MONTE CARLO METHOD

A random number generator using the theory of Don Knuth (see reference 7) is used to give a uniform distribution on (0,1). Also see reference 2, page 240f, for a FORTRAN listing of this random number computer program. Let $Q = Q(S_1, S_2, \ldots, S_5)$ be the quality function where S_i , $i = 1, \ldots, 5$ are the errors given above. A Monte Carlo approach is used to obtain Figure 2. A random number is selected from the random number generator corresponding to a uniform distribution. This number is then scaled to the maximum range of the possible error for S_i . The five errors S_i are assumed to be independent of each other. Hence, one to five different uniformly distributed random numbers are obtained to give the histogram of Figure 2. The data for each of the histograms was formatted as follows:

Run No.	sl	s ₂	s ₃	s ₄	s ₅	RMSOPD	AVG.	RMSOPD
1								
2								

One thousand runs were made and the average RMSOPD for these 1000 runs was plotted on the Y-axis.

One thousand runs were made where X-Y tilt and X-Y decenter were given an equal probability of occurring. The tolerance range used for each of these four errors was the range that would give a .25 λ RMSOPD wavefront error. If we take the root sum square (RSS) of these four values we get 0.5 λ . From Figure 4 we see that the average RMSOPD is 0.302 λ . Hence, this would imply for this scenario that the RSS technique is a more rigid tolerance than a Monte Carlo technique. So an optical system designed with respect to the RSS method would be better than one designed relative to the tolerances given by a Monte Carlo method.

Taking the RSS of two errors with a value of .25 λ we get 0.354 λ . From Figure 4 we see that the Monte Carlo method used on any combination of errors X-tilt, Y-tilt, X-decenter, and Y-decenter taken two at a time will give a range of .158 λ to .226 λ .

V. AN OPTICAL SYSTEM VIEWED AS AN AUTOMATON

Let $A = (S, \Sigma, M)$ be an automaton



 $\Sigma = \{\sigma/\sigma = a \text{ unit of measure of X-axis tilt of the secondary mirror in arc min}\}.$

Let N be some positive integer such that $\sigma^N = 0$. To obtain $\sigma^2 = \sigma\sigma$ we define σ^2 to be two units of tilt, e.g., let $\sigma = 1$ arc min then σ^2 is two arc min, etc. With this binary operation Σ makes a semigroup with zero which acts like an identity. Note Σ is semigroup isomorphic to $(Z_N, +)$. $(Z_N, +)$ is the semigroup of integers modulo N with respect to addition.

S = states of the system which will be the Zernike coefficients A_1, \ldots, A_k in the polynomial approximation. $W(X,Y) = A_1P_1 + \ldots + A_kP_k$. Note: k is to be a fixed positive integer; P_1 , $i=1,2,\ldots,k$, are the Zernike polynomials.

Now for $M_{\sigma} \in M$, $\sigma \in \Sigma$, define

$$M_{\sigma}: S \rightarrow S$$

 $A_{i} \rightarrow A_{i}M_{\sigma} = A_{i}$

so
$$M_{\sigma} \sim \begin{pmatrix} A_1 & \cdots & A_k \\ & & & \\ A_1 & \cdots & A_k \end{pmatrix}$$

Choose P_1, \ldots, P_k such that they are orthogonal with respect to the inner product

$$(P_{i}, P_{j}) = f P_{i}P_{j} .$$

$$X^{2}+Y^{2} \leq 1$$
Thus, if $M_{\tau} = \begin{pmatrix} A_{1} \cdots A_{k} \\ A_{1} \cdots A_{k} \end{pmatrix}$ then
$$M_{\sigma}M_{\tau} = \begin{pmatrix} A_{1} \cdots A_{k} \\ A_{1} \cdots A_{k} \end{pmatrix}$$
where $A_{i} = A_{1} + A_{i}$

VI. RESULTS AND DISCUSSION

The usual method of combining wavefront errors is the root sum square (RSS). For example, using the five errors above and combining them as follows:

$$\left(s_{1}^{2} + s_{2}^{2} + s_{3}^{2} + s_{4}^{2} + s_{5}^{2}\right)^{\frac{1}{2}}$$

Also, another method is to combine those by a Monte Carlo technique. If S_5 , despace, is not considered then we obtain Figure 4. Hence, an optical system designed to operate within the tolerance criterion of the RSS method would also satisfy the tolerance conditions of the Monte Carlo method.

The maximum bounds of the error on focus were approximately -10 to $10 \ \mu\text{m}$. The focus proved to be a critical error in this analysis and further study is required.

Problems to consider:

1. Develop algorithms for an optical system considered as an automaton.

2. Extend this Monte Carlo method of tolerance analysis to more complicated optical systems.

3. Develop an algorithm and program it in FORTRAN for a Zernike coefficient program (see Davenport, NASA/ASEE summer report, 1979).



PRIMARY MIRROR



XXV-5



Figure 2. No Aberrations

8-VXX



Figure 3. 0.1 Arc Min Tilt About X-Axis

XXV-7



FIGURE 4 HISTOGRAM OF AVERAGE RMSOPD UNIFORM DISTRIBUTION OF 1000 POINTS.

ST 2.4M CONFIGURATION, FIELD PT. .100, .000 101 RAYS

RMS OPD	.2432
STREHL	-1.334
CENTROID:	
2 X	3355
Y	.0000
Z	.0000
CHIEF RAY:	
. X	3351
Y	.0000

RANK 10

. 0

P1'= -.1079021E-01

ZERNIKE COEFFICIENTS **P**2 P3 P5 P6 P4 X TILT Y TILT FOCUS ASTIG(45) ASTIG(0) -1.46027 -.264879E-07 -.496520E-02 .163329E-18 -.642378E-04 P7 **P8** P11 P12 Y COMA X COMA 5TH-ORDER 3D-ORDER .182050E-07 -.495005 .141003E-04 .170063E-05 DESIGN PARAMETERS \$ D Ε QN · R 10.0000000000000 -1.00228977203300 1 -1102.50000000000 -1.000002 DUMMY -490.0000000000000 3 -1.49599512243700 -135.464362850970 -1.00000 4 DUMMY 5 640.000000000000 -1.00000000000000 1000000000.00000 1.00000 í R1 =699.507000000000 120.000 R4 =5760.00 EE = .340000 FL = .632800E-04 NRAS = 13 QLO =*STOP* 0

Table 1.

Zernike Coefficients with 0.1 Arc Min Tilt About the X-Axis XXV-9

ST 2.4M	CONFIGURATION,	FIELD PT.	.000,	.000
	101 RAYS			

RMS OPD	.7330E-05
STREHL	1.000
CENTROID:	
×	.0000
Y	.0000
Z	.0000
CHIEF RAY:	
×	.0000
Y	.0000

RANK 10

P1 = .3218636E-04

÷ ZERNIKE COEFFICIENTS **P**2 P3 P4 **P**5 **P6** X TILT Y TILT FOCUS ASTIG(0) ASTIG(45) -.409722E-12 -.708786E-11 -.847167E-21 .298539E-12 .308430E-04 **P7 P8** P11 P12 3D-ORDER STH-ORDER Y COMA X COMA .251956E-12 .129803E-11 .163000E-05 .116445E-04 DESIGN PARAMETERS D R QN \$ E 1 10.000000000000 -1.00228977203300 -1102.50000000000 -1.00000 S DUWWA -490.000000000000 -135.464362850970 -1.49599512243700 3 -1.00000DUMMY 4 1000000000.00000 640.000000000000 5 -1.000000000000000 1.00000 699.507000000000 R1 = 120.000 R4 5760.00 .340000 FL • EE • .632800E-04 NRAS - 13 QL0 -

STOP 0

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

POWER DISTRIBUTION FOR ELECTRON BEAM WELDING

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1980

POWER DISTRIBUTION FOR ELECTRON BEAM WELDING

By

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ABSTRACT

Electron beams are being used to apply heat to metals for welding purposes.

In this report, the power distribution in the beam is analyzed. Experimental and digital computer techniques are used to evaluate the radial distribution of power detected by a wire probe circulating through the beam. Analytical models developed at MSFC of the Electron Beam-Workpiece interation contain two weld loss parameters in a function of the radial power distribution. The results from this research are intended to yield information on the mechanism by which these losses take place.

Additional information on the second loss mechanism is provided by measuring metal weight losses during welding. The power wasted on these weld losses can thus be estimated and distributed to obtain a more accurate weld penetration computation.

ACKNOWLEDGEMENTS

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I especially would like to recognize Dr. Arthur Nunes, my NASA Counterpart, for outstanding contributions toward the success of this work. Also at MSFC's Materials and Processes Laboratory, I acknowledge Paul H. Schuerer (Division Chief) and Melvin McIlwain (Branch Chief, EH42). The technical assistance of Pete Smith (EH15), Clifton Green (EH42) and Howard Novak (EH42) was appreciated, as well as the inspiration of Willibald Prasthofer (EH44) and Carl Wood (EH44). Many thanks to Doris Flowers and Beverly Robinson for typing and reviewing this paper, respectively.

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NOMENCLATURE

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AV	-	accelerating voltage
BC	-	beam current
BF	-	beam focus
D	-	diameter of the irradiated target
F	-	in welder's computer program, focus
FIL	-	filament
Ι	-	beam current
^I e	-	emission current
οK	-	degrees Kelvin
L	-	length of the wire probe
Р	-	perveance
P _C	-	power lost to the crucible by conduction
Pd	-	power dissipated
Pe	-	power loss for electrons not reaching the target
Peff	-	effective power
Pg	-	power of the gun
Pi	-	power developed in the electron beam
P ₁ ,P'1	-	convergence points
PL	-	power loss due to latent heat
Pn	-	loss of power to the evaporant
Pr	-	power lost by heat radiation
Pv	-	power lost by electrons not striking the target
Px	-	loss of power due to X-ray production
POT 、	-	potentiometer
R	-	brightness of the beam
T	-	cathode temperature
٧a		acceleration voltage
da	-	cathode diameter at point (a)
df	-	beam's spot diameter
d _k	-	cathode diameter at k
d _m	-	smallest diameter of the beam
е	-	electron charge of 1.6 x 10 ⁻⁹ coul.
eVo	-	probable thermal energy

- j_F current density of the beam at the target
- j_k current density for beam current (J) at the cathode
- k constant, such as the k^{th} term, also K, as a constant
- kb Boltzman constant
- p power density at the target
- p'_F high power density
- α alpha, space-charge-limited current flow function
- $\boldsymbol{\alpha}_{1}$ aperture at the target
 - gamma, aperture angle of marginal rays between the anode
 - aperture of marginal rays at the position of the smallest beam cross section
- gamma, thickness of the wire probe
- omega, width of the wire probe
- ϕ phi, angle of current signal for computer input
- **π** pi, ≃ 3.14

Ż.

- ho rho, beam target distance from motor-plate to some point on the probe
- $\boldsymbol{\Theta}$ theta, aperture angle of the cathode beam generator

OBJECTIVES

The objective of this study is to investigate the power distribution of the electron beam in order to understand the loss mechanisms associated with the beam-workpiece interation. Another objective of this research is to apply techniques that will yield distribution and profiles of the beam such that power losses may be carefully examined.

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INTRODUCTION

Electron Beam Welder (Sciaky Bros. Inc., Chicago, Illinois)

In an electron beam process, the part is welded by the Kinetic energy of a dense beam of accelerated electrons. As the electrons strike the workpiece, their Kinetic energy is converted to the thermal energy causing the metal to melt and fuse.

The device which emits, accelerates, and focuses the electrons on the workpiece is referred to as the electron beam gun. The gun can be mounted on a carriage to provide several axes of motion, or it can be held stationary while the work is driven, or both the gun and the work can be driven. See Figure 1 below for a simplified illustration.



FIGURE 1 - Illustration of Travel Direction

The gun assembly is housed in a chamber which is pumped down to a fine vacuum level, usually to about 1×10^{-4} torr. or less. By operating in a vacuum the life of the filament (Figure 2) is protected and the electrons can be focused into a fine dense beam. The filament which is heated to a high temperature would be destroyed if exposed to air at the operating temperature. If there were a sufficient concentration of loose molecules in the chamber, the electrons would collide with these molecules. This would cause the beam to be diffused and the electrons to lose some of their Kinetic energy.

In Figure 2, the voltage of the bias allows the beam current to be changed independent of the accelerating potential (within the operating limits of the gun). Irrespective of the bias level, the maximum beam current cannot exceed the maximum current range of the gun. This range is determined by the mating elements installed in the gun. Maximum current is obtained at 0 bias. As the bias is increased, the current is reduced.



The spacing between the filament, cathode, and anode determines the internal resistance of the gun. This resistance is non-linear and varies directly with the distance between these elements. As the distance is increased, the beam current is decreased.

The model E-S9460 gun has 2 major ranges; 250 mA and 500 mA. A mating filament and cathode are provided for each range. In each of these 2 ranges, additional ranges can be obtained by inserting a spacer between the 2 main sections. The same anode is used in both major ranges.

Ranges of Gun E-S9460

Range : 500 mA	Range : 250 mA
Filament: C-K2501	Filament: C-G8615
Cathode : B-K2501	Cathode : B-H844
**Anode : B-M5740	**Anode : B-M5740
For additional ranges use:	For additional ranges use:
350 mA W/0.050" spacer	150 mA W/0.100" spacer
	100 mA W/0.200" spacer
	50 mA W/0.500" spacer

For application requiring shallow penetration with narrow welds at low currents, a small hole cathode is used.

Electron beam welds posses several unique characteristics:

 Welds are produced in many cases 15 to 20 times narrower than comparable TIG/MIG welds. Notice the dotted isothermal lines of typical Tungsten Arc welding compared to Electron Beam welding (Figure 3).







(B) ELECTRON BEAM



**The same cathode is used in both major ranges.

- (2) Less thermal energy is transferred to the unmelted base metal and thus reducing residual stresses, warping, and increasing the strength of the weld.
- (3) Absorption of atmospheric gasses by the weld is eliminated by the vacuum system, thus highly oxidizable materials can be welded (Zirconium, Beryllium, etc.).

POWER RELATIONS

The output power from the electron beam gun follows the general power formula of the form

$$P_{g} = V_{a}I_{e}, \tag{1}$$

where, P_q is the gun power

 V_a is the acceleration voltage

and I is the emission current.

Power, P_d , is lost as the electrons are taken off of the anode. This dissipated power must be subtracted from the gun power.

Since all of the electrons will not reach the welding target the gun power becomes even smaller. The beam focus plays an important role in allowing more electrons to reach the target. Now, the effective power becomes

$$P_{eff} = P_g - P_d - P_e, \qquad (2)$$

where P_{ρ} is the power lost due to electrons not reaching the target.

For certain applications, a low precision gun with a diffused output beam may allow a little more than 50% of the emitted electrons to reach the target [v],

Energy is lost when the electrons collide with system components and target samples. Smith, reference [1], attribute some of this energy loss to:

- excitation and ionization of electrons, by electronelectron interaction, and displacement of atoms with the lattice by energy trnasferred to individual atoms. This occurs at energies of a few-hundred KEV.
- X-ray production by resonance absorption occurs at the high energy range. These losses are minor.
- o inadequate focusing method creating minor loss of electrons from the beam.

- o vapor between the welding sample and gun can cause minor losses due to collisions.
- back scatter of electrons reflected produces the main source of loss (25%).

It is generally safe to assume that the effective power that is converted to heat the sample is

$$P_{eff} = 0.60 P_{q}.$$
 (3)

Note that equation Eq. (3) is approximately the equation for average power. Information on evaporation losses will be presented later in this paper.

The important relationship between beam power and quality of the weld penetration can be obatained for various metals, metal sizes, and welding speeds. A computer routine is available that gives results similar to those shown in Figure 4 (NASA-MSFC).

A summary of the power-energy distribution is given by Hunt and Hughes 2 as the process heat balance:

$$P_{i} = P_{v} + P_{r} + P_{L} + P_{n} + P_{x} + P_{c}, \qquad (4)$$

- where, P_i is the power developed in the electron beam by acceleration to the anode voltage.
 - P_v is the power lost by electrons striking other than the target; e.g., filament-to-anode current (negligible).
 - P_r is the power lost by heat radiation from the liquid evaporant surface (hard to determine).
 - P_L is the power loss due to the latent heat of evaporation for the evaporant (available for most materials).
 - P_n is the loss of power to the evaporant by ionization and secondary electron generation (due to vapor density and electron back-scattering).
 - P_v is the power loss due to production of X-rays (negligible).

P_c is the power loss to the crucible by conduction (very high).

Table I (reference [2]) on page XXVI-15 shows data on power requirements of typical sources evaporating various materials from a 4-inch-diameter water cooled copper crucible, fed from the bottom with rods of evaporant. This data implies that there appears to be an optimum beam density above and below which evaporation rate decreases for a given level of electron beam power at the evaporant surface.

- 2219 Aluminum--Plate Thickness .75 Inches
- 50% Nonconductive Losses--10% to Nailhead
- .08 Inch Root Width



FIGURE 4 - Typical Minicomputer Output on Beam Power and Weld Speed

TABLE 1

•

<u>Material</u>	Power In	Evap. Rate	Specific Power Requirement
Zirconium	72kw	2.57 lb/hr	28.0 kwh/1b
20% Cr S.S.	70kw	9.38 lb/hr	7.5 kwh/1b
Ti-6A1-4V	70kw	5.17 lb/hr	13.5 kwh/1b
Aluminum-Bronze	80kw	8.96 lb/hr	13.1 kwh/1b
Inconel 600	70kw	5.06 lb/hr	13.8 kwh/1b

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TABLE 1 - Power Relations for Evaporation Loss

EQUATIONS OF THE BEAM CURRENT AND POWER DENSITY

When the E.B. gun is operating, its beam current follows the equation [3]

$$I = P V_a^{3/2}$$
 (5)

where, V_a is accelerating voltage and P is the perveance. Schiller, Heisig, and Lenk [3] used the equation below for perveance (P) as well as the following equations including a deviation of the power density (p_f) :

P = perveance =
$$15 \times 10^{-6} \frac{(1 - \cos \theta)}{\alpha^2}$$
, (6)

$$\alpha$$
 = f $\frac{\alpha_{\rm K}}{d_{\rm A}}$, between the cathode diameter

 d_k and the anode bore diameter d_a . The f implies function of.

 is the aperture angle of the cathode beam generator or the convergence angle of marginal rays in the beam generator (See Figure 5).

$$eV_0 = probable thermal energy = k_b T = \frac{1}{11,608} ev$$
, (7)

where,

- V_o is thermic electron potential
- e is the charge of 1.6 x 10^{-19} coul.
- k_b is the Boltgmann constant in $\frac{ev}{deq}$.
- T is the cathode temperature $^{\circ}K$.

A Maxwellian energy distribution is assumed with usual emission temperatures, perhaps 3000°K.

R = brightness of the beam =
$$\frac{J_k V_a}{\pi V_0} = \frac{J_k e V_a}{\pi k_b T_K}$$
, (8)

where,

 \mathbf{j}_{ν} is the current density for beam current (J) at the cathode.

 $p = power density at target = j'_{F} V_{a}$ (9)

where,

 j'_{F} is the current density of the beam at the target and

equals $R\Pi \alpha_1^2$. Here, α_1 is the aperture at the target.

An arrangement of Equations (7), (8), and (9) yields (a high power density p_F)

$$P_{\mathsf{F}} = \frac{\mathbf{j}_{\mathsf{k}}}{\mathbf{V}_{\mathsf{0}}} \, \boldsymbol{\alpha}_{\mathsf{L}}^{2} \cdot \, \mathbf{V}_{\mathsf{a}}^{2}. \tag{10}$$



FIGURE 5 - Cross Section of a Spherical Beam Generation System of Pierce-type (Schematically)

d_k = diameter of cathode

da

Θ

d_m

Ÿ

- = diameter of anode bore
- = aperture angle of the beam generator convergence angle of marginal rays in the beam generator
- $P'_1 P_1 = convergence points$
 - = smallest diameter of the beam consider the intrinsic space charge
 - = aperture of marginal ray at the position of the smallest beam cross section



FIGURE 6 - Reduction of the Current Density Difference Between Center and Margin of an Irradiated Area of Diameter D by an Increased Electron Beam Diameter $d_{\rm E}^{\rm E}$



FIGURE 7 - Creating a Constant Power Density p''(x) on a Length $1 - d_F'$ by Time Linear Deflection of an Electron Beam d_F'' over the Length 1. (The range over which power density decreases to 0.63 p''(x=0) is = d_F')

Reference [3] also used Figures 6 and 7 to show that time-linear deflection is one coordinate results in a power density distribution (deflection $X = \pm .5$) of constant values in certain ranges. Power outside this range decreases and is a power loss. The term d_F is the beam's spot diameter and D is the target diameter (irradiated).

TECHNIQUES FOR MEASURING AND EVALUATING THE ELECTRON BEAM

This section explains the experimental and computer aided approaches used to evaluate the beam configuration.

The initial problem task for this section is that of determining what available method and apparatus to use to take measurements of the beam. The rotating probe (or wire) approach was chosen. This method utilizes a small heat protected motor to turn the wire probe through the beam. The signal obtained on the probe is fed into a storage oscilloscope. Pictures of the signal for various operating conditions of the system are taken from the scope and analyzed. The technique has the following advantages:

- (a) simple
- (b) apparatus available and not refined
- (c) beam current is measured
- (d) beam diameter is obtainable

The wire probe did not obtain appreciable damage from the beam and adequately allowed suitable measurements to take place.

Adjusting the accelerating voltage (thus power output) appears not to change the shape nor the general dimensions of the beam.

The experimental setup used to measure the beam is shown in Figure 8. The oscilloscope was used to monitor and record not only the beam signals but general signals (noise) in the vacuum. During pump down the oscilloscope was triggered by noise signals equivalent to those shown in Figure 9.

Since this electron beam welding machine receives its instructions from a computer controlled system, the sample computer program for a typical set of data inputs is shown on page XXVI-23.

When the beam comes into contact with the rotating wire probe, the electrons that are not backscattered or secondary-emitted are received as the current of the beam (perhaps 50%). The current through the wire has the common variation in magnitude at various angles of emergence. The surface contour of the current is obtained from the electron distribution. Care must be taken in determining the needed current signal configuration and associate information instead of bad data. The collecting wire probe has a symmetrically fixed amount of wire extending from two sides of the plate affixed to the

VACUUM CHAMBER

.



FIGURE 8 - EXPERIMENTAL SETUP






(b) Noise in the E.B. Welder Recorded at 5 Milliseconds Fullscale (above)

FIGURE 9 - Signals Triggering the Scope Due to Noise Present During Pumping of Vacuum Chamber

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TYPICAL DATA RESULTS

ρ = 2.833 INCHES

:

 ω = .048 INCHES

 Γ = .003 INCHES

BF (60 KV) 5.00 FIL 3.50

AV 30 KV

BC 50 MA

THE SAMPLE COMPUTER PROGRAM FOR THE WELDER IS SHOWN BELOW.

	FILE RECORD NASA EB WELDER	
FILE NO. 110	BEAM CROSS SECTION STUDY PROGRAM	PAGE 1
(BEAM CROSS SECT) OVE POT 0 G1APT X0 Y0 F500 FIL350 F20 BF500 F28 AV300 BC50 F20 AV300 BC50 F1000 AV0 BC0 F20	ON STUDY PROGRAM) M0	

A TABLE OF COMPUTER INPUT DATA (Ø,I,ETC...) IS DEVELOPED FROM FIGURE 11 FOR USE ON THE DIGITAL MINICOMPUTER.

rotor of the motor (as was shown in Figure 8). The motor was shielded from the beam and from heat by a thin sheet of metal. The current collected was sent through a load resistor and the output from this load to the oscillo-scope.

In order to adequately measure the beam current, the wire probe dimensions were carefully measured (Figure 10). The beam was also precisely applied to a target area of the probe at a chosen radius from the center of the plate of the motor.

Figure 11 shows the typical current signal and can be plotted versus angle position. With the given beam characteristics or welding operation status, the signal profile is always of a similar shape. To avoid possible aggravation of the signal, it should be saved on the scope as soon as a clear configuration is observed. The scope will automatically trigger to the signal prior to being available for saving the signal. Interferences during signal generation, such as surfaces disturbances not allowing adequate distribution of beam electrons, were considered minor.

Two cases representing the output current signal are in Figures 12 and 13. The first case (Fig. 12) is the peak beam current for two pulse signals. The second case (Fig. 13) is an expanded version of one of the pulse signals distributed with a wider profile. Several sweep time divisions of the scope were investigated for many conditions until satisfactory signals were realized.

The current vs. probe angle was plotted and used as inputs for the computer routine that calculates the current density per unit radius. Additional inputs to the computer included (a) the distance from the center of the plate of the motor to a target point on the wire, (b) the width of the wire probe (receptor), (c) the total beam current, and (d) the number of current-angle data points.

As can be seen from Table 2 (page XXVI-28) and Figures 14 and 15, a current density profile can be obtained. The radial distribution is modulated by a strong periodic error signal of a sort known to arise from small errors (about 0.1%) in data. Work is continuing to obtain current density profiles.

The measurements taken from this experimental setup show that much more beam power is lost than can be explained from measurements taken from the wire probe, unless very large amounts of energy are carried away per secondary emission or backscattered electrons. This justifies the need to continue investigating the evaporation power loss and other power losses accounting for this reduction of total beam power. This phenomenon occurs quite often when samples are being welded. Some information is available on secondary emission losses from a 1974 study conducted at NASA-MSFC.



FIGURE 10 - Wire Probe Characteristics



FIGURE 11 - Typical Beam Current Configuration (actual photo)

...

EXPERIMENTAL RESULTS



FIGURE 12 - Peak Beam Current for Two Pulse Signals



FIGURE 13 - Single Pulse Signal Distributed

THE CHARACTERISTICS OF THE TUNGSTEN WIRE ARE

.

- $\rho, \ \ \,$ THE DISTANCE FROM THE CENTER OF THE MOTOR PLATE TO A TARGET POINT ON THE WIRE
- ω , THE WIDTH OF THE WIRE
- Γ, THE THICKNESS OF THE WIRE

THE E.B. WELDER WAS COMPUTER CONTROL FOR AN OPERATION STATUS FOR VALUES OF

BF, BEAM FOCUS

- FIL, FILAMENT SETTING
- AV, ACCELERATING VOLTAGE BC, BEAM CURRENT

TYPICAL DATA RESULTS ARE SHOWN ON THE NEXT PAGE.

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TABLE 2

ANGLE	CURRENT	RADIUS	CURRENT DENSITY
(DEG)	(MA)	(IN)	(AMPS/SQ IN)
.017	26.32	8.40541E-04	-832.032
.031	28.15	1.53275E-03	1153.54
.053	28.97	2.62051E-03	-571.086
.074	31.79	3.65883E-03	301.177
.093	33.61	4.59827E-03	.0935703
.11	35.43	5.43882E-03	214.231
.134	37.25	6.62548E-03	-3.99142
.154	39.08	7.61436E-03	104.89
.178	40.89	8.80103E-03	75.7133
.211	42.72	.0104327	66.7768
.248	44.54	.0122622	-57.2598
.266	46.36	.0131522	246.266
.327	48.18	.0161683	6.38338
.386	50	.0198856	45.3961

Ratio of Total Current Calculated to Total Beam Current.

TABLE 2 - Digital Computer Results on Current Density





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FIGURE 15: Radial Current Distribution (profile)

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CONCLUSIONS

At the present time we are able to capture by experimental techniques the current configuration for an electron beam. The computer routines allow us to theoretically determine the beam characteristics on the workpiece for a given power profile. Techniques developed and described in this report can be valuable for gathering information needed to assess the nature of weld power losses.

Future work should be done in order to relate accurately the total beam characteristics and power distribution to weld geometry. However, we have successfully completed the experimental task of obtaining the signal configuration which determines the cross sectional power distribution in the electron beam.

The results of Figures 11 and 13 compare with those obtained by Sayegh and Dumonte $\begin{bmatrix} 4 \end{bmatrix} \begin{bmatrix} 5 \end{bmatrix}$.

An analysis for obtaining the radial current density and the profiles in Figures 14 and 15 is available but small errors in data (or deviations from a radial distribution) apparently cause strong periodic error modulations in the radial distribution.

RECOMMENDATIONS

1. Techniques for obtaining more information on electron reflection should be investigated.

2. Controlled use of the welding system such that the time wasted in equipment venting and pump down is minimized.

3. Advanced studies should be done on the trajectories of the beam (both gaussian and nongaussian type).

4. Curvilinear distribution analyses should be considered for further study.

5. Relate the diameter of the beam and the power distribution on a welding sample in items 3 and 4 above.

6. Determine if the target surfaces cause any disturbance in the distribution of the beam's electrons on the wire probe.

7. Determine the optimum setting for the E.B. welder in order to obtain the optimum power density profile.

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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

MEASUREMENT OF VELOCITY FIELDS IN FLUID DYNAMICS EXPERIMENTS

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XXVII.1

MEASUREMENT OF VELOCITY FIELDS IN FLUID DYNAMICS EXPERIMENTS

by

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ABSTRACT

In many fluid dynamics experiments in which the motion has both spatial and temporal variations, it is necessary to measure the entire two-dimensional field of velocity at an instant. Two methods to accomplish this measurement have been investigated. In both cases the emphasis has been on using a microcomputer-video system in the analysis of data. The first method is the traditional one in which tracers are introduced into the fluid and their position compared at two closely spaced times. The second method involves scattering coherent light in the fluid and obtaining motion by analyzing the multipleexposed speckle pattern recorded on photographic film. Both of these velocity field methods can be used in the geophysical fluid flow and space processing experiments in progress at NASA.

1. Introduction

In many fluid dynamics experiments both spatial and temporal variations of the flow patterns are important. This is particularly true in experiments modelling geophysical flows and in space-processing experiments, both in progress at NASA. With conventional instrumentation the experimentalist must rely on the use of fine wire probes, laser-Doppler measurements, or other similar techniques that are all limited to a single point in space. It is possible to move the measuring point around in the fluid, but the technique is never satisfactory when there are significant time variations in the flow field.

Streak photography has often been used in such cases, i.e., taking photographs of the displacement of tracers in the velocity field. Data analysis is quite cumbersome, however, whenever there is much variation in the flow field, or when a dense coverage of data points is required.

It is the goal of this summer's research to investigate a promising alternative to conventional velocity field measurement. The technique to be investigated will be termed light-speckle techniques, and all are closely related to streak photography. The key in each case is that the tracers and time intervals are chosen so that optical correlation techniques can be used to recover velocities from the data.

2. Light-Speckle Velocity Field Measurement

Although there are several variations in details, these techniques are all basically the same. Light from scatterers that move with the fluid is recorded at closely-spaced time intervals on photographic film. The optical pattern from the first instant is slightly changed by the fluid motion at succeeding time intervals. Thus, when the multiple-exposed negative is interrogated by a narrow beam of coherent light, the correlation between patterns recorded at succeeding times is indicated by a pattern of regular fringes. The spacing of the fringes tells the amount of displacement, i.e., the time interval and the orientation of the fringes tells the direction of displacement. Thus, by illuminating the fluid with a thin sheet of light and viewing it at a right angle to the plane of illumination, an entire two-dimensional field of velocity can be obtained at an instant.

2.1 Generating the Optical Pattern

The optical pattern that is to be displaced by the fluid can be generated either by using the coherent nature of laser light with very small scatterers, or with white light and larger scatterers. The former method has been used by Simpkins and Dudderer (1978) and is based on the fact that laser light appears grainy The grainy when diffusely reflected off a surface. appearance is caused by constructive and destructive interference of coherent light scattered off roughness elements the same size as the wavelength. These "objective speckles" are a function of the size of the scatterers, while the "subjective speckles" seen by the observer or recorded on film are dependent on the aperture size of the lens through which they are viewed. When the displacement of the recorded subjective speckles due to fluid motion is between one and twenty speckle diameters the correlation will yield a good fringe pattern. The fringes will also be enhanced if more than two optical patterns are recorded on the same negative.

A useable optical pattern can also be obtained by using larger scatterers illuminated by white light (Chiang and Asundi, 1979), or by a laser (Meynart, 1980). In the latter case the spatial coherence of the laser light is used only to obtain a thin light sheet of high power density. Again, multiple exposures increase the visibility of the fringe.

2.2 Interrogating the Negative

Once the multiple-exposed negative has been obtained, there are two methods to recover the velocity field. Illuminating the negative point-by-point with a small coherent beam yields fringes that come from a small portion of the flow field where the velocity was constant. The negative is thus interrogated at each point in the field that the velocity is required.

A whole-field method of analysis can be obtained by illuminating the entire negative and using a spatial filtering setup (see Meynart, 1979) that consists of two lenses (Fourier transformers) and an off-axis pinhole

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(spatial filter). The result is the whole velocity field described in isolines of the component of velocity depending on the orientation of the spatial filtering hole.

There are advantages to both these interrogation methods. The first yields results that are more precise, with the limits of precision depending on the quality of the fringes that are obtained. The wholefield method is simpler and much quicker.

3. Use of Microcomputer in Analysis

In order to speed up analysis to make possible the evaluation of fast-changing geophysical and spaceprocessing fluid flows, it is desirable to automate the data analysis as much as possible. Using a microcomputer-TV system it should be possible to accomplish the point-by-point interrogation of the multipleexposed negatives automatically. The microcomputer will be programmed to count the fringes, determine orientation, and then move the film transport on to the next position. In addition, the TV system can determine velocity by simply subtracting successive positions of large scatterers to serve as a check on the velocities obtained using the speckle techniques.

4. Planned Work and Work Accomplished to Date

At this writing the experimental work is just getting into progress. Multiple exposures have been taken in a small water flume and thermal convection cells illuminated by a 1 watt CW argon laser. The pulse repetition rate and flow rate have been varied to determine optimum conditions for obtaining good fringes.

In addition considerable program development work has been accomplished on the TV-microcomputer system. Picture enhancement and pattern recognition programs have been written and debugged, so that they can be put together to measure fringes and track individual scatterers.

5. Conclusions

The light-speckle velocity field techniques described above offer tremendous possibilities toward the understanding of geophysical and space-processing fluid flow experiments. The ability to obtain an entire two-dimensional velocity field at an instant makes these techniques extremely powerful. The experiments and computer program development in progress should demonstrate the utility of these lightspeckle techniques.

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM MARSHALL FLIGHT CENTER THE UNIVERSITY OF ALABAMA

ON THE CONTROL AND STABILITY OF THE PINHOLE-OCCULTER FLEXIBLE BOOM FACILITY

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ON THE CONTROL AND STABILITY OF THE PINHOLE-OCCULTER FLEXIBLE BOOM FACILITY

By

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Abstract

The dynamics and control of the Shuttle based, gimbal mounted, boom pointing system for use in the x-ray pinhole experiments were studied. The overall system stability was studied, and root locus compensation was designed to achieve stability and pointing stability requirements. This single axis control study found the compensated system to be stable and capable of pointing to within 6.5 arc sec while the Shuttle rocks in its 0.1° deadband. The system can follow step (position) inputs with zero error and ramp (velocity) inputs with a steady state error coefficient of 4.5 sec^{-1} .

Introduction

The pinhole-occulter system is a Space Shuttle based experiment for the production of hard X-ray images taken primarily from the Sun. The system is basically a pinhole camera utilizing a deployable 50-m flexible boom for separating the pinhole from the recording devices located in the Shuttle as seen in Figure 1. At the distal end of the boom from the Shuttle is a 50 kg mask containing two sets of pinholes and two chronograph shields as seen in Figure 2. At the proximal end the detectors are located and mounted, along with the boom, to a gimbal pointing system (either IPS or AGS) mounted in the Shuttle Payload Bay.

The mask of Figure 2 must be pointed at the X-ray source with a pointing stability of less than 10 arc sec to align the axes of the detectors with the pinholes and shields. Failure to do so will result in a blurring of the images on the detectors and a loss of resolution. Being a Shuttle based experiment, the system will be subjected to the disturbances of the Shuttle. The worst of these is thruster firing for orbit correction; Shuttle uses a bang-bang thruster control system to maintain orbit to within $\pm 0.1^{\circ}$. Other disturbances include man motion, motion induced by other systems, and gravity gradient torques.

The control system of the pointing mount senses both position and velocity of the mask tip and uses these to accurately point the boom. The AGS employing perfect sensors was used in this study of the single axis (y-axis) control system. The extension of this study to a three-axis system will be the topic of a later study.

Background

The structural analysis of the boom [1,2,3] revealed the seven mode shapes and natural frequencies shown in Table 1. These natural frequencies varied with both boom length and tip mass as seen in Figure 3. For a 50-m boom with a 50 kg tip mass, the first two natural frequencies are 1 rad/sec for deflections about the x and y axes, respectively. The third natural frequency is 17.1 rad/sec for z axis motion. For x and y motions the next two natural frequencies are 17.4 rad/sec and 59.9 rad/sec, respectively.

For y-axis control (torques about y-axis), the equations of motion for the boom, assuming a damping factor of 10 percent, are [1]:

$$\dot{\eta}_1 + .2 \dot{\eta}_1 + \eta_1 = -3687.93 \dot{\theta}_2$$
 (1)

$$\dot{\eta}_2 + .2 \dot{\eta}_2 + \eta_2 = 0 \tag{2}$$

.

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$$\dot{\eta}_3 + 3.42 \dot{\eta}_3 + 292.4 \eta_3 = -.018396 \theta_2$$
 (3)

$$\dot{\eta}_4 + 3.46 \dot{\eta}_4 + 300 \eta_4 = 1250.734 \theta_2$$
 (4)

$$\dot{\eta}_{5}^{*} + 3.46 \, \dot{\eta}_{5}^{*} + 300 \, \eta_{5}^{*} = 0 \tag{5}$$

$$\dot{\eta}_{6}^{*} + 11 \dot{\eta}_{6}^{*} + 3014 \eta_{6}^{*} = 52.3905 \theta_{2}^{*}$$
 (6)

$$\dot{\eta}_{7} + 11 \dot{\eta}_{7} + 3014 \eta_{7} = 0$$
 (7)

$$\theta_{\rm TIP} = 2.895 \times 10^{-4} \eta_1 - 8 \times 10^{-10} \eta_3 + 5.31 \times 10^{-5} \eta_4$$
$$- 3 \times 10^{-5} \eta_6 + \theta_2 \qquad (8)$$

Taking the Laplace transform of equations (1) through (7) and inserting into equation (7), we obtain:

$$\theta_{\text{TIP}}(S) = \left[\frac{-1.07S^2}{S^2 + .2S + 1} + \frac{1.5 \times 10^{-11} S^2}{S^2 + 3.42 S + 292.4} + \frac{.07S^2}{S^2 + 3.465 + 300} + \frac{1.57 \times 10^{-3} S^2}{5^2 + 11S + 3014} + 1\right] \theta_2(S) \quad .$$
(9)

Ignoring terms 2 and 4 and reducing, the ratio of input motion to output motion for the boom is obtained:

$$\frac{\theta_{\text{TIP}}(S)}{\theta_2(S)} = \frac{-.07 (S^2 - 2.865 - 14.28)}{S^2 + .2S + 1} + \frac{.07S^2}{S^2 + 3.48S + 300}$$
(10)
$$= \frac{-.0289 (S^3 + 688.17S^2 - 2194.12S^1 - 10380.62)}{S^4 + 3.67S^3 + 301.69S^2 + 63.47S^1 + 300}$$
(11)

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In its factored form, this transfer function for the boom is:

$$G_{\rm B}(S) = \frac{-.0289 (S + 2.63) (S - 5.88) (S + 671)}{(S^2 + .2S + 1) (S^2 + 3.46S + 300)} = \frac{N_{\rm B}(S)}{D_{\rm B}(S)} \quad .$$
(12)

The block diagram for the system is shown in Figure 4. The pointing mount uses a position plus integral control with a velocity feedforward [4]. For the sake of clarity, the velocity feedforward will be considered separately from the forward transfer function of the Gimbal Pointing System which is:

$$G_{G}(S) = \frac{K_{p}(S + 1.2)}{S}$$
 (13)

The velocity feedforward and the boom comprise a loop which can be reduced to a new forward transfer function, $G_{BS}(S)$, to treat the system as a unity feedback system as seen in Figure 5. The new forward transfer function is given by:

$$G_{BS}(S) = \frac{G_B(S)}{1 + K_R S G_B(S)} = \frac{N_B(S)/D_B(S)}{1 + K_R S N_B(S)/D_B(S)}$$
(14)

$$G_{BS}(S) = \frac{N_B(S)}{D_B(S) + K_R S N_B(S)}$$
(15)

From equation (15) we can see that the open loop eigenvalues can be arbitrarily set by adjustment of the rate gain, K_R . The closed loop eigenvalues will then be set by means of the compensator, $G_C(S)$, and the forward gain, K_P .

Results

The open loop eigenvalues were set by adjustment of the rate feedforward gain, K_R . The plot of these roots (eigenvalues) as K_R is increased from zero is shown in Figure 6. At a gain between 0.1 and 0.2, the system goes unstable. At a gain of 0.07 the open loop roots are:

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$$S_{1,2} = -.14 \pm j.98$$

änd,

$$S_{3,4} = -1.23 \pm j 17.38$$
.

Yielding the new transfer function:

$$G_{BS}(S) = \frac{-.02896 (S + 2.63) (S - 5.88) (S + 671)}{(S^2 + 28S + .99) (S^2 + 2.46S + 303)}$$
(16)

The major result of this rate compensation (which is built into the pointing mount) is to increase the damping ratio of the first quadratic root and decrease the damping of the second. This gives the basic system transfer function:

$$G_{SYS}(S) = \frac{K^{1} (S + 1.2) (S + 2.63) (S - 5.88) (S + 671)}{S (S^{2} + .28S + .99) (S^{2} + 2.46S + 303)}$$
(17)

Setting $G_c(S) = 1$, we can again plot the root locus for the system as K^1 is varied ($K^1 = -.02896 K_p$). This plot is shown in Figure 7. At a gain between -0.2 and -0.03 the system goes unstable and oscillates; the system is unstable for all values of positive gain. At a gain of -0.2 the dominate roots have a time constant of about 8 seconds and would be extremely underdamped with $\xi = 0.01$ ($S_{1,2} = -0.13 \pm j$ 12.3). This is not acceptable; compensation is required.

The compensation chosen was:

$$G_{c}(S) = \frac{(S^{2} + 2.46S + 303)(S + 2)}{(S + 671)(S + 10)^{2}}$$
(18)

This compensator cancels the open loop roots at $s = -1.23 \pm j$ 17.38 and the zero at S = -671. If the compensator does not cancel the complex roots exactly it is better to undersize the real part of the compensator roots than oversize them. The response will contain terms of Ae^{-1.23} COS (17.38t + ϕ) but A will be extremely small due to the proximity of the zeroes to these roots.

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The basic idea of the compensation is to cause the roots nearest the imaginary axis (first mode) to move to the left as gain is increased while higher order modes (roots) move to the right. This allows for a high value of the gain which produces low steady state ramp errors and a wide passband. Ideally a type 2 system is desired but due to the zero in the right half s-plane, this is impossible.

Using the compensator of equation (18), a new G_{total} is obtained:

$$G_{\text{total}}(S) = \frac{K^{1} (S + 1.2) (S + 2) (S + 2.6) (S - 5.88)}{S (S^{2} + .28S + .99) (S + 10)^{2}} = \frac{K^{1}N(S)}{D(S)}$$
(19)

With unity feedback, the closed loop control ratio is:

$$\frac{C}{R} = \frac{G}{1+G} = \frac{K^{1} N(S) / D(S)}{1 + K^{1} N(S) / D(S)}$$
(20)

which reduces to

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$$\frac{C(S)}{R(S)} = \frac{K^{1} N(S)}{D(S) + K^{1} N(S)}$$
(21)

The plot of the closed loop roots is seen in Figure 8. At a gain of approximately -16, system becomes unstable. At a gian of -12, the dominant root is S = -0.75 and the ramp error coefficients is $K_1 = 4.5 \text{ sec}^{-1}$. For a ramp input of 0.01°, the steady state error for the system would be 8 arc sec.

The error response of the system to the Shuttle's thruster firing and drift due to gravity gradient is seen in Figure 9. The peak error response is 3.6 arc sec as the Shuttle drifts through its limit cycle and 6.5 arc sec when one thruster is firing. The maximum gimbal torque required to oppose the thruster acceleration is 17.9 NT-m while the maximum torque during drift is 8.3 NT-m.

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The step response of the system to a 1° step is shown in Figure 10. Within 5 sec of the step, the tip angle is within 104 percent of steady state. The peak overshoot is 42 percent occurring at 7 sec. The response is within ± 1 percent of steady state within 16 sec. Steady state error to step commands is zero. The torque required at the gimbal motors for this response exceeds the rated 33 NT-m during the first 12 sec. The torque required to initially accelerate the boom is up to 182 NT-m/degree. This limits step commands to less than 0.18 degree.

The frequency responses for the boom and rate compensated boom are seen in Figure 11. The responses of the fixed boom is a series of single order zeroes and quadratic poles starting at 1 radian/sec (.16 Hz). The boom is itself stable having an 18 dB gain margin and a 35° phase margin. The effect of the gimbal system rate compensation is to increase the damping ratio of the first mode and decrease the damping of the second. At a $K_n = 0.07$, stability is unaffected.

The frequency response of the gimbal mounted boom system is shown in Figure 12 for a gain of 16. At this gain, the system is unstable having a gain margin of -50 dB. And a phase margin of nearly -90° . For a stable system, the gain would have to be reduced drastically and would yield a slow, low bandpass system with high ramp following errors.

The frequency response of the compensated system is shown in Figure 13 for a gain of 16. At this value of gain, the system is just unstable with both a phase margin and a gain margin of zero. Reducing the gain of 2.4 dB to a gain of 12, the system becomes stable and has the closed loop frequency response of Figure 14. The system bandpass is 2.5 Hz and it will follow up to 0.2 Hz signal without error or phase shift. This is the basic reason the system can tolerate the drift of the Shuttle in its deadband and the firing of one thruster. The drift of the Shuttle is very nearly a 0.01 Hz signal while the turnaround at the deadband is like a 1 Hz signal. The system response to thruster firing is not frequency (dynamics) limited but torque limited by the gimbal motors.

Conclusions and Recommendations

As compensated, the gimbal mounted boom system is stable with fast dynamics and low following errors. The system is relatively unaffected by the drift of the Shuttle in its deadband and by one thruster firing (maximum error 6.5 arc sec). The system is limited by the torque produced by the gimbal motors not by dynamics.

This study only considered motions about the y-axis, not x-axis or z. Motion about the x-axis should be very similar to that of the yaxis except modes shapes 2 and 5 would predominate. The control system for x-axis should be nearly identical to that of the y-axis. Motion about the z-axis is twisting motion of primary the third mode (see Table 1). This control system should be much simpler than either x or y control. This study assumed perfect motion detectors for the feedback loops. Good detectors [6] are available for x, y, and z motions but their sensitivities and accuracies and sensitivities need to be added to the control simulation as disturbance.

The dynamic as well as probabilistic characteristics of each of these disturbances as well as man motion need to be characterized and incorporated into the control model to determine the pointing accuracies and pointing stability of the gimbal mounted boom. Future work should include a stochastic analysis of the control system concerning probabilistic disturbances and the minimization of their effects on pointing stability. The results of such a study would be a three-axis model of the system compensated for stability as well as compensated for disturbance induced pointing variations.

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L = 50 METERS, TIP MASS = 505.7 KG		
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TABLE 1. PINHOLE BOOM FREQUENCIES AND MODE SHAPES

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CONFIGURATION



Figure 2. Pinhole occulter facility configuration.

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Figure 5. Reduced block diagram of pinhole control system.

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Figure 9. Error response of boom tip to thruster firing and gravity gradients.



NDRMALIZED DUTPUT





Figure 12. Frequency response of the uncompensated gimbal driven boom system.



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1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

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FFT METHODS IN SIGNAL PROCESSING OF THE COAL INTERFACE DETECTOR RADAR

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(Laboratory) (Division) (Branch) MSFC Counterpart: Date: Contract No.: Communications & Tracking Billy R. Reed August 1, 1980 NGT-01-002-099 (University of Alabama)

Engineering

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FFT METHODS IN SIGNAL PROCESSING OF THE COAL INTERFACE DETECTOR RADAR

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ABSTRACT

The FM radar for the coal interface detector, operating in the frequency band 2 to 4 GHz, is intended for the display of thicknesses between 2 cm and 20 cm. Because of such a short range, the thickness information is contained in the very few lowest spectral components of the output signal. To overcome this inconvenience, the Fourier series of the output signal has been augmented to approximate a Fourier integral. This modification in the signal processing resulted in a higher spectral density, which in turn enabled an easier identification of the interface position in the laboratory. The orientation and spacing of the receiving and transmitting antennas is found to have an important influence on the system performance. A field test in the coal mine is planned in the future.

ACKNOWLEDGEMENTS

I appreciate the opportunity of continuing the work on the challenging problem of the CID radar during my second year of NASA/ASEE Summer Faculty Research Fellowship Program. My NASA counterpart, Mr. Billy R. Reed provided an excellent support in all aspects of the project. Mr. Ivan A. Burroughs was very helpful in programming of the signal processing procedure, and Mr. Edmund H. Gleason provided the expertise in the selection and utilization of the various electronic instruments and subsystems. The typing of the report was performed by Joyce Gray.

INTRODUCTION

Coal interface detector (CID) radar is designed to measure the thickness of the coal layer in the longwall mining method. The frequency of the radar transmitter is modulated in a saw tooth fashion between 2 and 4 GHz. The thickness of the coal layer is measured by observing the frequency difference between the signals reflected from the front and rear surface of the coal. The radar output signal, which contains this difference frequency, is analyzed on a digital Fourier Analyzer, which then provides a display of the reflection amplitude vs. the coal thickness.

The basic principle of the CID radar has been under investigation at the MSFC for several years. The difficulty in implementing the radar lies in the presence of a multitude of erroneous signals, which can be misinterpreted as the rear surface return signals. Also, the frequency of the reflected signal is only several times (<10) higher than the modulation frequency. Therefore, it is difficult to determine which of the individual spectral components belongs to the position of the rear surface.

The presence of the multiple reflections may be somewhat reduced by using long cable sections between the individual components of the system, and by placing absorbing materials around the antennas. The second difficulty of distinguishing between the inidvidual components in the spectrum can be greatly reduced by processing the time-domain signal before taking the Fast Fourier Transform. Examples of measured wave-forms and their spectra are included in the report.

OBJECTIVES

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This report describes the work performed in the second period of the NASA/ASEE Summer Faculty Research Fellowship Program. The radar configuration is somewhat different from the one described in the last year's report (Reference (1)). The difference lies in the fact that a direct detector receiver has been utilized instead of the mixer-type receiver. The objective of the investigation described in the present report is to achieve the radar configuration which is suitable for application not only in the laboratory, but in the actual coal mine situation. Much of the effort is directed toward determining the most suitable signal processing procedure which produces a clear display of the coal thickness.



Fig. 1. Block diagram of the CID radar using the detector receiver

The transmitting part of the CID radar in Fig. 1 consists of the Hewlett Packard Function Generator Model 3312, the Wiltron Sweep Generator Model 610, the Avantek Transistor Amplifier Model 406-3M, and the Scientific Atlanta Ridged Horn Antenna Model 40M-2.0. The length of the coaxial cable between the amplifier and the antenna is $\mathcal{L}_{i} = |\mathbf{m}|$. The receiving part of the radar consists of an identical antenna, as in the transmitting part, and a Narda Detector Mount Model 4503. The detected signal is amplified and filtered in the Ithaco Dual Filter Model 4302. The filter is set for pulse operation (Bessel type response) in the lowpass mode.

The operating data are as follows:

Frequency range of the sweep oscillator -----2 to 4 GHz. Sweep period----- T = 25.6 ms RF power delivered to transmitting antenna-----138 mW Lowpass filter cutoff frequency ------3.15 KHz (two sections in cascade, each with 10 dB gain) Distance between the antenna and the coal -----1 = 60 cm

As indicated in Fig. 1, the received signal consists of two parts: One part comes from the wave which was reflected from the front surface of the coal, and the other part is a weaker signal from the wave which penetrated the coal and was then reflected from the rear interface. If the coal dielectric constant is denoted by \pounds r the sweep period by T, the coal layer thickness by d, and the RF deviation by B, the frequency difference between the front and rear reflection is

$$f_a = \frac{4Bd\sqrt{\mathcal{E}_r}}{cT}$$
(1)

c is the velocity of light in free space. For the data listed above, a coal layer of thickness d =6" (15.24 cm) and the dielectric constant of $\mathcal{E}r=5$ would produce a difference frequency approximately 355 Hz.

When such a mixture of the two microwave signals is applied to the square law detector, their difference frequency (here 355Hz) is obtained. This signal is interrupted by the repetition rate of the sweep generator. It is afterwards amplfied and filtered before being delivered to the Fourier Analyzer Hewlett Packard Model 5451B, which performs the signal processing and displays the result.

The radar system described above is similar in concept to the radar described in Reference (2). The main difference of the present system is the use of a direct detector system instead of the heterodyning receiver, and the use of a digital signal processing system instead of an analog one.

SIGNAL PROCESSING

The tests in the laboratory are performed on slabs of "artificial coal". These are slabs of different thicknesses, made from a mixture of dielectric and conducting materials, so that the dielectric constant and the loss tangent approximate the values of the actual coal from the mine. In the particular measurement to be described, the slab thickness 15.5 cm (6") and of the cross section 61x61 cm (2'x2') was backed by an aluminum foil for better rear surface reflection. The received signal at the input to the Fourier Analyzer is shown in Fig. 2.

The observed signal is periodic with the period T= 25.6 ms. The sawtooth waveform which modulates the transmitter is shown in Fig. 3. The characteristics of the transmitter are such that the modulation voltage 2.4 V produces an output of 2 GHz and 4.8 V produces an output frequency of 4 GHz. It is seen from Figures 2 and 3 that the detected signal displays an even symmetry within each half period. This is to be expected, because the transmitted frequency attains the same value twice within each period ; once on the upswing, and once on the downswing of the modulation signal.

The signal shown in Fig. 2 has been sampled with the time intervals 50 μ s, the total number of sample points being 1024. The waveform shown includes two full periods of the signal. If now only one period is retained (first 512 points) and the Fast Fourier Transform of this waveform is computed, the resulting spectrum is such as shown in Fig. 4. Each spectral component makes one point in the plot. Due to an automatic plotting procedure, the points are interconnected by straight lines, creating the appearance of a continuous spectrum. The spectrum actually consists of discrete frequencies, separated from each other. by the repetition frequency 39 Hz. According to (1), the beat frequency for the 6" artificial coal is 355 Hz. From Fig. 4 it can be seen that the two longest spectral components are components number one and number eight. Thus, by neglecting the first component which belongs to the repetition frequency, the frequency of the return signal is estimated to be eight times the repetition frequency, or 312 Hz (instead of 355 Hz).

There are several inconveniences associated with the display such as in Fig. 4. In the first place, the repetition frequency usually comes out to be the strongest component, which fact makes it difficult to read the thickness of the thin coal layers, where spectral components are very close to the repetition frequency. Furthermore, the components **immediately** next to the observed return frequency often have a small amplitude, so that the signal is not always readily identifyable as in Fig. 4, where the seventh, eighth, and ninth spectral components are all large. It was decided that a difficulty in locating the return signal is caused by the fact that the spectral components are too far apart



FIG. 3 MODULATION SIGNAL AT THE OUTPUT OF THE FUNCTION GENERATOR

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from each other. In order to create a more densely populated spectrum, advantage has been taken of the digital signal processing in the following manner.

The original sampled signal from Fig. 2 consists of 1024 points. The sample extends over two periods, each period has a half-period symmetry. Therefore, the basic information is contained within 256 points. Thus, a time window is created, of the length 256 sample intervals, as shown in Fig. 5. This is the so-called Hann window (3) of the shape 1 -COS x. When the sampled signal is multiplied with the window, the result looks very much like a single burst of oscillations shown in Fig. 6. The total sample length is still 1024 points, but 75% of the sample points are forced to be zero. The Fast Fourier Transform performed on these 1024 sample points will have much larger spectral dnesity from the spectrum in Fig. 4, and thus will allow more accurate reading of the coal thickness.

Before the spectrum is displayed, another operation is performed. The radar return signal is redundant in the sense that the half period which corresponds to the modulation upswing is a mirror image of the other half period which corresponds to the modulation downswing. Therefore, another Hann window is created, shifted for 256 points. Again the sampled signal is multiplied with this second window, and the Fast Fourier Transform is completed. The resulting spectrum is then multiplied with the previously evaluated spectrum. The procedure is equivalent to taking the convolution of the two half periods in the time domain. This insures that the information contained in each half period contributes equally to the final result. The amplitude of the resulting spectrum is then displayed in a logarithmic scale, as shown in Fig. 7.

The spectrum in Fig. 7 is dense enough for each strong spectral component to be easily identified. When comparing this spectrum with the one in Fig. 4, it is noticed that now the return signal has the largest amplitude, and is thus easily recognized. It appears that the amplitude of this return is about 20 dB larger than other spectral components on either side. However, it should be remembered that the spectrum in Fig. 7 has been obtained by multiplying the two spectra emanating from each of the two half periods, so that the resulting product is made of the squared amplitudes.

Because of this, the number of decibels in Fig. 7 must be divided by two, so that the actual difference between the largest lobe and the next largest lobe is only about 10 dB, and not 20 dB.

The frequency corresponding to the rear surface reflection in Fig. 7 is 310 Hz, instead of the predicted value 355 Hz. The discrepancy may have been caused by an inaccurate knowledge of the frequency deviation B and the dielectric constant \mathcal{E}_r which both enter into equation(1).







FIG. 7 FOURIER TRANSFORM DISPLAY

When a sinusoidal signal is interrupted by the square pulses, the specturm of such a modulated signal contains not only the carrier frequency, but also a number of sidelobes which are decreasing in amplitude according to sin x/x function. The first sidelobe of this function is 13.5 dB smaller than the maximum. The radar return signal is switched each time the modulation waveform changes its slope. Therefore, the observed spectrum will contain considerable sidelobes on each side of the carrier frequency (355 Hz in the example discussed above. These sidelobes may be misinterpreted as apparent radar returns. One way of reducing these sidelobes is to use the Hann window, such as shown in Fig. 5. The sidelobes of the sinusoidal signal modulated with the Hann window are 37 dB smaller than the maximum. This is the reason that the sampled signal in Fig. 6 has been multiplied by the Hann window.

One unavoidable consequence of reducing the sidelobes by using the Hann window is the doubling of the spectral width of the main lobe, when compared with the rectangular window (4) should two close surfaces be distinguished in the radar display, their difference in frequency should be at least half width of the main lobe. For the sinusoidal signal multiplied with the Hann window, the first zero appears at double the value of the sin x/x function:

$$\widehat{T} \Delta f \frac{T}{2} = 2 \widehat{I}$$

The frequency difference between the main lobe maximum and the first zero is

$$\Delta f = \frac{4}{T} \tag{2}$$

If two signals are reflected from two very closely located surfaces their frequencies may differ for less than Δf , and cannot be distinguished on the display. Substituting (2) into (1), we find the minimum resolution distance between the two reflections in the coal

$$d_{\text{res}} = \frac{2c}{B\sqrt{\epsilon_r}} \tag{3}$$

The resolution distance is independent of the repetition frequency. The only way to obtain a finer resolution is to increase the frequency deviation For the system with B = 2 GHz, the resolution distance is $d_{res} = 6.7$ cm. When two reflection surfaces are dloser to each other than d_{res} , their main spectral lobes will merge into a single lobe, and the two returns will not be distinguishable on the radar display. One way to reduce the resolution distance is to use the rectangular window instead of the Hann window. This would split the resolution distance in half at the expense of increasing the sidelobes. It follows from the previous discussion that large sidelobes are undesirable. Therefore, the fact that the frequency deviation of the radar is 2 GHz sets on a priori limit of 6.7 cm as the smallest recognizable coal thickness (3.3 cm with the rectangular window).

ANTENNA CONSIDERATIONS

Little is known about the design of microwave antennas suitable for sensing the material properties in close range. The majority of microwave antennas are designed to produce a given electromagnetic radiation in the far field region. In the early experiments with the CID radar, the transmitting and receiving antennas have sometimes been placed less than one wavelength apart from each other or from the coal interface. It has been empirically found afterwards that these distances must be increased to several wavelengths.

One important property of the antenna to be used for the CID radar is low dispersion. The time delay for the signal, to pass from the antenna terminal to an obstacle in front of the antenna and back to the terminal, should be independent of frequency. One of the popular wideband antennas, the log periodic array, is ill suited for the task, as pointed out in [2].

Another important property of the pair of antennas to be used in the radar is a high decoupling when they are placed side by side. By looking at Figurel, it becomes obvious that a direct propagation from the transmitting to the receiving antenna creates a third wave impinging upon the detector. The difference frequency of that wave and the front surface reflection may produce an erroneous "return" signal on the radar display.

Without making any theoretical investigation, and without even comparing the performance of various commercially available antennas, the pair of ridged horn antennas has been assigned to do the job. The orientation and the distance between them has been experimentally adjusted to give the best performance as follows.

Figure 8 depicts two possible relative positions of the receiving and transmitting antennas, denoted parallel and collinear. It has been found experimentally that the collinear orientation offers higher isolation between the antennas. The distance D has also been varied, and the value D=25 cm appears to be sufficient. The measurement has been conducted when the antenna-to-coal distance is $l_{a1} = l_{a2} = 60$ cm.

Another unexpected critical adjustment proved to be the angle 0 in figure 9. This angle measures the departure of the coal surface from making a right angle with the antenna system. It has been found experimentally that the return signal from the rear surface drops considerably when the difference $l_{al} - l_{a2}$ becomes larger than 2 cm. For D = 24 cm and b = 10 cm, this implies that the angle between the coal surface and the antenna boresight should not depart from the right angle for more than $\theta = 3.3$ degrees.



Fig. 8. POLARIZATION OF ANTENNAS: (a) PARA LLEL (b) COLLINEAR



FIG. 9. INCLINATION OF THE COAL SURFACE WITH RESPECT TO THE ANTENNA SYSTEM

CONCLUSIONS

The CID radar system which has been developed has certain advantages over the previously utilized systems. The digital processing of the signal on a Fourier Analyzer System enables more convenient display which seems to improve the separation between the actual return and other unintentionally created signals. When also proper care is exercised in antenna positioning, the system seems to be capable of giving meaningful real-time results in a coal mine environment.

The improvement in the resolution distance may be achieved only by increasing the frequency deviation of the system. Further improvements on the antenna system may also bring an enhancement of the desired return signal and a reduction of the undesired signals.

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NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

EXCHANGE OF STABILITY FOR A COLUMN OF FLUID WITH VARIABLE RAYLEIGH NUMBER UNDER FREE BOUNDARY CONDITIONS

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EXCHANGE OF STABILITY FOR A COLUMN OF FLUID WITH VARIABLE RAYLEIGH NUMBER UNDER FREE BOUNDARY CONDITIONS

by

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ABSTRACT

Motion starts in a column of fluid subject to an adverse temperature gradient when the gravitational forces are large enough to overcome those of viscosity. This point is governed by the critical (smallest) Rayleigh number.

When the column is heated rapidly from below and not well mixed the Rayleigh number varies with height.

For such a system with harmonic boundary conditions the principle of exchange of stabilities is shown. Attempts to show this principle under rigid and semirigid boundary conditions failed.

The Rayleigh number was assumed to follow the nondimensional distribution $\Re(z) = \Re\left(\frac{2+2}{z_o}\right)^{-4}$, $\alpha = 4/3$ or $\alpha - 3/2$, $z_o = 10^{-5^-}$, $0 \le z \le 1$. The lowest values for at which there would be convection was estimated at 8.512 x 10⁸ for $\alpha = 4/3$ and 4.7023 x 10⁹ for $\alpha = 3/2$. The eigenfunction was approximated in both cases.

This work has application to both columns of air in the Earth's atmosphere and the GFFC experiment to be flown in Spacelab 3.

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INTRODUCTION

The Navier Stokes equations have classically been used to describe the motion of fluid in the presence of temperature gradients.

In the Benard problem, the fluid is assumed to be incompressible and at rest; it is assumed to be uniformly heated from below. The vertical temperature distribution is assumed to be linear. The equations are then linearized by looking at temperature and velocity perturbations.

The equations are then reduced to a single sixth order linear partial differential equation with constant coefficients in the vertical velocity perturbation ω . Fourier transform in the horizontal space variables has reduced the number of independent variables. Only time, t, and height, z, remain. The equation is then transformed in t and non-dimensionalized. It becomes:

$$\left[(D^{2} a^{2}) (D^{2} - a^{2} - \sigma) (D^{2} - a^{2} - \rho \sigma) + Ra^{2} \right] W(2) = 0 \qquad 0 \le 2 \le 1$$

Here the vertical velocity perturbation is

$$w = e^{-t + i(a_1 x + a_2 y)} \setminus N(z)$$

Here DW = W and $a^2 = a_1^2 + a_2^2$.

The principle of exchange of stabilities holds if convection modes which neither grow nor decay with time are time independent. If **R**, the Rayleigh number, and **p**, the Prandl number, are constant, exchange of stabilities can be shown to hold under both free and rigid boundary conditions.

If **R** is allowed to vary with height, what will happen? We were able to show the principle of exchange of stabilities holds under free, but not rigid or semirigid, boundary conditions.

Having this result, the onset of convection was investigated for certain distribution of $\mathbf{\hat{k}}$ which model what occurs in the summer atmosphere below the inversion. The values for $\mathbf{\hat{k}}$ used were

 $\mathcal{R}(z) = \mathcal{R}\left(\frac{z}{z_0}\right)^{-\alpha}$ Zo= 2 = d , x=4/302 d=3/2.

Here d is the height of the inversion, 2_0 is surface roughness length, and \propto is empirically chose **n**. This is nondimensionalized, and the critical (smallest) value of R for which convection takes place is estimated.

The results of the calculations were checked by determining the temperature gradient at the surface, $\frac{\partial \Theta}{\partial z}\Big|_{z=z_0} = \beta_0$. This determined $\frac{\partial \Theta}{\partial z} = \beta_0 z^{-4/3}$ which was then integrated to give a temperature drop of roughly 15° in the first meter above the surface. This figure checks reasonably well with the data.

EXCHANGE OF STABILITIES

These calculations show that the principle of exchange of stability holds for a column of fluid heated from below if the Rayleigh number is variable when the boundary conditions are harmonic. The Boussinesq approximations are used. The transverse velocities, u and v, the pressure, p, and the temperature perturbation, θ , are eliminated. The nondimensional equation is

$$\nabla^2 (\mathcal{O}_t - \nabla^2) (p \mathcal{O}_t - \nabla^2) \omega = -\nabla_h R \omega$$

Here $\nabla^2 \omega = \omega_{xx} + \omega_{yy} + \omega_{zz}$; $\nabla_h^{t} \omega = \omega_{xx} + \omega_{yy}$ $\rho = \gamma/R$ is the Prandtl number, and the Rayleigh number, $R = g \propto \beta d^{1/(rk)}$, depends on the height, z.

Proceeding with the analysis into normal modes, set

$$w = e^{\sigma t + i(a_1 \times a_2 y)} W(z)$$

The operator then becomes:

$$\approx (D^2 - a^2)(D^2 - a^2 - pc)W = -Ra^2W$$

Here $a^2 = a_1^2 + a_2^2$ and DW = W.

The harmonic boundary conditions are:

$$\begin{array}{l}
W(0) = 0 = V(1) \\
W''(0) = 0 = V''(1) \\
V'''(0) = 0 = V''(1)
\end{array}$$

Multiplying (*) by \sqrt{V} and integrating forms the following equation.

The following integral occurs in the analysis of (**):

$$I_1 = -S'(D^2 - a^2)WWdz = S'(DWl^2dz + a^2)Wl^2dz$$

The boundary conditions, W(0) = 0 = W(1), make the integrated terms vanish. Set $S_0' |W|^2 dz = ||W||^2$ and $S_0' |DW|^2 dz + \alpha^2 S_0' |W|^2 dz = ||\nabla V ||^2$

Both ||W|| and $||\nabla W||$ are strictly positive unless $W \equiv 0$ under the boundary conditions. So $I_1 = ||\nabla W||^2$ is strictly positive unless N = 0

Again the integrated terms vanish because W(o) = o = W(l)and W''(o) = 0 = W''(l). (The same result can be obtained for this integral under rigid boundary conditions.)

Finally

$$\begin{aligned}
\mathbf{I}_{3} &= -\int_{0}^{1} (D^{2} - a^{2})^{3} W \overline{W} dz \\
&= \int_{0}^{1} (D^{2} - a^{2})^{2} D W D \overline{W} + a^{2} (D^{2} - a^{2})^{3} W \overline{W} dz \\
&= -\int_{0}^{1} (D^{2} - a^{2})^{2} W (D^{2} - a^{2}) \overline{W} dz
\end{aligned}$$

Again the integrated terms vanish under both free and rigid boundary conditions.

$$I_{3} = S_{0}^{1} |(D^{2} - a^{2}) DW|^{2} dz + a^{2} S_{0}^{1} |(D^{2} - a^{2}) W|^{2} dz + (D^{2} - a^{2}) W|^$$

Under free boundary conditions the integrated terms vanish so

$$I_{3} = \int_{0}^{1} |(D^{2} - a^{2})DW|^{2}dz + a^{2} \int_{0}^{1} |(D^{2} - a^{2})W|^{2}dz = ||\nabla (D^{2} - a^{2})W||^{2}$$

When (**) is multiplied by -1, it becomes

$$-\int_{0}^{1} (D^{2} - a^{2})^{3}W \overline{W}dz + (p+1)\nabla \int_{0}^{1} (D^{2} - a^{2})^{2}W \overline{W}dz - p\sigma^{2} \int_{0}^{1} (D^{2} - a^{2})W \overline{W}dz$$

$$= a^{2} \int_{0}^{1} R |w|^{2}dz$$
Set $J = \int_{0}^{1} R |w|^{2}dz$. If I_{1}, I_{2}, I_{3} and J are
substituted in the equation above it becomes

$$p \underline{I}_{1} \sigma^{2} + (p+1) \underline{I}_{2} \sigma + \underline{I}_{3} - J = 0.$$

Since \mathcal{P} , the Prandtl number, is always positive, and \mathcal{I} , is positive unless $\omega=0$, the quadratic formula can be applied to solve for σ . This gives

$$\sigma = \left[-(p+1)I_2 = V(p+1)^2 I_2^2 - 4pI_1(I_3 - J) \right] / pI_1.$$

To show that exchange of stabilities holds, we must show that if $\mathcal{R}_{e} \circ = \mathcal{O}$, then $\mathcal{I}_{m} \circ = \mathcal{O}$.

There are two cases where $Re \sigma = O$

(i) $4 \neq J$, $(I_3 - J) = 0$ and (ii) $(p+1)I_3 = 0$ and $4 \neq J$, $(I_3 - J) < 0$. If (i) holds $\sigma = 0$, if (ii) holds, $\overline{I_3} = 0$ so $\int_0^1 |(D^2 - a^2) W|^2 dz = 0$. S implies

This implies

$$(0^2 - \alpha) W \equiv 0$$

The last implies that

$$\underline{T}_{1} = -\int_{0}^{1} (D^{2} - a^{2}) W \overline{W} dz = 0$$

In both cases $\mathcal{R}_{e} \sigma \circ o$ implies $\sigma \circ o$. This completes the proof of the principal of exchanges of stabilities for operators whose Rayleigh number is variable under free boundary conditions.

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Chandrasekhar, S. "Hydrodynamic and Hydromagnetic Stability" Oxford University Press, 1961.

ANALYSIS INTO NORMAL MODES

Since the principle of exchange of stabilities holds for the variable Rayleigh number problme, we attempt to solve the steady state problem for certain functions, \mathbf{K}

 $\mathcal{R}(z) = \mathcal{R}\left(\frac{z}{z_0}\right)^{-\alpha}$ 20210-5, x=1/3 or x= 3/2, The equation is $\left[\left(\nabla^2 \right)^3 - R \left(\frac{2}{z_0} \right)^{-2} \nabla_{\mu}^{t} \right] u = 0$ Z. = Z = d. with the harmonic boundary conditions 4(0) = 0 = 4(1) $\mu^{*}(0) = 0 = \mu^{*}(1)$ $\mu^{(m)}(n) = n = \mu^{(m)}(1)$ Here $\nabla^2 u = u_{xx} + u_{yy} + u_{zz}$ and $\nabla^2 u = u_{xx} + u_{yy}$ If we set $y = z - z_{\bullet}$, the equation becomes $(\nabla^2)^3 u = R(2 + z_{\bullet})^{-\alpha} \nabla_u^2 u_{\bullet}$ 0 = z = d - z .. with harmonic boundary conditions at 0 and d-z. The equation is normalized by setting x=x/(d-2.) y = y/(d - 20) 2 = 3/(d - 20) and becomes $(\nabla^2)^3 u = R[z_0^{\alpha}/(d-z_0)^4] (z+z_0)^{-\alpha} \nabla_h^2 u, \quad 0 \le z \le l_0$ with harmonic boundary conditions at 0 and 1. Let $R_{o} = R z_{o}^{4} / (d - z_{o})^{4}$ The equation reduces to $(\nabla^2)^3 u = R_0 (z + z_0)^{-2} \nabla_h^2 u$ with $a^2 = a_1^2 + a_2^2$, the equation reduces to the ordinary differential equation: $(D^{2}-a^{2})^{3}u = -R_{0}(z+z_{0})^{-a}a^{2}u$

If $A_n \cdot o$, $n \ge 2$, we can look for a first approximation to the critical (smallest) R_o for which the equation can be satisfied. This will be approximated by finding the

smallest 'R' such that $0 = \int [(0^2 - a^2)^3 + (R_0(2 + 2_0)^{-\alpha} a^2] \sin \pi 2 \sin \pi 2 dz$ That is (12+a2) 3 So sin 12 dz = 'Roa' So (2+20) sin 2 112 dz I " = So' (2+20) - sin 2 12 dz Set S' sin 2 17 2 = 1/2. and note that This yields $R_{0} = (\pi^{2} + a^{2})^{3} / (2 a^{2} I_{1,1}^{*}) = (1/(2 I_{1,1}^{*})) (\pi^{2} + a^{2})^{3} / a^{2}$ It is easy to see that ' R_0 has a minimum when ' $R_0' = 0$, that is, when $\alpha^2 = \pi^2/2$. Then 'Ro = 27 17 1/(8 I 1.) Since numerical integration yields the values $\pm \frac{4/3}{1} = 1.760401$ $I_{1,1}^{3/2} = 2.157553.$ and The first estimate, 'R, of R is $'R_{\rm b} = 186.75045^{\circ}$, a = 4/3, if a = 3/2. and 'R = 152.3743 , if The first estimate of R, then is x = 4/3, 8.667841×108, if and $\alpha = 3/2$ 4. 81 3 3 0 65 × 109 if

The second approximation is made by assuming $A_n \circ D, n \ge 3$.

The problem is to find the smallest number, ${}^{z}R_{o}$, and a pair of numbers A_{1} and A_{2} , with

$$O = S_{0}^{1} [(D^{2} - a^{2})^{3} + {}^{*}R_{0} (z + z_{0})^{-1} a^{2}] (A_{1} \sin \pi z + A_{2} \sin 2\pi z) \sin \pi z dz$$

and

$$0 = S_{1} [(0^{2} - a^{2})^{3} + {}^{2}R_{0}(2+2_{0})^{-1}a^{2}] (A_{1} \sin \pi 2 + A_{2} \sin 2\pi 2) \sin 2\pi 2 dz.$$

.

That is

$$A_{1}(\pi^{3}+a^{2})^{3}\left[\int_{0}^{t}\sin^{3}\pi z\,dz\right] = a^{3}R_{0}\left[A_{1}\int_{0}^{t}(2+z_{0})^{-d}\sin^{3}\pi z\,dz + A_{2}\int_{0}^{t}(2+z_{0})^{-d}\sin^{2}\pi z\,dz\right]$$

and

$$A_{2}(\pi^{2}+a^{2})\left[S_{sin}^{2} a_{\pi 2}d_{z}\right] = a^{2} CR_{s}\left[A_{1}S_{s}(z+z_{s})^{-4}sin\pi z sina\pi z d_{z} + A_{2}S_{s}(z+z_{s})^{-4}sin^{2}a_{\pi 2}d_{z}\right]$$

Set

$$I_{j,K}^{d} = S_{o}(2+z_{o})^{-d} \sin j\pi z \sin k\pi z dz$$

Note that $I_{j,K}^{\alpha} = I_{K,j}^{\alpha}$ and that $S_0^{\prime} \sin^2 j \pi z dz = \sqrt{2}$. This means that

$$A_{1}(\pi^{2}+a^{2})^{3}/2 = a^{2} R_{0}[A_{1}] I_{1,1}^{4} + A_{2}I_{1,2}^{4}]$$

and

$$A_{2}(4\pi^{2}+a^{2})^{3}/2 = a^{2} R_{1} [A_{1} I_{1,2}^{*} + A_{2} I_{2,2}^{*}].$$

The numbers $\underline{I}_{\mathbf{j},\mathbf{k}}$ are found to any desired degree of accuracy by Simpson's rule.

The problem can be written now as an eigenvalue problem in \not/ R_{\bullet} with eigenvector (A_1, A_2) .

$$(1/2R_{o}) A_{1} = 2a^{2}/(1^{2}+a^{2})^{3} [I_{1,1}^{a}A_{1} + I_{1,2}^{a}A_{2}]$$

$$(1/2R_{o}) A_{2} = 2a^{2}/(4\pi^{2}+a^{2})^{3} [I_{1,2}^{a}A_{1} + I_{2,2}^{a}A_{2}]$$
At the value of a^2 corresponding to the smallest value of R₀, the function 1/2R₀ takes on its largest value. This will be the maximum of the largest eigenvalue of all the matrices,

$$M = \begin{pmatrix} m_{11} & m_{12} \\ m_{21} & m_{22} \end{pmatrix}$$
$$M_{j_1k} = (2a^2/(j^2\pi^2+a^2)^2) I_{j_1k}^{k}$$

where

M is not symetric.

It is convenient to set
$$b = \alpha^{3}/\pi^{2}$$
. Then
 $M_{j,k} = (2b/(j^{2}+b)^{3}) I_{j,k}^{2} / \pi^{4}$

Let $r = b/(1+b)^2$ and $s = b/(4+b)^3$. r reaches its maximum when $b = \sqrt{2}$; then $r = \frac{4}{27}$ and $s = \frac{4}{(27)^2}$. s reaches its maximum when b = 2; then $s = \frac{1}{108}$ and $r = \frac{2}{27}$.

It is clear that the entries of \mathcal{M} are positive since $\mathcal{I}_{\mathbf{j},\mathbf{k}}$ is the integral of a positive function and the entries of the second row are much smaller than those of the first row. $\alpha = \frac{4}{3}$

I"'3	5	1.760401	Σ_{ii}	7	2.157553
L 1/3	=	1.177827	I ","	2	1.667493
I 2,2	2	2.593355	工 3/2	N	3,446855

These numbers are accurate to the last place, though some of them are extrapolated to determine the last place.

The problem then is to find the largest eigenvalue, λ , of

$$2\left(\begin{array}{ccc} r \stackrel{\uparrow a}{\coprod} & r \stackrel{\uparrow a}{\coprod} \\ s \stackrel{\downarrow a}{\coprod} & s \stackrel{\downarrow a}{\coprod} \end{array}\right)$$

Then λ/π^4 will be the largest eigenvalue of \mathcal{M} and $\mathcal{R}_{\sigma} = \pi^{*}/4$

This yields $O = \lambda^2 - 2(r I_{i,i}^{\alpha} + s I_{i,2}^{\alpha}) \lambda + 4rs (I_{i,i}^{\alpha} I_{i,2}^{\alpha} - (I_{i,2}^{\alpha})^2)$

It is difficult to maximize λ as a function of a^2 analytically. Instead, using the values of $\Box_{j,\kappa}$ obtained by numerical intergration, shown in the tables, values of λ were calculated in a range between b = .5and $b = \lambda$.

When $a^* = \pi \frac{1}{2}$, $b = \frac{1}{2}$. This is the value of both the critical Rayleigh number in the constant coefficient case (a=0) and the value of b corresponding to the first estimate R, of R, we did earlier.

The calculation was done as follows. For $\propto =4/3$, λ and $\approx R_{o}$ were evaluated at numbers

b = 000001, 0.10001, 0.20001, ..., 1.90001

The largest value of λ occurred when 0.50001 . λ and ${}^{*}\!\!R_{\star}$ were then evaluated at

b = 0.50001, 0.5100 , 0.5200 , ..., 0.59001

The maximum value of λ this time occurred when b = 0.51 col. So λ and R, were evaluated at

b = 0.50101, 0.50201, ..., 0.51801, 0.51901

This process was continued until the machine produced no differences in the sixth decimal place for \mathcal{R}_o . This represents eight significant digits. The numbers $\mathcal{L}_{\mathbf{J},\mathbf{l}e}$ are known only to seven significant digits. The calculation is not very sensitive to changes in b (and therefore b^2) when is near its critical value, but it should be quite sensitive to changes in $\mathcal{L}_{\mathbf{i},\mathbf{k}}$.

When $\alpha = \frac{4}{3}$, the critical value was established at b = 0.50904, $a^2 = 5.024023$

2R. = 183.5693 Then 2R = 8.520189×108 and The eigenvector is $\begin{pmatrix} A_{1} \\ A_{2} \end{pmatrix} = \begin{pmatrix} 0.9996005 \\ 0.0260555 \end{pmatrix}$ b = 0.50904, $\lambda = 0.5306395$, At 5 = 0.0055526 r=0,1481322 and The corresponding critical values for a = 3/2 were b = 0.51208a² = 5.05 4 127 ${}^{2}R_{2} = 148.9276$ R = 4.709315 ×107 The eigenvector is $\begin{pmatrix} A_1 \\ A_2 \end{pmatrix} = \begin{pmatrix} 0.9995499 \\ 0.0301839 \end{pmatrix}$ At b= 6.51208, &= 0.6540702 r=0.1481199 and s= 0.0055 745 If we compare R_o , the first estimate of R_o with R_o , the second estimate of R_o , we have x = 4/3 x = 3/2. R. 186.7505 152.3742 $^{2}R_{n}$ 183.5693 198.9276 The numbers ${}^{j}R_{\circ}$ converge quickly to R_{\circ} . If a third estimate is made the entries $\mathcal{I}_{\mathbf{3},\mathbf{k}}$ are smaller than 5.0. $\mathcal{L}=4/3$ $\mathcal{L}_{\mathbf{3},\mathbf{k}}$ Lus (),832954 1,289302 2.791557 1.871715 4.442455 Ĩ. 3.182768

This problem is analogous to the last. We are looking \prime for a function

$$\begin{split} & \mathbf{W}_{(2)} = A_{1} \sin n\pi + A_{2} \sin 2\pi z + A_{3} \sin 3\pi z \\ & \text{with} & j = (, 2, 3) \\ & \int_{0}^{1} \left[\left(D^{2} - a^{2} \right)^{3} W + a^{2} \frac{3}{R_{0}} (z + z_{0})^{-d} W \right] \sin j\pi z \, dz = 0 \\ & \text{Let } t = b/(9 + b)^{3} & \text{Then we must find the largest eigenvalue} \\ & \text{of the matrix, } M^{3} \\ & M^{3} = 2 \begin{pmatrix} r \ I_{1,1}^{d} & r \ I_{1,2}^{d} & r \ I_{1,3}^{d} \\ s \ I_{1,2}^{d} & s \ I_{2,2}^{d} & s \ I_{2,3}^{d} \\ t \ I_{1,3}^{d} & t \ I_{2,3}^{d} & t \ I_{3,3}^{d} \end{pmatrix} \end{split}$$

The factor t is much smaller than s, just as s is much smaller than r. The determinate of \mathcal{M}^{s} is then $\mathcal{O}(rst)$. The sum of the determinates of the principal submatrices is $\mathcal{O}(rs)$. The trace is $\mathcal{O}(r)$.

Since the determinate is the product of the eigenvalues, the trace is the sum of the eigenmodes, and the sum of the partial products of the eigenvalues is the sum of the determinates of the principal submatrices, it is easy to see that \mathcal{M}^3 has one relatively large eigenvalue, λ , and that its other eigenvalues are near \mathcal{O} . The large eigenvalue should be $\mathcal{O}(\mathbf{r})$.

Because the large eigenvector is so isolated and because we have a good guess $(2 \wedge L_{i,i})$ for it, the power method was used to calculate λ and the eigenvector. This converged, rapidly, giving a value of λ that depended on β .

 λ was maximized exactly as in estimating ${}^{\tau}R_{o}$.

For $\alpha = \frac{4}{3}$, the maximum occurred when b = 0.50970and $\alpha^{-5.5030532}$. Then, the third estimate, $R_0 = 183.3736$ and R = 8.5/237540? The eigenvector is $\begin{pmatrix} A_1 \\ A_2 \\ A_3 \end{pmatrix} = \begin{pmatrix} 0.999656 \\ 0.026135 \\ 0.001981 \end{pmatrix}$ For d = 3/2, the occurred when b = 0.5/32, and $a^{2} = 5.06508$. Then $^{3}R_{0} = 148.7001$ and $R = 4.702310 \times 109$

XXX-12

The eigenvector is

$(A, \setminus$		(0.99 95 37)
A _z	;	0.030308
(A_3)		0.0025201

The	three	estimates	of the eigenvalue	converged quickly.
	10		$\alpha = 4/3$	a = 3/2
	K _o		104.10	732,37
	2Ro		183.57	148.43
	³R。		183.39	148,70

It should be noted that none of these values, λ , R_{\bullet} , or the eigenvector are very sensitive to changes of **b** or **a** near the critical value.

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Velarde, M. G. and Christian Normond "Convection", Vol. 243 #1, Scientific American, July 1980.

Conclusions and Recommendations

Work like this in the case of variable viscosity, thermal conductivity and gravity has atmospheric applications as well as applications to the space program. This would be applicable to the GFFC experiment to be flown in Spacelab 3, especially if rigid boundary conditions were handled. At least some of this is presently feasible.

1980

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

IMPROVEMENTS TO THE NASAP CODE

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XXXI

IMPROVEMENTS TO THE NASAP CODE

ΒY

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ABSTRACT

The object of this work is the modification and improvement of the FORTRAN code, NASAP, written by the author. The purpose of NASAP is the transformation of CAD-generated NASTRAN input data to input data for DESAP II and/or DESAP I. The latter programs are used for structural optimization, and in the initial design phase are often more useful than NASTRAN, which is used for structural analysis.

NASAP is designed to operate interactively, and to this end, modifications and refinements have been made which simplify the interactive participation of the engineer, thus reducing chances for error as well as time spent at the computer terminal. Redundancies have been eliminated, and a tabular form of input has been incorporated into NASAP.

Currently, NASAP is being expanded to include iterative design cycles involving DESAP II and/or DESAP I.

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INTRODUCTION

The Preliminary Design Office currently has the capability of creating NASTRAN bulk data by use of an interactive graphics system implemented on a Computervision system. This method of creating NASTRAN input data is far more efficient in terms of time and accuracy than manual preparation of the data. The CADDS software associated with the Computervision creates NASTRAN input data. This data is then transmitted to a main computer for NASTRAN execution in the batch mode. The output of the program is essentially the stress and displacement fields of the structure being analyzed.

DESAP I and DESAP II are also structural programs, but differ from NASTRAN in that they optimize the structure with respect to some variable, usually weight (i.e., minimizes the weight) subject to user-supplied limits on stress and displacement (DESAP I), and stress and buckling (DESAP II).

The input required for DESAP I and II is rather lengthy, but much of it, including the geometric description of the structural model, may be derived from the CADDS-generated NASTRAN input data. This is the purpose of NASAP.

The current version of DESAP I allows constraints on stress and displacement, while DESAP II allows constraints on stress and buckling. In order to generate a design satisfying constraints on stress, displacement, and buckling, it is necessary to use both DESAP I and II in an iterative cycle. Development of this capability is currently underway.

OBJECTIVE

The objective of this project is the improvement and expansion of NASAP in the following ways: (1) elimination of redundancies; (2) simplification of user-supplied input; and, (3) incorporation of the capability of iterative design cycles involving DESAP I and DESAP II.

REPORT

The body of this report consists mainly of the NASAP program. Its major subroutines are self-explanatory. An overall flow chart, Figures la-ld, outlines the main features of the program. The program is based on the following structural equivalences between NASTRAN and DESAP I and II:

NASTRAN	DESAP I and II
ROD	BAR
BAR	BEAM
QDMEM	Plane Stress Quadrilateral
QUAD2	Plate Quadrilateral
TRIA2	or Triangle
SHEAR	Quadrilateral Shear Panel

This is reflected in the five subroutines in NASAP called BAR, BEAM, QDMEM, QT, and SHEAR. These subroutines deal only with the structural elements their names imply, and perform ordering and manipulation of NASTRAN data via the subroutines CANDP, STOR, PAIR, VEC, and ID.

Figure 2 illustrates the design cycles that are possible using NASAP with DESAP I and DESAP II. The main feature of these cycles is the modification of file 13 (DESAP II) via calculated design variables and/or tolerances from DESAP I, and the corresponding route for file 14 (DESAP I).

When an acceptable design has been achieved using both DESAP I and DESAP II, there is no guarantee that this design is an optimum, i.e., that for the given structure it minimizes weight subject to the given constraints on stress, displacement, and buckling. There may exist other designs of lower weight also satisfying the constraints. This situation cannot be remedied without incorporating the three constraints in a single program.

MAIN HELDENG ORDER TT (VEC PROGRAM CONTROL SIGNA DESTEN CONTROL COUNT NODAT BAR BEAM QUMENI QUMEN QUMENZ SHEAR QT -STEUCTURAL LOAS DATA BUCKLING CONTROL NODAL LOAD DATA VARIABLE DATA restan FND LEGEND ' TO FILE IS (DESAP II) NASAP 53BROUTENE F=G. 12 XXXI-2





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FIG.11



FIG. IC

XXXI-4





FIG. 1d



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- * SATISFIFS DEGAP2 OR DESAP2 AND DESAP1
- ** SATESFIES DESADI OR DESADZ AND DESADI

*** FILE MODIFICATIONS INVOLVE CHANGES IN DESIGN VARIABLES AND VARIOUS TOLERANCES XXXI-6

DESIGN CYCLES

FIG. 2

	BAR				DA1E 073080 PASE 2
	ND.ve	1 557430	ж 1	CANDE T OFFICE KIN	60cm 1 007453 815
	<u> </u>	1 11.7455	<u>+16</u>	0000 ± 007474 $100 = 0011 \pm 001454$ $110 = 0000 \pm 007054$ 1007455 k_2	6000 T 007936 83
		I 007431	K4		0000 I 007442 88
	6000	I 00744z	К9	GOLO I 062114 MAICH 0004 00000 MAILI 0004 8 000024 MAIL2	0000 1 cc6736 MTC0N1
	U00G	R 067152	HTCON2	00-0 R 007002 MTPROP 3000 I 007412 NEID 3000 I 007344 NPAR	6000 I 007413 NPID
	0036	I 067423	NROW	DOU'S DEDUZZ NETART JOU'S I COUDOD NUM DOOD T PO7424 NUMBED	DOUD I OC7420 NUMMAT
	0000	I 007401	NUM12	<u>0030 I 007416 NUM18 0000 I 007400 NUM5 0000 I 006344 PROD1</u>	ODUD R DG6426 PROD2
	000	1 032734	TOCROE	0000 I 007356 TYPE 0000 I 007352 VAR 0000 I 002424 VEID	0000 I 005214 VE1D2
-					
	L0101	1 =		SUBROUTINE BAR (CONFAC, NKODE, IDV1, NTDV1)	600002
	60103	2 ≄		COMMON/BACH/NUM(18),NSTART(18)/MOZART/HAT11(20),MAT12(20,10)	00002
	00103	3 *	<u>C</u> **	CHANGE GROUP. NO. OF DESAP BARINASTRAN ROD) ELEMENTS	
	60104	4 #		INTEGER CROD(100,6),CRODID()J0,5),MATCH(100,2),VEID(100),INDEX(100	600002
		5*		J. TOCROD(190,6), LLOFT1(1CD,6), VEID2(100)	000002
	LG105	5* -	· ·	DIMENSION ELDAT2(100,4),DUMMY(100,1)	000002
	60105		<u>C **</u>	CHARGE GROUP. NO. OF PID'S	
	60106	d¢ O⇒		INTEGER PRODICES, 21	000002
	<u> </u>	<u></u>	C ++	UIMENSIUN PROUZIZS,SI, BEUPRZIZS,SI	UUUUUU2
	00107	10*	(**	CHANGE BRUUP. NU. UF HIU'S	600002
				$\frac{1011000}{101000} = 1100000000000000000000000000000000000$	
	00111	13#	C **	CHANGE GROUP, NO. OF DESIGN VARIARIES	600002
×	60112	14 *		01MENSION 1001(100).1001(50).10012(50)	000002
2	00112	15÷	C **	***	000ng2
2 T	60113	16*		INTEGER KOAD(2), NPAR(6), VAR(4), TYPE(2)	000002
-i	60114	17*		REAL MAT12, EMUL (4,4)	600002
7	00115	18#		DATA VAR/*A', 'B', 'C', 'D'/TYPE/'BAR', ' */	000002
	00120	19×		NUM5=NUM(5)	GOUDC2
	121نى	2:)¢		NUH12=NUH(12)	600004
	L0122	21*		CALL CANUP(S,NUM5,NUM12,CROD,DUMMY,PROU1, PPOD2)	<u> </u>
	UU122	22*	C	PRINT 14	000006
		23*	<u> </u>	FORMATC' CHOD IN BAR FROM CANDP')	
	00122	<u>∠</u> 4≠ ⊃⊑.	C		000006
		<u> </u>	()	PRINT 8. (CROD(L.J).J-1.4)	000006
		20*		TUKTAI (0, , 418)	000006
	60122	<u>-617</u> 78±	(13	FRANT 12 POODI AND POODI IN RAP FOOM CANDDIN	000006
	00122	294	(TO 16 II. NOVE AND TROPE IN CAN FROM CANDE 7	000006
	66122	30*	<u>c16</u>	PRIM 12. (PP601(1.1),J=1.2).(PR0D2(1.1),J=1.4)	00006
_		31*	C12	FORMAT (8%,218,456,4)	L00006
	LC123	32*	7	FORMAT()	000017
	UT124	33*		CALL FURMIINKODE, KOAD, TYPEI	000017
	UQ125	34 \$		NPAR (1)=1	CCUN24
	60120	35*		NPAE:21=NUH5	000026
	66127	36*		NPAR (6)=1	000030
	<u>00130</u>	37*	<u> </u>	Uo 999 I=1+NuH5	000051
	60133	38*		00 999 J=1,6	636351
· _	<u>Un136</u>	394	999_	10CR0[1].J]=CR0[1].J]	
	00141	40 4		DADIG-FOADULA	000062
	<u></u>	42+	(**	AFARTST-RUADINT CONTRUCTION CODE. SETD TO 25	000062
	CD145	43*	U 44	IF (NEDE-EC) I GU TO 25	CAUA64
	00147	44#		F(J1.60.2) 60 T0 4PUU	LOUG66
	00151	45÷		CALL FORM2(J1, KOAD, TYPE, NPAR(2), VEID, NUM5)	00071

	НАН				DATE 073080	PAGE	3
	uG152	46+		ISTOP=NPAR(2)			
	66153	47#		KOHNTEG	000103		
	U0154	48 +		U0. 3100 IJK=1.NUH5	000114		
	00157	49#		IFLAGEU	000114		
	00160	_50×		DO 3054 IJKL-1.ISTOP	U00117		
	60163	51*	3050	IF(CROD(IJK, 1).EL.VEID(IJKL))IFLAG=1	000117		
	<u> <u> </u> <u></u></u>	5.2 *		IF(IFLAG.FG.I) GU TO 3100	600125		
	UŬ17U	53*		KOWNIT=KOWNI+1	600130		
	60171	<u>54×</u>		VEID2(KO=NT)=CROD(1JK.1)	000133		
	60172	55*	3100	CONTINUE	000142		
	66174	56*	<u>4 น ท น</u>		000142		
	00175	57*		IF(J1+EC+1) GO TO 4100	000142		
	60177	<u>59¢</u>		ISTOPENUM5-ISTOP			
	40200	594		NPAR(2)=ISTOP	000147		
· ·	60201	60*		00-4650 IJK=1,ISTOP	000154		
	00204	61 <i>×</i>	4050	VEIL(IJK)=VEID2(IJK)	660154		
	<u>UG284</u>	624	<u> </u>	PRINT 4051.ISTOP	606154		
	402 <u>5</u> 4	034	C	DO 4L52 IJK=1,ISTOP	606124		
	66204	644	<u>C4052</u>	PRINT 4053.VEID(IJK)	<u>UÖD154</u>		
	60204	ь5¥	C4053	FORMAT(16)	000154		
	<u></u>	<u>66</u> *	<u>C4051</u>	FORMAT(/' VEID IN BAR FOR J1=2'//' ISTOP=',16)	000154		
	LC206	67#	4100	CONTINUE	000157		
	<u> </u>	63*		UO 868 I=1.NUM5	LDU157		
	46212	69¢		10 888 J=1,6	600164		
	00215		808	CROD(1,J)=TOCRQD(1,J)	006164		
	UL 215	71 *	C	PRINT 333	000164		
(j	<u> </u>	12#		FORMATIC CROL IN BAR JUST BEFORE SIDR .)	<u></u> <u></u> <u>_</u> <u>_</u>		
1		13=	0	00 777 1=1,60M5	090164		
÷		<u> </u>	<u> </u>	<u>FRINI 222. (CRODIIIJ), J=1,1510P)</u>			
ż		7.5*		FURMAL(SIS)			
	<u> </u>	77.		LALL STURISTUPSNUNS, CRUU, VEIU, 41			
		11+	(L Z	FRENT DI Formatif From there with ware form study)			
	<u>Luzzu</u>	798	<u> </u>	LOTALITY LANGE AND A DEPENDENT AND A LOT ALL AND A LOT AND A	C001172		
	60225		(77	DPINT 76. (CP0)((.1.k).k*)./	(00172		
	00220	61.	<u> </u>				······································
	00220	ö ↓ 87.	668	FORMATCH VETU IN RAP JUST BACK FROM STURI	630172		
	(22)	839	(PAINT 87. VETUTIAL TELEVITAN	000172		
	66226	<u>04</u> ≠	C.8.7		006172		
	LD72.		C76		100172		
	1.2221	55 55 \$	0.0	10 TO 26	000212		
	60222	±7≠	25		000203		
	60223	öð≠	20	UO 7L J=1.ISTOP	606265		
	60226	69\$		NETU-CROL(J.1)	0.05211		
	00227	93*		NPIGECROD(J.<)	006213		
	LU221	÷1≠	C **	ETNU PROUL CARD WITH SAME PLU	LO0213		
	u023.i	92*	•	10.65 K=1.NUM12	6.00.220		
	LU233	73¢		1F(NPID .E2.PR0D1(K.1))G0 TO 61	06220		
	LL1235	.94*		40 TO 65	100223		
	66230	95×	61	Kzk	(00225		
	uu237	96#	-	60 16 62	CGU226		
	00240	97*	65	CONTINUE	000232	-	
	U0242	98*	6.2	CRODID(J+1)=NEIU	600232	<u> </u>	<u>.</u>
	60243	93*		CROUID(J,2)=CRUD(J,3)	000234		
	69244	1		CRUDID(J.J)=LRUN(J.4)			
	60245	161*		CROUID(J,4)=PROD1(KK,2)	606240		
	<u>00246</u>	1024		CROUID(J.5)=1,P1D	696242		

.

	BAR				DATE 073080	PAGE	4
	60247	163+	70	- CONTINUE	606246		
	UD247	104*	C	PRINT 73	000246		
	00247	105+	C73	FORMAT(CRODID FROM BAR)	000246		
	60247	166+	С	U0 74 J=1,ISTOP	000246		
	00247	107*	C74	PRINT 75, (CRODID(J.K),K=1.5)	000246		
	60247	168*	C75	FORMAT(515)	000246		
	60247	109#	<u> </u>	CRODID ARRAY IS DONE. IT CONTAINS, FOR THIS CONST. CODE.	000246		
	60247	110*	C **	EID,G1,G2,MID,PIU,IN ISTUPATIONAR(2))ROWS.	000246		
_	00247	111*	C **	FIND NUMMAT AND MATCH.	600246		
	00247	112+	C **	IN CALL PAIR, PROD1 IS NOT USED	000246		
·	60251	<u> </u>		NUM18=NUH(18)	600246		
	00252	114*		KKODE=U	000250		
	60253	115+		CALL PAIR(KKODE, CRODIN, PRODI, TSTOP, NUM18, 4, NUMMAT, MATCH, INDEX)	000251		
	60254	116#		NPAR (3)=NUHMAT	000264		
	00254	117*	<u>C **</u>	SET UP HATERIAL CONTROL CARD FOR EACH OF THE NUMMAT	000264		
	60254	118*	C ++	HAT1 CARDS ASSOCIATED WITH CRODID,FOLLOWED BY THE	000264		
	60254	119*	<u>C **</u>	MATERIAL PROPERTY CARD FOR THAT MATERIAL	000264		
	60255	120*		DO 83 JIG =1,NUHHAT	000277		
	<u>UD260</u>	121*			000277		
	60261	122*		HTCON1(J10+2)=1	000301		
	_L0261	123*	<u>C **</u>	FOR MID NO. INDEX(J10) FIND CORRESPONDING ROW NO. IN MAT12	000301		
	C0262	124×		DO 84 J11=1,NUHMAT	000306		
	60265	125*		IF (MATCH(J11.1).EU.INDEX(J10)160 TO 85	<u> </u>		
	60267	126*		GO TO 84	000311		
	00276	127*	. 85	NROW=MATCH(J11,2)	000313		
	60271	128*		GO TO 66	600314		
2	00272	129*	84	CONTINUE	<u> </u>		
2	0274 ت	13 ∂ ≠	86	MTCON2(J10) = MAT12(NROW,4)*CONFAC	000320		
≓ .—	60274	<u>131*</u>	<u> </u>	_PRINT_2222MAT12(NROW,4)	000320		
5	60274	132*	C2222	FORMAT(* MAT12 =*,F10.0)	600320		
			C	PRINT 1111, MTCON2(J10)	<u>ii00320</u>		
	00274	134*	C1111	$FORMAT(2x, M_1TCON2 = F2_0.8)$	600320		
	60274	135*	<u> </u>	PRINT 95, NRON, CONFAC	620320		<u> </u>
	60274	136*	C95	FORMAT(* NROW, CONFAC*, 13, 2X, F8, 2)	000320		
	<u> </u>	<u>137¤</u>	<u>C **</u>	SET UP MATERIAL PROPERTIES CARD FOR THIS MATERIAL	<u> </u>		· • · · · · · · · · · · · · · · · · · ·
	09275	138*		MTPROP(J10,1)=0.	600323		
	00276	139*		HIPROPLJ10.2)=HAT12(NROW.1)	000324		<u> </u>
	60277	140*	_	MTPROP(J10,3)=NA112(NROW,5)	000326		
_	<u> </u>	<u>141*</u>	<u> </u>	PRINT 111, HIPROP(J10.2), HIPROP(J10.3)	600326		··
	60277	142*	CIII	FORMAI(* MIPROP-2 AND MIFROP-3 =*2F20.8)	000326		
	<u> </u>	143#		HIPROP(J10,41=HA112(NROW.6)	000330		
	60301	144*		MTPEOP(J16,5)=MATI2(NROW,9)	000332		
	<u></u>	145*					
	00302	1404	C +++	TATERIAL PROPERTIES DATA IS DONE	000336		
	60302	146.	<u> </u>	This Not sent to file 12 UNITE AFTER NP AR 15.	000336		· · · · · · · · · · · · · · · · · · ·
	60302	1494	(++	SINCE NONE OF THE ELS OF PRODZ ARE USED BY DESAP	000330		
	00302	150*	<u> </u>	IT IS NOT RELEASENT TO HATCH THE FID'S OF THE GROU'S	000776	· · ·	
	10702	151#	(##	WITH INC ROUG OF RODE Set up geowerse ponerates wata. Deeduct to adea -tv-17-1.	606736		
	LD304	152*		WRITE GERET KOAL GITETISTOP	<u>UUUJJD</u>		······
	66310	153=	я A	FORMAT (52, 19NTER NUMBER OF LITEFERENT GEOMETERS DOUDLOTTES FOR COM	000330		
	60310	154#		ISTRUCTION COLFT. 14.1. MUST BE LESS THAN OF COLLETING TOTAL	000745		
	00313	165*		of AN (5.7) NUMBER O	000345		
	00344	156*		NPAP LUISHINGFO	UUU343		
	60315	1574			000333		
		158*	795	FORMATCY FORM FIFMENT CONTRAL FROM RAPTA	<u> </u>		······
	60320	159#	.,,,	WRITE(2,79) (NAR(TE),TELL)	U00302 200162		
+				THE CONTRACT OF THE TAXABLE FOR THE TAXABLE FO	000302	· · · · ·	

	BAL		DATE 073060	PAGE	5
U ₁₁ 32,	<u>16</u> ij≄	C ++ NPAR TO FILE 12	000362		
60321	ú 161≠	C PRINT 799	000362		
6032	U 162#	C799 FORMAT(NPAR TO FILE 12.)	C00362		
0032.	u 163*	C PRINT 79, (NPAR(IP),IP=1,6)	000362		
<u> </u>	3 164*	79 FORHAT(615)	<u> </u>		
L0324	4 165#	WRITE(12,349)	600372		
	<u>t166</u> ≠	349 FORHATC COMM HATERIAL CONTROL AND PROPERTIES FROM BAR	600404		
6032	/ 16/ _‡	DO 350 JIZEI, NUMHAI	600404		
	2 168*	ERITE (12, SUD) (HILONIIJI2, J13], J13=1, 21, MILON2(J12)			
60336	2 1099 2 1711+	C PRINT 8777	600404		
	2 171#	(0) = (0)	000404		· · ·
00354	1 1724	The Format (15:15:16:3)	000404		
C0342	2 173#	WRITE(12,301) (MTPROP(d12,d13),d13=1.5)	600416		-
60342	2 174*		000416		
6034	2 175 ±	C9999 FORMAT(* MTPROP TO FILE 12*)	600416		
0034	2 176#	C WRITE(6,301) (MTPROP(J12,J13),J13=1,5)	000416		
6635	177*	331 FORMAT (5F10.0)	UCU437		
6035	1 178+	35P CONTINUÉ	000437		
LO35.	1 179#	C ** MATERIAL PROPERTIES DATA HAVE BEEN SENT TO FILE 12	006437		
0035.	<u>181*</u>	IF1NUMGE0.6T.1366 TO 160			
LC359	5 161*	DO 101 K1=1,3	000446		
60365	<u>1d2#</u>	161GEOFR2(1),K1)=1	000446		<u> </u>
6036.	2 183*	LO 108 K4=1,1STOP	600453		
	5 164#	108			
6036	/ 185#	FITE (6,59)	000455		
	1	BY FORMAT 122, "FOR THIS CONST CODE THERE IS UNLI ONE BEOMETRIC PROPERTY	<u>UUU462</u>		
	1 1014	ADEALATY ATTACT TO YOU HANT A DECEDENT OPDERTY OF THE	000462		
- 1037	1 1824	UMER-JIT-IJIC-IA AF IND BARLA A UFFERENLEPUPERIL SELAT	000462		-
÷ L0372	2 1907	READ (5.7) DUM1	000462		
C 10 37	2 191*	C PRINT 666-DuMI	000462		
Ca37	: 192*	C666 FORMATI DUMI LINE 173 MAIN .F10.5/1	000462		
0037	5 193×	IF (DUM1 .EC, G.) GO TO 110	600470		
	7194*	READ (5.7) DUM2+DUM3	000472		
u040.	3 195#	GEOPR2(1,1)=DUM1	600501		
6940	<u>4 196*</u>	GEOPR2(1,2)-GUH2	000503		
6040	5 197*	GEOPR2(1,3)=GUM3	000505		
<u> </u>	<u>6 198*</u>	<u>60 TO 113</u>	<u> </u>		
L040	/ 199*	160 DO 163 K2=1,KUMGEO	000511		
	<u> </u>	<u>DU 105 KSE13</u>	<u>UUU522</u>		<u> </u>
UD41:	¥⊥ر∠ C		000522		
<u> </u>	<u> </u>	ON LODAL 12Y LEDE FACE OF THE TIT COMPTONE DOADEDTY NUMBERS THE			
UU42. 1.542	ວ ∠ບວ÷ Հ ວ/⊨⊨±	TO TOMMAL 124, TUR EACH OF THE TILL, COUNCIRLE PROPERT NUMBERS, THE	000541		
<u></u>	3 255×	2 YEARAN ENVERTIES HAVE DEEN ASSIDNED. 7			
00.42	3 246+	The same optically following the Geometric Property No. To be G	100541		
6042	3 2: 7×	41ven Otherwise Default*1	000541		
<u> </u>	<u>↓ 269</u> ¢	UQ 114 K4=1,NUMGLQ	600541		
0042	7 269*	wRITE (6,91)n4	Ú00541		
UQ432	2210*	91 FORMAT (5X, GEUMETRIC PROPERTY NO. 14)	000597		
LN43.	3 211*	READ (5,7)DUM1	600547		
UC43	<u>⊳ 212</u> ≠	1F (100M1.EQ.00.100 TO 104	000555		
L044(ն 213≠	READ(5,7) DUM2	000557		
<u></u>	<u>3 214±</u>	READ (5.7) DUH3			
60440	6 215*	GEOPR2(K4,1)=DUM1	000573		
6044	7216*	GEOFRZIK4,ZI=DUMŹ		· · · ·	

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LO456 217*	GEOPR2(K4+3)=DUM3	000577		
LU451 218*	104 CONTINUE	000603		- · ·
00451 219+	C ** SET UP CRODID FOR USE IN ELEMENT DATA	000663		
C0453 220#	WRITE (6,92) NUMGEO	606603		
60450 221*	92 FORMATIZX, FOR EACH DESAP BAR ELEMENT NUMBER GIVEN, ENTER THE ASSOC	000614		
60456 222*	1IATED GEOMETHIC PROPERTY NUMBER 1 THROUGH*,14)	000614		
<u> </u>	UO 105 K5=1,1 _{ST} OP	000614		
6 ₂ 46 ₂ 224*	WRITE (6,7)CROUID(K5,1)	600614		
<u>LD465 225</u> *	105 READ (5,7)CRODID (K5,5)	600621		
UU471 226*	110 CONTINUE	000631		
	C ## GEOMETRIC PROPERTIES DATA CARDS ARE DUNE	000631		
	WRITE(12,96) Def forward for the company of the book difference and the	000631		
	96 FORMATI COM GEORERILES FROM BAR'S	<u> </u>		
00475 2304	UU 100 KO-1,KUMBEU Note 110 otive /cendojive vii ki-1 ti	000033		
		000646		
(050) 232+ (050) 233±	C FRINT 3353 RESE FROMATIN GEODDO TA FILE 1211	000040		
		000040		
LOSUU 234#	03 FODMAT 15 59 7510.31	000040		
<u> </u>		000665		<u> </u>
60516 237*	C 44 GEORFINE PROPERTIES DATA HAS REEN SENT TO DESAP	000665		
60510 238#		000665		<u> </u>
10512 239+		000665		
00515 240*	111 FORMAT (15X. FLEMENT LOAD MULTIPLIERS FOR CONST. CODE +.14)	000677		
L0516 241*	DO 115 K6=1.4	000677		
, LU521 242*	DO 115 K7=1.4	000677		
1.0524 243*	115 EMUL(K6,K7)=0.	000677		
CO527 244*	DO 120 K8=1,4	000710		
60532 245+	WRITE (6.112) VAR(KB)	000710		
L U0535 246≠	112 FORMAT (2X, 'FOR LOAD ', A1, ' ENTER X, Y, Z ELEMENT LOAD FRACTIONS	000715		
<u> </u>	1 IN THAT ORDER. DEFAULT = ALL ZEROS *)	000715		
60536 248 *	READ (5,7)DUH1	000715		
<u> </u>	IF(DUM1.EQ.D.)60 TO 120	00_0723		
60543 250×	READ (5,7)DUM2	000725		
<u> </u>	READ (5+710)H3	000733		
00551 252*	EWOL (1,KB)=DUMI	000741		
LU552 253*	EMUL (2,K8)=(UM2			
60553 254×	EMUL (3,KB)=DUM3	000745		1 A.
LG554 255#		000752		
	C ** ELEMENT LOAD MULTIPLIERS ARE DONE	000752		
<u> </u>		000752		
	CODO FUNMAI' EMUL IU FILE 12"J	000752		
00566 250 *	TT FORMATCH FORM FL. LOAD MILLYT, FORM DAOTA			
10000 200+ 100561 261+	IO 121 KOTLA	500782 [.NN762		
LU201 2014		<u> </u>		
00004 2024		000762		
00573 264*		E01003		
265*	C. ** GENERATE ELEMENT DATA			
LU574 266*	UO 150 KKOW=1,1STOP	LO1003		
<u>60577 267+</u>	00 149 KCOL=1.5	L01003		
UU602 268#	149 ELDAT1(KROW, KCOL)=CPODID(KROW, KCOL)	001003		
<u>60614 269</u> *	IX=ELDAT1(KROW,1)	L01005		
UO604 270*	C ELDAT1(KKOW,6)=1x	001005		
UD604 271*	C LLUAT2(KROH,1)=2+1X	<u> </u>		
60605 272*	WRITE (6,13() 1X	UD1007		
<u>CO610</u> 273+	130 FORMAT(2X, 'ENTER THE DESIGN VARIABLE NO., IUV, FOR ELEMENT NO. *, I5)	001015		

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in611	274*	READ (5.7) ELDAT1(KROW.6)	001015		
60614	275*	ELDAT2(KROW,1)=1.	601023		
60614	276*	C WRITE(6,131) IX	001023		
00615	277*	131 FORMATIZX'ENTER DESIGN VADIABLE FRACTION ,FRC, FOR EL.NO14. DE	601025		
ÜÜ615	278*	1FAULT=1+0*1	001025		
LD615	279*	C READIS.7 JOUM	601025		
6615	28ila	C IF(DUM+E4-3-) 60 T0 151	601025		
L0615	281*	C ELDATZ(KROW-1)=DUM	601025		
00616	282*	151 CONTINUE	601025		
10617	263*	EL () A 12 (KROW - 2) = 0	001025		
00617	264*	C BRITE(6,132) IX	001025		
60626	265¥	132 FORMATIZX. FATER END-FIXITY COEFFICIENTS C FOR BUCKLING ABOUT THE	601026		•
	286*	1Y AND Z AXES.RESPECTIVELY.FOR EL.NO. 1.14)	001026		
U062U	287*	C READ (5.7)ELDAT2(KROW_3).ELDAT2(KROW.4)	001026		
68621	288*	$F_{1}D_{1}T_{2}K_{P}D_{1}3I_{2}I_{2}$	001026		
1.(1622	2:0*		001027		
68622	2911=		601027		
00622	2914		001027		
00022	2924		001021		
<u> </u>	2014				
00023	2934	C PAINE 170	001034		
00623	2944	UTIG FURMATC ELUATI AND ELUATZ IN BAR THAT IS SENT TO FLORD	UUIU34		
00623	2937	CC DO 1122 KROU-1,1STOP	001034		
<u> </u>		C BRITE (B.7) IELDATIKERDE.JJ.J=1.6)	001034		
00623	291#	C1122 WRITE (6,7) (ELDAT2(KROW,J),J=1,4)	001034		
LUBZS	<u>298</u> #	C ## ORDER THE ELDAT ARRAYS IN ASCENDING ORDER OF FLEMENT			
L0625	299÷	CALL ELORD (ISTOP,ELDAT1,ELDAT2,6,4)	601034		
<u> </u>	<u>3i</u> #		001034		
00626	361*	WRITE(12,135)	601043		
<u> </u>	<u>3u2*</u>	135FORMATL'_COMMELDATA_FROM_BAR')	001050		
L2630	3u3™	C4444 FORMAT(* ELDAT1 AND ELDAT2 FROM ELORD TO BAR TO FILE 12*)	001050		
60631	3⊾4≠	<u> </u>	001050		
LD634	3/∪5 ⊯	160 wRITE (12,133)(ELDAT1(K12,K13),K13=1,6),(ELDAT2(K12,K13),K13=1,4)	001056		
<u>LD634</u>	<u> </u>	<u>C160 #RITE 16,133;(ELUAT1(K12,K13);K13=1,6);(ELDAT2(K12,K13);K13=1,4)</u>	001056	- ··· · · ·	
6647	3u7*	133 FORMAT(615,4F10.0,5X)	001101		
<u>650</u>	<u> </u>	<u> </u>	001101		
L0651	369 ÷	450 ISTGP1=ISTOP	001111		
60652	<u>31</u> ;)≄	UO_451_K15=1,ISTOP	001112		
LD655	311#	451 IDV11(K15)=ELDAT1(K15,6)	001116		
<u> </u>	312*	60 10 1030	001120		
68666	313*	460 ISTOPZEISTOP	601122		
00661	314#	00 461 K16=1.ISTOP	601123		
66664	315*	461 IDV12(K16)=ELDAT1(K16,6)	001127		
L0666		1000 CONTINUE	001133		
DG670	317#	IF(NKODE.EQ.1) GO TO 1100	001133		
C0672	318*	NIDV1=1STOP1+1STOP2	LD1136		
6673	319*	00 1.1.3 K17=1,1STOP1	601157		
00676	320*	1)10_10v1(K17)=10v11(K17)	U01157		
60700	321*	00 1020 K18=1.ISTOP2	001166		
00763	322#	1026 IDV1(ISTOP1+K18)=TDV12(K18)	001166		
03705	323≠	RETURN	LB1170		
60706	324≠	1100 NIDVIEISTOP1	601174		
n7n7	325*	40 1114 K17=1. ISTOP1	001175		
00712	326#		004173		
00714	3/7*		<u></u>		
10715	2011 2012	END CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACTOR CONTRACT	001203		
			U0126U		

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	_								
		007330	ELDAT	1 UUUO R 016267 EMUL	UDOD I DIGZAY ENGFOR	0000 R 014544 FRC	<u> 0nnn I 014772</u>	GEOPR1	
	0000 R	015251	GEOPRA	2 COUD R 015415 GEOPR3	0000 I 016322 I	0000 I 016352 IDUM		IDUMM	
	<u> </u>		INDEX		0000 1 016330 IFLAD			IJAL	······
	infini I	016344	INDEA		0000 I 016325 ISTOP	0000 I 016324 J1		131072	
		016345	<u></u>		0000 I 016351 J13	0000 I 016353	0000 I 016354	J15	
	0000	016335	ĸ	6000 I 016336 KK	U000 I U16321 KKDE	0000 I 016340 KKODE	0000 T 016341	KKOL	
	0000 1	016223	KOAD	0000 I 016326 KOWNT	U000 I 016370 KROW	0000 I 016364 K10	GOOD I 016410	K15	
		016412	K16	COOD I 016413 K17	GOD <u>n I 016414 K18</u>	0000 I 016355 KG	0000 1 016356	K7	
	0000 I	U16357	K8	GDUG I 016363 K9	0000 I 003554 HATCH	0004 000000 MAT11	0004 R 000024	HAT12	
	00001	<u>U15643</u>	MTPRO	1 COUO R 015667 MTPR02	0000 I 016366 M1	0000 I 016405 M12	0000 I 016406	M13	
	ւնոն լ	016367	M2	CUJO I 016372 M3	üO _{OO} I D16373 H4	0000 I 016374 H4H1	UD _{DO} I 016377	M5	
	<u> </u>	016400	M6	<u></u>	0000 I 016401 M8	0000 I 016402 M9	<u>LOLO I 016333</u>	NEID	
	0000 I	016332	NNCOL	0000 I 016403 NNCOL1	0000 I 016404 NNCOL2	0000 I 016265 NODE	GCUO I 016375	NONE	
		016225	NPAR		UNUU I U16346 NROW	UUUS UUUUZZ NSTARI		NUM	
		016365		UULU I C16347 NUMBEO Dava I 014710 PRAPI	LULU I UI6342 NUMMAI	0000 0 014303 551			
	<u> </u>	016266	IYPE	0000 1 014710 PBARL	UND T 002114 VETD	0000 T 01774 VET-2		IUDAKI	
			1176	0000 I 010233 ¥AK	0,00 I 002114 4CID	0000 I 015124 VEIDZ			
	60101	1#		CHEDONTINE REAMINALFAR NUM	CF. 1047. N10431		680000		
		2*		COMMON/BACH/NUM(18).NSTART	(18)/M07ART/MAT11(20)	AT12(20.10)	000002		
	U.103	3#	C ++	CHANGE GROUP, NO. OF DESAP	REAMINASTRAN RARI FLEN	FNTS	000002		
<u>ہ</u> –	LO104	4*	<u> </u>	INTEGER CBAR1(100.61. ICBAR	1(100.5), VEID(100), CBAR	ID(100.7).MATCH(1	000002		
2	60104	5*	1	100.2).INDEX(1na).ELDAT(160	.16).ELDAT1.100.23).VEI	D2(100)	000002		
⊀`_	60105	6*		DIMENSION CBAR2(100,3),FRC	(1,0,1)		00002	· ·	· · · · · · · · · · · · · · · · · · ·
	<u> </u>	7*	C **	CHANGE GROUP. NO. OF PID'S	•-·		000002		
<u>.</u>	00106	8 *		INTEGER PBAR1(25,2),GEOPR1	(23,2)		600002		
~	<u> </u>	9#		DIMENSION PBAR2(25.5) GEOP	R2(25.4).GEOPR3(25.6)				
	60107	10*	C ++	CHANGE GROUP. NO. OF MID'S			L00002		
		11+		INTEGER MTPRO1(20)		· ·	600002		
		12*	c	REAL MIPRUZIZU,61			000002		•
	00112	10.	L ##	CHANGE GROUP, NO. OF DESIGN	N VARIABLES		000002		
	00112	15±	C **	DIMENSION ID42(160),10421(*****	000002		
	1.0113	16#		<u></u>		TTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTTT	<u>uuunoz</u>		·
	00115	17#		THENSION DUMMICIANDEL21-	FMul [4.3].SFT[12]	Druktor (Cl Zr	100002		
-	60115	18+		REAL MAT12	▝▖▏▖▋▖▝▖▝▁▝▁▝▎▝▎▝▌▖▌▖▝▖▝▎▟▕▙▔▐▖▃▖▖▖▖		000002		
	00116	19*		UATA VAR/ "A", "B". "C". "D"/T"	YPE/*REAM.*.* */.iOR/*	I'.'.'.	000002		
	L0122	20*	7	FORMAT ()			600002		
	00123	21*		NUM6=NUM(6)			000002		··································
	00124	22*		NUM13=NUM(13)			000004		•
		23*		KKDE=6			400000		· '
	00126	24 #		CALL CANDP (KKUE, NUM6, NUH1.	3,CBAR1,CBAR2,PBAR1,PBA	R2)	600010		•
	00126	25*	<u>L **</u>	CBARZ IS NEVER USED		· • • • • • • • • • • • • • • • • • • •	000010		
	10126 10126	<0 7 27±	с 75	NRIL (6,5) FORMAT 125V 10CAM LIENSAT			000010		•
	00126	. <u></u>	<u> </u>	PURPAI 16024 BLAM LLEMENT 1	JATA IDAK IN NASIKANI'I				
	10126	204	C14	FORMATEL CRART AND CRAST T	N REAM FORM CANDD.		000010		
	00120	3.)*	C	UO 9 L=1.NUH6			000010		
	L0126	31*	Č 9	PRINT 88, (CEAR1(L.J).J=1.	5),(C8_R2(L,J),J=1.3)		600010		
	00126	32*	C88	FORMAT(2x,516,3F8.2)			000010		
	60126	33*	с	PRINT 13			000010		· <u>·······························</u> `
	60126	34*	C13	FORMATE PBAR1 AND PBAR2 I	N BEAM FROM CANDP")		000010		•
	00126	35*	с	00_16_L=1,NUM13			600010		

	BLAM				DATE 073080	PAGE 3
	60126	36#	(16	ORINT 12. (PHAR)(1.1).1-1.21.(PRAR2(1.1).1-1.5)	006010	
	00126	37*	C12	FORMAT(2X.216.5Fb.2)	Ú80010	
	L0127	38*		CALL FORMIINKOUE, KOAD, TYPE)	000021	
	00130	39+		NPAR(1)=2	000026	
	<u>uc131</u>	<u>40</u> +		NPAR 121=NUM6	000030	
	00132	41*		00 999 I=1,200	000047	
·		<u>42*</u>			600047	· · · · · · · · · · · · · · · · · · ·
	1:0146	43 * 444	999	10 1501 1171 UKODE	<u>000047</u>	
	60145	45*		NPAR(5)::KOAD(J))	000000	
	66146	46 ±	C **	IF ONLY ONE CONSTRUCTION CODE.SKIP TO 25	00000	
	L0147	47*		IF (NKODE.ED.1) GO TO 25	000062	
	00151	<u>48</u>		<u>1F(J1+E0+2) GO TO 4000</u>		
	60153	49*		CALL FORH2(J1,KOAD,TYPE,NPAR(2),VEID,NUH6)	000067	
	<u> </u>	<u> </u>		<u>ISTOP=NPAR(2)</u>	000101	
	60155	51*		KONNIEU No zno, tuka nume	000103	
_		<u>22#</u> 53±		<u>UU SIUG IJN-1+NURG</u>		
	60162	54*		00 3050 LIKI-1.ISTOP	000112	
	<u>00165</u>	55¥	3050	IF(CHARLIJK.1).EQ.VEID(IJKL))IFLAG=1	600115	
	40170			IFLIFLAG.FQ.11 GO TO 3100		
	J0172	57#		KOWNT=KOWNT+1	600126	:
	LD173	58*		VEID21KOWNT)=CHARITIJK,1)		
	LC174	59×	3100	CONTINUE	C00140	
	00176	<u>6Ù</u> #	<u> </u>			
<	0177	614		1F(J1+2Q+1) 60 TO 4100	000140	
k						
5	00202	637 64#		NC 6050 LIKELISTOP	600153	
<u> </u>	0206	65*	4050	VEIU(IJK)=VEID2(IJK)	000153	
5	<u>E0206</u>	<u>65</u>	<u> </u>	PRINT 4051, ISTOP	000153	
	60206	67 *	С	DO 4052 IJK=1,ISTOP	606153	
	66206	68*	<u>C4(152</u>	PRINT 4053, VEID(1JK)	000153	
	00206	69#	C4053	FORMAT(16)	600153	
	00200	<u> </u>	<u> </u>	CONTINUE		<u> </u>
	6.0211	72 *	4▲06	00 688 T=1.200	E00101	
	L0214	73#		00 888 J=1.5	000161	
	00217	74=	888	CBAK1(1,J)=TCBAR1(1,J)	L00161	
_	60217	75*	د	PRINT 333	000161	
	60217		<u>C333</u>	FORMATI' CHARL IN BEAM JUST BEFORE STOR')	00161	•
	60217	77* 70	C	U0 777 I=1,HUH6	600161	•
		<u> </u>	<u> </u>	<u></u>		
	L[] L I I	/ / / 平 兵门业	6222	NC01 - 5	500101 500147	
	<u>60223</u>	<u> </u>	· · ·	CALL STODITSTOD, NUMA, CRADI, NETG, NNCOL)	CD0171	
	00223	82*	C	PRINT 67	000171	•
	L0223	03×	C 8 7	FORMATE' CHARI AND VEID IN BEAM JUST BACK FROM STOR')	606171	•
	L0223	84 #	<u> </u>	_00 77_J=1,ISTOP	<u></u>	*********************************
	60223	65*	C77	PRINT 76, (CBAR1(J,K),K=1,5),VEID(J)	600171	
	00223	86*	<u> </u>	FORMAT1615)	600171	•••••••••••••••••••••••••••••••••
	u0224	87*	-	60 TU 26	00200	
		<u> </u>				
	00226	077 934	26	NETD-CHADAA I 13	000204	
	<u>60232</u>	<u></u> 91*				•••••••••••••••••••••••••••••••••••••••
	60232	92×	C **	FIND PBART CARD WITH SAME PID	000215	
					·····	

BE	AM			DATE 073080	PAGE	4
60233	93*		D0 65 K=1.NUM13	000222		
60236	94.0		IF(NPID.EQ.PEAR1(K 1))GO TO 61	U00222		
60246	95×		60 T0 65	000225		
60241	96*	61	KK=K	000227		
60242	97*		60 TO 62	00023n		
LD243	98*	65	CONTINUE	000234		
00245	99*	62	CBAR ID(J,1)=NEID	000234		
60246	100*		CBARID(J,2)=CBAR1(J,3)	600236		
60247	1.1*		CBARID(J,3)=CBAR1(J,4)	000240		
60250	162*		CBARID(J,4)=CBARI(J,5)	000242		
60251	103+		CBARID(J,SJ=PBARI(KK,Z)	000244		
60252	104#	•	CBARID(J,6)=NPID	000246		
00253	105#			600252		
00253	1057	C 7 7	PRINT / 3 Footate, Crarto Franti	000252		
<u> </u>	16.8*	<u> </u>	PORTALLY COARD FROM CLAP /	000252		
6.0253	100+	C74	DU 14 D-1115107 DD1x1 57. (CADTD11.x)x-1.7)	000252		
00255	110#	<u> </u>	FORMAT(715)	000252		
10253	111#	C ##	CRAPTA ACRAVITS DONE FYCEPT FOR CRAPTO 1 .71	600252		
60253	112*	<u>C **</u>	FIND NUMBER AND MATCH	000252		<u></u>
60255	113#	• • •	NUM BENUM (18)	600252		
<u>6025</u> 5	114*		KKODE=0	600254		
00257	115+		NK0L=5	000255		
60257	116*	C	PRINT 1011, ISTOP, NUM6, NUM18, NUM13	000255		· · · · · · · · · · · · · · · · · · ·
60257	117*	C1011	FORMAT(415)	600255		
L026U	118*		CALL PAIR(KKODE,CBARID,PBAR1,ISTOP,NUM18,KKOL,NUMMAT,MATCH,INDEX)	000257		
C0261	119#		NPAR (3)=NUMMAT	600274	<u></u>	
UD262	12U#		WRITE(6,503)KOAD(J1)	600276		
60265	121*	543	FORMATIZX, 'ENTER NO. OF FIXED END FORCE SETS FOR CONST. CODE . 141	600305		
00266	122*	• • •	READ (5,7) NPAR(6)	000305		
<u>00266</u>	123*	<u>C **</u>	SET UP HATERIAL CONTROL CARD FOR EACH OF THE NUMMAT MAIL CARUS ASSOCIATE	0 000305		
00200	124#	L **		- 000305		
00271	126#					
00274	127#			000310		•
10275	128#	(**	FAR WIN & INDEVINGLETING COOPES, DON & IN MATL2	000320		
60276	129#	C + +	TO A DITAL NUMBER	600320		
6.0301	130*			680324		
00303	131¢			000327		
LD 304	132*	85	NROK = MATCH(J11.2)	606331		
00305	133*		60 TO 86	600332		
00306	134*	64	CONTINUE	000336		
00310	135*	86	MTPRC2(J10+1)=MAT12INROW,4)+CONFAC	000336		
60311	136*		HTPR02(J10,2)=HAT12(NROW,1)	600341		
<u> </u>	137*		HTPP02(J10,3)=HAT12(NR0N,3)	606343		
66313	138*		MTPR02(J10,4)=HAT12(NR0W,8)	000345		
<u> </u>	139*		HIPROZ(J10,5)=HAT12(NROW,9)	006347		
00315	1467	~ 7	MIPRUZ(J11,6)=MAI12(NRUW,1U)	U <u>n</u> 0351		
	102+	63		600355		
00310	1424	ر ++ ۲ ++	LALULAIL NEARINI Set nd geometrie drop-dife gata	600355		
(11320	144+	<u> </u>	SET OF BEUNEIRIE PROFERILES DATA			
60326	145#			000355		
60322	146*		CALL PATHIKKUDE CRAPTO PRADI ISTOP NUMIT VVOL NUMERO MATCH THORY	000741		
00323	147*		WRITE(12.795)	000301		
00325	148*		NPAR (4) = NUHGE O	LOGUOU		
60326	149*		WRITE (12,504)(NPAR(J11),11=1,6)	000406		

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_	81	.A.M.			DATE 073080	PAGE	5
	60331	15ü+	795	FORMATLY COMM ELEMENT CONTROL FROM BEAN'I	000416		
		151*	C **	NPAR TO FILE 12	000416		
	60331	152+	c	PRINT 799	000416		
	00331	153*	C799	FORMAT(* NPAR TO FILE 12+)	000416		
	60331	154*	C	PRINT 504. (NPAR(IP).IP=1.6)	<u> </u>		
	00332	155*	504	FORMAT (615)	000416		
	60333	156 *		wRITE(12,349)	600416		
	60335	157*	349	FORMAT(COMM MATERIAL PROPERTIES FROM BEAM)	000427		
	LO336	<u>158*</u>		DO 350 J12=1, NUMMAT	000427		
	60341	159*	35n	WRITE (12,300) MTPRO1(J12),(MTPRO2(J12,J13),J13=1,6)	UO0427		
	60351	160*	300_	FORHATII5.5X.F10.4.F10.0.F10.4.3F10.0]	000445		
	i0351	161*	С	PRINT 8999	000445		
_	60351	<u> 162 </u>	<u>C8999</u>	FORMAT(MTPRO1 AND MTPRO2 TO FILE 12")	000445	·	
	uU351	163+	С	$PRINT 300, HTPR01(J_{12}), (HTPR02(J_{12}, J_{13}), J_{13}=1, 6)$	000445		
	60352	164#			000445		
	0355	165*	270	FORMAT (2X, FOR CONST. CODE , 14, FOR THE FOLLOWING PROPERTY IDS,	000456		
	<u></u>	166*		<u>LENTER_CROSS-SECTION_CODE_(KSEC]:1=SYMMETRIC:2=ZEE:3=CIRCULARDEF</u>	000456		
	60355	167*			000456		
		<u> 168 </u>		DO 282 JIREL NUMBEO	000456		
	(0361	1094			LUU456		
	<u> </u>	171*			<u>LUU457</u>		
	00365	171*	2/1	FURHATION, "PROPERTY ID~",14)	000465		
	00300	1734					
	- C 373	174-	787	CONTINUE DE CORTIGIO, 27-1000	500473 500507		
	<u>HLJ1J</u>	175%			000507		
~	6040.	176#			000507		
2 -	L0400	177*	(* *	FOR DID NO. INDEVENDITETND CORPESSION NO. IN PRARZ	000507		
X	0.0401	178*	C ·	no 264 JIEI-NUMERO	000514		
-	L0404	179#		IF (MAICH(J11.1).E.Q. INDEX (110)) 50 TO 285	000514		
<u>+</u>	60400	183*		GO TO 284	000517		
. .	60407	101*	285	NRGW=MATCH(J11,2)	000521		
	60410	182*		<u>60 10 286</u>	000522		
	60411	183×	284	CONTINUE	000526		
	<u> </u>	184#	286	GEOPR2(J10+1)=PBAB2(NROW.1)		· · · · - · · ·	
	60414	105*		GEOPR2(J1C,2)=PBAR2(NROW,4)	600530		
	60415	106*		GEOPH21J1D.3]=FHAR2(NROW.3)			
	6041c	187*		GEOPR2(J13,4)=PBAR2(NROW,2)	600534		
	60417	188*			006543	· · · · · · · · · · · · · · · · · · ·	
	60422	1974	290	GEOPR3(J10, J12)=0.	600543		
	00424	190#		WRITE(6:2/2)INDEX(JID)	000544		····
	60427	1914	212	FORMATIZX, FOR PROPERTY ID, 14, 'ENTER THE SIX SECTION MODULI 2. Y	000554		
		107.		TUD HAVE TU SPECIE LALL OR NUNE THEFAULTIS' / ISX. "HEFAULT MEANS LURK			
	1 3435	104.		TESPUNDING SIRESS IS ZERU'I	000554		
		165#	295				
	00435	196#	275		000555		
	<u> </u>	107*					~ "
	60442	198×			000565		
	60445	199=		D0 298 J15=1.6	000602		
	LN45U	260*	298	GEOPR3 (J16, J15)=DUMM(J15)	606662		
	C0452	2010	297	CONTINUE	000615		
	60453	21i2#	283	CONTINUE	60615		
	60453	203*	C **	GEOMETRIC PROPERTY DATA CARDS ARE DONE	000615		
	60455	204*		WRITE(12,96)	000615		
	60457	265*	96	FORMAT(* COMM GEUMETRIC PRUPERTIES FROM BEAM)	000627		
	<u>60460</u>	206*		D0 200 J10=1.NUMGE0	LD0627		

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	00463	2117*	299 WRITE (12.57))(GEOPR1(J)(0.J))).J11=1.2).(GEOPR2(J10.J12).J12=1.4).	000627		
	Un463	2118*	1(GEOPR3(J10, J13), J13=1,6)	600627		
	៤០ី463	209*	C PRINT 327	000627		
_	60463	210*	C327 FORMATI' GEOMETRIC PROPERTY CARDS TO FILE 12")	600627		
	60463	211#	С 00 331 J10=1, NUMGEO	000627		
•	00463	212*	C331 WRITE (6,273)(GEOPR1(J10,J11),J11=1,2),(GEOPR2(J10,J12),J12=1,4),	600627		
	60463	213*				
	00502	214#	2/3 FURMATIZIS,4FIU.3/0FIU.3/	000661		
	(0503	216#		800661		
	00505	217*	111 FORMAT (//15x.*FLEMENT LOAD MULTIPLIERS FOR CONST. CODE*.14/)	000673		
	L0507	218*	Do 115 K6=1,3	000673		
	00512	219#	DO 115 K7=1.4	000673		
-	60515	220*	115 EMUL(K6,K7)=0.	000673		
	<u>UU520</u>	221*	UO 120 Kg=1,4	000704		
	60523	222*	WRITE (6,112) VAR(K8)	000704		
	60526	223*	112 FORMATIZX, FOR LOAD . A1. FITER X, Y, Z ELEMENT LOAD FRACTIONS, IN T	000711		
	00526	224*	IHAT ORDERDEFAULTEALL ZEROS*J	000711		
·	40527	2237	READES / JUDIM	000717		
	60532 1.0532	2204		600721		
	66540	228#				
	60541	229*		(100732		
	LU542	230*	EMUL (3, K8) = DUM 3	000734		
	1.0543	231*	12D CONTINUE	606741		
	60543	232*	C PRINT 6666	600741		
ک	00543	_233*	C6666 FORMAT(" EMUL TO FILE 12")	000741	<u></u>	
5	60545	234*	wRITE(12,1117)	600741		
ና	<u>10547</u>	235*	1117 FORMAT(COMM EL. LOAD HULTIPLIERS FROM BEAM)	000751		
.	00551	2307	UU 121 K9-1,4 121 VDTE 4.2 1464/EMIN (Ko K10) K10-1 41	000751		
7 7	00555	238#		000751		
	60562	239*	116 FORMAT (4FIG.0)	000765		
	LD562	240*	C ** GENERATE FIXED-END FORCE DATA	000765		
	66563	_241*	IF (NPAR(6).EQ.D) 60 TO 125	600765		· · ·
	60565	242*	WRITE(6,117)KOAD(J1)	000767		
	<u>L0570</u>	243*	117 FORMAT (20X, * FIXED END FORCE DATA FOR CONST. CODF*.14)	600775		
	00571	244*	NUMFX=NPAR(6)	600775		
	00571	245*		600775		
	60572	2467	STICLES IN ALL SFI TO FILLES	000775		
	LD574	248#	1118 FORMAT(F COMM SET FROM BEAM*)	001004		
	<u>un575</u>	249*	0 123 M1=1.NUMFX	001004		
	00600	256*	WRITE (6,118)M1	001011		
	60603	251*	118 FORMAT (2X. "FOR FIXED FORCE SET NO.". I3. ENTER RX.RY.RZ.MX.MY.MZ	661017		
	00603	252*	1FOR HODE I *)	001017		
	60604	_253*	READ (5,7)(SFT(M2),M2=1,6)	001017		
	00607	254 # 265 #	WRITE (6,119) 119 Format Joyn Clame Theo For Adde 111	001027		
 .	00011	256#	HAT TUNERT 12A, SARE INFU FUN NUL J'I			
	rin61s	257#	WRITE (12.1221W).(SFT(M2).M2=1.121	[UJUPT 007034		
	60615	258*	C WRITE (6,122)M1,(SFT(H2),H2=1,12)	UC1044		
	60621	259×	122 FORMAT (15,6F10.2/5X,6F16.2)	00100		
	UC622	263*	123 CONTINUE	601060		
	00624	261*	125 CONTINUE	<u>u01060</u>		
	00624	262*	C ** GENERATE ELEMENT DATA	001060		
	66625	2037	₩ <u>R11E (6,12/)KOAU(J1)</u>	<u> </u>		

<u> </u>				
111671	264*	127 FORMAT (//15X."BEAM FLEMENT DATA FOR CONSTA CODE" 15/1	001101	
00037	265*	DO 150 KRON=1.ISTOP	L01101	
Ú0634	266*	IX=CGARIU(MROW.1)	001101	
00635	267#	NODE(1)_CBARID(KROW,2)	001163	
00636	268*	NODE (2)=CBARID (KROL: 3)	001105	
60637	269*	WRITE (6,130)IX	601107	
<u> </u>	27:0*	130 FORMAT 12X+ "ENTER DESIGN VARIABLE, NO++IDV+FOR FL+ NO++IS)		
60643	271*	READ (5,7)CBARID(KROW,7)	601115	
<u> </u>	272*		L01123	
00651	275*	131 FORMAT 12X, "ENTER DESIGN VARIABLE FRACTION, FRC, FOR EL. NO.", 14,	601131	
	274*			
60652	2154	FRC IKRON, LJII.	001131	
<u></u>	277+		601143	
00050	2714		001141	
00661	279#		001146	· · · · · · · · · · · · · · · · · · ·
10662	280~		001146	
<u> </u>	281#		C01152	
00505	282*		601154	
<u>UD671</u>	2814		001156	
00071	284#	NATIC (0,1327)A 132 FARMAT (27, TENTED LUMEEDS OF ETYENWEND FORCE SETS FOR FL. LOADS A.	001150	
<u> </u>	285#	$H_{1} \cap PESPECT_{1} \in GP = 1 \circ O^{-1} \circ A^{-1} \circ D^{-1} \cap D^{-1} \cap A^{-1}		
00675	286#	REAL (5.7) TRUMMAN	001164	
	287*		001172	
60702	288*		001176	
60705	289*	Eo 154 M3=1.4	001213	
00710	29J≭	154 ELDAT(KROW-M3)=TDUMM(M3)	001213	
Un712	291*	153 CONTINUE	001217	
uč713	272*	U0 16D H4=5,16	601217	
60716	293*	160 ELDAT(KROW,M4)=* *	001217	
<u> </u>	294#		001224	
60723	295*	M4HI=M4-1	001224	
66724	296*	WRITE (6:135)1x.JOR(H4).NODE(M4)	001227	<u> </u>
ú0 731	297*	135 FORMAT (2X*FOR EL+ NO+*,13,,* NODE *,A1,*(*,I3,*) ENTER THE NO+ OF	001237	
50731	298*	1 END FORCES RX.RY.RZ.MX.MY.MZ.KNOWN TO BE ZERO")	601237	
∠7310	299*	READ (5,7) NONE	001237	
	363*	1F (NONE.EG. 0) GO TO '17D	001245	
60737	≠1ن3	IF(NONE+EQ+6) GO TO 168	601247	
00741	362*	<u>GO TO 169</u>	601252	
60742	3113*	168 DO 165 M7=1,6	001254	
00745	304*	165 ELDATIKROW,4+M4M1+6+M7)=*1*	001264	
L0747	345*	60 TO 175	001266	
<u>L0750</u>	<u></u>	169 WRITE (6.137)JOR(M4).NODE(M4)	001270	
00754	3u/≄	137 FORMAT (2X, FOR NODE ', A1, '(', I3, ') ENTER THE END FORCES KNOWN TO	001305	
<u> </u>		1 BE ZEROUSE THE FOLLOWING CODES: RX=1.RY=ZMZ=6*)		
00755	309#	READ (5,7) (ENDFOR (M5), MSEI, NONE)	001305	
	310#		601327	
00766	3114		001327	
<u></u>	<u> </u>	171 CONTINUE		
66776	314		001157	
<u>utra</u>	<u></u>	ITU CONTINUE		
1,1002	316-		001357	
ULUUL .	317±			· ·
01005		UV XID N721 /	001321	
01005	3184	175 = 610411446 + 403 = c c a c 10 / MG = MO3	001757	
01005	3184	175 ELDATI(H8, M9)-CBARID(M6, M9)	<u> </u>	

1		
- }	·	

	BEA	м		DATE 073080	PAGE	8
•	01021	321+	176 ELDAT1(M8, M9)=ELDAT(M8, M9-7)	001371		
	01024	322.	NNCOL1=23	001377		
	01625	323*	NNCOL2=1	601461		
	01026	324#	CALL ELORD(ISTOP,ELDAT1,FRC,NNCOL1,NNCOL2)	001403		
	<u>61026</u>	325+	C PRINT 4444	001403		
	U1025	326*	C4444 FORMAT(" ELEMENT DATA TO FILE 12")	601403		
·	61627	327*	wRITE(12,4445)	001412		
	01031	328*	4445 FORHATE COMM EL. DATA FROM BEAM)	001417		
	<u> </u>	329*	00 180 M12=1,ISTOP	001417		
	61635	330+	18DRITE_ (12,136)(ELDAT1(H12,H13),H13=1,7),FRC(H12),(ELDAT1(H12,H13),	601426		
	01035	331*	1H13=8,23)	001426		
	ü1035	332*	C180 WRITE (6,136)(ELDAT1(H12,H13),H13=1,7),FRC(M12),(ELDAT1(H12,H13),	601426		
	61035	333*	<u>C 1H13=8,23)</u>	001426		
	61051	334 👞	136 FORMAT (715,F10.0,4A5,12A1,3X)	001454		
	61052	335*	<u> </u>	<u>C01454</u>		
	61053	336*	450 ISTOP1=ISTOP	CO1464		
	<u>61654</u>	337*	00 451 K15=1, tSTOP			
	ü1ü57	339+	451 IDV21(K15)=ELDAT1(K15,7)	001471		
	61661	339*	<u>60 TO 1000</u>	<u> </u>		
	<u>í</u> 1ü6ž	340*	46D ISTOP2=ISTOP	001475		
·	01063	341*	D0 461 K16=1.ISTOP	001476		
	U1 G66	342*	461 IDV22(K16)=ELDAT1(K16,7)	001502		
	01070	343*	1000_CONTINUE	<u>C01506</u>		
	61672	344*	IF(NKOUE.E0.1) GO TO 1100	C01506		
		345*	NIDV2=ISTOP1+ISTOP2	601511		
	61675	346*	DO 1610 K17=1,ISTOP1	601532		
<u> </u>	61100	<u>347*</u>		601532		
a –	01102	348*	DO 1020 K18=1,ISTOP2	001541		
<u> F</u>	<u> </u>		1020 I0V2(ISTOP1+K18)=IDV22(K18)	001541		
<u> </u>	61107	350+	GO TO 1115	601543		
<u> </u>	01116	351*	1100 NIDV2=1STOP1	001545		
œ	U1111	352*	00 1110 K17=1,ISTOP1	001546		
	01114	353*	1110 IDv2(K17)=IDv21(K17)	001554		
	01116	354 *	1115 CONTINUE	001557		
-		355*	RETURN	001557		
	61126	356*	END	001645		
	ENU FOR					

.HDG,P CANDP

CANUE	>				DATE 073080 PAGE	1
éFOR . S	CANDP . CANDP					
HSA E3 -	07/30/80-09:4	45:12 (53,)				
SUBROU	TINE CANDP	ENTRY POINT COD663				
				······································		
STURAGE		(1) 000/10; UATA(U) 000141	; BLANK CUMMUN(2) UUUUUU			
			· · · · · · · · · · · · · · · · · · ·			
6003 6004	BACH DOOD Handel Good	044 174				
EXTERN		S (BLOCK, NAME)			·····	
0005	 I L	······································				
<u>uoc6_</u>	NRESS	· · · · · · · · · · · · · · · · · ·				
0037	NRDUS					
0010	N1036					
4012	NIUZS NFRR25					
0013	NIO15					
<u>J014</u>	NERR35					
STORAUE	ASSIGNMENT	IBLOCK, TYPE, RELATIVE L	OCATION, NAME)			
0000 1000	000033 1F	0000 060054 10F	0000 000057 11F	0061 00041 1156	0001 000064 127G	
UOU1	000267 1620	6 0001 000175 17L	JOD1 000242 1746	0001 000230 18L	U001 000261 20L	
0000	000034 2C1F	6001 000273 2056	0001 000314 211	0001 000332 2176	0001 000340 2236	
0001	0u0372 236G	6 UUG1 000412 246G	0001 000427 25L	0001 000445 2536	0001 000453 2576	
6631	000504 261	<u> </u>	<u> </u>	0001 000530 2776	<u> </u>	
	UUU6U5 316G	6 UGUO DUCD62 35F	0000 000065 36F	0060 00070 37F	0000 000042 5F	
	<u>. 000220 216</u>			0000 T 000031 KC		
0000 1	L 066632 KP	DDU4 GGODDA KVCHI	D0004000024_KVCP10	0000 I 000025 L	<u>U000 I 000026 LIM</u>	
4 004	ULD170 MAXM	10 0004 000171 HAXPI	D 0000 I 000024 NEND	UDU3 I CUOD22 NSTART	0003 I 00000 NUM	
0004 (<u></u>	<u>110034 1 560173 NUMP1</u>	D			
00101	1*	SUBPOUTINE CANUPIKUE, NC	CARD, NPCARD, COUT1, COUT2, POI	UT1,POUT2)	000030	
		COMMON/BACH/NUM(18),NSI	ART(16)			
60104		CHANGE GROUP, NO. OF FU	//////////////////////////////////////	NAUUTAINAULTA	000030	
C0105	5÷	INTEGER COUTI(100.6)			000030	
60100	6*	DIMENSION COUT21100,31			600030	
66106	7* C **	CHANGE GROUP. NO. OF PI	D'S		000030	
	<u>8</u> *	INTEGER POUTI(25,2)	·····		000130	
00110 00110	77 10≉ C ±±	UINCNSIUN PUUI2(25,5)	****	6 4	600030 600030	
00111	11*	DIMENSION DUM(20)		······································	<u></u>	
					000030	

CAN	NDP			DATE_673080	PAGE	2	
66111	174	C **		6 000 10			
00111	144	<u> </u>	NCCARD, INFUT NO. OF C CARDS TO BE READ	006030	····		
00111	164		NPCARDA INPUT NO. OF P LARDS HO BE READ	000030			
10111	154			000030			
601112	10+	C ++		000030			
00112	184		REMINU AA NENN - NSTADT (MIRA-1	00003[[
66116	19±			000033			
10117	2114	50		C00030			
L0123	21#	1		000041			
00124	22*	-		000051			
1.0125	23*		Lan Northean Northa	000053			
LU125	24*	С	PRINT 100	000053			
60125	25+	C 100	FORMAT(/.1X*OUTPUT FROM CANDP FOR COUT1 AND COUT2. IN CANDP*/)	00053			
uti126	26*		00 51 L=1.LIM	000064			
60131	27*		GO TC (15,16,17,18,17,20,21).KDEM4	600064	•		
CU132	∠8*	15	READ (11,5) (COUT1(L,J),J=1,4)	600101			
60132	29*	С	PRINT 5. (COUTI(L.1)+J=1+4)	000101			
60132	30*	C	PRINT 200,NUMPID	600101			
LC132	<u>31</u> *	C200	FORMAT(* NUMPID IN CANDP(COUT) *.18)	<u></u>			
L014-J	32 ×		CALL ID(2,NUMPID,COUT1(L,2),KC)	600116			
60141	33*		COUT1(L.2)=KC	600126			
60141	34 ≉	С	PRINT 5, (COUT1(L,J),J=1,4)	000126			
L0142			60 T0 51	000130			
60143	36 #	16	READ (11,6) (COUT1(L,J),J=1,5);(COUT2(L,J),J=1,3)	000132			
L0143	37*	<u> </u>	<u>WRITE (6.6) (COUT1(L.J), J=1.4), (COUT2(L,J), J=1.3)</u>	000132			<u> </u>
00155	38*		CALL ID (2,NUMPID,COUTI(L,2),KC)	000161			
	39#			000171			
0157	40+	17		606175			
<u></u>	42+	L I		000175		<u> </u>	
Ge167	43#	č		000214			
60175	44#			606224			
C0171	45≉		GO TO 51	600226			
60172	46*	18	READ(11,8) (COUT1(L,3),J=1,6)	600230			
LG172	47#	C	WRITE(6,6) (COUT1(L,J),J=1,6)	000230			
LC200	45*		CALL IU(2,NUMPID,COUT1(L,2),KC)	600245			
<u>Un201</u>	49*		COUT1(L,2)=KC	<u> </u>			
LU202	50*		GO TO 51	U00257			
00203	<u>51*</u>	20	READ (11,10) (COUT1(L,J),J=1,5),COUT2(L,1)	000261			
0203	52¥	C	₩RITE(6,1c) (COUT1(L,J),J=1,3),COUT2(L,1)	000261			
60212	<u>53*</u>		CALL 10(2:NUMPID:COUTI(1:2).KC)	600300			
	54 <i>×</i>			000310			
			60 10 S1	L0U312			
00215	50*	~ ~ ~	READ (11,11) (COUT(11,3),3=1,2), (COUT(21,3),3=1,4)	000314			
1 11 2 7 7	<u> </u>	<u> </u>		000314			
6023	-0±		Call I D (2, NORP D), COUTIE, (2), RC	000343			
L0231	60*	5.		<u></u>			
1.0233	61*	-1		000361			
6n234	62*		NEND = NSTART(KDE+7)-1	ED0364			
បច័235	63*		00 52 L=1.NEND	000367			
LU240	64*	52	REAU (11,1)Daim	000372	······································		
00244	65*		LIM = NUM(KDE+7)	000402			_
60244	66#	C	PRINT 101	L00402			
60244	67*	C101	FORMATIIX, UTPUT FROM CANDE FOR POUTL AND POUT2, IN CANDE*/)	600402			
60245	68≉		UO 53 L=1,LIM	000404			
<u>00250</u>	69*		60 TU 125,26,27,27,27,27,27, KDEM4	000412			

XXXI-20

60251 70= 60251 71= 60263 72=	25				
60251 71* 60263 72*	£ 3		666677		
60263 72*		$\frac{\alpha_{1}\alpha_{2}}{\alpha_{2}} = \frac{\alpha_{1}\alpha_{2}}{\alpha_{1}} = \frac{\alpha_{1}\alpha_{2}}{\alpha_{1}} = \frac{\alpha_{1}\alpha_{2}}{\alpha_{2}}	£00427		
00203 124	C C	[A(1)] = S + (F + O + T + C + O + T + C + T + F + O + C + C + C + O + C + C + O + C + C	000427		
1					
UU204 734	~		000466		
<u>00264</u> 744		PRANI ZULINUMIU			
00265 754	201	FORMATI ' NUMMID IN CANDY (FOUL)', 18)	000470		
		CALL TULLANDAM TURDULAN IZANAPI			
	c	PDUITL(2) = PPUITL(1) + P = P = P = PPUIT2 + P = P = P = P = P = P = P = P = P = P	000500		
<u>UU201 104</u>	Ų		000500		
UU2/U /7≢ ∠a271 kas	24		000502		
		$\frac{R_{AV}}{R_{AV}} = \frac{(A_{A,A}) (A_{A,V}) (A$			<u> </u>
	L	$\begin{array}{c} PRINI 35, POUII(1, 3, 3-1, 2), POUII(1, 3), 3-1, 5) \end{array}$	000504		
<u>111303 824</u>	······································				
(0305 84*		r_{00}	000545		
00305 65+			000545		
00000 004 00306 86±	r		000000		
66307 00*	····· V		<u></u>	· ·	
	77	DEAD (11,37) (DOUTINE IN 1-1,7) (DOUT2NE IN 1-1,5)	000007		
	<u>61</u>				
	ι		000561		
10322 9U+					
0323 914			000620		
<u>(0324 - 924</u>		CALL ID LINERIU. POULIIL. 21, RPJ			
UU325 93#	~		010632		
<u>00325 994</u>	<u>_</u>		<u> </u>		·
	53		000640		
00330 90+			000840		
00221 414		FORMAL (0X,518,578,47)	000640		
LUISSZ 98*	<u>(</u>		000640		
0774 1.0+	•		000640		
<u>00334 100</u> 4					
	11	FURNAT 183,218,418,44	000640		
CO330 102+					
	30	FORMAT (00, 210, 350, 44)	000640		
00340 165±			000640		
L0342 156±			C00307		
END FOR					
aHDG.P CO	UNT				
			,		
		· · · · · · · · · · · · · · · · · · ·			

COUNT

<u>aFOR,S</u> <u>COUNT,COUNT</u> HSA E3 -07/30/80-09:45:18 (3,)

SUBROUTINE COUNT ENTRY POINT 600053

STORAGE USED: CODE(1) DODU63; DATA(U) DUDD12; BLANK COMMON(2) DODUDD

COMMON BLOCKS:

GOG3 HANDEL JC0172

EXTERNAL REFERENCES (BLOCK, NAME)

UUU4 NERR35

STURAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME)

Set 3 1 000124 KVCPID 60.3 I 000170 HAXHID 3003 I 000171 HAXPID	

DATE 073080

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X					
\mathbf{Z}^{-}					
Τ	CU101	14		SUBRCUTINE COUNT(NUMMID.NUMPID)	
N 10	LU133	2 #		COHMON/HANDEL/KVCMID(20), KVCPID(100), HAXHID, HAXPID	000005
·•	60103	<u> </u>	<u>C ++</u>	NUMMID(NUMPIG).OUTPUT.NO.OF NON ZERO ELS.	000005
	60103	4 ≠	C **	IN KVCMIU(KVCPID)	000005
	<u> </u>	5*	(; **		000005
	60104	6 *		K0UNT=0	600005
	LU105	7*		LO ICO I=1.MAXMID	C00011
	6011.	8 #		IF (KVCMID(I) +NE+0) GO TO 20	600011
_	<u>L0112</u>	9*		60 TO 126	000013
	60113	±11	20	KOUNT=KOUNT+1	000015
-	60114	11+	100		000022
	60116	12*	120	CONTINUE	600022
	60117	13*		NUMMIDEKOUNT	000022
	60120	14#		KOUNTEL	000023
	00120	<u>15*</u>	<u> </u>		000023
	U0121	16*		00 101 I=1,MAXPID	600027
	<u>i0124</u>	17#		IF (KVCPIU(I)_NE_D) GO TO 21	000027
	60120	18#		60 TO 121	600031
	66127	19*	21	KOUNT_KOUNT+1	0nnn33
	60130	20×	101	CONTINUE	UCU040
_	00132	21*	121		000040
	60133	22*		NUMPID_KOUNT	606040
	60134	23#		RETURN	000041
	00135	24*		END	00062
	ENU FOR				

aHUG,P UIF

DIF	

_FOR.S__UIF.UIF_ HSA_E3_07/30/80-09:45:20 (3,)

SUBROUTINE DIF ENTRY POINT UDU105

STORAGE USED: CODE(1) ODD123; DATA(U) ODD220; BLANK COMMON(2) ODD000

EXTERNAL REFERENCES (BLOCK . NAME)

LUD 3 NERR 35

STORAGE	ASSIGNMEN	T (BLOCK, T	YPE, RELA	TIVE LOCA	ATION, NA	MEJ								
6001	000016 10	5G 00V1	000633	116G	0001	000036	1216	0001	000000	136G	0001	000050	19L	
	000042.30	L0000	I_060176		0000	000201	TNJPS	οποα τ	000200	J	00001	000177	KOUNI	
3030 I	AN DOUDUG MA	x cooo	1 000001	VIDV1										

DATE 073080

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_	U0101	1*		_SUBROUTINE_DIF(NVIDV.VIDV.NDIF)		
	60101	2*	(**	NVIUV.INPUT.NO. OF ELS. IN VIDV	000011	
X _	60101	3*	<u> </u>	VIDV.INPUT.VECTOR OF DESIGN VARIABLE NOS.		
X	60101	4+	C **	NDIF.OUTPUT.NO. OF DIFFERENT DESIGN VARIABLE NOS.	000011	
<u> </u>	<u>ualas</u>	5*		INTEGER VIDV(125).VIDV1(125)	000011	
T	60104	6 *		MAX=VIDV(1)	ū00011	
¦22	60105			DO 10 I=2,NVIDV		
••	00110	8 🕈		IF(VIDV(I).GT.HAX) HAX=VIDV(I)	U00016	
	60112	9.	10	CONTINUE	000025	
	U0114	10+		KOUNTEG	000025	
·	L0115	11+		DO 20 I=1.MAX	000026	
	60120	12+		DO 19 J=1,NVIDV	000036	
	60123	<u>13*</u>		IF(VIDV(J),EU,I) GO TO 3G	000036	
	00125	14+		GO TO 19	000040	
_	<u>µ0126</u>	<u>15*</u>				
	60127	16*		VIDV1(KOUNT)=I	606045	
•	60130	17*	19		00053	
	üD132	18 #	2 ü	CONTINUE	000053	
_	<u>DD134</u>	<u>19*</u>	40.	NDIF=1	600053	
	LO135	2:)≠		DO 5L I=2,NVIDV	000060	
	<u>00140</u>	21*		IF(v10v1(1).NE.VIDv1(I-1)) NUIF=NDIF+1	000060	
	00142	<2*	50	CONTINUE	000067	
·	60144	23*				
	L0145	24 +		END	606122	
	END FOR			_		

GHDG,P ELORD
FLORD

DATE 073080 PAGE 1

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SFOR, S ELURU, ELORD

HSA E3 -07/30/80-09:45:23 (20,)

SUBROUTINE ELORD ENTRY POINT DO0151

STORAGE USED: CODE(1) OUC165; DATA(U) OCOD73; BLANK COMMON(2) ODDUOU

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EXTERNAL REFERENCES (BLOCK, NAME)

UUU3 NERR35

STORAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME)

6001	00041 1166	6801	000105 1326	0001	000122 142G	0001	000023 151L	6001	000053 152L
	I 000040 I	0000	000044 INJP\$	0000 1	000041 J	0000 I	DUDD36 NEND	0000 I	OCOO37 NROWMX

.

COULD 10 SUBPORTING ELEMPTING LIATIFEDATION COL21 COUNT COUNT 1			• •			
Colloi 2* C ** C ** <thc **<="" th=""> C ** C ** <thc< td=""><td></td><td></td><td></td><td></td><td>SUBROUTINE ELORDINUP, ELDATI; ELDAT2, NCOL1, NCOL2)</td><td></td></thc<></thc>					SUBROUTINE ELORDINUP, ELDATI; ELDAT2, NCOL1, NCOL2)	
Control State Integer (LDA) 11100,23 Count Control State Control Count Count Control State Control Count Count Control State Control Count Count Control State Count Count Count Control State Count Count Count Control State Count Count Count Count Control Count	\times	00101	2 #	(**	CHANGE GROUP. NO. OF ELEMENTS	000017
COULD Could Could Could Could Could Could <thcould< th=""> <thcould< th=""> <thcould<< td=""><td>× -</td><td></td><td></td><td>~</td><td>INTEGER ELDATITIOU,23)</td><td>000017</td></thcould<<></thcould<></thcould<>	× -			~	INTEGER ELDATITIOU,23)	000017
T CDD0 Set C C C C COUDT C CDD5 6* INTEGER ELDMAX, HOLD1(23) COUDT C CDD5 6* C CUD017 CDD017 CD106 7* CH1MENSION HOLD1(3) COUDT CUD017 CD106 7* CH1MENSION HOLD1(3) COUDT CUD017 CD106 7* CH1MENSION HOLD1(3) COUDT CUD017 CD106 7* CH1MENSION HOLD1(3) CUD017 CUD017 CD106 7* C HOLD110, CF POUS IN ELDATI AND ELDAT2 CUD017 CD106 1* C PUT IN ASCENGING ORDER CUD017 CD106 1* C PUT IN ASCENGING ORDER CUD017 C0101 1* NENCENNUH1 COUDT CU017 C0110 1* NENCENNUH1 CUD017 CU017 C0110 1* NENCENNUH1 CU0017 CU017 C0110 1* NENCENNUH1 CU0023 CU017 C0110 1*	X	60104	44	.	DIMENSION ELDATZ(100,6)	
COLDS 6* INTEGEN ELDMAX.HOUDI23 CD0017 COLDS 6* UNREGN HOUDI263 CD0017 COLDS 6* CORDERS ELDAT ARHANS IN ASCENDING ORDER OF TEL (ELDAT1 (L.1)) CD0017 COLDS 6* CONDERS ELDAT ARHANS IN ASCENDING ORDER OF TEL (ELDAT1 (L.1)) CD0017 COLDS 10* C ELDATI.ELDATA CON INPUT.ELEMENT DATA ARRAYS. ON OUTPUT.EL. NUS. HAVE BEEN CD0017 COLDS 10* C ELDATI.ELDATI.ELDATI AND ELDAT2 CD0017 COLDS 10* C ENDITE CD0017 COLDS 12* C MOCL, INCOL2.INPUT.NO.OF COLS. IN ELDATI AND ELDAT2 CD0017 COLDS 12* C MCOL1.NCOL2.INPUT.NO.OF COLS. IN ELDATI AND ELDAT2 CD0017 COLDS C PPINI INT. NEND. COUD23 CD0017 COLDS C PPINI AND COUD23 COUD23 COLD 10 16* ELDATI AND ELDAT3 COUD23 COLD 110 16* ELDATA COUD23 COLD 110 16* ELDATA COUD23 COLD 12 C PRINI AND C OLDA <	T	<u> </u>			~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	
+ L0106 /* UTRENSION HOLD/16/ CD0017 -0106 8* C OPRENSION HOLD/16/ CD0017 CD0017 -0106 9* C NUM-INPUI-NO, UF POWS IN ELDATI AND ELDATI (L,L) CD0017 CD0017 -0106 9* C NUM-INPUI-NO, UF POWS IN ELDATI AND ELDATI CD0017 CD0017 -0108 ELDATIELQATZ NNDELDATIELEMENT DATA ARRAYS. ON OUTPUT,EL. NUS, HAVE BEEN CD0017 -0108 C.0.017.0.012.1NPUT.NO.OF COLS. IN ELDATI AND ELDATZ CD0017 -0110 12* C NENCENUM-I CD0017 -0110 14* 151 NENCENUM-I CD0017 -0110 14* 151 NENCENUM-I CD0017 -0110 16* C111 FORMATI NEND CD0023 CD017 -0111 16* EDPAXELDATITIE CD0023 CD0023 -0111 16* EDPAXELDATITIE CD0024 CD0025 -0111 16* EDPAXELDATIE CD0025 CD1140 -0112	ί <u>ν</u>	60105	0.9		INTEGER EIDMAX, HOLD1(23)	600017
L019b 8* C ORDERS ELDAT ARRAYS IN ASCENDIG ORDER OF IEL (ELDAT1 (L,1)) D00017 L010b 10* C ELDAT1 (ELDAT2 ON INPUT,ELEMENT DATA ARRAYS. ON OUTPUT,EL. NUS, HAVE BEEN C00017 L010b 10* C ELDAT1 (ELDAT2 ON INPUT,ELEMENT DATA ARRAYS. ON OUTPUT,EL. NUS, HAVE BEEN C00017 L010b 12* C NCOL1,NCOL2.INPUT.NO.OF COLS. IN ELDAT1 AND ELDAT2 UC0017 L0101 13* ACROENUM41 UC0017 UC0017 L0110 14* 151 NENDENUM41 UC0017 L0111 14* NENDENUM41 UC0017 UC0017 L0111 14* IS1 NENDENUM41 UC0017 L0111 14* IS1 NENDENUM41 UC0017 L0111 14* IS1 NENDENUM41 UC0017 L0111 15* C PSIN1 III NEDDENUM41 L0111 IF (ELDAT1*(1*NENU IS0 UC0023 IS0 L0111 IF (ELDAT1*(1*NENU IS0 UC0025 IS0	÷	<u>L0106</u>	/+		DIMENSION HOLD2(6)	600017
JUIDS J# C NUM.INFUTINO. OF POUS IN ELDATI AND ELDATI 2 LODOIT L0105 10% C ELDATI ELDATI 2: ON INPUT, ELEMENT DATA ARRAYS. ON OUTPUT, EL. NUS, HAVE BEEN LODOIT L0105 11% C PUI IN ASCENTING ORDER LODOIT L0105 12% C NENDENUM-1 LODOIT L0110 14% 151 NENDENUM-1 LODOIT L0111 14% 151 NENDENUM-1 COUD23 L0111 15% C PRINT ATTA COUD23 L0111 16% C111 FORMAT(* NENUE*********************************		50106	8¥	C	ORDERS ELDAT ARRAYS IN ASCENDING ORDER OF IEL (ELDAT1 (L,1))	000017
L0106 10* C EUATI.ELDAT2. ON INPUT.ELEMENT DATA ARRAYS. ON OUTPUT.EL. NUS. HAVE BEEN L00017 L0106 1.* C PUT IN ASCENCING ORDER UD0017 L0106 1.* C NCOL, NCOL2. INPUT.NO.OF COLS. IN ELDAT1 AND ELDAT2 UD0017 L0110 1.* NENDENUM*1 UD0017 UD0017 L0111 1.* NENDENUM*1 UD0023 UD0023 L0111 1.* NENDENU*1 UD0023 UD0023 L0111 1.* IF (NENDENU*1 UD0023 UD0023 L0111 1.* IF (NENDENU*1 UD0023 UD0023 L0111 IF (NENDENU*1 UD0023 UD00023 UD0024 L0112 2.* UD0051 UD0001 UD0001 UD0001 L0120 2.* IF (NENDENU*1 UD0001 <td>-</td> <td>01100</td> <td>9*</td> <td>C</td> <td>NUM.INPUT.NO. OF POWS IN ELDATI AND ELDAT2</td> <td></td>	-	01100	9*	C	NUM.INPUT.NO. OF POWS IN ELDATI AND ELDAT2	
LO106 11* C PUI IN ASCENGING ORDER Dubbit L010 12* C NENDENUM+1 L00017 L0110 13* NENDENUM+1 L00017 L0110 14* 151 NENDENUM+1 L00017 L0110 14* 151 NENDENUM+1 L00017 L0110 14* 151 NENDENUM+1 L00023 L0110 16* C111 FORMAT(* NENDE*, 13) C00023 L0110 16* C111 FORMAT(* NENDE*, 15) C00023 L0113 16* EIDMAXELDAT1(1,1) C00025 C00021 L0113 16* EIDMAXELDAT1(1,1) C00027 C00021 L0112 22* L0 L0125 C1 C00041 L0122 22* L0 L0125 C00041 C00045 L0125 23* L53 ELMAXELDAT1(1,1) L01055 C00055 L0125 25* L52 C01110AX*CIDMAXELDAT1(1,2) L00055 L00055		C0100	10*	C	ELDAT1,ELDAT2. ON INPUT,ELEMENT DATA ARRAYS. ON OUTPUT,EL. NUS. HAVE BEEN	000017
C010b 12* C NC0L_1.NC0L2.INPUT.NO.OF COLS. IN ELDAT1 AND ELDAT2 UC0017 U0110 14* 151 NENCENUH-1 U00017 U0110 14* 151 NENCENUH-1 U00017 U0110 15* C PRINT_111. NENU C00023 U0110 16* C111 FORMAT(* NEND*,13) U00023 U0111 16* E1D*AXELUAT1(1,1) U00023 U0113 16* E1D*AXELUAT1(1,1) U00027 U0114 19* ARGHXEL U00027 U0112 21* U0 152 152,NEN0 U00021 U0120 21* IF4ELDAT1(1,1)*GI-EIDMAX1 00 TO 153 000041 U0122 22* U0 152 152 C00041 U0122 22* U0 152 152 C00041 U0125 25* 152 C00110 U00050 U0125 25* 152 C0NTINUE U00055 U0125 25* 152 NENU, NROWMAX,EIDMAX U00055 U0125		L'0106	.1*	Ç	PUT IN ASCENDING ORDER	<u>000017</u>
UD1U1 13* NENDERUM+1 UDD11 UD1U 14* 151 NENDERUM-1 CD0023 UD1U 15* C PRINT 111. NEND CD0023 UD1U 16* C11 FORMAT(* NEND=*,13) CD0023 UD11U 16* C11 FORMAT(* NEND=*,13) CD0023 UD13 16* E1D*Ax:ELDAT(1,1) CD0025 UD13 16* E1D*Ax:ELDAT(1,1) UD0027 UC13 16* E1D*Ax:ELDAT(1,1) CD0025 UC14 19* MRQ*MX:1 CD0031 UC15 U* U0 152 1:2; NLNU CD0041 UD122 22* U0 152 CD14 D0041 UD122 23* 153 E1UMAx=rLDAT(1,1) CD0045 UD125 23* 153 E1UMAx=rLDAT(1,1) CD0045 UD125 25* 152 CDNTINUE UD0055 UD125 26* C PRINT 22; NENU ARCHARSE 10 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1 MAX = 1		C010P	12*	C	NCOL1,NCOL2.INPUT.NO.OF COLS. IN ELDAT1 AND ELDAT2	UCU017
U0110 14* 151 NENCENENU-1 C00023 U0110 15* C PRINT_111 NENU=*,13) C00023 U0110 16* C111 FORMATI* NENU=*,13) C00023 U0113 16* C100x,000,000 C00027 U0113 16* E10PAX=ELDAT1(1,1) U00027 U0113 16* E10PAX=ELDAT1(1,1) U00041 U0120 21* U0152 L2, NLNU U00041 U0122 22* G0 T_0 152 C00045 U0122 22* G0 T_0 152 C00050 U0122 22* G0 T_0 152 C00045 U0124 24* NROWMX=1 U0050 U0125 25* 152 CONTINUE C00050 U0125 25* 152 CONTINUE C00055 U0125 26* C PRINT 222, NENU, NROWMAX,ELDMAX=*, 1(2x,131) L00055 U0125 27* C222 RECHARGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0126 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND U00055 <	• _	<u>ueiu7</u>	13#		NEND=NUM+1	LODO17
C0110 15* C PRINI_111, NENU C00023 C0110 16* C111 FORMAT(* NEND=*,13) C00023 C0113 16* EID*Ax=ELDAT1(1,1) C00025 C0114 19* HRQ*MX=1 C00031 C0115 CJ* C00041 C00041 C0120 C1* IF(ELDAT1(1,1)*GI*EIDMAX) 60 TO 153 C00041 C0120 C1* IF(ELDAT1(1,1)*GI*EIDMAX) 60 TO 153 C00041 C0122 C2* C0 To 152 C0044 C0123 C3* C0044 C0044 C0124 C4* OTo 152 C0044 C0124 C4* NROWMX=I G00941 C0125 C3* 152 CONTINUE G0095 C0125 C4* C PRINI 22, NENO, NROWMX, EIDMAX C00055 C00055 C0125 C7* C222 FORMATI* NENU, NROWMAX, EIDMAX C00055 C00055 C0125 C7* C222 FORMATI* NENU, NROWMAX, EIDMAX C00055 C00055 C0125 C7* C222 FORMATI* NENU, NROWMAX.EIDMAX C00055 C00055 <td></td> <td>L0110</td> <td>140</td> <td>151</td> <td>NEND=NENU-1</td> <td>000923</td>		L0110	140	151	NEND=NENU-1	000923
L0110 164 C111 FORMAT(* NEND=*,13) C00023 L0111 17* IF (NEND,EQ.1) 60 TO 160 C00025 L0113 164 EID*Ax=ELOAT1(1,1) UDC027 L0114 19* NQ&MX=1 CDU031 L0125 L1* IF(ELOAT1(1,1),51:EIDMAX) 60 TO 153 UD0041 L0122 L2* L0 TO 152 C00041 L0122 22* L0 TO 152 C00047 L0124 L3* EID#Ax=ELOAT1(1,1) C0 TO 153 L0122 22* L0 TO 152 C00047 L0124 24* NRUMX=I L00050 L0125 25* 152 CONTINUE L00050 L0125 25* 152 CONTINUE L00055 L0125 26* C PRINT 222, NENU, NROWMAX, EIDMAX L00055 L0125 27* C222 FORMAT1* NENU, NROWMAX, EIDMAX L00055 L0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 L0127 29* IF(NG_MAX+EQ-NENU) GO TO 151 L00055 L00055 L0127 29* IF(NG_MAX	-	60110	15*	C	PRINT 111. NENU	600023
50111 17* IF (NEND_EQ.1) GO TO 160 C00025 50113 16* EIDPAX:ELDAT1(1,1) 00007 50113 16* EIDPAX:ELDAT1(1,1) 00007 50114 19* ARQWAX:1 000031 50115 2.0* 52 1:2,NLN0 000041 50122 22* 53* 153 6104x:ELDAT1(1,1) 50123 23* 153 6104x:ELDAT1(1,1) 61.6104X 50124 24* NROWMX:ELDAX 50.0047 50.0047 50125 25* 152 CONTINUE 50.0055 50.0047 50125 25* 152 CONTINUE 50.0055 50.0047 50125 25* 152 CONTINUE 50.0055 50.0055 50125 26* C PRINT 222, NEND, NROWMX, EIDMAX:*,3(2X,I3) 50.0055 50.0055 50125 27* C222 FORMAT1' NEND, NROWMX, EIDMAX:*,3(2X,I3) 50.0055 50.0055 50125 27* C222 FORMAT1' NEND, NROWAX, EIDMAX:*,3(2X,I3) 50.0055 50.0055 50125 27* C222 FORMAT1'		L0110	16*	C111	FORMAT(* NEND=*,I3)	600023
UU113 16* EIDPAX:ELDAT1(1,1) UD0027 UC114 19* HRQWMX=1 CD0031 UC115 UV UD 152 12,NNU U00041 UD120 21* UFLEDAT1(1,1)+GT.EIDMAX1 GO TO 153 CD0041 UD122 22* UO TO 152 CDU045 UD122 22* UO TO 152 CDU045 UD124 24* NRUMX=EIDAT1(1,1) UD0050 UD125 25* 152 CONTINUE UD0055 UU125 26* C PRINT 222, NENU, NROWMX, EIDMAX COU055 UU125 26* C PRINT 222, NENU, NROWMX, EIDMAX COU055 UU125 27* C222 FORMAT1 NROW MX = 1 UU125 26* C PRINT 222, NENU, NROWMX, EIDMAX COU055 UU125 27* C222 FORMAT, NENU, NROWMX, EIDMAX COU055 UD125 27* C222 FORMAT, NENU, NROWMX, EIDWAX U0055 UD125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 UD127 29* IF(NRO,MX,EQ.NENU, J)		0111	17*		IF (NEND_EQ.1) GO TO 160	C00025
UC114 19* NRQMMX=1 UD031 UC115 U0 U0 152 U0 152 U0 00041 U0122 22* U0 TG152 000941 00045 U0122 22* U0 TG152 000941 U0122 22* U0 TG152 000941 U0123 23* 153 E10MAX=ELDAT1(1,1) 000941 U0124 24* U0 TG152 U00047 U0125 25* 152 CONTINUE 000955 U0125 26* C PRINT 222, NENU, NRGWMAX, EIDMAX 00055 U0125 26* C PRINT 222, NENU, NRGWMAX, EIDMAX=', TG2X, TG3) U00055 U0125 26* C PRINT 222, NENU, NRGWMAX, EIDMAX=', TG2X, TG3) U00055 U0125 26* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND U00055 U0126 U0 154 J=1, NC011 U00055 U00055 U0131 U0 154 J=1, NC011		GC113	16*		EIDMAX=ELDAT1(1,1)	00027
UC115 UV U0 152 I=2,NLNU U00041 UD120 21* IF(ELDATI(1,1)*GI*EIDMAX) GO TO 153 000041 UD122 22* GO TG 152 00041 UD122 22* GO TG 152 000041 UD122 22* GO TG 152 000041 UD122 22* GO TG 152 000047 UD124 24* NRGWMX=I U00050 UD125 25* 152 CONTINUE 600055 UD125 26* C PRINT 222, NLNU, NRGWMAX, EIDMAX 100055 UD125 27* C222 FORMATI* NENU, NRGWMAX, EIDMAX**, T(2X, T3)) 100055 UD125 27* C222 FORMATI* NENU, NRGWMAX, EIDMAX**, T(2X, T3)) 100055 UD127 29* IF(NRG_MX*EQ*NEND) GO TO 151 000055 UD131 30* UO 154 J=1, NCOL1 000055 UD134 31* HOLU1(J)=ELDAT1(NRGWAX,J) U00106 UD135 32* LLDAT1(NEND,J)=HOLD1(J) U00106	<u> </u>	60114	19*		NRQEMX=1	<u>COUO31</u>
L0126 21* IFIELDATI(1,1)+GT+EIDMAX) 60 TO 153 000041 L0122 22* GO TO 152 CDL045 C[123 23* 153 EIDMAX=ELDATI(1+1) UGD047 L0124 24* NROWMX=I GO0050 U0125 25* 152 CONTINUE GO055 U0125 26* C PRINT 222, NENU, NROWMX, EIDMAX GO055 U0125 27* C222 FORMATI* NENU, NROWMAX, EIDMAX=*, 3(2X, 13) L00055 U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NK0_MMX+EQ+NEND) GO TO 151 U00055 U0134 31* U0 154 J=1, NCOL1 U00055 U0134 31* H0LULJ>ELDATI(NROWMX,J) U00106 U0135 32* ELDATI(NROWMX,J) U00106		üc115	≠ل ∡		UO 152 I=2,NLNU	U00041
U0122 22* U0 TU 152 C0U045 C_123 23* 153 EIDMAX=ELDATI(1,1) UED0047 U0124 24* NRUWMX=1 UED0050 U0125 25* 152 CONTINUE 000055 U0125 26* C PRINT 222, NLNU, NRUMAX, EIDMAX 100055 U0125 27* C222 FORMAT(* NENU, NRUMAX, EIDMAX** 100055 U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NROWMX+EQ+NEND) GO 170 151 U00055 U0131 30* U0 154 J=1, NCOL1 U00055 U0134 31* HOLU(J) = ELDATI(NROWMX,J) U00105 U0135 32* ELDATI(NROWMX,J) = HOLD(J) 00106 U0136 33* ELDATI(NROWMX,J) = HOLD(J) 00106	_	L0120	21*		IF(ELDAT1(1,1).GT.EIDMAX) 60 TO 153	000041
Cr123 23* 153 EIDMAX=ELDAT1([],1) UGD047 U0124 24* NR0WMX=1 UD050 U0125 25* 152 CONTINUE U0055 U0125 26* C PRINT 222, NENU, NR0WMX, EIDMAX U0055 U0125 27* C222 FORMAT(* NENU, NR0WMAX, EIDMAX U0055 U0125 27* C222 FORMAT(* NENU, NR0WMAX, EIDMAX=*, 3(2X, 13)) U00055 U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NEOWMX*EQ*NENU) GO (TO 151 U00055 U0131 3U* U0 154 J=1, NCOL1 U0134 31* HOLU(J)=ELDAT1(NEND, J) U00155 U0135 32* ELDAT1(NEND, J)=ELDAT1(NRGWMX, J) U00106 U0136 33* ELDAT1(NROWMX, J)=HOLD1(J) U00106		60122	22*		60 Τ ₀ 152	00045
U0124 24* NR0WMX=I U0125 25* 152 CONTINUE G00050 U0125 26* C PRINT 222, NEND, NR0WMX, EIDMAX G00055 U0125 26* C PRINT 222, NEND, NR0WMX, EIDMAX G00055 U0125 27* C222 FORMATI* NEND, NRGWMAX, EIDMAX=*, 3(2X, I3)) L00055 U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NEO_MAX.EQ.NEND) GO (TO 151 U00055 U0131 3U* U0 154 J=1, NCOL1 U00055 U0134 31* HOLU1(J)=ELDAT1(NEND,J) U00105 U0135 32* ELDAT1(NEND,J)=ELDAT1(NRGWMX,J) U00106 U0136 33* ELDAT1(NROWMX,J)=HOLD1(J) U00106		66123	23*	153	EIDMAX=FLDAT1(T+1)	460047
UU125 25* 152 CONTINUE GGG055 UU125 26* C PRINT 222, NENU, NROWMX, EIDMAX EOU055 U0125 27* C222 FORMAT1* NENU, NROWMAX, EIDMAX=*, 3(2X, I3)) L00055 U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NKOWMX, EQ.NEND) GO TO 151 U00055 U0131 30* U0 154 J=1, NCOL1 U00055 U0134 31* HOLU1(J)=ELDAT1(NEND, J) U00106 U0135 32* ELDAT1(NROWMX, J)=HOLD1(J) U00106 U0136 33* ELDAT1(NROWMX, J)=HOLD1(J) U00106		66124	24*		NROWMX=I	600050
UU125 26+ C PRINT 222, NEND, NROWMX, EIDMAX EU0055 UD125 27+ C222 FORHAT1* NEND, NRGWMAX, EIDMAX=*, 3(2X, I3)) L00055 UD125 28+ C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 UD127 29+ IF(NROWMX, EQ.NEND) GO (TO 151 U00055 UD131 3U+ UO 154 J=1, NCOL1 U00060 UD134 31+ HOLU1(J)=ELDAT1(NEND, J) U00105 UD135 32+ ELDAT1(NEND, J)=HOLD1(J) U00106 UD136 33+ ELDAT1(NROWMX, J)=HOLD1(J) U00100		00125	<u>25*</u>	152	CONTINUE	600055
Ún125 27* C222 FORMATI* NENU, NRGWMAX, ÉLÚMAX=*, 3(2X, I3) LD0055 UG125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 UG127 29* IF(NRG_MX+EQ+NEND) GO (TO 151 U00055 UG131 30* UO 154 J=1, NCOL1 U00055 UG134 31* HOLU1(J)=ELDATI(NEND, J) U00106 U0135 32* ELDATI(NEND, J)=HOLD1(J) U00106 U0136 33* ELDATI(NRGWMX, J)=HOLD1(J) U00100		JU125	26*	С	PRINT 222, NENU, NROWMX, EIDMAX	00055
U0125 28* C INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND C00055 U0127 29* IF(NEO_MXxEQ*NEND) GO (TO 151 U00055 U0131 30* U0 154 J=1,NCOL1 U00060 U0134 31* HOLUL(J)=ELDATI(NEND,J) U00105 U0135 32* ELDAT1(NEND,J)=ELDAT1(NRGWMX,J) U00106 U0136 33* ELDAT1(NRGWMX,J)=HOLD1(J) G00110		- Un125	27*	C222	FORHAT1 NENU, NROWMAX, EIUMAX= (3 (2X, I3))	600055
L0127 29* IF(NEO_MMX+EQ+NEND) GO (TO 151 U00055 L0131 30* U0 154 J=1,NCOL1 CD0060 U0134 31* HOLU1(J)=ELDAT1(NEND,J) CD0105 L0135 32* ELDAT1(NEND,J)=ELDAT1(NRGWHX,J) CD0106 L0136 33* ELDAT1(NRGWHX,J)=HOLD1(J) C0010		60125	∠8 ≠	С	INTERCHANGE ROW WITH LARGEST EID WITH ROW NEND	00055
LU131 JJ* LU154 J=1,NCOL1 LU0060 LU134 J1* HOLL1(J)=ELDAT1(NEND,J) LU0105 LU135 32* ELDAT1(NEND,J)=ELDAT1(NRGWHX,J) LU0106 LU136 33* ELDAT1(NRGWHX,J)=HOLD1(J) LU130		LG127	29×		IF (NROWMX+EQ+NEND) GO TO 151	000055
UD134 31* HOLUI(J)=ELDATI(NEND,J) GOD105 UD135 32* ELDATI(NEND,J)=ELDATI(NRGWMX,J) GOD106 UD136 33* ELDATI(NRGWMX,J)=HOLD1(J) GOD10		60131	+ ل 3		UO 154 J=1,NCOL1	LOUO60
U135 32* ELDAT1(NEND,J)=ELDAT1(NRGWMX,J) U00106 U036 33* ELDAT1(NRGWMX,J)=HOLD1(J) GOD110		00134	31*		HOLU1(J)=ELDAT1(NEND.J)	600105
LUI36 33* ELDATI(NROWMX,J)=HOLD1(J) GOD110		60135	32*		LLDATI(NEND, J)=ELDATI(NROWMX, J)	000106
		LU136	33×		_ELDAT1(NROWMX,J)=HOLD1(J)	600110

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. (.0137	34 *	154	CONTINUE	000122	
10141	<u> </u>				
00144	36*		HOLD2(J)-FLDAT2(NEND.J)	000122	
00145	37*		ELDATZ (NEND.J) = ELDATZ (NROWNX.J)	600123	······································
60145	3a*		FLDAT2(NROWMX,J)=HOLD2(J)	600125	
· 60147	39*	155	CONTINUE	UQ0130	
60147	40*	(PRINT 333. ELDAT1(1.1).ELDAT1(261).ELDAT1(3.1)	U00130	
00147	41*	C333	FORMATI" ELDATI-3 ROWS,FIRST COL,=",3(2X,I3))	000130	
60151	42*		<u>GO TO 151</u>	000130	
60152	43*	160	CONTINUE	000132	
00153	44*		<u></u>	000132	
00154	45*		END	000164	
ENDFOR					<u> </u>
dHUG , P	FORM1				
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FURM	1			DATE 073080	PAGE 1	<u>ı </u>
SEOD C	6.00M I	5.00M1	•			
HSA E3 -	07/30/8	BD=uo:4	5:27 (10.)		···· <u></u> ··	
	0., 30,		J. Z [\ 1047			
C. 8000	T 1 415 E 7					
	IINE PO			··· · · · · · · · · · · · · · · · · ·		
STORAG	E USED	CODEI	1) COUU72; DATA(G) DODU42; BLANK COMMON(2) DUCODO			
<u> </u>	AL REFE	RENCES	(BLOCK, NAME)			
<u></u>	NUDUS		· · · · · · · · · · · · · · · · · · ·			
3004	NIDIS	5				
	N1029					
	NEDUS					
	NERRS	55				
STORAD	E ASSIC	SNMENT	(BLUCK, TYPE, RELATIVE LOCATION, NAME)			
	<u></u>	10 1060		0000 0000	6 9 F	
0000 0000	00001	SI INJP	2			
			······································			
20101	1*		SUBROUTINE FORM1(NKODE,KOAD,TYPE)	00000		
<u> </u>	<u></u>		INTEGER KUAU(2), ITPE(2)			
00103		č	NRODE-OUTPUT-ING OF CONST- CODES	000000		
66103	5.*	<u> </u>	TYPE INDUCTION OF OF ORDERNT FIENDENT	600000		
6-104	6*	U U	WRITE (6.) TYPE	600000		
L0112	7 *	6	FORMAT (5X. 'ENTER THE NO. OF CONST. CODES USED FOR '. A6. A2. ' ELEME	C00013		
L0112	8 🕈		1NTS,1 OR 2')	000013		
60113	9#		KOAU, 1) = 1	600013		
CO114	10*		KOAU(2)=2	600015		
UD115	11+		READ(5,7)NKODE	600017		
<u></u>	12*	7	FORMATI J	000025		
L0121	13*		IF (NKOUE.EC.2) GU TO 20	600025		
60123	14*		wRITE (6,8)	<u> </u>	· · · · · · · · · · · · · · · · · · ·	
60125	15*	8	FORMAT (5x, 'ENTER THE CONST. CODE NO. (1 OF 2)')	000035		
L0126	16*		READ(5,7) KOAD(1)	000035		
60131	17*	2 Û	RETURN	000044		

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600071

LD132 18*

HUG.P FORM2

END

FOR	M2	<u> </u>			DATE 073080	PAGE 1
FOR S	FORM2 I	FORM2				
HSA E3	-07/30/8	0-09:45	31 (22,)			
						· · · · · · · · · · · · · · · · · · ·
SUBRO	UTINE FOR	RMZ	INTRY POINT GOOL41		· · · · · · · · · · · · · · · · · · ·	
STORA	GE USED:	CODE(1	000165; DATA(U) 900131; BLANK COMMON(2) 000000			
EXTER	NAL REFER	RENCES	BLOCK . NAME)			
	NEDUS					
J034	NI015		······································			
0005	NIO25					
UDU6	NRDUS					
0007	NERR3	\$				
STORA	LE ASSIG	NMENT	3LOCK, TYPE, RELATIVE LOCATION, NAME)			
3000	000050	10F	0001 060006 1066 6001 000017 1146 0001 CO	00046 1306	0061 000054 1	134G
ບິດບາ	06010;	7 1526	0001 0L0122 1616 0000 000014 20F 0000 00	10047_7F	<u> </u>	PF
0000	1 00000	U I	CONO 000113 INJPS CONO I 000001 K			
60101	1*		SUBROUTINE FORM2(J1.KOAD.TYPE.ISTOP.VEID.MAX)		<u>100006</u>	<u> </u>
60101	2*	C ++	J1.INPUT.INDEX OF KOAD		000006	
		<u> </u>	TADE TADATA TODE OF CUDENT FLEMENT		000006	
00101	4 4 5 ±	ر * *	TYPE SINFUT STATE OF CURRENT ELEMENT CONST. CODE		000006	
00101	<u> </u>	<u> </u>	VEID OUTPUT TO NUMBERS OF FLEMENTS		000008	· · · · · <u>· · · · · · · · · · · · · · </u>
60101	7*	C **	MAX, INPUT.CONTAINS MAXIMUM NO. OF FLEMENTS		000006	
60101	8.	C ++			000006	
60101	9.*	<u>C ++</u>	CHANGE GROUP. NO. OF ELEMENTS		000006	
00103	10*		INTEGER VEID(100)		000006	
00103	<u>11*</u>	<u>C **</u>	***************		<u> </u>	
00104	12*		INIEGER KOADIZJ, TYPE(Z)		000006	
<u></u>	137		<u>)U 1 [-X+140</u>			
60112	15*	•	WRITE (6.9) TYPE .KOAD(J1)		600006	
00121	16#	9	FORHAT (2X, "ENTER NO. OF ", A6, A2." ELS. FOR CONST. CODE". 14)	······	600024	
00122	17+		REAU (5.7) ISTOP			
60125	18*		IF(ISTOP.GE.MAX) WRITE(6,20) TYPE, TYPE, MAX		000032	
00141	19*	20	ORMATL' THE NO. OF '.A6.A2. 'ELS. FOR CONST. CODEL IS GREATED	R*/5X	600061	
60141	20*		'THAN OR EQUAL TO THE TOTAL NO. OF ",A6,AZ," ELS.,WHICH IS",I	4/15X	000061	
00141			ST RELAILE NOS OF ELSATI			
00144	<<* 23±	7	LETTOLOGOUANT ATAN 1201172106		006001	
60147	24*		WRITE (6.10)ISTOP.TVPF		600073	
60156	25*	10	FORMATIZX. "ENTER THE".14.1X.46.42." ELEMENT 1D NOS. FOR CONST	. COD	000112	
U0156	26*		ND.1", /5X, "MAKE THEM THE SAME AS NASTRAN NUS."/	·····	600112	· • · · · · · · · · · · · · · · · · · ·
60156	27+		5X, THEY MAY BE PRINTED ON A LINEISI SEPARATED BY A SPACEISI	AND/Q	000112	<u></u>
60155	28*		R CUMMA*)		nnu 112	

000112 000112

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00157

29*

READ (5.7) (VEIU(K), K=1. ISTUP)

FURH2			DA	<u>TE 673080</u>	PAGE	2
00165 30* 10166 31* END FOR	RETURN END			000125		
àHDG,P ID					. <u></u>	
· · · · · · · · · · · · · · · · · · ·						
			·			
					<u> </u>	
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1	4.1	
	v	

éFOR,S 10,ID HSA E3 -07/30/80-09:45:34 (7.) ENTRY POINT UDU045 SUBROUTINE ID STORAGE USED: CODE(1) DUC057; DATA(g) DUC020; BLANK COMMON(2) DUC000 COMMON BLOCKS: UD113 HANDEL DC0172 EXTERNAL REFERENCES (BLOCK, NAME) NERR25 ដាំងដូ C0C5 NERR35 STORAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME) **UUU1** JL0015 1L 6061 000032 100L <u>0001 000005 1066</u> 0001 000021 21 0001 nnn025 50L 2006 000001 7F DUD007 INJPS U000 I 000000 K Unno Uno3 I DUDUDO KVCMID 0003 I 000024 KVCPID ចាព្រំ 3 DUD175 HAXMID 6663 000171 MAXPID UG101 1# SUBROUTINE ID(KIND, NDIFID, IDIN, IDOUT) 000005 60103 2* COMMON/HANDEL/KVCHID(20).KVCPID(100).MAXMID.MAXPID. 000005 00103 3 ¢ C ** KIND+INPHT+1=MID + 2=PID 000005 60103 4 * C ** NDIFID.INPUT. THE NO OF ELS. IN KYCHID OR KYCPID 000005 IDIN. INPUT. THE ORIGINAL MTD OR PID CD103 5+ C ** 000005 L0103 C ** IDOUT.OUTPUT, MODIFIED MID OR PID 6* 000005 60103 7+ С 000005 00103 8≉ 000005 60103 9.0 С PRINT 7,KIND,NDIFID, IDIN 606005 60104 10+ 7 FORMATI * KIND, NUIFÍD, IDIN, INID * 318) 000005 11* 10 100 K=1,NDIFID 60105 000005 00116 12* 60 TO (1.21.KIND 000005 66111 13* 1 IF(IUIN_EQ_KVCHID(K)) GO TO 50 000015 L0113 14 = GO TO 100 006017 60114 15* 2 IF(IUIN.EQ.KVCPID(K)) GO TO 50 000021 00116 16# GO TO 100 600023 60117 17* 50 IDOUT=K 000025 00120 18+ RETURN 000026 100 CONTINUE 60121 19* 000056 -60123 23* ĔND 600056 END FOR aHDG P MAIN

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	MAIN						DATE 073080	PAGE 2
·	<u>0000 I</u> C	002721	<u> </u>	<u> </u>	<u>5060 I 002712 LIM</u>		<u>GC00 I 052674 L2</u>	
	1000 I C		1.3	0030 1 002700 L4	0000 I 002/04 L5	0000 I 002703 NCF		
·		<u>Juz 64 /</u>	NELTTE	P UUUU I UU2642 NELITI	0000 1 002643 NELTT	$\frac{1}{2} \frac{1}{2} \frac{1}$	113 0000 1 002645 NE	<u></u>
		102040	NELIT:	COUNT DU2710 NEND				
	1000 1 1	102652 160622	NETADI		0000 + 002054 HIVE	0000 1 002700 NLO		
	0000 1 4	62671	NUM5	0000 I 000000 NUM2	0000 T 002675 NUM7	0000 1 002722 NOM		149
	40.34 I f	000000	81	0000 R 000316 R2	<u>μθου Β 002505 1000</u>			
. 010	N. 4) #	C ##				00000	
		2#	<u> </u>	COMMON (DACH/NUM/18) - NSTART	(18)		000000	
L010	1	2 ' 3 #	C **	FIRST DIMENSION OF R1 AND	R2 MUST BE THE SAME A	5	000000	
L010	1 4	4 #	C **	THAT OF LLDATI AND ELDAT2	IN ELORD.		000000	
0010	3	5.*		INTEGER R1(100.2)			Dn0001	
C010	14 6	6*		DIMENSION R2(100,2)			000001	
6010	4	7*	<u>C</u> ++	NO. OF DIFFERENT DESAP BAR	DESIGN VARIABLES	· · · · · · · · · · · · · · · · · · ·		
601c	5 E	8 *		DIMENSION IDVI(100)			000001	
010	5	9#	C **	NO. OF DIFFERENT DESAP BEA	M DESIGN VARIABLES		000001	
010	16 1 <i>i</i>]¢		DIMENSION IDV2(100)			606001	
	6	*	<u>C</u> ++	NO. OF DIFFERENT DESAP QUA	D DESIGN VARIABLES		10000	
6010	1 1	2*		DIMENSION IDV3(100)			600001	
	7	<u>, .</u>	<u> </u>	NU. UF DIFFERENT DESAP SHE	AR_DESIGN_VARIABLES			
6011	U 14	4 7 C -	C -+	DIMENSION ICV4(10))	DESTEN NAD-ADLES		600001	
(011		5.¥	<u> </u>	DIMENSION TOVE (100)	DESIGN VARIABLES		600031	
6011	· · · ·	7 #	c ++	TOTAL NO OF DIFFESENT DES	TON VADTABLES		1:00001	
6011	2 15	<u>/ ~</u>	_ <u>*_</u>	DIMENSION TOVENSENT DES			606001	
6011	2 19	ç≉	(##	NO. OF STRUCTURAL LOAD MIL	TTPLIERS		600001	
6011	3 2,			DIMENSION STR(15.4)			000nc1	
L011	3 21	<u>1 *</u>	C **	*********	************	****		
L011	.4 ci	2 #		INTEGER DUMM(4), BUCK1(4)			00001	
6011	5 2;	3 #		DIMENSION HEADI 201 BUCK 213	s)		000041	
0011	o 24	4 ≠		DATA DUM/0./NELTY1,NELTY2,	NELTY3, NELTY4, NELTY5,	IELTYP,	600001	
L011	6 25	5×		<u>CNIDV1+NIDV2+NIDV3+NIDV4+NI</u>	DV5.NIDVT0/12*D/DUHM/	COM */	<u></u>	
CO13	15 20	6 *		WRITE (6,5U)			000001	
<u> </u>	<u>1</u>	7*	<u></u>	FORMAT (15X, "ENTER JOB HEA	DING ON_ONE LINE .		000000	
LU14	ju ∠o	d # ().		READ(5,1) HEAD			000006	
<u>L(114</u>	3 2	<u>7 *</u>	<u> </u>	FURMALIZIAN	(10			
LU44 LD14	ເມ 31	0≁ 1±	C \$\$	UDITE (12 INHEAD	SAP		600016	
CD14	<u> </u>	*	(**	CONVERT NACTORN MACE DENCT				
Lo14	7 2		• • •	WRITE (6.10)	TI TO DESKE WEIGHT DEF		6000±0	
L015	1 34	4*	10	FORMAT(15X. 'ENTER UNITS CO	DE: ENGLISHE1.HKSE2")		L00033	
	2 39	5.4		READ(5,7) IVCODE	of - c.defere = three = t		L00033	
UU15	5 36	6 #		CONFAC=1.			600041	
6015	63	7*		IFIIVCUDE.EC.2) CONFAC=9.8	140 -			
6016	ι <u>υ</u> 3ε	8*	7	FORMAT()			606050	
L016	1 39	<u>9 #</u>		CALL ORDER		· · · · · · · · · · · · · · · · · · ·	<u> </u>	
LU16	2 41) *		WRITE(6,670)			600052	
6016	4 41	*	600	FORMAT(15X, "ENTER MAX NO.0	F REDESIGN CYCLES NCYC	L IC=INITIAL DESIG	L00057	
6016	4 42	2*	1	IN ONLY // ICX AND MAX. NO.	SCALINGS, NSCALE IDEFAL	LT=3). SEPARATE BY	600057	
	4 43	5 4	7	2 COMMA ONLY 1			6069257	
LU16	5 44	4 4		READ 15,71 NCYCL, NSCALE			606057	
L01/	4:	.		IF INSUALE .EU.U) NSCALE 3			L06066	

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	MA	IN		DATE 073080	PAGE	3
	60173	46*	WRITE (6 601)	00072		
	U0175	47*	601 FORMAT (15X. 'ENTER SCALING CODE.KSCALE')	000077	•	
	00176	48*	READ(5.7) KSCALE	00077		
	60201	49*	WRITE (6,602)	000105		
	60203	50*	602 FORMAT (15X, "ENTER DELTA(DEFAULT=0.05), AND EPSILON (DEFAULT=0.1)"/	000112		
	00203	51*	115X*SEPARATE BY COMMA ONLY*J	000112		
	6234	52*	REAU (5,7) DELTA,EPSIL	000112		
	00210	53×	IF (DELTA+EQ+ Q+) DELTA= +05	000121		
	60212	54*	IF (EPSIL = 0.) EPSIL = 1	000125		
	00214	55*	WRITE (6,603)	000131		
·		<u> </u>	603 FORMAT (15X, ENTER CODES FOR NODAL DISPL. PFINIOUT RPRINT (0=NO PR	00136		
	60216	5/*	TINT, I = PRINT VIUX AND BUCKLING CONSTRAINT LBUCK. SEPARATE BY SPA	600136		
	(0217				·	
	50223	57# 60-	KCAU (3)///FRINI,EDUCK	000145		
-	60224	61*		600146		
	60226	62*	611 FORMATI' COMM DESTGN CONTROL FROM MAIN')	000153		
	60227	63*	URITE (12.610) NCYCL NSCALE KSCALE DELTA EPSIL KPUNCH KPRINT I BUCK	000153		
	60227	64 #	C PRINT 114	000153		
	JG227	65*	C114 FORMAT(' IN MAINNCYCL, NSCALE, KSCALE, DELTA, EPSIL, KPUNCH, KPRINT, LB	000153		
	00227	66#	<u>c</u> <u>luck</u> ,	000153		
	L0227	67≠	C WRITE (6,610)NGYCL,NSCALE,KSCALE,DELTA,EPSIL,KPUNCH,KPRINT,LBUCK	000153		
	60241	<u>68</u> ≠	610_FORMAT_(315.2F10.3,315)	<u>ü0017c</u>		
	60242	69*	CALL NODPT	000170		
	00243	70+	<u>NUH5=NUH(5)</u>	000172		
N.	60244	71÷	IF(NUH3.NE.O) PRINT 15	000174		
Q -	<u>U0247</u>	72*	15 FORMAT(' ************************************	000202		<u>`</u>
8	00247	/ 5 *	1,/* * // * DESAP BAR ELEMENT (NASTRAN ROD) *,/,	000202		
Η –	00297	<u> </u>	TEALINE NE DARALL EADICONFAC NELTAL TOUL NT- 435	000202		
ယ်	6.0252	75# 76#	VELTAD-VELTAD PREFILAS	CO0202		
<u>⊢</u> –	60252	77*		000215		
	00253	78*	C PRINT 333. NIDVI.NELTVI.NELTVP	000215		
	00253	79*	C333 FORMAT(* NIDV1.NELTY1.NELTYP=*,3(2X,14))	600215		
	60253	80*	C PRINT 666	000215		•
	L0253	81*	C666 FORMAT(+ LOOKOUT HERE COMES THE IDV ARRAY)	600215		
	00255	82*	UO 821 L1=1,NIUV1	<u> </u>		<u></u>
	UD250	63×	821 IDV(L1)=IDV1(L1)	000224		
	<u></u>	84*	<u>CE21</u> PRINT 444, IOV(L1)	<u> </u>		<u> </u>
	00260	85¥	C444 FORMAT()	600224		
_	<u> </u>			U00227		
	10202	0/\$ 88±	C PRINT 555, NIDVIO	606227		
	LD263			000231		
	60263	9114		000231	*	
	UU263	91≠	C 1F(MIKE+E0-D)60 TO 2000	000231		
	00264	92*	$1F(NUM6 \cdot NE \cdot r_i) PRINT 20$	600233		
	00267	93*	2U FORMAT(* ***********************************	000241		
	60267	94#	1./ **/ * DESAP BEAM ELEMENT INASTEAN BAR! ./.	000241		
	L0267	95×	2 * * ' / * * * * * * * * * * * * * * * *	600241		
	60270	96*	IF(NUM6.NE.D)CALL BEAM(CONFAC,NELTY2,IDV2,NIDV2)	000241	······································	
	00272	97*	NELTYP=NELTYP+NELTY2	006254		
	00273	98*		000257		
	UU273 60273	¥9∓ 160*	C PRILI 332, NIUVZINELIYZINELIYY (777 FOOMATTI NIGYYY NG TYYYY TAAT	000257		
	00213	<u>1,11÷</u>	C PDINT // PINT <u>100257</u>			
	66273	1112 #	C667 FORMATIN LOOKONT HERE COMES THE TOW APPAYN	(10257		
			CONTRACT CONCOUNTRE CONCOUNT INT THE WARKET	000237		

	MA	10		DATE 073080	PAGE 4
	60275	1:34	DO 673 12-1 NTOV2	000270	
	00306	164*	623 IDVI2+NIDVI01-IDV2/121	<u> </u>	
	60300	105*		000270	
	<u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u><u></u></u>	10.*		000273	
	66302	107*	C PRINT 555. NIDVTO	000273	
	60302	168+	C MIKEED	000273	
	L0302	149*	C IF (MIKE_EQ.0)GO_TO_2000		
	60303	110+	NUH7=NUH(7)	600275	
	<u>tin 504</u>	<u>111*</u>	IF (NUM7.NE.U) PRINT 25	000277	
	00307	112*	25 FORMAT(* ***********************************	000305	
	60307	113*	1,/* **/* * DESAP QUAD ELEMENT (NASTRAN ODMEN)*,/,	000305	·
	60307	114*	2° *'/' *********************************	000305	
	60310	<u>115</u> *	IF (NUM7.NE.O) CALL GDMEN (GONFAC.NELTY3.IDY3.NIDY3)	<u> </u>	
	60312	116#	NELTYP=NELTYP+NELTY3	000320	
	60313	117#	1F (NUM7, E0, n) 60 10 626	000323	
	60315	118#	D0 625 L3=1,N1DV3	000334	
_	60320	<u>119*</u>		000334	
	00322	1207	626 NIDVTO=NIDVTO+NIDV3	600337	
	<u> </u>	1214			
	00324	122#	IFINDEG.NE.UJ PRINI SU	000343	
·		1237			
	66327	1244	1,/***/** UESAP SHEAR ELEMENT (NASTRAN SHEAR)',/,	000351	
		1260	$\frac{1}{1} = \frac{1}{1} + \frac{1}$	000751	
	60330	1278	IF INDEONEODICALL SECAR IGUNFACINELITA,1004,N1044, KFI TVD-NI TVDANG, TVU	000351	
		128#		000367	
X	60335	129#		600400	
<u> </u>	10346	1307	628 [DV(14+N]DV(0)=TDV(14)		
X	00342	131+	627 NIDVID=NIDVID+NIDV4	000403	
	60342	152*	C2DCU CONTINUE	000403	
ž _	E 343	133*	NUM9=NUM(9)	600405	
	66344	134 ×	NUH1G=NUH(10)	000407	
	UC 345	135*	NCTOT=NUM9+NUM10	000411	
	ບ() 346	136.	IF(NCTOT.NE.U) PRINT 35	006413	
	60351	137#	<u>35 FORMAT(* ++++++++++++++++++++++++++++++++++++</u>	000421	
	Ú0351	139*	1,/* **/* # DESAP QIT ELEMENTS (NASTRAN GUADZ & TRIA2)*,//,	000421	
	60351	<u>139*</u>	<u>2" +"/" ++++++++++++++++++++++++++++++++</u>	600421	
	60352	140*	IF(NCTOT.NE.U)CALL OT(CONFAC,NELTYS,IDV5,NIDV5)	UD0421	
	00755	141*	NELTYPENELTYPENELTYS	600434	
	60355	142#	IF (NCIO) EU LI GO TO 629	000437	
	00357	143#		000450	
	60364	145=	639 IDV(LS+NIDVIO)=IDV5(L5) 629 CONTINUE	000450	
	10365	146#		000453	· · · · · · · · · · · · · · · · · · ·
	6.6366	1404		000453	
	00367	149*		000433	
	60367	149#		600435	
	L0367	150*	CITY FORMATIS TOW ARRAY AND NUMBER TO MATH AFTER SETUDAL FROM DIFY)	000855	
	66367	151 *	C PRINT 12. (DW(1). TELNIDYTO)	000455	
_	L0367	152*	C112 FORMAT(2x 13)		
	60367	153*		000400 []06455	
	60367	154*	C113 FOOMAT(* NUMBU =*.13)	000455	
	60370	155*	PRINT 40	000462	
	LC 372	156#	40 FORMAT(/// END OF FLEMENT PROCESSING SET UTHER CONTROL VARIABLE	U00466	
	60372	157*	<u> </u>	600466	
	00373	158.	WRITE (6,750)	600466	
·	<u>uu</u> 375	159*	700 FORMAT (20X, STRUCTURAL LOAD MULTIPLIERS 1/2CX, SENTER NO. OF LOAD	600473	

	MAIN		· · · · · · · · · · · · · · · · · · ·	DATE C73080	PAGE	5	
	Űn.375	160.*		200473			
	60376	161*		<u> </u>			
	66401	162*		000501			
	00404	163*		000510			
	60407	164*	750 STR(L1,L2)=0.	000510			
	60412	165*	DO 751 L1=1,NLOAD	000520			· · · ·
	60415	166#	WRITE (6,701)L1	000523			
	68420	167*	701 FORMAT (2X, "FOR LOAD CONDITION", I4, " ENTER STRUCTURAL LOAD MULTIPL	600531			•
	00420	168*	IIERS FOR ELEMENT LOADS A,B,C,D,IN THAT ORDER, DEFAULT TO ALL ZEROS	000531			'
	00420	169*	2 • 1	000531			•
	60421	170*	READ (5,7) DUMM(1)	000531			'
	60424	171*	IF(DUMM(1),EQ.D) GC TO 751	000537			
	00426	112#	READ(5),77 (DUHM(L2),L2=2,4)	000541			"
	00431	1734		000556			
	500434 500434	175		000563	• • • • • • • • • • • • • • • • • • • •		"
	ED436	176±		000563			
—	6.0436	177#	CIIS FORMATI'S IN HAINSTR ADRAVI)	000563			<u> </u>
	60440	178#	WRTF(12,759)	000563			,
	1161.0.2	179*	759 FORMATI' COMM STRUCTUDAL LOAD MULTIPLIFES FROM MATNIS	600573		···-	,
	60443	18Ú*		000573			
	LI0446	181+	755 WRITE (12.7n2)(STR(L1.L2).L2=1.4)	C00573			7
	00446	132*	C755 WRITE (6,7G2)(STR(L1.L2).L2=1.4)	<u>600573</u>			,
	60455	183*	7U2 FORMAT (4F1C.3)	000607			,
	00455	164*	C ** BUCKLING CONTROL CARD	<u>600607</u>			*
	üU456	185*	IF(LBUCK+EQ+ \bar{u}) GU TO 85D	000607			
X	<u>C0460</u>	166#	WRITE (6.703)	<u>U0U611</u>			*
X	00462	187*	703 FORMAT (10X, BUCKLING CONTROL CARD)	COU616			ינ
\mathbf{X} –	<u></u>	168*	write 16,704)	<u>600616</u>	· · · · · · · · · · · · · · · · · · ·		»
	UO465	189*	704 FORMAT (2x, "ENTER COEFFT. DEFAULT=1.")	000623			*
- 22 –		190*		000623			¥
	60467	191*	READ (5,7) DUH	000625			*
-	60472	192*		000633			`
	00474	1934	THE FORMAT LAS MADIETA HAS DEEN SET TO DIVI	000637			• "
	00470	195±		000644		· — ·	— :
	60500	196#		000645			-
	60502	197#	706 FORMAT L2X-VENTED NMODE - DEFAULT-19A	600652		-	
	60502	198*		606652			•)
-	60504	199*	READ (5.7)DUM	CDU654			· · ·
	60507	2ົບປ≠	IF (DUM.NE.O)BUCK1(2)=DUM	000662			-
	L0511	261+	wRITE (6,7G7)	600673			
		262*	707 FORMAT (2X. "ENTER INDET AND NVEC.IN THAT ORDER")	00700			*
	60514	26 3 *	READ (5,7) BUCK1(3),6UCK1(4)	000700			••
	60520	264*	WRITE (6,708)				*
	00522	205*	7UB FORMAT (2X,*ENTER ALPA*)	000714			-
	<u> </u>	206*	READ (517) BUCK2(2)	606714			
	LU526	2674	write $(6, 709)$	600722			
	60536	2:0+	759 FORMAT (2X. ENTER OMEGA , DEFAULT = 0.8")	600727		· · · · ·	•••
	00531	2094		600727			•
	00532	<u></u> ⊃11≏		000731			<u> </u>
	60535	217±	AT TOURSTESS BULKAISS-OUN	000/3/			
	L0541	213*	710 FORMAT (2X.*FNIFR SHIFT, DEFAIL (27.*)	<u> </u>			,
	60542	214.	READ 15.71 BUCK2(4)	600750			
	U0542	215*	C PRINT 116	<u>600750</u>			—.
•	U0542	216*	C116 FORMAT(' IN MAINBUCK2(1),Buck1 ARRAY,BUCK2 ARRAY')	006750			
							•

•7

UDS15 217 FEILE(12.711) UDD156 UDS57 218 731 FORATI CLATINGUERALINE CONTROL FROM MAIN*) 000763 UDS50 219 C FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000763 UDS50 229 C FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000763 UDS50 229 C FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000763 UDS50 224 11 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000763 UDS50 224 14 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000760 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000760 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 000760 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 001600 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM MAIN*) 001600 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM FROM MAIN*) 001611 UDS51 224 FEIL (LATINGUERALINE CONTROL FROM FROM MAIN*) 001611 UDS51 224	L0545 217* PRIFE(12.713) D00756 U0547 216* 713 FORMATI' COMM D00761 D00753 U0550 220* C #RITE (12.713)BUC #2(1).15UC #2(1).15UC #2(1).152.4) D00763 U0550 220* C #RITE (17.713)BUC #2(1).15UC #2(1).15UC #2(1).152.4) D01763 U0550 221* 711 FORMATI' D01763 D01763 U0555 221* 711 FORMATI' D0100 D0100 U0555 221* Sin Continue D0100 D0100 U0557 22** If (NUM13).60:00 60 T0 950 D0100 D0100 U0562 22** If (NUM13).60:00 60 T0 950 D0100 D0101 U0564 22** P01 FORMATI(1) D0100 D01012 U0565 22** P01 FORMATI(2) D01012 D01012 U0573 230* LIMERADILLA D01012 D01012 U0571 23** P03 FORMATILLA FORMATILLA FORMATILLA FORMATILLA U0573	<u> </u>
00.947 214 713 000411 000703 00.953 210 estit (1,71114/24/2111/18/2411/121,441,80/2211/122,41) 000763 00.955 210 111 10041/11/1121,441,141/11111,441,411/1121,441,40/2211/122,41) 000763 00.955 2214 111 10041/141,411,411/1111,180/4111/1121,441,480/2211/122,41) 001000 00.957 2244 111 10041/141,410,41111111,180/411111111,141,411,411,411 001000 00.957 2244 114 10041,160,010 001000 00.957 2244 114 10041 001000 00.957 2244 114 10041 001000 00.951 2244 114 10041 00100 00.951 2244 114 10041 00100 00.951 2244 114 10041 001100 00.951 2245 114 1147,1140/4131 00100 00.951 2245 2461111 1147,1140/41431 001100 00.951 2245 925 1141/140/4131	DD12 D11 D11111 D111111 D11111	
100551 111 1.1111 1.111 1.111 <td< td=""><td>D0350 219 WRITE (14.711)g0C#211).1E1.41.1(BUCK2[1].1E2.4) 000763 D0555 2214 711 F0R47.1[103CK2[1].1BUCK1[1].1=1.41.4[BUCK2[1].1=2.4] 000763 D0555 2214 711 F0R47.1[103.4[1.5].3F10.3] 000763 000763 D0556 2224 85n CONTINUE 001000 001000 D0556 2234 F11 UIA.7113.20.01 GO TO 950 001000 001000 U0557 2244 IFINUM13.60.01 GO TO 950 001000 001000 U0562 2235 C.4* NCMDAL LOAD DATA 001000 U0552 2244 IFINUM13.60.01 GO TO 950 001000 U0552 2264 NCMDENSTART(3)=1 001000 U0552 2264 NCMDENSTART(3)=1 001012 U0554 2274 909 925 KE11.1KMD 001012 U0555 214 90 930 K251.1LM 001020 U0573 2304 L1MENDH33 001020 U0573 2304 L1MENDH33 U01030 U0574 214 00 930 K251.1LM 001030</td></td<> <td></td>	D0350 219 WRITE (14.711)g0C#211).1E1.41.1(BUCK2[1].1E2.4) 000763 D0555 2214 711 F0R47.1[103CK2[1].1BUCK1[1].1=1.41.4[BUCK2[1].1=2.4] 000763 D0555 2214 711 F0R47.1[103.4[1.5].3F10.3] 000763 000763 D0556 2224 85n CONTINUE 001000 001000 D0556 2234 F11 UIA.7113.20.01 GO TO 950 001000 001000 U0557 2244 IFINUM13.60.01 GO TO 950 001000 001000 U0562 2235 C.4* NCMDAL LOAD DATA 001000 U0552 2244 IFINUM13.60.01 GO TO 950 001000 U0552 2264 NCMDENSTART(3)=1 001000 U0552 2264 NCMDENSTART(3)=1 001012 U0554 2274 909 925 KE11.1KMD 001012 U0555 214 90 930 K251.1LM 001020 U0573 2304 L1MENDH33 001020 U0573 2304 L1MENDH33 U01030 U0574 214 00 930 K251.1LM 001030	
D055. 220* C #TTE (6,71) EUCK2[1], 400K1[1], 121, 41, 400K2[1], 122, 41 D00753 D055. 2214 711 698.47, 410.1, 415.316.41 D01000 D055. 2224 657 6971/buc 00100 D055. 2224 657 6971/buc 001000 D055.1 2254 87 MUNH31.64.0.0 001000 D055.2 2264 MCMONSTATISTST 001000 D056.1 2264 MCMONSTATISTST 001000 D056.2 2264 MCMONSTATISTST 001001 D056.1 2264 MCMONSTATISTST 001001 D056.2 2264 MCMONSTATISTST 001002 D056.1 2264 MCMONSTATISTST 001002 D057.3 230* Literountist 00100 00102 D057.3 230* Literountist 00.210.000 00102 D057.3 230* Literountist 00.210.000 00102 D057.3 230* Literountist 00.2100 000100	L055. 22.0* C *RITE (6,71):BUCK2(1):IBUCK2(1):IE1,4):(BUCK2(1):IE2,4) 0010763 L0555. 22.2* S5n CONTAUE 00100 L0555. 22.2* S5n CONTAUE 00100 L0555. 22.4* DOAL LOAD DATA 001000 L0557. 22.4* IF(NUM13): EQ.01 GO TO 950 001000 L0557. 22.4* IF(NUM13): EQ.01 GO TO 950 001000 L0557. 22.4* IF(NUM13): EQ.01 GO TO 950 001000 L0556. 22.2* REMUIN 11. 00100 L0556. 22.2* 92.5 READ(11,100M 001012 L0557. 22.4* D0 92.5 K12:1,NEND 001012 L0557. 22.4* D0 92.5 READ(11,100M 001012 L0573. 23.0* LIM=WH431 00102.0 00102.0 L0571. 22.2* 90.1 FORMAT (1/) D0100.0 00102.0 L0572. 2.2* 90.1 FORMAT (1/) D0102.0 00102.0 L0572. 2.2* 90.1 FORMAT (1/) D0102.0 00102.0	
U0355 2214 711 FORMAL (F107, 415, 2710, 31) Online U0355 2228 659 CONTINUE	U0555 221+ 711 FORMAT. (f10:3,415,3F10,3) OD1000 U055 223+ C ** NODAL LOAD DATA 001000 U055 223+ C ** NODAL LOAD DATA 001000 U055 224+ IFINDH(3), EQ.0) 60 T0 950 001000 U056 224+ IFINDH(3), EQ.0) 60 T0 950 001000 U0562 224+ D0 925 KE]1, NEND 001000 U0562 228+ 925 REDU(11,100H 001020 U0573 230+ U1 FORMAT (12,1), (R2(K2,K3), K3=1,3) 001020 U057 232+ 9.0 READ(11,902) R1(K2,1), (R2(K2,K3), K3=1,3) 001031 U0607 234+ C 400 53 K = 1, LH U001031 U0051 U0607 234+ C 400 53 K = 1, LH U001031 U0051 U0613 235* C 400 53 K = 1, LH <t< td=""><td></td></t<>	
U0555 222* 65n CONTINUÉ ÚDICO C0556 223* C* NODELADO DATA 001000 U0577 224* IFTRUMI 31+CLOD GO TO 750 001000 U0564 226* NODELADO DATA 001000 U0564 226* NODELADO DATA 001000 U0564 226* NODELADO DATA 001000 U0564 226* SALE 00 925 KALE 001000 U0577 230* LINFORMAS 001000 001012 001012 U0577 231* 910 FALE 1154.14.16.14.574.11 001000 001012 U0577 231* 910 FALE 1154.14.16.14.574.11 001000 001010 001010 001010 U0513 2355 C * STIALL CARC CONCITION NUMBERST. INS MAY BE MODIFILD BY MAVING THE USER 001001 U0514 2355 C * STIALL CARC CONCITION NUMBERST. IN 2570.14.10.10.00.00.00.00.00.00.00.00.00.00.00.	U0356 222* 85n CONTINUE 001000 U0357 22* NODAL LOAD DATA 001000 U0357 22* IF (NUM(3),EQ,D) 60 T0 950 001000 U0357 22* IF (NUM(3),EQ,D) 60 T0 950 001000 U0351 225* RFWIND 11 001001 U0352 225* NENDENSTART(3)-1 001004 U0355 227* 00 925 K;1:NEND 00102 U0352 227* 00 925 K;1:NEND 00102 U0351 227* 00 925 K;1:NEND 00102 U0553 220* SEE ALL 100H 00102 U0573 230* U READ(11,10UH 00102 U0577 232* 901 FORHAT (3)- C01020 U0577 232* 910 READ(11,92) R1K2,13,4321,31 C01031 U0577 232* 910 READ(110 NUMBERSE1, THIS MAY BE HODIFIED BY HAVING THE USER G01051 U0507 234* C ** SET ALL LOAD CONDITION NUMBERSE1, THIS MAY BE HODIFIED BY HAVING C01051 U0503 <	
D0555 223* C ** h004L 1040 DATA D0100 00557 22** If thum 31. EG. 10 EO TO 950 001001 00561 225* Argaino 11 001001 00562 225* Argaino 11 001001 00562 225* Argaino 141.0.00 001012 00573 200* 11.4*0.00 001012 00573 200* 11.4*0.00 001012 00573 200* 11.4*0.00 001012 00573 200* 11.4*0.00 001010 00677 21.4* 0.4*2.1*1.0* 0.0*0.1*0.0*1.0*0.0*1.0*0.1*0.0*1.0*0.0*0	C0556 223* C ** NODAL LOAD DATA UDIDUD UD557 224* If (NUM13).66.01 GO TO 950 UD1000 UD551 225* RrwIn 11 001000 UD552 226* NTMDENSTART(3)-1 001001 UD562 226* NTMDENSTART(3)-1 001001 UD562 227* UD 925. Kj=1.NEMD UD1017 UD565 227* UD 925. Kj=1.NEMD UD1012 UD573 230* LIM=NUM131 UD1020 UD573 230* UD162.1R1K7.1).(R2K2.K31.K3=1.3) UD1030 UD577 234* C * ST ALL LOAD CONDITION NUMBERS=1. THIS MAY EE HODIFIED BY HAVING THE USER C01051 UD577 234* C * ST ALL LOAD CONDITION NUMBERS=1. THIS MAY EE HODIFIED BY HAVING THE USER C01051 UD513 235* C ** INT LOAD CON	
UDS57 224* If thum(3).fc.uD, 60 T0 950 UD1000 UD562 224* Archonslamit 001001 UD562 224* McD5NSlamit 001001 UD562 224* McD5NSlamit 001001 UD562 224* 92 FACINIT 00102 UD573 230* ULM*AND43 001020 UD574 239* S1 ALLOND 001020 UD573 230* ULM*AND43 001020 001020 UD574 239* S1 ALLOND CONDITION FACINITATION 001021 UD673 239* S1 ALLOND CONDITION FOR FACH ANDALLOND CARD 001051 UD674 239* S1 ALLOND CONDITION FOR FACH ANDALLOND CARD 001051 UD631 239* C ** S11 ALLOND CONDITION FOR FACH ANDALLOND CARD 001051 001051 UD631 239* C ** FACH ANDALLOND CARD 001051 001051 UD631 239* C ** FILLUND CONDITION FOR FACH ANDALLOND CARD 001051 UD631 239* <td>U0557 224* IF (NUM 13).EQ.01 60 T0 950 001000 U0561 225* RFMIND 11 001001 U0562 226* NENDENSTART(3)-1 001001 U0564 227* 00 925 K1=1,NEND 001001 U0565 228* 925 READ(11,1)00H 001012 U0572 229* 901 EARC11,902 READ(11,902) 001020 U0573 230* U1#NUM13 001020 001020 U0577 232* 910 READ(11,902) R1(K2,1), (R2(K2,K3),K3=1,3) 001030 U0577 232* 910 READ(11,10N NUBERS=1, THIS MAY EE MODIFIED BY HAVING THE USER G01051 U0567 234* C * ENTER THES CALL CONCENTRATED NODAL LOAD CARD 001051 U0513 236* C ** SET ALL CONCENTRATED NODAL MUMENTS 70 ZER0. THIS MAY BE MODIFIED BY HAVING 001051 U0513<</td> <td></td>	U0557 224* IF (NUM 13).EQ.01 60 T0 950 001000 U0561 225* RFMIND 11 001001 U0562 226* NENDENSTART(3)-1 001001 U0564 227* 00 925 K1=1,NEND 001001 U0565 228* 925 READ(11,1)00H 001012 U0572 229* 901 EARC11,902 READ(11,902) 001020 U0573 230* U1#NUM13 001020 001020 U0577 232* 910 READ(11,902) R1(K2,1), (R2(K2,K3),K3=1,3) 001030 U0577 232* 910 READ(11,10N NUBERS=1, THIS MAY EE MODIFIED BY HAVING THE USER G01051 U0567 234* C * ENTER THES CALL CONCENTRATED NODAL LOAD CARD 001051 U0513 236* C ** SET ALL CONCENTRATED NODAL MUMENTS 70 ZER0. THIS MAY BE MODIFIED BY HAVING 001051 U0513<	
LD551 2258 FRUMD 11 001001 LD552 2264 NNDETSTAT131-1 001007 LD552 2264 00007 00107 LD557 2264 00007 00107 LD557 2264 00007 00107 00107 LD557 2264 00007 00107 00107 LD557 2264 00007 00107 00107 LD557 2264 00007 00007 00107 LD557 2264 00007 00007 001051 LD557 2264 00007 00107 001051 LD557 2264 00007 001051 001051 LD557 2264 00007 001051 001051 LD557 001007 001051	LD561 225* RFWIND 11 DD1001 L0562 225* NCDNSNSTAT(3)-1 D01004 L0565 227* D0 925 K1=1+NEND D01007 L0566 228* 925 READ(11,1)DUM D01012 L0573 230* LTM=NUM(3) D01020 L0577 230* LTM=NUM(3) D01020 L0577 232* 930 READ(11+,92) R1(K2+N), (R2(K2+K3)+K3=1,3) L01030 L0577 232* 930 READ(11+,92) R1(K2+1), (R2(K2+K3)+K3=1,3) L01030 L0607 233* C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER D01051 L0607 235* C ** ENTE, THE LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER D01051 L0607 235* C ** SET ALL LOAD CONDITION NUMERS=1. THIS MAY BE HODIFIED BY HAVING THE USER D01051 L0613 235* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 L0613 239* C ** THE INFER THESE VALUES FOR EACH NODAL LOAD CARD D01051 L0615 240* D0 936 K5=1+LIM D01051 D01051 L0615 240* <td></td>	
U0556 226* MKNDPNSTAFT(2)-1 U0100* U0556 227* 90 PSS_SK111,1100* U01012 U0557 229* 90 PSS_TALLIA U01012 U0577 230* 00 PSS_TALLIA U01012 U0577 230* 00 PSS_TALLIA U01012 U0577 230* 90 PSSUT1,920 PSST_TALLIA U01013 U0577 230* 90 PSSUT1,920 PSST_TALLIA U01013 U0577 230* C* STALL UASC CONDITION YOR FACE ADDAL HOD PS HAVING THE USER U01013 U0613 230* C * STALL UASC CONDITION YOR FACE ADDAL HOD PS HAVING THE USER U0103 U0613 230* C * STALL UASC CONDITION YOR FACE ADDAL HOD PS HAVING THE USER U0103 U0613 230* C * STALL UASC CONDITION YOR FACE ADDAL HOD PS HAVING THE USER U0103 U0613 230* C * STALL UASC CONDITION YOR FACE ADDAL HOD PS HAVING THE USER U0103 U0613 230* C * STALL UASC CONDITION YOR FACE ADDAL	L0562 226* NENDENSTART(3)-1 C01004 L0563 227* D0.925.K1=1.NEND U010107 L0566 228* 925 READ(11,1)0UH U01012 L0573 230* LIFNUH(3) 001020 L0577 230* LIFNUH(3) C01020 L0577 232* 930 READ(11,92) R1(K7,1)*(R2(K2,K3)*K3=1,3) U01030 L0577 232* 930 READ(11,92) R1(K7,1)*(R2(K2,K3)*K3=1,3) U01030 L0577 232* 930 READ(11,92) R1(K7,1)*(R2(K2,K3)*K3=1,3) U01030 C0607 23** 942 FORMAT (16X:16*,16X:3Fga.1) U01051 C0607 23** C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY HAVING THE USER G01051 C0617 23** C ** SET ALL LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 C0612 23** C ** ENTL: THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 C0613 23** C ** SET ALL CONCENTRATED NODAL MOMENTS 70 ZERO. THIS MAY BE MODIFIED BY HAVING CO1051 001051 C0613 23** C ** SET ALL CONCENTRATED NODAL MOMENTS 70 ZERO. THIS MAY BE MODIFIED BY HAVING CO1051 001057	
LD565 227 D0.925.Kj=1,MKMD LD1610 LD565 220* 001 FLAULI,JICH DD1012 LD575 220* 001 FLAULI,JICH DD1012 LD577 212* 001 FLAULI,JICH CD1020 LD577 213* 001 FLAULI,JICH CD1021 LD577 213* 001 FLAULI,JICH CD1010 LD577 213* 001 FLAULI,JICH CD10110 FLAULI,JICH CD10110 LD577 213* C ** STILL LOAD CONDITION FARS FLAULINA MAY EL MODIFILD BY MAVING THE USER CD1051 LD577 213* C ** STILL CONCINTRATED NODAL MOMENTS TO ZERO, THIS MAY EL MODIFILD BY MAVING THE USER CD1051 LD518 240* C ** STILL CONCINTRATED NODAL MOMENTS TO ZERO, THIS MAY EL MODIFILD BY MAVING THE USER CD1051 LD52 242* 00 ST KERL NATER CD1051 LD518 240* C ** ST KILL LOAD CAND, CARD, C	L0565 227* D0 925 K1=1,NKND L01067 L0565 228* 925 FKD(11,1)DUH 00102 L0572 229* 901 FORMAT (/) 001020 L0573 230* L1M=NUH(3) 001020 L0577 230* L1M=NUH(3) 001020 L0577 230* L1M=NUH(3) C01020 L0577 232* 930 FCAD(11,902) R1(K2,1), (R2(K2,K3),K3=1,3) U01030 L0507 234* C *, SET ALL LOAC CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 C01051 L0607 235* C ** ENTER THE LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 C01051 L0607 235* C ** ENTER THE LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 C01051 L0607 235* C ** ENTER THE LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 C01051 L0613 236* D0 935 K4*1,L1H 001051 C01051 L0613 236* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE HODIFIED BY HAVING D01051 C01051 L0613 239* C ** THE USER ENTER THESE YALUES FOR EACH NODAL LOAD CARD C01057 C01051	
Lobes 2000 V25 FLAD(1),100H 00012 Lobes 2000 V25 FLAD(1),00H 00012 Lobes 2000 Lobes 2000 Lobes 2000 Lobes 2	L0566 228* 925 READ(11,1)DUM 001012 u0571 230* L1M=NUM(3) 001020 u0573 230* L0* 001020 u0573 230* L0* 001020 u0574 231* u0 930 READ(11,92) u0577 232* 930 READ(11,92) R1(K2,1),(R2(K2,K3),K3=1,3) 001030 u0607 234* 932 FORMAT 16X,18,16X,376,11 001030 u0607 234* C ** SET ALL 00001100 NUMBERS=1. THIS HAV ING THE USER G01051 u0607 234* C ** SET ALL 00001100 NUMBERS=1. THIS HAV ING THE USER G01051 u0607 234* C ** SET ALL 00001100 NUMBERS=1. THIS HAVING THE USER G01051 u0613 235* C ** FILE THE USER FOR FACH NODAL L0AD CARD G01051 u0613 235* C ** SET ALL CONCENTRATEO NODAL L0AD CARD G01051 u0613 235* C ** THE USER ENTER THESE VALUES FOR FACH NODAL L0AD CARD	
UB312 Dist Dist Dist UB312 2319 Q Q ACADA Control UB312 2319 Q READ(1);Q21 F1(K7,1);K72(K2,K3);K321,33 UB1030 UB423 2329 Q READ(1);K721 F1(K7,1);K72(K2,K3);K321,33 UB1031 UB423 2329 C SET ALL LOAD CONDITION FOR EACH MODAL LOAD CARD. UB1031 UB424 SET ALL LOAD CONDITION FOR EACH MODAL LOAD CARD. UB1031 UB1031 UB424 SET ALL LOAD CONDITION FOR EACH MODAL LOAD CARD. UB1031 UB425 2409 D 915 F114R12121 UB1011 F115 F116 UB413 2409 D 916 F114R12121 UB1031 F116 UB414 2409 D 916 F114R12121 UB1031 F116 UB413 2409 D 916 F114R12121 UB1031 F116 UB414 D D16 F1174R12121 UB1031 F116 UB1031 F116 UB414 D16 F1174 D16 F1174R12121 UB1031 F116 UB1031 F116 UB424 D10 F16 F111177 UB1031 F116 F11777	UD573 230* UH FORMAL (7) UD120 UD573 230* UH FORMAL (7) UD120 UD573 230* U0 930 K2=1,LIM UD120 UD577 232* 930 READ(11,902) R1(K2,1),(R2(K2,K3),K3=1,3) UD1030 UD677 232* 930 READ(11,902) R1(K2,1),(R2(K2,K3),K3=1,3) UD1030 UD677 234* C ** SET ALL CACE CONDITION NUMBERS=1. THIS MAY EE HODIFIED BY HAVING THE USER G01051 UD1051 UD607 235* C ** FNTF, THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 UD613 236* D0 935 K4=1,LIM 001051 UD613 236* D0 935 K4=1,LIM 001051 UD613 236* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING 001051 UD613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING 001051 UD613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001057 UD613 240* 00 936 K6=1,b 001057 UD614 240* 00 936 K6=1,c 001057 UD620 242* 936 K2(K5,K6)=0. 001057	
UB57.1 230* LH*10/1/31 UB102 UB57.1 232* 00 Extension UB1051 UB57.2 232* 00 Extension UB1051 UB07.2 234* 00 Extension UB1051 UB07.2 234* 00 Extension UB1051 UB07.2 234* C ** Extension UB1051 UB07.2 Extension UB1051 UB1051 UB07.2 UB12.2 UB1051 UB1051 UB07.2 UB12.2 UB1051 UB1051 UB07.2 UB12.2 UB1051 UB1051 UB12.2 UB12.2 UB1051 UB1051 UB12.2 UB12.2 UB1051 UB1051 UB12.2 UB12.2 UB111111 UB12.2 U	00573 230* L1H-NOMISI 001020 00574 231* 00930 K2=1,1H 00930 00577 232* 930 READ(11,902) R1(K2,1),(R2(K2,K3),K3=1,3) 001030 00574 234* 942 FORMAT (16k,18,116k,18,18,18,18,18,18,18,18,18,18,18,18,18,	
10037 232 910 Deckin Local (Arborn 1) 100102 10037 2314 912 EDBAH 115K.1E.11.1 1001051 10067 234* C *** SET ALL LOGO CONDITION NUMBERST, THIS MAY BE MODIFIED BY MAVING THE USER ODIOS1 110017 235* C *** SET ALL LOGO CONDITION FOR FACH NODAL LOAD CARD 001051 110017 235* C *** SET ALL LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 11017 935 SET ALL CONCENTRATED NODAL MUMERTS TO ZERO. THIS MAY BE MODIFIED BY MAVING DELOSI 001051 11018 239* C *** SET ALL CONCENTRATED NODAL MUMERTS TO ZERO. THIS MAY BE MODIFIED BY MAVING DELOSI 11018 239* C *** SET ALL CONCENTRATED NODAL MUMERTS TO ZERO. THIS MAY BE MODIFIED BY MAVING DELOSI 11018 123* C *** SET ALL LOAD CARD 001051 11018 11018 11018 11018 11018 11018 11018 11010 11018 11018 11018 11018 11018 11018 11018	LUDS14 Z31 D0 Y30 REACTION LUDS77 232* 930 REACTION REACTION UD1030 LUD607 233* 942 FORMAT (16X.18,16X.3Fg.1) UD1030 U0607 234* C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY MAVING THE USER G01051 LU0617 235* C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY MAVING THE USER G01051 LU0613 236* D0 935 K4=1.LIM 001051 001051 LU0613 236* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING D01051 LU0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING D01051 LU0613 239* C ** THE USER ENTER THESE YALUES FOR EACH NODAL LOAD CARD D01051 LU0613 239* C ** THE USER ENTER THESE YALUES FOR EACH NODAL LOAD CARD D01051 LU0613 239* C ** THE USER ENTER THESE YALUES FOR EACH NODAL LOAD CARD D01051 LU0614 240* D0 936 K5=1.LIM D01051 D01051 LU623 242* 936 K2(K5,K6)=0. D01057 LL626 243* CALL ELORD(LLM.R1.R2.2.6) U01057 U01057 LL626 244* C PRINT 117 U01064 U01064<	
UDDD: 2314 902 FORMAI ALEX, FEATUL UDDDS: UDDD: 234* C ** C ** EALL LOAG CONDITION MORE \$\$251, THIS MAY BE MODIFIED BY MAYING THE USER 001051 UDD1: 235* C ** EALL LOAG CONDITION MORE \$\$251, THIS MAY BE MODIFIED BY MAYING THE USER 001051 UDD1: 235* C ** EALL COACCENTRATED NODAL MUMENTS 70 2ERO. THIS MAY BE MODIFIED BY MAYING 001051 UDD1: 235* C ** SET ALL COACCENTRATED NODAL MUMENTS 70 2ERO. THIS MAY BE MODIFIED BY MAYING 001051 UDD1: 235* C ** SET ALL COACCENTRATED NODAL MUMENTS 70 2ERO. THIS MAY BE MODIFIED BY MAYING 001051 UDD2: 242* 93 6 82*1.0 001057 001057 UDD2: 242* 93 6 82*1.0 001057 001057 UDD2: 242* 03 6 82*0.0 001057 001057 UDD2: 242* 03 6 82*0.0 001057 001057 UDD2: 242* 03 6 82*0.0 001057 001064 UDD2: 242* 010105 001056 0010106 UDD2: <td>00017 233* 930 FRENTL (15X, 18, 16X, 3Fg, 1) 001051 00007 233* C ** ENTEL THE LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY HAVING THE USER G01051 00007 235* C ** ENTEL THE LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY HAVING THE USER G01051 00017 235* C ** ENTEL THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 00013 235* 00 935 k=1,LH 001051 001051 00013 237* 935 R1(K4,2)=1 001051 001051 00013 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING 001051 0013 239* C ** IHE USER ENTER THESE YALUES FOR FACH NODAL LOAD CARD 001051 0014 00 936 K51+LIH 001051 001057 00165 240* 00 936 K51+LIH 001057 01623 242* 936 K2(K5,K6)=20+ 001057 01057 01057 01057 001064 001057 01052 243* CALL ELOKDILLM.R1,R2,2,6) 001064 001064 01056 01064</td> <td></td>	00017 233* 930 FRENTL (15X, 18, 16X, 3Fg, 1) 001051 00007 233* C ** ENTEL THE LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY HAVING THE USER G01051 00007 235* C ** ENTEL THE LOAD CONDITION NUMBERS=1. THIS MAY BE MODIFIED BY HAVING THE USER G01051 00017 235* C ** ENTEL THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 00013 235* 00 935 k=1,LH 001051 001051 00013 237* 935 R1(K4,2)=1 001051 001051 00013 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING 001051 0013 239* C ** IHE USER ENTER THESE YALUES FOR FACH NODAL LOAD CARD 001051 0014 00 936 K51+LIH 001051 001057 00165 240* 00 936 K51+LIH 001057 01623 242* 936 K2(K5,K6)=20+ 001057 01057 01057 01057 001064 001057 01052 243* CALL ELOKDILLM.R1,R2,2,6) 001064 001064 01056 01064	
Dec? 23** C ** SET ALL COAC CONDITION NUMBERS: INTE MAY EE MODIFIED BY MAVING THE USER COIDS: C000 235* C ** SET ALL COAC CONDITION NUMBERS: INTE MAY EE MODIFIED BY MAVING THE USER COIDS: C001 235* C ** SET ALL COACCUMPATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING COIDS: C001 23** C ** SET ALL COACCUMPATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING COIDS: C001 23** C ** SET ALL COACCUMPATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING COIDS: C001 23** C ** SET ALL COACCUMPATED NODAL MODAL LOAD CARD. COIDS: C001 C ** SET ALL COACCUMPATED NODAL MODAL LOAD CARD. COIDS: COIDS: C001 C ** SET ALL COACCUMPATED NODAL MODAL LOAD CARD. COIDS: COIDS: C010 C ** SET ALL COACCUMPATED NODAL MODAL MODAL LOAD CARD. COIDS: COIDS: C010 C ** SET ALL COACCUMPATED NODAL MODAL ADD CARD. COIDS: COIDS: C010 C ** SET ALL COACCUMPATED NODAL MODAL COAD DATA COIDS: <td< td=""><td>U06:07 234* C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 U06:07 235* C ** ENIFE THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 CC61U 236* D0 935 K4=1+LIH 001051 001051 U0613 237* 935 B1K4+21=1 001051 U0613 237* 935 R1K4+21=1 001051 U0613 239* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING C01051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 240* D0 936 K5=1,LIM 001057 001057 U0623 242* 936 K5+1,EI 001057 U0624 243* CALL ELORD(LIM,R1,R2,2,6) U01064 U0626 244* C PRINT 117 001064 U0627 244* C PRINT 117</td><td></td></td<>	U06:07 234* C ** SET ALL LOAD CONDITION NUMBERS=1. THIS MAY BE HODIFIED BY HAVING THE USER G01051 U06:07 235* C ** ENIFE THE LOAD CONDITION FOR FACH NODAL LOAD CARD 001051 CC61U 236* D0 935 K4=1+LIH 001051 001051 U0613 237* 935 B1K4+21=1 001051 U0613 237* 935 R1K4+21=1 001051 U0613 239* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING C01051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD 001051 U0613 240* D0 936 K5=1,LIM 001057 001057 U0623 242* 936 K5+1,EI 001057 U0624 243* CALL ELORD(LIM,R1,R2,2,6) U01064 U0626 244* C PRINT 117 001064 U0627 244* C PRINT 117	
iDadi7 2255 i.** ENTLE.THE LOAD CONDITION FOR FACH NODAL LOAD CARD. IDADISI iC0511 237* 915 RETALLAN IDADISI iC0511 237* 915 RETALLANCE IDADISI iC0511 237* 915 RETALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING IDADISI iC0512 237* C.** THE USER ENTER THESE VALUES FOR FACH NODAL LOAD CARD. IDADISI iC0512 240* DO 936 KS1-LIM IDADISI IDADISI iC0520 244* CALL ELOBOLLIMERIA.E2.6 IDADISI IDADISI iC1520 245	GD607 235* C ** ENTEL THE LOAD CONDITION FOR FACH NODAL LOAD CARD D01051 CC610 236* D0 935 K4=1+LIH 001051 L0613 237* 935 R1K4;21=1 001051 L0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 L0613 239* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 L0613 239* C ** IHE USER ENIER THESE VALUES FOR EACH NODAL LOAD CARD D01051 L0613 239* C ** IHE USER ENIER THESE VALUES FOR EACH NODAL LOAD CARD D01051 L0613 239* C ** IHE USER ENIER THESE VALUES FOR EACH NODAL LOAD CARD D01057 L0623 242* 936 K2(K5,K6)=0. D01057 L0624 242* 936 K2(K5,K6)=0. U01057 L0625 244* C PRINT 117 C01064 L0626 244* C PRINT 117 C01064 L0627 246* WRITE(12,913) C01073 C01073 L0631 247* U0 940 K7=1+LIM U010	
CC61U 236* D0 935 %1 NIMA;ZII CO1051 U0113 238* C ** SCT ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING D01051 U0113 238* C ** SCT ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING D01051 U013 238* C ** SCT ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY MAVING D01051 U0145 240* D0 936 K551.LIM D01057 D01057 U0125 241* U0 936 K51.KS10.CO. D01054 D01054 U0126 241* U0 936 K21K5K0120. D01054 D01054 U0126 241* C PRIMI 117 D01054 D01054 U0262 241* C PRIMI 117 D01064 D01064 U0262 241* G01073 D01064 D01064 U0262 244* WRITE(12,913) G01106 D01100 U0263 244* 913 FORMATI'L NABINASTAL21162 G01106 U0263 244* 913 FORMATI'K COMM MODAL L	CC610 236* D0 935 K4=1+LIH 001051 L0613 237* 935 R1(K4,2]=1 L01051 L0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED By HAVING D01051 L0613 239* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED By HAVING D01051 L0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD D01051 L0615 240* D0 936 K5=1,LIH D01057 L0623 242* 936 K2(K5,K6)=0. D01057 L0624 243* CALL ELOKD(LIM:R1:R2:2:6) D01064 X L0626 244* C PRINT 117 D01064 L0626 245* C117 FORMAT(* IN MAINR1 AND R2 ARRAY*) D01064 D01064 L0627 246* WRITE(12,913) G01073 G01073 L0631 247* U0 940 K7=1:LIM G01106 U0634 248* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) G01106	
LODIJ 2378 915 First 271 Long	L0613 237* 935 R1(K4,2)=1 L01051 L0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 L0613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD D01051 L0615 240* D0 936 K5=1.LIH D01057 D01057 L0620 241* U0 936 K5=1.LIH D01057 L0623 242* 936 K2(K5,K6)=0. U01057 L0623 242* 936 K2(K5,K6)=0. U01057 L0624 243* CALL ELORD(LIM.R1,R2.2.6) U01064 L0625 244* C PRINT 117 D01064 L0626 245* C117 FORMAT(* IN MAIN=-R1 AND R2 ARRAY*) U01064 L0627 246* WRITE(12,913) C01073 L0631 247* U0 940 K7=1.LIM U01100 U0634 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) C01106 L0634 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) C01106	
UB-13 238+ C ** SET ALL CONCENTRATED NODAL MUMERTS TO ZERO. THIS MAY BE MODIFIED BY HAVING DOIDS1 CD01051 UD-15 239+ C ** THE USER CHER THESE FOR FACH NODAL LOAD CARO. DOIDS7 UD-15 240+ D0 936 KSE1,LIH DOIDS7 DOIDS7 UD-15 242+ 936 KSE1,LIH DOIDS7 DOIDS7 UD-26 242+ 936 KSE1,LIH DOIDS7 DOIDS7 UD-26 242+ 936 KSE1,LIH DOIDS7 DOIDS4 UD-26 243+ C HE LEDOIDLAND RIFE,2,2,6) DOIDS64 UD-26 245+ CILL EDOSDLIM,RI,RE,2,2,6) DOID64 UD-26 243+ CILL EDOSDLIM,RI,RE,2,2,6) DOID64 UD-27 240+ WRITELIZ,913) COID AL ARCANY! DOID64 UD-27 240+ WRITELIZ,913) MORAL LOAD DATA FROM MAIN!! COID64 UD-28 243+ 913 FORPATI' COMM NODAL LOAD DATA FROM MAIN!! COID106 DOID64 UD-28 243+ 9141E (12,903) (RILKRB1,RE1,21,1RZ(RT,KB1,RE1,61,6) DOI106 DOI106 <t< td=""><td>U0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 U0613 239* C ** IHE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD D01051 U0615 240* D0 936 K5=1,LIM D01057 U0623 241* U0 936 K6=4,6 D01057 U0623 242* 936 K2(K5,K6)=0. U01057 U0623 242* 036 K2(K5,K6)=0. U01057 U0624 243* CALL ELORD(LIM,R1,R2,2,6) U01064 U0626 244* C PRINT 117 001064 U0627 246* WRITE(12,913) 001064 001064 U0627 246* WRITE(12,913) 001064 00100 U0634 243* 913 FORMAT(* COMM NCDAL LOAD DATA FROM MAIN*) G01106 U0634 243* 913 FORMAT(* COMM NCDAL LOAD DATA FROM MAIN*) G01106</td><td></td></t<>	U0613 238* C ** SET ALL CONCENTRATED NODAL MOMENTS TO ZERO. THIS MAY BE MODIFIED BY HAVING D01051 U0613 239* C ** IHE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD D01051 U0615 240* D0 936 K5=1,LIM D01057 U0623 241* U0 936 K6=4,6 D01057 U0623 242* 936 K2(K5,K6)=0. U01057 U0623 242* 036 K2(K5,K6)=0. U01057 U0624 243* CALL ELORD(LIM,R1,R2,2,6) U01064 U0626 244* C PRINT 117 001064 U0627 246* WRITE(12,913) 001064 001064 U0627 246* WRITE(12,913) 001064 00100 U0634 243* 913 FORMAT(* COMM NCDAL LOAD DATA FROM MAIN*) G01106 U0634 243* 913 FORMAT(* COMM NCDAL LOAD DATA FROM MAIN*) G01106	
	LD613 239* C ** THE USER ENTER THESE VALUES FOR EACH NODAL LOAD CARD DD1051 L0615 240* D0 936 K5=1,LIH D01057 L0623 241* U0 936 K5=0. D01057 L0623 242* 936 K2(K5,K6)=0. U01057 L0626 243* CALL ELORD(LIM.R1.R2.2.6) U01064 L0626 245* C117 FORMAT(* IN MAIN-R1.R2.2.6) U01064 L0626 245* C117 FORMAT(* IN MAIN-R1.AD R2 ARRAY*) U01064 L0627 246* WRITE(12,913) U0100 L0631 247* U0.940 K7=1.LIM U0100 L0634 248* 913 FORMAT(* COMM NCDAL LOAD DATA FROM MAIN*) G01064	
USels 240* D0 936 K51,1P D01057 CG623 242* 936 K21K5,K6150 HD1057 CG623 242* 936 K21K5,K6150 HD1057 CG623 242* 936 K21K5,K6150 HD1057 CG623 242* 936 K21K5,K6150 HD1064 CG623 244* C PPIN117 HD1064 CG627 246* WF11K112,V11 HAND R2 ARRAY'1 HD1066 CG634 244* 913 FORMATI* COMM NODAL LOAD DATA FROM MAIN*1 C01106 CG634 244* 913 FORMATI* COMM NODAL LOAD DATA FROM MAIN*1 C01106 CG634 244* 913 FORMATI* COMM NODAL LOAD DATA FROM MAIN*1 C01106 CG634 244* 913 FORMATI* COMM NODAL LOAD DATA FROM MAIN*1 C01106 CG635 250* C940 WR1E (12,903) (R1K7,K61,K61,21,11,R2(K7,K81,K61,61,61) C01106 CG635 254* 950 WR1E (12,903) (R1K7,K61,K61,21,7,K61,K61,K61,61) C01132 CG635 254* C * 0 0 0 100 K1, K1,K1,K1,K1,K1,K1,K1,K1,K1,K1,K1,K1,K1,K	L0615 240* D0 936 K5=1,LIM D01057 L0620 241* D0 936 K5=4.6 D01057 L0623 242* 936 K2(K5,K6)=D. UD1057 L0623 242* 936 K2(K5,K6)=D. UD1057 L0626 243* CALL ELORDLIM.R1.R2.2.6) UD1064 L0626 244* C PRINT 117 UD1064 L0627 246* WRITE(12,913) UD1064 L0631 247* UD 940 K7=1.LIM UD100 U0634 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) G01106 L0635 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) G01106	
CCC2U 241* U0.916.K624.5 D01057 C0622 243* CALL FLOKDILINELAGA2.6) U01057 CL622 243* CALL FLOKDILINELAGA2.6) U01057 CL622 243* CALL FLOKDILINELAGA2.6) U01057 CL622 245* C117 FORMATI*IN MAIN-R1 AND R2 ARRAY*I U01064 CC622 245* C117 FORMATI*IN MAIN-R1 AND R2 ARRAY*I U01064 CC622 245* C117 FORMATI*IN MAIN-R1 AND R2 ARRAY*I U01064 CC623 245* U0.90 RTIE1 (19.913) U01013 CC633 247* U0.90 RTIE1 (12.903) URIX*X81.K851.61 C01106 CC653 253* C940 RTIE (12.903) URIX*X81.K851.61 C01106 CC653 254* 950 RTIE (12.904) U01132 U0132 CC654 255* C** OESION VARIABLE DATA*/I U01166 U01132 CC655 254* C * OESION VARIABLE DATA*/I U01143 U0143 CC657 255* C ** OESION VARIA	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	
→ CO623 242* 936 K2165,K6150. UD1057 CL52 244* C PRINT 117 UD1064 UD1064 CC526 244* C PRINT 117 UD1064 UD1064 CC527 24** VETTOR VETTOR UD1064 UD1064 CC537 24** VETTOR VETTOR UD1064 UD1064 CC532 24** VETTOR VETTOR UD1064 UD1064 CC532 24** VETTOR VETTOR UD1064 UD1064 CC532 24** VETTOR VETTOR UD1064 UD1064 CC542 253* VETTOR VETTOR UD1064 UD1064 CC542 254* C** DESIN VETTOR UD1064 UD1064 UD552 255* VETTOR VETTOR UD1064 UD1132 UD1136 UD552 254* C ** DESIN VETTOR UD1136 UD1136 UD553 254* <td< td=""><td>L0623 242* 936 R2(k5,K6)=0. UD1057 LL626 243* CALL ELORD(LIM.R1.R2.2.6) UD1064 L0626 244* C PRINT 117 UD1064 L0626 245* C117 FORMAI(* IN MAIN=R1 AND R2 ARRAY*) UD1064 L0627 246* WRITE(12,913) UD1064 L0631 247* UD 940 K7=1.LIH UD100 J0634 243* 913 FORMAT(* COMH NGDAL LOAD DATA FROM MAIN*) UD106</td><td></td></td<>	L0623 242* 936 R2(k5,K6)=0. UD1057 LL626 243* CALL ELORD(LIM.R1.R2.2.6) UD1064 L0626 244* C PRINT 117 UD1064 L0626 245* C117 FORMAI(* IN MAIN=R1 AND R2 ARRAY*) UD1064 L0627 246* WRITE(12,913) UD1064 L0631 247* UD 940 K7=1.LIH UD100 J0634 243* 913 FORMAT(* COMH NGDAL LOAD DATA FROM MAIN*) UD106	
CL526. 243* CALL ELORDICIMERIATE, 22.63 001064 L6526. 244* C PRINT 17 001064 L6526. 244* C PRINT 17 001064 L6526. 244* C L17 FORMATI* IN MAIN-R, AND R2 ARRAY*) 001064 L6631. 245* 011 FORMATI* COMM NODAL LOAD DATA FROM MAIN*) 001100 L6631. 245* 913 FORMATI* COMM NODAL LOAD DATA FROM MAIN*) 001100 L6651. 255* 940. K7111(14.13.4612.11.17.1481.K81.K81.481.461.61) 001106 L6551. 255* 940. K7111(14.13.4612.51) 001106 L6551. 255* 940. KRITE (12.903) (R1K7.K81.K851.21.182(K7.K81.K851.61) 001106 L6551. 255* 940. KRITE (12.904) 001132 L6551. 251* 940. KRITE (12.904) 001136 L6551. 254* C * 0 000 KRITE (13.4004) 001136 L6551. 254* C * 0 000 KRITE (13.4004) 001136 L6552. 254* C * 0 000 KRITE (13.4004) 001136 L6552. 254* C * 0 000 KRITE (13.4004) 001136 L6553. 254* C * 0 000 KRITE (13.4004) 001136 L6553. 254* L0 155. KRITE (NUMPY 001143 L6557. 256* C A (A1.1.1.1.40000) 001143	LL626 243* CALL ELORD(LIM,R1,R2,2,6) U01064 LL626 244* C PRINT 117 GD1064 LL626 245* C117 FORMAI(* IN MAIN=R1 AND R2 ARRAY*) DD1064 LL626 245* C117 FORMAI(* IN MAIN=R1 AND R2 ARRAY*) DD1064 L0627 246* WRITE(12,913) GD1073 L0631 247* U0 940 K7=1.LIH U01100 JU634 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) GD1066	
X LC526 244* C PRINT 117 LC526 C117 FORMATI* IN MAINR1 AND R2 ARRAY*) DD1064 LC527 246* WRITE(12,913) GD1073 LC527 246* WRITE(12,913) GD1064 LC527 246* WRITE(12,913) GD1064 L053 24** 913 <formati* comm="" data="" from="" load="" main*)<="" nodal="" td=""> GD106 L053 24** 913<formati* comm="" data="" from="" load="" main*)<="" nodal="" td=""> GD1106 L053 25** 94** FORMATI* COMM NODAL LOAD DATA FROM MAIN*) GD1106 L054 25** 95** C*** FORMATI** GD1106 L055 25** 95** FORMATI** FORMATI** GD1122 L055 25** 95** GRMAT 114** FORMATI** L055 25** 95** GRMATI** GD1136 L055 25** GENAT** GD1136 GD1135 L055 25** GD15** GD1143 GD1143 L055 25** GD15** GD1143 GD1143 L055 25** GU15** GD15** GD14** L055 25** GU15** GD14** GD1143 L055 25** GD15</formati*></formati*>	X LC626 244* C PRINT 117 GD1064 I LC626 245* C117 FORMAI(* IN MAIN=R1 AND R2 ARRAY*) DD1064 I LC627 246* WRITE(12,913) GD1073 I LC631 247* U0 940 K7=1.LIH U0100 JU634 243* 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) GD1066	
-1 LU1226 245± C117 FORMAT(* 1/K MAIN-shi AND R2 ARRAY*) C01073 LGB31 247± JD 940 K721.LIH C01073 C01000 LGB31 247* JD 940 K721.LIH C01100 LGB35 249* 940 K721.LIH C01106 LGB35 249* 940 K721.LIH C01106 LGB35 249* 940 H711 (12,903) (R1(K7.K8).K821.21, (R2(K7.K8).K821.65) C01106 LGB54 2535 C940 H711 (12,903) (R1(K7.K8).K821.21, (R2(K7.K8).K821.65) C01106 LGB54 2535 C940 H711 (12,903) C1(K7.K8).K821.65) C01106 LGB54 254* G0 G01132 G01132 LGB54 254* C * 02510N VARIABLE UATA G01136 LGB54 255* H716 (16,1G01) G01136 LGB54 255* G107 GRMAT (15,1GN VARIABLE DATA*/) G01143 LGB55 256* C AK1.11:L1. G01143 LGB54 255* L015 (2, K11.21).A(K1.21).LIK G01143 LGB55 256* C AK1.11:L1. G01143 LGB57 256* C AK1.11:L1.LIK G01143 LGB57 256* C AK1.11:L1.LIK G01143 LGB57 256* C AK1.11:L1.LIK <	□ □	
CDD C 2 / 240* WRITE (12/97)3 CDD C 2 / 240* CD C 2 / 240* <thc 2="" 240*<="" th=""> CD C 2 / 240* <thc 2="" 24<="" td=""><td>CODE Z40% WRITE(12,913) CODIO M LOB31 247% LOB 940 K7=1.LIH LOB100 JUE34 243% 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) GO1106 JUE34 243% 0.00 LOAD DATA FROM MAIN*) GO1106</td><td></td></thc></thc>	CODE Z40% WRITE(12,913) CODIO M LOB31 247% LOB 940 K7=1.LIH LOB100 JUE34 243% 913 FORMAT(* COMM NGDAL LOAD DATA FROM MAIN*) GO1106 JUE34 243% 0.00 LOAD DATA FROM MAIN*) GO1106	
UB31 UB31 UB31 UB121 UB121 UB121 UB121 UB33 249* 940 HRITL (12:9D3) (R1(K7,K8);K8=1,21)(R2(K7,K8);K8=1,6) UB1106 UB33 2535 249* 940 RITE (6;903) (R1(K7,K8);K8=1,21)(R2(K7,K8);K8=1,6) UB112 UB53 251* 943 FORMAT (14:13,56E12,5) UB112 UC651 252* 950 WRITE (12:904) UB1136 UC653 253* 904 FORMAT (12:704) UB1136 UC653 254* C ** 0ESIGN VARIABLE UATA UB1136 UC654 255* #RITE (6;1001) UB1136 UC655 256* 100; FORMAT (13:7, *0ESIGN VARIABLE DATA*/) UB1143 UC657 258* C A(K1,1):1. UB143 UC657 258* UB157 UB157 UB143	UDDJ 24/- DD 240 R/-14L10 DD104 UDD DD14 R FROM MAIN+) DD1106	
C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C0000 C00000 C00000 C00000 C00000 C00000 C00000 C00000 C00000 C000000 C000000 C000000 C000000 C000000 C000000 C000000 C0000000 C0000000 C0000000 C0000000 C0000000 C0000000 C0000000 C0000000 C00000000 C00000000 C00000000 C00000000 C00000000 C00000000 C00000000 C00000000 C000000000 C000000000 C000000000 C0000000000 C0000000000000 C00000000000000 C0000000000000000 C000000000000000000000000000000000 C000000000000000000000000000000000000		
CG655 253* C940 *RITE 16,903) (R1(KT,KB),KB=1,2),(R2(KT,KB),KB=1,6) D01106 CU551 251* 935 FORMAT (14,13,6E12,5) D01132 CG653 252* 950 #RITE (12,904) D01136 CG653 253* 904 FORMAT (1*,*) D01136 CG653 254* 0** DESIGN VARIABLE UATA D01136 CG653 254* C ** DESIGN VARIABLE DATA*/) D01136 CG653 256* 1.000 FORMAT (15X*, "DESIGN VARIABLE DATA*/) D01136 CG657 258* C AIK1+151* D01143 D01143 CG657 258* C AIK1+151* D01143 D01143 CG657 258* C AIK1+151* D01143 D01143 CG657 258* C AIK1+151* D01143 D01151 CG657 258* C AIK1+151* D01143 D01151 CG657 259* C1056 Rata (2x, FG0R VARIABLE NO*, 13,* ENTER AOLD AND AMIN, IN T D01174 CG657 258* C AIK1+11* AIK1+1* C61174 C61174 CG672 264* C PRMAT (12x, F	GAGAA ZAZE VARI ARTIZ BIZANUNI KRIKKANKANKANKANKANKANKANKANKAN (DINKA	
LU65U 251* 9U3 FORMAT L14:13.6E12.51 D01132 L0651 252* 950 wRITE 12.904 001132 L0653 253* 904 FORMAT 12.904 001132 L0653 254* C ** 0E5100 VARTABLE UATA 001136 001136 L0654 255* wRITE 16.1500 001136 001136 L0657 256* UO [154 KI=1,NUMDY 001143 001143 L0657 257* L0 1054 KI=1,NUMDY 001143 U0657 258* C Ath,1;1:- 001143 001143 L0657 258* C Ath,1;1:- 001143 001143 L0657 258* C Ath,1;1:- 001151 001151 L0657 258* L056,2;1:- 001151 001151 L0662 2:- 1056,7;1:- 001174 001174 L0672 2:- 1001 FORMAT (2x,*FOR DESIGN VARTABLE NO.*, 13,* ENTER AOLD AND AMIN, IN T 001174 L0672 2:-<	LG635 250* C940 wRITE (6,903) (R1(K7.K8).K8=1.2).(R2(K7.K8).K8=1.6) 001106	
u0651 252* 950 wRITE (12,904) 001132 u0653 253* 904 FigHAT(**) 001136 u0653 254* C ** 0ESINN VARIABLE UATA 001136 u0654 255* wRITE (6,1004) 001136 u0655 256* 1000 FORMAT (15X,*DESIGN VARIABLE DATA*/) 001136 u0657 258* C A(K1,1)::1,NUMDV 00143 u0657 258* C A(K1,1)::1,NUMDV 001143 u0657 258* ClugC Atti:1,NUMDV 001143 u0657 259* ClugC Atti:1,A(K1,2): 001143 u0662 261* 1021 FORMAT (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN,IN T 001174 u0672 263* Clug FORMAT (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN,IN T 00174 u0672		
LD653 253* 904 FORMAT(* *) DD1136 LD653 254* C ** DESIGN VARIABLE DATA LD136 LD654 255* #RIL (6.1500) OD136 UC655 256* 10°0 FORMAT (15X,*DESIGN VARIABLE DATA*/) U01143 UC657 256* C A(K1,1):1. U0143 UG657 256* C M(K1,1):1. U01143 UG652 260* wRITL (6,1001)K1 U01151 UC672 262* 1001 FORMAT (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN, IN T U01174 UC672 264* C PRINT 118 U0174 UC672 264* C PRINT 118 G01174 U0673 266* D 0.51 K1=1,NUMUV U0174 U0674 264* D 0.51 K1=1,NUMUV U0174 U675 264* C 0.151 K1=1,NUMUV U0174 U0676 2	uC651 252* 950 wRITE (12,904) 001132	
LG 653 254* C ** DESIGN VARIABLE DATA L01136 LG 654 256* HRITE 16.1600) 001135 UC 655 256* 10% GORMAT (15X, 'DESIGN VARIABLE DATA'/) U01143 LG 657 257* L0 1L5J K1=1,NUMDV G01143 UG 657 258* C Atk1,1;=+ 001143 UG 657 258* C Atk1,1;=+ 001143 UG 657 259* Clu5G Atk1,2]=.1 001143 UG 657 259* Clu5G Atk1,2]=.1 001143 UG 657 250* HRITE (6,1G01)K1 001151 LG 652 26.0* wRITE (6,1G01)K1 001151 LG 652 26.2* 1001 FORMAT (2X, 'FOR DESIGN VARIABLE NO'', 13, 'ENTER ADLD AND AMIN, IN T 001174 UG 672 26.4* C PRINT 118 G01174 LG 672 26.5* Cl18 FORMAL', I.M. MAINKLAND K ARRAYAOLD AND AMIN, IN T 001174 UG 673 26.6* D0 1.51 K1=1, NUMUV G01174 UG 674 26.7* 1051 WRITE (12,1002) K1.(A(K1,K2),K2=1,2) G01174 UG 676 26.6* Clu51 WRITE (16,02) K1.(A(K1,K2),K2=1,2)	69653 253* 904 FORMAT(* *)	
U05% 25% WRITE (6.1000) 001116 U7656 256* 10°0 FORMAT (15%,*DESIGN VARIABLE DATA*/) 001143 U057 257* G0143 G01143 U0657 258* C A(K1,1)::A G01143 U0657 259* Clu56 A(K1,2)::A G01143 G01143 U0657 259* Clu56 A(K1,2)::A G01143 G01143 U0657 259* Clu56 A(K1,2)::A G01151 G01151 U0652 260* WRITE (6,1001)K1 G01157 G01157 U0652 262* 1001 FORMAT (2%,*FOR DESIGN VARIABLE NO*', 13,* ENTER AOLD AND AMIN, IN T G01174 U0672 264* 1HAI ORUER*) G01174 G01174 U0672 265* Clu8 + ORPAI1* IN MAINK1, AND K AHRAYAOLD AND AMIN*) G01174 U0673 266* D0 1.51 KI=1, NUMOV G01174 U0674 267* 1051 KRITE (12,16,02) K1, (A(K1,K2),K2=1,2) G01174 U0675 268* Clu51 KRITE (12,16,02) K1, (A(K1,K2),K2=1,2) G01174 U0676 268* Clu51 KRITE (12,16,02) K1, (A(K1,K2),K2=1,2) G01174	LD653 254* C ** DESIGN VARIABLE DATA LO1136	
UP656 256* 10%0 FORMAT (15X,*DESIGN VARIABLE DATA*/) U01143 U0657 257* U0 115, NEIL,NUMDY 001143 U0657 259* Clubs Attal,1,1.4 001143 U0657 259* Clubs Attal,1,1.4 001143 U0657 259* Clubs Attal,21.1 001143 U0657 254* 1050 Repart (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN,IN T 001174 U0672 264* 101 FORMAT (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN,IN T 001174 U0673 266* Clubs FORMAT.* IN MAINKI,AND K ARRAYAOLD AND AMIN*J Coll74 U0673 266* Clubs FORMAT.* IN (AK1.K2),K2=1.21 Coll74 U0674 266* Clubs FORMAT.* IN (A(K1.K2),K2=1.21 Coll74 U0676 266* Clubs FORMAT.* IN (A(K1.K2),K2=1.21 Coll74 C0706 266* Clubs FORMAT.* IS,2F10.3)	LU654 255* #RITE (6,100U)	
L0657 257* L0 1L5J KI=1,NUHDV GD1143 L0657 258* C A(K1,1)=1. DD1143 L0657 259* Clu50 A(K1,2)=1. DD1143 L0662 260* WRITE (6,1001)K1 DD1151 L0663 261* 1055 READ (5,7) A(K1,1),A(K1,2) DD1151 L0663 261* 1055 READ (5,7) A(K1,1),A(K1,2) DD1174 L0672 262* 1001 FORMAT (2X,*FOR DESIGN VARIABLE NO.*,13,* ENTER AOLD AND AMIN, IN T DD1174 L0672 265* L18 FORMAT (2X,*FOR DESIGN VARIABLE NO.*,13,* ENTER AOLD AND AMIN, IN T DD1174 L0672 265* Clu8 FORMAT (12X,*FOR DESIGN VARIABLE NO.*,13,* ENTER AOLD AND AMIN, IN T DD1174 L0672 265* Clu8 FORMATI,* IN MAIN==K1, AND K ARRAY==AQLD AND AMIN*) GD1174 L0673 266* D0 1,51 KI=1,NUMDV GD1174 L0674 266* D0 1,51 KI=1,NUMV GD1174 L0675 268* Clu51 KI=1,NUMV GD174 L0674 266* D0 1,51 KI=1,NUMV GD174 L0675 268* Clu51 KI=1,NUMV GD174 L0676 268* Clu51 KI=1,K1,	UC656 256* 1000 FORMAT (15X, "DESIGN VARIABLE DATA"/) UC1143	
50657 258* C A(K1,1):1. 001143 00657 259* Clu56 A(K1,2):1. 001143 00657 259* Clu56 A(K1,2):1. 001143 00652 260* wRIT (6,1601)K1 001151 00652 262* 1001 FORMAT (2X,*FOR DESIGN VARIABLE NO**,13,* ENTER AOLD AND AMIN, IN T 001174 00672 263* 1HAT ORDER*) 001174 00672 264* C PRINT 118 001174 00673 266* 001.51 K1=1,NUMU 001174 00676 266* 00.1.51 K1=1,NUMU 001174 00676 266* C1051 K1=1,NUMU 001174 00676 266* C1051 K1=(12,1602) K1.(A(K1,K2),K2=1,2) 001174 00676 266* C1051 K1=(1602) K1.(A(K1,K2),K2=1,2) 001174 00706 269* 1002 FORMAT(15,2Fi0.3) 001174 00707 270* NUMNF=NUM(1) 001213 00712 01215 01215 01215 00712 270* NUMNF=NUM(1) 001213 00712 270* NUMNF=NUM(1) 001215 <td>601143</td> <td></td>	601143	
U0557 259* Clu55 A(k1.2)=.1 001143 U0567 260* wRITE (6,1001)K1 001151 U0567 262* 1001 FORMAT (2X,*FOR DESIGN VARIABLE NO*,13,* ENTER AOLD AND AMIN, IN T 001174 U0572 263* 1HAI ORDER*) 001174 U0672 264* C PRINT 118 001174 U0673 266* Clu51 HOIL43 001174 U0674 266* Clu51 HRITE (12:1002) K1.(A(K1:K2),K2=1.2) 001174 U0675 266* Clu51 wRITE (6,1002) k1.(A(K1:K2),K2=1.2) 001174 U0675 268* Clu51 wRITE (6,1002) k1.(A(K1:K2),K2=1.2) 001174 U0705 269* 1002 FORMAT(15:2F:0.3) U01174 001213 U0707 270* NUMNPENUM(1) 001213 001213 U0711 272* KEWIND 12 00120 001215	5657 258+ C A(K1,1)=1.	
C0662 260* WRITE (6,1G01)KI 001151 L0665 261* 1050 READ (5.7) A(K1.1).A(K1.2) G01157 L0672 262* 1001 FORMAT (2X, 'FOR DESIGN VARIABLE NO.*, 13, 'ENTER AOLD AND AMIN, IN T 001174 00672 263* 1HAI ORUER') G01174 00673 265* C118 FORMAT('IN MAINK1.AND K ARRAYAOLD AND AMIN') G01174 00673 266* D0 1.51 K1=1,NUMÜV G01174 00676 266* D0 1.51 K1=1,NUMÜV G01174 00676 266* C1051 WRITE (12.1G02) K1.(A(K1.K2),K2=1.2) 001174 00676 266* C1051 WRITE (6,1G02) K1.(A(K1.K2),K2=1.2) 001174 00706 269* 1002 FORMAT(15,2F10.3) 001213 00707 270* NUMNF=NUM(1) 001213 00701 270* NUMNF=NUM(1) 001215 00711 272* KEWIND 12 001220		
LUGU		
C0072 262* 1001 FORMAT (22, FOR DESIGN VARIABLE NO**, 13, * ENTER ADED AND AMIN, IN T 001174 00672 264* C PRINT 118 001174 00673 265* C118 FORMAT(* IN MAINK1, AND K ARRAYAOLD AND AMIN*) 001174 00673 266* D0 1,51 K1=1,NUMDV 001174 00676 267* 1051 WRITE (12,1002) K1, (A(K1,K2),K2=1,2) 001174 00676 268* C1051 WRITE (6,1002) K1, (A(K1,K2),K2=1,2) 001174 00706 269* 1002 FORMAT(15,2F10,3) 001213 00707 270* NUMNPENUM(1) 001213 00711 272* KEWIND 12 001220	$\frac{1005}{100} = \frac{261^{\circ}}{100} = \frac{1005}{100} + \frac{261}{100} + \frac{1001}{100} + $	
00012 2054 C PRINT 118 00174 00672 255* C118 FORMATI* IN MAINK1, AND K ANRAYAOLD AND AMIN*) 001174 00673 266* D0 1,51 K1=1,NUMDV 001174 00676 267* 1051 WRITE (12,1002) K1, (A(K1,K2),K2=1,2) 001174 00676 268* C1051 WRITE (6,1002) K1, (A(K1,K2),K2=1,2) 001174 00706 269* 1002 FORMAT(15,2F10.3) 001213 00707 270* NUMNPENUM(1) 001213 00711 272* KEWIND 12 001220	(0672 2634 INT FORMAL VAR FOR DESIGN VARIABLE NO® (15), ENTER AULD AND ANIN, IN I DOILING	
C0012 C00174 C00174 C0073 C00174 C00174 C0073 C074 C00174 C0076 C074 C00174 C0076 C08* C1051 k114 (A1(k1, k2), k2=1, 2) C00174 C0076 C08* C1051 k114 (G102) k1, (A1(k1, k2), k2=1, 2) C00174 C0766 C68* C1051 k114 (G102) k1, (A1(k1, k2), k2=1, 2) C00174 C0766 C69* 1002 FORMAT(IS, 2F10, 3) C001213 C0707 270* NUMNF=NUM(1) C01215 C0711 C72* KEWIND 12 C01220		
00673 266* D0 1,51 k1=1,NUMDV 001174 00676 267* 1051 WRITE (12,1002) k1,(A(K1,K2),K2=1,2) 001174 00676 268* C1051 wRITE (6,1002) k1,(A(K1,K2),K2=1,2) 001174 00706 269* 1002 FORMAT(15,2F10,3) 001213 00707 270* NUMNP=NUM(1) 001213 00710 271* ENDETLE 12 001215 00711 272* KEWIND 12 00120	L0672 = 265 C118 FORMATI' IN MAIN-KI, AND K AHRAY-AQID AND AMIN'I C0174	
U0676 267* U051 WRITE (12,1002) k1, (A(K1,K2),K2=1,2) 001174 U0676 268* C1051 WRITE (6,1002) k1, (A(K1,K2),K2=1,2) U0174 U0706 269* 1002 FORMAT(15,2F10,3) U01213 U0707 270* NUMNF=NUM(1) 001213 U0711 272* KEWIND 12 U0120		
U0676 268* C1U51 wRITE (6,1002) k1,(A(k1,k2),k2=1,2) U01174 U0706 269* 1002 FORMAT(15,2F10,3) U01213 U0707 270* NUMNF=NUM(1) 001213 C071, 271* ENDETLE 12 001215 U0711 272* KEWIND 12 001220	$\frac{10676}{267^{4}} = \frac{267^{4}}{1051} + \frac{1051}{1051} + \frac{112}{100} + \frac{1}{100} + \frac{1}{10$	
L0706 269* 1002 FORMAT(15,2F10.3) U01213 00707 270* NUMNF=NUM(1) 001213 00710 271* ENDETLE 12 001215 00711 272* REWIND 12 001220	60676 268* C1051 wRITE (6,1602) k1,(A(k1,k2),k2=1,2) 001174	
G0707 270* NUMNP=NUM(1) G01213 C0710 271* ENDFILE 12 G01215 G0711 272* REWIND 12 G01220	L0706 2694 1002 FORMAT(15,2F10.3)	
<u>C071, 271* ENDETLE 12</u> 001215 0012120	60707 270+ NUMNP=NUM(1) 601213	
60711 272* REWIND 12 001220	<u> C071, 271* ENDETLE 12</u>	
	60711 2724 REWIND 12 B01220	
<u>0712 273* REAU(12+1) HEAD</u> 001223	60122 3* REAU(12-1) HEAD CO1223	

MAIN		DATE 07308n	PAGE	7
	WRITE(13,1) HEAD	001233		
u0720 275*	WRITE (13,1003) NUMNP, NEL TYP, NLOAD, NUMDY	CO1243		
<u>60720 276* C</u>	PRINT 1004	601243		
60720 277+ C1004	FORMATI' NUMNPNELTYPNLOADNUMDV NEXT PRINT')	001243		
<u>60726 278* C</u>	WRITE (6,1003)NUHNP,NELTYP,NLOAD,NUHDV	001243		
60726 279* 1005	READ(12,1,END_2) HEAD	001255		
<u>00731 280*</u>	IF(HEAD(1) .EQ.DUHM)GO TO 1005	001265		
00733 281*	WRITE(13,1) HEAD	CO1270		
00736 262*		001300		
00737 263* 1003	5 FORMAT (415)	601302		
<u> </u>	STOP	001302		
	END	001305		
ENU FOR	· · · · · · · · · · · · · · · · · · ·			
HDG, P NAME				
APDT S NAME				
FURPUR 28R1H1 E36 S74T1	1 07/30/80 09:45:45			
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NOUPT

DATE 073080 PAGE 1

WFOR, S NOUPT, NOUPT

HSA E3 -07/30/80-09:45:46 (27,)

SUBROUTINE NOUPT ENTRY POINT GOU457

STORAGE USED: CODE(1) 000472; DATA(U) 015130; BLANK COMMON(2) 000000

COMMON BLOCKS:

UDU3 BACH UGOD44

EXTERNAL REFERENCES (BLOCK, NAME)

 <u> 2004</u>	NREWS		
5LÚÚ	NRDUS		
 <u>u006</u>	N1015		
0007	N1025		
 6010	NI035		
0011	NEDUS		
5012	NERR35		

2	STORAGE	ASSIGNMENT	(BLOCK, TYPE, RELATIVE LOC	ATION, NAME)		
X	u ÜU 1	3L0U17 1166	CGU1 000025 123G	0001 000031 1276	UD01 00051 1376	0001 000053 1426
—		ULOU75 1556	<u> </u>	U0a1 000134 1776	0001 000223 1853L	<u>00n1 000147 2076</u>
ట	CO 01	UUU154 2136	0001 000171 223G	0001 000174 226G	0061 000216 241G	U0G1 0CD240 256G
਼ 	<u> </u>	UUE242 2616	60ú1 00n254 >676	0001 000312 314c	0001 000331 3246	0001 000343 3356
	CO 01	000351 3406	UDU1 UU0353 343G	0001 000365 3516	0701 CD0410 367G	GOD1
	<u> </u>	000421 377G	1.000 015062 5F	U001 000370 61L	0001 CU0360 62L	6000 015051 700F
	აძეს	015655 701F	COUD 015656 702F	U001 000057 751L	0001 000105 752L	0001 000107 753L
	1.00	GUC115 765L	<u>COUL 0C0200 851L</u>	0001 nnu226 652L	COG1 000230 853L	0001 nnn234 864L
	0601	000265 881L	CG01 000247 882L	0000 015073 9C1F	0000 015064 903F	0000 015061 910F
	<u></u>	000273 950L	CCU1 0004n3 959L	0000 I 000000 cR0n	0000 R 0150-1 DUH	0000 I 015030 I
	0000 I	615631 II	LOUD 015110 INJPs	UCOD I n15032 J	0000 I 015036 JJ	ÚDÚO I n15033 JK
	սվեն I	U15027 K		0000 I 015035 L	0000 I 015045 L1	0000 I 015047 12
	5006 1	015050 L3	6000 I 015646 L4	6060 I 015043 M	0000 I 015037 M1	UNUO I 015044 NCROn
	<u>1_000</u>	015143 NEND	6060 I 015634 NEND3	6000 I 005524 NODPT1	0003 I 000022 NSTART	6303 I 000nng NUM
	6060 I	U15C25 NUMNP	2 LUUD I U15026 NUM4	UDUD I UUU310 SHARI	0000 p 011610 SHAR2	UOUD I 013414 SPC1
		015642 T	<u> </u>			-

LU101	1 #		SUBFOUTINE NODPT	000000	
60105	2*		COMMON/BACH/NUM(18),NSTART(18)	00000	
60103	3 #	C **	CHANGE GROUP. NO. OF DESAP BAR ELS.INASTRAN RODI	000000	
66104	4 *		INTEGER_CROD(1110+2)	60000	
66104	5*	C **	CHANGE GROUP. NO. OF NODAL POINTS	LOUDDD	
00105	6\$		INTEGER_SHAR1(300,9)	00000	
00106	7*		UIMENSION NOUPT1(300,7), SHAR2(300,3)	600000	
60106	8*	<u>C</u> **	CHANGE GROUP. NO. OF SPCI CARDS	00000	
60107	9 *		INTEGER SPC1(50,15)	00000	
60107	11+	C **	*******************	<u>UOODVO</u>	

	NO	UP T		DATE UT3080	PAGE	2
	60110	11*	INTEGER V(7)	00000U		
	60111	12*	DIMENSION DUM(20)	000000		
_	00112	13*	REWIND 11	00000		
	60113	14+	NUMNP=NUM(1)	000002		
	<u> </u>	15*	NUH4=NUH(4)	000005	··	
	L0114	16*	C ++ CREATES NODAL POINT DATA	000005		
·	60114	<u> </u>	<u>C_** HHEN_NUM(4)=U_(NO_SPC1_CAROS).READS_GRID_CARDS_FROM_FILE_11.STORE</u>	<u>S IN000005</u>		
	60114	18*	C ** ARRAYS SHAR1 AND SHAR2 AND WRITES NODAL PT. DATA CARDS ON FILE 12	2 000005		
	00114	19*	C ** SHAR1 CONTAINS NODE NO. AND NASTRAN CONSTRAINTS	<u>000005</u>	<u> </u>	
	60114	20*	C ** SHARZ CONTAINS CORRESPONDING COUNDINATES (SAME NOW NO.)	000005		
		21*		000007		
	60126	22*	$K_{AU} (11, 100) SHARI(K, 1), (SHAR2(K, 1), 1-1, 3), (SHAR1(K, 1), 1-2, 9)$	800017		
	<u> </u>	- 23+	TAC NORTHIN INCOMPLATIONAL INCOMPLATION IN THE AND AND AND AND AND AND AND AND AND AND	000017	······································	
	60135	29#	/00 NUUFII(N,1)-SHAKI(N,1) 700 KOUMATION TO 00 280 Å OV 0111	000034		
	60135	26#		000053		
	(0175	27±	C THE NORPE CONTAINS DESAG NORPENG, AND 6 MOTION CODES	000055		
	60135	28*	C ** INITIALIZE DESAP CONSTRAINT CODES TO ZERO	000053		
	00136	29*		00053		
	60141	3.)*		000053		
	00144	31*	766 NODPT1(K,I)-G	000053		
	00144	32*	C ** II COUNTS THE 8 COLUMNS OF SHAR1 (K.2 TO 9)	000053		
	un146	33#		600054		
	00147	34*	751 II=11+1	600057		
•	L0150	35 ☆	IF (II.6T.9)60 TO 765	600061		
×	L015U	36*	C ** CHECK IF COLUMN IS BLANK	00nn61		
\times _	00152	37*	IF(SHAR1(K,II), EQ.D) GO TO 751	<u> </u>		
\times $-$	60152	38*	C ** J IS THE NASTRAN RESTRAINT CODE. J=1 MEANS UX=0 .J=6 MEANS DX=0	000064		
Γ_	L0154	39*	D0 752 J=1.6	<u> </u>		
ယ္ခ	00157	43*	IF(SHAR1(K,II).EQ.J) GO TO 1753	000075		
~ <u>-</u>	60161	41*	60 10 752	600100		
	60162	42×	1753 JK=J	608102		
	<u>U0163</u>	43*	<u>60 t0 753</u>	000103		
	ÚD164	44 +	752 CONTINUE	000107		
	<u>00166</u>	45*	753 NODPT1(K+JK+1)=1	000107		
	60167	46≠	GO T _O 751	000113		
	<u> </u>	47*	765 CONTINUE	600121		
	60175	48*	C PRINT 1860	000121		
	<u> </u>	49.4	CIBUD FORMAT(IX: MODPT_ JUST BEFORE SPC1 CARDS')			
	60170	÷10	C DO IBUL KEL,NUMNP	600121		
_	<u></u>	<u> </u>	CIBUL PRINT 910 (INCOPTING, II-1-1, T)			
	601/0	527	U MM IF (HERE ANE SHUI CANDS,MODIFY NOOPTI ARRAY Te louming e. Digo to osg	000121		
_	10172	 5.4 w	C AN UPEN SDC. CAUDE ETEINS 2 TUDOUGU O AND STODE -N SDCI			
	172	34* 55±	C TT NERD STUL CARDS FIELDS 2 INRUDOR Y AND STURE IN SPEL	000121		
	<u></u>	<u></u>	<u> </u>			
	00174	57#	NEWING AA	000125		
	<u>LU175</u>	58#	$\frac{1}{10} - \frac{1}{10} + \frac{1}{10} $			
	66201	59±		600134		
	60205	617+	701 FORMAT (2044)	000147		
	Unizné	61¥	60 771 L=1.NUM4	505117 506147		
	00211	62*	771 READ (11.7C2) (SPC1(L,J),J=1-15)	006147		
	66220	63*	742 FORMAT(8X,18,81,618)	000163		
_	60221	64*	REWIND 11	000163		
-	<u> </u>	65×	C ## TRANSFER CONSTRAINT COUES FRUM SPC1 ARRAY TO NODP11 ARRAY	U00163		
	60221	66 ₩	C ** V IS STORAGE VECTOR	600163		
-	00221	67*	C ** K INDEXES SPC1 RUW(SPC1 CARD)	000163		

_	<u>NU</u>	UPT			DATE 073080	PAGE	3
	LI0222	68*		UO 865 K=1 NUM4	600174		
	60225	69*			600174		
	00230	70+	860	v(_)=0	000174		
	60232	71*		1111	000175		
	00233	72*	851	II=II+1	000200		
	60234	73≎		IF (II.6T.9) GO TO 864	600202		
	60234	74*	<u> </u>	CHECK IF COLUMN IS BLANK	000202		
	00236	/5* 76*	(* * *	IF ISPCII(K,II) +EU+U/UO IO 851	000205		
	1:0240	77 ±		UO 852 JELAS	00216		
	60243	78*		IF(SPC1+K, II)+E0+J)60 TO 1853	006216		
	00245	79*		60 TO 852	000221		
	60246	<u> 80+</u>	1853	ن=ان	000223		
	60247	61÷		60 TC 653	UDD224		
	00250	62*	852	CONTINUE	000230		
	UU252	83×	853		000230		
	00253		c +		000232		
	60255	034 56#	÷ د ج	KIH SPCI IS DUNE. V CUNIAINS 6 DESAP CUNSIRAINT CODES FOR THAT K			
	<u> </u>	87*	<u> </u>	PLACE NEW CONSTRAINT CODES IN MODPIL	000234		· · · · · · · · · · · · · · · · · · ·
	60254	68*	č	PRINT 908. K. (v(I).I=1.7)	000234		
	60254	<u>,</u> 9≉	6638	FORMAT(1X, "V FOR SPC1", 13/5X, 715)	000234		
	<u>L0255</u>	Υับ +		D0 880 M1=10,15	LD0234		
	60260	91÷		DO E81 M=1,NUMNP	000242		
	00263	92*		IF (NOUPI1(M,1)+EQ+ SPC1 (K,M1)) GO TO 882	<u></u>		
X	60265	53 *		60 TO 987	000245		
×	00265	94*	<u> </u>	NODAL PI. NO. IN NOPPII (H, I) IS REFERENCED ON SPCI CARD INDEXED BY K	000245		
IX	00265	Q/± ∀⊃≁		PLACE NEW CONSTRAINTS ON THIS NODAL PIC	000245		
	L0271	97*		IF(V(L), NF. 0.1 NUDPT1 (M.L)=V(L)	600254	·	
š.	L0273	98×	883	CONTINUE	000273		
	60273	64	C **	THE MTH NODPT1 CARD IS NOW COMPLETE	D00273		
	60273	1*	C	PRINT 909.M	000273		
	60273	101*	6909	FORMAT(1x, NUDPT1 CARD, 13/)	000273		
_		162*	<u> </u>	PRINT 910.1%, (DpT1(M+L)+L=1.7)	000273		
	10275	1.34+	910		000273		
	.0300	1.15+	100				
	60306	1654	C **	ALL NODELS CARDS ARE NOW COMPLETE	600273		
-	LO302	107*	865	CONTINUE	000273		
	60304	1u8×	950	CONTINUE	600273		
	60365	109*		KN=U	000273		
	60306			<u></u>	600273		a
	00306	111*	C **	HOUIFY HOTION CODES IF THERE ARE ANY NASTRAN RODS	000273		
	<u> </u>	<u>112</u> ≠	<u> </u>	BRING CRODS FROM FILE 10 AND GET THE GRID PT NO'S.	000273		
	6307	1104	L ##	PIND CORRESPONDING NODE PI NO'S IN NODPII AND ENFORCE ZERO ROTATIONS	000273		
	<u> </u>	115*			600277		
	60312	116*			000301		
	60313	117*		DO SE LEINEND	LC0306		
	<u> </u>	<u>118¢</u>	50	REAL (11,701)DUM	600312		
	60322	119#		NCR(D=NUM(5)	600322		
	60323	120+		U0_51_L=1.NCROU	000324		
	60326	121*	51	READ (11,5) CROD(L,1), CROD(L,2)	606331		
	<u> </u>	144	<u> </u>	TURHAI 1243,2187	600343		
	60334	124#		00 60 LI-IFRUKUU 00 70 LU21.2	000343		
					000333		

L035 L05 00 ft L22:::UNPP 000055 L031 L22:::UNPP L00055 L00055 L031 L27 L00055 L000575 L031 L27 L000575 L000575 L0315 L27 L200 FORMATIN - L12: L20: L20: L20: L20: L20: L20: L20: L2	NOD	PT	······································		DATE 073080	PAGE	4
LG345 126+ 17, MCOPTILE, 1).CO.GROD (L ₁ ,L4)) GO TO 62	0342	125*		00 61 L2=1.NUMNP	000353		
C0350 127* 60 10 61 C00356 C0351 128* 62 C00350 C00355 C0351 128* 63 c001100 C00355 C0351 128* 64 C001100 C00375 C0351 128* 60 C001100 C00375 C0351 138* C200 F0MATI * FINAL OUTPUT OF NODPT.*) C00375 C00375 C0351 138* C200 F0MATI * FINAL OUTPUT OF NODPT.*) C00375 C00375 C0354 138* C200 F0MATI * FINAL OUTPUT OF NODPT.*) C00375 C00375 C0354 138* C4011412.*033 C4011412.*037 C00375 C0354 138* 950 F0 K11 NULL * NOLAR E0M NODEPT.* C00375 C0355 138* 950 F0 K11 NULL * NOLAR E0M NODEPT.* C00401 C0375 138* 950 F0 K11 NULL * NOLAR E0M NODEPT.* C00401 C0371 149* 950 F0 K11 NULL * 11.*17.*1.*5MA21K1.*1.*1.*1.*1.*1.*1.*1.*1.*1.*1.*1.*1.*1	0345	126*		IF (NODPT1(L2,1).EQ.CROD (L1,L4)) GO TO 62	L00353		
00550 128* 62 00 63:5, 120* 000000 00551 120* 61 000116 000116 00551 120* 61 000116 000116 00551 120* 60 000116 000116 00551 120* 60 000116 000115 00551 120* 60 000116 000115 00551 120* 000116 000115 00551 120* 000116 000115 00551 120* 000115 000115 00551 120* 000115 000115 00551 120* 000116 000115 00551 120* 000116 000115 00551 120* 000116 000115 00551 120* 000116 000115 0056 131* 000116 000115 00571 139* 600 90 90 90 900 <td>0347</td> <td>127*</td> <td></td> <td>60 10 61</td> <td>GDU356</td> <td></td> <td></td>	0347	127*		60 10 61	GDU356		
2035 120* 63 .00.11/01 .00.0375 2035 130* 64 .00.11/01 .00.0375 2036 131* 60 .00.11/01 .00.0375 2036 130* 64 .00.11/01 .00.0375 2036 130* 64 .00.11/01 .00.0375 2036 130* 64 .00.11/01 .00.0375 2036 130* Constants .00.0375 .00.0375 2036 130* .00.01.11/01 .00.0375 .00.0375 2036 130* .00.01.11/01 .00.0375 .00.0375 2036 130* .00.01.11/01 .00.0375 .00.0375 2036 130* .00.01.11/01 .00.0375 .00.0375 2036 130* .00.01.11/01 .00.01.11/01 .00.01.11/01 2037 130* .00.01.11/01 .00.01.11/01 .00.01.11/01 2037 130* .00.01.11/01 .00.01.11/01 .00.01.11/01 2037 130* .00.01.11/01 .00.01.11/01 .00.01.11/01 2037 130* .00.01.11/01 .00.01.11/01 .00.01.10 2037 130* .00.01.11/01 .00.01.11/01 .00.01.11/01	0350	128*	62	UO 63 L3=5,7	C00360		
UB35 130* 61 CONINUE DOU375 UB31 114 64 CONINUE 000375 UB31 113* C CENTINE 000375 UB31 113* C CENTINE 000375 UB31 113* C CENTINE 000375 UB35 135* C ** CONDUCT OF NODEL* 000375 UB36 135 OD *QO *71.14* UD00000000 000375 UB36 130* 000 *QO *71.14* UD00000000 CONDUCT OF NODEL* CONDUCT UB37 14* CONDUCT OF NODE* CONDUCT CONDUCT CONDUCT UB37 14* CONDUCT CONDUCT CONDUCT CONDUCT UB37 CONDUCT CONDUCT CONDUCT CONDUCT CONDUC	0353	129*	63	N012111221231=1	000365		
LB35 131* 64 CONTINUE 000375 LB36 133* C 200 FORMATIC FINAL OUTPUT OF NODPT.*1 000375 LB36 133* C 200 FORMATIC FINAL OUTPUT OF NODPT.*1 000375 LB36 135* C 200 FORMATIC SCHOLLAND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* C 600115.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* V01112.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000375 LB36 135* V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000405 LB36 140 V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000405 LB36 V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000416 000416 LB37 V0111.000 FLA AND SHAREZ LO FORMATE ADDAL PIL DATA 000416 000416	0355	130*	61	CONTINUE	000375		
UBSE 122* 6U CUNINOL 000375 135 C C C CONTROL STADETLAND STARS TO SEAF MODAL PI_ DATA 000375 000375 000375 000375 000375 000375 000375 000375 000375 000375 00003 00351 139* 900 PG PEIN POLICAL FROM NODPI', 00003 00351 139* 900 PG PEIN POLICAL FROM NODPI', 00003 00371 149* 900 PG PEIN POLICAL FROM NODPI', 000010 00071 142* PEINT POLICADING PEINTS, 112:131, KM, 1 000010 00071 142* PEINT POLICADING PEINTS, 113:131, 12:131, KM, 1 000336 00071 142* PEINT POLICADING PEINTS, 1000136 00071 142* PEINT POLICADING PEINTS, 1000136 00071 149* PEINT POLICADING PEINTS, 1000136 00071 140* PEINT POLICADING PEINTS, 1000136 00071 140* PEINTS, 1000136 000356 00071 140* PEINTS, 1000136 000356 000136 00	0357	<u>131</u> #	64				
UB36 134 C200 Fokkiji (10) FUKU UTFUT OF NODOT.*) 000375 UD361 135 C200 CONDINIS NODETIA NO SHARZIO FORM DESAF NODAL PI. DATA 000375 UD361 136 SCIENCE (001)NIS NODETIA NO SHARZIO FORM DESAF NODAL PI. DATA 000375 UD361 136 SCIENCE (001)NIS NODETIA NO SHARZIO FORM NODETIA 0000375 UD361 136 SCIENCE (001)NIS NODETIA NO SHARZIO FORM NODETIA 0000000 UD361 136 SCIENCE (001)NIS NODETIA NO SHARZIO FORM NODETIA 0000000 UD361 SCIENCE (001)NIS NODETIA NO SHARZIO FORM NODETIA 0000000 UD371 139 950 00 %00 KEI (112) %01 111111111111111111111111111111111111	0361	132*	60		000375		
135- 135- 135- 135- 135- 000175 135- 135- 135- 135- 000175 000175 135- 135- 135- 135- 000175 000175 135- 137- 903 F08Hall' COM	<u>0361</u>	1 2/1 #	6200	FAINT 200		···· <u></u> ···	
2035 136 • • • • • • • • • • • • • • • • • • •	0361	135#	C ##	CONTRACT FINAL CONFOL OF NODELL'S	000375		
113* 903 F00Hail COD403 0356 135 950 0.90 F00Hail COD403 0371 139* 950 960 960 971 149* COD403 0371 139* 960 971 149* COD403 COD403 0371 149* 91 F00Hail F00Hail COD403 COD403 0471 149* 91 F00Hail F00Hail F00Hail COD403 0407 142* RETURM COD4045 COD445 COD445 COD445 0407 142* RETURM COD445 COD445 COD445 COD445 0407 142* RETURM COD445 COD445 COD445 COD445 0407 142* RETURM COD445 COD445 <td< td=""><td>U 36 3</td><td>136*</td><td></td><td></td><td><u> </u></td><td></td><td></td></td<>	U 36 3	136*			<u> </u>		
D366 136* 755 D0 9.0 KTL,NUMAP C0003 D371 139* 750 490 KTL,NU,STL,J,JL,TJ,JL,SHAR2(K,IJ,IZL,3J,KN,T 000410 D371 140* 760 FRIMT 901 (NODFI(K,IJ,IZL,7J,(SHAR2(K,IJ,IZL,3J,KN,T 000410 C400 140 9.1 FORAKT (TIS,JZLU,J,IS,FLU,J) 000436 D0007 142* RETURN U00436 U00446 U00446 U00446 U00446 U00446 U00446 U00446 U0046 U0046 U0046 U0046 U0046	Ú 36 5	137#	903	FORMATE COMM NODAL POINT DATA FROM NODPT"	000403		
00371 139* 950 WRITE (12:0_011000PT1(K.11.151.71.(51AR2(K.11.151.33).KK.1 000410 00371 149* (9.0 PRINT 901,(NODPT1(K.11,151.71.(51AR2(K.11.151.33).KK.1 000430 00005 141* 9,1 FORMAT (715.3F10.31,15AR2(K.11.151.33).KK.T 000435 00007 142* RETURN 0000435 00007 142* RETURN 0000435 00007 142* RETURN 0000435 00007 142* RETURN 0000435 00007 142* RETURN 0000435 000047 142* 0000435 000047 142* 0000435 000047 142* 0000435 000047 142* 0000435 0000040000000000	0366	138*	959	D0 960 K=1,NUMNP	C00403		
20371 140* C950 PRINT 901, (NÖOPTIKK, 1), [=1,7], (SHAR21K, 1), [=1,3], KN, T 000435 0406 140 9,1 FORMAT (15, SF0.3, 15, F10.3, 15, F10.3, 1) 0400 142* RETURN 000435 0400 36 0400 142* EBU 000435 0004 000435 0004 000435 0004 000435 0004 000435 0004	0371	139*	960	WRITE (12.901)(NODPT1(K.I).I=1.7).(SHAR2(K.I).I=1.3).KN.T	<u> </u>		
20406 1410 9,1 FORMAT (715,3F10,3,15,F10,3) 000435 10407 1420 RETURN 000435 10417 1420 RETURN 000435 104 FOR NU FOR NU FOR NU DER	0371	143*	6960	PRINT 901,(NÖDPT1(K,I),I=1,7),(SHAR2(K,I),I=1,3),KN,T	000410		
UD 40 7 142* RETURN UD 43 6 UD 43 0 UD	0400	141*	9.11	FORMAT (715, 3F10, 3, 15, F10, 3)	000436		···-
Add Max Add Max <t< td=""><td>0407</td><td>142*</td><td></td><td>RETURN</td><td>000436</td><td></td><td></td></t<>	0407	142*		RETURN	000436		
		-143*		LNU	<u> </u>		
	HDG - P	UDDE	P				
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DATE 073080 PAGE 1

OFUR, S URDER, ORDER

HSA E3 -07/30/80-09:45:50 (29,)

SUBROUTINE ORDER ENTRY POINT DOG552

STORAGE USED: CODE(1) DOD561; DATA(0) DOD570; BLANK COHMON(2) DODDDD

COMMON BLOCKS:

·	UÜ J 3	васн	00044		 	
	<u>5004</u>	HUZART	000334	 		
	UUU 5	HANDEL	GCU174			

EXTERNAL REFERENCES (BLOCK, NAME)

	UDU6	Vic
	6007	COUNT
	0110	SIGNA
	u U11	10
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4	u021	N1015
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STORAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME)

ມີ ປິ ຟ 1	000002 1176	6001	CJ0062 1506	6001 000679	5 1576 0001	L COO141 2046	0001 0C0177 222G
UU	040235 240G	0001	060270 2566	0or.1000327	7 2746	000336 3016	0nn1000350_310G
	3004 <u>00</u> 3276	6661	000417 3406	UD01 00044r	3476 0001	000460 3576	0001 000476 3716
նմնն	060500 400F	0000	060501 402F	6060 00050	3 405F GOUI	nunna2 5L	0001 060042 501L
ü0u1	0J0115 502L	ÚD01	060111 503L	0001 000162	2 507L 0001	000262 550L	0001 000314 552L
<u>uDu1</u>	0.nc17 6L	0000	000517 604F	0001 000525	5.655L UDD1	000514 657L	0000 0nn523 658F
սննե	060505 749F	Upan	000515 750F	0000 R 00000	A Conc	R DUDU24 B	0000 R 000046 DUM
	DODU72 GRUMAX	<u> 6000 I</u>	000464 I	UNUD I 600455	5 101	I 000456 ID2	000555 INJP\$
5000 I	JUD475 J	1000 I	000453 K	6000 I 000476	S KHOAD UOGO) I DU0477 KM	0000 I 000472 KOUNT
<u>uuu5_1</u>	JUDUOU KVCMID	LOU5 I	JLOUZA KVCPID	UCUD I 000470) L0000	I 666473_LL	0000 I 000474 LLL
uUu4 I	000000 MAT11	6064 R	JUDU24 MAT12	UD65 I 000170	MAXMID DOOS	I COO171 MAXPID	0000 I 000466 MID
UUUU	JUD462 NEND	<u>. 0000 I</u>	000467 NEND17	<u>_000000465</u>	5 NPCARDOOOC	I CUD457 NREC	0000 T 000461 NRECH1
6003 I	GUDU22 NSTART	6033 1	DUDLOU NUM	UCUS I 000172	NUMMID 0000	I DUD454 NUMNP	0005 I 000173 NUMPID
600 <u>0</u>	100463 NUMRE	<u> </u>	DUD460 NUMREC		L <u>NUM18 0000</u>	<u>1 000426 PID</u>	6000 I nnn427_XMAT11
LUDU R	JUUII6 XMATI2						

0101	1.4	SUBRUITINE ORDER	u00002	
00103	2*	COMMON/BACH/NUH(18), NSTART(18)/MOZART/HAT11(20), MAT12(20,10)/HANDE	600002	
60103	3*	1L/KVCHID(2c), KVCPID(100), MAXHID, MAXPID, NUMMID, NUMPID	600002	· · · · · · · · · · · · · · · · · · ·

L0104 L0105 L0115 L0121 L0124 L0125 L0127 L0132 L0135	4* 5* 6* 7* 8* 9* 10* 11* 12* 13* 14* 15* 16* 17* 18* 20*	DIMENSION A(20).B(18).DUM(20).GRDMAX(20) DATA NUM/18*U/B/*GRID*,*OMIT*,*FORC*,*SPC1*,*CROD*,*CBAR*,*CQDM*, 1*CSHE.,*CQUA*,*CIRI*,*CONM*,*PROD*,*PBAR*,*PUDM*,*PSHF*,*PQUA*, 2*PTRI*,*HAT1*/KVCMID/20*C/KVCPID/100*U/MAXHID,MAXPID/20,100/ REAL MAT12.XMAT12(20,10) INTEGER PID,XMAT11(2U) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OMIT.FORCMAT1 C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** C ** C ** C ** C ** C ** C ** C ** MAXMID(MAXPID) IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KYCHID(KYCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A IS INCREASE DIMENSIONS OF 10 6	U01002 U00002	
L0105 L0105 L0105 L0105 G0114 C0115 L0115 L0115 G0115 G0121 C0124 G0126 G0127 G0132 G0135	5* 6* 7* 8* 9* 1J* 12* 13* 12* 13* 15* 15* 15* 15* 19* 20*	UATA NUM/18*U/A'GRID', 'OHIT', 'FORC', 'SPC1', 'CROD', 'CBAR', 'CQDM', 1'CSHE, 'CQUA', 'CTRI', 'CONM', 'PROD', 'PBAR', 'PQDM', 'PSHE', 'PQUA', 2'PTRI', 'HAT1'/KVCHID/20*C/KVCPID/100*U/MAXHID,MAXPID/20,100/ REAL MAT12,XMAT12(20,10) INTEGER PID,XMAT11(20) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OHII.FORCMAT1 C ** CALCULATE NO. OF EACH TYPE.E.GG,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** MAT1 CARDS C ** MAT1 CARDS C ** MAXMIDIMAXPIDI IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KYCHID(KYCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A IS INCREASE DIMENSIONS OF 10 6	L000002 L000002 L00002 L00002 L00002 U00002 U00002 L0002 L00002 L00002 L00002 L00002 L00002 L00002 L00002 L0002	
<u> [n105</u> [0105 [0114 [0115 [0115 [0115 [0115 [0115 [0115 [0115 [0115 [0115 [0116 [0121 [0124 [0126 [0127 [0132 [0135 [013 [013 [013 [013 [013 [013 [013 [01	6* 7* 8* 9* 10* 12* 13* 12* 13* 15* 15* 15* 16* 17* 18* 19* 20*	1°CSHE, «CQUA", «CTRI", «CONM", «PROD", «PBAR", «PQUH", «PSHE", «PQUA", 2°PTRI", «HAT1*/KVCHID/20*C/KVCPID/100*U/MAXHID, MAXPID/20,100/ REAL MAT12, XMAT12(20,10) INTEGER PID, XMAT11(20) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OHIT.FORCMAT1 C ** CALCULATE NO. OF EACH TYPE.E.GG., NUM(1)=NO. OF GRID CARDS, NUM(18)=NO. OF C ** MAT1 CARDS C ** MAT1 CARDS C ** MAXMID(MAXPID) IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED, ALSO C ** INCREASE DIMENSIONS OF KVCHTD(KVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400, END=501) A TE (4411 GO PIEND) GO TO 6	600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002 600002	
C0105 G0114 C0115 G0115 G0124 G0124 G0126 G0127 G0132 G0135	7* 8* 9* 10* 11* 12* 13* 14* 15* 15* 16* 17* 18* 19* 20*	2*PTRI*,*HAT1*/KVCHID/20*C/KVCPID/100*U/HAXHID,HAXPID/20,100/ REAL MAT12.XMAT12(20,10) INTEGER PID,XMAT11(20) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OMIT.FORCMAT1 C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** MAT1 CARDS C ** C ** MAXMID(MAXPID) IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCMID(KVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A	000002 L04002 006002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002	
GO114 CU115 GD115 GD121 GD124 GD126 GD127 GD132 GG135	8* 9* 10* 11* 12* 13* 14* 15* 15* 15* 16* 17* 18* 19* 20*	REAL MAT12:XMAT12(20:10) INTEGER PID,XMAT11(20) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OMIT.FORCMAT1 C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** MAXMID!MAXPID! IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** C ** MAXMID!MAXPID! IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCMID(KVCPID) ACCORDINGLY. DO 5GO K=1,18 S READ (9.400,END=501) A TE (AALL EO BUHN) GO TO 6	L00002 000002 000002 00002 00002 00002 C00002 000002 000002 000002 000002 000002	
CU115 GD115 GD115 GD115 GD115 GD115 GD115 GD115 GD115 GD115 GD115 GD115 GD124 GD124 GD124 GD124 GD124 GD127 GD132 GD135	9* 10* 11* 12* 13* 14* 15* 15* 16* 17* 18* 19* 20*	INTEGER PID, XHATII(2U) C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OHII.FORCHATA C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** MATI CARDS C ** C ** MAXMIDIMAXPIDI IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCHTDIKVCPIDI ACCORDINGLY. DO 5GO K=1,18 5 READ (9.400,END=501) A IE (441) EO RUELSO (4	000002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002 000002	
L0115 L0115 L0115 L0115 L0115 L0115 L0115 L0115 L0115 L0115 L0115 L0116 L0121 L0124 L0126 L0127 L0132 L0135	10* 11* 12* 13* 14* 15* 15* 16* 17* 18* 19* 20*	C ** WRITE ON FILE 10 IN THIS ORDER: GRID.OMIT.FORCMATL C ** CALCULATE NO. OF EACH TYPE.E.G.,NUM(1)=NO. OF GRID CARDS,NUM(18)=NO. OF C ** MATI CARDS C ** C ** MAXMIDIMAXPIDI IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCHTD(KVCPID) ACCORDINGLY. DO 5GO K=1,18 5 READ (9.400,END=501) A TE (4411) EO B(K)) GO TO 6	600002 600002 600002 600002 600002 600002 600002 600002 600002 600002	
C0115 in115 C0115 C0115 C0115 C0115 C0115 C0116 C0124 C0124 C0124 C0124 C0127 in132 C0135	11* 12* 13* 14* 15* 15* 16* 17* 18* 19*	C ** CALCULATE NO. OF EACH TYPE.E.G.,NUH(1)=NO. OF GRID CARDS,NUH(18)=NO. OF C ** MAT1 CARDS C ** C ** MAXMIDIMAXPIDI IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KYCHID(KYCPID) ACCORDINGLY. DO 5GO K=1,18 5 READ (9.400,END=501) A TE (4411) EO RUNN GO TO 6	U00002 U00002 U00002 C00002 U00002 U00002 C00002 C00002 U00002 U00002	
60115 60115 60115 60115 60115 60115 60115 60116 60121 60124 60126 60127 60132 60135	12* 13* 14* 15* 15* 15* 15* 15* 19* 20*	C ** MATI CARDS C ** C ** C ** MAXMID(MAXPID) IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCHID(KVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A TE (A(1) EO P(K)) GO TO 6	606002 600002 600002 600002 600002 600002 600002 600002	
00115 00115 00115 00115 00116 00121 00124 00126 00127 00132 00135	13* 14* 15* 15* 15* 17* 18* 19* 20*	C ** C ** MAXMID(MAXPID) IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PRUGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCMTD(KVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A 15 (4411) 50 R(K1) 60 TO 6	600002 600002 600002 600002 600002 600002 600002	
<u>60115</u> <u>60115</u> <u>60115</u> <u>60121</u> <u>60124</u> <u>60124</u> <u>60126</u> <u>60127</u> <u>60132</u> <u>60135</u>	<u>14</u> * 15* <u>15</u> * <u>17</u> * <u>18</u> * 19* 20*	C ** MAXMIDIMAXPIDI IS THE MAX NO. OF DIFFERENT MID(PID)NOS. C ** THE PROGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCMTD(KVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A 15 (441) 50 R(K)) 60 TO 6	C00002 C00002 U00002 C00002 C00002	
60115 60115 00116 60121 60124 00126 00127 00132 00135	15* 16* 17* 18* 19* 20*	C ** THE PRUGRAM CAN HANDLE. IF IT IS INCREASED,ALSO C ** INCREASE DIMENSIONS OF KVCHTBIKVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A 15 (441) 50 R(K)) 60 TO 6	000002 000002 000002 000002	
<u>UG115</u> U0116 <u>U0121</u> C0124 <u>U0126</u> U0127 <u>Ú0132</u> UG135	<u>16</u> # 17# <u>18</u> # 19# 20#	C ** INCREASE DIMENSIONS OF KVCHTDIKVCPID) ACCORDINGLY. DO 560 K=1,18 5 READ (9.400,END=501) A	<u>600002</u> 600002 <u>600002</u>	<u> </u>
00116 00121 00124 00126 00127 00127 00132	17* 18* 19* 20*	DO 560 K=1,18 5 READ (9,400,END=501) A 15 READ (9,400,END=501) A	600002 600002	
<u> C0121</u> C0124 <u> U0126</u> U0127 <u> 00132</u> U0135	<u>18*</u> 19* 20*	5 READ (9,400,END=501) A		
60124 <u>00126</u> 00127 <u>00132</u> 00135	19# 20#		000012	
<u> </u>	20*			
00127 00132 00135	2 L T T		660015	
00132 00135	 >1±		000017	
UG135	22*		000011	
	23+		600035	
10136	24-		000033	
			000042	
00137	20+	SON CONTANT	000042	
<u></u>	27*			
60140 60140	21+	C PRINT OUL	000046	
00140	<u> </u>		000046	
60140	29#	C = FRIN(22) (N)H(R) (R-1) (0)	008046	
<u> </u>	<u>30</u> #			
LU142	31*	4 GU FORMAT (ZUA4)	000046	
<u></u>		4U2 FORMAI(1X,1944)		
60144	337		600046	
LU145	35#	NUMNPENUMITI	000051	
<u> </u>	<u></u>	C ** CALCULATE STARTING RELORD NUMBERS IN FILE AU		
LU146	3/*		000053	
00147		D0 2c R=2.18		
60152	294	20 NSTART(R)=NSTART(R_1)+NUM(R-1)	000062	
	<u>40</u> ¥	RESIND II		
00154	41*	C ** CALCULATE LARGEST NODAL POINT NUMBER AND CARD ON WHICH IT OCCURS NREC **	000065	
00155	427		000070	
00156	43*		000075	
	44#	<u>ktau 110:4651102</u>		
60164	45*	405 FURMAT (82,16) Te 105 CT 1011 (0 TO 507	000103	
<u> </u>	<u> </u>			
60167	4/#		010107	
<u>U/U</u> _	40#			
00173	474	NHEL-N EDD C-WITAUF	090112	
00174	547	NUTREC-NOIARIIIDITNUHIIDIT	000116	
<u> </u>	<u> </u>	C DOINT 37 NUMBER C		
00174))¥ 54 ±	C PRINT 239 NUMBEC - 1 TAN	000116	
<u></u>	55+	TELOBOR CONTRACT 1147		
00175		TEINKE (CONTRACTOR DU TO DOULA NOTAT NUMBER LAST AN ENERT	000122	
<u> </u>	<u> </u>	C ** PLACE RECORD WITH LARGEST NUDAL PUINT NUMBER LAST ON FILE II	000125	
00177	5/*	REWIND AU	000125	
<u></u>	<u></u>	AFTINKELETCHT, BO TO 501		······································
63200	577 40-	C *** READ FROM IN ALL MECONDS BEFORE THE ONE WITH LARGEST NUDAL PT. NO. AND	000130	

HUDU ALV HPECT12HBEC+1 DODIS UC300 6.34 UD SUS ALL NATCHA UDAIL UC311 6.44 UDAIL UDAIL UC311 6.44 5.35 PARTE (11) + SOTUPM UDAIL UC311 6.44 5.35 PARTE (11) + SOTUPM UDAIL UC311 6.44 5.35 PARTE (11) + SOTUPM UDAIL UC311 6.44 5.45 SOTA (10) + SOTUPM UDAIL UC312 6.4 C.44 C.44 C.44 C.44 UC312 6.4 C.44 C.44 C.44 C.44 UC311 0.55 STALE (11) + SOTUPM UDAIL C.44 C.44 UC321 7.4 C.44 C.44 C.44 C.44 UC323		0.6	DLR			DATE U7308n	PAGE	3	
UC:03 0:0 0:0 0:0 0:0 0:0 UC:03 0:3 0:0 0:0 0:0 0:0 UC:03 0:3 0:0 0:0 0:0 0:0 UC:03 0:3 0:0 0:0 0:0 0:0 0:0 UC:03 0:3 0:0 0:0 0:0 0:0 0:0 UC:03 0:4 0:5 0:0 0:0 0:0 0:0 UC:03 0:4 0:5 0:0 0:0 0:0 0:0 UC:03 0:5 0:5 0:5 0:0 0:5 0:0 </th <th></th> <th>60202</th> <th>61*</th> <th></th> <th>NRECH1=NREC-1</th> <th>000133</th> <th></th> <th></th> <th></th>		60202	61*		NRECH1=NREC-1	000133			
G200. 0.23 READ 10.400 DUM 000141 C00111 0.000150 000150 C00111 0.000114 000114 C00117 0.000114 0.000114 C00118 0.000114 0.000114 </td <td></td> <td>LC203</td> <td>62*</td> <td></td> <td>DO 505 K=1,NRECH1</td> <td>000136</td> <td></td> <td></td> <td></td>		LC203	62*		DO 505 K=1,NRECH1	000136			
UD111 044 505 PATT C11.NGDTUDH 000150 UD11 055 C50 PATT C11.NGDTUDH 000150 UD11 056 C50 PATT C11.NGDTUDH 000150 UD115 057 SED0 Linter Difference 000150 UD115 057 SED0 Linter Difference 000162 UD115 057 SED0 Linter Difference 00017 UD127 114 000017 00017 00017 UD27 124 546 SED1111.4C0160 VITH LARGEST MODAL PT. NO. 000206 UD27 124 546 SED111.4C0160 VITH LARGEST MODAL PT. NO. 000206 UD271 124 546 SED111.4C0160 VITH LARGEST MODAL PT. NO. 000206 UD271 124 124 C00017 C00217 UD216 124 C194 FTELLIN.4C0160 VITH LARGEST MODAL PT. NO. 000217 UD217 124 124 C194 C194 C194 UD217 C000217 C00217 C00217		60206	63#		READ (10,400)DUM	000141			
10211 c55 C505 PRINT 4021 DODLAPT. NO.1 DODLSD 10315 c66 C M READ RECODE LITH LARGEST NODAL PT. NO.1 (GRID PT. NO.1) DODLSD 10315 c66 FUD. READ LINANDISDAL DODLSD DODLSD 10321 c66 FUD. READ LINANDISDAL DODLSD DODLSD 10321 c66 FUD. READ LINANDISDAL DODLSD DODLSD 10321 ref WEAD COMMARTANESC DODLSD DODLSD 10321 ref WEAD COMMARTANESC DODLSD DODLSD 103221 ref WEAD COMMARTANESC DODLSD DODLSD 10323 ref WEAD COMMARTANESC DODLSD DODLSD 10333 ref VEAD COMMARTANESC DODLSD DODLSD 10333 ref VEAD COMMARTANESC DODLSD DODLSD 10333 ref VEAD COMMARTANESC DODLSD DODLSD 10334 ref SPRESCOMMARTANESC DODLSD DODLSD 10335 ref SPRESCOMMARTANESC		CO211	64*	505	WRITE (11.400)00M	000150			
10.11 06.1 06.11 06.150 10.215 07.4 30.162 06.162 10.215 0.6 C.* HEAD INFARINGE OF GRID CAPDS AND UPITE ON 11 06.162 10.215 0.6 C.* HEAD INFARINGE OF GRID CAPDS AND UPITE ON 11 06.117 10.021 0.7 0.6 0.6 1.4 06.017 10.022 7.8 5.10 0.811.1 0.0017 00.0206 10.021 7.8 5.10 0.811.1 0.0017 0.00276 10.021 7.8 5.10 1.41.00100M 0.00276 0.0017 10.021 7.8 5.11 1.40.0100 MAR 0.00271 0.0027 10.021 7.8 C.97.078.11.8.7 1.41.00100MAR 0.0027 0.0027 10.021 7.8 C.97.078.11.8.7 1.41.0010MAR 0.0027 0.0027 10.021 7.8 C.97.078.11.8.7 1.41.0010MAR 0.0027 0.0027 10.021 7.8 C.97.078.1.1.0.000 0.0027 0.0027 0		6.0211	65 *	6505	PRINT 402, DUH	000150			
LULIS 5.07 EGD (LACE) (EGD FAIL VALUE CALL CALL <thcal< th=""> CALL CALL <thc< td=""><td></td><td>60211</td><td>66*</td><td>C **</td><td>READ RECORD WITH LARGEST NODAL PT. NO. (GDID PT. NO.)</td><td>000150</td><td></td><td></td><td></td></thc<></thcal<>		60211	66*	C **	READ RECORD WITH LARGEST NODAL PT. NO. (GDID PT. NO.)	000150			
D215 0.8* C =* FEED FLAND PARTEC DEED LARDS AND VRITE ON 11 DD0162 U0221 TU* U0 506 K21 AR NO U00114 U00174 U0221 TU* U0 506 K21 AR NO U00174 U00174 U0221 TV* U0 S10 K21 AR NO U00174 U00174 U0227 TV* C =* FS11 K11 AR UNDON U00206 U00206 U2231 TV* C =* FS11 K N1 AR UNDON U00206 U00207 U0233 TV* C =* FS11 K N1 AR UNDON U00207 U00217 U0233 TV* C =* FS11 K N1 AR UNDE U00227 U00217 U0233 TV* C =* FS11 K N1 AR UNDE U00227 U00227 U0234 TV* NUMELAUMAP U00227 U00227 U00227 U0235 TV* NUMELAUMAP U00227 U00227 U0235 TV* NUMELAUMAP U00227 U00227 U0236 TV* NUMELAUMAP		L0215	67*	507	READ (10.4CD)GRDMAX	000162			
CD222 6** KUDENDMAP-MEC CD0111 00221 10* D0 5 (6 + 1) NEND CD0117 00224 11* D0 5 (6 + 1) NEND CD0117 00227 72* 506 611 (1) NO 1000 CD0206 00227 7** C ** F01 (1) NO 1000 CD0206 00237 7** C ** F01 (1) NO 1000 CD0206 00237 7** C ** F01 (1) NO 1000 CD0206 00237 7** C ** F01 (1) NO 1000 CD0206 00237 7** C ** F01 (1) NO 2000 CD0221 00337 7** C * F01 (1) NO 2000 CD0221 00338 - C * F01 (1) NO 2000 CD0221 00339 - C * F01 (1) NO 2000 CD0221 00339 - C * F01 (1) NO 2000 CD0221 00339 - C * F01 (1) NO 2000 CD0221 00340 - CD0 S (2) NO 10 CD0221		. n215	68+	C ++	READ REMAINDER OF GRID CARDS AND WRITE ON 11	000162			
00221 70* 00 5 6 4 4.1 kiu 0001 4 00224 71* RAD 16 0.4 Anjiujuh 0001 7 00231 72* 506 411 (11,400 100 m 000206 00231 73* C 50 F2411 Adv. D01 m 000206 00231 73* C 50 F2411 Adv. D01 m 000206 00231 73* C 50 F2411 Adv. D01 m 000207 00231 74* C P4111 Adv. P017 MAX 000217 00231 74* C P4111 Adv. P3* fax 000217 00233 74* C P4111 Adv. P3* fax 000217 00235 74* C P4111 Adv. P3* fax 000217 00235 74* C P4111 Adv. P3* fax 000221 00235 74* P3* fax Number 2* site 000232 00235 84* C D1 P310 MUMP 2* site 000232 00235 84* C C P4 P311 MUMP Control P3* 000232 00236 84* C C P1 P3* 000242 00237 84* C C P1 P3* 000244 00234		00220	69#	- • -		600171			
03224 11 REACTOR NUMBER 00017 00227 72* 500 FRINT 10, NOTOUR 000206 02227 73* 500 FRINT 10, NOTOUR 000206 02227 73* 500 FRINT 10, NOTOUR 000206 02233 73* C FRINT 10, NOTOUR 000206 02233 73* C FRINT 11, NOTOUR 000210 02233 73* C FRINT 10, NOTOUR 000211 02233 73* C FRINT 10, NOTOUR 000212 02233 73* C FRINT 10, NOTOUR 000217 02335 73* C FRINT 12*, NUMER ANDRO 000221 02335 73* C FRINT 42*, NUMER ANDRO 000221 02335 63* C 24 FRINT 42*, NUMER ANDRO 000221 02335 63* C 24 FRINT 42*, NUMER ANDRO 000221 02335 64* 100 500 00024 02335 64* 100 <		00221	7()*		10 5/6 KII.NEN()	600174			
U.3.7 7.8 5.00 PRIT (11) + 40 (00) D00206 U.3.7 73* C 50* PRIT (0%) LARGEST NODAL PT. NO. U00206 U.3.7 73* C ** PRIT (0%) LARGEST NODAL PT. NO. U00206 U.3.7 74* C ** PRIT (11) + 500 (000 AT U00217 U.3.3 76* C ** PRIT (11) + 500 (000 AT U00217 U.3.3 76* C ** PRIT (12) + 500 (000 AT U00227 U.3.3 76* C ** PRIT (12) + 500 (000 AT U00227 U.3.3 80* C ** PRIT (12) + 500 (000 AT U00227 U.3.3 80* C ** PRIT (12) + 500 (000 AT G00232 U.3.3 80* C ** PRIT (12) + 500 (000 AT G00232 U.3.4 PRIT (12) + 500 (000 AT G00232 G00244 U.2.3 80* S S + 14, NUME G00244 G00244 U.2.4 80* S S + 14, NUME G00245 G00246 U.2.5.1 80* S S + 1611 NU		68224	71 #			600177			
U0227 73* CSUB PERK1*165.00M* C00206 U0227 74* CSUB CO0206 C0223 U0227 74* C PERK1*11*COUSH0MAX C00206 U0223 75* FEITE (11*COUSH0MAX C00217 U0233 76* C PERK1*192 C00217 U0233 77* C PERK1*192 C00221 U0233 77* C PERK1*192 C00221 U0235 77* C PERK1*192 C00221 U0237 C2* DEFK1*1*40000 C00221 C00222 U0237 C2* DEFK1*1*40000 C00223 C00225 U0237 C2* DEFK1*1*40000 C00223 C00225 U0237 C4* U05*0000 C00235 C00235 U0237 C4* E DO10000 C002235 U0238 S* C400 PERK1*10000 C00226 U0237 C4* E DO10*1000 C00226		00.27	72 #	506		000214	· · · · · · · · · · · · · · · · · · ·		
UC221 P#* C** PETE UM 1; ECORD WITH LARGEST NODAL PT. NO. UD0205 UC223 P#* C** PETE ILA SOULMEPPAX UD0217 UC223 P** C PRINT 405;600MAX UD0221 UC224 P** D NUMERCHANDAR UD0221 UC225 P** C PRINT 407;000M UD0222 UC224 P** D** PRAD UNMERCHANDAR UC224 PRAD UNMERCHANDAR UD0224 UC224 PRAD UD41511 UD4250 UD4251 UC224 PRAD UD424 UD424 UD424 UC224 PRAD UD424 UD424 UD424 UC225 PRAD UD424 UD424		00227	73	C546		600208			
C2233 Fill (1) Line Control (1) (1) (1) (1) (1) (1) (1) (1) (1) (1)		1.0227	74+	<u> </u>	JULT (N., DECODD VITH LARGEST NODAL DT NO	000208			
0.011 10* 0.011 100.017 0.0231 71* C Pillin 1.09 0.00217 0.0232 71* C.99 FORMATCS,**INAL WEITE ON 11*1 0.00227 0.0233 71* C.99 FORMATCS,**INAL WEITE ON 11*1 0.00227 0.0235 83* C PPINT 2*, NUMPE,NUMPP -**21*2 0.00227 0.0235 83* C PPINT 2*, NUMPE,NUMPP -**21*2 0.00227 0.0235 83* C PPINT 2*, NUMPE,NUMPP -**21*2 0.00227 0.0235 84* C.44 ODD.0000 0.00227 0.0235 85* C.000 C.00000 0.00225 0.0235 85* C.000 C.00000 0.00225 0.0235 85* C.000 C.00000 0.00225 0.0235 85* C.000 C.000000 0.00220 0.0235 85* C.000000 0.00220 0.000000 0.0223 85* C.0000000 0.000270 0.0240 90* C.0000000 0.000270 0.0251 91* C.0000000000		00227	75+	C ++	WRITE ON 11 RECORD WITH LARGEST NUDAL PIO NUO	000206			
U0031 19% C PERINT DOS TORMAN U0031 U0033 19% C PERINT DOS TORMAN U0031 U0033 19% C PERINT DOS TORMAN U00327 U0235 19% NUMBELENUMBEC-NUMPP C00227 U0237 22 00 50 K-31, NUMBE C00227 U0237 22 00 50 K-31, NUMBE C00227 U0237 22 00 50 K-31, NUMBE C00227 U0234 24 FORMATE AND NUMPE C00227 U0242 81* C24 FORMATE AND NUMPE C00225 U0242 61* C54 K-11K-11K-11K-11K-11K-11K-11K-11K-11K-1			76 *						
Ld23 f/2 L C PEAL 732 FEAL VALUE DEEL VALUE<		00233	704	L A	PRINI 402,6KUMAX	000217			
U233 78 COV FURATISAT, TARL WATE UN TEUN U213 U213 10021 U235 78 NUMEEDURACCONDEND U213 U213 U213 U235 0 C C U213 U213 U213 U235 0 C C U213 U213 U213 U213 U2242 SI READ_UARSODUM U2024 U2244 U2244 U2244 U2243 SI READ_UARSODUM U20244 U20244 U20244 U2243 SI C SI U2111 U20244 U20244 U2243 SI C SI U2111 U20244 U20255 U2233 SI SI U2111 U20244 U20255 U2233 SI SI SI U20244 U20257 U2233 SI SI U21111 U20244 U20257 U223 SI SI SI U21111 U2027 U223 SI		<u> </u>	((*	<u> </u>	PRINI 399	000217			
		60233	78#	63333	FORMAT(SX, FINAL WRITE ON 11.")	680217			
L0235 B38 C PPINT 24, NUMRE, AUR NUMPE ***214) DD0227 U0237 62* C24		<u> </u>				600227			
0.0235 614 C24 FORMATI-NUMRE_AND NUMME =:,,1a) 0.00227 0.0235 624 0.050 K-11,NUMRE_AND NUMME 0.00232 0.0244 0.0235 600232 0.0245 65* C_000 Print A02,00M 0.00244 0.0255 65* C_000 Print A02,00M 0.00244 0.0255 65* 600 10.552 0.00244 0.0255 65* 600 10.552 0.00244 0.0255 65* 600 10.552 0.00244 0.0255 65* 600 10.552 0.00244 0.0255 600 10.552 0.00244 0.00242 0.0255 1.00552 8.9* C.002462 0.0255 1.00552 0.00244 0.00242 0.0255 1.00552 0.00110 0.00242 0.0255 1.00552 0.00110 0.00242 0.0255 1.00551 0.001 0.00244 0.0267 9.4* 0.00110 0.00244 0.0267 9.4* 0.00114 0.00277 0.0267 9.4* 0.00114 0.00114 0.02		L0230	80*	С	PRINT 24, NUMRE, NUMNP	600227			
L0237 b2* D0 528 K:1,NUMRE 000232 L0245 b3* BEAD L04.06.00.0000 C00244 L0245 b3* Stab L11.14.00.000 C00244 L0245 b3* Cub Stab L11.14.00.000 C00244 L0255 b3* EMOFILE 11 C00255 L0253 b3* EMOFILE 11 C00256 L0253 b3* C00256 C00262 L0253 b3* C00256 C00262 L0254 VV READ VIL C00262 L0255 VI NINCE FILE 1 NUMBEL C00262 L0255 VI NINCE FILE 1 NUMBEL C00262 L0255 VI NINE FILE 1 NUMBEL C00262 L0263 93* S51 VRITE 1 NUMBEL C00277 L0263 93* S51 VRITE 1 NUMBEL C00277 L0267 95* ENDFILE 1 NUMBEL C00277 L0267 95* ENDFILE 1 NUMBEL C00277 L0267 95* CEAT END		0236	81*	<u>C24</u>	FORMATER NUMRE AND NUMNP = "+214)	000227			
UD2*2 \$1* READ (10,400,10,M GD0235 UD2*4 50* State \$11; (11,400,10,M) CD0244 UD2*1 66* CADPIL DD0244 UD2*1 66* CADPIL DD0244 UD2*1 66* CADPIL DD0244 UD2*1 66* CADPIL DD0245 UD2*1 66* CADPIL DD0244 UD2*1 67* SAT CD0244 UD2*1 68* 550 CADPIL DD0262 CD2*4 9* C* SAT DD0262 CD2*4 9* FEAD TAD DD0270 D00262 CD2*5 9* C* SAT D00270 D00270 CD2*5 9* C* SAT CADPAT D00270 CD2*5 FEAD TAL TAT D00270 D00270 CD2*5 FEAD TAL TAT D00270 D00270 CD2*5 FEAD TAL TAL TAT D00270 CD2*		00237	62*		DO 508 K=1,NUMRE	000232			
LD2% 5% SUB RRIE 111, 4UG1DUM CD0244 LD251 65% CSUB PRINT 402, DUM D00244 LD251 66% ENDFILE 11 U00255 LD253 69% 550 CONTRUE U00244 LD253 69% 550 CONTRUE U002262 C0254 97% C** INCE FILE 12 ALREADY IN CUBRECT ORDER JUST WRITE 10 FILE 11 U00262 C0254 97% REWIND 10 000224 0002262 C0255 91% REWIND 10 0002262 0002262 C0254 92* REACIU,40C1 DUM 000277 000262 C02643 93* CSS1 PRINT 402, DUM 000277 C02643 94* CSS1 PRINT 402, DUM U00277 C02643 94* CSS1 PRINT 402, DUM U00277 C02643 94* CSS1 PRINT 402, DUM U00277 C0267 96* C ** CREATE MATERIAL 10 CHARTAL U00310 U00277 U0270		00242	<u> 83*</u>			600235			
C0225 65* CQUB D00244 C0251 66* ENDFILE 11 000255 C0253 68* 550 Continue 000262 C0254 90* estic file 11 000262 C0255 91* n0.51 rille 11 000270 C0264 92* HEADTIN DUM 000270 C0263 93* 551 wRITE (11+4001 DUM 000277 C0263 93* 551 wRITE 11 U00267 C0267 95* ENDFILE 11 00010 C0267 95* ENDFILE 11 000277 C0267 95* ENDFILE 11 00010 C0267 95* ENDETILE 14 000310 C0267 95* ENDFILE 11 000310 C0271 C0000 000314 000314 C0272 97*<		60245	84*	5u8	WRITE (11,400)DUM	600244			
UB251 66* ENDFILE 11 UD0255 L0253 63* 550 CONTANCE CO0220 L0253 63* 550 CONTANCE CO0220 L0253 63* 550 CONTANCE CO0220 L0254 90* REWIND 1L D00262 C0254 90* REWIND 1L D00262 C0255 11* D00551 TELIANUMERC D00262 C0265 91* D0551 TELIANUMERC D00270 L0265 92* REAUTURYDOT DUM UD0277 D00277 L0263 93* 551 PRINT 402, DUM UD0277 L0264 94* C551 PRINT 402, DUM UD0277 L0267 96* C** CREATE MATERIAL VECTOR MATII (NUMIBIAND MATERIAL UD0310 L0270 95* REWIND 11 CONTAND UD0310 L0270 95* SET UP KYCHU AND THE CUMERT HIL'S AND PID'S SINCE CAUDS UD0314 L0270 1.1 SACCESSARY TO RENUMERT HIL'S AND PID'S SINCE CAUDS		60245	85*	<u>C508</u>	PRINT 4D2+ DUM	000244			
CC222 str GO 10 552 GO0260 C0253 83* C ** SIGE FILE 12 ALREADY IN CORRECT ORDER JUSI WRITE ID FILE 11 U00262 C0253 83* C ** SIGE FILE 12 ALREADY IN CORRECT ORDER JUSI WRITE ID FILE 11 U00262 C0254 93* C ** NCE FILE 12 ALREADY IN CORRECT ORDER JUSI WRITE ID FILE 11 U00262 C0263 93* S51 r51.NURFEC 000270 C0263 93* C51 PRINT 40.01 UMM U00277 C0263 93* C51 PRINT 40.02 UMM U00277 C0264 95* ENDFILE 11 UC0310 U00277 C0267 96* C ** FREXTRATE AL RETAL VECTOR MATIL (NUMERAND MATERIAL UC0310 U0267 97* C ** FREXTRATE AL RETAL VECTOR MATIL (NUMERAND MATERIAL UC0310 U0267 97* C ** FREXTRATE ALS THAT ARE TALL VECTOR MATIL (NUMERAND MATERIAL UC0310 U0271 97* C ** FREXTRATE ALS THAT ARE TALE VECTOR MATIL (NUMERAND MATERIAL UC0314 U0270 1000		66251	66≉		ENDFILE 11	000255			
C U253 e8* 550 CONTINUE LAREADY IN CORRECT ORDER JUST WRITE TO FILE 11 D00262 1 C0254 90* REWIND 1L 00262 00262 1 C0254 90* REWIND 1L 000262 000262 1 C0254 91* REWIND 1L 000262 000270 1 C0260 92* READ(1U,4001) DUM 000271 000271 1 C0261 93* SS1 VRITE 1L IL ALMERE. 0000271 1 C0264 94* CS51 PRIN 402, OUM 000271 1 C0267 96* C ** CREATE HATERIAL VECTOR HATII (NUM18)AND MATERIAL 0000310 1 C0270 90* C ** GREATE NO.10 RAUDID 0000314 1 G0270 90* C ** INTERSARY TO RENUMER HIL'S AND PID'S SINCE CAUDS 000314 1 G0270 1/0* C ** INTERSARY TO RENUMER HIL'S AND PID'S SINCE CAUDS 000314 1 G0270 1/0* C ** SINCE FRATE	X	60252	<u>87≠</u>		60 T0 552	600260			
≤1 50233 67* C ** SINCL FILE LG ALREADY IN CORRECT ORDER JUST WRITE TO FILE 11. D00262 L C025* yu* REWIND TU D00262 L025* yu* n0.551 FELENUMERC D00262 U0260 92* READINFACE D00262 U0263 93* 551 WRITE (11+4001 DUM 000270 U0263 93* 551 WRITE (11+4001 DUM D00217 U0264 94* CS1 PRINT 402, DUM D00217 U0267 95* ENDFILE 11 D0010 D00310 U0267 96* C ** CREATE MATERIAL VECTOR MATII (NUMIS)AND MATERIAL U00310 D00314 U0270 98* S52 REWIND 11 EGUNTENT OF MATII(N.) SINE FLAU U00310 U0270 98* S52 RENNO 11 EGUNTENT OF SINCE CAUDS U00314 U0270 100* C ** MATERANT OF RENUMER MIL'S AND PID'S SINCE CAUDS U00314 EGU314 U0270 100* C ** MATERANT OF RENUMER MIL'S AND PID'S SINCE CAUDS U00314 EGU314 U0270 100* C ** SET UP RYCHU AND AVEPID U00314 EGU314 EGU314	<u>X</u>	LU253	8 8 ≠	550	LONTINUE	600262			
1 CO254 90* REWIND 10 OD0262 6 60255 91* n0551 513LNUREC 000270 00260 92* HEAD(10, 00H 000270 00263 93* 551 PRINT 402, 00H 000270 00267 96* C551 PRINT 402, 00H 000270 00267 96* C** CREATE MATERIAL VECTOR MATLE NUMBER AND MATERIAL 000310 00270 98* 552 REWIND 11 TECTOR MATLE OMATLE OF MATLEN	<u> </u>	60253	89*	C **	SINCE FILE 15 ALREADY IN CORRECT ORDER JUST WRITE TO FILE 11	000262			
CD CD S1 T1 T1 <tht1< th=""> T1 T1 <tht< td=""><td>1</td><td>C0254</td><td>9ŭ*</td><td></td><td>REWIND 16</td><td>000262</td><td></td><td></td><td></td></tht<></tht1<>	1	C0254	9ŭ*		REWIND 16	000262			
UD220 92* READING DUM OD0270 L0220 92* VRIET [11,400,0 DM OD0277 L0267 93* S51 PRINT 402,0 UM OD0277 L0267 95* ENDFILE 11 DD0110 OD010 L0267 95* ENDFILE 11 DD0110 OD010 L0267 95* C ** RAFEL MATERIAL VECTOR MATII (NUMIBJAND MATERIAL U00310 L0267 97* C ** MATERIAL VECTOR MATII (NUMIBJAND MATERIAL U00310 L0267 97* C ** REALTON (NUMIBJAND MATERIAL U00310 L0270 90* 552 REWIND 11 C00314 L0271 104 C ** SET UP KVCHU AND KVCPID U00314 L0270 102* C WCHU AND KVCPID U00314 L0271 102* NENCENSTART(12)=1 000314 L0271 102* VO 1512:17 U00314 L0272 104* NENCENSTART(12)=1 000314 L0271 U04* NENCENSTART(12)=1 U0032	12 -	60255	41		D0 551 T=1+NUMREC	000264			
L0263 93* 551 WRITE (11, 400,) DUM 000277 L0267 95* ENDFILE 11 000310 000310 L0267 95* ENDFILE 11 000310 00310 L0267 95* C ** CREATE MATERIAL VECTOR MATII (NUMIGIAND MATERIAL 000310 00310 L0267 97* C ** CREATE MATERIAL VECTOR MATII (NUMIGIAND MATERIAL 000310 000314 L027U 98* 552 REWIND 11 EUNEMENT OF MATIIKI IS THE HID OF MATIIKI, IS THE HID OF MATIZK, JJ GG0314 L027U 98* C ** IT IS NECESSARY TO RENUMBER HID'S AND PID'S GINCE CAUDS U00314 L027U 1.1* C ** SET UP KVENU AND NVCPID U00314 U00314 L027U 1.1* C ** SET UP KVENU AND NVCPID U00314 U00314 L0271 1.0* NENEINSTATTI12,-1 U00316 U00314 L0271 1.0* NPCANDERO U00316 U00316 L0271 1.0* NPCANDENDCARDENDCARDENUH(1) U00327 U00316 L0271 1.0* NPCANDENDCARDENUH(1) U00327 U00326 L0273 1.0* TSENEND U		L026U	92*		READ(10,400) DUM	000270			
U0263 94* C551 PRINT 402, DUM U00277 U0267 95* ENDFILE 11 000310 000310 U0267 96* C ** CREATE MATERIAL VECTOR MATII (NUMIB)AND MATERIAL 000310 U0267 97* C ** CREATE MATERIAL VECTOR MATII (NUMIB)AND MATERIAL 000310 U0267 97* C ** HATPIX MATIZ (NUMAD, 10) THE CUNTENT OF MATII(K) IS THE HID OF MATIZ(K, J) CG0314 U0271 90* 552 REWINDS THATA RE TOO LARGE. U00314 U0270 1.1* C ** SET UP MYCHID AND MYCPID U00314 U00314 U0271 1.02* C SET UP MYCHID AND MYCPID U00314 U00314 U0271 1.02* SET UP MYCHID AND MYCPID U00314 U00314 U0271 1.03* NENCENSTART(12)-1 000314 U00314 U0271 1.04* NPCANDED U00314 U00314 U0272 1.04* NPCANDEND*/NULL U00321 U032 U0272 1.04* NPCANDEND*/NULL U00327<		60263	93×	551	WRITE (11.400) DUM	006277			
U0267 95* ENDFILE 11 D00310 U0267 96* C ** CREATE MATERIAL VECTOR MATII (NUM18)AND MATERIAL U00310 U027U 97* C ** MATPIX MATERIAL VECTOR MATII (NUM18)AND MATERIAL U00310 U027U 98* 552 REWIND 11 C00314 U00314 U027U 98* 552 REWIND 11 C00314 U00314 U027U 160* C ** HAY GENERATE NOS, THAT ARE TUO LARGE. U00314 U027U 1.1* C ** SEI UP KYCHID AND KYCPID U00314 U0271 1.2* C U00314 U00314 U0271 1.2* C U00314 U00314 U0271 1.2* C U00314 U00314 U0271 1.2* MENCENSTART(12)-1 000314 U00314 U0271 1.2* NELENSTART(12)-1 000314 U003314 U0271 1.0* NECENSTART(12)-1 000314 U00321 U0271 1.0* NECENSTART(12)-1 000321		60263	94#	C551	PRINT 402. DUM	600277			
U0267 96* C ** C ** MATERIAL VECTOR MATII (NUM18)AND MATERIAL U00310 U0267 97* C ** MATERIA MATIZINNIASIDI THE CUNTENT OF MATILIK) IS THE HID OF MATIZIK.JJ CDD310 U0270 98* 552 REN NO 11 000314 000314 U0270 99* C ** IT IS NECESSARY TO RENUMBER MID'S AND PID'S SINCE CAUDS U00314 U0270 100* C ** MAY GENEATE NOS. THAT ARE TOO LARGE. U00314 U0270 102* C U00314 000314 U0271 102* NENCENSTART(12=1 000314 U0271 102* NEACORADON NORARDON U00321 000321 U0272 104* NEACORADON NORARDON U00327 000327 U0301 105* 73 <td< td=""><td></td><td>60267</td><td>95×</td><td></td><td>ENDFILE 11</td><td>000310</td><td></td><td>•</td><td>,</td></td<>		60267	95×		ENDFILE 11	000310		•	,
U0267 97* C ** HATPIX HATI2(NUM18.10) THE CUNTENT OF MAT11(K) IS THE HID OF MAT12(K.J) COUSID U027U 98* 552 RENTAD 11 GO0314 GO0314 U027U 99* C ** HAY GENERATE NOS. THAT ARE TUO LARGE. U00314 U027U 1.0* C ** HAY GENERATE NOS. THAT ARE TUO LARGE. U00314 U027U 1.1* C ** SET UP KYCHID AND KYCPID U00314 U027U 1.0* C ** SET UP KYCHID AND KYCPID U00314 U027U 1.0* C ** SET UP KYCHID AND KYCPID U00314 U027U 1.0* C ** SET UP KYCHID AND KYCPID U00314 U027U 1.0* NENCENSTART(12)=1 000314 U00314 U0271 102* U0 7.0 SET UP KYCHID AND KYCPID U00314 U0271 102* NENCENSTART(12)=1 U00314 U00314 U0271 102* NPCANDENDEANDENDENDENDENDENDENDENDENDENDENDENDENDEN		00267	96*	C **	CREATE MATERIAL VECTOR MATII (NUMIB)AND MATERIAL	000310			
U027U 98* 552 REWIND 11 000314 U027U 99* C ** 11 IS NECESSARY TO RENUMBER HID'S AND PID'S SINCE CAUDS 000314 U027U 1.00* C ** HAY GENERATE NOS. THAT ARE TUO LARGE. 000314 U027U 1.1* C ** SET UP KYCHID AND NYCPID 000314 U027U 1.2* 000314 000314 U027U 1.2* 000316 000316 U0271 1.2* 000316 000321 U0272 1.4* NENEINSTART(12)=1 000321 U0275 1.0* NELENSTART(12)=1 000321 U0276 1.06* 00 1.1* 000321 U0276 1.06* 700 NPCARDENPCARD*NUH11 U0C337 U0303 1.0* 733 REAU(11,400)UM U00336 U0303 1.0* 733 REAU(11,400)UM U00336 U0312 1.0* REAU(11,400)UM U00350 000350 U0312 1.0* REAU(11,400)UM U00350 000350 U0312 1.0* REAU(11,400)UM U00350 <t< td=""><td></td><td>60267</td><td>97*</td><td>C **</td><td>MATRIX MATI2 (NUM18-10) THE CUNTENT OF MATI1(K) IS THE MID OF MAT12(K)</td><td>000310</td><td></td><td></td><td></td></t<>		60267	97*	C **	MATRIX MATI2 (NUM18-10) THE CUNTENT OF MATI1(K) IS THE MID OF MAT12(K)	000310			
U027J 99* C ** II IS NECESSARY TO RENUMBER HID'S AND PID'S SINCE CAUDS U00314 U027U 100* C ** MAY GENERATE NOS. THAT ARE TUO LARGE. U00314 U027U 1.1* C ** SEI UP RYCHID AND RYCPID U00314 U027U 1.1* C ** SEI UP RYCHID AND RYCPID U00314 U027U 1.1* C ** SEI UP RYCHID AND RYCPID U00314 U027U 1.1* C ** SEI UP RYCHID AND RYCPID U00314 U027U 1.1* C ** NENCENSTART(12)-1 000314 U0271 105* NENCENSTART(12)-1 000314 U0271 105* NPCANDEO 000321 U0270 106* 70 NPCANDEO 000321 U0270 107* 70 NPCANDEORO U00322 U0270 107* 733 FENEDANCARD*NUH11 U00336 U0303 10* 733 FENEDANCARD*NUH11 U00336 U0304 U0733 U0733 U0733 U0733		10274	94#	552	RENIND 11	600314			
L027u 160* C ** MAY GENERATE NOS. THAT ARE TUD LARGE. U00314 U027u L1* C ** SET UP KYCHIU AND KYCPID U00314 U027u Lu2* U00314 U00314 U0271 L02* U00314 U00316 U0271 L02* U00316 U00316 U0272 L4* NPCARD=0 U00321 u275 L04* NPCARD=0 U00327 u275 L05* U0 710 1=12+17 CD0327 u275 L05* 700 NPCARD=NUM(1) U00321 u2301 L07* U0 733 1=1, NENU U00322 u0301 L07* U0 733 KEAU(11,400)UM U00320 u0301 L07* U0 710 1=1.NPCARD U00350 u0301 L07* U0 710 1=1.NPCARD U00350 u0301 L07* U0 710 1=1.NPCARD U00350 u0302 L030 L07* U00350 U00350 u0312 L10* REAU(11,750) PID, MID U00350 U00356 u0312 L11* C PRINT 749, PID, MID U00356		L027J	99×	C **	IT IS NECESSARY TO RENUMBER MYDES AND STOPS STARE CAUDS	600314			
U027u 1.1* C ** SET UP KVCHIL AND KVCPID Un0314 U0270 102* C U00314 U00314 U0271 103* NENCENSTART(12)=1 000316 000316 U0272 104* NPCAHD=0 000321 000321 U0276 106* 700 NPCAHD=NPCAHD+NUH(1) 000322 U0276 106* 700 NPCAHD=NPCAHD+NUH(1) U00321 U0276 106* 700 NPCAHD=NUH(1) U00322 U0270 107* U0 733 FEAU(11,400)UM U00322 U0303 108* 733 FEAU(11,400)UM U00336 U00350 U0312 110* REAU(11,750) PID,MID U00350 U00350 U0312 110* REAU(11,750) PID,MID U00350 U00350 U0312 111* C PRINT 749,PID,HID U00356 U00356 U0317 113* 750 FORMAT(* PID ANU MID READ FROM 11 IN ORDER* ,2X, 2163		L027u	160*	C **	MAY GENERATE NOS. THAT ARE TUO LARGE.	(00314			
L027U L024 C U00314 L027U L034 NENENSTART(12)=1 000316 L0272 L04* NECANDEQ 000321 UC73 L04* NPCANDEQ 000321 UC75 L05* U07U L122.17 000327 U076 L06* 700 NPCANDENPCARD*NUM(1) U00327 U0303 L05* 733 REAC(11,400) DUM U00332 U0303 L05* 733 REAC(11,400) DUM U00350 U0312 L10* REAC(11,750) PID,MID U00350 U0312 L10* REAC(11,750) PID,MID U00350 U0312 L14* C PRINT 749,PID,MID U00350 U0317 L13* 750 FORMAT(87,216) U00356 U0317 L14* C PRINT 911 U00356 U0317 L14* C PRINT 911 <td></td> <td>60270</td> <td>1.1*</td> <td>C ##</td> <td>SET DE RUCHTG AND RUCETD</td> <td>000011</td> <td></td> <td></td> <td></td>		60270	1.1*	C ##	SET DE RUCHTG AND RUCETD	000011			
L0271 L03 NENCENSTART(1/2)=1 000314 G02712 1U4* NPCANDED 000314 G0272 1U4* NPCANDED 000321 G273 1U5* 00 7.0 1=12,17 G00327 G0276 1U6* 700 NPCANDENDEARD+NUH(1) G00327 G00327 G030 1G* 00 7.3 1=1,NPCAND G00332 G0303 1G* 7.3 REAU(11,400)DUM G00332 G0307 1U9* 00 7.10 1=1,NPCARD G00350 G0312 110* REAU(11,400)DUM G00350 G00350 G0317	~	L0270	1,12*	<u> </u>	NET NI VIRUAR DUR UTRIAR				
Internation Internation <thinternation< th=""> <thinternation< th=""></thinternation<></thinternation<>		60271	1013	-	NENFINSTART/121	000314			
0.012 1044 NPCANDU 00021 0.273 1054 0 0 122.17 00027 0.0276 1064 700 NPCARD=NPCARD+NUH(1) 000327 0.0300 1074 00733 121.1800 000332 0.0303 1084 733 REAU(11,400)DUM 000350 0.0307 1094 00710 121.1400 000350 0.0312 1104 REAU(11,750) PID,MID 000350 0.0312 1114 C PRINT 749.PID,MID 000350 0.0316 1124 749 FORMAT(* PID AND MID READ FROM 11 IN ORDER* ,2X, 216) 000356 0.0317 1134 750 FORMAT(6X,216) 000356 0.0317 1144 C PRINT 911 C00356 0.0317 1144 C PRINT 911 C00356 0.0317 1144 C PRINT 911 C00356 0.0317 1164 CALL VEC(MID,PID) 000356 0.0320 1164 CALL VEC(MID,PID) 000356 0.0320 1174 C PRINT 912 000356		<u></u>	11.4 #			000321			
U0215 U0327 U0327 U0276 U064 700 NPCARD=NPCARD+NUH(1) U00327 U0301 U074 00733 IE1.NEND U00332 U0303 1054 733 REAU(11,400)DUM U00350 U0307 1094 U0710 IE1.NPCARD U00350 U0312 1104 READ(11,750) PID.MID U00350 U0312 1144 C PRINT 749.PID.MID U00356 U0317 1134 750 FORMAT(* PID ANU MID READ FROM 11 IN ORDER* ,2X, 216) U00356 U0317 1144 C PRINT 749.FID.MID U00356 U0317 1144 C PRINT 911 000356 U0317 1154 C911 FORMAT(* IN ORDER GOING TO VEC*) U00356 U032U 1164 CALL VEC(HID,PID) U00356 U00356 U032U 1174 C PRINT 912 U00356			1044		NFCARD+0	000321			
00210 100* 100 100 100 100 00303 100* 733 HEAU (11,400) UM 100336 00307 109* 00 111 111 00312 110* READ (11,75ŋ) PID, MID 000350 00312 110* READ (11,75ŋ) PID, MID 000350 00312 110* READ (11,75ŋ) PID, MID 000350 00312 112* 749 FORMAT(* FIU ANU MID READ FROM 11 IN ORDER*, 2X, 218) 000356 00317 113* 750 FORMAT(* FIU ANU MID READ FROM 11 IN ORDER*, 2X, 218) 000356 00317 114* C PRINT 911 000356 00317 115* C911 FORMAT(* IN ORDER GOING TO VEC*) 000356 00320 116* CALL VEC(MID, PID) 000356 00320 116* CALL VEC(MID, PID) 000356 00320 117* C PRINT 91. 000356			104+	7.04					
00000 107* 00753 121,400 100352 00303 105* 733 REAU(11,400)DUM 100350 00307 109* 00710 100350 00312 110* READ(11,750) PID,MID 000350 00312 11* C PRINT 749,PID,MID 000350 00317 112* 749 FORMAT(* FID AND MID READ FROM 11 IN ORDER*,2X,216) 000356 00317 113* 750 FORMAT(8,218) 000356 00317 115* C911 FORMAT(* IN ORDER 60ING 10 VEC*) 000356 00320 116* CALL VEC(MID,PID) 000356 000356 00320 116* CALL VEC(MID,PID) 000356 000356 00320 117* C PRINT 912 000356		66300	1004	100					
L0307 108* 733 REAC(11,450,00H 100356 L0307 109* 0010 100350 100350 L0312 110* REAC(11,750,) PID, MID 000350 100350 L0312 111* C PRINT 749, PIU, MID 1000350 L0316 112* 749 FORMAT(* PIU ANU MID READ FROM 11 IN ORDER*, 2X, 216) 000356 L0317 113* 750 FORMAT(8x, 218) 000356 L0317 114* C PRINT 911 000356 L0317 115* C911 FORMAT(* IN URBER GOING TO VEC*) L01356 L032U 116* CALL VEC(MIU, PID) 000356 L032U 117* C PRINT 912 000356		00300	1	777	US / 33 I-1 INCNU		·		
U0307 L09* U0710 1=1:NPLARD U00350 U0312 110* REAC(11,75) PID, MID U00350 U0312 111* C PRINT 749, PID, MID 000350 U0312 111* C PRINT 749, PID, MID 000350 U0316 112* 749 FORMAT(* PID AND MID READ FROM 11 IN ORDER*, 2X, 216) 000356 U0317 113* 750 FORMAT(8X, 216) 000356 U0317 114* C PRINT 911 000356 U0317 115* C911 FORMAT(* IN URBER GOING TO VEC*) L0L356 U032U 116* CALL VEC(MID, PID) U00356 U032U 117* C PRINT 912 000356		60103	1004	(2)		1.00336			
C0312 110* REAUTIT, (5)) PID, MID 000350 L0312 111* C PRINT 749, PID, MID 000350 U0316 112* 749 FORMAT(* PID AND MID READ FROM 11 IN ORDER* ,2X, 218) 000356 L0317 113* 750 FORMAT(8X,218) 000356 L0317 114* C PRINT 911 000356 L0317 115* C911 FORMAT(* IN URBER GOING TO VEC*) 000356 L0320 116* CALL VEC(MID, PID) 000356 L0320 117* C PRINT 912 000356			<u> </u>				<u> </u>		
L0312 111* C PRINT 749,PID,HID C00350 U0316 112* 749 FORMAT(* PID_AND_MID_READ_FROM_11_IN_ORDER*,2X,216) U00356 L0317 113* 750 FORMAT(8X,218) U00356 L0317 114* C PRINT 911 C00356 U0317 115* C911 FORMAT(* IN URBER GOING TO VEC*) C00356 L032U 116* CALL VEC(MID,PID) U00356 L032U 117* C PRINT 912 U00356		60312	1104	~	READ(11,/5ŋ) PID,MID	000350			
LU316 112* 749 FORMAT(* PIU ANU MID READ FROM 11 IN ORDER* ,2X, 216) UDU356 L0317 113* 750 FORMAT(8X,216) UDU356 L0317 114* C PRINT 911 COU356 U0317 115* C911 FORMAT(* IN URGER GOING TO VEC*) L0U356 L0320 116* CALL VEC(MID,PID) UOU356 L0320 117* C PRINT 912		00312		<u> </u>	PRINI /491PIDIHID	000350			
LU31/ LI3* /50 FORMAT(8X,218) U00356 L0317 114* C PRINT 911 C00356 L0317 115* C911 FORMAT(* IN URGER GOING TO VEC*) L00356 L0320 116* CALL VEC(MID,PID) D00356 L0320 117* C PRINT 912		00316	112*	749	FORMATE * FID AND MID READ FROM 11 IN ORDER* ,2X, 216)	000356			
L0317 L14* C PRINT 911 C00356 L0317 L15* C911 FORMAT(* IN URUER GOING TO VEC*) L00356 L0320 L16* CALL VEC(MID,PID) D00356 L0320 L17* C PRINT 912		LU31/	113*		FOMMA(188,218)	600356			
UU31/ LIS* C911 FORMAT(* IN URGER GOING TO VEC*) LOU356 LU32U 116* CALL VEC(MIU,PID) U00356 LU32U 117* C PRINT 912		00317	114*	L	PRINT VII	000356			
LU32U 116* CALL VEC(HIU,PID) UOU356 <u>C032U 117* C PRINT 912</u> GOD356		<u>uU317</u>	115*	<u> </u>	LORMATI' IN URDER GOING TO VEC')	L0L356			
<u>C0326 117* C PRINT 912</u> G00356		60326	116*	-	CALL VEC(MID,PID)	000356			
		60320	117*	<u> </u>	PRINT 912	600356			

Q F	DER			DATE 073080	PAGE	4
60320	118*	<u> </u>	FORMATI . IN ORDER JUST BACK FROM VEC.	000356		
00321	119*	710	CONTINUE	000363		
60321	120*	<u>C **</u>	THE NEXT NINE LINES ARE DEBUGS.TO BE COMMENTED OUT LATER.	<u>600363</u>		
60321	121*	C i	PRINT 751	00 ₀ 363		
·U0321	122*	C	<u>00 760 I=1,HAXHIU</u>	000363		
00321	123*	C760	PRINT 761, KVCHID(I)	C00363		
<u>00321</u>	124*	<u> </u>	PRINT 152	600363	• <u>-</u>	
00321	125*	C	DO 770 I=1, MAXPID	000363		
00321		<u> </u>				
00321	1274	0751		606363		
00321	128*	<u> </u>	FORMALL ' KYCHID IN ORDER'S	000363		
00321	1274	(152	rugnari kycriu in under j	606363		
<u>00323</u>	11.0	6		000363		
· £.0.32.3	132*	6771	FORMATE * NUMBED AND NUMPED IN $Q_{D} = R^{0} \cdot 2 \pi A$	000363		
6.0.324	133*			000367		
· U0325	134*		NEND17=NSTART(18)=1	600372		
66326	135+		U0 654 L=1.NEND17	000375		
Ln 33 i	1364	654	READ (11,400)DUM	000460		
LU335	137*		NUM18=NUM(18)	606410		
60335	<u>138 +</u>	C_**	CHANGE MID IN MAT11	600410		
60335	139#	C **	MID AND PID IN C AND P CARDS WILL BE CHANGED IN CANDP	030410		
60336	<u>140*</u>		KQUNT_1	000412		
00337	141*		U0 655 LL=1,NUM18	600417		
<u> </u>	142*			600417	· · · · · · · · · · · · · · · · · · ·	
UD 34 3	143*		LLL=L	000424		¢.
60344	144*			<u>L00426</u>		
60353	145*	604	FORMAT(8x, 18, 2L8, 3, 5F8, 4)	000443		
<u></u>	140#					
00355	1474		NDUALU	000452		
	140*		$\frac{100000}{100000000000000000000000000000$			
00301	1612	800		000480		
<u> </u>	151*	0ue	LF (KHOAD + EQ + Q) GO TO 657	<u> </u>		
LU367	152*		MAT11(L)=XMAT11(L)	000470		
60374	153*		00 8.5 J=1.10	000476		
00373	154*	805	HAT12(L.J)=XMAT12/L.J)	000476		
U0373	155*	С	PRINT 623,L,MAT11(L)	000476		
L0373	156*	C625	FORMAT(* REFORE CHANGE, MATIL(* , 12, *)=* , 13)	<u> </u>		
60375	157÷		CALL ID(1,NUMMID,MAT11(L),KM)	600500		
60376	158*		HAT11(L)=KN	000510		<u></u>
ulj 376	159*	Ċ	PRINT 627,L,MAT11(L)	000510		
<u> </u>	<u> 160* </u>		FORMATI' AFTER CHANGE, MATIL(*,12,*)=*,13)			
60377	161#		GO T _U 855	606512		
<u> </u>	<u> </u>	657	_PRIN1_658.XMa111(_)	<u></u>		
50403	163*	(= 0	KOUNTEKOUNTEL	600521		
<u> </u>	<u> </u>	626	THRUBELL AN DAU NUL REFERENCEU BL ANT PILLA 14	<u>NUU228</u>		
60405	166#	655	CONTINUE	000526		
60405	167#	<u> </u>	PRINT 420	U00526	····	
60405	168#	c42n	FORMAT(* MAT11 AND MAT12 IN URUER*)	000526		
60407	169#	<u> </u>		000526		
0041u	170*			404531		
60410	171*	c	UO 660 M1=1,NUM18	000531		
·60410	<u>172*</u>	<u>C66D</u>	PRINT 614.MATILL(M1).(MAT121M1.J).J=1.10)			
u041j	173*	C614	FORMAT(/15,5111.5/3X,5E11.5)	000531		
Ļ0411	174*			600532		

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60412	175*	RETURN					<u> </u>		00	0535		
L0413 END EOD	176*	END							00	0560		
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•HDG • P	PATR	· · · · · · · · · · · · · · · · · · ·										·
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SFOR, S PAIR, PAIR HSA E3 -U7/30/80-09:46:12 (55,)

SUBROUTINE PAIR ENTRY POINT 000251

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STORAGE USED: CODE(1) 000307; DATA(U) 700230; BLANK CONHON(2) 000000

COMMON BLOCKS:

MOZART 000334 BACH 000044 0003 <u>0034</u>

EXTERNAL REFERENCES (BLOCK, NAME)

UUU5 NERR2\$ LOG6 NERR35

STORAGE ASSIGNMENT	(BLOCK,	TYPE,	RELATIVE	LOCATION,	NAHEJ

	0000 0001	000160 00nr.77	1F 133G	00J1 C0J1	000202	100L 1426	0001	000052 1126 000120 1076	0001	000053 115G C00123 152g	000 000	000064	123G 167G
ج	0001	000206	200L	0001	000167	201G	6001	000172 2046 000212 831	~0001	000132 78L 000164 INJP	000	L 000127	79L 12
		I 000152	J3	0000	I 000153	<u>ј</u> 4 к	0000 I 0000 I	000155 J5	1 0000	I DOD154 J6	UDDU UDDU) I 000156 .	J7
 		R 000024	HAT12	0000	I 000150	HAXID	0004	ODUG22 NSTART	0004	I DUDODO NUM	0000) I 000147 M	IUM18
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DATE 073080

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	60101	T *	SUBROUTINE PAIR (KGDE,CID,PRID,ISTOP,NCARDS,KOL,NOUT,MATCH,INDEX)	000053
·	00101	2*	C ** KODE INPUT. D FOR MID PAIRING, 1 FOR PID PAIRING	000053
	CD101	3*	C ** CID• INPUT• ELEMENT ID ARRAY• E•G•,CRODID	000053
	60101	4#	C ** PRID. INPUT. PROPERTY ID ARRAY. E.G. PROD1	000053
	L0101	5*	C ** ISTOP. INPUT. NO. OF ELS. WITH GIVEN CONST. CODE (=NPAR(2))	000053
·	60101	6*	<u>C ** NCARDS, INPUT, NUMIA IF KODE=D, IF KODE=1, TOTAL NO. OF P. CARDS FOR GIVEN</u>	
	00101	7*	C ☆☆ ELEMENT. E.G., IF NASTRAN RUD,NCARDS=NUM12	000053
	60101	8*	<u>C ** KUL. INPUT. IF KOUEED, COL. NO. OF MID IN ELEMENT ID ARRAY.</u>	
	60101	9*	C ** E.G. IF GIVEN ELEMENT IS NASTRÅN ROD,KOL=4. IF KODE=1,COR.	000053
	L0101	<u> 10* </u>	C ** NO. OF PIU IN ELEMENT ID ARRAY. E.G. IF GIVEN EL. IS	600053
	60101	11*	Č ≠♦ NASTRAN ROD+KUL=S	000053
·	60101	12*	C ** NOUT, OUTPUT, IF KODE=0,NOUT=NUMMAT FOR GIVEN EL, AND CONST. CODE.	600053
	60101	13*	C ## IF KODE=1,NOUT#NUMGEO FOR GIVEN EL. AND CONST. CODE.	600053
	00101	14*	<u>C #* MATCH, OUTPUT, FIRST COL, CONTAINS MID(KODE=C) OR PID(KODE=1), SFCOND COL</u>	00rin53
	C0101	15*	C ** CUNTAINS ROW NO. OF THAT MID IN MAT12(KODE=1),OR ROW NO. OF THAT PID IN	600053
·	60101	16*	C ** PROPERTY ARRAY OF GIVEN ELEMENT (E.G. PRODZ ARRAY)	000053
	00101	17*	C ** INDEX. UUTPUT.THE ELS. OF INDEX ARE HID OR PID NOS. OF THE CURRENT ELEMENT	000053
·	00103	<u>18</u> *	COMMON/MOZART/MAT11(20), MAT12(20,10)	000053
	սց1ս4	19*	COMMON/BACH/NUM(18),NSTART(18)	000053
·	60104	20+	C ** CHANGE GROUP. NO. OF ELEMENTS	600053
•	60105	21*	INTEGER CID(100,7),VID(100),INDEX(100),MATCH(100,2)	000053
~	00105	22*	C ** CHANGE GROUP. NO. OF PID'S	<u>000053</u>

P A	IR		DATE 073080	PAGE	Z
60106	23*	INTEGER PRID(25,2)	000053		
60106	24#	(000053		
00107	25×	REAL MAT12	000053		
6n11.j	26#	1 FORMAT()	000053		···
uõ110	27#	C PRINT 2	000053		
60110	28#	C2 FORMAT(5x,*KODE*)	000053		
00110	29*	C PRINT 1, KODE	000053		
6.0111	30+	U0 666 KR=1.100	000053		
L0114	31*	00,666 KC=1,2	000053		
00117	32*	666 MATCH(KR,KC)=0	000053		
60122	33*	DO 8 K=1,100	000064		
60125	34≠	8 INDEX(K)=0	000064		
60125	35*	C PRINT 3	000064		
60125	36#	C3 FORMATISX. *CIDHS JUST INSTUE PATR*)	000064		
60125	37#		000064		
00125	384	$\begin{array}{c} \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet \\ \hline \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet & \bullet$	000004		
00125	39≠		000004		
<u> </u>	<u> </u>				
1.0127	41±		440000		
<u></u> (0127	<u>ŢĂŸ</u>		000045		
00127	 4 3 m	C DO 41 7-1 MINER	000005		
<u>UUACI</u>	4.9.4		000065		·····
00127	444	$C_4 = FRIN_4 + 3, RA III (1), (RA II2 (1, 0), (31, 10))$	000065		
	<u> </u>	<u>U 45 FURFAI(/15:5E11.5/33:5E11.5)</u>	000065		-
(0130	404		000067		
	4/#				•• • • • • • • • • • • • • • • • • • • •
00132	457	D0 75 J2=2,1510P	000077		
	<u> </u>	$\frac{11}{11} \frac{11}{11} 11$			
00177	⊃(j∓ 51	75 CONTINUE	000106		
	51*	C ** FOR ALL INTEGERS BEIWEEN 1 AND MAXID, FIND OUT HOW MANY HID'S OR PID'S THERE	000106		
00137	52*	C ## ARE UF EACH+ ASSUME MAXID =100	000106		
			000166		
01137	54 *	C4 FORMAI(5X, MAXID IN PAIR')	000106		
	55*		000106		
00141	20*		000106		
00144	5/*		000114		
66146	58¥		000123		
<u> </u>	59#		000123		
60154	6U <i>\$</i>	IF (CID(34,K0E).EQ. 33) GO TO 79	000123		
00156	<u> </u>	60 10 78	600125		
00157	0∠# .7+	79 10 (33) = 10 (33) + 1	000127		
	0.5*		000135		·
00162	644	// CONTINUE	000135		
	<u>05</u> #	C PRINT 15	600135		
60162	11.		301.176		
<u>40162</u>	66*	C IS FORMATE VIU IN PAIR")	000135		
LC162	66* <u>67</u> *	C IS FORMATC VIU IN PAIR") C UO 16 J3=1.MAXID	000135		
	66* <u>67*</u> 63*	C 15 FORMATC VIO IN PAIR") C 10 16 J3=1.MAXID C16 PRINT 1, VID(J3)	<u> </u>		
<u>LC162</u>	66* 67* 63* 69*	C IS FORMATC' VIU IN PAIR') C UO 16 J3=1.HAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID.	000135 000135 000135 000135		
L0162	66≠ <u>67</u> ≭ 63≠ 69≠ 7J≠	C IS FORMATC' VIO IN PAIR') <u>C</u> UO 16 J3=1.MAXID C16 PRINT 1, VID(J3) <u>C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZEHO ELS. OF VID.</u> <u>C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE</u>	000135 000135 000135 000135 000135		
LC162 LC162 LC162	66* 67* 63* 69* 7J* 71*	C IS FORMATION IN PARCY C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID.	000135 000135 000135 000135 000135 000135		
LC162 LC162 U0162 LO164	66* 67* 63* 69* 7J* 71* 72*	C IS FORMATY VID IN PAIR") C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=G J6=G	000135 000135 000135 000135 000135 000135		
LC162 LC162 UO162 LO164 LC165	66≉ 67≉ 69≉ 7J¢ 71¥ 72≉ 73≉	C IS FORMATION VID IN PAIR") C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZEHO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=G NOUT=C	000135 000135 000135 000135 000135 000135 000135 000135		
LC162 LC162 UO162 LC164 LC164 LC165 LC166	66* 67* 69* 73* 73* 72* 73* 74*	C IS FORMATIC VID IN PAIR") C UO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZEHO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEUMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=G NOUT=C UO 80 J5=1.MAXID	000135 000135 000135 000135 000135 000135 000135 000135 000136 000142		
LC162 LC162 L0162 L0164 L0165 L0166 L0171	66* 67* 63* 69* 73* 71* 72* 73* 74* 75*	C IS FORMATIC VIO IN PAIR") C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZEHO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEUMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=G NOUT=C U0 &G J5=1.MAXID IF(VID(J5).EL.U)GO TO 80	000135 000135 000135 000135 000135 000135 000135 000135 000136 000142		· · · · · · · · · · · · · · · · · · ·
LC162 LC162 LO162 LO165 LO165 LC166 LC171 LC173	$ \begin{array}{r} 66 \\ 67 \\ 67 \\ 69 \\ 73 \\ 71 \\ 72 \\ 73 \\ 73 \\ 74 \\ 75 \\ 76 \\ 76 \\ \end{array} $	C IS FORMATY VID IN PARTY C UO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. JG=G NOUT=C UO EG JS=1.MAXID IF(VID(J5).EC.U)GO TO BD NOUT=NOUT+1	000135 000135 000135 000135 000135 000135 000135 000136 000142 000142 000142		
LC162 LC162 LC162 LC164 LC165 LC166 LC171 LC173 LC174	66* 67* 69* 73* 73* 72* 73* 74* 75* 76* 77*	C IS FORMATY VID IN PARTY C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID. C ** THE N*S ON THE MATERIAL CONTROL CARDS AND GEUMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=C, NOUT=C U0 80 J5=1.MAXID IF(VID(J5).E(.0)GO TO 80 NOUT=NOUT+1 J6=J6+1	000135 000135 000135 000135 000135 000135 000135 000136 000142 000142 000144 000144		
LC162 L0162 L0162 L0164 L0165 L0166 L0171 L0173 L0174 L0175	66* 67* 69* 73* 73* 73* 73* 73* 74* 75* 76* 77*	C IS FORMATY VID IN PARTY C DO 16 J3=1.MAXID C16 PRINT 1, VID(J3) C ** NOUT (=NUMMAT GR NUMGEO) IS THE NO. OF NONZERO ELS. OF VID. C ** THE N'S ON THE MATERIAL CONTROL CARDS AND GEOMETRIC PROP. CARDS ARE THE C ** INDICES OF THESE NONZERO ELS. OF VID. J6=G NOUT=C U0 &G J5=1.MAXID IF(VID(J5).EL.U)GO TO BD NOUT=NOUT+1 J6=J6+1 INDEX(J6)=J5	000135 000135 000135 000135 000135 000135 000135 000135 000142 000142 000142 000142 000142 000142		

PAIR	DATE_073080PAGE	3
	000160	
U_{17} U		
COID OF C TT FIND THE MALLI OR FID INDEX CORRESPONDING TO E	AUD UT THE ELSOVE INVEA UVUIDU	
U0203 83* D0 82 J8=1,NCARDS	0001/2	
60.10(100,200),KODE	<u>GOD172</u>	
LU207 85+ 100 IF(MAT11(J8) _EQ, INDEX(J7)) GO TO 83	000202	
<u>60 10 82 60 10 82 60 10 82 60 10 82 60 10 82 60 60 82 60 60 82 60 60 82 60 80 80 80 80 80 80 80 80 80 80 80 80 80</u>		
UU212 87* 200 IF (PRID (J8,1,.EQ.INDEX (J7)) GO TO 83	000206	
<u>60 To 82</u>	000210	
GD215 89* 83 MATCH (J7+1)=INDEX(J7)	000212	
L0216 90+ MATCH (J7+2)=J8		
U0217 91≠ d2 CONTINUE	L00224	
GD221 92* 81 CONTINUE	000224	
	000224	
UN221 94. CE EDEMAT(SY MAT(SI AND INDEX IN PATRI)	000224	
	000224	
UU221 907 CIDU PRINT 1+1MATCH(M1+H2)+M2=1+21+INUEX(M1)		· ·
UU221 97* C PRINT 6, NOUT	000224	
LU221 98* C6 FORHAT(5X+"NOUT="+13)	000224	
UU223 99+ RETUKN	000224	
L0224 100* END	<u>COD306</u>	
END FOR		
WHUG.P LOMEM	· · ·	
	· · · · · · · · · · · · · · · · · · ·	
· · · · · · · · · · · · · · · · · · ·		
-	· · · · · · · · · · · · · · · · · · ·	
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GFOR, S UDMEM, UDMEM HSA E3 -07/30/80-09:46:16 (6,)

SUBROUTINE ODMEN ENTRY POINT CO0145

STORAGE USED: CODE(1) DUC177; DATA(U) DDC176; BLANK COMMON(2) DOCODO

COHMON BLOCKS:

6023 BACH 600044

EXTERNAL REFERENCES (BLOCK, NAME)

JUJ4 FORM1 **UUU5 ODMEM1** UUn6_ UUMEM2

GUJ7 NERR35

STORAGE ASSIGNMENT (BLOCK, TYPE, RELATIVE LOCATION, NAME)

	<u>0001 0001na 11L</u>	0001 000063 1216	0001 000072 1266	<u>6001 000120 20L</u>	6060 I 0000n4 IDV31
×	JUGO I JCC666 IDV32	COUD BUD161 INJPS	0000 I 000153 ISTOP1	0000 I 000154 ISTOP2	0000 I 000002 KOAD
1	<u></u>	<u>6000 I 600156 k18</u>	000022_NSTART	6063 I 000000 NUM	0060 I 000151 NUM14
\mathbf{S}	UDUC I GUD152 NUM18	COUD I CCO150 NUM7	3000 I 000000 TYPE		
-					

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<u>u0101</u>	1 =	SUBROUTINE OLMEM(CONFAC.NKODE.10V3.NIDV3)	000002	^ `````````````````````````````
00103	2*	COMMUN/BACH/NUM(18),NSTART(18)	000002	· · ·
00104	3#	INTEGER TYPE(2), KOAD(2), IDV3(100), IDV31(50), IDV32(50)	600002	· · ·
60105	44	DATA TYPE/*GUADHE*,*M */	606002	,
	<u>5 + </u>	CALL FORM1 (NKODE, KOAD, TYPE)	000002	
L011 _Ŭ	· 6*	NUH7=NUH(7)	000007	,
60111	<u>7</u> *	NUM14=NUM(14)	000011	
60112	8 *	NU _H 16=NUH(18)	000013	•
LU113	<u> 7*</u>	IF(NKOGF+FQ+1) 50 TO 11	000015	•
66 1 Ī5	lu≄	CALL GUMEM1(NUM7, NUM14, NUM18, CONFAC, KOAD, IUV31, ISTOP1, NKODE)	000020	•
<u>LO116</u>	11+	CALL QUMEMZINUH7, NUH18, CUNFAC, KOAD, INV32, ISTOP2, NKODE)	600032	
60117	12*	NIDV3=1STOP1+ISTOP2	600 <u>n</u> 44	
LOIZU	13*	D1_1K17=1,ISTOP2	000063	•
60123	14+	101U [DV3(K17)=IDV31(K17)	600063	
<u>60122</u>	15*	<u>UO 1020 K18=1, ISTOP2</u>	600072	. <u></u> '
66138	16≠	1026 IDV3(ISTOP1+K16)=IUV32(K18)	000072	•
L0132	17#	RETURN	000074	
60133	18*	11 IF (KOAD (1).E	600160	•
00135	19#	CALL ODMEMZ(NUM7,NUM14,NUM18,CONFAC,KOAD,IDV3,NKODE)	000102	•
60130	∠ U #	RETURN	60 ₆ 114	•
L0137	21*	20 CALL QUMEMILINUM7, NUM14, NUM18, CONFAC, KOAD, IDV3, NIDV3, NKUDE)	000120	
UO14G	22*	RETURN	000131	
1.0141	<u>∠3*</u>	ENO	C00176	•

QUMEM.	1
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	60101	1*	SUBROUTINE QDMEMI(NUM7,NUM14,NUM18,CONFAC,KOAD,IDy31,ISTOP,NKODE)	U00000	
	60103	2*	COMMON/BACH/NUM(18),NSTART(18)/MOZART/MAT11(20),MAT12(20,10)	000000	
_	00103	3*	C ** CHANGE GROUP. NU. OF DESAP PLANE STRESS QUADRILATERALS (NASTRAN	000000	
·	<u> 00103</u>	4≠	C ** QUADRILATERAL MEMBRANE; CONSTRUCTION CODE 1	00000	
	00104	5*	INTEGER CODM1(100,6),VEID(100),CODMID(100,9),MATCH(100,2),INDEX(10	00000	
·	60104	6*	<u> </u>	00000	
	00135	7*	DIHENSION DUMMY(100,1)	000000	
	00105	8*	C ** CHANGE GROUP, NO. OF PID'S	60000	
	0106	9*	INTEGER PQDM1(25,2)	000000	
•	60107	<u>*ن 1</u>	DIMENSION PUDM2(25,2),GEOPH2(25,6)	<u> </u>	
	501107	114	C ** CHANGE GROUP • NU • OF HID 'S	000000	
		. 7 #		000000	.
	60111	144	C MARGE REAL MARGE REAL OF STON VARTARIES	00000	
	60112	15+	DIMENSION TRANSION TRANSPORT	000000	
	60112	16#		000000	
	00113	17#	INTEGED KOAD(2).Type(2).NPAR(7) VAR(4)	00000	
	60114	18*	DIMENSION ENUL (4.4) - ELDAT2(1,00.4) - DUMM(4)	60000	
	L0115	19+	REAL MAT12	60000	
	LU116	źJ*	DATA VAR/'A', 'B', 'C', 'D'/TYPE/'QUADHE', 'H '/	00000	
	60121	21≠	7 FORMAT ()	000000	
	<u></u> C0122	22*	CALL CANDP17,NUM7,NUM14,CQUM1,DUMMY,PQDM1,PQDM2)		
	60123	23*	WRITE (6,5)	200010	
	<u> </u>	24*	<u>5. FORMAT (2X, PLANE STRESS CUAURILATERALIQUAD, MEMBRANE IN NASIRAN), C</u>	000015	
M	L0125	25₹	IONST. CODE 1')	600015	
- Q −	00120	207	$\frac{NPAR(1)=3}{NPAP(2)}$	000015	· · · ·
2	00130	21*		006021	
	60131	<u> </u>		000023	
4	60132	30+	NUM 7 = NUM (7)	000024	
	60133	31*	ISTOP=NUM7	600025	
	60134	32+	1=1	<u>u00026</u>	
	60135	33*	IF(NKODE.EQ.i) GO TO 12	000027	
	00137	34*	CALL FORM2(JJ1,KOAD,TYPE,NPAR(2),VEID,NUM7)	600031	
	00140	35*	ISTOP=NPAR(2)	000041	
				000043	•••••••••
	00142	21# 21#	The start start and start	000045	
	00146	39#		000055	
	00147	4.1*		000066	
_	0147	41*	C ** FINO PUMMI CARD WITH SAME ID	000066	
	<u> </u>	42*	U0 65 K=1.NUM14	000073	
	60153	43≠	IF(NPIU_EQ.PuDM1(K,1))GO TO 61	600073	
	<u> </u>	44*	<u>60 TQ 65</u>	000076	
	60156	45*	61 KK=K	000100	
`	00157	46*	<u> </u>		
	00160	4/7		000105	
	60163	404			
	60165	4,7÷ ⊾Ω≢		000107	
	 LU165	51*		600113	
_	L0166	52*	CODMID(J,5)=CODM1(J,6)	000115	
	UD167	53×	CQDMID(J,6)=PQGM1(KK,2)	600117	
·	60170	54*	<u>CCDMID(J,7)-NPID</u>	000121	
	60171	55*	70 CONTINUE	600125	
	00171	56*	C 🔅 FIND NUMMAT AND MATCH	000125	

_	<u></u> cu	HEN1		DATE 073080	PAGE	3
	66173	57*	NKODE=0	600125		
	UC174	58*	KKOL=6	000126		
	60175	59 *	CALL PAIR(KKODE,CODMID,PUDM1,ISTOP,NUM18,KKOL,NUMMAT,MATCH,INDEX)	000130		
	CO176	63*	NPAR (3) = NUMHAT	000145		
	00177	61*	WRITE (6,501)	<u> </u>		
	u0201	62#	501 FORMAT (2X, 'ENTER CODE FOR INCOMPATIBLE DISPL. MODES: O MEANS USE	000155	-	
	L0201	63*	1THEM.; 1 MEANS DON,T USE THEM "	000155		
	L0202	64 #	READ (5,7) NPAR(6)	U00155		
	<u>60212</u>	65*	C ++ SET UP MATERIAL PROPERTIES DATA	000155		
	60205	66 *	DO 63 JIG=1,NUHMAT	006167		
	60210	67#	HTPRO1(J10,1)=INDEx(J10)	000167		
	UC211	6 ⁸ *	MTPF01(J10,2)=1	000171		
	60212	- 69*		000176		· · · · · · · · · · · · · · · · · · ·
	00215	70*		000176		
	60217	72#		000203		
	00220	712		000203		
	66222	74*		000204	· · · · · ·	
	66224	75*	86 MTPR02(J)D)=H+T12(NR0H+4)#CONFAC	000210		
	u0225	76#	HIPRO3(JIn. 1)Z().	000213		
	60226	77#	MTPR03(J10.2)=MAT12(NROW.1)	000214		
	00227	78*	MTPR03(J17,3)=MAT12(NROW_3)	000216		
	00230		MTPR03(J10+4)=n.	000220		
_	L0231	៩ <u>ដ</u> ្≄	MTPR03(J10,5)=MAT12(NROW,8)	600221		
	60232	81*	MTPR03(J10,6)=MAT12(NR0H.9)	<u> </u>		
×	60233	°2≠	MTPR03(J10,7)=MAT12(NROW,1G)	LOU225		
×	60234	<u> </u>	MTPRU3;J10,6)=MTPRU3(J10;6)	600227		
×	00235	64 *	IX=INDEX(J10)	000231		
· ·	00236	<u> </u>	B3 CONTINUE	L00235		
50	60236	86*	C ++ MATERIAL PROPERTIES DATA IS DONE.	000235		
		8/*	<u>C ** SET UP GEOMETRIC PROPERTIES DATA</u>	000235		
	LU240	69. 80.	KKK0DE=1	600235		
	66242	<u> </u>	CALL DATE VEROUS COMMENDATION INTERPORTUNATE VERO NUMERO MATCH INDEXI			
	00242		NPAD (7) = NIMAGE A	000241		•
_	60244	97*		606254		·
	60246	93*	795 FORMATLY COMM FLEMENT CONTROL SROM ODVEW17)	000256		
	u0247	94 ±		L00263	· · · · · · · · · · · · · · · · · · ·	
	1.0252	95×	504 FORMAT(715)	00277		
• -	L0252	¥6#	C ** URITE MATERIAL PROPERTIES DATA	000277		
_	60253	974	WRITE(12,349)	000277		
	00255	¥8*	349 FORMATI' COMM MATERIAL PROPERTIES FROM QUMEM1+)	606313		
	Up256	99*	U0 35D J12=1.NUMMAT			. <u></u>
	00261	160*	35n WRITE(12,300)(MTPR01(J12,J13),J13=1,2),MTPR02(J12),(MTPR03(J12,J13	606313		
-	<u>UU261</u>	101#	1), J13=1,6)	600313		
	60275	162*	300 FORMAT (215,F10.3/2F10.0,F10.3,5F10.0)	606341		
	60276	163*	WRITE(0,3D1)	000341		
	00300	164*	301 FORMAT (10%, "GLOMETRIC PROPERTIES FOR CONST. CODE 1")	000355		
	00301	<u>115*</u>	DO 283 J10=1, NUMGEO	<u></u>		
	60304	106#	D0 264 J11=1,NUMGE0	000355		
-	60307	10/#	IF (MAICH(J11,1)+E0, INDEX(J10))60 10 285	606355		
	00311	108 4		600360		
	10312	116.00		UUU362	·	
	00313	1104		000363		
	<u>UU314</u> _	112 #	207 LUNIINUE 286 INFORCELLIG, 11750, M21NEAU, 11			······
	60317	1130	200 BETTELS SADINESTING	(0017)		
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0.022 114 322 7000 Mark 1/2 A, "FOR PROVENT 10".14." ENTER V.SA.SLO.VE.IN.INAL.00027 0.0037 0.0323 115* cf.015/7) 0.00037 0.00037 0.0323 115* cf.015/7) 0.00037 0.00037 0.0324 115* cf.015/7) 0.00037 0.00037 0.0325 115* cf.015/7) 0.00037 0.00037 0.0326 115* cf.015/7) 0.00037 0.00037 0.0335 115* cf.015/7) 0.00042 0.00042 0.0335 12* cf.015/7 cf.00042 0.00040 0.0335 12* cf.015/7 cf.00042 0.00040 0.0335 12* cf.015/7 cf.00040 0.00040 0.0335 12* cf.015/7 cf.00041 0.00040 0.0335 12* cf.015/7 cf.00041 cf.00041 0.0335 12* cf.015/7 cf.00041 cf.00041 0.0335 12* cf.015/7 cf.00041 cf.00041 cf.0		00			DATE 073060	PAGE	4
C022 115* CAD15*1 COD37* C032 116* CAD15*1 COD37* C032 117* 223 CONTUNE COD37* C032 117* 223 CONTUNE COD37* C032 117* 223 CONTUNE COD37* C033 116* 9 CONTUNE COD37* C033 116* 9 CONTUNE COD37* C033 116* 9 CONTUNE COD37* C034 117* CONTUNE COD37* COD37* C035 127* PATILITS / STANDAR VIDDA, CODPRECIDE PROPERTIES FOR CONST. CODE 1*1 COD37* C035 127* 111 FORMATILIA COD37* COD37* C035 127* 111 FORMATILIA COD37* COD37* C035 127* FORMATILIA COD37* COD37* COD37* C035 127* FORMATILIA COD37* COD37* COD37* C035 137* FORMATIL		60322	114#	302 FORMAT/2X. FOR PROPERTY ID. 14. ENTER W.SA.SI.D.WE.IN THAT ORDER	000377		
C0233 11%* rgC005;7) 105022(121, 1322, 6) 000011 C0350 11% 723 CONTINUE COOL1 C0350 11% 723 CONTINUE CONTINUE C0350 11% 723 CONTINUE CONTINUE C0355 12% 700 PARTILIZ-10011MOREQUID_J11/JJ121:60 CONTINUE C0356 12% 7004 PARTILIZ-10011MOREQUID_J11/JJ121:60 CONTINUE C0356 12% 7004 PARTILIZ-10011MOREQUID_J11/JJ121:60 CONTINUE C0351 12% 11 PARTILIZ-10011MOREQUID_J11/JJ121:60 CONTINUE CONTINUE C0351 12% 11 PARTILIZ-10011MOREQUID_J11/JJ121:60 CONTINUE CONTINUE C0351 12% 11% CONTINUE CONTINUE CONTINUE C0351 12% 11% CONTINUE CONTINUE CONTINUE C0351 13% CONTINUE CONTINUE CONTINUE CONTINUE C0351 13% CONTINUE CONTINUE CONTINUE <td></td> <td>60322</td> <td>115*</td> <td>1)</td> <td>000377</td> <td>· · · · · · · · · · · · · · · · · · ·</td> <td></td>		60322	115*	1)	000377	· · · · · · · · · · · · · · · · · · ·	
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0.010 110 100 111.112.4761 0.0011 0.011 0.0012 0.0012 0.0012 0.011 100 100 100 100 0.011 100 100 100 100 100 0.012 122 100 100 100 100 100 0.015 122 100 100 100 100 100 100 100 0.015 122 111 100 111<		U0326	117*	283 CONTINUE	606411	-	
L 2012 114* 76 FORMATI' COMP COUNT ALL FROMPATIES FROM COMENT'S COMESS 2013 124 224 224 303 FORMATIESTELEMENT LOAD MULTIPLIERS FOR CONST. CODE 1'S COMESS 2014 224 224 303 FORMATIESTELEMENT LOAD MULTIPLIERS FOR CONST. CODE 1'S COMESS 2014 224 224 224 224 224 224 224 224 224 2		<u> </u>	118*	write(12,96)	600411	· . ·	
1033 114 00 200 JU 200 JU21 AUROLO 1010 (ECOP2[JU]0, J11) JJ111,61 100042 0034 124 131 FORMATISSED10(0) 100 (ECOP2[JU]0, J11) JJ111,61 100042 0034 124 131 FORMATISSED10(0) 100 (ECOP2[JU]0, J11) JJ111,61 100045 00351 125 111 FORMATISSED10(0) 100 (ECOP2[JU]0, J11) JJ111,61 100045 00351 125 101 FORMATISSED10(0) 000 (ECOP2[JU]0, J11) JJ111,61 100045 00351 125 101 FORMATISSED10(0) 000 (ECOP2[JU]0, J11) JJ111,61 100045 00351 125 00 (ECOP2[JU]0, J11,71,71 000045 100045 00351 126 00 (ECOP2[JU]0, J11,71,71 000045 100045 00351 126 00 (ECOP2[JU]0, J11,71,71 000045 100045 10351 126 127 FORMATISSED10(0) (ECOP2[JU]0, J11,71,71 100045 100045 10351 126 127 FORMATISSED10(0) (ECOP2[JU]0, J11,71,71 100045 100055 10371 138 112 FORMATISSED10(0) (ECOP2[JU]0, J11,71,71 100055 100555 100556 10371 138 111 FLICALONO COD 120 10		60332	119*	96 FORMAT(COMM GEOMETRIC PROPERTIES FROM QDHEH1)	600422		
U038 11.2 2014 <th< td=""><td>·</td><td>6033</td><td>1204</td><td></td><td>600422</td><td></td><td></td></th<>	·	6033	1204		600422		
UD10 List UD10 List UD10 UD10 <th< td=""><td></td><td>00336</td><td>1414</td><td>299 WRITETZ, SUSTRUEZ(JLU), (GEOPRZ(J10, J11, J11-1,6)</td><td>L00422</td><td></td><td></td></th<>		00336	1414	299 WRITETZ, SUSTRUEZ(JLU), (GEOPRZ(J 1 0, J 1 1, J 1 1- 1 ,6)	L00422		
C0337 1:35 111 FORT TOTAL Contended C0351 1:55 111 FORT TOTAL Contended Contended L0352 1:56 D0 115 KF1.4 Contended Contended L0352 1:56 D0 115 KF1.4 Contended Contended L0352 1:57 D0 115 KF1.4 Contended Contended L0352 1:57 D0 1:58 KF1.4 Contended Contended L0352 1:35 READIS.7 READIS.7 Contended Contended Contended L0371 1:12 1:12 Contended Contended <td></td> <td>00346</td> <td>1/1#</td> <td>C 44 CENEDATE FIEMENT LOAD NOT TOUTED</td> <td>000440</td> <td></td> <td></td>		00346	1/1#	C 44 CENEDATE FIEMENT LOAD NOT TOUTED	000440		
0.051 11:5 11:1 COMPATION COMPATION 0.055 12:6 00:15:KSI:4 COMPASI COMPASI 0.055 12:7 00:15:KSI:4 COMPASI COMPASI 0.056 12:7 00:12:KSI:4 COMPASI COMPASI 0.057 13:4 IFLOWERDITIC COMPASI COMPASI		L0347	124=	write (6.111)	600440		
LU352 162* D0 115 Keil4 C00451 L0355 127* D0 115 Keil4 C00451 L0366 128* 115 Evel(KeiK7)514 L0366 128* L15 Evel(KeiK7)514 L0366 128* L15 Evel(KeiK7)514 L0366 128* L15 Fernitation (L010) (L11) (L010) (60351	125*	111 FORMAT(10X, *ELEMENT LOAD MULTIPLIERS FOR CONST. CODE 1*)	600451		
L G355 127* D0 115 K7:1,4 G0051 G0363 129* D0 12 K5:1,4 G0051 G0363 129* D0 12 K5:1,4 G0051 G0363 129* D1 20 K5:1,4 G0051 G0363 129* D1 20 K5:1,4 G0051 G0374 122* D1 27 K5:1,7 G00FK1.1,51:1,51:1,51:1,51:1,51:1,51:1,51:1,5		LU352	126*	DO 115 K6=1,4	000451		
00360 125 D0251 D0251 00360 129* 001201 D0261 D0264 0136 130* PRIFE(4.12) VAR(A) D0264 D0272 0131 131* 112 FORMATI2A.*FUR COAD *.11.*ETERDST) D0072 D0072 01312 131* 11610.0007 D0072 D0072 01312 134* 11610.0007 D0072 D0072 00312 134* 11610.0007 D0072 D0072 00312 134* 11610.0007 D0072 D0072 00312 134* 11610.0007 D00172 D0052 00312 134* 1120.0007 D00515 D00511 00404 137* 120.0007 D0072 D00525 00410 134* 121.0007 D00525 D00525 00412 144* 121.0007 D0151.0007 D00525 00412 144* V01164.121.0007 D00551 D00525 00421 144* V01164.121.0007		60355	127*	DO 115 K7=1,4	000451		
U0363 10° U0 120 k81.4 000661 U0365 130° 01164.1122/WARLAD 000672 U0371 131° 112 FORMATI2A, 'FOR LOAD 'A, ', 'ENTER X, Y, 2 ELEMENT LOAD FRACTIONS, IN 000672 U0371 133° READISAT, 'FOR LOAD 'A, I, 'ENTER X, Y, 2 ELEMENT LOAD FRACTIONS, IN 000672 U0375 133° READISAT, 'FOR LOAD 'A, I, 'ENTER X, Y, 2 ELEMENT LOAD FRACTIONS, IN 000672 U0375 135° (O) 177 00173 000772 U0375 135° (O) 171 (S) (S) (S) (S) (S) (S) (S) (S) (S) (S)		<u>UO36U</u>	128*	115 EMUL (K6,K7)=10.	000451		
L0366 100 HEITELSYLARLES 00064 L0371 131 112 FORMATIZA, *FOR LOND *ALL PEROS*) 000672 L0372 133 READES, 71 (DUMR (MIL), KAIL-1, 3) 000672 L0373 134 REDUML 1, KAIL-1, 3) 000672 L0374 135 REDUML 1, KAIL-1, 3) 000672 L0375 134 REDUML 1, KAIL-1, 3) 000672 L0384 111 MULE AND ISONAL 000515 L0404 135 111 MULE AND ISONAL 000515 L0404 135 111 MULE AND ISONAL 000515 L0404 135 111 MULE AND ISONAL 000525 C0410 135 1117 MULE AND ISONAL 000525 C0410 135 114 MULE ANT ISONAL 000525 C0410 141 121 KRITELSIZE 111 MULE AND ISONAL L0425 142 KRITELSIZE 1117 000525 C0410 136 KRITELSIZE 1117 000525 L0412 KRITELSIZE KRITELSIZE 1111 11111		60363	129×	UO 120 K8=1,4	000461		
L 0311 132* 112 FORMAT(2x,*FOR LOAD *,1,* ENTER X,*/2 ELEMENT LOAD FRACTIONS, IN DOUB72 1132* 114* DEFENDET = ALL ZEROX*1 (OAD FRACTIONS, IN DOUB72 10372 133* MEROIS,FI,100MM(K11,K11;1,3) 10372 134* MEROIS,FI,100MM(K11,K11;1,3) 10372 135* 1117 FORMAT(12,100 TO 120 10374 135* 1117 FORMAT(12,000 TO 120 10404 135* 112 FORMAT(12000 TO 120 10405 135* 1117 FORMAT(12000 TO 120 10405 135* 1117 FORMAT(12000 TO 120 10405 135* 1117 FORMAT(12000 TO 120 10405 135* 1117 FORMAT(12000 TO 120 10405 135* 1117 FORMAT(12000 TO 140 10406 135* 1117 FORMAT(12000 FORMAT(12000 TO 140 10406 135* 1117 FORMAT(12000 TO 140 10406 135* 1117 FORMAT(12000 TO 140 10406 135* 1117 FORMAT(12000 FORMAT(12000 FORMAT(12000 TO 140 10405 1117 FORMAT(12000 FORMAT(12000 FORMAT(12000 TO 140 10405 114 141* 1116 FORMAT(12000 TO 1400 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 140 104020 145* 127 FORMAT(12000 TO 140 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 140 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 1400 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 140 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 140 FOR CONST. COUE 1*1 104020 145* 127 FORMAT(12000 TO 140 FOR CONST. COUE 1*1 104020 146* FORMAT(2000 TO 140 FOR CONST. COUE 1*1 104020 140* INF FORMAT(20000 TO 140 FOR CONST. COUE 1*1 104020 140* INF FORMAT(20000 TO 140 FOR CONST. COUE 1*1 104020 140* INF FORMAT(20000 TO 1400 TO 14000 TO 140		60366	130*	wRITE(6+112)VAR(k8)	000464		
L0371 L132 L1DAL DEPERAL DEFAULT FAIL FAULT L0372 L0372 L0372 L33* FERDER, TI GUMM (AIL), ALLE, L31 C00472 C0051 L0375 L11 FULL MARKILESCHOOTO 122 C00511 C00511 L0404 L34* L11 FULL MARKILESCHOOTO 122 C00515 L0404 L34* L11 FULL MARKILESCHOUTON C00515 L0410 L39* KILLIAZ-LILIA C00515 L0410 L39* KULLIAZ-LILIAZ C00515 L0410 L39* KULLIAZ-LICAZON C00525 L0410 L39* L11 FULL MARTICIZZING C00525 L0410 L014 L41* L41* KATICIZZING C00525 L0425 L42* L42* L44* L00551 C00551 L0426 L45* L2* C0051 C0051 L0427 L44* L44* L44* L44* L44* L44* L0426 L44* L44* L44* L44* L44* L44* L0426 <t< td=""><td></td><td>60371</td><td>131*</td><td>112 FORMAT(2X, FOR LOAD ', AI, ' ENTER X, Y, Z ELEMENT LOAD FRACTIONS, IN</td><td>000472</td><td></td><td></td></t<>		60371	131*	112 FORMAT(2X, FOR LOAD ', AI, ' ENTER X, Y, Z ELEMENT LOAD FRACTIONS, IN	000472		
00312 113* READSALIDUMENTATION 00012 00312 13* UDDMENTATION 0001 00312 13* UDDMENTATION 00001 00312 13* UDDMENTATION 00001 00312 13* UDDMENTATION 000001 00312 13* UDDMENTATION 000001 00312 13* UDDMENTATION 0000001 00406 13* 12* 000000000000000000000000000000000000			1774	IIHAI ORDER: DEFAULT = ALL ZEROS'			
C0317 15* C0157 C0031 C0317 15* C011000 C0031 C0404 13* C011000 C0031 C0414 14* C011000 C000525 C0414 14* 12* VETE(12,116)(EWL(NS,R10),R10_1,4) C00525 C0423 14* VETE(16,127) C00531 C00541 C0425 14* VETE(16,127) C00551 C0051 C0425 14* VETE(16,127) C00551 C00551 C0425 14* VECCONDICKROW,13 C00551 C00551 C0435 14* VETE(16,127) C00551 C00551 C0435 14* VETE(16,127) C0056 C00551 C0435 150* Isomart22* ENTRE DESIGN VARIABLE FRACTION.FEC.FOR EL.NO.*.16*.0E C00566		00372	133# 174#	$READ(S,I) = \{U,U,U,U,I,I,I,I,I,I,I,I$	000472		
U0102 155* 111 UULTANKILJSDUMHKILL UD0511 U0406 135* 120 CONTAWE UD0515 U0406 135* 1117 FORALI'.CONTAUE UD0525 U0410 135* UD121.K951,4 UD0525 U0411 1117 FORALI'.CONTAUELEMENT LOAD MULTIPLIERS FROM LOMEMI'') UD0525 U0412 141* UD 121.K951,4 UD0525 U0412 141* 121.KF1142.11151 UD0545 UD0525 U042 144* 121.KF1142.1015 UD0541 UD0525 U042 144* WRITE(6.127) UD051 UD0521 U0422 144* WRITE(6.127) UD0451 UD0551 U0424 144* WRITE(6.137) UD0451 UD0551 U0425 147* 137.COM101KR04.13 UD0451 UD0551 U0425 147* 137.COM101KR04.8 UD0551 UD0551 U0435 149* H7116(6.131)1X UD0551 UD0566 U0445 152* 137.FORAMIC2X*FREP DESIGN VARIABLE FRACTION_FECFOR EL_NO.*.14.*. UE COU57* UD0566 U0445 1		60373	135*				
UG404 137 120 CONTINUE CONSIS U0410 138 VRIE(12,1117) DDDS15 DDDS25 U0410 139 1117 FORMATI* COMP ELEMENT LOAD MULTIPLIERS FROM COMEMI*) DDDS25 U0411 121 VRITE(12,116)(EMULTR9,K10],K10=1,4) DDDS25 DDDS25 U042 121 VRITE(12,116)(EMULTR9,K10],K10=1,4) DDDS25 DDDS25 U0423 143 C 40 GENERATE ELEMENT DATA DDDS51 U0425 143 C 40 GENERATE ELEMENT DATA DDDS51 U0426 143 127 FORMATIESTO DDDS51 U0426 143 124 GENERATE ELEMENT DATA DDDS51 U0426 143 124 FORMATIESTO DDDS51 U0427 144 124 GENERATE ELEMENT DATA DDDS51 U0428 144 124 FORMATIESTO DDDS51 U0435 149 137 FORMATIESTO DDDS52 U0443 149 137 FORMATIESTO DDDS54 <td></td> <td>60402</td> <td>136*</td> <td></td> <td>606511</td> <td></td> <td></td>		60402	136*		606511		
LÖGUG 138 VRITE(12.1117) DODSIS LÖGUG 139 1117 FORMAT' COM ELEMENT LOAD MULTIPLIERS FROM COMEMI') DODSS LÖGUG 144 121 KYET14 GODSS LÖGUG 142 116 FORMATIGELA GODSS LÖGUG 142 116 FORMATIGELA GODSS LÖGUG 143 GORGEL GODSS LÖGUG 143 GORGEL GODSS LÖGUG 145 GORATIGELA GODSS LÖGUG 145 GORATIGELA GODSS LÖGUG 145 VERTEGELA GOTS GODSS LÖGUG 145 VERTEGELA GOTSS GODSS LÖGUG 145 VERTEGELA GOTSS GODSS LÖGUG 146 WERTEGELA GOTSS GODSS LÖGUG 147 FACOMINICARONA GODSS LÖGUG 146 WERTEGELA GODSS GODSS LÖGUG 147 FACOMINICARONA GODSS GODSS LÖGUG </td <td></td> <td>00404</td> <td>137#</td> <td>120 CONTINUE</td> <td>600515</td> <td></td> <td></td>		00404	137#	120 CONTINUE	600515		
U0410 137* 1117 FORMATI' COMM ELEMENT LOAD MULTIPLIERS FROM COMEMI') U00525 U0414 144* 121 WRITE(12,116)(EMML(K9,K10),K10_1,K10_1,K) 000525 U0423 143* C ** GENRAI(#E10,L) 000541 U0423 143* C ** GENRAI(#E10,L) 000541 U0426 144* WRITE(12,115) 000551 000551 U0426 145* 127 FORMAT(15X,*LLEMENT DATA FOR CONST. COUE 1*) 000551 U0426 145* 127 FORMAT(15X,*LLEMENT DATA FOR CONST. COUE 1*) 000551 U0426 145* 127 FORMAT(15X,*LEMENT DATA FOR CONST. COUE 1*) 000551 U0431 148* WRITE(6,1301X 000551 000551 U0431 148* WRITE(6,131)X 000556 000574 U0431 130* READ(5,71COMLORROWAB) 000566 000574 U0445 152* 131 FORMAT(2X,*ENTE DESIGN VARIABLE FRACTION,FEC.FOR EL.NO.*.14.*. UE 000574 U0445 152* 147.100H 000566 000574		0446	138+	wRITE(12.1117)	000515		
C 2011 143* 00 121 K9751,4 C00525 C C014 141* 121 K97TC(12,116)(EWL(K9,K10],K10_1,4) C00525 C00531 C C024 142* 116 FORMAT(14,10,1) C00541 C00541 C C024 143* C *** GENERATE ELEMENT DATA C00541 C C042 144* WRIE(6,127) D00551 C00551 C C042 144* WRIE(6,127) D00551 C00551 C C043 144* WRIE(6,130) C00551 C00551 C C043 144* WRIE(6,130) C00551 C00551 C C043 144* WRIE(6,130) C00551 C00551 C C043 144* WRIE(6,130) C00550 C00550 C C043 130* READIS,71CCMRID(RGNA,8) C00556 C00556 C C0455 131 FORMAT(22,*ENTER DESIGN VARIABLE FRACTION.FFC.FOR EL.NO.*.14.*. DE C00574 C C0455 152* 131 FORMAT(22,*ENTER DESIGN VARIABLE FRACTION.FFC.FOR EL.NO.*.14.*. DE C00574		ú041u	137*	1117 FORMATI' COMM ELEMENT LOAD MULTIPLIERS FROM COMEM1')	000525		
C0014 1010 121 WRTE(12,116)(EMUL(K9,K10),K10),K10) C00525 U0021 102 116 COMPATIVEDUD C00541 U0022 103 C C COMPATIVEDUD C00541 U0024 1044 WRTE(6,127) 000551 000551 U0026 105 FORMAT(15x,*LEMENT DATA FOR CONST. COUE 1') 000551 U0026 105 FORMAT(12x,*ENTER DATA FOR CONST. COUE 1') 000551 U0026 1047 IX3CCONTONENCENCENCENCENCENCENCENCENCENCENCENCENC	5	63411	143*	UD 121 K9=1,4	<u> </u>		
1 142* 116 FORMATIGETO EDGsul 1 1042: 142* 116 FORMATIGETO ELEMENT DATA EDDSul 1 1042: 144* WRITE(6,127) EDDSul EDDSul 1 004: 150* 127 FORMATIGETO EDDSUL 004: 145* 127 FORMATIGETO EDDSUL 004: 145* 127 FORMATIGETO EDDSUL 004: 146* 127 FORMATIGETO EDDSUL 004: 146* 127 FORMATIGETO EDDSUL 004: 149* 13 FORMATIGETOR FORMATIGETOR EDDUST 004: 149* 13 FORMATIGETOR FORMATIGETOR EDDUST 004: 15: READIS.7: COUNDICKROW, ANTARE FRACTION.FFC.FOR EL.NO.*, 14,*. 0E EDDUST 004: 15: If AULTIL*.* FORMATIGETOR EDDUST 004: 15: If AULTIL*.* EDDUST EDDUST 004: 15: If AUL	2	ÚC414	141*	121 WRITE(12,116)(EMUL(K9,K10),K10=1,4)	000525		•. •
UU423 193* C ** UU424 144* WHITE(6,127) UU424 144* WHITE(6,127) DDSS DDDSS UU426 145* 127 FORMAT(15X,*LEMENT DATA FOR CONST. COUE 1') DDDSS1 UU426 145* 127 FORMAT(15X,*LEMENT DATA FOR CONST. COUE 1') DDDSS1 UU423 147* IXECOMBUT(KOW,1) DDDSS1 DDDSS1 U0435 149* 13p. FORMAT(2x,*ENTER DESIGN VARIABLE NO.,IUV,FOR EL.NO.',IS) DDDS56 U0435 151* WRITE(6,131)1X DDDS56 DDD56 U0445 151* WRITE(6,131)1X DDD574 DDD574 U0445 153* IFAULT1-*' DDD576 DDD574 U0445 154* LLDAT2(KROW,1)=LUAT2(KROW,1)=LUH DDD576 DDD576 UU454 157* IFAULT1-*' UD0576 DD0617 UU455 158* FRAD(15,7)TOUM UD0617 UD0617 UU455 158* FRAD(15,7)TEUDAT2(KROW,1) UD0617 UD0617 UU455 158* <	- 1	<u> </u>	142*	116 FORMAT(4F10.0)	<u> </u>		
LU124 LU124 LU124 LU124 LU124 U025 145* 127 FORMAT[15X,*LLEMENT DATA FOR CONST. COUE 1'] 000551 C0427 146* U0 15C KROM-1LISTOP 000551 C0433 146* WRITELG.L3CD1X 000551 U0435 147* IX=c_QONDIOLRGON,1D 000551 U0435 149* MRITELG.L3CD1X 000550 U0435 149* MRITELG.L3CD1X 000560 U0435 149* MRITELG.L3CD1X 000560 U0442 151* READIS.7.1CODMIDIRRON.B) 000560 U0442 151* WRITELG.L3CD1X VARIABLE FRACTION.FRC.FOR EL.NO.*.14.*. UE COU574 U0444 154* 131 FORMAT(2X.*ENTER DESIGN VARIABLE FRACTION.FRC.FOR EL.NO.*.14.*. UE COU574 U0445 155* IFAULT:1.*' U0455 COU566 U0445 154* 154 154 157* U04574 U0454 157* ELDATZ(KRON.12=LUM U00576 U00576 U0455 158* K	л	00423	145*	C ** GENERALE ELEMENT DATA	000541		
C0420 143 143 001501 000501 C0432 144* 1X=C_QDHDUKROW,11 000551 C0432 144* 1X=C_QDHDUKROW,11 000551 C0432 144* IX=C_QDHDUKROW,11 000551 C0432 149* 13n FORMAT(23,*ENTER DESIGN VARIABLE NO*,10V,FOP EL*NO*',15) 000560 C0431 150± READIS,7LCODHDIKROW.81 000566 000560 U0442 151* WRITE(6,131)1X 000566 000574 U0445 152* 131 FORMAT(23,*ENTER DESIGN VARIABLE FRACTION,FFC,FOR EL_NO,*,14,*, DE C00574 U0445 153* IFAULT:1.*') U00574 000574 U0446 154* LDAT2(KROW,1)=1. U00574 000574 U0451 156* READIS,7DOM 000574 000574 U0451 157* ELDAT2(KROW,1)=004 000574 000574 U0452 156* IF (DUM,NE,3)=ELDAT2(KROW,1)=004 000604 000574 U0451 157* ELDAT2(KROW,2)=00 000617 000617 U0454 157* ELDAT2(KROW,3) 000617 <	<u> </u>	<u> </u>	145*	NETITIONALI			
L0432 147* IX=C_CDHIDIKRGN,1) 000551 _0433 148* wRITEL6,1301;X 000552 U0435 149* INFORMATIC2X,*CNTER DESIGN VARIABLE NO.,IUV,FOP EL.*NO.*,15) 000560 L0437 150* READIS,7ICODHIDIKROV.83 000560 L0443 151* WRITEL6,1311X 000566 L0445 152* 131 FORMATIC2X,*CNTER DESIGN VARIABLE FRACTION,FFC.FOR EL.NO.*,14,*. DE 000574 L0445 152* 131 FORMATIC2X,*CNTER DESIGN VARIABLE FRACTION,FFC.FOR EL.NO.*,14,*. DE 000574 L0445 152* 151* WRITEL6,1311X 000574 L0445 159* ELDATZ(KROW,1)=1. 000574 L0445 155* READIS,710UM 000576 L0447 155* READIS,710UM 000576 L0447 155* READIS,710UM 000576 L0447 157* ELDATZ(KROW,1)=0. 000576 L045* 157* ELDATZ(KROW,1)=1. 000617 L045* 157* ELDATZ(KROW,1)=1. 000617 L045* 159* 132 FORMATIC2A,*ENTER ANGLE BETA FOR EL. NO.*,14,*.		60427	146*		000551		
C0433 148* WRITE(6,130)x 000552 U0435 149* 13n FORMAT(2x,*ENTER DESIGN VARIABLE NO.,1UV,FOR EL.NO.*,15) 000560 U0442 151* WRITE(6,131)1X 000566 U0443 152* 131 FORMAT(2x,*ENTER DESIGN VARIABLE FRACTION,FFC.FOR EL.NO.*,14,*. UE 000566 U0445 152* 131 FORMAT(2x,*ENTER DESIGN VARIABLE FRACTION,FFC.FOR EL.NO.*,14,*. UE 000574 U0445 153* IFAULT=1.* U00574 000574 U0445 154* ILDAT2(KROW,11=1. U00576 U0445 155* READIS,7100UM U00576 U0445 155* IFOUMANE.0.FLDAT2(KROW,12:0. U00576 U0451 157* ELDAT2(KROW,12:0. U00576 U0452 157* ELDAT2(KROW,13:0. U00617 U0453 158* WRITE(5,1331X U00617 U0464 161* WRITE(5,1331X U00617 U0454 162* 133 FORMAT(2x,*ENTER FOR FEL.NO.*,14,*. DEFAULT =1.*) U00617 U0464 161*		60432	147*		000551		
Ú0436 149* 13n FORMAT(22,*ENTER DESIGN VARIABLE N0.*,1UV,FOR EL.N0.*,15) Ú00560 L0442 151* READIS.7.1CODMIDIKROW.81 Ú00566 L0442 151* READIS.7.1CODMIDIKROW.81 Ú00566 L0442 151* READIS.7.1CODMIDIKROW.81 Ú00566 L0445 152* 131 FORMAT(22,*ENTER DESIGN VARIABLE FRACTION,FEC,FOR EL.N0.*,10,*DE G00574 L0445 153* IFAULT1.*) U00574 G00574 L0446 154* LLDAT2(KROW,1)=1. G00574 L0447 155* READIS.7.1DUM G00574 L0447 155* READIS.7.1DUM G00574 L0447 155* READIS.7.1DUM G00574 L0447 155* READIS.7.1ELDAT2(KROW,1)=DUM G00576 L0447 155* HILDAT2(KROW,2)=0. G00610 U0453 158* HRITE(6,132)1% G00617 L0461 160* READIS.7.1ELDAT2(KROW,3) G00617 L0461 160* READIS.7.1ELDAT2(KROW,3) G0053 L0461 160* HEADIS.7.1ELDAT2(KROW,4)=DUM G00625		60433	<u>148</u> *	WRITE(6,130) 1X	_000552		
L0437 L50* READIS,71CODMIDIRROW.8) D00560 U0442 151* WRITE(6,13)1X D00566 L0445 152* 131 F00MAT(2X,*ENTER DESIGN VARIABLE FRACTION,FEC.FOR EL_NO.*,14,*. UE D00574 L0445 153* IFAULT:1*' U00574 U00574 L0447 155* READIS,7100M U00576 L0447 155* READIS,7100M U00576 L0447 155* READIS,7100M U00576 L0452 156* IFI00MNE.0.1ELDAT2(KROW.1]EDUH U00576 L0454 157* ELDAT2(KROW.2)::0. U00576 U0455 158* WRITE(6,132)1x U00610 U0454 157* ELDAT2(KROW.3) U00617 U0455 158* WRITE(6,132)1x U00617 U0461 160* WRITE(6,133)1X U00617 U0464 161* WRITE(6,134)12. U00617 U0464 161* WRITE(6,134)1X U00633 U0464 164* READIS,71EDAT2(KROW.4):=UUH U00633 U0464 164* READIS,71EDUH U00633 <t< td=""><td></td><td>UC436</td><td>149*</td><td>13n FORMAT(2X, "ENTER DESIGN VARIABLE NO., IUV, FOR EL.NO.", IS)</td><td>000560</td><td></td><td></td></t<>		UC436	149*	13n FORMAT(2X, "ENTER DESIGN VARIABLE NO., IUV, FOR EL.NO.", IS)	000560		
U0442 151* WRITE(6,131)1X 000566 L0445 152* 131 FORMAT(2X,*ENTER DESTGN VARIABLE FRACTION,FFG.FOR EL_NO.*.14,*. DE 000574 L0445 153* 1FAULT21.*1 U00574 000574 L0446 154* ELDAT2(KROW,1)=1. 000576 L0447 155* READ(5,7)DUH 000576 (1452 156* IF(0UM,NE.0.FLCAT2(KROW,1)=0. 000576 U0454 157* ELDAT2(KROW,1)=0. 000576 U0455 158* HFIE(5,132)1x 000609 U0454 159* 132 FORMAT(2X,*ENTER ANGLE BETA FOR EL. NO.*,14, 000611 U0451 160* HELOTZ(KROW,3) 000617 000617 U0461 160* HELOTZ(KROW,3) 000617 000617 U0461 160* HELOTZ(KROW,3) 000625 000617 U0461 160* HELOTZ(KROW,4)=1.* 000617 00063 U0461 160* HELOTZ(KROW,4)=1.* 000617 000635 U0471 162* 133 FORMAT(2X,*ENTER FEC FOR EL. NO.*,14,*. DEFAULT =1.*) 000633 U04		60437	15ü*	READ(5.7)CODMID(KROW.8)	000560		
L0445 152* 131 FDEMAT(2X, "ENTER DESIGN VARIABLE FRACTION.FFC.FOR EL.NO.",14,". DE C00574 U0445 153* 1FAULT:1." UD0574 U0446 154* ELDAT2(KROW.1):1. UD0574 U0447 155* READ(5,7)DUM UD0576 (10452 156* IF(DUM.NE.Q.)ELDAT2(KROW.1):UUM UD0576 U045 157* ELDAT2(KROW.2):O. UD0610 U045 158* MRITE(6,132)IX UD0611 U045 160* NERTE(6,132)IX UD0617 U046 160* READ(5,7)ELDAT2(KROW.3) UD0617 U0461 160* NRITE(6,133)IX UD0617 U0464 161* WRITE(6,133)IX UD0625 U0464 161* WRITE(6,133)IX UD0625 U0464 161* WRITE(6,133)IX UD0633 U0464 161* WRITE(6,137)IX UD0625 U0464 161* WRITE(6,137)IX U00633 U0464 164* READ(5,7)DUM U00633 U0471 163* ELDAT2(KROW,4)=UUM U00635 U0474		00442	151*	WRITE(6,131)IX	000566		А.
U0445 153* 1FAULT:1.*) U00574 U0445 154* LLDAT2(KR0W,1):1: U00574 U047 155* READ(5,7)DUM U00576 U0452 156* 1F(DUM:NE_D_IELDAT2(KR0W.1):=UUM U00576 U0455 158* HEIDAT2(KR0W.2):=0. U00610 U0455 158* HRITE(6,132)1x U00611 U0450 159* 132 FORMAT(2X,*ENTER ANGLE BETA FOR EL. NO.*,14) U00617 U0464 160* HRITE(6,133)1X U00617 U00625 U0464 161* WRITE(6,133)1X U00625 U00633 U0464 161* WRITE(6,133)1X U00633 U00633 U0464 161* WRITE(6,134)1X U00633 U00633 U0470 163* ELDAT2(KR0W,4)=1. U00633 U00633 U0471 164* READ(5,7)DUM U00643 U00643 U0474 165* 1F(DUM:NL+0+ELDAT2(KR0W,4)=UUM U00643 U00643 U0474 165* 1F(DM+NL+0+ELDAT2(KR0W,4)=UUM U00643 U00647 U0511 167* 134 <t< td=""><td></td><td>60445</td><td>152*</td><td>131 FORMAT(2X, "ENTER DESIGN VARIABLE FRACTION, FFC, FOR EL, NO, ", 14, ", DE</td><td>600574</td><td></td><td></td></t<>		60445	152*	131 FORMAT(2X, "ENTER DESIGN VARIABLE FRACTION, FFC, FOR EL, NO, ", 14, ", DE	600574		
U0445 154* U0574 U0447 155* READ(5,7)DUM U00576 U0452 156* IF(0UM*NE_0*)ELDAT2(KR0W,1)=DUM U00604 U0453 158* LDAT2(KR0W,2)=0 U00610 U0455 158* LDAT2(KR0W,2)=0 U00611 U0455 158* WRITE(6,132)1x U00617 U0461 160* READ(5,7)ELDAT2(KR0W,3) U00617 U0464 161* WRITE(6,133)1X U00625 U0464 161* WRITE(6,133)1X U00625 U0470 163* ELDAT2(KR0W,4)=1 U00633 U0471 164* READ(5,7)DUM U00635 U0471 164* READ(5,7)DUM U00635 U0474 165* IF(0UM.NE.0.)ELDAT2(KR0W,4)=UUM U00635 U0474 165* IF(0UM.NE.0.)ELDAT2(KR0W,4)=UUM U00643 U0474 165* IF(0UM.NE.0.)ELDAT2(KR0W,4)=UUM U00635 U0531 167* 134 FORMAT(2x,*ENTER STRESS PRINTOUT CODE,KS,FOR EL.NO.*,I4,*. DEFAULT U00655 U0501 168* 1=3*) U00655 U00655		60445	153*	IFAULTEI.")	000574		
C0441 135* READ13; THOM C00510 C0452 156* IF (0UM:NE:0)-IELDAT2(KROW.1)=UUM C00604 C0453 157* ELDAT2(KROW.2)=0. C00610 C0455 158* WRITE(6,132)1x C00611 C0461 160* READ15; TIELDAT2(KROW,3) C00617 C0464 161* WRITE(6,133)1X C00625 C0470 162* 133 FORMAT(2x.*ENTER EFC FOR EL. NO.**IA.*. DEFAULT =1.*') U00633 C0470 163* ELDAT2(KROW,4)=1.* U00633 U00633 C0474 165* IF (0UM.NL-0.*ELDAT2(KROW,4)=UUM U00643 U00647 C0474 165* IF (0UM.NL-0.*ELDAT2(KROW,4)=UUM U00643 U00647 C0501 167* 134 FORHAT(2x.*ENTER STRESS PRINTOUT CODE.*KS.*FOR EL*NO.*,14,*. DEFAULT U00655 U0501 167* 134 FORHAT(00446	155+		<u>UU0574</u>		<u> </u>
L0454 157* ELDAT2(KROW,2)=0. L00610 U0455 158* WRITE(6,132)1x U00611 L0464 159* 132 FORMAT(2X,*ENTER ANGLE BETA FOR EL. NO.*,14) U00617 L0461 160* WRITE(6,132)1x U00617 L0464 161* WRITE(6,133)1X U00625 C0467 162* 133 FORMAT(2X,*ENTER EFC FOR EL. NO.*,14,*. DEFAULT =1.*) U00633 L047L 163* ELDAT2(KROW,4)=1. U00635 L047L 163* ELDAT2(KROW,4)=1. U00635 L0474 165* IF(DUM.NL+0.+IELDAT2(KROW,4)=DUM U00635 L0474 165* IF(DUM.NL+0.+IELDAT2(KROW,4)=DUM U00643 L0476 166* WRITE(6,134)1X U00647 L0551 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE,KS,FOR EL+NO+*,14,** DEFAULT U00655 UD501 168* 1=3*) U00655 U00655 _UD502 167* COMID1KROW,91=3 U00655 U00655 U0503 17J* READ(5,7)1DUM U00657		(1)452	156+	ΠΕΛΟΙΟ,//DUM ΤΕ/ΟΙΜΑ.ΝΕ.Ο.ΙΕΙΠΑΤ2/ΚΡΟΥ.ΙΙΞΟΙΗ	000578		
U0455 158* WRITE(6,132)1x U00611 U0461 160* YEAD(5,7)ELDAT2(MROW,3) U00617 U0461 160* WRITE(6,133)1X U00617 U0464 161* WRITE(6,133)1X U00625 U0467 162* 133 FORMAT(2X,*ENTER EFC FOR EL, N0***Lu*** DEFAULT =1**) U00633 U0474 163* ELDAT2(KROW,*)=1: U00635 U0474 165* IF(DUM*NE*0*)ELDAT2(KROW,*1=UUM U00635 U0474 165* IF(DUM*NE*0*)ELDAT2(KROW,*1=UUM U00643 U0476 166* WRITE(6,134)1X U00643 U0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE*KS*FOR EL*N0***,14*** DEFAULT U00655 U0502 167* COMID(KROW**)=3 U00655 U00655 U0503 170* KEAU(5,7)IDUM U00657	_	60454	157*	ELDATZ(KROW-2)=0.			
L046u 159* 132 FORMAT(2X,*ENTER ANGLE BETA FOR EL+ NO.*,14) UD0617 L0461 160* HEAD(5,7)ELDAT2(HROW,3) 000617 L0464 161* WRITE(6,133)IX U00625 G0467 162* 133 FORMAT(2X,*ENTER EFC FOR EL, NO.**Lu.*, DEFAULT =1.*) U00633 L047u 163* ELDAT2(KROW,4)=1. U00633 L0474 165* IF(DUM.NL+0.)ELDAT2(KROW,4)=UUM U00635 L0474 165* IF(DUM.NL+0.)ELDAT2(KROW,4)=UUM U00635 L0474 165* IF(DUM.NL+0.)ELDAT2(KROW,4)=UUM U00643 L0474 166* WRITE(6,134)1X U00647 U0501 167* 134 FORHAT(2X,*ENTER STRESS PRINTOUT CODE,KS,FOR EL+NO.*,14,*. DEFAULT U00655 U0501 167* 123* COMID(KROW,9)=3 U00655 U0502 169* COMID(KROW,9)=3 U00655 U0503 170* HEAD(5,7)IDUM U00657		00455	158*	WRITE(6,132)1v	000611		
L0461 160* READ(5,7)ELDAT2(NROW,3) Q00617 L0464 161* WRITE(6,133)1X U00625 G0467 162* 133 FORMAT(2X,*ENTER EFC FOR ELNO.**.L4.**_DEFAULT =1.*') U00633 L047L 163* ELDAT2(KROW,+)=1* U00633 L047L 165* ELDAT2(KROW,+)=1* U00633 L047L 165* IF(DUM*NL*0*)ELDAT2(KROW,4)=UUM U00633 L0474 165* IF(DUM*NL*0*)ELDAT2(KROW,4)=UUM U00643 L0476 166* WRITE(6,134)IX U00647 L05J1 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE+KS,FOR EL+NO+*,14,** DEFAULT U00655 U05J1 167* 134 FORMAT (2X,*ENTER STRESS PRINTOUT CODE+KS,FOR EL+NO+*,14,** DEFAULT U00655 U0502 169* CODMID(KROW,9)=3 000655 000655 U0503 170* READ(5,7)IDUM 000657 000657		60460	159*	132 FORMATIZX, "ENTER ANGLE BETA FOR EL. NO.", 14,	000617		
L0464 161* wRITE(6,133)1X L00625 G0467 162* 133 FORMAT(2X,*ENTER EFC FOR EL, NO.**J4,**, DEFAULT =1.*') L00633 L047L 163* ELDAT2(KROW,*)=1. U00633 L047L 164* READ(5,7)DUM U00633 L0474 165* IF(DUM*NL*0.*)ELDAT2(KROW,*)=DUM U00635 L0476 166* WRITE(6,134)1X U00647 L0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE+KS,FOR EL*NO*',14,** DEFAULT U00655 L0501 168* 1=3*) U00655 U00655 L0502 169* CODMID(KROW,9)=3 U00655 U00655 L0503 170* READ(5,7)IDUM U00657	`	60461	160*	READ(5,7)ELDAT2(NROW,3)	000617		
G0467 162* 133 FORMAT(2X,*ENTER EFC FOR EL, NO.**J4,** DEFAULT =1.*) UD0633 L047L 163* ELDAT2(KROW,*)=1* UD0633 L0471 164* READ(5,7)DUM UD0635 L0474 165* IF(DUM*NL*0*)ELDAT2(KROW,*)=DUM UD0643 L0476 166* WRITE(6,134)IX UD0647 U0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE+KS,FOR EL*NO*',14,** DEFAULT UD06455 U0501 168* 1=3*) UD0655 UD0655 U0502 169* CODMID(KROW,9)=3 UD0655 UD0655 U0503 170* READ(5,7)IDUM UD0657		60464	161*	WRITE(6,133)IX	600625		
L0470 163* ELDAT2(KR0W,+1;1* 000633 L0471 164* REAU(5,7)DUM 000635 L0474 165* IF(DUM*NL*0*)ELDAT2(KR0W,4)=DUM 000643 L0476 166* WRITE(6,134)1X 000647 L0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE+KS+FOR EL*NO**,14,** DEFAULT 000655 L0501 168* 1=3*) 000655 L0502 169* CODMID(KR0W+9)=3 000655 L0503 170* READ(5,7)IDUM 000657		60467	162*	133 FORMAT(2X, ENTER EFC FOR EL, NO IA DEFAULT =1)	<u> </u>		
C0371 L037 READIS, F/DUR D00035 L0474 165* IF (DUM.NL+0.)ELDAT2(KROW,4)=DUM G00643 L0476 166* WRITE(6,134)1X G00647 U0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE,KS,FOR EL+NO+*,14,** DEFAULT G00655 G0501 168* 1=3*) U00655 000655 G0502 169* CODMID(KROW,9)=3 000655 000655 G0503 170* READ(5,7)IDUM 000657 000657		60476	1034 T034	ELUATZIKKOWy4121.	000633		
L0476 160 WRITE(6,134)1X 000647 L0501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE,KS,FOR EL+NO+*,14,** DEFAULT 000655 00501 168* 1=3*) 000655 00502 169* CODMID(KROW,9)=3 000655 00503 170* READ(5,7)IDUM 000657		<u>UU471</u>	1.6*		000635		
UD501 167* 134 FORMAT(2X,*ENTER STRESS PRINTOUT CODE,KS,FOR EL+NO+*,14,** DEFAULT UD0055 UD501 168* 1=3*) UD0055 UD502 169* CODMID(KROW,9)=3 000655 UD503 170* READ(5,7)IDUM 000657		LU476	166*		000643 000643		
UD501 168* 1=3*) U0502 169* CODMID(KROW,9)=3 000655 U0503 170* READ(5,7)IDUM 000657		00501	167#	134 FORMAT(2X, "ENTER STRESS PRINTOUT CONF.KS.FOR FL.NO.".14.". DEFAILT	600655	- · · ·	
L0502 167* CODMID(KROW,9):3 000655 L0503 170* READ(5,7)IDUM 000657		<u></u>	<u>168</u> *	1=3*)	<u>UDG655</u>		
000657	_	60502	167*	CODMID(KROW,9):3	000655		
	_	60503	173*	READ(5,7)IDUM	000657		

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. 6050	6 1	71 *		- 1F(IDUM.NE.D)CGDM+D(√ROW.9)=IDUM	Unn665		
0051	<u>Ú</u> 1	72*	150	CONTINUE	UQU673	·····	
0051	2 1	73#		NNCOL1=9	600673		
51ن	3 1	74*		NNCOL2=4	UDD675		
6051	4 1	75*		CALL ELORD(ISTOP,CGDMID,ELDAT2,NNCOL1,NNCOL2)	000677		
0051	4 1	76*	C	PRINT 179	000677		
<u> </u>	4 1	11*	<u> </u>	FORMAT(//' ELEMENT RECORD ON FILE 12, IN QDMEM1'/)	COD677		
0051	5 1	78# 70+		WRITE(12,1135)	606766		
0051	/ 1	19#	1135	FORMATC' COMPLETENENT DATA FROM GOMENT'			
L052	3 1	00÷	100	UU 16U A12-1,15107	000713		
L052	3 1	52 *	100		600723		
6652	3 1	 93≠	C180	WRITE(6.186) (COUMTD(M12.M13).M13=1.8).(FIDAT2(M12.M13).M13=1.4).C	000723		
0052	3 1	84*	C	1(DHID(M12.9)	<u> </u>		
6053	7 1.	85*	186	FORMAT(815,2F1U+0,20X/2F10+0,15,5X)	000755		
UD 54	ũ 1	86*		UO 19U K1=1,ISTOP	000755		
· UD54	3 1	87*	190	IDy31(k1)=CQDHID(k1,8)	000755		
6054	5 1	88*		RETURN	000757		
<u> </u>	<u>6 1</u>	<u>89*</u>		END	001051		
LNU	FUR						
GHUG	1 <u>P</u>	LUME	<u>M2</u>			<u> </u>	
X							
XI							
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SUBROUT	INE GDHEM2 EN	NTRY POINT GOUG64	·····	·····		
STORAGE	USED: CODE(1) C	000732: DATA(0) 005575:	BLANK COMMON(2) 000000	·····	······	
COMMUN	BLOCKC			<u> </u>	<u> </u>	
	5200431			·····		
ម0រូ3 ម0រំ4	BACH 000044 Nozart 000334					
EXTERNA	L REFERENCES (BL	LOCK, NAME)	· · · · · · · · · · · · · · · · · · ·		· · · · · · · · · · · · · · · · · · ·	· • · · · · · ·
ບປັບ 5	CANDP	··				
<u> </u>	FURM2					
<u>0100</u>	PAIR		· · · ·			
0011	ELORD					
	N1025		· · · · · · · · · · · · · · · · · · ·			
<u>014</u>	NADUS			· · · · · · · · · · · · · · · · · · ·		
LUIS JUIS	N1035 N1015					
6017	NERR35				· · · · · · · · · · · · · · · · · · ·	
					· ·	
STORAGE	ASSIGNMENT ADD	DURA TYPEA RELATIVE LUG	A 11 UN NARCE 1	······································		
<u> </u>	005351 111F			<u> </u>	0000 005414 116F	
<u></u>	005472 133F	0000 005505 134F	0000 005527 136F	<u>6001 00067 1456</u>	0001 000076 1526	
ûÜU 1	000210 2156	U001 060217 2226	UJU1 000266 252G	GOD1 GUD273 2566	0001 000301 2636	
<u></u>	<u></u>	0001 00060 3L 0001 000401 3346	<u>0000 005343 300F</u>	0060 005333 3495		
0001	000467 3776	0001 000607 4506	UOC1 000614 4546	0001 CU0620 460G	0001 000641 4706	
-000	365265 SF	0000 005303 501F	0000 005332 504F	G001 GU0103 61L	0001 000110 62L	
<u>UUU1</u> GUUI 1	000231 84L	6000 CL5264 7F 6000 I 601274 CD0M+D	<u>0000 005323 (95F</u> 0000 1 000600 00081	0000 R 005254 00M	0001 000224 85L	·
0000 R	<u>003410 00MMY</u>	LOUD R CO4400 ELDATZ	1000 R 004360 EMUL	0000 I 065256 IDUM	0000 I 003244 INDEX	
- UUU	UUS547 INJPS	6000 I 065242 IX	0060 I 005227 J	0000 I 005225 JJ1	0000 I 005240 J10	
<u>0000 1</u>	005224 VKDF	UUUU 1_UU5243_J12	0000 1 005244 013	0000 I 005232 M	0000 1 005253 KK	
0000	005252 K10	<u>0000_1_005250_K11</u>	U000 I U05245 K6	0000 I 005246 K7	6060 I 005247 K8	
սնսյ I	005251 K9	UOLO I CU2734 MATCH	6064 00000 MAT11	0004 R 000024 HAT12	0060 I 004033 MTPRO1	
<u></u>	0.4103 MTPR02	<u>6000 R 864127 MTPR03</u>	000 I 005255 M1	10000 I 005261 H12	10000 I 004345 NPAP	
<u> </u>	115231 NPID	UUUU I UU5241 NROW	<u>1003 100022 NSTART</u>	0003 I CUOUCO NUM	0000 I 004345 NUMMAT	
υμη Ι	DC3554 PCDM1	LOUD R DU3636 PODM2	UDUR I UD4343 TYPE	UNUD I UU4354 VAR	6000 I 001130 VEID	

	QD	ненг			DATE 073080	PAGE	22
	60103	2*		COMMON BACH/NUM(18) NSTART(18)/MOZART/WAT11(20) - WAT12(20.10)	նորող		
	<u>U0103</u>	3*	C **	CHANGE GROUPA NO. OF DESAP PLANE STRESS QUADRIATED STRESS CHANASTRAN	000000		
	60103	4.*	C ++	CUADATIATERAL MEMBRANESCONSTRUCTION CODE 2	000000		
	60104	5*	•	INTEGER CQD+1(100+6) . VEID(100) . CODHID(100-8) . MATCH(100-2) . INDEX(10	000000		
	00104	6*		10)	00000		
	60105	7 +		DIMENSION DUMMY(100,1)	000000		
	0105	8*	C **	CHANGE GROUP. NO. OF PID'S	000000		
	60106	9*		INTEGER PQDM1(25,2)	000000		
	00107	<u>+11</u> +		UIHENSION PQUHZ(25,5)	000000	-	
	60107	11*	C **	CHANGE GROUP. NO. OF MID.S	000000		
	<u> </u>	12*		DIMENSION MTPRO1(20,2)	000000		
	00111	13*		REAL MTPRO2(2D), MTPRO3(2G,7)	000000		
		14#	<u> </u>	CHANGE GROUP. NO. OF DESIGN VARIABLES	000000		
	L0112	15+		DIMENSION IDV32(50)	000000		
	00112	16*	. (**	**********	000000		
	00113	1/*		INTEGER KOAD(2), TYPE(2), NPAR(7), VAR(4)	000000		
	<u> </u>	18*		DIMENSION_EMUL(4,4),ELDAT2(100,4),DUMM(4)	000000		
	00115	10±		REAL MATIZ	000000		
		2U#		DATA VARY'A', 'B', 'C', D'/TYPE/'QUADHE', 'H	000000		
	10122	214	1	FORMATE J	606000		
	10124	224			000000		
	10125	234		CALL CANDY (KNDE, NON/, NON/4, C4DH1, DUNNY, P4DH1, P4DH2)			
	<u> </u>	24#	£	NK111(0)31	000012		
	10126	25+	5	FORMATICA, "FLANE SIRESS QUADRILATERAL QUAD. HENBRANE IN NASTRANI,	000017		
<u> </u>	00120	27*			<u> </u>		
2	60130	28#		ND AD (1) - 5	000017		
2 5	60131	29#		NDAR(2)-NO(1)	<u>U00021</u>		
4	60132	3:1#			000025		
n —	60133	31#		NUM7=NUM(7)	000027	<u> </u>	
~	UD134	32*		ISTOP=NUM7	600030		
	60135	33*		JJ1=2	600031		
	L0136	34*		IF (NKOUE . EQ. 1) GU TO 3	000032		
	60140	35*		CALL FURM2(JJ1,KOAD,TYPE,NPAR(2),VEID_NUM7)	000034		
	00141	<u></u>		ISTOP=NPAR(2)	000044		•
	60142	37≠		NNCOL=6	606046		
	00143	38*		CALL STORIISTOP, NUM7, CQDK1, VEID, NNCOL)	000050		
	60144	39×	3	DO 70 J=1,ISTOP	000060		
	60147	40*		NEID=CQDH1(J,1)	000067		
	60156	41*		NPID=CQDM1(J,2)	000071		
	<u> </u>	42*	<u> </u>	FIND PGDM1 CARD WITH SAME ID	000071		
	L0151	43*		D0 65 K=1,NUM14	000076		
	60154	44*		IF (NPID, E0, PCDM1(K, 1))GO TO 61	UCU076		
	LU156	45*		60 10 65	000101		
~		40#	61		000103		<u> </u>
	00160	4/#			000104		
	00161	487			606110		
	60163	49# 50#	62		000110		
	00404						
	00100	⇒ 5.7 ±		CODATO(1)+-CODAT(1)+1	000114		
	(0167	<u> </u>					
	0170	54#			000120		
	<u> </u>	55*	7.1				
	00171	56*	C **	FIND NUMMAT AND MATCH	(00120		
	U0173	57*		KKODET J	CO0126		
	L0174	58*		KKOLEG	00127		

QU	MEM2		DATE U73n8µ	PAGE	3
60175	59#	CALL PATRIKKODF - CODMID. PODMIATSTOPANUMIR. KKCL. NUMMATAMATCHAINDEX)	000131		
<u></u> ដ0176	6.7*		000144		
00177	6 1 ≠	WRITE(6+501)	000146		
60201	62*	501 FORMATIZX, "ENTER CODE FOR INCOMPATIBLE DISPL. MODES: D MEANS USE T	000153		
60201	63*	IHEM: 1 MEANS DO NOT USE THEM *)	000153		
00202	64+	READ(5,7)NPAR(6)	606153		
00205	65*	<u>write(12,795)</u>	600161		
00207	o6*	795 FORMAT(COMM ELEMENT CONTROL FROM QDMEM2)	000166		
0210	67*	write(12,504)(NPAR(J11),J11=1,6)	600166		
60213	68*	SU4 FORMAI(615)	000210		
<u> </u>	70+	L TT SET UP TATENAL PROFEMILES DATA	000210	· · · · · ·	
60217	71#		600210		
<u><u> </u></u>	72*	MTPR01(J10.2)=1	000212		
60221	73×	DO 84 J11=1.NUMMAT	000217		
L0224	74 *	IF (MATCH (J11,1), EQ, INDEX (J10)) GO TO 85	600217		
<u> </u>	75*	60 TO 84	<u> 0nn222</u>	·	
00227	76*	85 NROW=MATCH(J11,2)	UÖÖ224		
<u> </u>	<u> </u>	<u>bo To 86</u>	000225		·
UC231	78*	84 CONTINUE	000231		
60233	<u> </u>	86 MTPRO2(J1D)=HAT12(NROH, 4)*CONFAC	000231		
LU234 (D234	8U¥		. 000234		
<u> </u>	<u>814</u>				
00230	027		000237		
<u> </u>	<u> </u>	MTPR03(J101-5)=M112(NR04-8)	000242		
LJ241	85*	MTPP0+(JID+4)=MAT12(NROW-9)	U00244		
00242	86#	MTPR03(J10,7)=MAT12(NRON,14)	600246		
00243	87*	IX_INDEX(JIG)	000250		
U0244	88*	83 CONTINUE	600254		
00244	89*	C ** MATERIAL PROPERTIES DATA IS DONE	600254	·	
60246	90+	WRITE(12,349)	000254		
60256	<u></u>	349 FORMATIV COMM MATERIAL PROPERTIES FROM ODMEM2*)		·····	
00251	727		000266		
60234	934	350 WHITE12:300/MIPROII312:3137:313-142/4MIPRO2I3127:4MIPRO3I312:313	000266		
60276	95#	300 - FORMATI215 - F10-3/2F10-8 - F10-3-4F10-0)	600314		
L0270	96*		600314		
10271	97*	WRITE (6,111)	000314		
U0273	98÷	111 FORMATIIUX, "LLEMENT LOAD MULTIPLIERS FOR CONST. CODE 2")	U00325	· · · · · · · · · · · · · · · · · · ·	
00274	. <u>99</u> *	UO 115 K6=1.4	000325		
00277	100*	DO 115 K7=1,5	000325		
60302	101*	115 EMUL(K6,K7)-0,			
00305	162*	UO 120 K8=1,4	600335		
	<u>1⊔3</u> ♥ 1.:uw	HEILEDTIZZYARYKSI 112 FODMATIZY (FOD LAAD V ALV ENTED DECSIDE AND V.V.Z FILMENT LOAD F	<u> </u>		
- 60313	105#	THE FORMATIZATION COAD TALL ENTER THE SOME AND ATTAL ELEMENT COAD T	600346		
60314	1.6*	REAU(5,7)(DUMM(K11),K11=1-4)	1:00346		
00317	107*	IF(DUMM(1).E.V.U.)00 10 120	000356		
60321	108*	D0 113 K11=2,5	00365		
<u>სი 324</u>	107*	113 EMUL(K8,K11)=DUMM(K11)	COU365		
L0326	11)*	120 CONTINUE	600371		
60330	111#		000371		
UU332	1124	III/ FURMATET COMM ELEMENT LUAU MULTIPLIERS FROM GDMEMZT)	600401		
<u> </u>	114#	121	000401		
- r.n.345	115#	164 - MMI (SI 2010) CHUCHTINI (MICINI) 116 - FORMAT (SE 10)	000401		

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<u>401</u>	4EH2		DATE 073080	PAGE	4
LD345	116#	C ** GENERATE ELEMENT DATA	000415		
60346	117#	WRITE(6,127)	000415		
6035 ₁₁	118*	127 FORMAT(15X, ELEMENT DATA FOR CONST. CODE 2")	000426		
00351	119*	DO 15D KROW_1,ISTOP	000426		
00354	120*	IX=CGDHID(KROy,1)	<u> </u>		
00355	121*	WRITE(6,130) IX	000427		
00360	1224	130 FORMATIZZ, 'ENTER DESIGN VARIABLE NO., IDV, FOR EL. NO.', 151			
00361	1244	KEAU(5)7764DTD(KROW)77			
00367	125#	131 FORMATICS INTER DESIGN VARIABLE FRACTION FRC. FOR FL. NO	000445		
Ú0367	126*	1 DEFAULTE1."	000451		
60376	127*		000451		
60371	128*	READ(5,7)DUH	660453		
60374	129*	IF (DUM.NE.O. JELDAT2(KROW, 1)=DUM	600461		
60376	13 0 ≠	DO 145 H1=2,4	000467		
00401	131*	145 ELDAT2(KROW, M1)=0.	000467		
60403	132*	<u>urite(6,132)IX</u>	000470		
00406	133*	132 FORMAT(2X, 'ENTER COMP. FORCE/UNIT LENGTH APPLIED TO SIDE 1-2 OF EL	000476	. –	
60406	134*	1.NO.*,14,*. DEFAULT=0.*)	000476		
60407	135*	READ(5,7)DUM	000476		
0412	136*	IF(DUM_NE_D_)ELDAT2(KROW,3)=DUM	<u> </u>		<u> </u>
60414	137*	WRITE(6,133)IX	000510		
00417	138*	133 FORMATI2X, 'ENTER THE ANGLE BETA FOR EL. NO. ', 14. '. DEFAULTED.')	000516		
60420	139#	HEAD(S+/JDUH	000516		
<u>UC423</u>	1417		000524		
00420 (8430	1424	HALLEGIJJYJA 130 - Formatijy Jented Stdess odiniont ander ve end elling teleto. Jented Stdess	000530		
UC430	143*	11=3)	000536		
00431	144*	CCDM1D(KROW.6)-3	000536		
60432	145*	READ(5,7)IDUH	L0C540		
Ln435	146*	IF(I1UH.NE.O)CQDHID(KROW.8)=IDUM	000546		
LU437	147#	150 CONTINUE	000557		
60441	148#	NNCOL 1 = 7	000557		
60442	149*	NNCOL2=4	000561		
60443	150*	CALL ELORD(ISTOP,CQDHID,ELUAT2,NNCOL1,NNCOL2)	000563		
00443	151*	C PRINT 179	000563		
60443	152*	C179 FORMAT(//' ELEMENT DATA RECORD ON FILE 12, IN ODMENT?/)	000563		
60444	153*	WRITE(12,1135)	000572		
00446	154*	1135 FORMATI COMM ELEMENT DATA FROM QDMEM2"	000577		
60447	155*	UU 180 M12=1,1540P	000577		
00452	156*	1011 WRITELIZ:136)(COUMLU(MIZ:MI3=1,7),(ELDAT2(MIZ:MI3),MI3=1,4).C			
00452	15/7	1908101812187 [190 _01771_124]/0000000101912 0121 012-1 21 75101230013 0125 0125 012 0	600407		
LUT22	152*			×	
10452	161ì±	• INUTIONIZION 136 FORMAT(7)5-FE-00-3F10-0-T5-551	((D0607		
1.0467	161#		UD6641		
66472	162#	1911 IDV32(K1)=CODMID(K1 7)	000641		
60474	163*	RETURN	600643		
6.0475	164*	END	000731		
END FOR					
	<i>t</i> : T				
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	LU101	1 *	SUBROUTINE GILCONFAC.NKODE.IUVS.NCTOT)	000000
	60103	2*	COMMON/BACH/NUM(18).NSTART(18)/MOZART/MAT11(20).MAT12(20.1n)	606000
	66103	3*	C ** CHANGE GROUP, NO. OF PLATE QUADRILATERALS ANU/OR PLATE TRIANGLES	000000
	00104	4 \$	INTEGER COULDIGIO.6).CTRI(100.5).COTID(100.7).HATCH(100.2).INDEX(1	00000
	00104	5+	1(100).C011(100.6).C012(100.1)	00000
	60105	6*	DIMENSION COUND2(1GC.1).CTRI2(100.1).ELDAT2(100.6)	r.nc.nun
	60105	7*	C ** CHANGE GROUP. NO. OF PID'S	
	00106	8.*	INTEGER POUAU1(25.2).P(R11(25.2).P0(1)(25.2)	60000
	60107	9*	DIMENSION POUND2125.21.PUR12125.21.POT2125.21	00000
	60107	111#		00000
	00101	11#		00000
	60111	12#	RFAL MIPRO2420-11-MIPRO3(20-7)	000000
	00111	134		000000
	(6112	14.	DIMENSION TOYSES	000000
	60112	15#		000000
	60113	16*	DTHENSTON NPARISISEMUL(5.4).VAR(4)	000000
	00114) 7 #		000000
	00115	.8 #		000000
_	00117	19#	7 FORMAT ()	00000
	60120	20±		600000
	10121	21+		C00001
	60122	22*	NiH 7-NiH (17)	000001
	60123	23#		
	60124	24#		660007
	00125	25.*		000011
X	60126	26*		000013
\times	LIC127	21#		000015
X	60136	28×	IF (NUM9.NE.D) CALL CANDP(KKDE.NUM9.NUM16.CQUAD1.CQUAD2.PGUAD1.PQUA	600017
$\overline{1}$	60136	294	102)	000017
5	U0132	30*	KKDE=1u	600032
	66133	31#	IF(NUMID-NE-G)CALL CANDP(KKDE,NUM10,NUM17,CTRI1,CTRI2,PTRI1,PTRI2)	600034
	60135	32*	IF (NUM9-FC-L)GO TO 40	000052
	60137	33*	00 25 LR=1.NUM9	000054
	00142	34 *	U0 25 LC=1.6	000063
	60145	35×	25 CGT1(LR,LC)=CQUAD1(LR,LC)	000063
_	60150	36*	U0 26 LR=1,NUM9	<u>COB074</u>
	60153	37*	26 CQT2(LR,1)=CQUAD2(LR,1)	000074
	60155	38*	UO 27 LR=1,NUM16	000107
	C0160	39×	00 27 LC=1,2	000107
	<u> </u>	4 <u>0</u> ÷	POTI(LR.LC)=PQUAD1(LR.LC)	000107
	00164	41*	27 PGT2(LR,LC)=PQUAU2(LR,LC)	600110
	60167	42*		
	60171	43≠	ISTARC=NUM9+1	000121
	<u> </u>	44*		
	69173	45*		
	60176	40*		000156
	60201	474		600177
	60204	40*		
	60207	497≁ (D±		100173 100173
	60214	51#	33 (012110):1-7102110-MUM0 11	<u> </u>
	6216	52±		000320
	<u> </u>	<u> </u>		000220
	60224	54×		cn0228
	00225	55*	34 POT2(LR-LC)=PTK12(LR-NUM16.LC)	600221
	60225	56*		600221
				<u></u>

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_	<u> </u>				DATE 673080	PAGE	3
	U0225	57¢	C 3 0	FORMATLY COTI AND POTL ARRAY IN QT*)	000221		
	UC225	58¢	C	UO 36 I=1.NCTOT	000221		
	60225	59*	C36	PRINT 35 (COT1(I.J).J=1.6).(PGT1(I.J).J=1.2)	000221		
_	60225	60*	C 3 5	FORMAT(615,215)	000221		
	60230	61*	50	NKODE=1	006234		
. –	60230	62*	C **	THERE IS ONLY UNE CONST. CODE FOR THIS ELEMENT	600234		
	L0231	63≠		NPAR (1)=6			
	60232	04#		NPAR (2)=NCTOT	600237		
	6.0235	65¥		NPAR (4)=1	000241		
_	60234	66*		NPAR (5)=1	000242		
	u0235	67×		DO. 7E J=1.NC101	000252		
	Cn24	68*		$NEID=_{CV}T1(U,1)$	000252		-
_	60241	<u> </u>		NPID=CQT1(J,2)	000254		
	00242	73*		00 65 K=1,NPTOT	000261		
	LDZ45	71*		$IF(NPID_{*}EQ_{*}PGT1(K_{*}))GQ_{*}TO_{*}G1$			
	60247	72*		GO TO 65	000264		
	60250	73*		<u>KK=K</u>	000266		
	L0251	74≠		GO TO 62	000267		
	60252				000273		
	L0254	76*	67	CQTID(J,1)=NEID	600273		
	LU255	77*		COTID(J,2)=COTI(J,3)	000275		
	6.250	78≠		CQTID(J.3)=CQTI(J.4)	000277		
	00257	79≠		COTID(J,4)=CUT1(J,5)	600301		
	00260	\$ 0 ≠		C_{1}	606303		
	60261	81*		CQTIU(J,6)=PUT1(KK.2)			
	60262	82×	70	CONTINUE	000311		
X	L0262	63¥	С	PRINT 71	000311		
<u> </u>	6r 262	84≠	C71	FORMAT(CLTID ARRAY IN GT JUST BEFORE GOING TO PAIR */)	000311		
<u> </u>	00262	65¥	C	UG 72 1=1.NCTOT	000311		
1	60262	86*	C72	PRINT 73, (CUTID(1,J),J=1,6)	600311		
58 _	L0262	67*	<u> </u>	FORMAT(615)	000311		
	L0262	68×	C **	FIND NUMMAT AND MATCH	L00311		
	00264	67*		KKOLE=ù		· · · · · · · · · · · · · · · · · · ·	
	L0265	¢0,		KKOL=6	000312		
	L0266	<u>91#</u>		CALL PAIRIKKODE.COIID.POII.NCTOT.NUMIB.KKOL.NUMHAT.MATCH.INDEX)	606314		
	60267	92+		NPAR (3) = NUMMAT	000327		
	<u>0027ú</u>	<u> </u>		WpItt(12,795)	<u> </u>		. <u></u>
	60272	94 \$	795	FORMAT(COMM ELEMENT CONTROL FROM QT)	000336		
	60273	55*		WRITE(12,504)(NPAR(.111),111=1.5)			
	60276	96*	564	FORMAT(515)	606360		
	60276	91*	<u> </u>	SET UP MATERIAL PROPERTIES DATA	000360		
	60277	88 4		UO 63 JIU=1,NUHMAT	600360		
_	<u> </u>		<u></u>	<u>MTPRO1(J10.1)-INDEX(J10)</u>	<u>000360</u>		
	00303	160*		HTPR01(J13,2)=1	000362		
	<u>Lo3o4</u>	11.1*		00 64 J11=1.NUMMAT			
	üÜ3Ü7	162+		IF(MATCH(J11,1).EQ.INDEX(J10))60 TO 85	000367		
	<u>ue311</u>	143*		<u> </u>			
	60312	164*	85	NROWEMATCH(J11,2)	008374		
_	60313	105*		<u>60 10 86</u>	<u>600375</u>		
	00314	166*	84	CONTINUÉ	600401		
	60316	107#	86	MIPRG2(J1C)=MAT12(NROW,4)*CONFAC	600401		
	00317	168*		HTPR(3(J10,1)=0.	600404		
_	60326	149*		MTPR03(J10,2)=MAT12(NR0H,1)	000405		
	60321	110*		MTPR03(J17,3)=MAT12(NROW,3)	000407		
-	00322	<u> 111+ </u>		MTPR031J10.41=0.	000411		
-	ŰC323	112#		MTPRU3(J10,5)=MAT12(NRUW,8)	000412		
	<u> </u>	<u>113</u> ≠		MTPR03(J14.6)=MAT12/NPON.9)	µ00414		

U0125 11** PHEPOSITION 0000*0 U0136 115* 12*POSITION 000*0 U0137 116* 63 CONTINUE 000*0 U0131 116* 63 CONTINUE 000*0 U0131 116* 63 CONTINUE 000*0 U0131 116* 34 CONTINUE 000*0 U0131 116* 35 PATICIAL PROPERTIES FROM OF*1 000*0 U0131 114* 100 FROM OF*0 000*0 U0133 114* CONTINUE CONTINUE 000*0 U0133 124* CONTINUE CONTINUE 000*0 U0133 124* CONTINUE CONTINUE 000*0 U0133 124* CONTINUE CONTINUE 0000*0 U0134		<u> </u>			DATE 073080	PAGE	4
0036 115* 11:1:NUC: NICE 000000 0037 116* 63 000000 000000 0037 117* 0************************************		40325	114+	MTPR03(J10.7)=HAT12(NROW.10)	000416		
C0227 C0227 C0227 C0227 C0227 C0227 C0227 C0224 C0224 C0224 C0221 C0224 C0224 C0224 C0221 Str C0224 C0224 C0222 Str Str C0224 C0224 C0222 C224 Str C0224 C0224 C0222 C224 Str Str C0224 C0224		<u> </u>	115#		000420		
Colst 11* C ** FARTERIAL PROPERTIES DATA IS ONE 000024 Colst 114* Safield Lass		00327	116*	83 CONTINUE	000424		
c.331 114* VPT[f112,142] 00022 c.0313 119* 30* 00034 00034 00313 110* 30* 00034 00034 00313 124* 110* 00034 00034 00313 124* 110* 00034 00034 00313 124* 110* 00044 00044 00313 124* 110* 00044 00044 00313 124* 10* 010* 00044 00314 124* 10* 010* 00044 00315 124* 00* 011* 00* 000475 00316 124* 00* 110* 0001* 000475 00316 124* 10* 0011* 0001* 000475 00317 124* 0011* 001* 000475 00015 00316 124* 110* 0001* 000475 000475 00317 124* 110* 0001*		60327	117+	C ++ MATERIAL PROPERTIES DATA IS DONE	000424		
00333 119* 347 FORMATI' COME ANTERIAL PROPERTIES FROM 07'1 00036 00331 112* 00 Jis. Jis. Jis. Jis. Jis. Jis. Jis. Jis.		60331	118*	WRITE(12,349)	000424	<u> </u>	
0032 122 0035 1221 NUMBER 00331 121 350 PRILIZING (NEPROLU12)131)13121, MTPRO2101211 000044 00331 123 350 FORMATIZING, NEPROLU12105		60333	119*	349 FORHAT(* COMM MATERIAL PROPERTIES FROM QT*)	600436		
U0337 121* 350 FAILT12;500 147:601032;410.001 000045 U0335 125* 130 FORMALT 121:401.000 000044 U0335 125* 130 FORMALT 121:401.000 000044 U0335 125* 130 FORMALT 110 000044 U0335 125* WHITE(5,111) 0000475 0000475 U0335 126* 00115 0000475 0000475 U0335 126* 00115 0000475 0000475 U0335 130* 00125 0000506 0000475 U0335 131* #FILL(12,12,120,120,100,100,100,100,100,100,10		60334	120*	Do 350 J12=1,NUMMAT	000436		
U0321 U24 U24 <thu24< th=""> <thu24< td="" th<=""><td>00337</td><td>121*</td><td>350 WRITE(12,300)(MTPROI(J12,J13),J13=1,2),MTPRO2(J12),(MTPRO3(J12,J13</td><td>000436</td><td></td><td></td></thu24<></thu24<>		00337	121*	350 WRITE(12,300)(MTPROI(J12,J13),J13=1,2),MTPRO2(J12),(MTPRO3(J12,J13	000436		
U0333 12** Cover Fetters (Control Control Con		00357	122*	$11_{1}_{1}_{1}_{1}_{1}_{1}_{1}_{1}_{1}_{$		·	
0155 125 0 02144 000444 0155 126 11 FORMATIESA*(ELEMENT LOAD MULTIPLIERS') 000475 0155 127 00 115 KEILS 000075 0155 127 00 115 KEILS 000075 0155 127 00 115 KEILS 000075 0151 127 00 115 KEILS 000075 0151 127 115 EAULINS, KILLS 000075 0151 127 127 115 EAULINS, KILLS 000051 0151 127 127 115 EAULINS, KILLS 0000524 0151 138 11 EAULINS, KOLMA 0000524 02407 138 115 EAULINS, KOLMA 0000524 0241 138 EAULINS, KOLMA 0000524 0000524 0241 139 EAULINS, KOLMA 0000524 0000524 0241 139 EAULINS, KOLMA 0000530 00005		00353	124+	C at GENEVATE FIFMENT LOAD MINITERTERS	000464		
C3356 111 FormAritist, ittement LOAD MULTIPLIERS') C00475 C0357 127 00 15 KC1 C00475 C0352 128 00 15 KC1 C00475 C0353 139 0 15 KC1 C0057 C0057 C0353 131 0 124 KC1 KC1 KC1 C0057 C0353 131 0 124 KC1 KC2 KC2 <td></td> <td>10354</td> <td>125*</td> <td></td> <td>000464</td> <td></td> <td></td>		10354	125*		000464		
C0357 127* U0 115 Kr21/4 C000K75 C0353 128* U0 115 Kr21/4 C000K75 C0313 1314 00 120 Kr21/4 C000K75 C0313 1314 00 120 Kr21/4 C000K75 C0313 1314 00 120 Kr21/4 C000K75 C0313 1314 00 120 Kr21/4 C000K75 C0317 1324 PATELS/112/4/KR41 EFECSURE AND X-X-2 FIFER C00051 C0317 1324 FEAD(5.7100/L100K2.000K3.000K4.000K3.000K1.000K2.000K3.000K1.000K2.000K3.000K1.000K2.000K3.000K1.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.000K2.000K3.0000K3.0000K3.000K3.000K3.000K3.0000K3.000K3.000K3.000K3.0000K3.00		60356	126*	111 FORMAT(15X, 'ELEMENT LOAD MULTIPLIERS')	000475		
60362 128 00 115 PATA 000075 00370 139 D0 120 MARIA 000075 00370 139 D0 120 MARIA 000075 00370 139 D0 120 MARIA 000000 00370 139 D0 120 MARIA 000000 00371 D0 120 MARIA 000000 000000 00371 D0 120 MARIA 0000000 000000 00305 135 Iftuming 200000 000000000000000000000000000000000000		00357	127*	UO 115 K6=1,5	000475		
C0355 115 ENULING, K7150. C00475 C0373 131* WRITE(6,1)21VAR(KR) C00506 C0374 132* WRITE(6,1)21VAR(KR) C00506 C0375 133* IT LOAD FRACTIONS, IN THAT ORDER, DEFAULT= ALL ZERGS'I C00513 C0376 133* IT LOAD FRACTIONS, IN THAT ORDER, DEFAULT= ALL ZERGS'I C00513 C0376 133* IT LOAD FRACTIONS, IN THAT ORDER, DEFAULT= ALL ZERGS'I C00513 C0316 133* IT LOAD FRACTIONS, IN THAT ORDER, DEFAULT= ALL ZERGS'I C00513 C0317 139* IHULIZZONAL DURZA C00404 C0410 139* IHULIZZONAL DURZA C00536 C0411 139* IHULIZKEDINI C00531 C0411 139* IHULIZKEDINI C00531 C0411 VE VICE SKRIDOWA C00531 C0411 VICE SKRIDOWA C00531 <td></td> <td>00362</td> <td>128*</td> <td>DO 115 K7=1,4</td> <td>000475</td> <td></td> <td></td>		00362	128*	DO 115 K7=1,4	000475		
L037U 130* 00 120 Kg214 100 L037U 131* 112 FORMATIZATION LOAD. TARTY ENTER LATERAL PRESSURE AND XATZ ELEMEN 00006 L037U 132* 112 FORMATIZATION LOAD. TARTY ENTER LATERAL PRESSURE AND XATZ ELEMEN 000054 L037U 133* 11 FLOWILGY ON LOAD. TARTY OF CAULT ALL ZEROS') 0000513 L037U 135* 1 FLUWILGY ON LOAD. TARTY OF CAULT ALL ZEROS') 000053 L0340 135* 1 FLUWILGY ON LOAD. TARTY OF CAULT ALL ZEROS') 000054 L0440 135* 1 FLUWILGY ON LOAD. 000054 L0441 135* FLUUTILGY ON LOAD. 0000530 L0441 135* FLUUTILGY ON LOAD. 0000530 L0441 135* FLUUTILGY ON LOAD. 000054 L0441 135* FLUUTILGY ON LOAD. 000054 L0441 140* 1111 FORMATICY ON LOAD. 000551 L0441 140* 1111 FORMATICY ON LOAD. 000551 L0441 140* 111 FORMATICY ON LOAD. 000565 L0441 140* FREMATICY FORMATICY FORMATICY FO		00365	129#	115 EHUL(K6+K7)=ù.	000475		
C0313 1314 PHILLS, 112/VARIAN CHIER LATERAL PRESSURE AND X-Y-2 FLEMEN CO0051 C0316 138 IT LOAD FRACTIONS, IN THAT COMES, DEFAULT= ALL ZEROS") CO00513 CO00514 C0316 138 IT LOAD FRACTIONS, IN THAT COMES, DEFAULT= ALL ZEROS") CO00514 C0316 138 IT LOAD FRACTIONS, IN THAT COMES, DEFAULT= ALL ZEROS") CO00514 C0316 138 IT LOAD FRACTIONS, IN THAT COMES, DEFAULT= ALL ZEROS") CO00514 C0417 138 IPULLIA, RAIDONA CO00530 C0411 139 ENULIA, RAIDONA CO00534 C0411 140 ITI CONTINUE CO00541 C0411 140 ITI FORMATIC COMMENTALINES FROM QT1 CO00541 C0411 141 FORMATICA, FERDER FROM QT1 CO00541 C0412 143 ITI FORMATICA, FERDER FROM QT1 CO00545 C0411 144	·	00370	130#	<u>D0 120 K6=1,4</u>	<u>C00506</u>		
L1215 122 122 122 122 124 <td< td=""><td></td><td>60373</td><td>131*</td><td>WRITE(6,112)VAR(K8)</td><td>000506</td><td></td><td></td></td<>		60373	131*	WRITE(6,112)VAR(K8)	000506		
00310 1334 AT LONG THE LINES, MAR JOINT OUR OF ALL ZERS T 000331 00401 1344 AT LONG THE LINES, DURA DURA DURA OF ALL ZERS T 000324 00401 1344 IFLUMILED 0.160 f0 120 000524 00401 1344 IFLUMILED 0.160 f0 120 000524 00401 1344 FRUL(4, NALEDURAL 000530 00411 1344 FRUL(4, NALEDURAL 000534 00413 1404 120 CONTINUE 000534 00413 1404 121 CONTINUE 000541 00413 1404 121 CONTINUE 000541 00413 1404 121 NOTE (21117) 000541 00413 1404 121 NOTE (21150) 000551 00413 1404 124 NOTE (21160, 0) 000555 00423 1444 121 NOTE (21160, 0) 000555 00415 146 127 PORMATIEX, CLENED ATAT 000555 00424 1454 127 PORMATIEX, CLENED ATAT 000555 00415 1494 127 PORMATIEX, CLENED ATAT		<u> </u>	177*	112 FURNALIZA, FUR LUAU (ATT, ENTER LATERAL PRESSURE AND ATTAC FIFMEN			
00:00:00:10:00:00:00:00:00:00:00:00:00:0		00378	1334	DEADERACTIONS, IN THAT ORDERA DEFAULT- ALL ZERUSTA	000513		
C0007 135* IMULIARSEQUAL CONSTR C0410 137* EMULIARSEQUAL C00530 C0411 138* EMULIARSEQUAL C00534 C0411 138* EMULIARSEQUAL C00534 C0411 139* EMULIARSEQUAL C00534 C0411 140* L04117 C00541 C0412 142* C04117 C0411 C0413 142* MITFC12,11171 C00551 C0423 L44* C14 MITFC12,11171 C00551 C0423 L44* C14 MITFC12,11171 C00551 C0423 L44* C14 MITFC12,11171 C00551 C0424 L44* C14 MITFC12,11171 C00551 C0425 L44* C21 WITFC12,11171 C00551 C0421 L44* L21 WITFC12,11171 C00551 C0421 L44* L21 WITFC12,11171 C00555 C0421 L44* L21 WITFC12,11171 C00555 <td></td> <td>00405</td> <td>135#</td> <td></td> <td>000524</td> <td></td> <td></td>		00405	135#		000524		
L0+1u 137* EMUL (3, KB)=DUM2 000530 L0+1u 138* EMUL (4, KB)=DUM3 000532 00+11 139* EMUL (5, KB)=DUM4 000534 00+11 140* WRITE(12, 1117) 000534 00+11 141* WRITE(12, 1117) 000534 00+11 142* WRITE(12, 1117) 000551 00+20 143* 00-121 K9=1, 5 000551 00+32 144* 00-121 K9=1, 5 000551 00+32 144* 101 FORMAT(14, 10, 410, 11, 14) 000565 00+32 145* 116 FORMAT(14, 10, 410, 11, 14) 000565 00+32 145* 116 FORMAT(14, 10, 410, 11, 14) 000575 00+33 14* WRITE(6, 13, 7) CTIO 000575 00+34 150* 127 FORMAT(14, 27, 14, 14, 14, 14, 14, 14, 14, 14, 14, 14		60407	136#		GD0526		
I.u.11 138* FHUL14,KR150UH3 G00532 GU415 140* 120 GU415 140* 000534 QU415 140* 120 GU417 120 GU415 140* 000534 UC417 142* 1117 FORMATI* COMM ELEMENT Loan MULTIPLIERS FROM 61* G00551 G00551 UC423 144* 121 WRITE(12,116)(HMULKS,KLD),KAGE1,4) G00555 G00555 UC423 144* 121 WRITE(12,116)(HMULKS,KLD),KAGE1,4) G00555 G00555 UC423 144* 127 FORMATILS,*(ELEMENT DATA*) G00555 G00555 UC433 147* WRITE(6,127) G00555 G00455 G00575 UC433 148* 127 FORMATILS,*(ELEMENT DATA*) G00575 G00575 UC441 150* WRITE(6,130)1X G00575 G00575 G00575 UC443 152* 130 FORMATICS,*ENTER DESIGN VARIABLE NOIDV.FOF EL. NO.*,151 G00576 UC444 153* RELAC5,710C410 UKR04,71 G00640 <		UB41ü	137#	EMUL(3,K8)=DUM2	000530		
X GU412 139* LMU(5,K3)=0044 000534 QU415 140* 120 CONTINUE 000551 U4415 1417 GRATIC 20H ELEGENT LOAD MULTIPLIERS FROM 61*) GROS51 U4415 1417 GRATIC 20H ELEGENT LOAD MULTIPLIERS FROM 61*) GROS51 U442 144* U0 121 K9=1,5 U0 00551 U442 144* U0 121 K9=1,5 U0 00551 U442 144* U1 RTIFLIZICISISTEMUL (MS, KLD, KLD, KLD, KLD, KLD, KLD, KLD, KLD		<u></u>	138.#	EMUL (4, KB)=DUH3	<u>600532</u>	<u> </u>	
C 00913 140* 120 CONTINUE 000541 1 00115 141* WRITC(12,1117) 000541 00417 142* 1117 FORMAT(* COMM ELEMENT LOAD, MULTIPLIERS FROM (1*) 000551 00423 144* 121 WRITC(12,115)(EMUL(X9,K10),K10=1,4) 000555 00423 144* 121 WRITC(12,115)(EMUL(X9,K10),K10=1,4) 000565 00433 14* 127 FORMAT(13,X,*(ELEMENT DATA 000565 00435 14* 127 FORMAT(13,X,*(ELEMENT DATA) 000575 00431 14* 127 FORMAT(13,X,*(ELEMENT DATA) 000575 00441 150* 14* WRITC(6,127) 000575 00441 150* 14** WRITC(6,130)1X 000575 00441 150* 14** WRITC(6,130)1X 000575 00441 150* 14** WRITC(6,130)1X 000604 00455 131 FORMATIZX,*(ENTER DESIGN VARIABLE NO.*,10*,151 000604 00454 155* 131 FORMATIZX,*(ENTER DESIGN VARIABLE NO.*,14**. DEFAULT*D.*) 000620 00455 155* 131 FORMATIZX,*(ENTER DESIGN VARIABLE NO.*,14**. DEFAULT*D.*) 000621 00455 155* 140* <t< td=""><td rowspan="4">XXXI-5</td><td>68412</td><td>139#</td><td>EMUL(5,K8)=DUM4</td><td>600534</td><td></td><td></td></t<>	XXXI-5	68412	139#	EMUL(5,K8)=DUM4	600534		
CL UC0415 111* WRITE(12:117) GOD541 UC0425 143. D0 121 K9=1,5 GOD551 UC0425 144. 121 KRIEL(2:116)(EMULK9,K10;K10=1,4) GOD551 UC0432 144. 121 KRIEL(2:116)(EMULK9,K10;K10=1,4) GOD551 UC0432 144. 121 KRIEL(2:116)(EMULK9,K10;K10=1,4) GOD555 UC0432 144. 121 KRIEL(2:116)(EMULK9,K10:1,4) GOD555 UC0433 14.7 KRIEL(2:116)(EMULK9,K10:1,4) GOD565 UC0435 148. 127. FORMATICX."(EMULK9,K10:1,4) GOD575 UC0435 148. 127. FORMATICX."(EMULK9,K10:1,4) GOD575 UC0436 149. 00 150 KR00=1, KC10T GOD575 UC0442 151* WRITE(6,130)1X GOD576 UC0442 152* HRITE(6,12), TICTIO UKR00,7) UC0604 UC442 152* HRITE(12, *URTER LATERAL PRESSUPE ON EL. NO.*, 14, *. DEFAULT=0.*) GOD676 UC455 154* FORMATICX, *URTER LATERAL PRESSUPE ON EL. NO.*, 14, *. DEFAULT=0.*) GOD620 UC454 155*		00413	140#		000541		
1 11/1 <t< td=""><td>00415</td><td>141*</td><td>WRITE(12,1117)</td><td>600541</td><td></td><td></td></t<>		00415	141*	WRITE(12,1117)	600541		
Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain Constrain		60417	143+	DO 121 K9-1.5	000551		
U0432 145* 116 FORMATIGETO.U) 000565 U0432 147* WRITELGENT DATA 000565 U0435 147* WRITELGENT DATA*') 000575 U0435 147* WRITELGENT DATA*') 000575 U0435 147* WRITELGENT DATA*') 000575 U0435 148* 127 FORMATISX**(LLMENT DATA*') 000575 U0435 148* 127 FORMATISX**(LLMENT DATA*') 000575 U0441 150* LY=CQTIDIKROW:II 000575 000575 U0445 152* 130 FORMATIZX.*ENTER DESIGN VARIABLE NO.*IDV:FOP EL. NO.*,151 000604 U0445 152* 130 FORMATIZX.*ENTER DESIGN VARIABLE NO.*IDV:FOP EL. NO.*,14,* 000604 U0454 155* FORMATIZX.*ENTER LATERAL PRESSUPE ON EL. NO.*,14,* 000620 U0454 155* FLOATIZKROW.11=0 000620 U0455 156* ELDATIZKROW.11=0 000621 U0456 157* READIS,7100H 000621 U0456 159* ELDATIZKROW.21=0 000633 U0451 159* EL	9	00423	144*	121 write(12,116)(EMUL(K9,K10),K10=1.4)	00551		
LQ432 145* C** GÉNERAIE ELEPENT.DATA QQ0565 LQ433 147* WRITE(6,127) QQ0575 LQ436 148* 127 FORMAT(15,7) QQ0575 LQ436 149* Q0 150 K ROWIL, CLUMENT DATA*) QQ0575 LQ436 149* Q0 150 K ROWIL, CLUMENT DATA*) QQ0575 LQ442 151* WRITE(6,130)1X QQ0576 LQ445 152* 130 FORMAT(2X,*ENTER DESIGN VARIABLE NO.*IDV,FOP EL. NO.*,15) QQ0576 LQ445 153* KEAC(5,77)CTID(KROW,7) UQ0604 GQ064 LQ451 154* WRITE(6,131)IX QQ0576 GQ064 LQ451 154* KRL(5,77)CTID(KROW,7) UQ0604 GQ064 LQ451 154* KRL(5,77)CTID(KROW,7) UQ062D GQ0642 LQ451 154* KRL(5,77)CTID(KROW,1):DUM GQ062D GQ0642 LQ451 154* KRA0(5,77)DUH GQ062D GQ062D LQ451 159* ELDAT2(KROW,1):DUM GQ0643 GQ0642 LQ451 159* ELDAT2(KROW,2):DUM GQ0642		U0432	145*	116 FORMAT(4F1C.U)	000565		
L0435 147* WRITE(6,127) 000565 L0435 148* 127 FORMAT(15X,*[LLMENT DATA*) 000575 L0436 149* 00 150 KR0+21,KCT0T 000575 L0441 150* 1/2CGTID(KR0+1) 000576 L0441 150* 1/2CGTID(KR0+1) 000576 L0442 151* WRITE(6,130)1X 000576 L0446 153* KEAD(5,7)(CTID(KR0+7) 000604 L0446 153* KEAD(5,7)(CTID(KR0+7) 000604 L0451 154* WRITE(6,13)11X GDD612 L0454 155* KEAD(5,7)(CTID(KR0+7) 000604 L0454 155* KEAD(5,7)(CTID(KR0+7) GDD620 GD455 15* KEAD(5,7)(DUH GDD62 GD455 15* KEAD(5,7)(DUH GD0620 GD455 15* KEAD(5,7)(DUH GD0620 GD455 15* KEAD(5,7)(DUH GD0621 GU455 15* KEAD(5,7)(DUH GD0642 GU455 15* KEAD(5,7)(DUH GD0642 GU456 15* KEAD(40432	146#	C ** GENERATE ELEMENT DATA	000\$65		
L0435 148* 127 FORMAT(1;X,*[LLEKNT DATA*) L000575 L0435 149* D0 150 KROW*1, KCTOT L00575 L0441 150* Ix=CQTIDIKROW*1, L00575 L0442 151* WRITE(6,130)1X D00576 L0442 151* WRITE(6,130)1X D00576 L0445 152* 130 FORMAT(2X*ENTER DESIGN VARIABLE NO**IDV*FOF EL* NO**,151 D00604 L0446 153* KEAD(5,7)CCTID(KRO*,7) U00604 000670 L0451 134* WRITE(A,131]X GD0620 000620 L0455 155* 131 FORMAT(2X,*ENTER LATERAL PRESSURE ON EL* NO**,14,*DEFAULT=0.*) U00620 C0455 155* ELDAT2(KRO*,1)=D. GD0620 GD0620 C0455 155* ELDAT2(KRO*,1)=D. GD0620 GD0621 U451 158* If(DUM,NE,0)=ELDAT2(KRO*,1)=D. GD0620 GD0621 U454 159* ELDAT2(KRO*,1)=D. GD0622 GD0642 U454 162* If(DUM,NE,0)=ELOAT2(KRO*,1)=D. GD0642 GD0642 U4547 165* If(DAT2X; CENTER DESIGN		LU433	147*	wRITE(6,127)	000565		
C0436 149* U0 150* U04575 U0441 150* 1y C101000000000000000000000000000000000		60435	<u>148</u> ≠	127 FORMATILSX, "ELEMENT DATA")	000575		
D0442 D30 D4 D4 <th< td=""><td>00436</td><td>1494</td><td>UO 150 KROWEI,NCIOI</td><td>600575</td><td></td><td></td></th<>		00436	1494	UO 150 KROWEI,NCIOI	600575		
UC442 151* WRITELOS, 1201A UD416 UC445 152* 130 FORMAT(2X,*ENTER DESIGN VARIABLE NO.*IDV*FOP EL. NO.*,15) UD0604 UC446 153* READ(5,7)CCTID(KRO*,7) UD0604 L0446 153* WRITELOS, 1311X UD0604 L0454 155* 131 FORMAT(2X,*ENTER LATERAL PRESSUPE ON EL. NO.*,14,*. DEFAULT=0.*) UD0620 U0455 155* ELDAT2(KRO*,1)=0. UD0620 U0456 157* READ(5,7)DUH UD0627 U0461 158* ELDAT2(KRO*,1)=0. UD0633 U0463 159* ELDAT2(KRO*,1)=0. UD0633 U0464 160* HE16.1311X UD0634 U0467 161# 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL*NO*,114,** D UD0642 U0467 162* 1EFAULT=1.*' UD0642 U0470 163* ELDAT2(KRO*,3)=1 UD0642 U0471 164* IF (DUM,NE*,0*,1)=0. UD0444 U0474 165* IF (DUM,NE*,0*,1)=0. UD0652 U0474 165* IF (DUM,NE*,0*,1)=0. UD0642 U0474 165* IF (DUM,NE*,0*,1)=0. UD0644 U0474 165* IF (DUM,NE*,0*,1)=0. UD0644 U0474		00441	151#		000575		
L0446 153* REACIS,7)CGTID(RROW,7) D00604 L0451 134* WRITELG,1311X GD0612 L0454 155* 131 FORMAT(2X,*ENTER LATERAL PRESSUPE ON EL. NO.*,14,*. DEFAULT=0.*) D00620 L0455 156* 11 FORMAT(2X,*ENTER LATERAL PRESSUPE ON EL. NO.*,14,*. DEFAULT=0.*) D00620 L0455 156* 120 ATZ(KROW,1)=0. G00620 G00621 L0454 158* IF(DUM,NE, GLJEDATZ(KROW,1)=DUM G00627 G00627 U0463 159* ELDATZ(KROW,1)=0. G00633 G00642 U0464 160* #RITE(6,132)1X U00634 U00644 U0467 161* 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL. NO.*,14,*. D G00642 U0467 162* IEFAULT=1.* G00642 G00642 U0470 163* ELDAT2(KROW,3)=UUM G00642 G00642 U0471 164* #CADIS,7JDUM G00652 G00642 U0474 165* IF(DUM,NL,0),ELDAT2(KROW,3)=UUM G00652 G00642 U0474 165* IF(DUM,NL,0),ELDAT2(KROW,3)=UUM G00652 G00642 </td <td>60442</td> <td>152#</td> <td>130 FORMATIZA "FNTER DESTGN VADTARLE NOTDV.FOR FL. NO." 151</td> <td>000518</td> <td></td> <td></td>		60442	152#	130 FORMATIZA "FNTER DESTGN VADTARLE NOTDV.FOR FL. NO." 151	000518		
L0451 154# WRITELG,13111X GD0612 L0454 155* 131 FORMAT(2X,*ENTER LATERAL PRESSURE ON EL. NO.*,14,*. DEFAULT=0.*) GD062D G0455 155* 110A12(XR0N,1)=0. GD062D GD062D G0455 157* READ(5,7)DUH GD062T GD062T G0464 158* IF(DUM,NE,G.)FLDAT2(KR0N,1)=DUH GD062T GD063 G0464 160* wRITEL6,1321X GD064Z GD064Z G0464 160* wRITEL6,1321X UD0634 GD064Z G0467 161* 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL. NO.*,14,** D GD064Z U0470 163* LDAT2(KR0N,3)=1 GD064Z U0471 163* LDAT2(KR0N,3)=DUM GD064Z U0474 165* IF (DUM,NE.0.)ELDAT2(KR0N,3)=DUM GD064Z U0474 165* IF (DUM,NE.0.)ELDAT2(KR0N,3)=DUM GD064Z U0470 166* WRITEL6.1331X GD064Z U0501 167* 133 FORMAT(2X, ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=P.*) GD0664 U0502 168* LDAT2(KK0V.4)=DU GD		10446	153*	REAC(5.7)CGTID(KROM.7)	000604		
L0454 155* 131 FORMAT(2X,*ENTER LATERAL PRESSURE ON EL. NO.*,14,*. DEFAULT=0.*) U00620 G0455 156* ELDAT2(KROW.1)=0. G00620 U0456 157* READ(5,710UH G00621 G0453 159* ELUAT2(KROW.2)=0. G00627 U0463 159* ELUAT2(KROW.2)=0. G00633 G0464 160* HRITE(6.132)1X U00633 U0467 162* IEFAULT=1.*) U00642 U0470 163* ELDAT2(KROW.3)=1 U00642 U0470 163* ELDAT2(KROW.3)=1 U00642 U0471 164* HEAD(5.7)DUM U00642 U0474 165* IF(0UM.NE.0.)FLOAT2(KROW.3)=0UM U00642 U0474 165* IF(0UM.NE.0.)FLOAT2(KROW.3)=0UM U00652 U0475 166* WRITE(5.133)IX U00655 U0501 107* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=0.*) 000664 U0502 166* WRITE(5.133)IX U00665 U00664 U0501 107* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=0.*)		L0451	154+	WRITE (6,131) IX	<u>600612</u>		
C0455 156* FLDAT2(KR0K,1)=0. C00620 00456 157* READ(5,7)DUH C00621 00463 159* FLDAT2(KR0K,2)=0. C00633 00463 159* ELDAT2(KR0K,2)=0. U00634 00467 160* HRITE(0:132)1X U00634 00467 162* FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL. NO.*,14,*. D C00642 00470 163* ELDAT2(KR0W,3)=1 C00642 00470 163* ELDAT2(KR0W,3)=1 C00642 00470 164* RFAD(5,7)DUH C00642 00471 164* RFAD(5,7)DUH C00642 00474 165* IF(DUM,NE.0.)FELDAT2(KR0W,3)=UH C00652 00474 165* IF(DUM,NE.0.)FELDAT2(KR0W,3)=UH C00642 00474 166* WRITE(6,133)IX U00652 0051 166* WRITE(6,133)IX U00664 0051 168* FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. N0.*,14,*. DEFAULT=P.*) 000664 0051 168* LUAT2(KK0W,4)=U U00665 0051 168* LUAT2(KK0W,4)=U U00665		LU454	155¢	131 FORMAT(2x, ENTER LATERAL PRESSURE ON EL. NO.",14,". DEFAULT=0.")	000620		
U0456 157* READ(5,710UM C00621 U0461 158* IF(DUM.NE.G.)EDAT2(KROW.1)=UUM 00627 U0463 159* ELUAT2(KROW.2)=0. 00633 U0467 161* 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC.FOR EL. NO.*,14,*.D U00634 U0467 162* IEFAULT=1.*' U00634 U0470 163* ELDAT2(KROW.3)=1 000642 U0471 164* REL0(5,710UM 000642 U0474 165* IF(DUM.NE.0.FELDAT2(KROW.3)=UUM U00652 U0474 165* IF(DUM.NE.0.FELDAT2(KROW.3)=UUM U00652 U0475 166* WRITE(6.133)1X U00652 U0501 167* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=P.*) 000664 U0502 168* ELDAT2(KROW.4)=J U00665 U00665 U0502 168* ELDAT2(KROW.4)=J U00665 U00665 U0504 169* REL0472(KROW.4)=J U00665 U00665 U0505 169* IELDAT2(KROW.4)=DUM U00665		00455	156.*	ELDAI2(KROW,1)=0.	<u> </u>		
CD461 158* IF 100M*NE*0.721KR0W.11=00M U0463 159* EL0AT2(KR0W.2)=0. U00633 C3464 160* wRITE[6:132]1X U00634 U0467 161* 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL*NO*,14,**D U00642 U0467 162* 1EFAULT=1.*' G00642 U0470 163* EL0AT2(KR0W,3)=1 U00642 U0471 164* READ15,7DDM U00644 U0474 165* IF 100M*NE*0*,1EL0AT2(KR0W,3)=UUM U00642 U0474 165* IF 100M*NE*0*,1EL0AT2(KR0W,3)=UUM U00652 U0475 166* wRITE[6:133]1X U00652 U0475 166* wRITE[6:133]1X U00652 U0475 166* LDAT2(KR0W,4)=D U00664 U0502 168* (LUAT2(KK0W,4)=D U00664 U0504 168* (LUAT2(KR0W,4)=DUM U00665 U0504 U00665 U00665 U00665 U0506 170* IF (LUM*NE*0*1ELDAT2(KR0W,4)=DUM U00665		UD456	157*	READ(S, 7)DUM	600621		
00003 157* 120* 000033 00004 160* wRITE(6,132)1X 000634 000047 161* 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL. NO.*,14,*D 000642 000047 162* 1EFAULT=1.*) G00642 000470 163* ELDAT2(KROW,3)=1 G00642 00471 164* READ(5,7)DUM 000642 00474 165* IF(DUM.NL.0).FELDAT2(KROW,3)=DUM 000652 00475 166* wRITE(6,133)1X 000652 00501 167* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=P.*) 000664 00501 168* ELDAT2(KROW,4)=J UD0664 UD0664 00502 168* ELDAT2(KROW,4)=J UD0664 UD0664 00501 167* REAU(5,7)DUH UD0664 UD0665 00501 167* REAU(5,7)DUH UD0665 UD0665 00506 170* IF(LUM.NE.50.FEDAT2(KROW,4)=DUM UD06673			<u>158#</u>				
U0467 161, 132 FORMAT(2X,*ENTER DESIGN VARIABLE FRACTION,FRC,FOR EL. NO.*,14,*.D U00642 U0467 162* 1EFAULT=1.*) G00642 U0470 163* ELDAT2(KROW,3)=1 U00642 U0471 164* READ(5,7)DUM U00642 U0474 165* IF(DUM,NE.0.)ELDAT2(KROW,3)=UUM U00652 U0475 166* WRITE(6,133)IX U00652 U0501 167* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*.DEFAULT=P.*) 000664 U503 167* REAU(5,7)DUM U00664 U0503 167* REAU(5,7)DUM U00665 U0503 167* REAU(5,7)DUM U00665 U0503 167* REAU(5,7)DUM U00665 U0503 167* REAU(5,7)DUM U00665 U05105 170* IF(LUM.NE.0.)ELDAT2(KROW,4)=DUM U00665		60469	163*		000033		
L0467 162* 1EFAULT=1.*) C00642 U0470 163* ELDAT2(KROW, 3)=1 U00642 U0471 164* READ(5,7)DUM U00642 U0474 165* IF(DUM,NE.0.)ELDAT2(KROW,3)=UUM U00652 U0476 166* WRITE(6,133)IX U00652 U0476 166* WRITE(6,133)IX U00664 U0501 167* 133 FORMAT(2X, ENTER THE ANGLE BETA FOR EL. NO.*, I4, *. DEFAULT=0.*) 000664 U0502 168* ELDAT2(KROW,4)=D U00664 U0503 167* REAU(5,7)DUM U00665 U0516 170* IF(LUM+NE+0-)ELDAT2(KROW,4)=DUM U00665		U0467	161.	132 FORMAT(2X, 'ENTER DESIGN VARIABLE FRACTION, FRC, FOR EL. NO.', 14, '. D	000642		
U0470 163* ELDAT2(KROW, 3)=1 U00642 U0471 164* READ(5,7)DUM U00644 U0474 165* IF(DUM,NE.0.)ELDAT2(KROW,3)=UUM U00652 U0476 166* WRITE(6,133)IX U00652 U0501 167* 133 FORMAT(2X, ENTER THE ANGLE BETA FOR EL. NO.*,I4,*. DEFAULT=0.*) 000664 U0502 168* ELDAT2(KROW,4)=J U00664 U0503 167* REAU(5,7)DUM U00665 U0516 170* IF(LUM.NE.0.)ELDAT2(KROW,4)=DUM U00665		<u>40467</u>	162#	lefault=1.*')			
UD 471 164* READ (5,7)DUM UD 0644 UD 474 165* IF (DUM_NL_0) ELD_AT2(KROW,3)=UUM UD 0652 UD 476 166* WRITE(6,133)IX UD 0656 UD 501 167* 133 FORMAT (2X, ENTER THE ANGLE BETA FOR EL. NO.*, I4, *. DEFAULT=P.*) 000664 UC 502 168* ELD AT2(KROW,4)=U UD 0664 UC 503 167* REAU(5,7)DUM UD 0664 UC 503 167* REAU(5,7)DUM UD 0665 UD 516 170* IF (LUM *NE*D*)ELD AT2(KROW,4)=DUM UD 0665		U047u	163#	£LDAT2(K _R OW, 3)=1	000642		
CD474 165* IF (DUM_NL_0) (ELD_AT2(KROW,3)=DUM CD0652 CD476 166* WRITE(6,133)IX UD0656 L0501 167* 133 FORMAT(2x, ENTER THE ANGLE BETA FOR EL. NO.*, I4, *. DEFAULT=P.*) CD0664 C0502 168* ELDAT2(KROW,4)=D UD0664 U0503 167* REAU(5,7)DUM UD0665 U0516 170* IF (LUM_NE_0D_)ELDAT2(KROW,4)=DUM UD0673		<u> </u>	164#	READ(5,7)DUM	<u> </u>		
UD4/D HATEL0113311x UD056 L0501 167* 133 FORMAT(2X,*ENTER THE ANGLE BETA FOR EL. NO.*,14,*. DEFAULT=0.*) 000664 L0502 168* ELDAT2(KKOW,4)=0 UD0664 U0503 169* REAU(5,7)DUH 000665 UD516 170* IF(LUM*NE*0*)ELDAT2(KROW,4)=0UM UD0673		60474	165*	LF (UUM.NE.(). JELDAT2(KROW, 3)=UUM	600652		
C0502 168* ELDAT2(KK0w,4)=0 UD0664 U0503 169* REAU(5,7)DUH 000665 U0516 170* IF(LUM+NE+0+)ELDAT2(KR0w,4)=0UM 000673		<u> </u>	167#	133 FODHATZ2Y FNTED THE ANGLE RETA FOD DE NO 1.14 1 DECLIN THO 14			·····
UU5U3 169* REAU(5,7)DUH UOD665 UD ⁵ U6 170* IF(LUM+NE+D+)ELDAT2(KRON+4)≃DUM UDD673		66502	168#	ELDAT2(KKOW+4)=0	000004		
UD0673		<u> </u>	167*	REAU(5,7)DUH	000665		
		սը 5լլ6	170*	IF (LUH+NE+D+)ELDAT2(KROW+4)=DUM	LID0673		
<u>u</u> t		DATE 073080	PAGE 5				
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00510 171#		006761					
<u> </u>							
		600763					
<u> </u>	CALL FLORD (NCTOT.COTID.FLD.T2.NNcOL1.NNcOL2)	600705					
6n515 175 *	WRITE(12,1135)	600714					
U0517 176*	1135 FORMATL' COMM EL. DATA FROM UT')	000721					
UC52017.7÷	DO 180 M12=1.NCTUT	600721					
LU523 178*	180 WRITE(12.136)(COTID(M12.M13).M13-1.7).(ELDAT2(M12.M1	3).H13=1.4) 000730					
20523 179+	CIAC WRITE (6.136) (COTIDIM12.M13).M13=1.7). (EL DAT2(M12.M13)).H13=1.4)					
00536 180+	136 FORMATIGIS, 5X, 15, 4F10.0)	C00760					
LD537 1814	D0 190 K1=1.NCTOT	000760					
UU542 182≠	190 IDV5(K1)=CQTID(K1.7)	000760					
<u> </u>	p E T U R N	000762					
UD545 184≠	FND	601033					
END FOR							
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äHDG,P REM	AP						
FURPUR ZORIH1 EI	36 \$74111 07/30/80 09:46:32	·····					
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DATE 073080 PAGE 1

aFOR, S SHEAR, SHEAR

HSA E3 -07/30/80-09:46:49 (30,)

SUBROUTINE SHEAR ENTRY POINT DOU527

STORAGE USED: CODE(1) DDD560; DATA(0) D05060; BLANK COMMON(2) DDDUDO

COMMON BLOCKS:

UUU3 BACH UUU044 UUU4 MUZART 000334

EXTERNAL REFERENCES (BLOCK, NAME)

<u>(005</u>	CANDP									
00005	PATR									
ü3ü7	ELORD	· · · · · · · · ·			· · · · · · · · · · · · · · · · · · ·					
J010	NEDUS									
i011	NI025									
6012	NIO3S									
6013	NIO15									
6014	NRDUS									
0015	NERR35									
SIARAGE	E ASSIGNMENT (BLOCK. TYP	E. RELATIVE LOCA	ATION. N	AMEI		·····			
	164677 111F	0000	004730 1117F	0001	U04710 112F	مممد	005011 1135E	0000	004740_116F	
u001	060317 120L	0000	064742 127F	0000	004751 130F	0000	DU4762 131F	0000	004774 132F	
	U05017 136F	6001	000044 1376		000053 1446	0001	000152 2016	0001	000161 2066	
1001	000221 2326	6001	060226 236G	6001	000234 2436	0001	000257 2556	0001	000260 2606	
	000271 2666	លោកបា	004672 300F		000331 3146	0001	000336 3206	0001	000355 3326	

-IXXX

X	STORAGE ASSIGNMENT (BLOCK. TYPE, RELATIVE LOCA	TION. NAMEL		······································	
-61	0000 064677 111F	0000 004730 1117F		0000 005011 1135E	0000 004740 116F	
	UBU1 000317 120L	0000 064742 127F	0000 004751 130F	0060 004762 131F	0000 004774 132F	
·	J001 000221 2326	0001 060226 236G	6001 000234 2436	0001 po0257 2556	0001 000260 2606	
	<u></u>	<u> </u>	<u>UC01 000331 3146</u> U001 000466 #026		<u>ugg1 000355 3326</u> 0000 nn4647 5F	
	0000 004662 504F	001 00060 61L		0001 00063.65L	0000 004646 7F	-
	<u>0000 004655 795F</u> <u>0000 1.060000 CSHR1</u>	0001 0001/1 84C	<u> </u>	0000 R 004631 DUM1	0000 I 001130 CSHRID	
	0000 R 004633 DUM3 6000 I 004637 IX	0000 R 003416 ELDAT2 3000 I 064611 J	0000 R 004572 EMUL 0000 I 004621 J10	0000 I 003100 INDEX 0000 I 004622 J11	0000 005033 INJP\$ 0000 1 004624 J12	
	0000 I 004625 J13	00JO I 004614 K	0000 I 004615 KK	0000 I 004610 KKDE	GOUD I DO4617 KKODE	
	0000 I 004627 K7	0000 I 004630 K8	UCOD I 004634 K9	0000 I 0J2570 MATCH	0004 00000 MAT11	
	<u>U004 R 000024 MAT12</u> 0000 I 004644 M13	0000 I 004343 HTPR01	0000 R 004413 MTPR02	0000 R 004437 MTPR03	0000 I 004643 M12	
•	0000 I 004613 NPID		UD03 UD0022 NSTART	0003 I 00000 NUM	0000 I 004620 NUMMAT	
	<u>0000 1 004566 VAR</u>	LUGU I 004607 NUM18	0000 I 004064 PSHR1	0000 R 004146 PSHR2	0000 I 004557 TYPE	

60101	L #	SUBROUTINE SHEAR(CONFAC, NKODE, IDV4, NUMB)	00000	
<u>L0103</u>	2*	<u>COMMON/BACH/NUM(18).NSTART(16)/MOZART/MAT11(20).MAT12(20.10)</u>		
60103	3*	C ** CHANGE GROUP. NO. OF SHEAR PANELS	000000	·
60104	4*	INTEGER_CSHR1(100+6)+CSHR10(100+8)+MATCH(100+2)+INDEX(100)	000000	

UD105 c+ OPERASIDE LUMERIZIONI LELOAZIZIENDEDI Operation C0105 c+ c+ CAMAGE GOUP, No. 07 P101'S COURDO C0107 c+ CHRESSED FSHR2ZS, 10 IS COURDO C0110 c+ c+ CAMAGE GOUP, NO. 07 D25 (00 APR) COURDO C0111 13 FRA. HPEGZICADIA HPEGZICADIA COURDO COURDO C0111 14 C+ C+ CAMAGE GOUP, NO. 07 D25 (00 APR) COURDO C0111 14 C+ C+ C+ C+ CAMAGE GOUP, NO. 07 D25 (00 APR) COURDO C0111 15 FRA. HPEGZICADARE COURDO COURDO COURDO C0112 15 C+ C+ C+ CAMAGE GOUP, NO. 07 D25 (00 APR) COURDO C0113 15 C+ C+ C+ COURDO COURDO C0114 15 C+ C+ C+ C+ COURDO C0115 15 C+ C+ C+ C+ C+ C01115 C+		Sн	LAR			DATE 073080	PAGE	2
10105 0 C ** C 4AAGC 0000 A. 00. 07 P10'S L0000 10107 F 0 HINESED PSHULLS22 L00000 10107 F 0 HINESED PSHULLS22 L00000 10101 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S L00000 10111 C = C HANESE GAUPL MSL, D' P10'S HANESE L00000 10111 C = C HANESE GAUPL MSL, D' P10'S HANESE L00000 10111 C = C HANESE GAUPL MSL, D' P10'S HANESE L00000 10111 C = C HANESE GAUPL MSL, D' P10'S HANESE L00000 10112 C = HANESE GAUPL MSL, D' P10'S HANESE L00000 10112 C = HANESE GAUPL MSL, D' P10'S HANESE L00000 10112 C = HANESE GAUPL MSL, D' P10'S HANESE L00001 10112 C = C = F F F F F F F F F F F F F F F F		00105	r #		0THENSION DUNHY(100.1).FLOAT2(100.3)	00000		
UDIO INTEGER SAMPLES 21 UDDOO 00107 ** UDROSSO UDROSSO 00107 ** C** UDROSSO UDROSSO 00107 ** C** UDROSSO UDROSSO 00107 ** C** UDROSSO UDROSSO 00111 1** C** CARANG 6800*. NO. 07 DESIGN VARIABLES UDROSSO 00111 1** C** CARANG 6800*. NO. 07 DESIGN VARIABLES UDROSSO 00111 1** C** CARANG 6800*. NO. 07 DESIGN VARIABLES UDROSSO 00111 1** C** CARANG 6800*. NO. 07 DESIGN VARIABLES UDROSSO 00111 1** C** CARANG 6800*. NARIABLES UDROSSO 00111 1** C** CARANG 6800*. NARIABLES UDROSSO 00112 1** C** CARANG 6800*. NARIABLES UDROSSO 00112 2** NARISSONTISS UDROSSONTISSONTISSO UDROSSONTISSONT	_	C0105	<u>6</u> *	C **	CHANGE GROUPS NO. OF PTD'S	00000		
C0107 0* UTRASION PSACIS;51 C0000 C0110 10* UTRASION PSACIS;51 C00000 C0111 10* UTRASION PSACIS;51 C00000 C0111 10* UTRASION PSACIS;51 C00000 C0111 12* C* CAMADA C00000 C0111 14* C* CAMADA C00000 C0114 14* C* CAMADA C00000 C0114 C* CAMADA CAMADA CO0000 C0114 C* CAMADA CAMADA CO0000 C0114 CAMADA CAMADA CAMADA CO0000 C0114 CAMADA CAMADA CAMADA CO0000 C0115 CAMADA CAMADA CAMADA CO0000 C0114 CAMADA CAMADA		LU106	7*	• • •	INTEGER PSHR1(25.2)	600000		
00107 ?* C** CHANGE CROUP. NO. ÓF MED'S CODEG 00111 10* INTEGE MERDING CONTENDING CODEG 00111 10* INTEGE MERDING CONTENDING CODEG 00111 10* INTEGE MERDING CODEG 00112 10* MERINES CODEG 00114 20* MERINES CODEG 00114 20* CODEG CODEG 00112 20* CODES CODEG		60107	8*		UIMENSION PSHR2(25.5)	U000nn		
C01LL 13* INTEGES HTPSOLECULATESOLECULAT C0000 C011L 11* C** CRANTSOLECULATESOLECULATESOLECULATION C00000 C011L 11* C** CRANTSOLECULATESOLECU		00107	9*	<u>C</u> ++	CHANGE GROUP. NO. OF MID.S	000000		
L111 HFR.074.001.MFR.031.02.M1 U0000 C0111 12* C* C+AL.M1PR.031.02.M1 U0000 C0111 12* C* C+AL.M201.M12.01 U0000 C0111 12* C* C+AL.M201.M12.01 U0000 C0111 12* C* C+AL.M201.M12.01 U0000 C0111 13* U14.1.4.4.4.1.4.1.4.1.4.1.1 U00000 C0112 14* FFAL.M21.4.1.4.4.4.1.4.1.4.1.1 U00000 C0112 14* FFAL.M21.4.1.4.4.4.1.4.1.4.1.1.1.1.1.1.1.1.1.1		00110	10+		INTEGER MTPRO1(20,2)	00000		
Colling C ** C ** C ** CHARGE GROUP > NO. OP DESIGN VARIABLES COUNCE Colling Contextion Duration COUNCE COUNCE COUNCE Colling Contextion Duration COUNCE COUNCE COUNCE Colling Contextion COUNCE COUNCE COUNCE Colling Contextion File COUNCE COUNCE Colling Counce File COUNCE COUNCE Colling Counce File Counce Counce Colling Counce Counce Counce Counce Counce Colling Counce Counce Counce Counce Counce Counce Colling Counce Counce <t< td=""><td></td><td><u> </u></td><td></td><td></td><td>RFAL_MTPR02(20)+MTPR03(20+4)</td><td>000000</td><td></td><td></td></t<>		<u> </u>			RFAL_MTPR02(20)+MTPR03(20+4)	000000		
00112 11* 00000 00113 14* 0 MRAS 10* 10*3150 00000 00111 14* RAL EMULT; HANTA2 00000 00111 14* RAL EMULT; HANTA2 00000 00111 14* RAL EMULT; HANTA2 00000 00112 14* RAL EMULT; HANTA2 00000 00113 14* RAL EMULT; HANTA2 00000 00123 14* RAL EMULT; HANTA2 00000 00123 14* MANDESUMIRD 00000 00124 14* RADTA2 00000 00125 24* CL EADOFRADELAURE AURS, CSHRLDUMMY,PSHRLPSHE21 000000 00125 24* CL EADOFRADELAURE AURS, CSHRLDUMMY,PSHRLPSHE21 000007 00125 24* CL EADOFRADELAURE AURS, CSHRLDUMMY,PSHRLPSHE21 000007 00125 24* CL EADOFRADELAURE AURS, CSHRLDUMY,PSHRLPSHE21 00007 00125 24* CL EADOFRADELAURE AURS, CSHRLDUMY,PSHRLPSHE21 00007 0125 24* CL EADOFRADELAURE AURS, CSHRLDUMY,PSHRLPSHE21 00007 </td <td rowspan="2"></td> <td>60111</td> <td>12*</td> <td>C **</td> <td>CHANGE GROUP. NO. OF DESIGN VARIABLES</td> <td>000000</td> <td></td> <td></td>		60111	12*	C **	CHANGE GROUP. NO. OF DESIGN VARIABLES	000000		
Unitic Let National Science D0000 Lotiti 16* Let National Science D0000 Lotiti 16* Unit Vale/Ar/10*/10*/10*/10*/10*/10*/10*/10*/10*/10*			13#		DIMENSION IDV4(50)	000000		
Odds Ditter Ditter Ditter Ditter Ditter 00113 17* UAA VAR/A: 'J'AAC JALVAR(J) Ditter 00113 17* UAA VAR/A: 'J'AC JALVAR(J) Ditter 00121 17* UAA VAR/A: 'J'AC JALVAR(J) Ditter 00122 17* UAA VAR/A: 'J'AC JALVAR(J) Ditter 00123 17* UAA VAR/A: 'J'AC JALVAR(J) Ditter 00124 27* NMM ISSNUM (IS) Ditter Ditter 00125 27* C PRINT (J'AVAR) JALVAR VAR/A: UAA VAR/A: UA		00112	14#	(**	***************************************	000000		
C0111 1/2 DATA SARZ/11/10/11/10/11/2 Control of the second se			16+		INIEGER ITPEIZI, NPARISI, VARIAI			
C0120 13* 7 FORMAT (1) 10 <th10< th=""> <th10< th=""> 10</th10<></th10<>		00447	10+ 17±		REAL ERUL(3,47,MATAZ) Nata VAD/141,104 104 104/1402/164FAD1.1 1/	000000		
UD12 19 NUMBENUM(§) DDDDD UD122 20 NUMBENUM(§) UD0001 UD123 11 NUMBENUM(§) UD0001 UD124 22 NUMBENUM(§) UD0001 UD125 24 CAL CAUCES UD0001 UD125 24* C PRINT 13 UD0007 UD125 24* C PRINT 13 UD0007 UD125 24* C FRINT 14 UD0007 UD125 24* C15 PRINT 15.NMRED1ANDARS UD0007 UD125 24* C15 PRINT 14.NEDANDARS UD0007 UD125 24* C15 PRINT 13.NEDANDARS UD0007 UD125 24* C15 PRINT 14.NEDANDARS UD0007 UD125 24* C15 PRINT 10.NEDANDARS UD0007 UD131 31* NEDANDARS UD0007 UD0007 UD131 31* NEDANDARS UD0007 UD0007 UD131 14*		(0)20	18#	7	FOR AT ()	000000		
U122 2.w NUM15:NUM151 U00001 U0124 214 NUM15:NUM131 U00001 U0124 224 NADC:0 U00001 U0125 234 CAL CANDPIRADL:NUM8_NUM15.CSHR1.DUMMY_PSHR1.PSHR21 U00001 U0125 234 CAL CANDPIRADL:NUM8_NUM15.CSHR1.DUMMY_PSHR1.PSHR21 U00001 U0125 244 C PRINT 13 U00001 U0125 244 C PRINT 14 STRATULY_PSHR1.PSHR1		40121	19#	•		00000		
L0123 11 NUM15:NUM1Es COUDD3 L0124 224 KAUE:8 D00005 L0125 23* CALL_CANDPIKADE.HUMB.HUM15.CSM1.DUMHY_PSMR1.PSHR21 C00007 L0125 24* C PRIN 13 C00007 L0125 24* C C PRIN 13 C00007 L0125 24* C C D5 J_LINUM15 D00005 L0125 24* C14 FORMAILY PSURE IN_SHEAP.JUGT BACK FROM CANDPY.J D00007 L0125 24* C14* FORMAILY PSURE IN_SHEAP.ANEL* D00007 L0125 24* C14* FORMAILS* C00007 L0125 24* C4* FORMAILS* C00007 L0131 34* PAREL* C00025 C000025 L0133 34* NPARE215-MUNA UD0021 C00031 L0134 55* NPARE315-MUNA UD0025 C00034 L0133 34* NPARE315-MUNA UD0026 C00034 L0134 55* <td< td=""><td></td><td>UU122</td><td>24*</td><td></td><td>NUM 15=NUM (15)</td><td>000001</td><td></td><td></td></td<>		UU122	24*		NUM 15=NUM (15)	000001		
U0124 22* NADES D00005 00125 23* CALL CANDERNATE, NUMB, NUM15, CSMR1, DSMR2] U00007 00125 23* C PRINT 13 U00007 00125 23* C PRINT 13 U00007 00125 24* C PRINT 13 U00007 00125 25* C1 FORMATION, NERRIAN, NERRIAN, NERRIAN, NERRIAND, NERRIAN		L0123	21#		NUM16=NUM(18)	600003		
00125 23* CALL CANDP (ANDE ANURA NUM15, CSHR1, DUMAT, PSHR1, PSHR2) C00007 00125 20* C PRN1 13 UD0007 00125 20* C11 FORMATIC' PSHR1 IN, SHEAR JULS, BACK FROM CANDP', OD0007 00125 20* C1 FORMATIC' PSHR1 IN, ISKEAR JULS, BACK FROM CANDP', OD0007 00125 20* C1 FORMATIC' SHODOT OD0007 00125 20* LETH (16.5) UD0007 OD0007 00126 20* HER (15.00LY UNE CONST. CODE FOR SHEAR PANELS UD00027 00131 30* NPAR(15:4 UD00031 UD00031 00133 30* NPAR(15:4 UD00031 UD00031 00133 30* NPAR(15:4 UD00031 UD00031 00135 40* UD 20* MPAR(15:4		00124	22*		KKDE_8	000005		
U0125 24* C PRINT 13 U0007 C0125 25* C11 FORMAILY PSHRI 14, SHEAR Jugt BACK FROM CANDPY, 000007 U0125 25* C U0 15 JI, NUM15 U00007 U0125 25* C U0 15 JI, NUM15 U00007 U0125 25* C11 FORMAILY PSHRI 134, IEAR J21 U00007 U0126 20* LPILE (6,15) U00007 U00007 U0131 30* FORMAILY (20*, "SHEAP PANEL") U00007 U00025 U0131 30* FORMAILY (20*, "SHEAP PANEL") U00025 U00017 U0131 30* FORMAILY (20*, "SHEAP PANEL") U00027 U00027 U0131 10* FORMAILY (20*, "SHEAP PANEL") U00027 U0007 U0131 10* FORMAILY (20*, "SHEAP PANEL") U00027 U00027 U0131 10* FORMAILY (20*, "SHEAP PANEL") U00027 U0007 U0132 50* FORMAILY (20*, "SHEAP PANEL") U00007 U00011 U0131 50* <t< td=""><td></td><td>00125</td><td>23*</td><td></td><td>CALL CANDP(KKDE.NUH8_NUH15.CSHR1.DUMMY.PSHR1.PSHR2)</td><td>600007</td><td></td><td></td></t<>		00125	23*		CALL CANDP(KKDE.NUH8_NUH15.CSHR1.DUMMY.PSHR1.PSHR2)	600007		
c0125 25* C13 FORMATI2* PSHR1 TL, SHEAR JULS FACK FROM_CANDP*/1 D00007 c0125 27* C15 PRINT 14* (PSHR1/L**PSHR1/L**L) C00007 c0125 27* C15 PRINT 14* (PSHR1/L**PSHR1/L**L) C00007 c0126 29* LRITE (6:5) C00007 C00007 c0113 10* MR06E21 C00007 C000025 c0131 11* MR06E21 C00007 C000025 c0131 12* C** HERE 15 ONLY ONE CONST. CODE FOR SHEAR PANELS C000025 c0133 34* MRAR(12*NUMB C000031 C000031 c0134 35* MRAR(12*NUMB C000031 C00034 c0135 36* MRAR(12*NUMB C000031 C00034 c0136 17* U0 70 TL 02*NUMB C000034 C00034 c0137 00 7L 02*LNUMB C000034 C00034 C00034 c0138 17* U0 7L 02*LNUMB C000034 C00034 c0139 18* 17*LNUMB C00034 C00034 C000034 c0139 18*L		60125	24*	С	PRINT 13	UC0007		
C0125 26* C D0 15 J:1,NUM15 D00007 C0125 27* C15 PENL1 14: [PSHR113K, [KE], 2] C00007 C0125 26* C14 FORMATIZIO C00007 C0130 30* 5 FORMATIZIO C00007 C0131 31* C FORMATIZIO C00025 C0131 31* C FORMATIZION CNE CONST. CODE FOR SHEAR PANELS C00027 C0131 31* FORMATIZION CNE CONST. CODE FOR SHEAR PANELS C00023 C00024 C0131 51* NPARISIEL C00034 C00034 C0131 51* NPARISIEL C00034 C00034 C0142 52* NPARISIELL C00034 C00034 C0142 52* NPIDECSARTILL, 12 C00004 C00035 C0142 42* NPIDECSARTILL, 13 C00053 C00054 C0142 43* FORDECRERIAL, 13 C00054 C00055 C0142 43* FORDECRERIAL, 13 C000054 C00055 <t< td=""><td>_</td><td>60125</td><td>25*</td><td><u> </u></td><td>FORMAT(/ PSHR1 IN SHEAR JUST BACK FROM CANDP //</td><td>000007</td><td></td><td></td></t<>	_	60125	25*	<u> </u>	FORMAT(/ PSHR1 IN SHEAR JUST BACK FROM CANDP //	000007		
U0125 27* C15 PP1N 14. (P5MR113/K).K51.2) U00007 U0128 29* (P11E 16.5) U0007 U0128 29* (P11E 16.5) U0007 U0131 31* MR00E21 U00025 U0131 31* MR00E14 U00025 U0131 31* MR00E14 U00025 U0132 33* MPAR112* U00025 U0133 34* MPAR12*NUR8 U00025 U0131 55* MPAR112* U00031 U0132 33* MPAR112* U00031 U0141 35* MPAR112* U00031 U0142 35* MPAR112* U00031 U0141 35* MEDICEMENTAL U00031 U0142 35* MEDICEMENTAL U00055 U0143 40* 00.65 MEDICEMENTAL U00055 U0154 40* 00.65 MEDICEMENTAL U00055 U0154 40* 60.16 AZ 000055 U0154 40* 60.16 AZ 000055 U0152 40* 60.16 AZ		60125	26₽	С	00 15 J=1,NUM15	000007		
CD125 25* C14 FORMATIZIO CD0001 CD130 30* 5 FORMATIZIO CD0025 CD131 31* MROLE1 CD0025 CD0025 CD131 32* C ** THERE IS ONLY ONE CONST. CODE FOR SHEAR PANELS CD0025 CD131 32* C ** THERE IS ONLY ONE CONST. CODE FOR SHEAR PANELS CD0025 CD131 32* C ** THERE IS ONLY ONE CONST. CODE FOR SHEAR PANELS CD0027 CD131 32* MPAR(112*A UD0027 UD0027 CD133 34* MPAR(21*AUN6 UD0031 UD0031 CD143 35* MPAR(51*1 DD0044 UD0031 CD141 35* RED0ESHRIU/2) CD0044 UD0046 CD142 S7* MPAR(2)*AUN6 CD0035 CD0034 CD144 S* RED0ESHRIU/2) CD0044 CD0044 CD144 S* MED0ESHRIU/2) CD0044 CD0045 CD150 G0 C0 S CD0045 CD0053 <td></td> <td>60125</td> <td>27*</td> <td><u>C15</u></td> <td>PRINT 14. (PSHR1(J.K).K=1.2)</td> <td></td> <td>·</td> <td></td>		60125	27*	<u>C15</u>	PRINT 14. (PSHR1(J.K).K=1.2)		·	
D01425 277 LH11E [0:5] D01020 L0131 310 FORMAT 120X, "SHEAP PANEL") C00025 L0131 310 MR06E31 G00025 L0132 330 NPAR1124 G00025 L0133 310 NPAR1124 G00025 L0132 330 NPAR1124 G00025 L0133 310 NPAR1212NUM8 G00031 C0134 350 NPAR131 G00034 G135 310 NPAR14121 G00034 G0134 330 NPAR1212NUM8 G00034 G0134 330 NPAR1212NUM8 G00034 G0134 330 NPAR1311 G00044 G0142 330 NPAR1411 G00044 G0142 330 NPAR141 G00053 G0142 G000055 G00053 G00053 G0144 16 (NP10+(10, PSHR14, 1)160 G00053 G0151 436 61 (KKK G00055 G0152 436 62 (CSHR104, 1)161		60125	26≢	C14	FORMAT(216)	600007		
L0111 100 </td <td></td> <td><u> </u></td> <td>294</td> <td>c</td> <td></td> <td></td> <td></td> <td></td>		<u> </u>	294	c				
20131 32* C ** THERE IS ONLY UNE CONST. CODE FOR SHEAR PANELS UD0025 20131 33* MPAR(1):** UD0031 20133 34* MPAR(2):** UD0031 20134 35* MPAR(2):** UD0031 20135 36* MPAR(2):** UD0031 20136 36* MPAR(2):** UD0031 20137 35* MPAR(2):** UD0031 20138 36* MPAR(2):** UD0031 20140 37* 40.7* UD0034 20141 38* ME10=CSHR1(J,1) UD004* 20142 37* ME10=CSHR1(J,2) UD004* 20143 40* D0 65 K: 1,NUHS UD005 20144 41* IF(MP10:C0.*SHR1(K,1))GO TO A1 UD005 20144 41* IF(MP10:C0.*SHR1(K,1))GO TO A1 UD005 20151 43* 61 KK:K UD005 20152 44* 61 KK:K UD0065 20153 45* 65 C0N1Nec UD0065 20154 45* 65 C0N1Nec UD0065 20155 46* 62 CSHR101,21:SCH11,41,51 UD0065 20155 46* 65 C0N1Nec <td>×</td> <td>66130</td> <td>30÷</td> <td>5</td> <td>NKORAL (20%, SHEAP PANEL)</td> <td>600025</td> <td></td> <td></td>	×	66130	30÷	5	NKORAL (20%, SHEAP PANEL)	600025		
X CU132 33. NPAR1124 CU101 CU	×	60131	32#	(**	THERE IS ONLY ONE CONST. CODE FOD SUFAR DANELS	<u></u>		······
I L0133 Site MPAR (21:NUM8 D00031 C0 C0134 Site MPAR (51:1) C00034 L0135 Site MPAR (51:1) C00034 L0136 Site MPAR (51:1) C00034 L0141 Site MPAR (51:1) C00034 L0142 Site MEIDECSHR1(J., 1) C00094 L0142 Site MPIDECSHR1(J., 1) C00053 L0154 Site GO TO 65 C00053 L0154 Site GO TO 62 U00066 L0155 Site CONTINUE U00065 L0155 Site CSHR10J., SiteSKR1(J., 1) U00065 L0155 Site CSHR10J., SiteSKR1(J., 1) U00065 L0155 Site CSHR10J., SiteSKR1(J., 1) U00065 L0155 Site CS	X	60132	336	••••	NPAR (1)24	600023		
CD CD <thcd< th=""> CD CD CD<!--</td--><td>ΞΞ</td><td>60133</td><td>34#</td><td></td><td>NPAR (2) = NUM8</td><td>u00031</td><td></td><td></td></thcd<>	ΞΞ	60133	34#		NPAR (2) = NUM8	u00031		
GP135 364 MPAR(5)=1 GD0034 c0141 38* NE10=CSHR1(J,1) GD0044 L0142 39* MP1U=CSHR1(J,2) GD0044 L0142 39* MP1U=CSHR1(J,2) GD0044 L0143 40* D0 65 K=1,NUM15 GD0055 L0144 1F(NP10=L0=PSHR1(K+1))GO TO A1 GD0056 L0151 42* GO TO 65 GD0056 L0152 44* OT 0 62 GD0061 L0153 45* 61 KK=x UD0066 L0153 45* 62 CSH TOLJ,11×E1D UD0067 L0153 46* 62 CSH TOLJ,21=CSHR1(J,31 UD0067 L0154 47* CSH TOLJ,31=CSHR1(J,4) UD0067 L0155 46* 62 CSH TOLJ,31=CSHR1(J,4) UD0067 L0154 47* CSH TOLJ,31=CSHR1(J,4) UD0067 L0154 50* CSH TOLJ,31=CSHR1(J,4) UD0073 U0164 50* CSH TOLJ,41,41 S1 UD0073 U0164 </td <td>62</td> <td><u> </u></td> <td>35*</td> <td></td> <td>NPAR(4)=1</td> <td>600033</td> <td></td> <td></td>	62	<u> </u>	35*		NPAR(4)=1	600033		
cn136 37* U0 7L JELNUME L00044 L014 38* NEDDECSHR14J,1 G00046 L0142 37* NPIDECSHR14J,21 G00046 L0143 40* D0 65 KEI,NUH15 G00053 L0144 40* D0 65 KEI,NUH15 G00053 L0150 41* F(FKPTDL2C0FRH2(K,1)150 TO 61 G00053 L0150 42* G0 TO 65 G00055 L0152 44* G0 TO 62 U00056 L0152 44* G0 TO 62 U00060 L0155 45* 65 L0NINE U00065 L0155 45* CSHR1014J,12ECSHR14J,31 U00065 U00065 L0156 47* CSHR1014J,22ESKR14J,31 U00073 U00073 L0161 50* CSHR1014J,12ESKR14J,51 U00073 U00073 L0161 50* CSHR1014J,12ESKR14K,22 U00073 U00073 L0161 50* CSHR1014J,51ESKR14K,23 U00073 U00103 L0163 52* TO CON		68135	36*		NPAR(5)=1	606034		-
L0141 38* NEID=CSHR1(J,1) C0004 L0143 40* D0 65 K=1,NUM15 C00053 L0143 40* D0 65 K=1,NUM15 C00053 L0150 41* IF(NPID.E0.PSHR1(K,1))60 TO 61 C00053 L0151 43* 61 KK=K C00060 L0152 44* G0 TO 65 C00061 L0153 45* 65 L0N1INUE L000661 L0154 47* CSHR10J,1=KID L00065 L0155 46* 62 CSHR10J,1=KID L00065 L0156 47* CSHR10J,1=KID L00065 L0157 48* CSHR10J,3=CSHR1J,3 L00071 L0164 47* CSHR10J,5 L00071 L0164 47* CSHR10J,6=SHR1J,5 L00071 L0164 47* CSHR10J,6=SHR1J,5 L00071 L0164 50* CSHR10J,6=SHR1J,5 L00073 L0164 52* 70 CN11NUE L00103 L0163 52* 70 CN11NUE L00103 L0163 54* C71 FORPATI* CSHR1J,K,21,7) L00103 L0163 54* C71 FORPATI* CSHR1J,K,21,7) L00103 L0163 54* C71 FORPATI* CSHR1		<u></u>	. 37*		UO 76 J=1,NUMB			
L0142 37* MP1D=CSHR1(1,2) G00046 L0143 40* D0 65 KT_1,NUH15 G00053 L0150 41* IF(NP1D_E0.PSHR1(K,1))60 TO 61 G00053 L0150 42* G0 TO 65 G01065 L0151 43* 61 KKEK U00060 L0152 44* G0 TO 62 L00061 L0153 45* 65 CONINUE U00065 L0156 47* CSHR10(J,1)=KEID U00065 L0156 47* CSHR10(J,2)=CSHR1(J,4) U00067 L0157 48* CSHR10(J,4)=CSHR1(J,4) U00071 L0161 50* CSHR10(J,4)=CSHR1(J,4) U00071 L0162 51* CSHR10(J,4)=CSHR1(J,4) U00073 L0163 50* CSHR10(J,4)=CSHR1(J,4) U00073 L0163 52* 70 CONTINUE U0013 L0163 54* C71 FORMAT(YENK, Z1 U0013 L0163 54* C71 FORMAT(YENK, Z1, T) U0103 L0163 55* L0 C72 PRINT 73 U0103 </td <td></td> <td>60141</td> <td>38*</td> <td></td> <td>NEID=CSHR1(J,1)</td> <td>600044</td> <td></td> <td></td>		60141	38*		NEID=CSHR1(J,1)	600044		
D0143 40* D0 65 K=1,NDH15 D0 65 K=1,NDH15 C0145 41* IF(PID:EC,PSHR1(N,1))GO TO 61 GOD053 D0150 42* GO TO 65 GOD054 U0150 43* 61 KKEK U00060 U0152 44* GO TO 62 C00061 U0153 45* 65 C0N1NUE U00065 U0154 45* 62 CSHR10(J,1)T=NEID U00065 U0154 46* 62 CSHR10(J,3)T=CSHR1(J,4) U00065 U0160 47* CSHR10(J,3)T=CSHR1(J,4) U00071 U0161 50* CSHR10(J,5)T=CSHR1(J,6) U00073 U0161 50* CSHR10(J,6)T=CSHR1(J,6) U00073 U0161 50* CSHR10(J,6)T=CSHR1(J,6) U00073 U0163 52* 70 CONTINUE U00103 U0163 53* C URINT U00103 U0163 54* C71 FORPATI * CSHR10(J,K),K=1,7) U00103 U0163 54* C72	·	<u> </u>	37*		NPID=CSHR1(J,2)			
C1440 Friker Dicker SHATKA, Fride TO AL C00035 C0151 43* 61 KK=K 000056 C0151 43* 61 KK=K 000060 U0152 44* 60 TO 62 000061 00153 45* 65 CONTINUE 000065 00154 45* 65 CONTINUE 000065 00155 46* 62 CSHFIDIJ,1=KID 000065 00156 47* CSHFIDIJ,2=SSHR1(J,3) 000071 00161 50* CSHFIDIJ,4=CSHR1(J,4) 000073 00161 50* CSHFIDIJ,6=SFR1(J,4) 000073 00161 50* CSHFIDIJ,6=SFR1(J,6) 000075 00161 50* CSHFIDIJ,6=SFR1(J,6) 000075 00163 52* 70 CONTINUE 000103 00163 53* C PRINT71 000103 00163 54* C71 FORMAT(* CSHRIU ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) 000103 00163 55*		00143	40*		DO 65 K=1,NUM15	600053		
00130 42* 001005 00005 00151 43* 61 KK±K 000060 00152 44* 60 T0 62 00065 00153 45* 65 0NTINUE 000065 00153 45* 62 CSHRID(J,1)=KID 000065 00157 48* CSHRID(J,2)=CSHRI(J,4) 000071 00161 50* CSHRID(J,4)=CSHRI(J,5) 000073 00161 50* CSHRID(J,6)=PSHRI(J,6) 000075 00163 52* 70 CONTINUE 000013 00163 53* C PRINT 71 000103 00163 54* C71 FORMATI* CSHRID(J,K)=FSHRIKK.21 000103 00163 55* C 0071 00103 00163 55* C PRINT 71 000103 00163 56* C 20 PRINT 73 00103 00163 56* C 20 PRINT 73 00103 <t< td=""><td></td><td>0150</td><td><u> </u></td><td></td><td>17 INTID: CO.P.SHATIK, 1760 10 61</td><td>000053</td><td></td><td></td></t<>		0150	<u> </u>		17 INTID: CO.P.SHATIK, 1760 10 61	000053		
OB 101 OD 101 NRTH OD 001 U0152 44* G 0 TO 62 U00061 00153 45* 65 LONINUE U00065 U0155 46* 62 CSHR10(J,1)=NEID U00065 U0156 47* CSHR10(J,2)=CSHR1(J,3) U00067 U0157 48* CSHR10(J,3)=CSHR1(J,4) U00071 U0161 50* CSHR10(J,4)=CSHR1(J,5) U00073 U0161 50* CSHR10(J,5)=CSHR1(J,5) U00073 U0161 50* CSHR10(J,6)=PSHR1(K,2) U00073 U0163 52* 70 CONTINUE U00077 U0163 53* C PRINT 71 U0003 U0163 54* C71 FORMATI* CSHR1U ARAY JUST BEFORE LEAVING SHEAR FOR PAIR*) U00103 U0163 55* U0 72 J=1,NUM8 U00103 U00103 U0163 56* C72 PRINT 73, (CSHR1U(J,K),K=1,7) U00103 U00103 U0163 57* C73 FORMATI* AND MATCH U		60150	424	61		000050		
C0153 45* C01000 C0000 C0153 45* C01100 C00065 U0156 47* CSHRID(J,1)=KID U00065 U0156 47* CSHRID(J,2)=CSHRI(J,3) U00067 C0157 48* CSHRID(J,3)=CSHRI(J,4) U00071 U0160 49* CSHRID(J,4)=CSHRI(J,5) U00073 U0161 50* CSHRID(J,6)=FSHRI(KK,2) U00075 L0163 52* 70 CONTINUE U00103 U0163 52* 70 CONTINUE U00103 U0163 54* C71 FORMATI* CSHRID(J,K)*K=1,7) U00103 U0163 55* C U0.72 J=1,HUH8 U00103 U0163 56* C72 PINT 71 U00103 U00103 U0163 58* C ** FIND NUMHAT AND MATCH U00103 U00103 U0163 58* C ** FIND NUMHAT AND MATCH U00103 U00103 U0163 58* C ** FIND NUMHAT AND MATCH U00103 U00103 U0166 59* KK00E=0 </td <td>-</td> <td>60152</td> <td>44*</td> <td></td> <td>60 ID 62</td> <td>000001</td> <td></td> <td></td>	-	60152	44*		60 ID 62	000001		
U5155 46* 62 CSHRID(J,1)=NEID U00065 U5156 47* CSHRID(J,2)=CSHR1(J,3) U00065 U0157 48* CSHRID(J,3)=CSHR1(J,3) U00071 U0160 49* CSHRID(J,4)=CSHR1(J,5) U00073 U0161 50* CSHRID(J,5)=CSHR1(J,6) U00075 L0162 51* CSHRID(J,6)=PSHR1(KK,2) U00075 L0163 52* 70 CONTINUE U0003 L0163 53* C PRINT 71 U00103 L0163 54* C71 FORPAT(* CSHRID ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) U00103 U0163 55* C U7 J_1,HUMB U00103 U0163 55* C U7 J_1,HUMB U00103 U0163 57* C73 FORMAT(716) U00103 U0163 58* C ** FIND NUMHAT AND MATCH U00103 U0165 59* KK02=6 U00103 U00103 U0165 59* KK02=6 U00103 U00105 U0165 59* KK02=6 U00105		00153	45*	65	CONTINUE	000065		
L0156 47* CSHRIDIJ.2]=CSHRILJ.3] U00067 L0157 48* CSHRID(J,3)=CSHRILJ.4) U00071 U0160 49* CSHRID(J,4)=CSHRILJ.5) U00073 U0161 50* CSHRID(J,6)=CSHRILJ.60 U00075 L0162 51* CSHRID(J,6)=PSHRI(KK.2) U00075 L0163 52* 70 CONTINUE U00073 L0163 53* C PRINT 71 U00103 L0163 54* C71 FORMAT(* CSHRID ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) 200103 U0163 55* C U0 72 21,410048 U00103 U0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 U0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 U0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 U0163 57* C73 FORMAT(716) U00103 U0163 58* C ** FIND NUMHAT AND HATCH U00103 U0165 59* KK0L=6 C00103 U00103 U0165 59*		JU155	46+	62	CSHFID(J,1)=NEID	600065		
C0157 48* CSHRID(J,3)=CSHRI(J,4) U00071 00160 49* CSHRID(J,4)=CSHRI(J,5) U00073 00161 50* CSHRID(J,5)=CSHRI(J,6) U00075 00162 51* CSHRID(J,6)=PSHRI(KK,2) U00077 00163 52* 70 CONTINUE U00073 00163 53* C PRINT 71 U00103 00163 55* C U072_J=1,NUM8 U00103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 00163 57* C73 FORMAT(716) U00103 00163 58* C ** FIND NUMMAT AND MATCH U00103 00163 58* C ** FIND NUMMAT AND MATCH U00103 00165 59* KK01=6 U00103 U00103 00165 59* KK01=6		60156	47*		CSHRID(J.2)=CSHR1(J.3)	000067		
00160 49* CSHRID(J,4)=CSHR1(J,5) 000073 00161 50* CSHRID(J,5)=CSHR1(J,6) 000075 00162 51* CSHRID(J,6)=PSHR1(KK,2) 000075 00163 52* 70 CONTINUE 000103 00163 53* C PRINT 71 00103 00163 55* C 0072 00103 00163 55* C 0072 00103 00163 55* C 0072 00103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) 000103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) 000103 00163 57* C73 FORMAT(716) 000103 00163 58* C ** FIND NUMMAT AND MATCH 000103 00163 58* C ** FIND NUMMAT AND MATCH 000103 00163 58* C ** FIND NUMMAT AND MATCH 000103 00165 59* KK0E=0 000103 000103		60157	48 #		CSHRID(J,3)=CSHR1(J,4)	000071		
00161 50* CSHRID(J,5)=CSHR1(J,6) 000075 0162 51* CSHRID(J,6)=PSHR1(KK,2) 000075 0163 52* 70 CONTINUE 000103 0163 53* C PRINT 71 00103 00163 55* C 00 72 J=1,NUM8 00103 00163 55* C 00 72 J=1,NUM8 00103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) 000103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) 000103 00163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) 000103 00163 58* C ** FIND NUMHAT AND MATCH 000103 00163 58* C ** FIND NUMHAT AND MATCH 000103 00165 59* KKOLE6 00103 00103 00166 60* KKODE=0 00103 00105 00167 o1* CALL PAIK(KKUDE, CSHRID, PSHR1, NUM8, NUM16, KK0L + NUMMAT, MATCH, INDEx) 00106	(00160	49#		CSHRID(J,4)_CSHR1(J,5)	000073		
L0162 51* CSHRID(J,6)=PSHR1(KK,2) U00077 L0163 52* 70 CONTINUE U00103 L0163 53* C PRINT 71 U00103 L0163 54* C71 FORMAT(* CSHRID ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) 00103 L0163 55* C U0 72 J=1,NUM8 U00103 L0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 L0163 56* C73 FORMAT(716) U00103 L0163 58* C ** FIND NUMMAT AND MATCH U00103 L0165 59* KK0L=6 U00103 U00103 L0166 50* KK0DE=U U00105 U00105 L0167 o1* CALL PAIN(KKUDE, CSHRID, PSHR1, NUM16, NUM16, KK0L + NUMAT, MATCH, INDEx) U00106		00161	50×		CSHRID(J,5)=CSHR1(J,6)	000075		
L0163 52* 70 CONTINUE C00103 L0163 53* C PRINT 71 C00103 L0163 54* C71 FORMAT(* CSHRID ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) C00103 L0163 55* C U0 72 J=1,NUM8 C00103 L0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) C00103 L0163 56* C73 FORMAT(716) C00103 L0163 58* C ** FIND NUMMAT AND MATCH U00103 L0165 59* KK0L=6 C00103 L0166 b0* KK0DE=U UC0105 UC0105 L0167 o1* CALL PAIN(KKUDE, CSHRID, PSHR1, NUM15, KK0L + NUMMAT, MATCH, INDEx) U00104		<u></u>	51*		<u></u>			
L0103 53* C PRINT /1 L00103 L0163 54* C71 FORMAT(* CSHRID ARRAY JUST BEFORE LEAVING SHEAR FOR PAIR*) C00103 00163 55* C 00 72 J=1,NUM8 C00103 00163 56* C72 PRINT /7, (CSHRID(J,K),K=1,7) C00103 00163 56* C72 PRINT (7,6) C00103 00163 58* C ** FIND NUMMAT AND MATCH G00103 00163 58* C ** FIND NUMMAT AND MATCH G00103 00165 59* KK0L=6 G00103 00166 50* KK0DE=C UC0105 00167 o1* CALL PAIN(KKUDE, CSHRID, PSHR1, NUM8, NUM16+KK0L+NUMAT, MATCH+INDEx) U00106		10163	52*	ç′0		606163		
L0103 54# C/1 FORPATT' CSHRID ARRAY JOST BEFORE LEAVING SHEAR FOR PAIR') L00103 L0163 55* C U0 72 J=1,NUM8 L00103 L0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 L0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) U00103 L0163 57* C73 FORMAT(716) U00103 L0163 58* C ** FIND NUMMAT AND MATCH U00103 L0165 59* KK0L=6 U00103 L0166 50* KK0DE=U U00105 L0167 01* CALL PAIN(KKUDE, CSHRID, PSHR1, NUM8, NUM16, KK0L+NUMAT, MATCH, INDEx) U00106		10163	534		PRINT /1			
CONST Constant Constant Constant C0163 56* C72 PRINT 73, (CSHRID(J,K),K=1,7) C00103 C0163 57* C73 FORMAT(716) C00103 C0163 58* C ** FIND NUMMAT AND MATCH C00103 C0165 59* KK0L=6 C00103 C0166 b0* KK0DE=C C00105 C0167 o1* CALL PAIN(KKUDE, CSHRID, PSHR1, NUM8, NUM16, KK0L + NUMMAT, MATCH, INDEx) C00106		00163	94# 66#	C/1	TORTATI' CSHRID ARRAT JUST BEFORE LEAVING SHEAR FOR PAIR'S			
UD163 57* C73 FORMAT (716) UD103 UD163 58* C ** FIND NUMMAT AND MATCH UD0103 UD165 59* KKOL=6 C90103 UD166 b0* KKODE=U UC0105 L0167 o1* CALL PAIN(KKUDE,CSHRID,PSHR1,NUM8,NUM16,KK0L+NUMMAT,MATCH,INDEx) U00106		60163	<u> </u>	C72	PRINT 73. (CSHPTOLI.K).K-1.7)			
U0163 58* C ** FIND NUMMAT AND MATCH U00103 U0165 59* KK0L=6 00103 U0166 b0* KK0DE=U U00105 U0167 o1* CALL PAIN(KKUDE,CSHRID,PSHR1,NUM8,NUM16,KK0L+NUMMAT,MATCH,INDEx) U00106		((0))63	57*	673	FORMAT(7)63	000103		
LD165 59+ KKOL=6 COULU3 LD166 b0+ KKODE=0 UCULD5 L0167 o1+ CALL PAIN(KKUDE,CSHRID,PSHR1,NUM8,NUM16,KK0L+NUMMAT,MATCH,INDEx) UCULD5		60163	58*	C **	FIND NUMMAT AND MATCH			
L0166 L0105 L0167 01* CALL PAIN(KKUDE,CSHRID,PSHR1,NUM8,NUM16,KK0L+NUMMAT,MATCH,INDEx) L00105	_	UD165	59¢		KKOL=6	000103		
LU167 01# CALL PAIN(KKUDE, CSHRID, PSHRI, NUM8, NUM16, KKOL, NUMMAT, MATCH, INDEX) UODIG6		60166	້ 6 ມີສ		KKODEEC	UCU105	· · · · · · · · · · · · · · · · · · ·	<u> </u>
		60167	01*		CALL PAIN(KKUDE, CSHRID, PSHRI, NUM8, NUM16, KKOL, NUMMAT, MATCH, INDEX)	000106		

	<u></u> \$н	EAR		DATE 073080	PAGE	3
	0.017	62≢	NDAD 13 NIIMMAT	000121		
	00171	63#	No. 1 F (1) 2, 7951	000123		
	60173	64*	795 FORWAT(" COMM ELEMENT CONTROL FROM SHEAR")	000130		1
	60174	65*	LTTE(12,50%)(NPAR(1),J=1,5)	000130		
	60177	66*	504 FORMAT (LIS)	000152		
	L0177	67+	C ++ SET UP HATERIAL PROPERTIES DATA	600152	•	
·	U02nn	68+	DO 83 J1G=1.NUMHAT			
	00203	69*	MTPRO1(J10,1)=INDEX(J10)	600152		
	60204	70*	MTPR01(J10+2)=1	000154		
	C02U5	71*	DO 84 J11=1+NUMMAT	000161		·. · ·
_	60216	12*	IF (MATCH(J11+1)*EQ*INDEX(J10))GQ TO 85	<u>00161</u>		·
	L0212	73 <i>*</i>	GO TO 84	600164		
·	<u></u>		85 NROVEHAICH(J11.2)	00166		
	00214	/5¥ 76 +		000167		
	60213	77#		000173		,
	6.0220	784	TPROJUTELISTIC	600175		1
	<u>μο 22 ι</u>	79*	MTPR03(J10.2)=MAT12(NRoW.1)	600177		
	LU222	81.*	MTPR03(J10.3)=MAT12(NROW.3)	000201		
	ÜG223	81*	MTPR03(J10,4)=MAT1>(NROW,10)	000203		
	00224	62*	83 CONTINUE	000207		
	60226	ь3 ¥	WRITE(12,349)	600207		3
	00230	84*	349 FORMATI' COMM MATERIAL PROPERTIES FROM SHEAR .	<u>000221</u>		·
	i0231	85*	DO 350 J12=1,NUMMAT	600221		,
·	60234	<u>6*</u>	<u>350 WRITE(12,300)(MTPR01(J12,J13),J13=1,2),MTpR02(J12),(MTPR03(J12,J13</u>	000221		'
	CD234	87*	1,,,13=1,4)	600221		,
- X	<u> </u>	68*	300 FORMAT (215,F10+3/2F10+0,F10+3)F10+0)			, `,
2	00250	89¥	C ** GENERATE ELEMENT LOAD MULTIPLIERS	600247		
ų —	00251	<u> </u>	HRITE 10:1111			·····
-с	60253	914	III FORMAL TIDA, ELEMENI LUAD HULIPLIERS FOR CONSISCODE 17	100200 (co260		
ట —	69257	<u> 93</u> *		<u> </u>	······	,
	LG262	94±	115 EMUL(K6,K7)=G.	000260		
	60265	95*	D0 120 K8=1,4	000271		1
	<u>60276</u>	96*	WRITE (6,112) VAR(K8)	600271		
	60273	97*	112 FORMAT (2X, "FOR LOAD ", A1," ENTER X, Y, Z ELEMENT LOAD FRACTIONS, IN	000276		-
·	60273	<u> </u>	1 THAT ORDER. DEFAULIT =ALL ZEROS*)	606276		*
	60274	99 *	READ (5,7)DUM1,DUM2,DUM3	000276		•
	L0301	<u>100</u> #	IF (DUM1+EQ+0+)60 TO 320	000306		
	00393	101*	EMUL(1,K8)=DUMI	C00310		4
	00304	102*		000312		
	00305	103*		00-12-		-
	6031.	105*		000321		
	r:n312	164	1117 FORMATAL COMM FLEMENT LOAD MULTIPLIERS FROM SHEAR*1	000331		-
	00313	107#		000331		
•	00316	148*	121 WRITE(12,116)(EMUL(K9,K10),K10-1.4)	Ú08331		
	<u>u</u> u325	109+	116 FORMAT (4F10.0)	000345		•
	60325	110+	C ** GENERATE ELEMENT DATA	600345		•
	60326	111#	WRITE (6,127)	000345		
· _	<u>00336</u>	112+	127 FORMAT (15x, ELEMENT DATA FOR CONST.CODE 2")	000355		
	00331	113*	DO ISU KROWEL,NUMB	000355		•
	<u> </u>	114#		600355	· · · · · ·	
	្រព្ឋរទទ	1157	WHILE TO FISUITA DESTEN VADIALE NO TOVEOD SE NO TEN	000356		
·	1.0341	117.	DEADIS 71 CSADIOIKDON 71	<u> </u>		~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~
	60344	▲▲「平 】] 서 #	$ \frac{1}{10} $	100304 (mm.172		
	<u></u>				i	

SHEAR				DATE 073080	PAGE	4
00347 11	19*	131	FORMAT (2X. "ENTER EDGE SUPPORT CONDITION. TSH. FOR FL. NO. ". TS)	600400		
4n35. 1	20*		READ (5-7) CSURTD(WROW-R)	004000		
60353 12	21*			600406		
uU356 14	22*	132	FORMAT 12X. 'ENTER DESIGN VARIABLE FRACTION.FRC.FOR FI. NO. '. 14	000414		
Un 356 12	23×		IDEFAULT=1)	000414		
UD357 12	24#		ELUAT2(KROW,1)=1.	000414	····	
LO360 12	25*		READ (5,7)DUH	000416		
Ln363 12	26*		IF (LUM.NE.U.ILUAT2(KROB,1)=DUM	000424		
LÕ365 12	27*	15 ₀		000432		
LD367 12	20*		NNCOL1=8	600432		
LG370 12	29*		NNCOL2=3			
60371 13	30*		CALL ELORD (NUMB, CSHRID, ELDAT2, NNCOL1, NNCOL2)	000436		
00371 13	<u>31* C</u>		PRINT 179	000436		
60371 13	32* C	179	FORMAT(//' ELEMENT DATA RECORD ON FILE 12, IN SHEAR'/)	000436		
60372 13	33*		WRITE(12,1135)	000445		
u0374 13	34 *	1135	FORMAT(* COMH EL. DATA FROM SHEAR*)	000452		
<u>66375 13</u>	35*		D0. 160 M12=1.NUM8	000452		
u040u 13	36*	180	wRITE (12,136)(CSHRID(H12,H13),H13=1,8),ELDAT2(H12,1)	000461		
<u>00406 13</u>	<u>37* c</u>	180	<u>wRITE_(6:136)(CSHRID(H12:H13).H13=1.8),ELDAT2(H12:1)</u>	600461		
0041 ₀ 11	38 ÷	136	FORMAT (815,F1G+0,25x)	800504		
60411 13	39*		DO. 19D K1=1.NUMA	600504		
00414 14	40*	190	IDV4(K1)=CSHRID(K1,7)	000504		
<u>UC416 14</u>	41*		RETURN	000506		
60417 14	42*		ÉNU EN EN EN EN EN EN EN EN EN EN EN EN EN	000557		
oHUG+P	SIGMA					
	.					
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SIG	MA						··· ·· ··	DATE 073080	PAGE	1	
èFOR • S	SIGMA . STG	на									
HSA E3	-07/30/80-0	9:46:53 (6,)									
SUBRO	UTINE SIGMA	ENTRY POINT									
STORA	SE USED: CO	DE(1) 000044; DA	TA(D) 000052;	BLANK COMMON	1121 000000	<u>_</u>			<u></u>	<u></u>	
EXTER	NAL REFEREN	CES (BLOCK . NAME)								
	NDDTE										
<u> </u>	NI025	· · · · · · · · · · · · ·									
0005	NRDUS										
<u>1006</u>	NERR35										
SLORA	DE ASSIGNME	NT (BLOCK, TYPE	RELATIVE LO	CATION, NAME))						
	060001 1	0F COUL	000016 1116		10036 7F	<u> </u>	00042 INJPS), J		
								·			<u>: .</u>
60101	1 *	SUBROUTINE	SIGMA (MATID, L	L, XHAT12)				000005			
<u> </u>	<u>2</u> *	DIMENSION X	MAT12(20+10)					000005			
60104	3*	PRINT 10, MA	TID					000005			
0107	4*	10 FORMATI //	F <u>or Material n</u> Ao storneydd 1	10 15 ENI	ER ALLUWAHL	L ILNSILL CU	E SUDE	<u> </u>			
UG107	5÷ 6*	2 TO USE F F	ORMAT WITH DEC	THAL POINT /		THESP PF D	_ 30KL	000016			
69110	7+	UO 15 J=8.1	0					000016			
<u> </u>	8*	15 READ 15 71XH	AT12(LLL,J)			<u></u> ,		000016			
00113	9# C	15 XMATIZILLL,	J)=HATID#1000	.+J*100.				600016			
	<u> </u>	PRINT SO	<u> </u>					000024			
60117	12 ¢C	00 20 JE8.1	c					000024			
60117	13# C	20 PRINT 60,LL	L,J,XMAT12(LLL	.,J)				000024			
60117	<u>14*</u> C	5D FORMATI * XM	ATI2 IN SIGHA	·)				000024			
60117	15* C	60 FORMATI' XM	AT128 ,I3,','	,13,11=",E1	2.5)			600024			
L0121	17*	END	···· ··· <u>·</u> ·					000043			
END FOR											
⊎HDG,P	STOR			<u>.</u>	·····						
				•						<u></u>	
			<u> </u>					****			
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STOR										DA	TE 0730	80	PAGE	1
aruris	STOR ST	-08 . 47	110 (10)											
		-07147												
<u>SUBKON</u>	TINE STO	R	ENTRY POIN	1_L00130				·						
STORAU	E USED:	CODE(1) 000152; D	ATAIG) CO	1174; BL	ANK COMM	ON(2) 000000							
										· .		,		
EXTERN	AL REFER	<u>ENCES</u>	IBLOCK, NAM	<u>E)</u>										<u> </u>
<u> 5003</u>	NERR 35													
STURAU	E ASSIGN	MENT	(BLOCK, TYP	E, RELATI	VE LOCAT	ION, NAM	E)				······			
	040633	1050	(0.01	a	106	1001	000055 1170	0001	nun 71 1	7.06	0001	000071	1336	
	<u> 0600666</u>	196	<u>6001</u>	000045 2	11	BUUD I	001131 I	0000	<u>I CU1132 I</u>	I	0001	001135	INJPS	
	I 001130	J	C000 I	00000C S	TORE									
								<u> </u>						
LC1U1	1*		SUBROUTINE	STORIIST	CP .NUM .C	.VEID.NC	QL)				0000	31		
66101	2*	(**	ISTOP=NPAR	(2)= NO.	OF ELEME	NITS WITH	SPECIFIED CO	NST. CODE	E. INPUT		0000	31		
<u>L0101</u>	3*	(**	NUM=TOTAL	VO. OF C	CARDS FO	<u>R THIS E</u>	LEMENT. E.G.	FOR ROD	S NUM=NUM5.	INPUT	0000	31		
L0101	4 4 5 ±			NIÈGER AR IT-	RAY FORM	ED FROM	THE NUM C CAR	$DS \neq E \cdot G$	•,CROD•		0000	31		
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CONCLUSIONS AND RECOMMENDATIONS

Currently NASAP transforms CAD-generated NASTRAN data to data for DESAP I or DESAP II with minimum input from the engineer. The program has been thoroughly checked.

An effort is underway to implement the design cycles shown in Figure 2. Such a capability will greatly enhance the effectiveness of DESAP I and DESAP II by allowing the simultaneous satisfaction of stress, displacement, and buckling constraints.

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MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

DEPLOYABLE STRUCTURE DESIGN FOR THE SCIENCE AND APPLICATIONS SPACE PLATFORM

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Date:

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DEPLOYABLE STRUCTURE DESIGN FOR THE SCIENCE AND APPLICATIONS SPACE PLATFORM

By

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ABSTRACT

NASA has long been interested in deployable structure technology as a means for achieving efficient spacecraft packaging for launch. An important application currently under study is the Science and Applications Space Platform (SASP). In this study, basic concepts regarding deployable structures design, including systematic design/classification schemes and a "deployability" criterion, are proposed for use in synthesis, analysis and evaluation of alternative deployable structure designs. Using design guidelines based on SASP requirements and the basic concepts developed, a variety of new designs are synthesized, and these along with previously proposed designs are analyzed and evaluated. Recommendations and conclusions regarding optimal deployable structure design are made based on insights gained in the study.

I. INTRODUCTION

NASA has long been interested in deployable structure technology as a means for achieving efficient spacecraft packaging for launch. An important application currently under study by NASA involves the Science and Applications Space Platform (SASP). A representative configuration (Fig. 1) has been evolved which satisfies the SASP objectives of providing accommodation for the simultaneous operation of several payloads of various science and application disciplines. The configuration incorporates three independently oriented platform arms, dedicated to celestrial, solar, and Earth viewing, respectively. Each platform arm provides interface provisions for payload carriers at two locations, and each location has provisions for two interfaces on opposite sides of the platform arm. The platform arms utilize deployable structures which allow compaction for launch in the Orbiter cargo bay.

A variety of deployable structure concepts have been proposed over the years (see Ref. [1]* for example) to meet different spacecraft packaging needs. In addition, several specific design concepts have been proposed for use in SASP, some of which are presently under development by NASA/MSFC. There does not exist, however, any clear-cut agreement regarding a preferred design approach for SASP, nor does it appear that all viable design alternatives have been identified. This report documents a 10-week, one-man effort, conducted between late May 1980 and August 1980, to take a fresh look at the deployable structure design problem in light of SASP design goals and requirements. Emphasis in this study has been placed on the mechanism aspects of the deployable structures problem. Structural considerations have been addressed only in so far as they impact the mechanism problem.

II. OBJECTIVES

The principal objectives of this study are (1) to completely define the deployable structure design problem in light of SASP design goals and requirements; (2) develop basic concepts relating to design morphology, systematic synthesis, deployment method, and performance criteria such as deployability, compactability, etc. which can be used to assist in the synthesis, analysis, and evaluation of deployable structure designs; (3) identify alternative deployable structure designs which appear to hold promise for the SASP application;

*Numbers in brackets refer to references at end of paper.

(4) analyze and evaluate new and previously proposed designs; (5) investigate various detail design considerations relating to structural dimensions, control of structural stiffness and damping, etc.; and (6) summarize findings in the form of recommendations for optimal design.

III. DESIGN GUIDELINES

For the purposes of this study, it is assumed that, to be acceptable, a deployable structure design should conform to the SASP design goals and requirements as currently envisioned in reference [2]. These requirements are summarized as follows:

(1) <u>State-of-the-Art Constraints</u>. The design should utilize current design techniques and materials in order to minimize the need for development of new technologies and the use of unproven space operations.

(2) Astronaut Participation. Deployment utilizing an astronaut in EVA mode should be avoided. The astronaut may be utilized in a back-up role.

(3) <u>Retract Capability</u>. In order to provide maximum flexibility and contengencies to conduct mission operations, it is desirable, but not necessary, that a retract capability of the deployed structure on orbit be provided.

(4) Payload Utilities Accommodation. The platform structure should facilitate means for distribution of payload utilities in the form of a separate electrical harness to each payload carrier interface (Fig. 1). Each harness will consist of 4-1/0 power cables plus other electrical and communication leads.

(5) Launch Packaging. The envelope of the platform arm in its compacted form must be such that the three platform arms can be accommodated within the Orbiter cargo bay with each of the arms connected to the SASP platform support module.

(6) <u>Misalignment and Distortion</u>. The maximum misalignment between the payload carrier interface and the platform arm mechanical interface at the rotary joint should not exceed <u>+1.0</u> degree. This alignment requirement is to include effects of fabrication tolerances, joint mechanical dead band, and interface misalignment. Dynamic stability of the platform arm alignment will be held to <u>+0.1</u> degree, including effects such as cyclic thermal distortion, structural distortion due to environmental and induced loads, and mechanical dead band.

- (5) The deployment drive should be small, mechanically simple, and straight forward in its operation.
- (6) A retract capability is desirable.
- C. Deployed Structure Considerations
 - (1) The deployed and rigidized structure should have a minimum of dead-band or other unwanted relative motion.
 - (2) Structural properties should not degrade or otherwise vary due to fluctuating loads or other adverse conditions inherent in the space environment.
 - (3) Mounting points of the deployed structure should lie in a plane normal to the longitudinal axis of the structure in order to permit interfacing of the structure with the platform support module and the payload carrier interface.
- D. General Considerations
 - (1) The overall deployable structure concept should be mechanically simple and free from unnecessary design complexities.
 - (2) Structural links and connections should be easily manufacturable from materials suitable for space applications.
 - (3) The design should be insensitive to manufacturing error and tolerance build-up; close tolerances should be avoided.

IV. Basic Concepts

The purpose of this section is to develop some basic concepts which can be used to assist in the synthesis, analysis, and evaluation of deployable structure design. As a starting point, it is useful to note that deployable structures operate both as mechanisms during the deployment stage and as structures after they are fully deployed. Conversion of the deployable structure from a mechanism into a structure is facilitated by hardening or freezing one or more of the kinematic pairs which connect the structural links together. It should also be noted that, depending on the deployable structure design, deployment

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5	6	6	7	5	5	6	6	
7	9	8	10	7	8	8	9	
9	12	10	13	9	11	10	12	
11	15	12	16	11	14	12	15	

TABLE 1. Possible Link-Joint Combinations to Give a Specified Mobility Based on Equation (1)

Examination of the deployable, three-sided planar truss structure of Figure 2a shows it to be unsatisfactory with regard to interfacing and mounting needs. Altering link proportions and mounting point locations gives the configuration of This design is unsatisfactory structurally, but its Figure 2b. square ends meet interfacing and mounting requirements. From Table 1, the next possible mechanism with a mobility of 1 has n = 6, $j_1 = 7$. Using this combination results in the foursided planar truss structure depicted in Figure 2c. This configuration is acceptable structurally and meets interfacing and mounting needs. Also, like the three-sided truss (Figure 2a), it requires only one imput motion for constrained deployment and can be converted to a structure by freezing only one joint.

Efforts to synthesize deployable structure designs utilizing more complex arrangements and numbers of links and joints resulted generally in designs which, if they were acceptable structurally, turned out to be various combinations of the three and four-sided planar structures characterized by Figure 2a and 2c. This insight suggests that the simplest deployable structure designs consist of a series of repeating cells, each of which are based on very simple planar structures. This conclusion is substantiated by the fact that most practical designs proposed to date are applications of this approach.

B. <u>Morphological Analysis</u>. Having decided that the simplest and therefore most practical deployable structures are made up of a series of repeating cells, the next step is to carefully examine the morphology of the simple planar structure or cell. Figure 2 shows that each simple planar structure is composed of three different structural links, namely the longeron, the lateral, and the diagonal. Consider now that each of these links can be constructed to have one of five different properties. A link can be rigid in which case its length is fixed; it can be telescoping in which case its length is changeable; it can fold at its midspan such as the longeron of Figure 2a or the diagonal member of Figure 2c; it can be flexible in which case it is rigid in tension but buckles elastically in compression; or it can be separable in which case parts of the link are not contiguous in the compacted mode.

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Different joint types can also be used to connect the various structural links. Observing the single-degree-of-freedom joint restriction limits joint type selection to pinned joints (revolute pairs) and sliding type joints (prismatic pairs). A screw pair can be substituted for a slider to facilitate actuation. In the case of flexible diagonal links, ball and socket joints and wrapping pairs (e.g., cable and drum, belt and pulley, etc.) can be utilized as long as the structure remains properly constrained. Also, properly designed flexural pivots or plastic hinges can be used in place of pinned or ball and socket joints. Finally, similar to the separable link, joints can be made detachable to facilitate more efficient compaction of the structure.

It should be noted that, kinematically speaking, the telescoping link and sliding pair are identical. However, from the standpoint of visualizing deployable structure design, the ability of the telescoping link to change length is an important property and hence it is treated separately from other sliding pairs. In mobility determinations, the telescoping link should be considered as two rigid links joined by a sliding pair. Similarly, the folding link is acutally two rigid links connected by a revolute pair. But, for the purposes of visualizing deployable structure design, it is treated as a particular link type. As will be shown subsequently, this deviation from conventional kinematic thinking leads to a powerful systematic synthesis procedure.

C. Deployment Methods. Deployment of the structure can be facilitated (1) manually using astronauts in EVA, (2) mechanically using remote manipulators, teleoperators, etc.; or (3) automatically using a self-contained drive system. All deployment methods other than the automatic methods may be classified as "erectable" methods. Automated deployment methods may be further subdivided as follows:

<u>Case 1.</u> The entire, multi-cell deployable structure is designed as a linkage having a mobility of 1. Hence, only one link need be driven to produce constrained motion during deployment.

Case 2. Actuating links in each cell are interconnected such that actuation of one link produces quasi-simultaneous deployment of all cells. angles, and other parameters of mechanisms which give insight as to whether a mechanism is a good one or a poor one are commonly used. Examples of these include mechanical advantage, transmission angle, and pressure angle. Many of these have a number of features in common, including the fact that most can be related to the velocity ratios of the mechanism and therefore can be determined solely from the geometry of the mechanism. However, most also depend upon some knowledge of the application of the mechanism, especially of which are the input and output links.

In the case of deployable structures, a more general "index of merit" is required since there are no clearly defined output links. A survey of the literature indicates that the index proposed by Denavit [4] may be useful as a measure of deployability. This index of merit is the determinant (Δ) of the coefficients of the simultaneous equations relating the dependent velocities of a mechanism. When this determinant becomes small, the mechanical advantage also becomes small and the deployability of the structure is reduced. This same determinant also appears in the denominator of the dependent accelerations and all other quantities which require taking derivatives of the loop-closure equation. Consequently, it is true in general that, if this determinant is small, the deployment mechanism will function poorly in all respects - force transmistransformation, sensitivity to manufacturing sion. motion errors, and so on.

The deployability index (Δ) proposed above depends on the deployable structure geometry, link dimensions, and on which link is driven to effect deployment (i.e., rotation of a link, contraction of a telescoping member, etc.). Consequently, the deployability index can be used to determine the most suitable actuation method for a particular design and to compare deployability potential of alternative designs.

Design Complexity. Design complexity is a nebu-F. lous concept which is difficult to quantify and yet it has an important bearing on the acceptability of alternative deployable structure designs. In general, it is safe to say the the probability of achieving high deployment reliability as well as meeting deployed structure alignment and stiffness design goals will decrease with increasing design complexity. When examined carefully, design complexity is found to involve a variety of factors such as manufacturing methods, materials, space, and the case of deployable In structures, these economics. considerations correlate well with the number of kinematic links, n, the number of joints, j_1 , and the mobility, m, of the structure. Mobility is involved because deployment system complexity increases with increasing degrees-of-freedom of the

Examination of this approach shows that, although the four considerations proposed are valid, they are not independent of each other in every case. Hence, the real driver for systematic synthesis in this approach is found to be the number of different link type combinations which are available. That is, the five link types (rigid, fold, telescoping, flexible, and separable) taken in groups of three (longeron, lateral/diagonal, and diagonal) results in a total of $5^3 = 125$ different possible combinations. Further variatons are possible by using different combinations of pinned and sliding joints as well as other joint types.

Possible link type combinations were organized by grouping the three-sided planar truss links (Fig. 2a) in the order of longeron-diagonal-diagonal and grouping the four-sided planar truss in the order of longeron-lateral-diagonal. Each link type was given the letter designation shown in Table 2. This notational convention gives the following 25 column by 5 row array of possible link type combinations for both the three and foursided planar truss cell.

AAA,...,AAE,ABA,...,ABE,ACA,...,ACE,ADA,...,ADE,AEA,...,AEE BAA,...,BAE,BBA,...,BBE,BCA,...,BCE,BDA,...,BDE,BEA,...,BEE CAA, DAA, EAA,....,EEE

In addition to systematic synthesis, the organizational scheme of Table 2 suggests a convenient method for classifying or coding various deployable structure concepts. Employing the notation of Table 2 gives the following alpha-numeric code,

X - X - XXX/XXX - X Deployment Method (Case 1 thru 4 and Erectable) Additional Link Combination groups used as needed. Diagonal Link Type (A,B,C,D, or E) Lateral or Diagonal Link Type (A,B,C,D, or E) Longeron Link Type (A,B,C,D, or E) Basic Repeating Cell Structure Type (3 or 4-sided) Deployment Direction (1,2, or 3- dimensional)



* MOBILINY AND COMPLEYINY ARE CALCULATED FOR PLANAR STRUCTURE

Figure 3. Previously Proposed Deployable Structure Concepts for SASP

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Figure 4. Alternative 1-4-AAA Designs





Figure 5. New Deployable Strucutre Concepts for SASP Application

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Loop Closure Equations:

$$\vec{r}_{1} + \vec{r}_{2} + \vec{r}_{3} + \vec{r}_{4} = 0$$

$$\vec{r}_{1} + \vec{r}_{5} + \vec{r}_{4} = 0$$

$$\Delta_{1} = f (\vec{r}_{1}, \vec{r}_{2}, \vec{r}_{3}, \vec{r}_{4}, \vec{r}_{2}, \vec{r}_{4})$$

$$\Delta_{2} = f (\vec{r}_{1}, \vec{r}_{4}, \vec{r}_{5}, \vec{r}_{4}, \vec{r}_{5})$$

$$\Delta_{1} = \int_{1}^{2} \Delta_{1} = \Delta_{1} + \Delta_{2}$$



Use of equation (3) is illustrated in Figure 6. Here it is seen that one cell of the MSFC-Hybrid design (Fig. 3a) contains two loop-closures and hence, its deployability index is the product of the "index of merit" or Δ calculated for each loop-closure. Since this design utilizes Case 2 deployment, the deployability index for the cell is also the deployability index `for the structure as a whole.

Examination of the large variety of deployable structure design concepts synthesized in this study shows that each design is made up of different combinations of basic mechanisms or linkages, where each linkage defines a particular loopclosure. The basic linkages comprising the selected designs of Figures 3 and 5 are presented in Figure 7. The deployability index (Δ) for each possible input motion to these linkages has been derived as a function of the link dimensions 1, h, and d and the degree of deployment, $x^* = x/1$, where $0 \le x^* \le 1$. In addition, each deployability index has been plotted as a function of percent deployment.

The results depicted in Figure 7 can be used in conjunction with equation (3) to gain considerable insight regarding detail design of deployable structures. Remembering It should be noted that a large 1/h ratio (or for a given h, a large 1 dimension) not only improves deployability, but also decreases the number of cells required to produce a required deployed length, L. Hence, design complexity of the overall structure will be reduced by using large 1/h ratios.

B. <u>Compactability Analysis</u>. Based on the design guidelines, a high degree of compactability is not needed in the SASP application. Nor is high compactability particularly desirable in this application because of complications arising due to handling of the utility cables. It is informative, however, to examine the sensitivity of compactability to changes in structural dimensions. Using the ratio of deployed length to compacted volume (L/V) as a measure of compactability, it is found that, for all designs, the magnitude of L/V and therefore, compactability, is increased as the l/h ratio is made larger. This is at least partly due to the reduction in the number of cells produced by a large l dimension. It should be noted that, for designs where L/V ratio involve complicated functions of l/h, compactability is improved by making h small as well as by making l large.

C. <u>Rigidization Considerations</u>. It has been stated previously that the deployable structure can be converted into a structure by hardening or freezing joints until the mobility is less than or equal to zero. The question is where to place the locking device, i.e., which joints should be hardened or frozen.

In a system where energy is not dissipated, the products of deflection and forces are constant (equal to the energy)

energy in = energy out

$$F_{a} \bullet \delta_{a} = F_{b} \bullet \delta_{b} = T_{c} \bullet \Theta_{c} = T_{d} \bullet \Theta_{d}$$
(4)

where a, b, c, and d are arbitrary points on the deployable structure, F is the force in the direction of the deflection δ , and T is the torque in the direction of the angular deflection θ . The product of velocity and force is also constant (equal to the power)

power in = power out

$$F_a \bullet V_a = F_b \bullet V_b = T_c \bullet \omega_c = T_d \bullet \omega_d$$
(5)

where V is the linear velocity and ω is the angular velocity.

These new concepts, as well as other previously proposed designs, were analyzed and evaluated.

Although no clear-cut, "best design" emerged from this effort, several insights into deployable structure design for the SASP application did become apparent. These insights are summarized by the following conclusions and recommendations:

(1) It is important to keep the deployable structure design as simple as possible in order to achieve required reliability goals. Poor deployability associated with Case 1 deployment, randomness and other "uncertainties" associated with Case 2 deployment, and extra weight and complexity associated with Case 4 deployment make Case 3 deployment appear most appropriate for the SASP application. Designs which minimize the number of deployment drives and are, at the same time simple, should be preferred.

(2) Both deployability and compactability are enhanced by large 1/h ratios. In addition, the number of cells which must be deployed to achieve a desired deployed length is reduced by large 1/h. It is therefore recommended that the largest 1/h ratio consistent with structural and spacecraft requirements be used.

(3) Because of the large number and wide distribution of joints in a deployable structure, it is likely that the dynamic behavior of the structure can be tailored through selective hardening of various joints and use of joints designed to have specific damping properties. It is recommended that the feasibility of such an approach be further investigated and verified.

Although much of the work in this study was directed (4) toward the SASP application, many of the results are applicable to a wide variety of deployable structure needs. The systematic design procedure developed led to a number of promising deployable structure concepts which were rejected, in this study, because they did not fit the SASP application. Since man first ventured into space, deployable structure technology has been an integral part of the spacecraft "packaging" problem. It appears that there will be many future needs for deployable structures in space. In view of this, and to avoid future duplication of effort, it is recommended that the material developed in this study, as well as that developed in other studies concerned with deployable structures, be consolidated into a Deployable Structures Handbook. This handbook should be designed in such a way that it can be used to help identify the best and most appropriate deployable structure approach for a particular application.

NASA/ASEE SUMMER FACULTY RESEARCH FELLOWSHIP PROGRAM

MARSHALL SPACE FLIGHT CENTER THE UNIVERSITY OF ALABAMA

PAYLOAD MAINTENANCE COST MODEL

FOR THE SPACE TELESCOPE

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Frank Pizzano

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PAYLOAD MAINTENANCE COST MODEL

FOR THE SPACE TELESCOPE

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ABSTRACT

The research project focuses on the development of an optimum maintenance cost model for the Space Telescope for a fifteen (15) year mission cycle. A review of various documents and subsequent updates of failure rates and configurations were made. The reliability of the Space Telescope for one year, two and one-half years, and five years were determined using the failure rates and configurations. The failure rates and configurations were also used in the maintenance simulation computer model which simulates the failure patterns for the fifteen (15) year mission life of the Space Telescope. Cost algorithms associated with the maintenance options as indicated by the failure patterns were developed and integrated into the model.

INTRODUCTION

This report presents the summer's activities directed toward determining the most feasible maintenance policy for the Space Telescope for a fifteen (15) year mission cycle. These include cost algorithms associated with part replacements and/or complete refurbishment. Participating in the summer's activities with me were Frank Pizzano, my counterpart, Rodney Stewart, Allen Forney, Molly Anderson, and Carol Cleveland.

Two basic tasks were adopted which were as follows:

- (1) To update a maintenance simulation computer model which simulates the failure patterns for the fifteen (15) year mission cycle of the Space Telescope.
- (2) To develop cost algorithms for the maintenance options according to the failure patterns to ascertain the optimum maintenance policy.

In order to accomplish the tasks the activities performed were as follows:

- (1.1) A detailed study of the maintenance simulation computer model.
- (1.2) Updates of failure rates were made for various parts whenever necessary.
- (1.3) Model configuration updates were made where revisions in the specifications called for a reconfiguration.
- (1.4) The reliability of the Space Telescope was determined for one year, two and one-half years, and five years.
- (1.5) Updates were made in the computer program where model configuration changed.
- (2.1) Cost Data were collected and organized for parts whose prices were known or available information would allow a price estimate.
- (2.2) Cost Algorithms were written involving a base-line algorithm, i.e. calculates cost if time schedule is standard and extended algorithm, i.e. takes base-line figure and adds a certain percentage according to the relationship between the time left in the new schedule and the time left in the standard schedule.

(b) Update the maintenance simulation computer model with respect to component/systems configurations, failure rates, and orbit replaceable unit cost estimates.

(c) Run the program and obtain the following cost comparisons against the specification plan of having three (3) in-orbit maintenance actions during the fifteen (15) year mission operating life of the Space Telescope:

(1) Assume in-orbit corrective maintenance actions only for the fifteen (15) year mission operating life with frequencies as dictated by the maintenance simulation computer model.

(2) Assume in-orbit corrective (Plus Preventive) maintenance actions only for the fifteen (15) year mission. (The preventive actions would involve components subject to degradation with age such as batteries.)

(3) Assume in-orbit corrective actions plus ground return actions with frequencies as dictated by the maintenance simulation computer model.

Reliability versus cost will be compared for each case using the Shuttle cost constants plus orbit replaceable unit cost estimates to obtain an indication of a preferable maintenance policy.

RELIABILITY OF THE SPACE TELESCOPE

The Space Telescope consist of three major subsystems: An Optical Telescope Assembly, A Support System Module, and The Scientific Instruments. The support system module encloses the optical telescope assembly and scientific instruments and also provide all interfaces with the shuttle orbiter.

The maintenance of the space telescope will involve either in-orbit maintenance or ground return maintenance or both. The items which will be maintained in orbit will be called orbit replaceable units. Each item is given a part number, a string number, and an orbit replaceable unit number for identification. The orbit replaceable units are configured on trays (i.e., A component in which all parts have the same orbit replaceable unit number), in such a way that they are easily accessible to the maintenance crew. The items which will be replaced on ground return will be called ground replaceable units.

The components of the optical telescope assembly were identified and failure rates associated with each component were obtained from references [1,4] to determine the reliability of each item for one year, two and one-half years, and five years.

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However, in the case of the DF-224 computer which consist of three memory units required and six provided with three active and three inactive, the reliability according to reference [3] is given By:

$$R(t) = \tilde{e}^{3\lambda t} + \frac{3\lambda}{\lambda'} \tilde{e}^{3\lambda t} (1 - \tilde{e}^{\lambda' t}) + \frac{3\lambda(3\lambda + \lambda')}{2\lambda'} \tilde{e}^{3\lambda t} (1 - \tilde{e}^{\lambda' t})^{2} + \frac{3\lambda}{6\lambda'^{3}} (3\lambda + \lambda') (3\lambda + 2\lambda') \tilde{e}^{3\lambda t} (1 - \tilde{e}^{\lambda' t})^{3}$$
(5)

Where λ is the failure rate and λ' is the standby failure rate, i.e., $\lambda' = 0.1 \lambda$. The central processor unit and the in-put-output unit are the other components of the DF-224. In these cases there are three provided with one required so the reliability formula is given by:

$$Rd = \bar{e}^{\lambda t} + \frac{\lambda}{\lambda'} \bar{e}^{\lambda t} (1 - \bar{e}^{\lambda' t}) + \frac{\lambda(\lambda + \lambda')}{2\lambda'^2} \bar{e}^{\lambda t} (1 - \bar{e}^{\lambda' t})^2 \quad (6)$$

The program for the computation of reliability of each component is given below.

The reliability of the support systems module for one year, two and one-half years, and five years is given in Table [2].

A breakdown of the base-line algorithm includes cost associated with maintenance analysis and planning, management of the orbit replaceable units, ground maintenance facility, and orbiter launch. The total expenditures being the sum of the cost for the maintenance analysis and planning, orbit replaceable unit management, ground maintenance facility and orbiter launch. The extended algorithm takes the base-line figure and adds a certain percentage according to the relationship between the time left in the new schedule and the time left in the standard schedule. The cost per part is used to determine the total cost for parts being replaced at a downstate.

MAINTENANCE SIMULATION MODEL

The maintenance simulation computer model is programmed to test each item once every 72 hours for failure. The failure rate of each item is used to determine the probability that the item has failed. With a random number generator the item is either failed or not failed by comparing a random number with the probability (computed) of failure. Each item is given a part number, a string number, and an orbit replaceable unit number for identification, as items are failed a log is kept of the failures by specifically identifying the failed item. This is done so the computer will know when the number of failed items result in a downstate. The Shuttle is then called for maintenance action. The time of each failure is also logged. The tests can be continued every 72 hours for a 15 year mission cycle. Each 15 year mission cycle test is called a pass. The model has the capabilities of making a number of passes sufficient to predict the mean time to failure with reasonable confidence. Plots of the failures versus time can also be made. This information together with the cost algorithm which is integrated in the model will give the total cost relative to maintenance of the Space Telescope according to the standard schedule as well as cost relative to the simulated schedule.

CONCLUSION

A maintenance policy for the Space Telescope is a must if the Space Telescope is to serve the needs of the scientific community effectively. The policy must optimize both cost for maintenance and availability for use by the scientific community. Therefore, the policy must be based on all available resources and information. Recognizing that many parts of the Telescope are of new design, very little is known other than simulated testing concerning the reliability thus the task of defining a policy becomes even more difficult. To this end, generic failure rates are used to determine the reliability of each item. Various configurations of the Space Telescope are continuously being updated in an effort to simulate a model which will more closely parallel the actual performance of the Space Telescope. The reliability of the Space Telescope with updated configurations was determined for one year, two and one-half years, and five years. The hope is that reliability as indicated by the model will provide a basis for a maintenance policy according to a particular time schedule. Due to the lack of acquired data relative to the actual item performance of the Space Telescope the model simulation approach seems appropriate. This approach has been used with much success in the past.

REFERENCES

- 1. Contractor's Reliability Allocations
- 2. IBM Nas 5-25630, "SI C&DH Reliability Prediction Report" November 20, 1980
- 3. Memorandum EF01, "Reliability Analysis and Evaluation of DF-224/NSSC-II Computers for Space Telescope," October 1978.
- 4. MIL-HDBK-217 B/C, "Reliability Prediction of Electronic Equipment."

TABLE 2

SUMMARY OF SUPPORT SYSTEMS MODULE ORBIT

REPLACEABLE UNIT (ORU) RELIABILITY STUDY

Reliability (Probability of Success)

	R (1 year)	R (2 1/2 years)	R (5 years)
Support Systems Module with present ORU capability	0.828343	0.214951	0.0 ₅ 3446
Support Systems Module with degraded mission capability	0.949195*	0.540912*	0.0 ₃ 3066*
Reliability enhance- ment with limited LMSC suggested	0.909337	0.709793	0.378308
(20 ORU's Total)	0.994114*	0.966236*	0.883826*
Reliability enhance- ment with MSFC suggested replacement	0.890368	0.628765	0.246092
(12 ORU's Total)	0.973377*	0.855933*	0.574936*

NOTE: Present ST Design includes approximately 37 ORU types with 69 total ORU's.

TABLE 4

SUMMARY OF TOTAL SPACE TELESCOPE SYSTEMS

RELIABILITY STUDY

Reliability (Probability of Success)

		R (1 year)	R(21/2 years)	R (5 years)
(1)	Probability of the Space Telescope functioning successfully in accordance with SPEC and including at least 3 of 6 science functions.	0.713088	0.108935	0.0 ₆ 473
(2)	Item (1) above except including mission degradation allowances.	0.794267	0.290403	0.0 ₄ 54

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